

**PHILIPS**

Data handbook



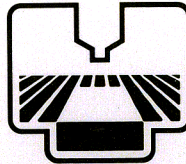
Electronic  
components  
and materials

**Semiconductors**

Book S7

1984

**Surface mounted semiconductors**



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- applications support
- quality



## SURFACE MOUNTED SEMICONDUCTORS

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## DATA HANDBOOK SYSTEM

Our Data Handbook System comprises more than 50 books with specifications on electronic components, subassemblies and materials. It is made up of four series of handbooks:

ELECTRON TUBES	BLUE
SEMICONDUCTORS	RED
INTEGRATED CIRCUITS	PURPLE
COMPONENTS AND MATERIALS	GREEN

The contents of each series are listed on pages iv to viii.

The data handbooks contain all pertinent data available at the time of publication, and each is revised and reissued periodically.

When ratings or specifications differ from those published in the preceding edition they are indicated with arrows in the page margin. Where application information is given it is advisory and does not form part of the product specification.

Condensed data on the preferred products of Philips Electronic Components and Materials Division is given in our Preferred Type Range catalogue (issued annually).

Information on current Data Handbooks and on how to obtain a subscription for future issues is available from any of the Organizations listed on the back cover.

Product specialists are at your service and enquiries will be answered promptly.

## ELECTRON TUBES (BLUE SERIES)

The blue series of data handbooks is comprised of the following parts:

- T1** Tubes for r.f. heating
- T2a** Transmitting tubes for communications, glass types
- T2b** Transmitting tubes for communications, ceramic types
- T3** Klystrons, travelling-wave tubes, microwave diodes
- ET3** Special Quality tubes, miscellaneous devices (will not be reprinted)
- T4** Magnetrons
- T5** Cathode-ray tubes  
Instrument tubes, monitor and display tubes, C.R. tubes for special applications
- T6** Geiger-Müller tubes
- T7** Gas-filled tubes  
Segment indicator tubes, indicator tubes, dry reed contact units, thyratrons, industrial rectifying tubes, ignitrons, high-voltage rectifying tubes, associated accessories
- T8** Picture tubes and components  
Colour TV picture tubes, black and white TV picture tubes, colour monitor tubes for data graphic display, monochrome monitor tubes for data graphic display, components for colour television, components for black and white television and monochrome data graphic display
- T9** Photo and electron multipliers  
Photomultiplier tubes, phototubes, single channel electron multipliers, channel electron multiplier plates
- T10** Camera tubes and accessories
- T11** Microwave semiconductors and components
- T12** Vidicons and Newvicons
- T13** Image intensifiers
- T14** Infrared detectors

## SEMICONDUCTORS (RED SERIES)

The red series of data handbooks comprises:

- S1 Diodes**  
Small-signal germanium diodes, small-signal silicon diodes, voltage regulator diodes (< 1,5 W), voltage reference diodes, tuner diodes, rectifier diodes
- S2a Power diodes**
- S2b Thyristors and triacs**
- S3 Small-signal transistors**
- S4a Low-frequency power transistors and hybrid modules**
- S4b High-voltage and switching power transistors**
- S5 Field-effect transistors**
- S6 R.F. power transistors and modules**
- S7 Surface mounted semiconductors**
- S8 Devices for optoelectronics**  
Photosensitive diodes and transistors, light-emitting diodes, displays, photocouplers, infrared sensitive devices, photoconductive devices.
- S9 Power MOS transistors**
- S10 Wideband transistors and wideband hybrid IC modules**

## INTEGRATED CIRCUITS (PURPLE SERIES)

The purple series of data handbooks comprises:

### EXISTING SERIES

- IC1** Bipolar ICs for radio and audio equipment
- IC2** Bipolar ICs for video equipment
- IC3** ICs for digital systems in radio, audio and video equipment
- IC4** Digital integrated circuits  
CMOS HE4000B family
- IC5** Digital integrated circuits – ECL  
ECL10 000 (GX family), ECL100 000 (HX family), dedicated designs
- IC6** Professional analogue integrated circuits
- IC7** Signetics bipolar memories
- IC8** Signetics analogue circuits
- IC9** Signetics TTL logic
- IC10** Signetics Integrated Fuse Logic (IFL)
- IC11** Microprocessors, microcomputers and peripheral circuitry

## NEW SERIES

- IC01N** Radio, audio and associated systems  
Bipolar, MOS
- IC02N** Video and associated systems  
Bipolar, MOS
- IC03N** Telephony equipment  
Bipolar, MOS
- IC04N** HE4000B logic family  
CMOS
- IC05N** HE4000B logic family uncased integrated circuits  
CMOS (published 1984)
- IC06N** PC54/74HC/HCU/HCT logic families  
HCMOS
- IC07N** PC54/74HC/HCU/HCT uncased integrated circuits  
HCMOS
- IC08N** 10K and 100K logic family  
ECL
- IC09N** Logic series  
TTL (published 1984)
- IC10N** Memories  
MOS, TTL, ECL
- IC11N** Analogue - industrial
- IC12N** Semi-custom gate arrays & cell libraries  
ISL, ECL, CMOS
- IC13N** Semi-custom integrated fuse logic  
IFL series 20/24/28
- IC14N** Microprocessors, microcontrollers & peripherals  
Bipolar, MOS
- IC15N** Logic series  
FAST TTL (published 1984)

### Note

Books available in the new series are shown with their date of publication.

## COMPONENTS AND MATERIALS (GREEN SERIES)

The green series of data handbooks comprises:

- C1 Assemblies for industrial use**  
PLC modules, PC20 modules, HN1L FZ/30 series, NORbits 60-, 61-, 90-series, input devices, hybrid ICs
- C2 Television tuners, video modulators, surface acoustic wave filters**
- C3 Loudspeakers**
- C4 Ferroxcube potcores, square cores and cross cores**
- C5 Ferroxcube for power, audio/video and accelerators**
- C6 Synchronous motors and gearboxes**
- C7 Variable capacitors**
- C8 Variable mains transformers**
- C9 Piezoelectric quartz devices**  
Quartz crystal units, temperature compensated crystal oscillators, compact integrated oscillators, quartz crystal cuts for temperature measurements
- C10 Connectors**
- C11 Non-linear resistors**  
Voltage dependent resistors (VDR), light dependent resistors (LDR), negative temperature coefficient thermistors (NTC), positive temperature coefficient thermistors (PTC)
- C12 Variable resistors and test switches**
- C13 Fixed resistors**
- C14 Electrolytic and solid capacitors**
- C15 Film capacitors, ceramic capacitors**
- C16 Permanent magnet materials**
- C17 Stepping motors and associated electronics**
- C18 D.C. motors**
- C19 Piezoelectric ceramics**
- C20 Wire-wound components**



SELECTION GUIDE

# SELECTION GUIDE

## GENERAL PURPOSE TRANSISTORS in SOT-23/SOT-89\*/SOT-143\*\*

type	RATINGS				h <sub>FE</sub>		V <sub>CEsat</sub>		f <sub>T</sub> typ. MHz	page
	V <sub>CB0</sub> V	V <sub>CEO</sub> V	I <sub>C</sub> mA	P <sub>tot</sub> mW	min./max. at I <sub>C</sub> /V <sub>CE</sub>	mA/V	max. at I <sub>C</sub> /I <sub>B</sub>	V mA		
<b>P-N-P</b>										
BC807	45	45	500	310	100/600	100/1	0,70	500/50	100	123
BC808	25	25	500	310						123
BC856	65	65	100	200	75/475	2/5	0,30	10/0,5	150	157
BC857	45	45	100	200	75/475	2/5	0,30	10/0,5	150	157
BC858	30	30	100	200	75/800	2/5	0,30	10/0,5	150	157
BC859	30	30	100	200	125/800	2/5	0,30	10/0,5	150	165
BC860	45	45	100	200	125/800	2/5	0,30	10/0,5	150	165
BC869*	20	20	1000	1000	85/375	500/1	0,50	1000/100	60	181
BCV62**	30	30	100	200	100/800	2/5	0,65	100/5	150	219
BCW29;R	32	32	100	350	120/260	2/5	0,30	10/0,5	150	227
BCW30;R					215/500					227
BCW61A	32	32	200	150	120/220	2/5	0,25	10/0,25	180	247
BCW61B					180/310					247
BCW61C					250/460					247
BCW61D					380/630					247
BCW69R	50	45	100	350	120/260	2/5	0,30	10/0,5	150	251
BCW70;R					120/500					251
BCW89;R	80	60			120/260					271
BCX17;R	50	45	500	425	100/600	100/1	0,62	500/50	100	275
BCX18;R	30	25								275
BCX51*	45	45	1000	1000	40/250	150/2	0,50	500/50	50	287
BCX52*	60	60			40/160					287
BCX53*	100	80			40/160					287
BCX69*	20	20	1000	1000	85/375	500/1	0,50	1000/100	60	301
BCX71G	45	45	200	150	120/220	2/5	0,25	10/0,25	180	311
BCX71H					180/310					311
BCX71J					250/460					311
BCX71K					380/630					311

\* Types in SOT-89 package.

\*\* Types is SOT-143 package.

## GENERAL PURPOSE TRANSISTORS in SOT-23/SOT-89\*/SOT-143\*\*

type	RATINGS				$h_{FE}$		$V_{CEsat}$		$f_T$ typ. MHz	page
	$V_{CBO}$ V	$V_{CEO}$ V	$I_C$ mA	$P_{tot}$ mW	min./max. at $I_C/V_{CE}$ mA/V	max. at $I_C/I_B$ mA	V	mA		
<b>N-P-N</b>										
BC817	45	45	500	310	100/600	100/1	0,70	500/50	200	129
BC818	25	25	500	310						129
BC846	65	65	100	200	220/800	2/5	0,25	10/0,5	300	135
BC847	45	45	100	200						135
BC848	30	30	100	200						135
BC849	30	30	100	200	450/800	2/5	0,25	10/0,5	300	145
BC850	45	45	100	200						145
BC868*	20	20	1000	1000	85/375	500/1	0,50	1000/100	60	175
BCV61**	30	30	100	200	100/800	2/5	0,60	100/5	300	215
BCV71	80	60	100	350	110/220	2/5	0,25	10/0,5	300	223
BCV72					200/450					223
BCW31;R	32	32	100	350	110/220	2/5	0,25	10/0,5	300	235
BCW32;R					200/450					235
BCW33;R					420/800					235
BCW60A	32	32	200	150	120/220	2/5	0,35	10/0,25	250	243
BCW60B					180/310					243
BCW60C					250/460					243
BCW60D					380/630					243
BCW71;R	50	45	100	350	110/220	2/5	0,25	10/0,5	300	259
BCW72;R					220/450					259
BCW81;R					450/800					267
BCX19;R	50	45	500	425	100/600	100/1	0,62	500/50	200	281
BCX20;R	30	25								281
BCX54*	45	45	1000	1000	45/250	150/2	0,50	500/50	130	291
BCX55*	60	60			40/160					291
BCX56*	100	80			40/160					291
BCX68*	20	20	1000	1000	85/375	500/1	0,50	1000/100	60	295
BCX70G	45	45	200	150	120/220	2/5	0,35	10/0,25	250	307
BCX70H					180/310					307
BCX70J					250/460					307
BCX70K					380/630					307

\* Types in SOT-89 package

\*\* Types in SOT-143 package.

# SELECTION GUIDE

## HIGH-FREQUENCY TRANSISTORS in SOT-23

type	RATINGS				$h_{FE}$		F		$f_T$	$C_{re}$	page
	$V_{CBO}$ V	$V_{CEO}$ V	$I_C$ mA	$P_{tot}$ mW	min./max. at $I_C/V_{CE}$ mA/V		typ. at f dB	MHz	typ. MHz	typ. pF	
<b>P-N-P</b>											
BF536	30	30	25	200	25/-	1/10	5	200	350	-	321
BF550;R	40	40	25	200	50/-	1/10	2	0,1	325	0,5	325
BF569	40	35	30	200	25/-	3/10	4,5	800	900	0,33	329
BF579	20	20	25	150	20/-	10/10	4,5	800	1350	0,46	333
BF660	40	30	25	200	30/-	3/10	-	-	650	0,65	345
BF767	30	30	20	200	15/-	3/10	4	800	900	0,3	349
BF824	30	30	25	300	-	-	3	100	450	0,1	365
<b>N-P-N</b>											
BFS18;R	30	20	30	250	35/125	1/10	4	100	200	0,85	473
BFS19;R	30	20	30	250	65/225	1/10	4	100	260	0,85	473
BFS20;R	30	20	25	250	40/85	7/10	-	-	450	0,35	479

## BROAD-BAND TRANSISTORS in SOT-23/SOT-89\*

type	RATINGS				$h_{FE}$		$d_{im}$	$f_T$	$C_{re}$	page	
	$V_{CBO}$ V	$V_{CEO}$ V	$I_C$ mA	$P_{tot}$ mW	min./max. at $I_C/V_{CE}$ mA/V		typ. at f dB	MHz	typ. GHz		typ. pF
<b>P-N-P</b>											
BFT92;R	20	15	25	200	20/-	14/10	60	493,25	5	0,7	501
BFT93;R	15	12	35	200	20/-	30/5	60	493,25	5	1,0	507
<b>N-P-N</b>											
BFQ17*	40	25	150	1000	25/-	150/5	-	-	1,2	1,9	389
BFQ18A*	25	15	150	1000	25/-	100/10	60	793,25	3,6	1,2	393
BFQ19*	20	15	75	500	25/-	75/10	-	-	5,0	1,3	397
BFR53;R	18	10	50	250	25/-	50/5	60	217,0	2,0	0,9	411
BFR92;R	20	15	25	200	25/-	14/10	60	493,25	5,0	0,7	421
BFR92A;R	20	15	25	200	40/-	14/10	60	793,25	5,0	0,35	431
BFR93;R	15	12	35	200	25/-	30/5	60	493,25	5,0	0,8	443
BFR93A;R	15	12	35	250	40/-	30/5	60	793,25	5,0	0,6	453
BFS17;R	25	15	25	250	20/150	2/1	45	217	1,3	0,65	467
BFT25;R	8	5	2,5	50	20/-	1/1	-	-	2,3	0,45	485

\* Types in SOT-89 package are denoted by an asterisk (\*).

## SWITCHING TRANSISTORS in SOT-23/SOT-89\*

type	RATINGS				h <sub>FE</sub>		V <sub>CEsat</sub>		t (max.)		page
	V <sub>CBO</sub> V	V <sub>CEO</sub> V	I <sub>C</sub> mA	P <sub>tot</sub> mW	min./max. at I <sub>C</sub> /V <sub>CE</sub>	at I <sub>C</sub> /V <sub>CE</sub> mA/V	max. at I <sub>C</sub> /I <sub>B</sub>	at I <sub>C</sub> /I <sub>B</sub> V mA/mA	on/off at I <sub>C</sub> /I <sub>B</sub>	ns mA	
<b>P-N-P</b>											
BSR12;R	15	15	100	250	30/120	50/1	0,45	100/10	20/30	30/3	529
BSR15;R	60	40	600	425	100/300	150/10	1,6	500/50	45/100	150/15	541
BSR16;R	60	60									541
BSR18;R	40	40	200	250	50/150	10/1	0,40	50/5	70/250	10/1	551
BSR18A;R	40	40	200	250	100/300	10/1	0,4	50/5	70/300	10/1	551
BSR30*	70	60	1000	1000	40/120	100/5	0,5	500/50	500/650	100/5	555
BSR31*	70	60			100/300						555
BSR32*	90	80			40/120						555
BSR33*	90	80			100/300						555
BSS63;R	110	100	100	350	30/-	25/1	0,25	25/2,5	-	-	567
BST60*	60	45	500	1000	1000/-	150/10	1,3	500/0,5	400/1500	500/0,5	593
BST61*	80	60									593
BST62*	100	80									593
<b>N-P-N</b>											
BSR13;R	60	30	800	425	100/300	150/10	1,6	500/50	35/285	150/-	535
BSR14;R	75	40					1,0				535
BSR17;R	60	40	200	350	50/150	10/1	0,3	50/5	70/225	10/1	547
BSR17A;R	60	40	200	350	100/300	10/1	0,3	50/5	70/250	10/1	547
BSR40*	70	60	1000	1000	40/120	100/5	0,5	500/50	250/1000	100/5	559
BSR41*					100/300						559
BSR42*	90	80	1000	1000	40/120	100/5	0,5	500/50	250/1000	100/5	559
BSR43*					100/300						559
BSS64;R	120	80	100	350	20/80	10/1	0,2	50/15	/1000	15/1	573
BSV52;R	20	12	100	250	40/120	10/1	0,2	50/5	12/18	10/3	597
BST50*	60	45	500	1000	1000/-	150/10	1,3	500/50	400/1500	500/0,5	589
BST51*	80	60	500	1000							589
BST52*	100	80	500	1000							589

\* Types in SOT-89 package are denoted by an asterisk (\*).

# SELECTION GUIDE

## LOW NOISE TRANSISTORS in SOT-23 ( $F < 4$ dB at $f = 1$ kHz; $B = 200$ Hz)

type	$V_{CB0}$ V	RATINGS			$h_{FE}$		$V_{CEsat}$		$f_T$ typ. MHz	page
		$V_{CEO}$ V	$I_C$ mA	$P_{tot}$ mW	min./max. at $I_C/V_{CE}$	mA/V	max. at $I_C/I_B$	V mA		
<b>P-N-P</b>										
BCF29	32	32	100	350	120/260	2/5	0,3	10/0,5	150	187
BCF30	32	32	100	350	215/500	2/5	0,3	10/0,5	150	187
BCF70	50	45	100	350	215/500	2/5	0,3	10/0,5	150	203
<b>N-P-N</b>										
BCF32	32	32	100	350	200/450	2/5	0,25	10/0,5	300	195
BCF33	32	32	100	350	420/800	2/5	0,25	10/0,5	300	195
BCF81	50	45	100	350	420/800	2/5	0,25	10/0,5	300	211

## HIGH VOLTAGE TRANSISTORS in SOT-23/SOT-89\*

type	$V_{CB0}$ V	RATINGS			$h_{FE}$		$V_{CEsat}$		$f_T$ min. MHz	page
		$V_{CEO}$ V	$I_C$ mA	$P_{tot}$ mW	min./max. at $I_C/V_{CE}$	mA/V	max. at $I_C/I_B$	V mA		
<b>P-N-P</b>										
BF621*	300	—	20	1000	50/—	25/20	0,8	30/5	60	341
BF623*	250	250	20	1000	50/—	25/20	0,8	30/5	60	341
BF821	300	—	50	310	50/—	25/20	0,8	30/5	60	359
BF823	250	250	50	310	50/—	25/20	0,8	30/5	60	359
BST15*	200	200	1000	1000	30/150	50/10	2,5	50/5	15	581
BST16*	350	300	1000	1000	30/120	50/10	2,0	50/5	15	581
<b>N-P-N</b>										
BF620*	300	—	20	1000	50/—	25/20	0,6	30/5	60	337
BF622*	250	250	20	1000	50/—	25/20	0,6	30/5	60	337
BF820	300	—	50	310	50/—	25/20	0,6	30/5	60	353
BF822	250	250	50	310	50/—	25/20	0,6	30/5	60	353
BST39*	450	300	1000	1000	40/160	20/10	0,5	50/4	15	585
BST40*	350	250	1000	1000	40/160	20/10	0,5	50/4	15	585

\* Types in SOT-89 package are denoted by an asterisk (\*).

FIELD-EFFECT TRANSISTOR in SOT-23/SOT-143\*

type	RATINGS				$-I_{GSS}$ max. nA	$I_{DSS}$ min./max. mA	$-V(P)GS$ max V	$ v_{fs} $ min. mS	$C_{rs}$ max. pF	$V_n$ max. $\mu V$	page
	$\pm V_{DS}$ V	$-V_{GSO}$ V	$I_D$ mA	$P_{tot}$ mW							
BF510	20	—	30	300	10	0,7/3,0	0,8	2,5	0,4	—	315
BF511						2,5/7,0	1,5	4			315
BF512						6/12	2,2	6			315
BF513						10/18	3	7			315
BF989*	20	—	20	200	50	2/20	2,7	9,5	0,025	—	371
BF990*	18	—	30	200	25	—	1,3	17	0,025	—	373
BF991*	20	—	20	200	50	4/25	2,5	10	0,020	—	377
BF992*	20	—	40	200	25	—	1,3	20	0,04	—	379
BF994*	20	—	30	200	50	2/20	2,5	15	0,025	—	381
BF996*	20	—	30	200	50	2/20	2,5	15	0,025	—	385
BFR30	25	25	10	250	0,2	4/10	5	1	1,5	0,5	401
BFR31						1/5	2,5	1,5			401
BFR101A*	30	30	10	200	5	0,2/1,5	1,0	1,2	—	—	465
BFR101B*	30	30	10	200	5	1/5	2,5	2,5	—	—	465
BFT46	25	25	10	250	0,2	0,2/1,5	1,0	1,0	1,5	0,5	493
BSD20*	10	—	50	230	1,0	—	2,0	—	0,6	—	525
BSD22*	20	—	50	230	1,0	—	2,0	—	0,6	—	525
BSS83*	10	—	50	230	10	—	2,0	—	0,6	—	577
BSR56	40	40	—	250	1	50/—	10	—	5	—	563
BSR57						20/100	6				563
BSR58						8/80	4				563

TRIGGER DEVICES

P-N-P-N	case	$V_{GA}$ max. V	$I_A$ max. mA	$I_p$ $\mu A$	$I_V$ $\mu A$	page
BRY61	SOT-23	70	175	5/1	30/50	513
BRY62	SOT-143	70	175	—	—	519

\* Type in SOT-143 package are denoted by an asterisk (\*).

# SELECTION GUIDE

DIODES in SOT-23 unless indicated; 1 = SOT-143, 2 = SOD-80

type	description	RATINGS		$t_{rr}$ max. mS	$V_F$ max (mV) at $I_F =$ mA 10/100-150	$C_d$ max. $\mu$ V	page
		$V_R$ V	$I_F$ mA				
BAS16	high-speed switch	75	250	6	855/- - 1250	2	55
BAS17	low-voltage stabilizer	-	250	-	830/960 -	140	59
BAS19	high-speed switch	100	200	50	- /1000 -	5	63
BAS20	high-speed switch	150	200	50	- /1000 -	5	63
BAS21	high-speed switch	200	200	50	- /1000 -	5	63
BAS28 <sup>1</sup>	fast switch double diode	75	250	6	855/- - 1250	2	71
BAS29	switch	90	250	50	750/900 -	35	75
BAS31	two diodes in series	90	250	50	750/900 -	35	75
BAS32 <sup>2</sup>	high-speed switch	75	200	4	- /1000 -	2	77
BAS35	common anode double diode	90	250	50	750/900 -	35	75
BAT17	Schottky barrier	4	30	-	600/- -	1	85
BAT18	band switch	35	100	-	/1200 -	1	89
BAV23 <sup>1</sup>	two diodes	200	200	50	- /1000 -	2,5	93
BAV70	common cathode double diode	70	250	6	855/- - 1250	1,5	95
BAV99	two diodes in series	70	250	6	855/- - 1250	1,5	99
BAV100 <sup>2</sup>	general purpose	50	250	50	- /1000 -	5	103
BAV101 <sup>2</sup>	general purpose	100	250	50	- /1000 -	5	103
BAV102 <sup>2</sup>	general purpose	150	250	50	- /1000 -	5	103
BAV102 <sup>2</sup>	general purpose	200	250	50	- /1000 -	5	103
BAW56	common anode double diode	70	250	6	855/- - 1250	2	103

## VARIABLE CAPACITANCE DIODES (SOT-23)

type	RATINGS		CHARACTERISTICS				page
	$V_R$	$I_F$	$C_d$ at $V_R$		$C_d$ ratio at $V_R = 3/25$ V at $f = 1$ MHz	$r_D$	
	V	mA	pF	V		$\Omega$	
BBY31	28	20	1,8 - 2,8	25	typ. 5	< 1,2	115
BBY40	28	20	4,3 - 6	25	5 to 5,6	< 0,6	119

## VOLTAGE REGULATOR DIODES

type	case	range (V)	voltage tolerance %	$P_{tot}$ mW	$I_{ZRM}$ mA	$I_{FRM}$ mA	max. $V_F$ at $I_F$		page
							V	mA	
BZV49	SOT-89	2,4 to 75	5	1000	-**	250	1	50	605
BZV55	SOD-80	2,4 to 75	5	500	-	250	0,9	10	615
BZX84	SOT-23	2,4 to 75	5*	350	250	250	0,9	10	629

\* Types with 2% tolerance available on request.

\*\*  $I_{ZRM}$  limited by  $P_{ZRMmax}$ .



In this alpha-numeric list we present all surface mounted devices mentioned in this handbook.

type number	SOT-23	SOT-89	SOT-143	SOD-80	marking type reverse type	device type	nearest conventional type(s)	complement	page
BAS16	●	—	—	—	A6	diode	BAW62, 1N4148		55
BAS17	●	—	—	—	A91	diode	BA314		59
BAS19	●	—	—	—	A8	diode	BAV19		63
BAS20	●	—	—	—	A81	diode	BAV20		63
BAS21	●	—	—	—	A82	diode	BAV21		63
BAS28	—	—	●	—	A61	diode			71
BAS29	●	—	—	—	L20	diode			75
BAS31	●	—	—	—	L21	diode			75
BAS32	—	—	—	●	black band	diode			77
BAS35	●	—	—	—	L22	diode			75
BAT17	●	—	—	—	A3	diode	BA481		85
BAT18	●	—	—	—	A2	diode	BA243, BA482		89
BAV23	—	—	●	—	L30	diode			93
BAV70	●	—	—	—	A4	diode	BAW62, 1N4148 (double)		95
BAV99	●	—	—	—	A7	diode	BAW62, 1N4148 (double)		99
BAV100	—	—	—	●	green and black	diode			103
BAV101	—	—	—	●	green and brown	diode			103
BAV102	—	—	—	●	green and red	diode			103
BAV103	—	—	—	●	green and orange	diode			103
BAW56	●	—	—	—	A1	diode	BAW62, 1N4148 (double)		111
BBY31	●	—	—	—	S1	diode	BB405		115
BBY40	●	—	—	—	S2	diode	BB809		119
BC807-16	●	—	—	—	5A 5AR	PNP	BC327-16	BC817-16	123
-25	●	—	—	—	5B 5BR	PNP	-25	-25	123
-40	●	—	—	—	5C 5CR	PNP	-40	-40	123
BC808-16	●	—	—	—	5E 5ER	PNP	BC328-16	BC818-16	123
-25	●	—	—	—	5F 5FR	PNP	-25	-25	123
-40	●	—	—	—	5G 5GR	PNP	-40	-40	123
BC817-16	●	—	—	—	6A 6AR	NPN	BC337-16	BC807-16	129
-25	●	—	—	—	6B 6BR	NPN	-25	-25	129
BC817-40	●	—	—	—	6C 6CR	NPN	BC337-40	BC807-40	129
BC818-16	●	—	—	—	6E 6ER	NPN	BC338-16	BC808-16	129
-25	●	—	—	—	6F 6FR	NPN	-25	-25	129
-40	●	—	—	—	6G 6GR	NPN	-40	-40	129
BC846A	●	—	—	—	1A 1AR	NPN	BC546A	BC856	135

# TYPE NUMBER SURVEY

type number	SOT-23	SOT-89	SOT-143	SOD-80	marking		device type	nearest conventional type(s)	complement	page
					type	reverse type				
BC846B	●	—	—	—	1B	1BR	NPN	BC546B		135
BC847A	●	—	—	—	1E	1ER	NPN	BC547, BC107	BC857	135
BC847B	●	—	—	—	1F	1FR	NPN			135
BC847C	●	—	—	—	1G	1GR	NPN			135
BC848A	●	—	—	—	1J	1JR	NPN	BC548, BC108	BC858	135
BC848B	●	—	—	—	1K	1KR	NPN	BC548, BC108	BC858	135
BC848C	●	—	—	—	1L	1LR	NPN			135
BC849B	●	—	—	—	2B	2BR	NPN	BC549, BC109	BC859	145
BC849C	●	—	—	—	2C	2CR	NPN			145
BC850B	●	—	—	—	2F	2FR	NPN	BC550B, BCY79	BC860	145
BC850C	●	—	—	—	2G	2GR	NPN	BC550C, BCY79		145
BC856A	●	—	—	—	3A	3AR	PNP	BC556	BC846	157
BC856B	●	—	—	—	3B	3BR	PNP			157
BC857A	●	—	—	—	3E	3ER	PNP	BC557, BC177	BC847	157
BC857B	●	—	—	—	3F	3FR	PNP			157
BC857C	●	—	—	—	3G	3GR	PNP			157
BC858A	●	—	—	—	3J	3JR	PNP	BC558, BC178	BC848	157
BC858B	●	—	—	—	3K	3KR	PNP			157
BC858C	●	—	—	—	3L	3LR	PNP			157
BC859A	●	—	—	—	4A	4AR	PNP	BC559, BC179, BCY78	BC849	165
BC859B	●	—	—	—	4B	4BR	PNP			165
BC859C	●	—	—	—	4C	4CR	PNP			165
BC860A	●	—	—	—	4E	4ER	PNP	BC560, BCY79	BC850	165
BC860B	●	—	—	—	4F	4FR	PNP			165
BC860C	●	—	—	—	4G	4GR	PNP			165
BC868	—	●	—	—	BC868		NPN	BC368	BC869	175
BC869	—	●	—	—	BC869		PNP	BC369	BC868	181
BCF29	●	—	—	—	C7	C77	PNP	BC559A, BCY78, BC179		187
BCF30	●	—	—	—	C8	C9	PNP	BC559B, BCY78	BCF32	187
BCF32	●	—	—	—	D7	D77	NPN	BC549B, BCY58, BC109	BCF30	195
BCF33	●	—	—	—	D8	D81	NPN	BC549C, BCY58		195
BCF70	●	—	—	—	H7	H71	PNP	BC560B, BCY79		203
BCF81	●	—	—	—	K9	K91	NPN	BC550C		211
BCV61	—	●	—	—	D91		NPN	BC547	BCV62	215
BCV62	—	●	—	—	C91		PNP	BC557	BCV61	219
BCV71	●	—	—	—	K7	K71	NPN	BC546A		223
BCV72	●	—	—	—	K8	K81	NPN	BC546B		223
BCW29	●	—	—	—	C1	C4	PNP	BC178A, BC558A	BCW31	227
BCW30	●	—	—	—	C2	C5	PNP	BC178B, BC558B	BCW32	227
BCW31	●	—	—	—	D1	D4	NPN	BC108A, BC548A	BCW29	235

type number	SOT-23	SOT-89	SOT-143	SOD-80	marking		device type	nearest conventional type(s)	complement	page
					type	reverse type				
BCW32	●	—	—	—	D2	D5	NPN	BC108B, BC548B	BCW30	235
BCW33	●	—	—	—	D3	D6	NPN	BC108C, BC548C		235
BCW60A	●	—	—	—	AA		NPN	BC548A	BCW61A	243
BCW60B	●	—	—	—	AB		NPN	BC548B	BCW61B	243
BCW60C	●	—	—	—	AC		NPN	BC548B	BCW61C	243
BCW60D	●	—	—	—	AD		NPN	BC548C	BCW61D	243
BCW61A	●	—	—	—	BA		PNP	BC558A	BCW60A	247
BCW61B	●	—	—	—	BB		PNP	BC558B	BCW60B	247
BCW61C	●	—	—	—	BC		PNP	BC558B	BCW60C	247
BCW61D	●	—	—	—	BD		PNP	BC558C	BCW60D	247
BCW69	●	—	—	—	H1	H4	PNP	BC557A	BCW71	251
BCW70	●	—	—	—	H2	H5	PNP	BC557B	BCW72	251
BCW71	●	—	—	—	K1	K4	NPN	BC547A	BCW69	259
BCW72	●	—	—	—	K2	K5	NPN	BC547B	BCW70	259
BCW81	●	—	—	—	K3	K31	NPN	BC547C		267
BCW89	●	—	—	—	H3	H31	PNP	BC556A		271
BCX17	●	—	—	—	T1	T4	PNP	BC327	BCX19	275
BCX18	●	—	—	—	T2	T5	PNP	BC328	BCX20	275
BCX19	●	—	—	—	U1	U4	NPN	BC337	BCX17	281
BCX20	●	—	—	—	U2	U5	NPN	BC338	BCX18	281
BCX51	—	●	—	—	BCX51		PNP	BC636	BCX54	287
BCX52	—	●	—	—	BCX52		PNP	BC638	BCX55	287
BCX53	—	●	—	—	BCX53		PNP	BC640	BCX56	287
BCX54	—	●	—	—	BCX54		NPN	BC635	BCX51	291
BCX55	—	●	—	—	BCX55		NPN	BC637	BCX52	291
BCX56	—	●	—	—	BCX56		NPN	BC639	BCX53	291
BCX68	—	●	—	—	BCX68		NPN	BC368	BCX69	295
BCX69	—	●	—	—	BCX69		PNP	BC369	BCX68	301
BCX70G	●	—	—	—	AG		NPN	BC107, BC547	BCX71G	307
BCX70H	●	—	—	—	AH		NPN	BC107, BC547	BCX71H	307
BCX70J	●	—	—	—	AJ		NPN	BC107, BC547	BCX71J	307
BCX70K	●	—	—	—	AK		NPN	BC107, BC547	BCX71K	307
BCX71G	●	—	—	—	BG		PNP	BC177, BC557	BCX70G	311
BCX71H	●	—	—	—	BH		PNP	BC177, BC557	BCX70H	311
BCX71J	●	—	—	—	BJ		PNP	BC177, BC557	BCX70J	311
BCX71K	●	—	—	—	BK		PNP	BC177, BC557	BCX70K	311
BF510	●	—	—	—	S6		FET	BF410A		315
BF511	●	—	—	—	S7		FET	BF410B		315
BF512	●	—	—	—	S8		FET	BF410C		315
BF513	●	—	—	—	S9		FET	BF410D		315

# TYPE NUMBER SURVEY

type number	SOT-23	SOT-89	SOT-143	SOD-80	marking		device type	nearest conventional type(s)	complement	page
					type	reverse type				
BF536	●	—	—	—	G3		PNP	BF936		321
BF550	●	—	—	—	G2	G5	PNP	BF450		325
BF569	●	—	—	—	G6		PNP	BF970		329
BF579	●	—	—	—	G7		PNP	BF979		333
BF620	—	●	—	—	BF620		NPN	BF420	BF621	337
BF621	—	●	—	—	BF621		PNP	BF421	BF620	341
BF622	—	●	—	—	BF622		NPN	BF422	BF623	337
BF623	—	●	—	—	BF623		PNP	BF423	BF622	341
BF660	●	—	—	—	G8	G81	PNP	BF606A		345
BF767	●	—	—	—	G9		PNP	BF967		349
BF820	●	—	—	—	1V		NPN	BF420	BF821	353
BF821	●	—	—	—	1W		PNP	BF421	BF820	359
BF822	●	—	—	—	1X		NPN	BF422	BF823	353
BF823	●	—	—	—	1Y		PNP	BF423	BF822	359
BF824	●	—	—	—	F8		PNP	BF324		365
BF989	—	—	●	—	M89		FET	BF960		371
BF990	—	—	●	—	M90		FET	BF980		373
BF991	—	—	●	—	M91		FET	BF981		377
BF992	—	—	●	—	M92		FET	BF982		379
BF994	—	—	●	—	M94		FET	BF964		381
BF996	—	—	●	—	M96		FET	BF966		385
BFQ17	—	●	—	—	BFQ17		NPN	BFW16A		389
BFQ18A	—	●	—	—	BFQ18A		NPN	BFQ34		393
BFQ19	—	●	—	—	BFQ19		NPN	BFR96		397
BFR30	●	—	—	—	M1		FET	BFW11, BF245		401
BFR31	●	—	—	—	M2		FET	BFW12, BF245		401
BFR53	●	—	—	—	N1	N4	NPN	BFW30, BFW93		411
BFR92	●	—	—	—	P1	P4	NPN	BFR90	BFT92	421
BFR92A	●	—	—	—	P2	P5	NPN	BFR90		431
BFR93	●	—	—	—	R1	R4	NPN	BFR91	BFT93	443
BFR93A	●	—	—	—	R2	R5	NPN	BFR91		453
BFR101A	—	—	●	—	M37		FET	—		465
BFR101B	—	—	●	—	M98		FET	—		465
BFS17	●	—	—	—	E1	E4	NPN	BFY90, BFW92		467
BFS18	●	—	—	—	F1	F4	NPN	BF185, BF495		473
BFS19	●	—	—	—	F2	F5	NPN	BF184, BF494		473
BFS20	●	—	—	—	G1	G4	NPN	BF199		479
BFT25	●	—	—	—	V1	V4	NPN	BFT24		485
BFT46	●	—	—	—	M3		FET	BFW13, BF245		493
BFT92	●	—	—	—	W1	W4	PNP	BFQ51; 52	BFR92	501

type number	SOT-23	SOT-89	SOT-143	SOD-80	marking		device type	nearest conventional type(s)	component	page
					type	reverse type				
BFT93	●	—	—	—	X1	X4	PNP	BFQ23; 24	BFR93	507
BRY61	●	—	—	—	A5		PNPN	BRY56		513
BRY62	—	—	●	—	A51		PNPN	BRY39		519
BSD20	—	●	—	—	M31		FET			525
BSD22	—	●	—	—	M32		FET			525
BSR12	●	—	—	—	B5	B8	PNP	2N2894A	BSV52	529
BSR13	●	—	—	—	U7	U71	NPN	2N2222		535
BSR14	●	—	—	—	U8	U81	NPN	2N2222A		535
BSR15	●	—	—	—	T7	T71	PNP	2N2907		541
BSR16	●	—	—	—	T8	T81	PNP	2N2907A		541
BSR17	●	—	—	—	U9	U91	NPN	2N3903		BSR18
BSR17A	●	—	—	—	U92	U93	NPN	2N3904	BSR18A	547
BSR18	●	—	—	—	T9	T91	PNP	2N3905	BSR17	551
BSR18A	●	—	—	—	T92	T93	PNP	2N3906	BSR17A	551
BSR30	—	●	—	—	BSR30		PNP	2N4030	BSR40	555
BSR31	—	●	—	—	BSR31		PNP	2N4031	BSR41	555
BSR32	—	●	—	—	BSR32		PNP	2N4032	BSR42	555
BSR33	—	●	—	—	BSR33		PNP	2N4033	BSR43	555
BSR40	—	●	—	—	BSR40		NPN	BSX46-6	BSR30	559
BSR41	—	●	—	—	BSR41		NPN	BSX46-16	BSR31	559
BSR42	—	●	—	—	BSR42		NPN	2N3020	BSR32	559
BSR43	—	●	—	—	BSR43		NPN	2N3019	BSR33	559
BSR56	●	—	—	—	M4		FET	2N4856		563
BSR57	●	—	—	—	M5		FET	2N4857		563
BSR58	●	—	—	—	M6		FET	2N4858		563
BSS63	●	—	—	—	T3	T6	PNP	BSS68	BSS64	567
BSS64	●	—	—	—	U3	U6	NPN	BSS38	BSS63	573
BSS83	—	—	●	—	M74		FET			577
BST15	—	●	—	—	BST15		PNP	2N5415	BST40	581
BST16	—	●	—	—	BST16		PNP	2N5416	BST39	581
BST39	—	●	—	—	BST39		NPN		BST16	585
BST40	—	●	—	—	BST40		NPN		BST15	585
BST50	—	●	—	—	BST50		NPN	BSR50		589
BST51	—	●	—	—	BST51		NPN	BSR51		589
BST52	—	●	—	—	BST52		NPN	BSR52		589
BST60	—	●	—	—	BST60		PNP	BSR60		593
BST61	—	●	—	—	BST61		PNP	BSR61		593
BST62	—	●	—	—	BST62		PNP	BSR62		593
BSV52	●	—	—	—	B2	B4	NPN	PH2369, BSX20	BSR12	597
BZV49	—	●	—	—	*		diode	BZV85		605

\* For marking of these types see page 15.

# TYPE NUMBER SURVEY

type number	SOT-23	SOT-89	SOT-143	SOD-80	marking type	reverse type	device type	nearest conventional type(s)	complement	page
BZV55	-	-	-	•			diode			615
BZX84	•	-	-	-	*		diode	BZX55, BZX79		629

\* For marking of these types see next page.

type	BZV49- SOT-89 diode nearest conventional type BZV85 series	page 605	BZX84- SOT-23 diode nearest conventional type BZX79 series	page 629
type number suffix	mark		mark	
C2V4	2Y4		Z11	
C2V7	2Y7		Z12	
C3V0	3Y0		Z13	
C3V3	3Y3		Z14	
C3V6	3Y6		Z15	
C3V9	3Y9		Z16	
C4V3	4Y3		Z17	
C4V7	4Y7		Z1	
C5V1	5Y1		Z2	
C5V6	5Y6		Z3	
C6V2	6Y2		Z4	
C6V8	6Y8		Z5	
C7V5	7Y5		Z6	
C8V2	8Y2		Z7	
C9V1	9Y1		Z8	
C10	10Y		Z9	
C11	11Y		Y1	
C12	12Y		Y2	
C13	13Y		Y3	
C15	15Y		Y4	
C16	16Y		Y5	
C18	18Y		Y6	
C20	20Y		Y7	
C22	22Y		Y8	
C24	24Y		Y9	
C27	27Y		Y10	
C30	30Y		Y11	
C33	33Y		Y12	
C36	36Y		Y13	
C39	39Y		Y14	
C43	43Y		Y15	
C47	47Y		Y16	
C51	51Y		Y17	
C56	56Y		Y18	
C62	62Y		Y19	
C68	68Y		Y20	
C75	75Y		Y21	





CONVERSION LIST

conventional to microminiature type

conventional type	microminiature type	conventional type	microminiature type	conventional type	microminiature type
BA243	BAT18	BC177B	BC857B	BC368	BC868
BA314	BAS17		BCW70	BC369	BC869
BA481	BAT17	BC178	BC858	BC546	BC846
BA482	BAT18		BCW29/30		BCV71/72
BAV19	BAS19	BC178A	BC858A	BC546A	BC846A
BAV20	BAS20		BCW29		BCV71
BAV21	BAS21	BC178B	BC858B	BC546B	BC846B
BAW62	BAS16		BCW30		BCV72
	BAV70	BC179	BC859	BC547	BC847
	BAV99		BCF29/30		BCW71/72/81
	BAW56	BC179A	BC859A	BC547A	BC847A
BB405	BBY31		BCF29		BCW71
BB809	BBY40	BC179B	BC859B	BC547B	BC847B
BC107	BC847		BCF30		BCW72
	BCW71/72	BC200/01	BC859B	BC547C	BC847C
BC107A	BC847A		BCF29		BCW81
	BCW71	BC200/02	BC859B/C	BC548	BC848
BC107B	BC847B		BCF29/30		BCW31-33
	BCW72	BC200/03	BC859C	BC548A	BC848A
BC108	BC848		BCF30		BCW31
	BCW31-33	BC327	BC807	BC548B	BC848B
BC108A	BC848A		BCX17		BCW32
	BCW31	BC327-16	BC807-16	BC548C	BC848C
BC108B	BC848B	BC327-25	BC807-25		BCW33
	BCW32	BC327-40	BC807-40	BC549	BC849
BC109	BC849	BC327A			BCF32/33
	BCF32/33	BC328	BC808	BC549B	BC849B
BC109B	BC849B		BCX18		BCF32
	BCF32	BC328-16	BC808-16	BC549C	BC849C
BC109C	BC849C	BC328-25	BC808-25		BCF33
	BCF33	BC328-40	BC808-40	BC550	BC850
BC146/01	BC849B	BC337	BC817		BCF81
	BCF32		BCX19	BC550B	BC850B
BC146/02	BC849B/C	BC337-16	BC817-16	BC550C	BC850C
	BCF32/33	BC337-25	BC817-25	BC556	BC856
BC146/03	BC849C	BC337-40	BC817-40		BCW89
	BCF33	BC338	BC818	BC556A	BC856A
BC177	BC857		BCX20		BCW89
	BCW69/70	BC338-16	BC818-16	BC556B	BC856B
BC177A	BC857A	BC338-25	BC818-25	BC557	BC857
	BCW69	BC338-40	BC818-40		BCW69/70

# CONVERSION LIST

conventional type	microminiature type	conventional type	microminiature type	conventional type	microminiature type
BC557A	BC857A BCW69	BCY56	BC850B BCF70	BF241 BF324	BF824
BC557B	BC857B BCW70	BCY57	BC849 BCF32/33	BF410A BF410B	BF510 BF511
BC557C	BC857C	BCY58	BC849 BCW60 fam.	BF410C BF410D	BF512 BF513
BC558	BC858 BCW29/30	BCY58-VII	BCW60A	BF419	BST40
BC558A	BC858A BCW29	BCY58-VIII	BC849B BCW60B	BF420	BF620 BF820
BC558B	BC858B BCW30	BCY58-IX	BC849B BCW60C	BF421	BF621 BF821
BC558C	BC858C	BCY58-X	BC849C BCW60D	BF422	BF622 BF822
BC559	BC859 BCF29/30	BCY59	BC850 BCX70 fam.	BF423	BF623 BF823
BC559A	BC859A BCF29	BCY59-VII	BCX70G	BF450	BF550
BC559B	BC859B BCF30	BCY59-VIII	BC850B BCX70H	BF451 BF457	BST40 BST40
BC559C	BC859C	BCY59-IX	BC850B BCX70J	BF458 BF459	BST40 BST39
BC560	BC860 BCF70	BCY59-X	BC850C BCX70K	BF469 BF470	BF622 BF623
BC560A	BC860A	BCY70	BC860 BCF70	BF471 BF472	BF620 BF621
BC560B	BC860B BCF70	BCY71	BC860 BCF70	BF494 BF494B	BFS19 BFS19
BC560C	BC860C	BCY72	BC859 BCF29/30	BF494C BF495	BFS19 BFS18
BC635	BCX54	BCY78	BC859 BCW61 fam.	BF495C BF495D	BFS18 BFS18
BC635-6	BCX54-6	BCY78-VII	BC859A BCW61A	BF606A BF819	BF660 BST40
BC635-10	BCX54-10	BCY78-VIII	BC859A/B BCW61B	BF857 BF858	BST40 BST40
BC635-16	BCX54-16	BCY78-IX	BC859B BCW61C	BF859 BF869	BST39 BF622
BC636	BCX51	BCY78-X	BC859C BCW61D	BF870 BF871	BF623 BF620
BC636-6	BCX51-6	BCY79	BC860 BCX71 fam.	BF872 BF926	BF621 BF660
BC636-10	BCX51-10	BCY79-VII	BC860A BCX71G	BF936 BF939	BF536
BC636-16	BCX51-16	BCY79-VIII	BC860A/B BCX71H	BF960 BF964	BF989 BF994
BC637	BCX55	BCY79-IX	BC860B BCX71J	BF966 BF967	BF996 BF767
BC637-6	BCX55-6	BF198		BF970	BF569
BC637-10	BCX55-10	BF199	BFS20	BF979	BF579
BC637-16	BCX55-16	BF240		BF980	BF990
BC638	BCX52				
BC638-6	BCX52-6				
BC638-10	BCX52-10				
BC638-16	BCX52-16				
BC639	BCX56				
BC639-6	BCX56-6				
BC639-10	BCX56-10				
BC639-16	BCX56-16				
BC640	BCX53				
BC640-6	BCX53-6				
BC640-10	BCX53-10				
BC640-16	BCX53-16				

conventional type	microminiature type	conventional type	microminiature type	conventional type	microminiature type
BF981	BF991	BSS68	BSS63	2N2368	BSV52
BF982	BF992	BSV15	BSR30/31	2N2369	BSV52
BFQ23	BFT93	BSV15-6	BSR30	2N2369A	BSV52
BFQ24	BFT93	BSV15-10	BSR30/31	2N2483	BC850B
BFQ34	BFQ18A	BSV15-16	BSR31	2N2484	BC850B/C
BFQ51	BFT92	BSV16	BSR30/31	2N2894A	BSR12
BFQ52	BFT92	BSV16-6	BSR30	2N2905	BSR15
BFR54	BSV52	BSV16-10	BSR30/31	2N2905A	BSR16
BFR90	BFR92A	BSV16-16	BSR31	2N2907	BSR15
BFR91	BFR93A	BSV17	BSR32/33	2N2907A	BSR16
BFR96	BFQ19	BSV17-6	BSR32	2N3019	BSR43
BFT24	BFT25	BSV17-10	BSR32/33	2N3020	BSR42
BFT44	BST16	BSX19	BSV52	2N3053	BSR40/41
BFT45	BST15/16	BSX20	BSV52	2N3903	BSR17
BFW11	BFR30	BSX45	BSR40/41	2N3904	BSR17A
BFW12	BFR31	BSX45-6	BSR40	2N3905	BSR18
BFW13	BFT46	BSX45-10	BSR40/41	2N3906	BSR18A
BFW16A	BFQ17	BSX45-16	BSR41	2N4030	BSR30
BFW30	BFR53	BSX46	BSR40/41	2N4031	BSR31
BFW92	BFS17	BSX46-6	BSR40	2N4032	BSR32
BFW93	BFR53	BSX46-10	BSR40/41	2N4033	BSR33
BFX29	BSR16	BSX46-16	BSR41	2N4123	BSR17
BFX30	BSR16	BSX47	BSR42/43	2B4124	BSR18
BFX84	BSR40	BSX47-6	BSR42	2N4856	BSR56
BFX85	BSR41	BSX47-10	BSR42/43	2N4857	BSR57
BFX86	BSR41	BSY95A	BSV52	2N4858	BSR58
BFX87	BSR16	BZX55	BZX84	2N5415	BST15
BFX88	BSR15	BZX79	BZX84	2N5416	BST16
BFY50	BSR40	BZV85	BZV49	BD135	BCX54
BFY51	BSR40	PH2222	BSR13	BD135-6	BCX54-6
BFY52	BSR40	PH2222A	BSR14	BD135-10	BCX54-10
BFY55	BSR40	PH2369	BSV52	BD135-16	BCX54-16
BFY90	BFS17	PH2907	BSR15	BD136	BCX51
BR101	BRY62	PH2907A	BSR16	BD136-6	BCX51-6
BRY39	BRY62	1N4148	BA516	BD136-10	BCX51-10
BRY56	BRY61		BAV70	BD136-16	BCX51-16
BSR50	BST50		BAV99	BD137	BCX55
BSR51	BST51		BAW56	BD137-6	BCX55-6
BSR52	BST52	2N929	BC850	BD137-10	BCX55-10
BSR60	BST60	2N930	BC850	BD137-16	BCX55-16
BSR61	BST61		BCF81	BD138	BCX52
BSR62	BST62	2N1613	BSR40	BD138-6	BCX52-6
BSS38	BSS64	2N1711	BSR41	BD138-10	BCX52-10
BSS50	BST50	2N1893	BSR42	BD138-16	BCX52-16
BSS51	BST51	2N2219	BSR13	BD139	BCX56
BSS52	BST52	2N2219A	BSR14	BD139-6	BCX56-6
BSS60	BST60	2N2222	BSR13	BD139-10	BCX56-10
BSS61	BST61	2N2222A	BSR14	BD139-16	BCX56-16
BSS62	BST62	2N2297	BSR40	BD140	BCX53

# CONVERSION LIST

conventional type	microminiature type	conventional type	microminiature type	conventional type	microminiature type
BD140-6	BCX53-6	BDW57	BCX55	BDX43	BST51
BD140-10	BCX53-10	BDW58	BCX52	BDX44	BST52
BD140-16	BCX53-16	BDW59	BCX56	BDX45	BST60
BDW55	BCX54	BDW60	BCX53	BDX46	BST61
BDW56	BCX51	BDX42	BST50	BDX47	BST61

## MARKING LIST

Types in SOT-23 and SOT-143 envelopes are marked with a code as listed below. The actual type number and date code are on the packing.

Types in SOT-89 usually have the type number marked in full on the envelope. An exception to this is the BZV-49 series.

mark type no.	mark type no.	mark type no.	mark type no.
A1	BAW56	BH	BCX71H
A2	BAT18	BJ	BCX71J
A3	BAT17	BK	BCX71K
A4	BAV70	C1	BCW29
A5	BRY61	C2	BCW30
A51	BRY62	C3	
A6	BAS16	C4	BCW29R
A61	BAS28	C5	BCW30R
A7	BAV99	C6	
A8	BAS19	C7	BCF29
A81	BAS20	C77	BCF29R
A82	BAS21	C8	BCF30
A9		C9	BCF30R
A91	BAS17	C91	BCV62
AA	BCW60A	D1	BCW31
AB	BCW60B	D2	BCW32
AC	BCW60C	D3	BCW33
AD	BCW60D	D4	BCW31R
AG	BCX70G	D5	BCW32R
AH	BCX70H	D6	BCW33R
AJ	BCX70J	D7	BCF32
AK	BCX70K	D77	BCF32R
B1		D8	BCF33
B2	BSV52	D81	BCF33R
B3		D91	BCV61
B4	BSV52R	E1	BFS17
B5	BSR12	E2	
B6		E3	
B7		E4	BFS17R
B8	BSR12R	E5	
BA	BCW61A	E6	
BB	BCW61B	E7	
BC	BCW61C	E8	
BD	BCW61D	E9	
BG	BCX71G	F1	BFS18
		F2	BFS19
		F3	
		F4	BFS18R
		F5	BFS19R
		F6	
		F7	
		F8	BF824
		F9	
		G1	BFS20
		G2	BF550
		G3	BF536
		G4	BFS20R
		G5	BF550R
		G6	BF569
		G7	BF579
		G8	BF660
		G81	BF660R
		G9	BF767
		H1	BCW69
		H2	BCW70
		H3	BCW89
		H31	BCW89R
		H4	BCW69R
		H5	BCW70R
		H6	
		H7	BCF70
		H71	BCF70R
		H8	
		H9	
		K1	BCW71
		K2	BCW72
		K3	BCW81
		K31	BCW81R
		K4	BCW71R
		K5	BCW72R
		K6	
		K7	BCV71
		K71	BCV71R
		K8	BCV72
		K81	BCV72R
		K9	BCF81
		K91	BCF81R
		L20	BAS29
		L21	BAS31
		L22	BAS35
		L30	BAV23
		M1	BFR30
		M2	BFR31
		M3	BFT46
		M31	BSD20
		M32	BSD22
		M4	BSR56
		M5	BSR57
		M6	BSR58
		M74	BSS83
		M8	
		M89	BF989
		M9	
		M90	BF990
		M91	BF991
		M92	BF992
		M94	BF994
		M96	BF996
		M97	BFR101A
		M98	BFR101B
		N1	BFR53
		N2	
		N3	
		N4	BFR53R
		N5	

# MARKING

mark type no.	mark type no.	mark type no.	mark type no.
N6	U1 BCX19	Y5 BZX84-C16	1K BC848B
N7	U2 BCX20	Y6 -C18	1KR BC848BR
N8	U3 BSS64	Y7 -C20	1L BC848C
N9	U4 BCX19R	Y8 -C22	1LR BC848CR
P1 BFR92	U5 BCX20R	Y9 -C24	1V BF820
P2 BFR92A	U6 BSS64R	Y10 BZX84-C27	1W BF821
P3	U7 BSR13	Y11 -C30	1X BF822
P4 BFR92R	U71 BSR13R	Y12 -C33	1Y BF823
P5 BFR92AR	U8 BSR14	Y13 -C36	2B BC849B
P6	U81 BSR14R	Y14 -C39	2BR BC849BR
P7	U9 BSR17	Y15 BZX84-C43	2C BC849C
P8	U91 BSR17R	Y16 -C47	2CR BC849CR
P9	U92 BSR17A	Y17 -C51	2F BC850B
R1 BFR93	U93 BSR17AR	Y18 -C56	2FR BC850BR
R2 BFR93A	V1	Y19 -C62	2G BC850C
R3	V2	Y20 BZX84-C68	2GR BC850CR
R4 BFR93R	V3	Y21 -C75	2Y4 BZV49-C2V4
R5 BFR93AR	V4 BFT25R	Z1 BZX84-C4V7	2Y7 BZV49-C2V7
R6	V5	Z2 -C5V1	3A BC856A
R7	V6	Z3 -C5V6	3AR BC856AR
R8	V7	Z4 BZX84-C6V2	3B BC856B
R9	V8	Z5 -C6V8	3BR BC856BR
S1 BBY31	V9	Z6 -C7V5	3E BC857A
S2 BBY40	W1 BFT92	Z7 -C8V2	3ER BC857AR
S3	W2	Z8 -C9V1	3F BC857B
S4	W3	Z9 BZX84-C10	3FR BC857BR
S5	W4 BFT92R	Z11 -C2V4	3J BC858A
S6 BF510	W5	Z12 -C2V7	3JR BC858AR
S7 BF511	W6	Z13 -C3V0	3G BC857C
S8 BF512	W7	Z14 -C3V3	3GR BC857CR
S9 BF513	W8	Z15 BZX84-C3V6	3K BC858B
T1 BCX17	W9	Z16 -C3V9	3KR BC858BR
T2 BCX18	X1 BFT93	Z17 -C4V3	3L BC858C
T3 BSS63	X2	1A BC846A	3LR BC858CR
T4 BCX17R	X3	1AR BC846AR	3Y0 BZV49-C3V0
T5 BCX18R	X4 BFT93R	1B BC846B	3Y3 BZV49-C3V3
T6 BSS63R	X5	1BR BC846BR	3Y6 BZV49-C3V6
T7 BSR15	X6	1E BC847A	3Y9 BZV49-C3V9
T71 BSR15R	X7	1ER BC847AR	4A BC859A
T8 BSR16	X8	1F BC847B	4AR BC859AR
T81 BSR16R	X9	1FR BC847BR	4B BC859B
T9 BSR18	Y1 BZX84-C11	1G BC847C	4BR BC859BR
T91 BSR18R	Y2 -C12	1GR BC847CR	4C BC859C
T92 BSR18A	Y3 -C13	1J BC848A	4CR BC859CR
T93 BSR18AR	Y4 -C15	1JR BC848AR	4E BC860A

mark type no.		mark type no.		mark type no.		mark type no.	
4ER	BC860AR	5F	BC808-25	6FR	BC818-25R	20Y	BZV49-C20
4F	BC860B	5FR	BC808-25R	6G	BC818-40	22Y	-C22
4FR	BC860BR	5G	BC808-40	6GR	BC818-40R	24Y	-C24
4G	BC860C	5GR	BC808-40R	6Y2	BZV49-C6V2	27Y	-C27
4GR	BC860CR	5Y1	BZV49-C5V1	6Y8	-C6V8	30Y	-C30
4Y3	BZV49-C4V3	5Y6	BZV49-C5V6	7Y5	BZV49-C7V5	33Y	BZV49-C33
4Y7	BZV49-C4V7	6A	BC817-16	8Y2	-C8V2	36Y	-C36
5A	BC807-16	6AR	BC817-16R	9Y1	-C9V1	39Y	-C39
5AR	BC807-16R	6B	BC817-25	10Y	-C10	43Y	-C43
5B	BC807-25	6BR	BC817-25R	11Y	-C11	47Y	-C47
5BR	BC807-25R	6C	BC817-40	12Y	BZV49-C12	51Y	BZV49-C51
5C	BC807-40	6CR	BC817-40R	13Y	-C13	56Y	-C56
5CR	BC807-40R	6E	BC818-16	15Y	-C15	62Y	-C62
5E	BC808-16	6ER	BC818-16R	16Y	-C16	68Y	-C68
5ER	BC808-16R	6F	BC818-25	18Y	-C18	75Y	-C75





## TAPE AND REEL SPECIFICATION

Semiconductors in SOT-23 and SOT-143 encapsulations can be delivered in reel packing for automatic placement on hybrid circuits and printed circuit boards. The devices are placed with the mounting side downwards in compartments.

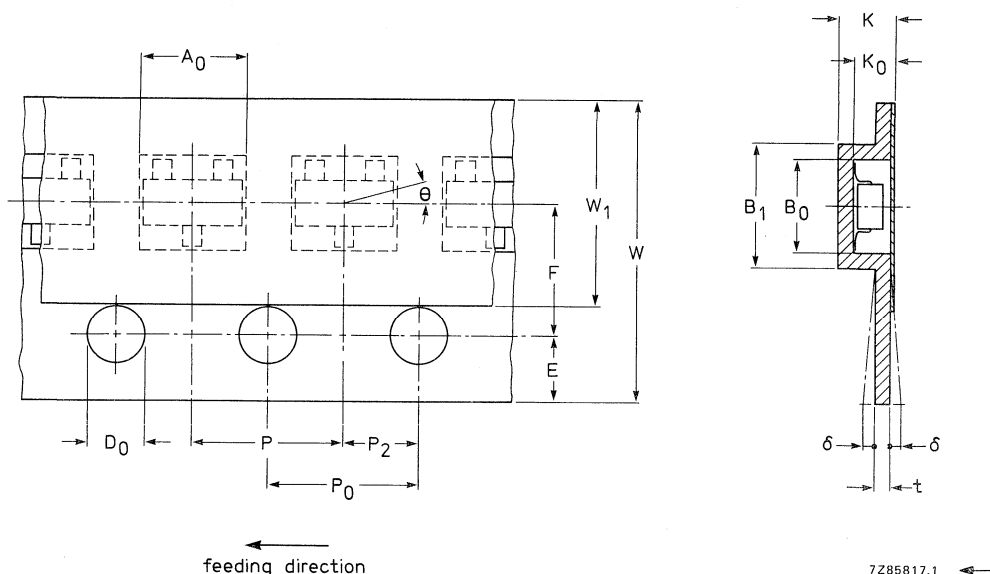
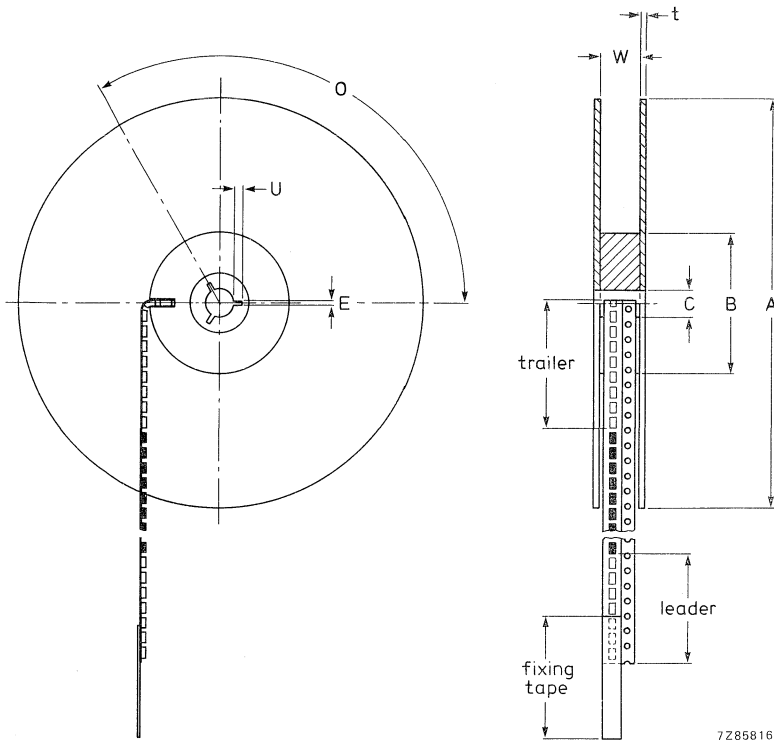


Fig. 1 Configuration of bandolier. Dimensions in mm.

<b>Compartment</b>			tol.	<b>Centre line dimensions</b>			tol.
length	$A_0$	component length	+0,2	length direction	$P_2$	2,0	$\pm 0,05$
width	$B_0$	component width	+0,2	width direction	$F$	3,5	$\pm 0,05$
depth	$K_0$		0,95 +0,2	<b>Fixing tape</b>			
width outside	$B_1$		3,3 max.	width	$W_1$	5,5	$\pm 0,25$
pitch	$P$		4,0 $\pm 0,1$	thickness	—	0,1	max.
deviation	$\Theta$		15° max.	<b>Carrier tape</b>			
<b>Sprocket hole</b>				width	$W$	8,0	$\pm 0,2$
diameter	$D_0$		1,5 +0,1	bending	$\delta$	0,3	max.
pitch	$P_0$		4,0 $\pm 0,1$	thickness	$t$	0,4	max.
distance	$E$		1,75 $\pm 0,1$	<b>Overall thickness</b>	$K$	1,5	max.
cumulative (10)							
pitch error			$\pm 0,1$				



7Z85816

Fig. 2 Configuration of reel and flange (dimensions in mm).

Flange			tol.	Hub			tol.
diameter	A	180	+0 -2	diameter	B	62	± 1,5
thickness	t	1,5	+0,5 -0,1	spindle hole	C	12,75	+0,15 -0
space between flanges	W	9,5	± 0,5	key slit			
				width	E	2	± 0,5
				depth	U	4	± 0,5
				location	O	120	degrees

**Amount of devices per reel**

The bandolier of a 180 mm reel contains at least 3000 devices with no more than 15 empty compartments (0,5%). Three consecutive empty places might be found provided this gap is followed by 6 consecutive devices.

The carrier tape (leader) starts with at least 75 empty positions (equivalent to 300 mm); the covering foil is at least 300 mm. In order to fix the carrier tape is self-adhesive tape of 20 to 50 mm is applied.

At the end of the bandolier (trailer) at least 75 empty positions (equivalent to a length of 300 mm) and 300 mm foil. For fixing onto the reel a self-adhesive tape of 20 to 50 mm is applied.

## SOLDERING RECOMMENDATIONS

### SOT-23, SOT-143 AND SOT-89 ENVELOPES

SOT-23, SOT-143 and SOT-89 devices are ideally suited for placement onto thick and thin film substrates and printed circuit boards.

To assure reliable and consistent connections particular attention should be paid to:

#### 1. Flux

A non-active flux is recommended. Where active fluxes are employed, great care in subsequent substrate cleaning must be exercised.

#### 2. Metal-alloy solder or solder paste

Correct choice of solder alloy or solder paste to be employed e.g. 62% Sn, 36% Pb, 2% Ag or 60% Sn/40% Pb. Any paste used should contain at least 85% metal dry weight.

#### 3. Soldering temperature

This will vary according to the actual method employed.

### REFLOW SOLDERING

The preferred technique for mounting microminiature components on hybrid thick and thin-film is the method of reflow soldering.

The tags of SOT-23, SOT-143 and SOT-89 envelopes are pre-tinned and the best results are obtained if a similar solder is applied to the corresponding soldering areas on the substrate. This can be done by either dipping the substrate in a solder bath or by screen printing a solder paste.

The maximum temperature of the leads or tab during the soldering cycle should not exceed 285 °C. The most economic method of soldering is a process in which all different components are soldered simultaneously for example SOT-23, SOT-143 or SOT-89 devices, capacitors and resistors.

Having first been fluxed, all components are positioned on the substrate. The slight adhesive force of the flux is sufficient to keep the components in place. Solder paste contains a flux and has therefore good inherent adhesive properties which eases positioning of the components.

With the components in position the substrate is heated to a point where the solder begins to flow. This can be done on a heating plate or on a conveyor belt running through an infrared tunnel. The maximum allowed temperature of the plastic body of a device must be kept below 280 °C during the soldering cycle. For further temperature behaviour during the soldering process see Figs 2 and 3.

The surface tension of the liquid solder tends to draw the tags of the device towards the centre of the soldering area and has thus a correcting effect on slight mispositionings. However, if the layout leaves something to be desired the same effect can result in undesirable shifts; particularly if the soldering areas on the substrate and the components are not concentrically arranged. This problem can be solved using a standard contact pattern, which leaves sufficient scope for the self-positioning effect (see Figs 4 and 5).

After cooling the connections may be visually inspected and, where necessary, repaired with a light soldering iron. Finally any remaining flux must be removed carefully.

### IMMERSION SOLDERING

Where a complete substrate or printed circuit board is immersed in solder:

- a. The temperature of the soldering bath should not exceed 280 °C.
- b. The duration of the soldering cycle should not exceed 10 seconds.
- c. Forced cooling may be applied (see Fig. 1).

### HAND SOLDERING

It is possible to solder microminiature devices with a light hand-held soldering iron, but this method has obvious drawbacks and should therefore be restricted to laboratory use and/or incidental repairs on production circuits.

1. It is time-consuming and expensive.
2. The device cannot be positioned accurately and therefore the connecting tags may come into contact with the substrate and damage it.
3. There is a great risk of breaking either substrate or even internal connections inside the encapsulation.
4. The envelope may be damaged by the iron.

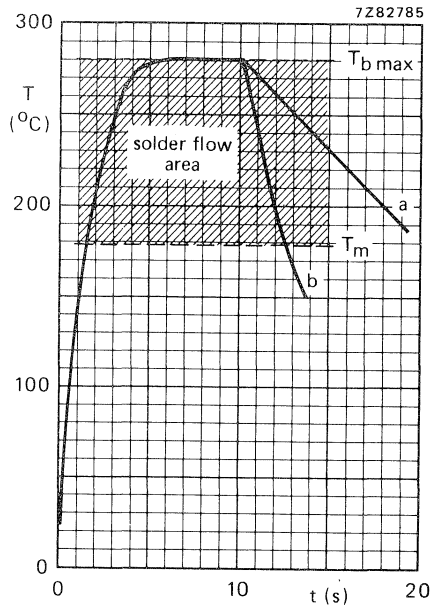


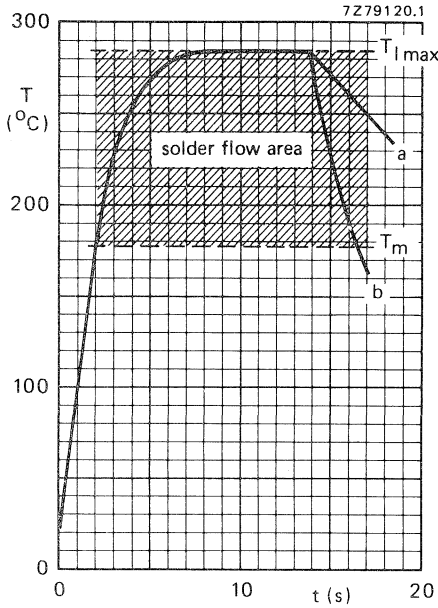
Fig. 1 Device temperature during *immersion* soldering.

Maximum time of immersion in soldering bath is 10 seconds at an ambient temperature of 25 °C.

a = free convection cooling; b = forced cooling.

$T_{b \text{ max}}$  = maximum bath temperature (280 °C).

$T_m$  = melting temperature of solder (179 °C).



- a = free convection cooling.
- b = permissible forced cooling.
- $T_{l\ max}$  = Maximum lead or tab temperature = 285 °C.
- $T_m$  = Melting point of the solder is 179 °C.
- $T_{amb}$  = 25 °C.

Time of heat supply:  
without preheating max. 14 s  
with preheating max. 10 s  
Maximum time of preheating 45 s

Fig. 2 Reflow soldering without preheating.

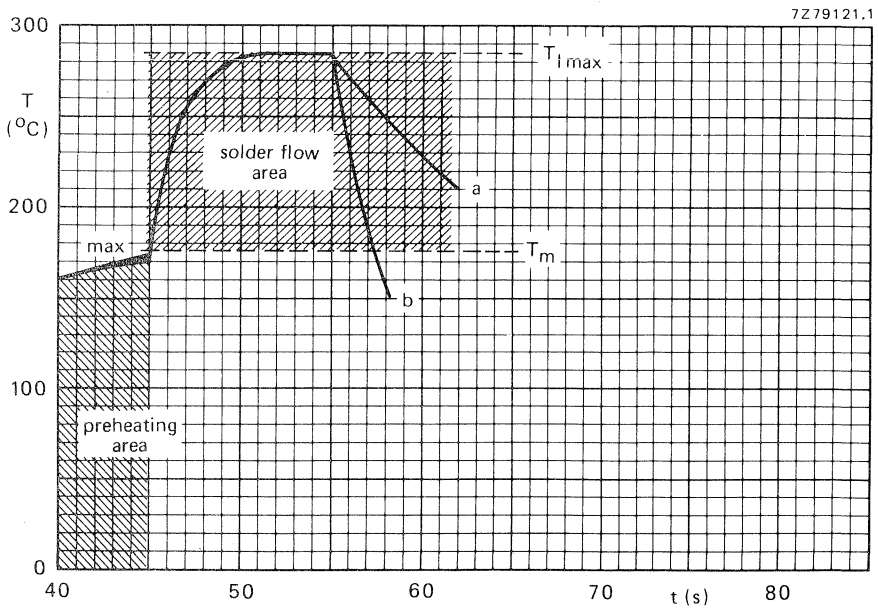


Fig. 3 Reflow soldering with preheating.

Minimum required dimensions of metal connection pads on hybrid thick and thin-film substrates.

Dimensions in mm

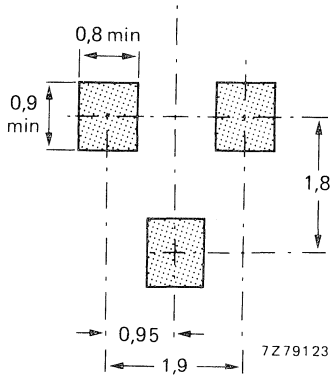


Fig. 4 SOT-23 pattern.

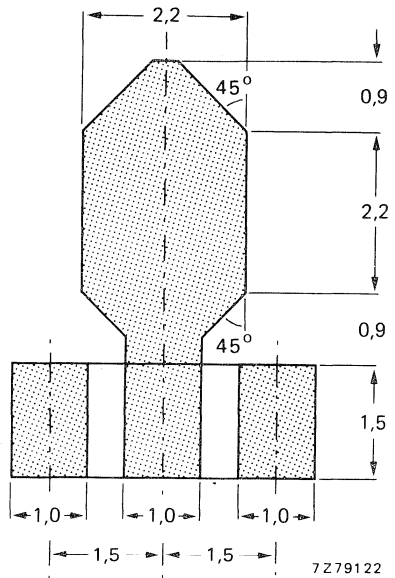


Fig. 5 SOT-89 pattern.

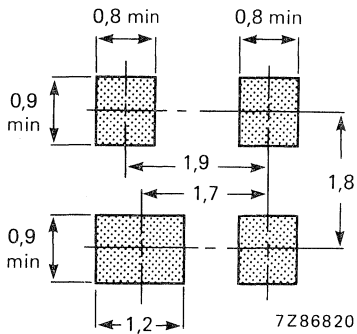


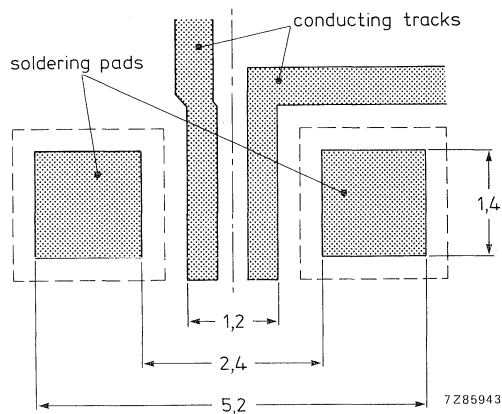
Fig. 6 SOT-143 pattern.

## SOLDERING RECOMMENDATIONS SOD-80 ENVELOPE

The layout shown below is intended for use with mounting of diodes having a SOD-80 envelope onto a printed circuit board in those cases where the diode is glued to the p.c. board first and soldered afterwards.

The dimensions given may be smaller if the diode in question is not fixed to the substrate prior to soldering. The position of the SOD-80 device is then self-adjusted during the soldering process.

Dimensions in mm







## THERMAL CHARACTERISTICS OF SOT-23 AND SOT-143 ENVELOPES

The heat generated in a semiconductor chip normally flows by various paths to the surroundings (ambient).

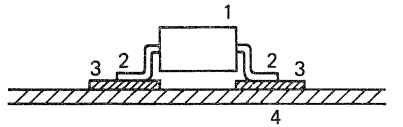
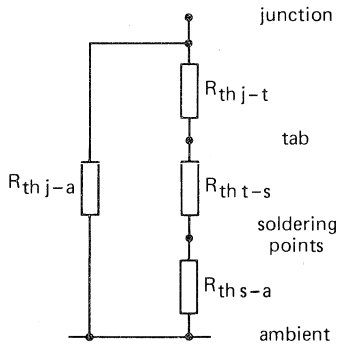


Fig. 1.

7Z89072.A

1. Heat radiation from the envelope to ambient (1).  
This heat transfer can be neglected when the envelope is mounted on a substrate or printed circuit board.
2. Heat transmission via leads (2) soldering points (3) and substrate (4).



7Z89073

Fig. 2 Thermal behaviour of heat flow when the device is mounted on a substrate or printed circuit board.

- $R_{th\ j-t}$  = Thermal resistance from junction to tab.
- $R_{th\ t-s}$  = Thermal resistance from tab to soldering points.
- $R_{th\ s-a}$  = Thermal resistance from soldering points to ambient.
- $R_{th\ j-a}$  = Thermal resistance from junction to ambient.

**Heat transfer directly from envelope to ambient**

This depends on the difference between the temperatures of envelope and the surroundings. When the device is mounted on a substrate or printed circuit board direct heat flow can usually be neglected in relation to the heat flow via leads and substrate. Thus the thermal model can be as in Fig. 3.

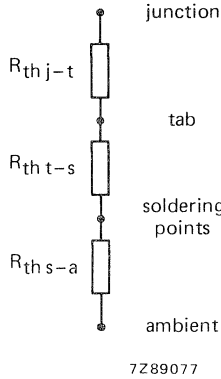


Fig. 3 Basic thermal model.

**Heat transfer from junction to tab**

This is an internal heat transfer and has been measured. In general it is:

- for high-frequency transistors, low-power diodes and (MOS) FETs
- for low-frequency and switching transistors
- for low-frequency medium-power transistors

- 60 K/W
- 50 K/W
- 30 K/W

**Heat transfer from tab to soldering points**

This value has also been measured for SOT-23 with  $P_{tot} < 350\text{ mW}$   
 for types of semiconductors in this envelope with  $P_{tot} < 425\text{ mW}$   
 for types of semiconductors in a SOT-143 envelope this value is

- 280 K/W
- 260 K/W
- 310 K/W

**Heat transfer from soldering points to ambient**

This depends on the shape and material of tracks and substrate. In figures 4 and 5 standard mounting conditions are given to set up the maximum power ratings for SOT-23 and SOT-143 encapsulations.

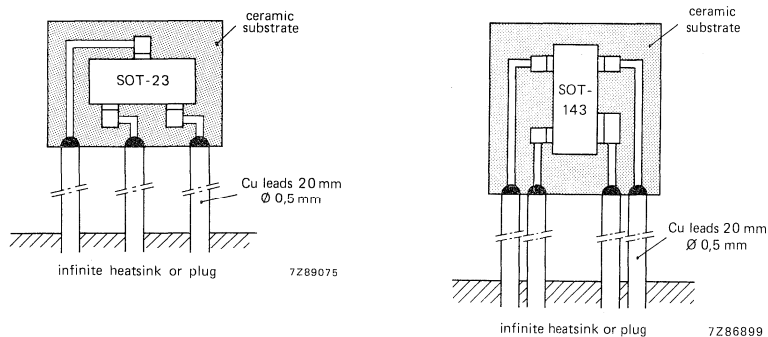


Fig. 4 Test circuits SOT-23 and SOT-143 mounting conditions on a ceramic substrate.

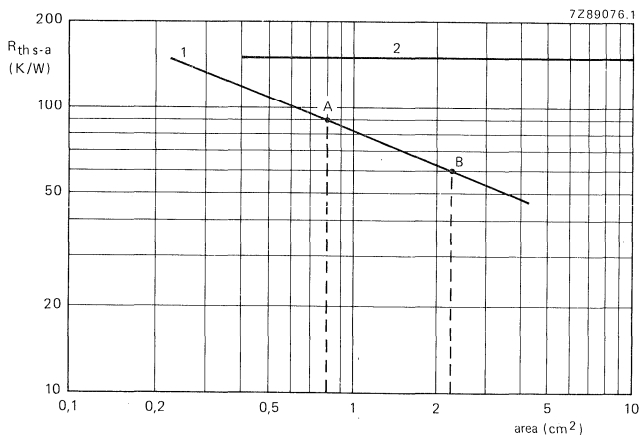


Fig. 5 Heat transfer from soldering points to ambient.

**1. Ceramic substrate**

Point A on the curve in Fig. 5 is for an area of the ceramic substrate of 8 mm x 10 mm x 0,7 mm for the maximum rating of all high-frequency, low-frequency and switching transistors and also for all diodes.

Point B on the curve in Fig. 5 is for an area of the ceramic substrate of 15 mm x 15 mm x 0,7 mm for the maximum rating of low-frequency medium-power semiconductors.

**2. Printed circuit board**

$R_{th\ s-a} = 150\ K/W$  for SOT-23 and SOT-143 envelopes mounted on a printed circuit board.

The values for the thermal resistance from junction to tab, and tab to soldering points, are given earlier and in Fig. 5.

The formula for devices in SOT-23 with one crystal can be generalized:

$$T_j = P (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

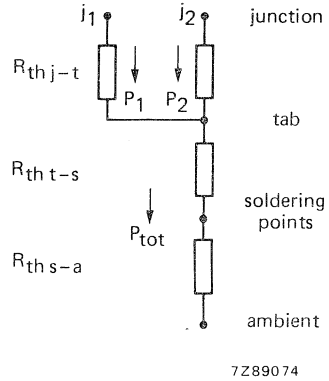
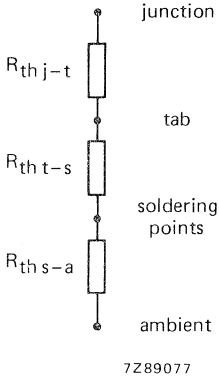


Fig. 6 Thermal model of SOT-23 envelopes with one crystal.

Fig. 7 Thermal model of SOT-23 envelopes with two crystals (double diode).

The formulae for devices with two crystals (double diodes) are:

$$T_{tab} = P_{tot} \cdot (R_{th\ t-s} + R_{th\ s-a}) + T_{amb} = P_{tot} (280 + 90) + T_{amb}$$

$$T_{j1} = (P_1 \times R_{th\ j-t}) + T_{tab} = P_1 \cdot 60 + T_{tab}$$

$$T_{j2} = (P_2 \times R_{th\ j-t}) + T_{tab} = P_2 \cdot 60 + T_{tab}$$

As mentioned on page 2:

$R_{th\ j-t}$  for diodes is 60 K/W.

$R_{th\ s-a}$  (area 8 mm x 10 mm x 0,7 mm) = 90 K/W.

$R_{th\ t-s}$  for all semiconductors in SOT-23 = 280 K/W.

Thus:

$$T_{j1} = 60 P_1 + 370 P_{tot} + T_{amb}$$

$$T_{j2} = 60 P_2 + 370 P_{tot} + T_{amb}$$

PRO ELECTRON TYPE DESIGNATION CODE  
FOR SEMICONDUCTOR DEVICES

This type designation code applies to discrete semiconductor devices — as opposed to integrated circuits —, multiples of such devices and semiconductor chips.

“Although not all type numbers accord with the Pro Electron system, the following explanation is given for the ones that do.”

A basic type number consists of:

*TWO LETTERS FOLLOWED BY A SERIAL NUMBER*

**FIRST LETTER**

The first letter gives information about the material used for the active part of the devices.

- A. GERMANIUM or other material with band gap of 0,6 to 1,0 eV.
- B. SILICON or other material with band gap of 1,0 to 1,3 eV.
- C. GALLIUM-ARSENIDE or other material with band gap of 1,3 eV or more.
- R. COMPOUND MATERIALS (e.g. Cadmium-Sulphide).

**SECOND LETTER**

The second letter indicates the function for which the device is primarily designed.

- A. DIODE; signal, low power
- B. DIODE; variable capacitance
- C. TRANSISTOR; low power, audio frequency ( $R_{th j-mb} > 15 \text{ }^{\circ}\text{C/W}$ )
- D. TRANSISTOR; power, audio frequency ( $R_{th j-mb} \leq 15 \text{ }^{\circ}\text{C/W}$ )
- E. DIODE; tunnel
- F. TRANSISTOR; low power, high frequency ( $R_{th j-mb} > 15 \text{ }^{\circ}\text{C/W}$ )
- G. MULTIPLE OF DISSIMILAR DEVICES — MISCELLANEOUS; e.g. oscillator
- H. DIODE; magnetic sensitive
- L. TRANSISTOR; power, high frequency ( $R_{th j-mb} \leq 15 \text{ }^{\circ}\text{C/W}$ )
- N. PHOTO-COUPLER
- P. RADIATION DETECTOR; e.g. high sensitivity phototransistor
- Q. RADIATION GENERATOR; e.g. light-emitting diode (LED)
- R. CONTROL AND SWITCHING DEVICE; e.g. thyristor, low power ( $R_{th j-mb} > 15 \text{ }^{\circ}\text{C/W}$ )
- S. TRANSISTOR; low power, switching ( $R_{th j-mb} > 15 \text{ }^{\circ}\text{C/W}$ )
- T. CONTROL AND SWITCHING DEVICE; e.g. thyristor, power ( $R_{th j-mb} \leq 15 \text{ }^{\circ}\text{C/W}$ )
- U. TRANSISTOR; power, switching ( $R_{th j-mb} \leq 15 \text{ }^{\circ}\text{C/W}$ )
- X. DIODE: multiplier, e.g. varactor, step recovery
- Y. DIODE; rectifying, booster
- Z. DIODE; voltage reference or regulator (transient suppressor diode, with third letter R)

## SERIAL NUMBER

Three figures, running from 100 to 999, for devices primarily intended for consumer equipment.\*  
One letter (Z, Y, X, etc.) and two figures, running from 10 to 99, for devices primarily intended for industrial/professional equipment.\*

This letter has no fixed meaning except W, which is used for transient suppressor diodes.

## VERSION LETTER

It indicates a minor variant of the basic type either electrically or mechanically. The letter never has a fixed meaning, except letter R, indicating reverse voltage, e.g. collector to case or anode to stud.

## SUFFIX

Sub-classification can be used for devices supplied in a wide range of variants called associated types. Following sub-coding suffixes are in use:

### 1. VOLTAGE REFERENCE and VOLTAGE REGULATOR DIODES: *ONE LETTER and ONE NUMBER*

The LETTER indicates the nominal tolerance of the Zener (regulation, working or reference) voltage

- A. 1% (according to IEC 63: series E96)
- B. 2% (according to IEC 63: series E48)
- C. 5% (according to IEC 63: series E24)
- D. 10% (according to IEC 63: series E12)
- E. 20% (according to IEC 63: series E6)

The number denotes the typical operating (Zener) voltage related to the nominal current rating for the whole range.

The letter 'V' is used instead of the decimal point.

### 2. TRANSIENT SUPPRESSOR DIODES: *ONE NUMBER*

The NUMBER indicates the maximum recommended continuous reversed (stand-off) voltage  $V_R$ . The letter 'V' is used as above.

### 3. CONVENTIONAL and CONTROLLED AVALANCHE RECTIFIER DIODES and THYRISTORS: *ONE NUMBER*

The NUMBER indicates the rated maximum repetitive peak reverse voltage ( $V_{RRM}$ ) or the rated repetitive peak off-state voltage ( $V_{DRM}$ ), whichever is the lower. Reversed polarity is indicated by letter R, immediately after the number.

### 4. RADIATION DETECTORS: *ONE NUMBER*, preceded by a hyphen (-)

The NUMBER indicates the depletion layer in  $\mu\text{m}$ . The resolution is indicated by a version LETTER.

### 5. ARRAY OF RADIATION DETECTORS and GENERATORS: *ONE NUMBER*, preceded by a stroke (/).

The NUMBER indicates how many basic devices are assembled into the array.

\* When these serial numbers are exhausted the serial number for consumer types may be extended to four figures, and that for industrial types to three figures.

## RATING SYSTEMS

The rating systems described are those recommended by the International Electrotechnical Commission (IEC) in its Publication 134.

### DEFINITIONS OF TERMS USED

*Electronic device.* An electronic tube or valve, transistor or other semiconductor device.

#### Note

This definition excludes inductors, capacitors, resistors and similar components.

*Characteristic.* A characteristic is an inherent and measurable property of a device. Such a property may be electrical, mechanical, thermal, hydraulic, electro-magnetic, or nuclear, and can be expressed as a value for stated or recognized conditions. A characteristic may also be a set of related values, usually shown in graphical form.

*Bogey electronic device.* An electronic device whose characteristics have the published nominal values for the type. A bogey electronic device for any particular application can be obtained by considering only those characteristics which are directly related to the application.

*Rating.* A value which establishes either a limiting capability or a limiting condition for an electronic device. It is determined for specified values of environment and operation, and may be stated in any suitable terms.

#### Note

Limiting conditions may be either maxima or minima.

*Rating system.* The set of principles upon which ratings are established and which determine their interpretation.

#### Note

The rating system indicates the division of responsibility between the device manufacturer and the circuit designer, with the object of ensuring that the working conditions do not exceed the ratings.

### ABSOLUTE MAXIMUM RATING SYSTEM

Absolute maximum ratings are limiting values of operating and environmental conditions applicable to any electronic device of a specified type as defined by its published data, which should not be exceeded under the worst probable conditions.

These values are chosen by the device manufacturer to provide acceptable serviceability of the device, taking no responsibility for equipment variations, environmental variations, and the effects of changes in operating conditions due to variations in the characteristics of the device under consideration and of all other electronic devices in the equipment.

The equipment manufacturer should design so that, initially and throughout life, no absolute maximum value for the intended service is exceeded with any device under the worst probable operating conditions with respect to supply voltage variation, equipment component variation, equipment control adjustment, load variations, signal variation, environmental conditions, and variations in characteristics of the device under consideration and of all other electronic devices in the equipment.

## DESIGN MAXIMUM RATING SYSTEM

Design maximum ratings are limiting values of operating and environmental conditions applicable to a bogey electronic device of a specified type as defined by its published data, and should not be exceeded under the worst probable conditions.

These values are chosen by the device manufacturer to provide acceptable serviceability of the device, taking responsibility for the effects of changes in operating conditions due to variations in the characteristics of the electronic device under consideration.

The equipment manufacturer should design so that, initially and throughout life, no design maximum value for the intended service is exceeded with a bogey device under the worst probable operating conditions with respect to supply voltage variation, equipment component variation, variation in characteristics of all other devices in the equipment, equipment control adjustment, load variation, signal variation and environmental conditions.

## DESIGN CENTRE RATING SYSTEM

Design centre ratings are limiting values of operating and environmental conditions applicable to a bogey electronic device of a specified type as defined by its published data, and should not be exceeded under normal conditions.

These values are chosen by the device manufacturer to provide acceptable serviceability of the device in average applications, taking responsibility for normal changes in operating conditions due to rated supply voltage variation, equipment component variation, equipment control adjustment, load variation, signal variation, environmental conditions, and variations in the characteristics of all electronic devices.

The equipment manufacturer should design so that, initially, no design centre value for the intended service is exceeded with a bogey electronic device in equipment operating at the stated normal supply voltage.



## TRANSISTOR RATINGS

The ratings are presented as voltage, current, power and temperature ratings. The list of these ratings and their definitions is given as follows:

### Transistor voltage ratings

#### Collector to base voltage ratings

$V_{CBmax}$  The maximum permissible instantaneous voltage between collector and base terminals. The collector voltage is negative with respect to base in PNP transistors and positive with respect to base in NPN types.

$V_{CBmax} (I_E = 0)$  The maximum permissible instantaneous voltage between collector and base terminals, when the emitter terminal is open circuited.

#### Emitter to base voltage ratings

$V_{EBmax}$  The maximum permissible instantaneous reverse voltage between emitter and base terminal. The emitter voltage is negative with respect to base for PNP transistor and positive with respect to base for NPN types.

$V_{EBmax} (I_C = 0)$  The maximum permissible instantaneous reverse voltage between emitter and base terminals when the collector terminal is open circuited.

#### Collector to emitter voltage ratings

$V_{CEmax}$  The maximum permissible instantaneous voltage between collector and emitter terminals. The collector voltage is negative with respect to emitter in PNP transistors and positive with respect to emitter in NPN types. This rating is very dependent on circuit conditions and collector current and it is necessary to refer to the curve of  $V_{CE}$  versus  $I_C$  for the appropriate circuit condition in order to obtain the correct rating.

$V_{CEmax} (Cut-off)$  The maximum permissible instantaneous voltage between collector and emitter terminals when the emitter current is reduced to zero by means of a reverse emitter base voltage, i.e. the base voltage is normally positive with respect to emitter for PNP transistor and negative with respect to emitter for NPN types.

NOTE: The term "cut-off" is sometimes replaced by  $V_{BE} > x$  volts, or  $\frac{R_B}{R_E} \leq y$  which are equivalent conditions under which the device may be cut-off.

$V_{CEmax} (I_C = x \text{ mA})$  The maximum permissible instantaneous voltage between collector and emitter terminals when the collector current is at a high value, often the max. rated value.

$V_{CEmax} (I_B = 0)$  The maximum permissible instantaneous voltage between collector and emitter terminals when the base terminal is open circuited or when a very high resistance is in series with the base terminal. Special care must be taken to ensure that thermal runaway due to excessive collector leakage current does not occur in this condition.

Due to the current dependency of  $V_{CE}$  it is usual to present this information as a voltage rating chart which is a curve of collector current versus collector to emitter voltage (see Fig. 1).

# TRANSISTOR RATINGS

This curve is divided into two areas:

A permissible area of operation under all conditions of base drive provided the dissipation rating is not exceeded (area 1) and an area where operation is allowable under certain specified conditions (area 2). To assist in determining the rating in this second area, further curves are provided relating the voltage rating to external circuit conditions, for example:

$$\frac{R_B}{R_E}, R_B, Z_{Bg}, V_{BE}, I_B \text{ or } \frac{V_{BB}}{R_B}.$$

An example of this type of curve is given in Fig. 2 as  $V_{CE}$  versus  $\frac{R_B}{R_E}$  for two different values of collector current.

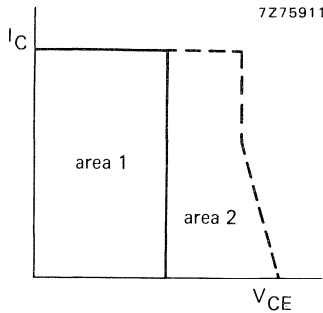


Fig. 1.

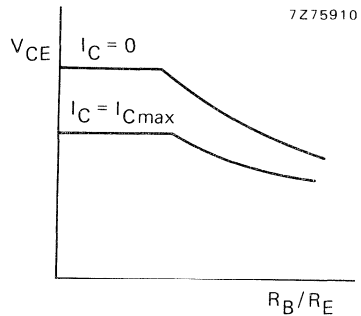


Fig. 2.

It should be noted that when  $R_E$  is shunted by a capacitor, the collector voltage  $V_{CE}$  during switching must be restricted to a value which does not rely on the effect of  $R_E$ . In the case of an inductive load and when an energy rating is given, it may be permissible to operate outside the rated area provided the specified energy rating is not exceeded.

## Transistor current ratings

### Collector current ratings

- $I_{Cmax}$  The maximum permissible collector current. Without further qualification, the d.c. value is implied.
- $I_C(AV)_{max}$  The maximum permissible average value of the total collector current
- $I_{CM}$  The maximum permissible instantaneous value of the total collector current.

### Emitter current ratings

- $I_{Emax}$  The maximum permissible emitter current. Without further qualification, the d.c. value is implied.
- $I_E(AV)_{max}$  The maximum permissible average value of the total emitter current.
- $I_{ER(AV)_{max}}$  The maximum permissible average value of the total emitter current when operating in the reverse emitter-base breakdown region.
- $I_{EM}$  The maximum permissible instantaneous value of the total emitter current.
- $I_{ERM}$  The maximum permissible instantaneous value of the total reverse emitter current allowable in the reverse breakdown region.

Base current ratings

$I_{Bmax}$	The maximum permissible base current. Without further qualification, the d.c. value is implied.
$I_{B(AV)max}$	The maximum permissible average value of the total base current.
$I_{BR(AV)max}$	The maximum permissible average value of the total reverse base current allowable in the reverse breakdown region.
$I_{BM}$	The maximum permissible instantaneous value of the total base current. The rating also includes the switch off current.
$I_{BRM}$	The maximum permissible instantaneous value of the total reverse current allowable in the reverse breakdown region.

Transistor power ratings

$P_{tot}$  max: The total maximum permissible continuous power dissipation in the transistor and includes both the collector-base dissipation and the emitter-base dissipation. Under steady state conditions the total power is given by the expression:

$$P_{tot} = V_{CE} \times I_C + V_{BE} \times I_B$$

In order to distinguish between "steady state" and "pulse" conditions the terms "steady state power ( $P_S$ )" and "pulse power ( $P_P$ )" are often used. The permissible total power dissipation is dependent upon temperature and its relationship is shown by means of a chart as shown in Fig. 3.

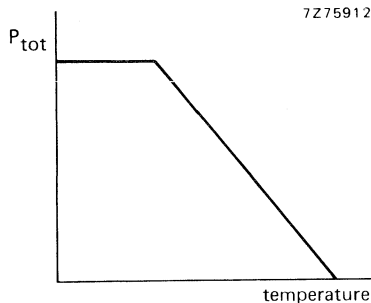


Fig. 3.

The temperature may be ambient, case or mounting base temperatures. Where a cooling clip or a heatsink is attached to the device, the allowable power dissipation is also dependent on the efficiency of the heatsink.

The efficiency of this clip or heatsink is measured in terms of its thermal resistance ( $R_{thh}$ ) normally expressed in degrees kelvin per watt (K/W). For mounting base rated devices, the added effect of the contact resistance ( $R_{thj}$ ) must be taken into account.

The effect of heatsinks of various thermal resistance and contact resistance is often included in the above chart.

# TRANSISTOR RATINGS

Thus for any heatsink of known thermal resistance and any given ambient temperature, the maximum permissible power dissipation can be established. Alternatively, knowing the power dissipation which will occur and the ambient temperature, the necessary heatsink thermal resistance can be calculated.

A general expression from which the total permissible steady state power dissipation can be calculated is:

$$P_{\text{tot}} = \frac{T_j - T_{\text{amb}}}{R_{\text{th } j-a}}$$

where  $R_{\text{th } j-a}$  is the thermal resistance from the transistor junction to the ambient. For case rated or mounting base rated devices, the thermal resistance  $R_{\text{th } j-a}$  is made up of the thermal resistance junction to case or mounting base ( $R_{\text{th } j-mb}$ ), the contact thermal resistance ( $R_{\text{th } i}$ ) and the heatsink thermal resistance  $R_{\text{th } h}$ .

For the calculation of pulse power operation  $P_p$ , the maximum pulse power is obtained by the aid of a chart as shown in Fig. 4.

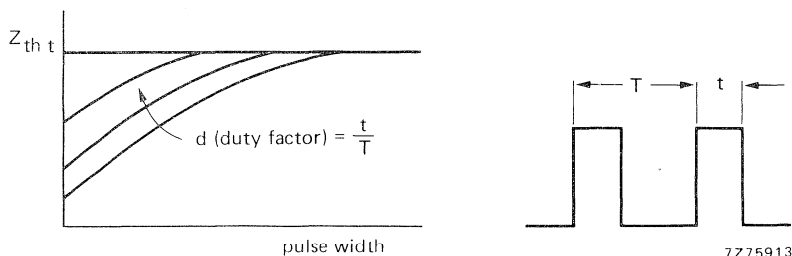


Fig. 4.

The general expression from which the maximum pulse power dissipation can be calculated is:

$$P_p = \frac{T_j - T_{\text{amb}} - P_s \times R_{\text{th } j-a}}{Z_{\text{th } t} + d (R_{\text{th } c-a})}$$

where  $Z_{\text{th } t}$  and  $d$  are given in the above chart and  $R_{\text{th } c-a}$  is the thermal resistance between case and ambient for case rated device. For mounting base rated device, it is equal to  $R_{\text{th } h} + R_{\text{th } i}$  and is zero for free air rated device because the effect of the temperature rise of the case over the ambient for a pulse train is already included in  $Z_{\text{th } t}$ .

## Temperature ratings

$T_{j\text{max}}$	The maximum permissible junction temperature which is used as the basis for the calculation of power ratings. Unless otherwise stated, the continuous value is implied.
$T_{j\text{max}}$ (continuous operation)	The maximum permissible continuous value.
$T_{j\text{max}}$ (intermittent operation)	The maximum permissible instantaneous junction temperature usually allowed for a total duration of 200 hours.
$T_{\text{mb}}$	The temperature of the surface making contact with a heatsink. This is confined to devices where a flange or stud for fixing onto a heatsink forms an integral part of the envelope.
$T_{\text{case}}$	The temperature of the envelope. This is confined to devices to which may be attached a clip-on cooling fin.

# LETTER SYMBOLS FOR TRANSISTORS AND SIGNAL DIODES

based on IEC Publication 148

## LETTER SYMBOLS FOR CURRENTS, VOLTAGES AND POWERS

### Basic letters

The basic letters to be used are:

I, i = current  
V, v = voltage  
P, p = power.

Lower-case basic letters shall be used for the representation of instantaneous values which vary with time.

In all other instances upper-case basic letters shall be used.

### Subscripts

A, a	Anode terminal
(AV), (av)	Average value
B, b	Base terminal, for MOS devices: Substrate
(BR)	Breakdown
C, c	Collector terminal
D, d	Drain terminal
E, e	Emitter terminal
F, f	Forward
G, g	Gate terminal
K, k	Cathode terminal
M, m	Peak value
O, o	As third subscript: The terminal not mentioned is open circuited
R, r	As first subscript: Reverse. As second subscript: Repetitive. As third subscript: With a specified resistance between the terminal not mentioned and the reference terminal.
(RMS), (rms)	R. M. S. value
S, s	{ As first or second subscript: Source terminal (for FETS only) As second subscript: Non-repetitive (not for FETS) As third subscript: Short circuit between the terminal not mentioned and the reference terminal
X, x	Specified circuit
Z, z	Replaces R to indicate the actual working voltage, current or power of voltage reference and voltage regulator diodes.

Note: No additional subscript is used for d. c. values.

Upper-case subscripts shall be used for the indication of:

- a) continuous (d. c.) values (without signal)  
Example  $I_B$
- b) instantaneous total values  
Example  $i_B$
- c) average total values  
Example  $I_{B(AV)}$
- d) peak total values  
Example  $I_{BM}$
- e) root-mean-square total values  
Example  $I_{B(RMS)}$

Lower-case subscripts shall be used for the indication of values applying to the varying component alone :

- a) instantaneous values  
Example  $i_b$
- b) root-mean-square values  
Example  $I_{b(rms)}$
- c) peak values  
Example  $I_{bm}$
- d) average values  
Example  $I_{b(av)}$

Note: If more than one subscript is used, subscript for which both styles exist shall either be all upper-case or all lower-case.

**Additional rules for subscripts**

Subscripts for currents

Transistors : If it is necessary to indicate the terminal carrying the current, this should be done by the first subscript (conventional current flow from the external circuit into the terminal is positive).

Examples :  $I_B$ ,  $i_B$ ,  $i_b$ ,  $I_{bm}$

Diodes : To indicate a forward current (conventional current flow into the anode terminal) the subscript F or f should be used; for a reverse current (conventional current flow out of the anode terminal) the subscript R or r should be used.

Examples :  $I_F$ ,  $I_R$ ,  $i_F$ ,  $I_{f(rms)}$

Subscripts for voltages

**Transistors:** If it is necessary to indicate the points between which a voltage is measured, this should be done by the first two subscripts. The first subscript indicates the terminal at which the voltage is measured and the second the reference terminal or the circuit node. Where there is no possibility of confusion, the second subscript may be omitted.

Examples:  $V_{BE}$ ,  $v_{BE}$ ,  $v_{be}$ ,  $V_{bem}$

**Diodes:** To indicate a forward voltage (anode positive with respect to cathode), the subscript F or f should be used; for a reverse voltage (anode negative with respect to cathode) the subscript R or r should be used.

Examples:  $V_F$ ,  $V_R$ ,  $v_F$ ,  $v_{rm}$

Subscripts for supply voltages or supply currents

Supply voltages or supply currents shall be indicated by repeating the appropriate terminal subscript.

Examples:  $V_{CC}$ ,  $I_{EE}$

**Note:** If it is necessary to indicate a reference terminal, this should be done by a third subscript

Example:  $V_{CCE}$

Subscripts for devices having more than one terminal of the same kind

If a device has more than one terminal of the same kind, the subscript is formed by the appropriate letter for the terminal followed by a number; in the case of multiple subscripts, hyphens may be necessary to avoid misunderstanding.

Examples:  $I_{B2}$  = continuous (d. c.) current flowing into the second base terminal

$V_{B2-E}$  = continuous (d. c.) voltage between the terminals of second base and emitter

Subscripts for multiple devices

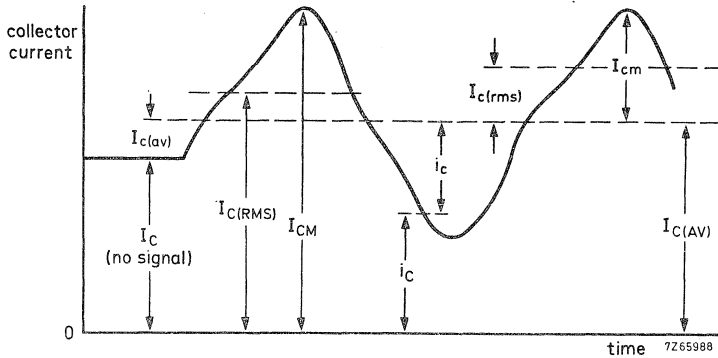
For multiple unit devices, the subscripts are modified by a number preceding the letter subscript; in the case of multiple subscripts, hyphens may be necessary to avoid misunderstanding.

Examples:  $I_{2C}$  = continuous (d. c.) current flowing into the collector terminal of the second unit

$V_{1C-2C}$  = continuous (d. c.) voltage between the collector terminals of the first and the second unit.

## Application of the rules

The figure below represents a transistor collector current as a function of time. It consists of a continuous (d. c.) current and a varying component.



## LETTER SYMBOLS FOR ELECTRICAL PARAMETERS

## Definition

For the purpose of this Publication, the term "electrical parameter" applies to four-pole matrix parameters, elements of electrical equivalent circuits, electrical impedances and admittances, inductances and capacitances.

## Basic letters

The following is a list of the most important basic letters used for electrical parameters of semiconductor devices.

- B, b = susceptance; imaginary part of an admittance
- C = capacitance
- G, g = conductance; real part of an admittance
- H, h = hybrid parameter
- L = inductance
- R, r = resistance; real part of an impedance
- X, x = reactance; imaginary part of an impedance
- Y, y = admittance;
- Z, z = impedance;



Upper-case letters shall be used for the representation of:

- a) electrical parameters of external circuits and of circuits in which the device forms only a part;
- b) all inductances and capacitances.

Lower-case letters shall be used for the representation of electrical parameters inherent in the device (with the exception of inductances and capacitances).

### Subscripts

#### General subscripts

The following is a list of the most important general subscripts used for electrical parameters of semiconductor devices:

F, f	= forward; forward transfer
I, i (or 1)	= input
L, l	= load
O, o (or 2)	= output
R, r	= reverse; reverse transfer
S, s	= source

Examples:  $Z_S$ ,  $h_f$ ,  $h_F$

The upper-case variant of a subscript shall be used for the designation of static (d.c.) values.

Examples :  $h_{FE}$  = static value of forward current transfer ratio in common-emitter configuration (d.c. current gain)  
 $R_E$  = d.c. value of the external emitter resistance.

Note: The static value is the slope of the line from the origin to the operating point on the appropriate characteristic curve, i.e. the quotient of the appropriate electrical quantities at the operating point.

The lower-case variant of a subscript shall be used for the designation of small-signal values.

Examples:  $h_{fe}$  = small-signal value of the short-circuit forward current transfer ratio in common-emitter configuration

$Z_e = R_e + jX_e$  = small-signal value of the external impedance

Note: If more than one subscript is used, subscripts for which both styles exist shall either be all upper-case or all lower-case

Examples:  $h_{FE}$ ,  $y_{RE}$ ,  $h_{fe}$

Subscripts for four-pole matrix parameters

The first letter subscript (or double numeric subscript) indicates input, output, forward transfer or reverse transfer

Examples:  $h_i$  (or  $h_{11}$ )  
 $h_o$  (or  $h_{22}$ )  
 $h_f$  (or  $h_{21}$ )  
 $h_r$  (or  $h_{12}$ )

A further subscript is used for the identification of the circuit configuration. When no confusion is possible, this further subscript may be omitted.

Examples:  $h_{fe}$  (or  $h_{21e}$ ),  $h_{FE}$  (or  $h_{21E}$ )

**Distinction between real and imaginary parts**

If it is necessary to distinguish between real and imaginary parts of electrical parameters, no additional subscripts should be used. If basic symbols for the real and imaginary parts exist, these may be used.

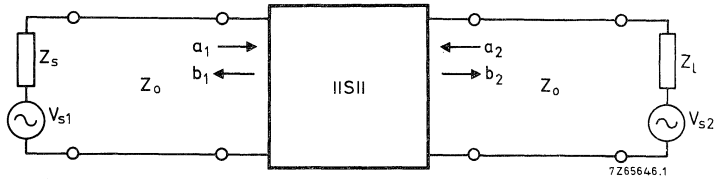
Examples:  $Z_i = R_i + jX_i$   
 $y_{fe} = g_{fe} + jb_{fe}$

If such symbols do not exist or if they are not suitable, the following notation shall be used:

Examples:  $\text{Re}(h_{ib})$  etc. for the real part of  $h_{ib}$   
 $\text{Im}(h_{ib})$  etc. for the imaginary part of  $h_{ib}$

## SCATTERING PARAMETERS

In distinction to the conventional h, y and z-parameters, s-parameters relate to traveling wave conditions. The figure below shows a two-port network with the incident and reflected waves  $a_1$ ,  $b_1$ ,  $a_2$  and  $b_2$ .



$$\begin{aligned}
 a_1 &= \frac{V_{i1}}{\sqrt{Z_0}} & a_2 &= \frac{V_{i2}}{\sqrt{Z_0}} \\
 b_1 &= \frac{V_{r1}}{\sqrt{Z_0}} & b_2 &= \frac{V_{r2}}{\sqrt{Z_0}}
 \end{aligned}
 \quad 1)$$

$Z_0$  = characteristic impedance of the transmission line in which the two-port is connected.

$V_i$  = incident voltage

$V_r$  = reflected (generated) voltage

The four-pole equations for s-parameters are:

$$\begin{aligned}
 b_1 &= s_{11}a_1 + s_{12}a_2 \\
 b_2 &= s_{21}a_1 + s_{22}a_2
 \end{aligned}$$

Using the subscripts i for 11, r for 12, f for 21 and o for 22, it follows that:

$$\begin{aligned}
 s_i &= s_{11} = \left. \frac{b_1}{a_1} \right|_{a_2 = 0} \\
 s_r &= s_{12} = \left. \frac{b_1}{a_2} \right|_{a_1 = 0} \\
 s_f &= s_{21} = \left. \frac{b_2}{a_1} \right|_{a_2 = 0} \\
 s_o &= s_{22} = \left. \frac{b_2}{a_2} \right|_{a_1 = 0}
 \end{aligned}$$

1) The squares of these quantities have the dimension of power.

The s-parameters can be named and expressed as follows:

$s_i = s_{11}$  = Input reflection coefficient.

The complex ratio of the reflected wave and the incident wave at the input, under the conditions  $Z_1 = Z_0$  and  $V_{s2} = 0$ .

$s_r = s_{12}$  = Reverse transmission coefficient.

The complex ratio of the generated wave at the input and the incident wave at the output, under the conditions  $Z_s = Z_0$  and  $V_{s1} = 0$ .

$s_f = s_{21}$  = Forward transmission coefficient.

The complex ratio of the generated wave at the output and the incident wave at the input, under the conditions  $Z_1 = Z_0$  and  $V_{s2} = 0$ .

$s_o = s_{22}$  = Output reflection coefficient.

The complex ratio of the reflected wave and the incident wave at the output, under the conditions  $Z_s = Z_0$  and  $V_{s1} = 0$ .

DEVICE DATA



## SILICON PLANAR EPITAXIAL HIGH-SPEED DIODE

Silicon epitaxial high-speed diode in a microminiature plastic envelope. It is intended for high-speed switching in hybrid thick and thin-film circuits.

### QUICK REFERENCE DATA

Continuous reverse voltage	$V_R$	max.	75 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	85 V
Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Junction temperature	$T_j$	max.	175 °C
Forward voltage at $I_F = 50$ mA	$V_F$	<	1,0 V
Reverse recovery time when switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$ ; measured at $I_R = 1$ mA	$t_{rr}$	<	6 ns
Recovery charge when switched from $I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$	$Q_s$	<	45 pC

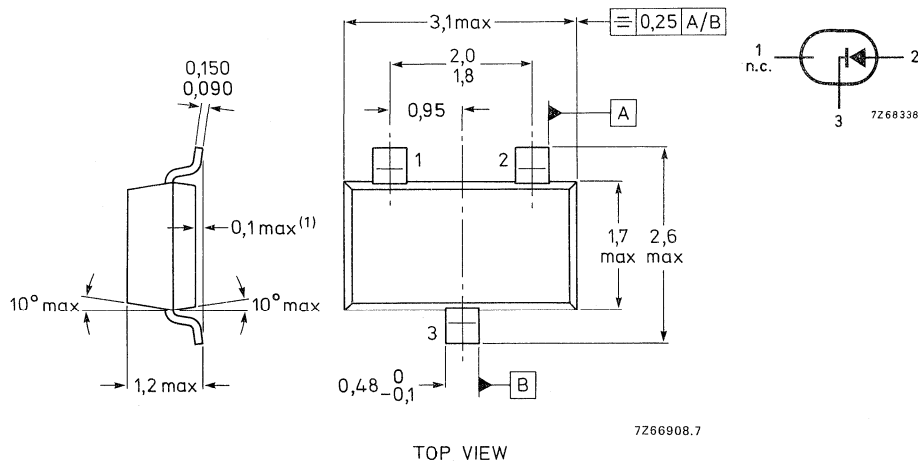
### MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BAS16 = A6



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Continuous reverse voltage	$V_R$	max.	75 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	85 V
Average rectified forward current <sup>▲</sup> (averaged over any 20 ms period) up to $T_{amb} = 25\text{ }^\circ\text{C}^{**}$	$I_F(AV)$	max.	250 mA
Forward current (d.c.)	$I_F$	max.	250 mA
Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Storage temperature	$T_{stg}$		-65 to +175 °C
Junction temperature	$T_j$	max.	175 °C

**THERMAL CHARACTERISTICS \***

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient **	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

**Forward voltage**

$I_F = 1\text{ mA}$	$V_F$	<	715 mV
$I_F = 10\text{ mA}$	$V_F$	<	855 mV
$I_F = 50\text{ mA}$	$V_F$	<	1000 mV
$I_F = 150\text{ mA}$	$V_F$	<	1250 mV

**Reverse current**

$V_R = 25\text{ V}; T_j = 150\text{ }^\circ\text{C}$	$I_R$	<	30 $\mu\text{A}$
$V_R = 75\text{ V}$	$I_R$	<	1 $\mu\text{A}$
$V_R = 75\text{ V}; T_j = 150\text{ }^\circ\text{C}$	$I_R$	<	50 $\mu\text{A}$

**Diode capacitance**

$V_R = 0; f = 1\text{ MHz}$	$C_d$	<	2 pF
-----------------------------	-------	---	------

**Forward recovery voltage (see also Fig. 2)**

when switched to $I_F = 10\text{ mA}; t_p = 20\text{ ns}$	$V_{fr}$	<	1,75 V
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**Reverse recovery time (see also Fig. 3)**

when switched from $I_F = 10\text{ mA}$ to $I_R = 10\text{ mA};$ $R_L = 100\ \Omega$ ; measured at $I_R = 1\text{ mA}$	$t_{rr}$	<	6 ns
---	----------	---	------

**Recovery charge (see also Fig. 4)**

when switched from $I_F = 10\text{ mA}$ to $V_R = 5\text{ V};$ $R_L = 500\ \Omega$	$Q_s$	<	45 pC
---	-------	---	-------

<sup>▲</sup> Measured under pulse conditions.  $t_p \leq 0,5\text{ ms}$ .  $I_F(AV) = 150\text{ mA}$ ,  $t_{(av)} \leq 1\text{ ms}$ , for sinusoidal operation.

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.



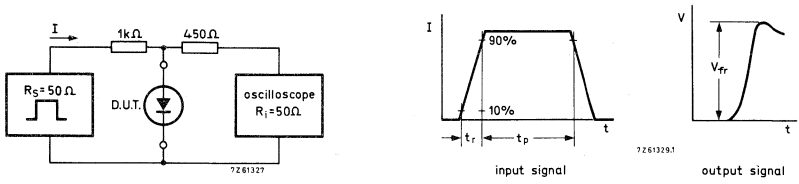


Fig. 2 Forward recovery voltage test circuit and waveforms.

Input signal: forward pulse rise time =  $t_r = 20$  ns; forward current pulse duration  $t_p = 120$  ns; duty factor =  $\delta = 0,01$ .

Oscilloscope: rise time =  $t_r = 0,35$  ns.

Circuit capacitance  $C \leq 1$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance).

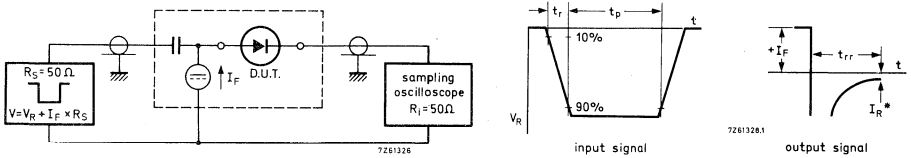


Fig. 3 Reverse recovery time test circuit and waveforms.

Input signal: reverse pulse rise time =  $t_r = 0,6$  ns; reverse pulse duration =  $t_p = 100$  ns; duty factor =  $\delta = 0,05$ . \*  $t_{rr}$  up to  $I_R = 1$  mA.

Oscilloscope: rise time =  $t_r = 0,35$  ns.

Circuit capacitance  $C \leq 1$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance).

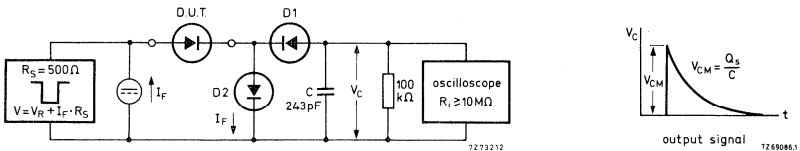


Fig. 4 Recovery charge test circuit and waveform.

D1 = BAW62; D2 = diode with minority carrier life time at 10 mA:  $< 200$  ps

Input signal

Rise time of the reverse pulse

Reverse pulse duration

Duty factor

$$\begin{aligned} t_r &= 2 \text{ ns} \\ t_p &= 400 \text{ ns} \\ \delta &= 0,02 \end{aligned}$$

Circuit capacitance  $C \leq 7$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance).

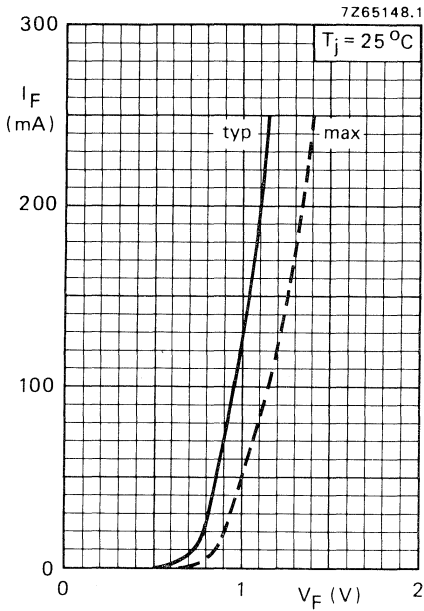


Fig. 5.

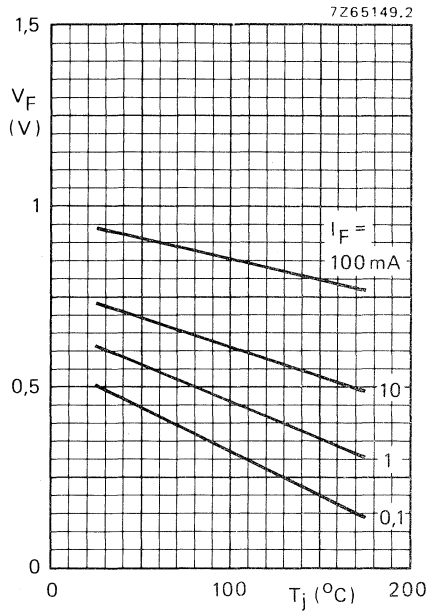


Fig. 6 Typical values.

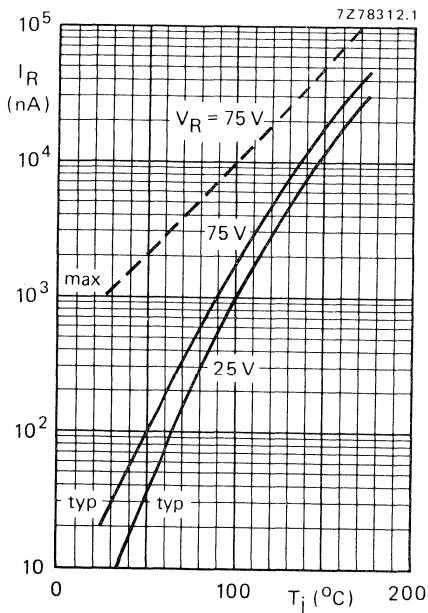


Fig. 7.

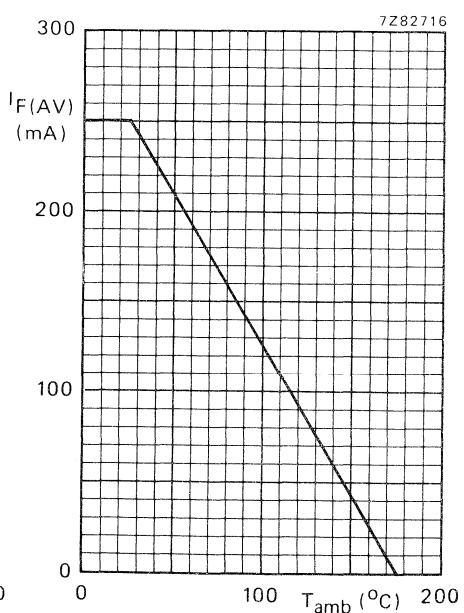


Fig. 8 Current derating curve.

## LOW VOLTAGE STABISTOR

Silicon planar epitaxial diode in SOT-23 envelope. This diode is intended for low voltage stabilizing e.g. bias stabilizer in class-B output stages, clipping, clamping and meter protection.

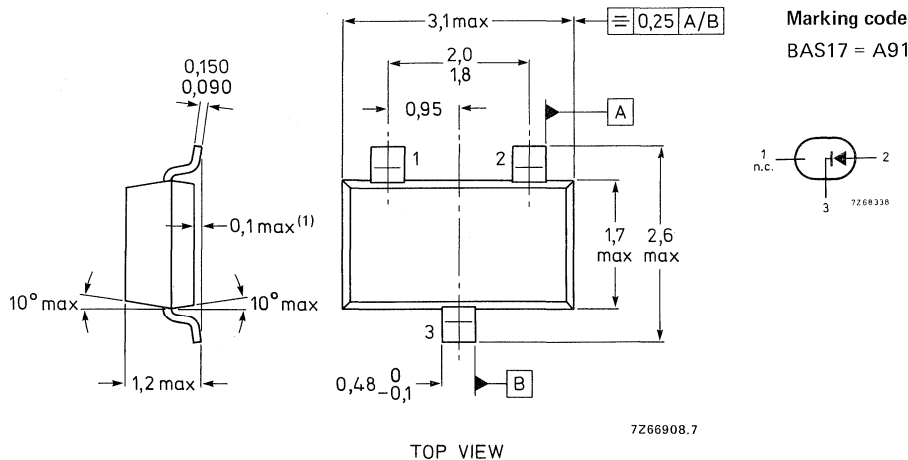
### QUICK REFERENCE DATA

Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Storage temperature	$T_{stg}$	-65 to + 150 °C	
Junction temperature	$T_j$	max.	175 °C
Forward voltage			
$I_F = 0,1$ mA	$V_F$		610 to 690 mV
$I_F = 1,0$ mA	$V_F$		680 to 760 mV
$I_F = 10$ mA	$V_F$		750 to 830 mV
$I_F = 100$ mA	$V_F$		870 to 960 mV
Diode capacitance			
$V_R = 0$ ; $f = 1$ MHz	$C_d$	<	140 pF

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also chapter *Soldering Recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Repetitive peak forward current **	$I_{FRM}$	max.	250 mA
Storage temperature	$T_{stg}$	-65 to + 150 °C	
→ Junction temperature	$T_j$	max.	175 °C

**THERMAL CHARACTERISTICS\***

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25\text{ °C}$  unless otherwise specified

**Forward voltage**

$I_F = 0,1\text{ mA}$	$V_F$	610 to 690 mV
$I_F = 1,0\text{ mA}$	$V_F$	680 to 760 mV
$I_F = 5,0\text{ mA}$	$V_F$	730 to 810 mV
$I_F = 10\text{ mA}$	$V_F$	750 to 830 mV
$I_F = 100\text{ mA}$	$V_F$	870 to 960 mV

**Reverse current**

$V_R = 4\text{ V}$	$I_R$	<	5 $\mu\text{A}$
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**Temperature coefficient**

$I_F = 1\text{ mA}$	$S_F$	typ.	-1,8 mV/K
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**Diode capacitance**

$V_R = 0; f = 1\text{ MHz}$	$C_d$	<	140 pF
-----------------------------	-------	---	--------

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

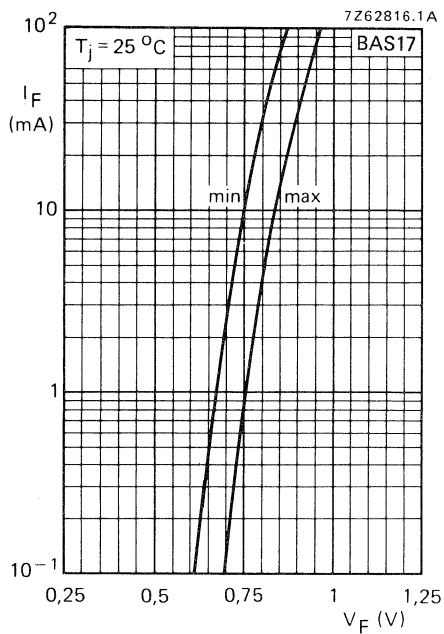


Fig. 2 Forward current as a function of forward voltage.



## SILICON PLANAR EPITAXIAL HIGH-SPEED DIODES

Silicon epitaxial high-speed diodes in a microminiature plastic envelope. They are intended for switching and general purposes.

### QUICK REFERENCE DATA

			BAS19	BAS20	BAS21
Continuous reverse voltage	$V_R$	max.	100	150	200 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	120	200	250 V
Repetitive peak forward current	$I_{FRM}$	max.		625	mA
Junction temperature	$T_j$	max.		150	°C
Forward voltage at $I_F = 100$ mA	$V_F$	<		1	V
Reverse recovery time when switched from $I_F = 30$ mA to $I_R = 30$ mA; $R_L = 100 \Omega$ measured at $I_R = 3$ mA	$t_{rr}$	<		50	ns

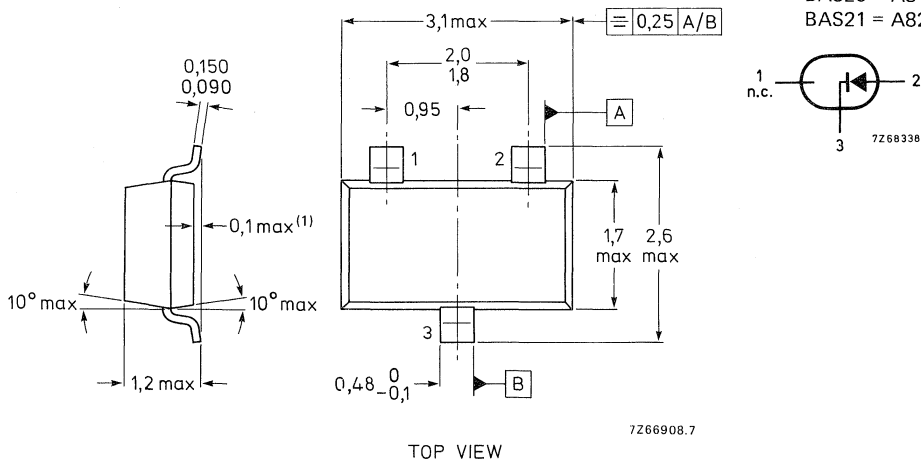
### MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BAS19 = A8  
BAS20 = A81  
BAS21 = A82



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BAS19	BAS20	BAS21
Continuous reverse voltage	$V_R$	max. 100	150	200 V
Repetitive peak reverse peak	$V_{RRM}$	max. 120	200	250 V
Average rectified forward current (1) (averaged over any 20 ms period)	$I_F(AV)$	max.	200	mA
Forward current (d.c.) up to $T_{amb} = 25\text{ }^\circ\text{C}^{**}$	$I_F$	max.	200	mA
Repetitive peak forward current	$I_{FRM}$	max.	625	mA
Storage temperature	$T_{stg}$		-65 to + 150	$^\circ\text{C}$
Junction temperature	$T_j$	max.	150	$^\circ\text{C}$
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	200	mW

## THERMAL CHARACTERISTICS\*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

### Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

### Forward voltage

$I_F = 100\text{ mA}$	$V_F$	<	1,0 V
$I_F = 200\text{ mA}$	$V_F$	<	1,25 V

### Reverse breakdown voltage (1)

BAS19; $I_R = 100\text{ }\mu\text{A}$	$V_{(BR)R}$	>	120 V
BAS20; $I_R = 100\text{ }\mu\text{A}$	$V_{(BR)R}$	>	200 V
BAS21; $I_R = 100\text{ }\mu\text{A}$ (2)	$V_{(BR)R}$	>	250 V

### Reverse current

$V_R = V_{Rmax}$	$I_R$	<	100 nA
$V_R = V_{Rmax}; T_j = 150\text{ }^\circ\text{C}$	$I_R$	<	100 $\mu\text{A}$

### Differential resistance

$I_F = 10\text{ mA}$	$r_{diff}$	typ.	5 $\Omega$
----------------------	------------	------	------------

(1) Measured under pulse conditions; Pulse time =  $t_p \leq 0,3\text{ ms}$ .

(2) At zero life time, measured under pulse conditions to avoid excessive dissipation and voltage limited to 275 V.

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.



Diode capacitance

$V_R = 0; f = 1 \text{ MHz}$

$C_d < 5 \text{ pF}$

Reverse recovery time (see Figs 2 and 3)

when switched from  $I_F = 30 \text{ mA}$  to  $I_R = 30 \text{ mA}$ ;

$R_L = 100 \Omega$ ; measured at  $I_R = 3 \text{ mA}$

$t_{rr} < 50 \text{ ns}$

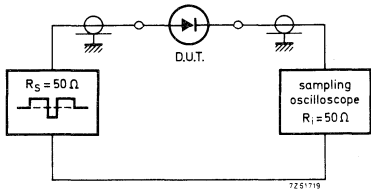


Fig. 2 Test circuit.

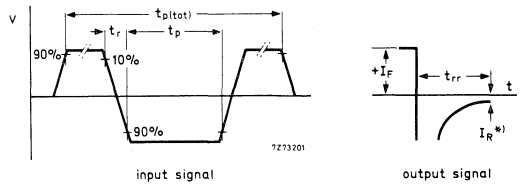


Fig. 3 Waveforms;  $I_R = 3 \text{ mA}$ .

Input signal

total pulse duration	$t_p(\text{tot}) = 2 \mu\text{s}$
duty factor	$\delta = 0,0025$
rise time of reverse pulse	$t_r = 0,6 \text{ ns}$
reverse pulse duration	$t_p = 100 \text{ ns}$

Oscilloscope

rise time	$t_r = 0,35 \text{ ns}$
circuit capacitance*	$C < 1 \text{ pF}$

\*C = oscilloscope input capacitance + parasitic capacitance.

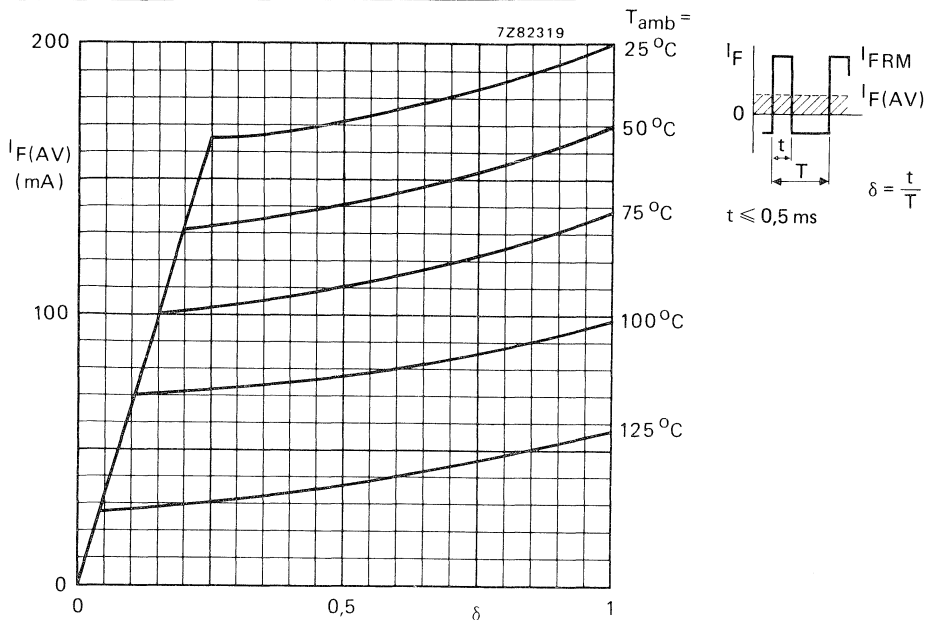


Fig. 4 BAS19; maximum permissible average rectified forward current for pulse operation as a function of the duty factor at  $V_R = 100 \text{ V}$ .

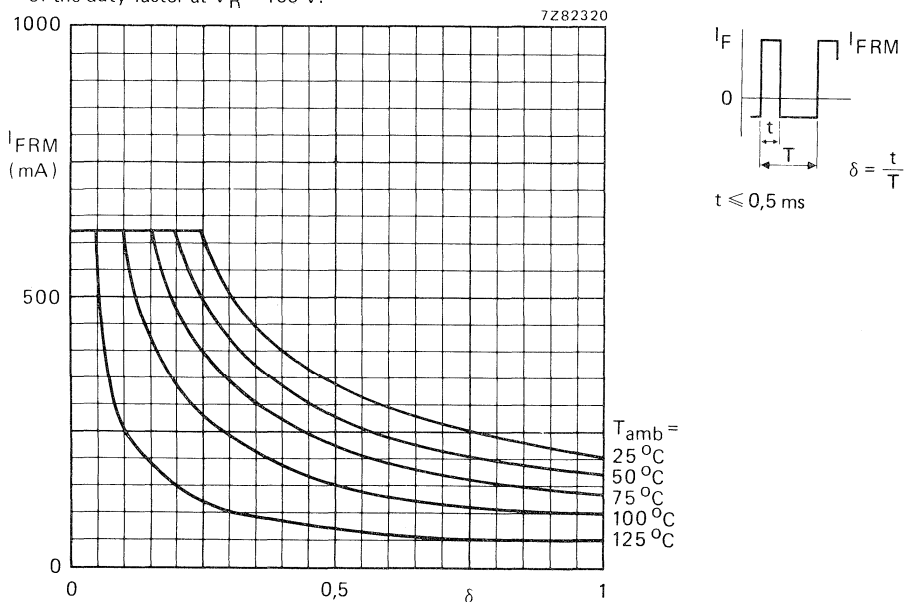


Fig. 5 BAS19; maximum permissible repetitive peak forward current for pulse operation as a function of the duty factor at  $V_R = 100 \text{ V}$ .

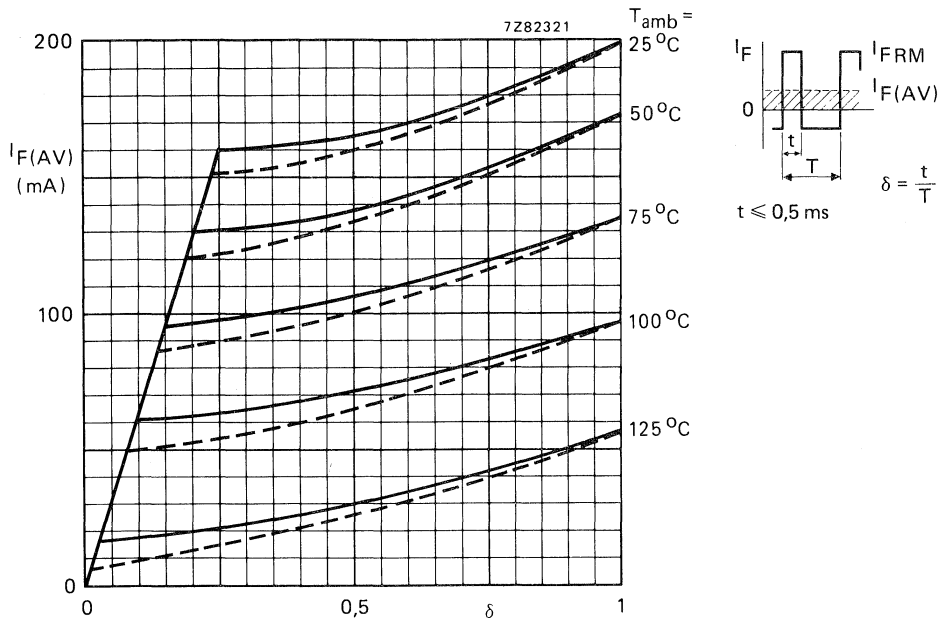


Fig. 6 BAS20/21; maximum permissible average rectified forward current for pulse operation as a function of the duty factor.

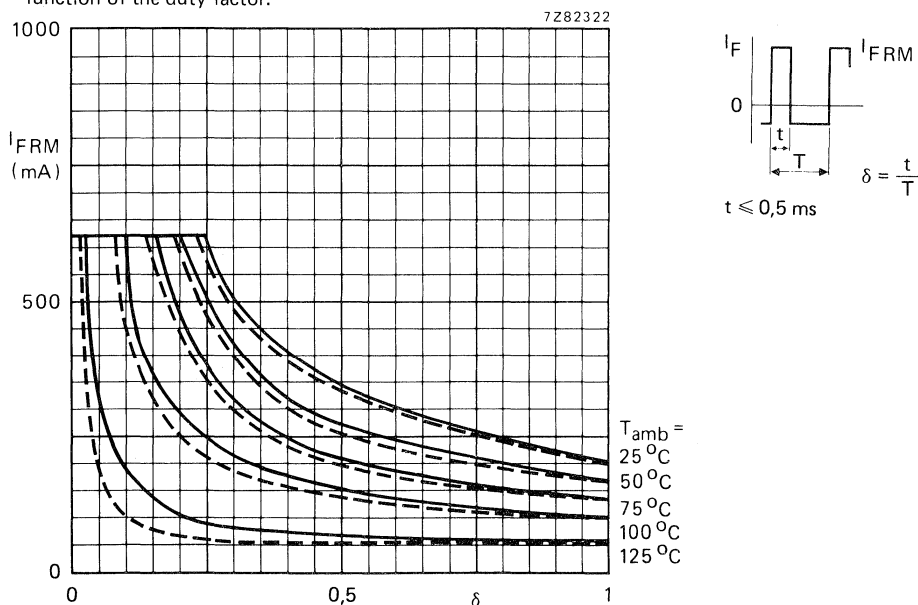


Fig. 7 BAS20/21; maximum permissible repetitive peak forward current for pulse operation as a function of the duty factor.

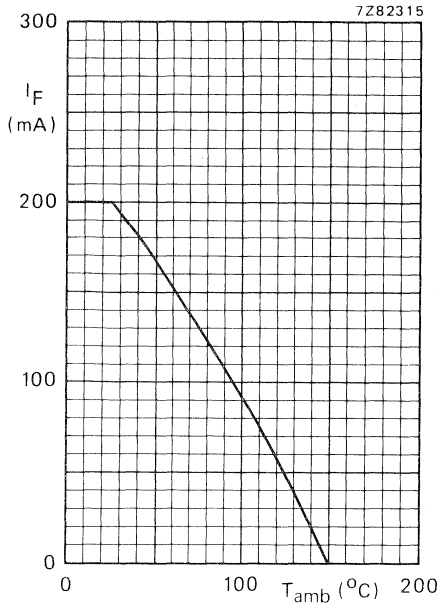


Fig. 8.

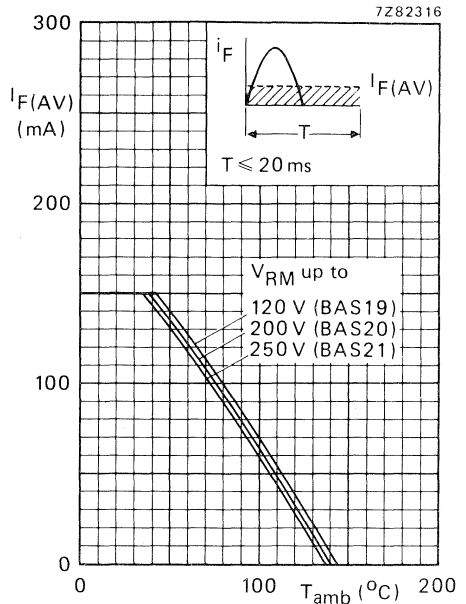


Fig. 9.

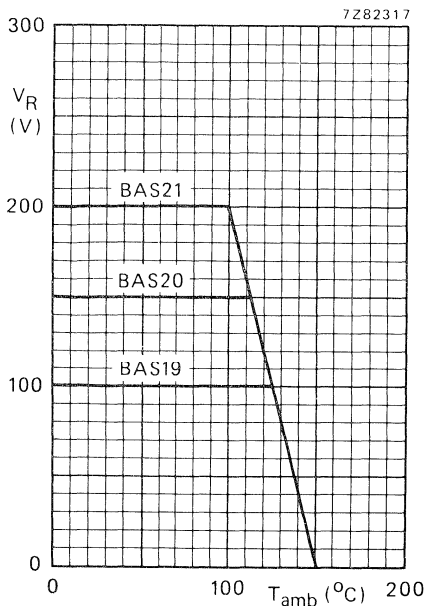


Fig. 10.

Fig. 8 Maximum permissible continuous forward current as a function of the ambient temperature.

Fig. 9 Maximum permissible average rectified forward current as a function of the ambient temperature.

Fig. 10 Maximum permissible continuous reverse voltage as a function of the ambient temperature.

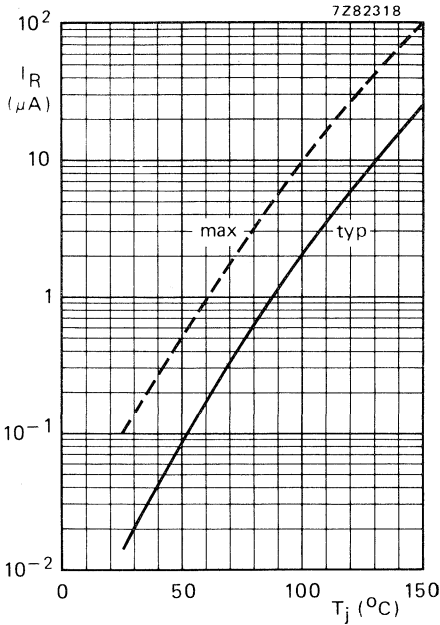


Fig. 11.

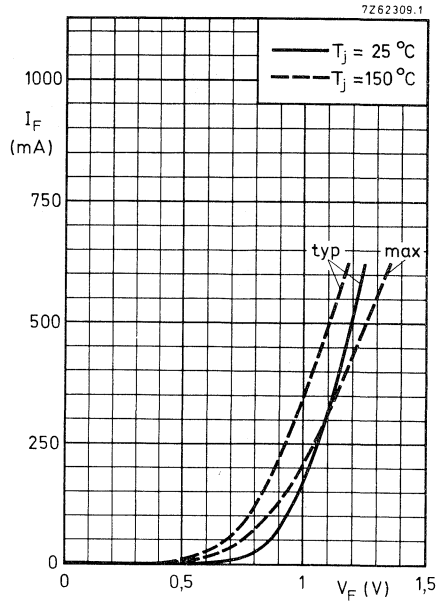


Fig. 12.

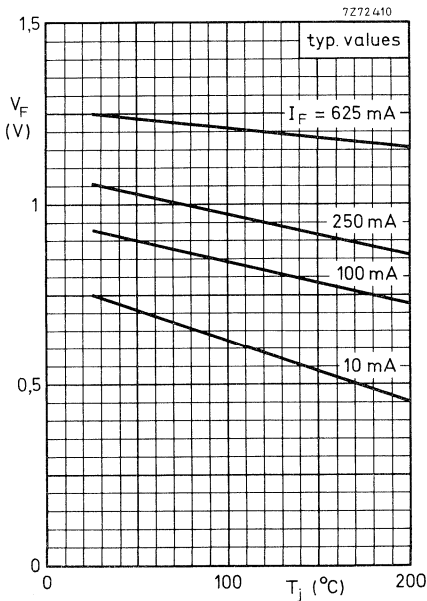


Fig. 13.

Fig. 11 Continuous reverse current as a function of the junction temperature.

Fig. 12 Forward current as a function of forward voltage.

Fig. 13 Forward voltage as a function of the junction temperature.

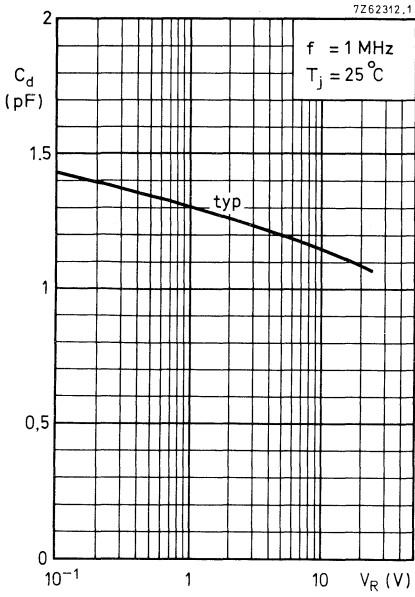


Fig. 14.

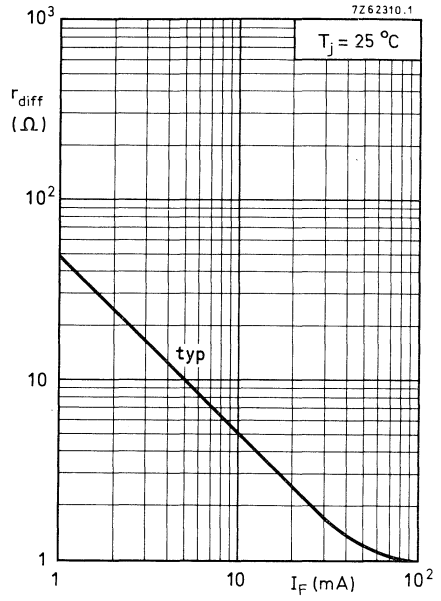


Fig. 15.

## SILICON PLANAR EPITAXIAL HIGH-SPEED DIODE

The BAS28 consists of two separate diodes in one microminiature envelope intended for surface mounting.

It concerns fast-switching general-purpose diodes.

### QUICK REFERENCE DATA

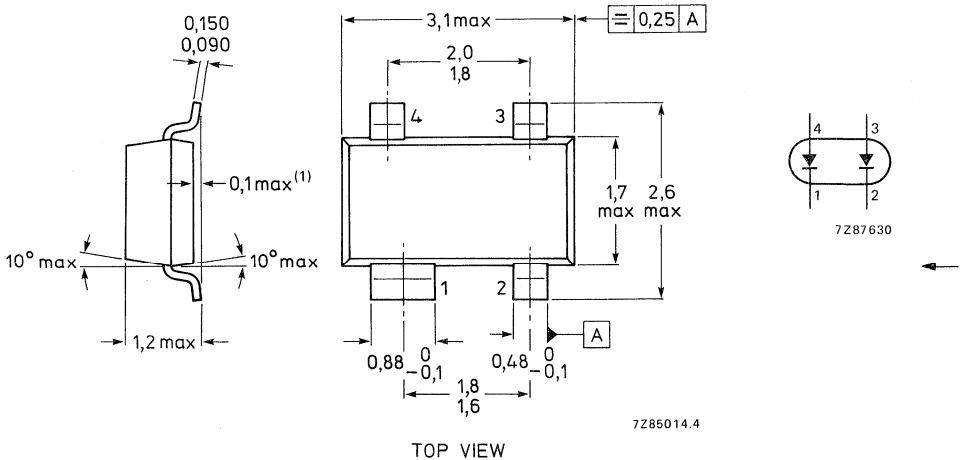
Continuous reverse voltage	$V_R$	max.	75 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	85 V
Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Junction temperature	$T_j$	max.	175 °C
Forward voltage at $I_F = 50$ mA	$V_F$	<	1,0 V
Reverse recovery time when switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$ , measured at $I_R = 1$ mA	$t_{rr}$	<	6 ns
Recovery charge when switched from $I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$	$Q_s$	<	45 pC

### MECHANICAL DATA

Fig. 1 SOT-143.

Dimensions in mm

Marking code. A61



(1) Also available in 0,1 – 0,2 mm version.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Continuous reverse voltage	$V_R$	max.	75 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	85 V
Average rectified forward current <sup>▲</sup> (averaged over any 20 ms period) up to $T_{amb} = 25\text{ }^\circ\text{C}^{**}$	$I_{F(AV)}$	max.	250 mA
Forward current (d.c.)	$I_F$	max.	250 mA
Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Storage temperature	$T_{stg}$		-65 to + 175 °C
Junction temperature	$T_j$	max.	175 °C

**THERMAL RESISTANCE\***

From junction to ambient	$R_{th\ j-a}$	=	430 K/W
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**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Forward voltage			
$I_F = 1\text{ mA}$	$V_F$	<	715 mV
$I_F = 10\text{ mA}$	$V_F$	<	855 mV
$I_F = 50\text{ mA}$	$V_F$	<	1000 mV
$I_F = 150\text{ mA}$	$V_F$	<	1250 mV
Reverse current			
$V_R = 25\text{ V}; T_j = 150\text{ }^\circ\text{C}$	$I_R$	<	30 $\mu\text{A}$
$V_R = 75\text{ V}$	$I_R$	<	1 $\mu\text{A}$
$V_R = 75\text{ V}; T_j = 150\text{ }^\circ\text{C}$	$I_R$	<	50 $\mu\text{A}$
Diode capacitance			
$V_R = 0; f = 1\text{ MHz}$	$C_d$	<	2 pF
Forward recovery voltage (see also Fig. 2) when switched to $I_F = 10\text{ mA}; t_p = 20\text{ ns}$			
	$V_{fr}$	<	1,75 V
Reverse recovery time (see also Fig. 3) when switched from $I_F = 10\text{ mA}$ to $I_R = 10\text{ mA};$ $R_L = 100\ \Omega$ ; measured at $I_R = 1\text{ mA}$			
	$t_{rr}$	<	6 ns
Recovery charge (see also Fig. 4) when switched from $I_F = 10\text{ mA}$ to $V_R = 5\text{ V};$ $R_L = 500\ \Omega$			
	$Q_s$	<	45 pC

<sup>▲</sup> Measured under pulse conditions.  $t_p \leq 0,5\text{ ms}$ .  $I_{F(AV)} = 150\text{ mA}$ ,  $t_{(av)} \leq 1\text{ ms}$ , for sinusoidal operation.

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.



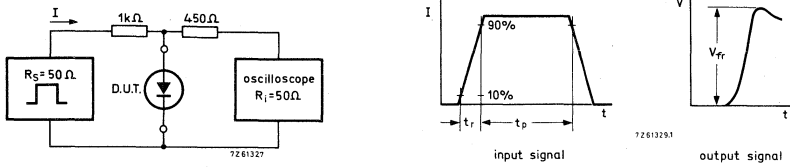


Fig. 2 Forward recovery voltage test circuit and waveforms.

Input signal: forward pulse rise time =  $t_r = 20$  ns; forward current pulse duration  $t_p = 120$  ns; duty factor =  $\delta = 0,01$ .  
 Oscilloscope: rise time =  $t_r = 0,35$  ns.  
 Circuit capacitance  $C \leq 1$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance).

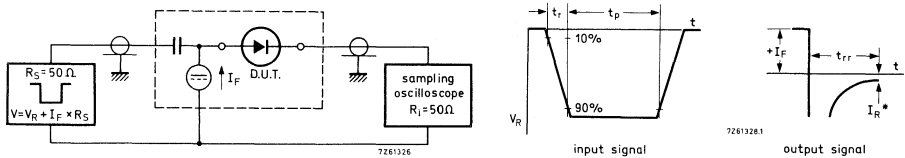


Fig. 3 Reverse recovery time test circuit and waveforms.

Input signal: reverse pulse rise time =  $t_r = 0,6$  ns; reverse pulse duration =  $t_p = 100$  ns; duty factor =  $\delta = 0,05$ . \*  $t_{rr}$  up to  $I_R = 1$  mA.  
 Oscilloscope: rise time =  $t_r = 0,35$  ns.  
 Circuit capacitance  $C \leq 1$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance).

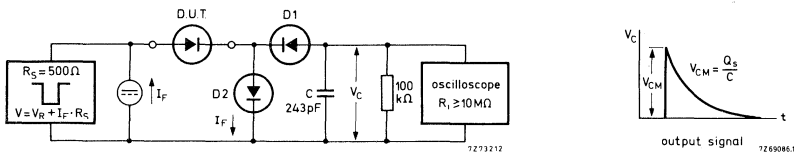


Fig. 4 Recovery charge test circuit and waveform.

D1 = BAW62; D2 = diode with minority carrier life time at 10 mA:  $< 200$  ps

Input signal

Rise time of the reverse pulse

Reverse pulse duration

Duty factor

$$\begin{aligned}
 t_r &= 2 \text{ ns} \\
 t_p &= 400 \text{ ns} \\
 \delta &= 0,02
 \end{aligned}$$

Circuit capacitance  $C \leq 7$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance).

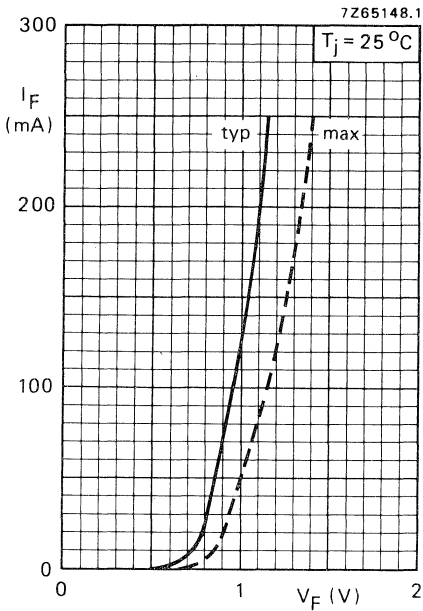


Fig. 5.

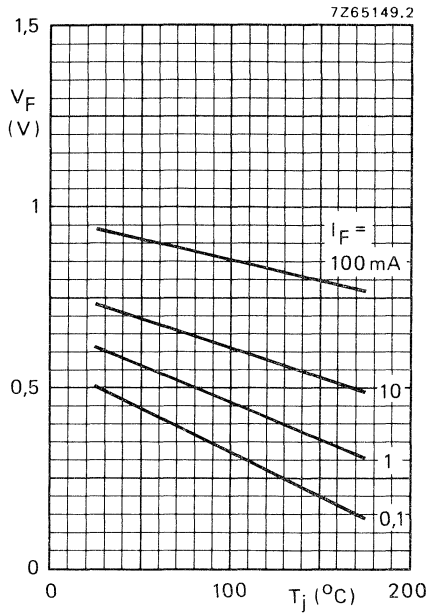


Fig. 6 Typical values.

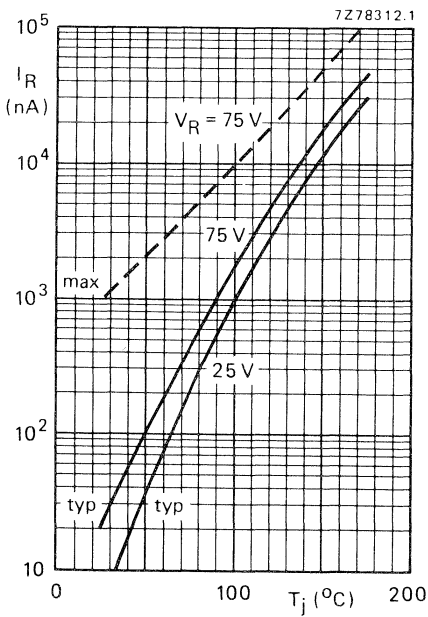


Fig. 7.

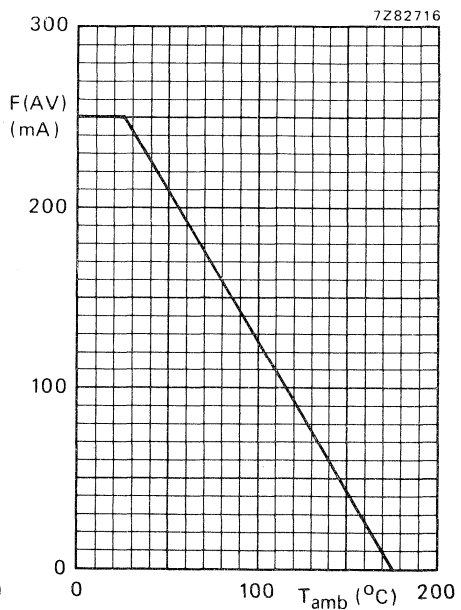


Fig. 8 Current derating curve.

## SILICON PLANAR EPITAXIAL HIGH-SPEED DIODES

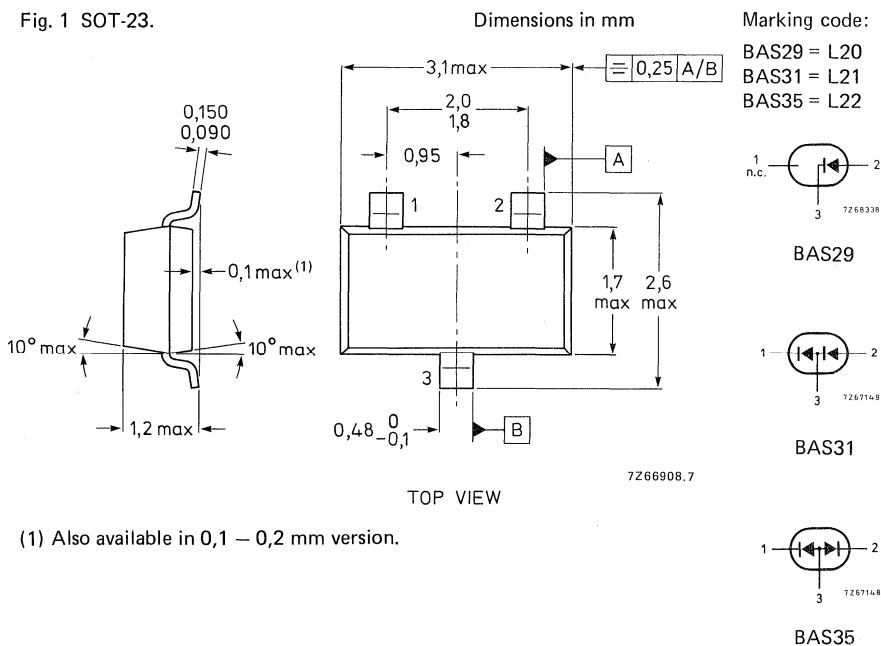
The BAS29, BAS31 and the BAS35 are silicon planar epitaxial diodes encapsulated in a SOT-23 envelope. The BAS29 consists of a single diode. The BAS31 has two diodes in series and the BAS35 has two diodes with a common anode. All diodes are designed for switching inductive loads in semi-electronic telephone exchanges.

### QUICK REFERENCE DATA (per diode)

Continuous reverse voltage	$V_R$	max.	90 V
Repetitive peak forward current	$I_{FRM}$	max.	600 mA
Forward current	$I_F$	max.	250 mA
Junction temperature	$T_j$	max.	150 °C
Forward voltage at $I_F = 50$ mA	$V_F$	<	0,84 V
Reverse recovery time when switched from $I_F = 30$ mA to $I_R = 30$ mA; $R_L = 100 \Omega$ ; measured at $I_R = 3$ mA	$t_{rr}$	<	50 ns

### MECHANICAL DATA

Fig. 1 SOT-23.



**RATINGS** (per diode)

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Continuous reverse voltage	$V_R$	max.	90 V
Repetitive peak forward current	$I_{FRM}$	max.	600 mA
Average rectified forward current (averaged over any 20 ms period)	$I_F$	max.	250 mA
Non-repetitive peak forward current $t = 1 \mu s$ ; $T_j = 25^\circ C$ prior to surge	$I_{FSM}$	max.	6 A
$t = 1 s$ ; $T_j = 25^\circ C$ prior to surge			1 A
Forward current (d.c.)	$I_F$	max.	250 mA
Storage temperature	$T_{stg}$		-65 to +175 °C
Junction temperature	$T_j$	max.	150 °C

**THERMAL RESISTANCE**

From junction to ambient when mounted on ceramic substrate of 7 mm x 5 mm x 0,5 mm

$$R_{th\ j-a} = 430\ K/W$$

**CHARACTERISTICS** (per diode)

$T_{amb} = 25^\circ C$  unless otherwise specified

Forward voltage

$$I_F = 10\ mA$$

$$V_F < 0,75\ V$$

$$I_F = 50\ mA$$

$$V_F < 0,84\ V$$

$$I_F = 100\ mA$$

$$V_F < 0,90\ V$$

$$I_F = 200\ mA$$

$$V_F < 1,00\ V$$

$$I_F = 400\ mA$$

$$V_F < 1,25\ V$$

Reverse current

$$V_R = 90\ V$$

$$I_R < 100\ nA$$

$$V_R = 90\ V; T_j = 150^\circ C$$

$$I_R < 100\ \mu A$$

Reverse avalanche breakdown voltage

$$I_R = 100\ \mu A$$

$$V_{(BR)R} > 90\ V$$

Diode capacitance

$$V_R = 0; f = 1\ MHz$$

$$C_d \begin{matrix} \text{typ.} & \dots & \mu F \\ < & & 35\ \mu F \end{matrix}$$

Reverse recovery time when switched from

$$I_F = 30\ mA\ \text{to}\ I_R = 30\ mA; R_L = 100\ \Omega;$$

$$\text{measured at } I_R = 3\ mA$$

$$t_{rr} < 50\ ns$$

## HIGH-SPEED SILICON DIODE FOR SURFACE MOUNTING

The BAS32 is a planar epitaxial high-speed diode designed for fast logic applications.

This SM diode is a leadless diode in a hermetically sealed SOD-80 envelope with tin-plated metal discs at each end. It is suitable for "automatic placement" and as such it can withstand immersion soldering.

The diodes are delivered in "super 8" tape.

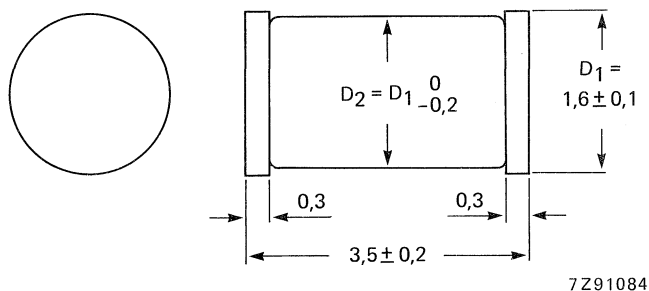
### QUICK REFERENCE DATA

Continuous reverse voltage	$V_R$	max.	75 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	75 V
Repetitive peak forward current	$I_{FRM}$	max.	450 mA
Junction temperature	$T_j$	max.	200 °C
Forward voltage $I_F = 100$ mA	$V_F$	<	1 V
Reverse recovery time when switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$ ; measured at $I_R = 1$ mA	$t_{rr}$	<	4 ns

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOD-80.



Cathode indicated by black band.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Continuous reverse voltage	$V_R$	max.	75 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	75 V*
Average rectified forward current	$I_F(AV)$	max.	150 mA**
Forward current (d.c.)	$I_F$	max.	200 mA
Repetitive peak forward current	$I_{FRM}$	max.	450 mA
Non-repetitive peak forward current			
$t = 1 \mu s$	$I_{FSM}$	max.	2000 mA
$t = 1 s$	$I_{FSM}$	max.	500 mA
Storage temperature	$T_{stg}$		-65 to + 200 °C
Junction temperature	$T_j$	max.	200 °C

**THERMAL RESISTANCE**

From junction to ambient in free air	$R_{th j-a}$	=	0,6 K/mW
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**CHARACTERISTICS**

$T_j = 25 \text{ °C}$  unless otherwise specified

Forward voltages

$I_F = 5 \text{ mA}$	$V_F$	0,62 to 0,75 V
$I_F = 100 \text{ mA}$	$V_F$	< 1,00 V
$I_F = 100 \text{ mA}; T_j = 100 \text{ °C}$	$V_F$	< 0,93 V

Reverse currents

$V_R = 20 \text{ V}$	$I_R$	< 25 nA
$V_R = 20 \text{ V}; T_j = 150 \text{ °C}$	$I_R$	< 50 $\mu A$
$V_R = 75 \text{ V}$	$I_R$	< 5 $\mu A$
$V_R = 75 \text{ V}; T_j = 150 \text{ °C}$	$I_R$	< 100 $\mu A$

Diode capacitance

$V_R = 0; f = 1 \text{ MHz}$	$C_d$	< 2 pF
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Forward recovery voltage when switched to

$I_F = 50 \text{ mA}; t_r = 20 \text{ ns}$	$V_{fr}$	< 2,5 V
--	----------	---------

\* Measured at zero life time at  $I_R = 100 \mu A; V_R > 100 \text{ V}$ .

\*\* For sinusoidal operation see Fig. 6. For pulse operation see Figs 4 and 5.

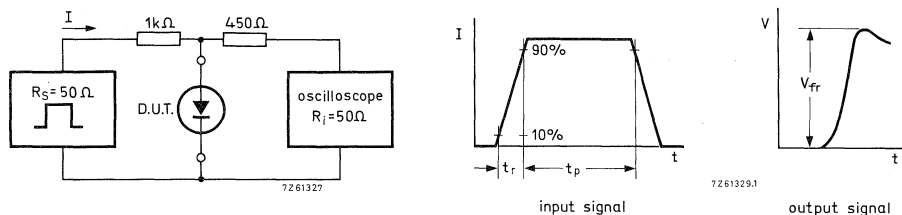


Fig. 2 Forward recovery voltage test circuit and waveforms.

Input signal : Rise time of the forward pulse  
 Forward current pulse duration  
 Duty factor

$t_r = 20 \text{ ns}$   
 $t_p = 120 \text{ ns}$   
 $\delta = 0,01$

Oscilloscope: Rise time

$t_r = 0,35 \text{ ns}$

Circuit capacitance  $C \leq 1 \text{ pF}$  ( $C =$  oscilloscope input capacitance + parasitic capacitance)

Reverse recovery time when switched from  
 $I_F = 10 \text{ mA}$  to  $I_R = 10 \text{ mA}$ ;  $R_L = 100 \Omega$ ;  
 measured at  $I_R = 1 \text{ mA}$

$t_{rr} < 4 \text{ ns}$

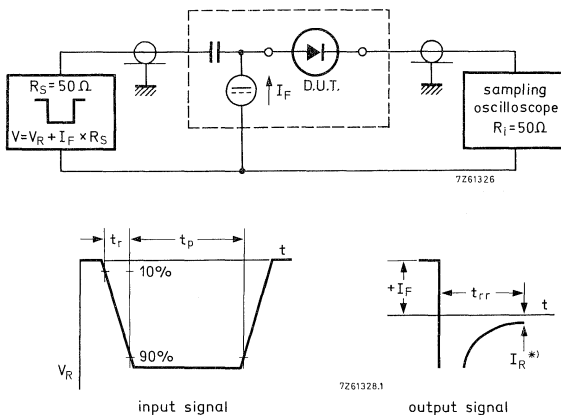


Fig. 3 Reverse recovery time test circuit and waveforms.

Input signal : Rise time of the reverse pulse  
 Reverse pulse duration  
 Duty factor

$t_r = 0,6 \text{ ns}$   
 $t_p = 100 \text{ ns}$   
 $\delta = 0,05$

\*  $I_R = 1 \text{ mA}$

Oscilloscope: Rise time

$t_r = 0,35 \text{ ns}$

Circuit capacitance  $C \leq 1 \text{ pF}$  ( $C =$  oscilloscope input capacitance + parasitic capacitance)

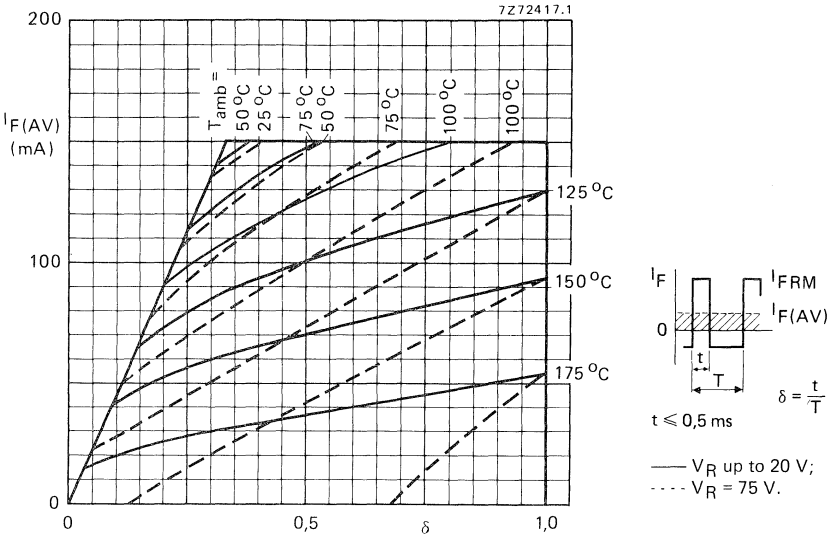


Fig. 4 Maximum permissible average rectified forward current versus duty factor (pulse operated).

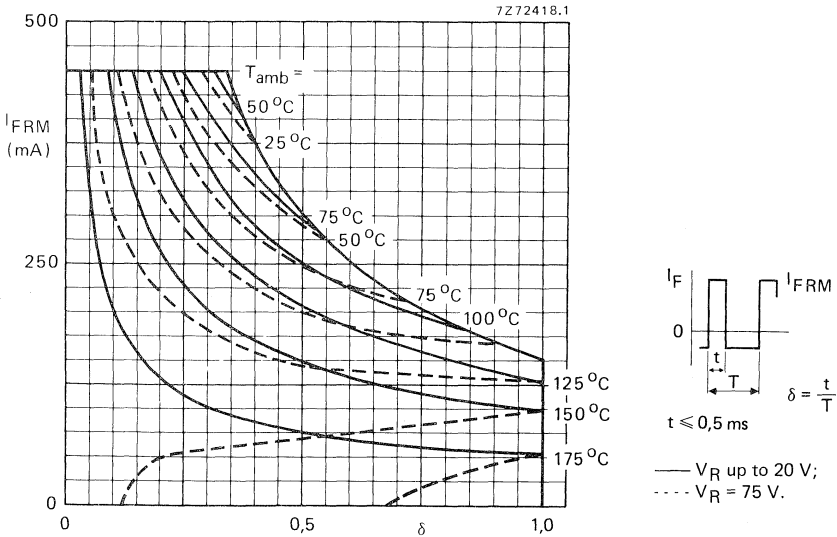


Fig. 5 Maximum permissible repetitive peak forward current versus duty factor (pulse operated).



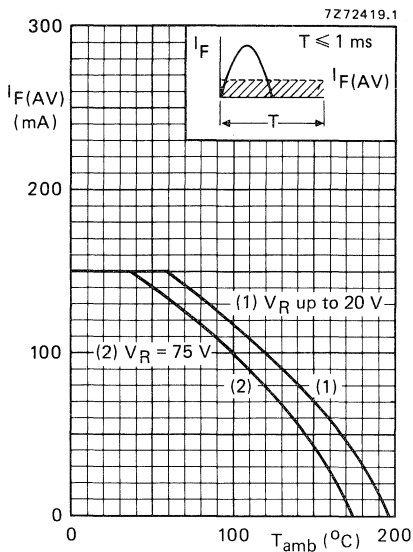


Fig. 6 Maximum permissible average rectified forward current versus ambient temperature.

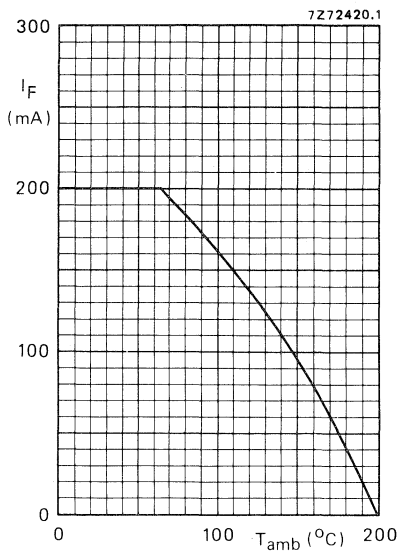


Fig. 7 Maximum permissible continuous forward current versus ambient temperature.

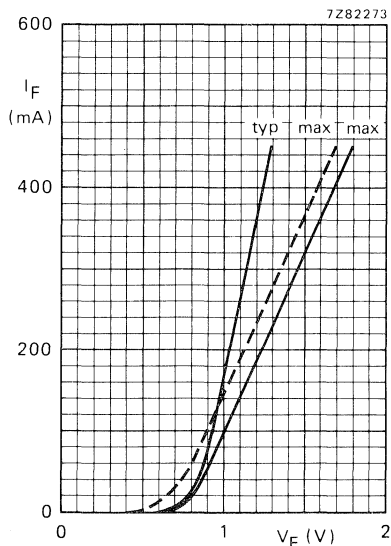


Fig. 8 Forward current versus forward voltage; —  $T_j = 25^{\circ}\text{C}$ ; - - -  $T_j = 175^{\circ}\text{C}$ .

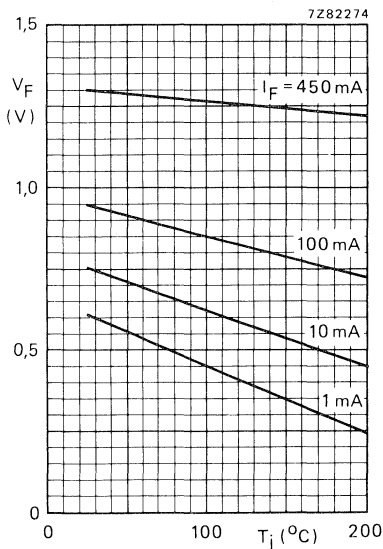


Fig. 9 Forward voltage versus junction temperature; typical values.

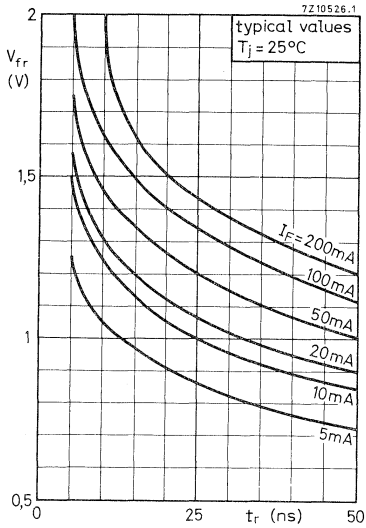


Fig. 10 Forward recovery voltage versus rise time.

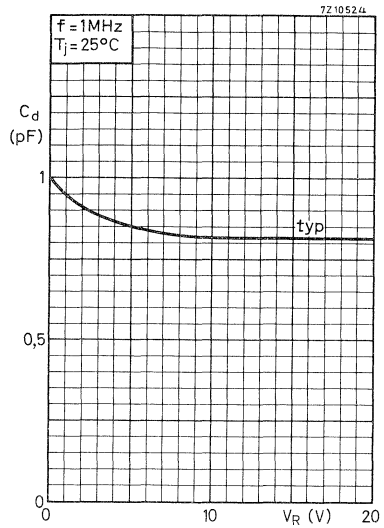


Fig. 11 Diode capacitance versus reverse voltage.

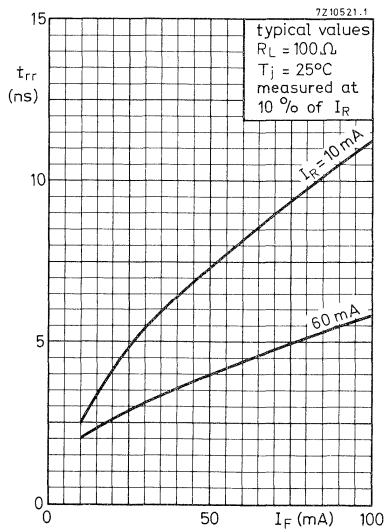


Fig. 12 Reverse recovery time versus forward current.

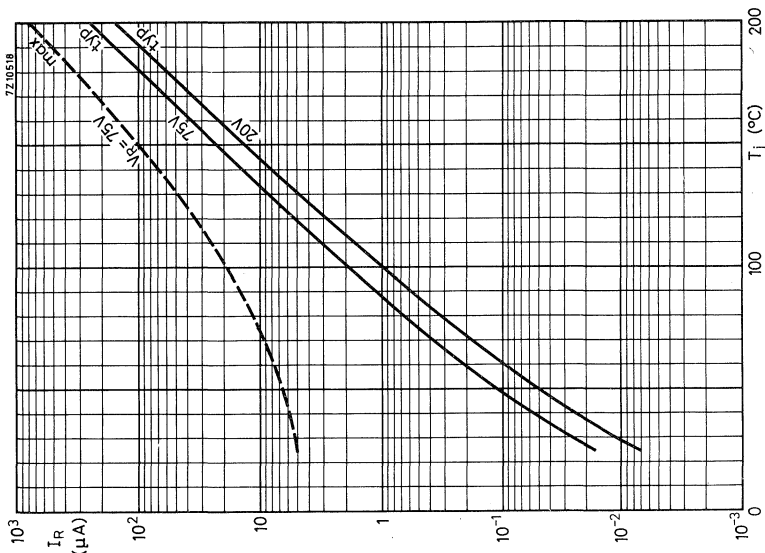


Fig. 14 Reverse current versus junction temperature.

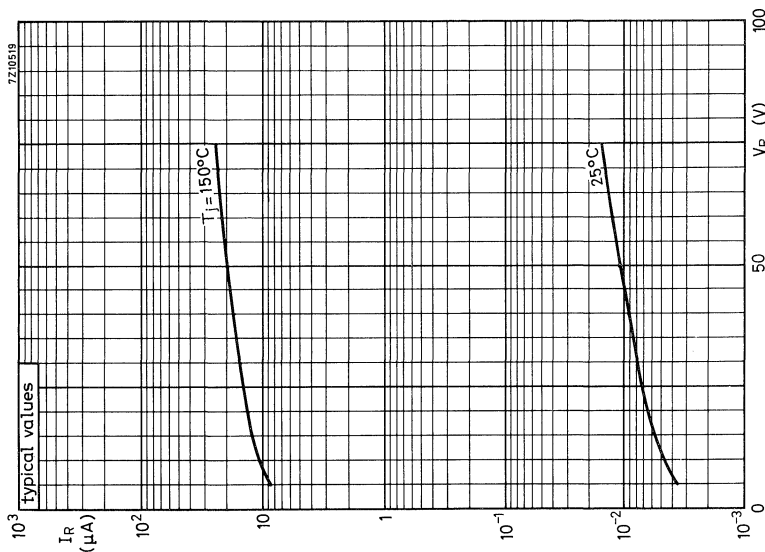


Fig. 13 Reverse current versus reverse voltage.



## SCHOTTKY BARRIER DIODE

Silicon epitaxial diode in a microminiature plastic envelope. Intended for u.h.f. mixer and fast switching applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

Continuous reverse voltage	$V_R$	max.	4 V
Forward current (d.c.)	$I_F$	max.	30 mA
Junction temperature	$T_j$	max.	100 °C
Forward voltage at $I_F = 10$ mA	$V_F$	<	600 mV
Diode capacitance at $V_R = 0$ ; $f = 1$ MHz	$C_d$	<	1,0 pF
Noise figure at $f = 900$ MHz	F	<	8,0 dB

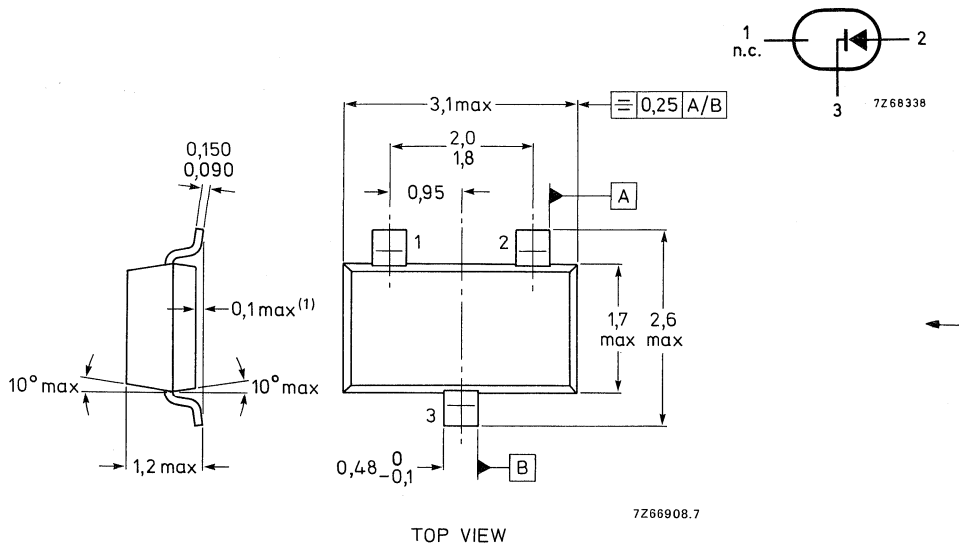
### MECHANICAL DATA

Dimensions in mm

Marking code

BAT17 = A3

Fig.1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Continuous reverse voltage	$V_R$	max.	4 V
Forward current (d.c.) **	$I_F$	max.	30 mA
Storage temperature	$T_{stg}$		-65 to +100 °C
Junction temperature	$T_j$	max.	100 °C

## THERMAL CHARACTERISTICS\*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

### Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

$T_{amb} = 25\text{ °C}$  unless otherwise specified

Reverse current

$$V_R = 3\text{ V}$$

$$I_R < 0,25\ \mu\text{A}$$

$$V_R = 3\text{ V}; T_{amb} = 60\text{ °C}$$

$$I_R < 1,25\ \mu\text{A}$$

Reverse breakdown voltage

$$I_R = 10\ \mu\text{A}$$

$$V_{(BR)R} > 4\text{ V}$$

Forward voltage

$$I_F = 0,1\text{ mA}$$

$$V_F < 350\text{ mV}$$

$$I_F = 1,0\text{ mA}$$

$$V_F < 450\text{ mV}$$

$$I_F = 10\text{ mA}$$

$$V_F < 600\text{ mV}$$

Diode capacitance

$$V_R = 0; f = 1\text{ MHz}$$

$$C_d < 1,0\ \text{pF}$$

Noise figure at  $f = 900\text{ MHz}$  ▲

$$F < 8,0\ \text{dB}$$

Series resistance at  $f = 1\text{ kHz}$

$$I_F = 5\text{ mA}$$

$$r_D < 15\ \Omega$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

▲ The local oscillator is adjusted for a diode current of 2 mA. I.F. amplifier noise  $F_{if} = 1,5\ \text{dB}$ ;  $f = 35\ \text{MHz}$ .

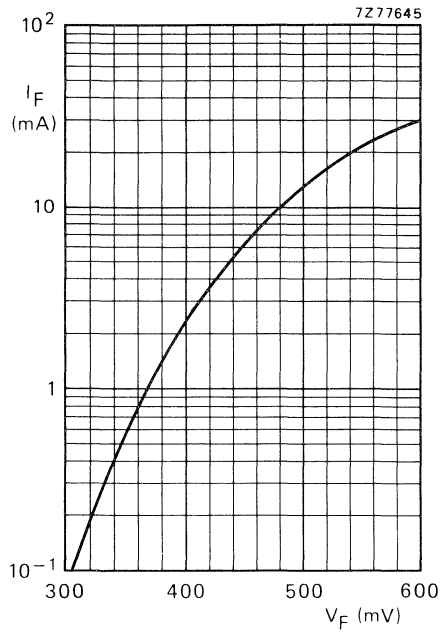


Fig. 2 Typical values.





## SILICON PLANAR DIODE

Band switching diode in a microminiature plastic envelope. Intended for thick and thin-film circuits.

### QUICK REFERENCE DATA

Continuous reverse voltage	$V_R$	max.	35 V
Forward current (d.c.)	$I_F$	max.	100 mA
Junction temperature	$T_j$	max.	100 °C
Diode capacitance at $f = 1$ MHz $V_R = 20$ V	$C_d$	typ. <	0,8 pF 1,0 pF
Series resistance at $f = 200$ MHz $I_F = 5$ mA	$r_D$	typ. <	0,5 $\Omega$ 0,7 $\Omega$

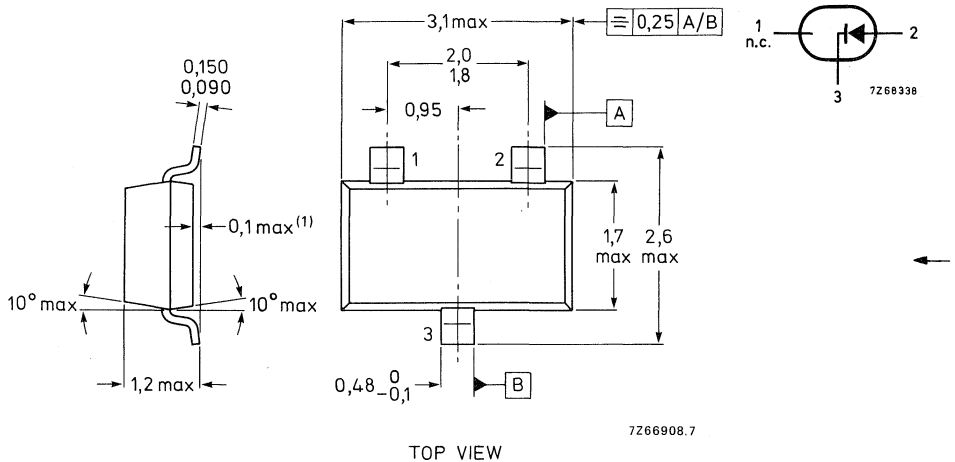
### MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BAT18 = A2



(1) Also available in 0,1 – 0,2 mm version.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Continuous reverse voltage	$V_R$	max.	35 V
Forward current (d.c.)	$I_F$	max.	100 mA
Storage temperature	$T_{stg}$		-55 to + 125 °C
Junction temperature	$T_j$	max.	125 °C

## THERMAL CHARACTERISTICS\*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

### Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

$T_j = 25\text{ °C}$  unless otherwise specified

Forward voltage at $I_F = 100\text{ mA}$	$V_F$	<	1,2 V
Reverse current	$I_R$	<	100 nA
$V_R = 20\text{ V}$	$I_R$	<	1 $\mu\text{A}$
$V_R = 20\text{ V}; T_j = 60\text{ °C}$			
Diode capacitance at $f = 1\text{ MHz}$	$C_d$	typ.	0,8 pF
$V_R = 20\text{ V}$		<	1,0 pF
Series resistance at $f = 200\text{ MHz}$	$r_D$	typ.	0,5 $\Omega$
$I_F = 5\text{ mA}$		<	0,7 $\Omega$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

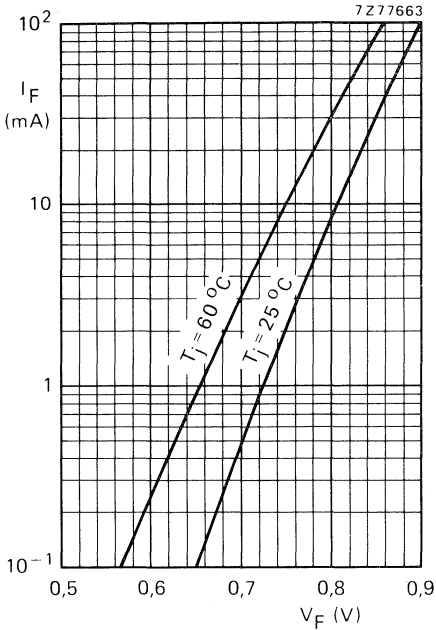


Fig. 2 Typical values.

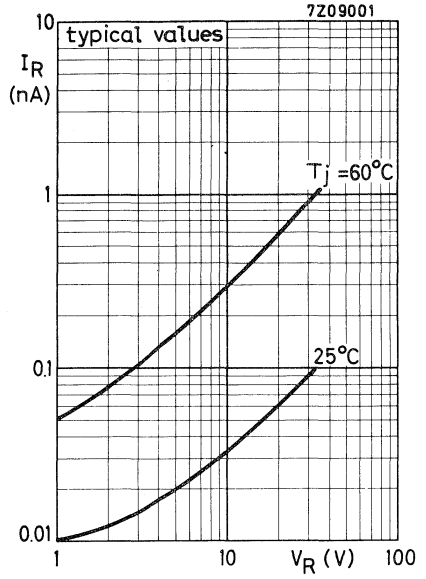


Fig. 3.

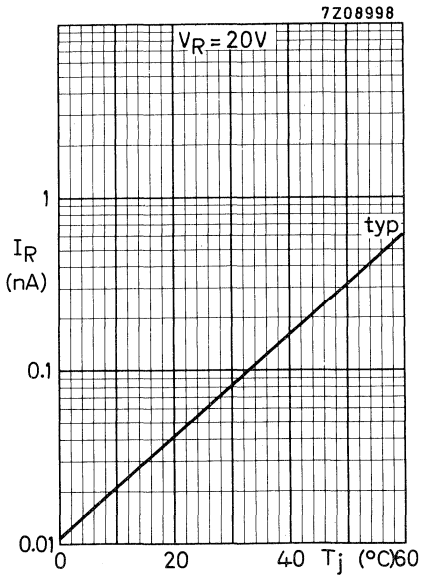


Fig. 4.

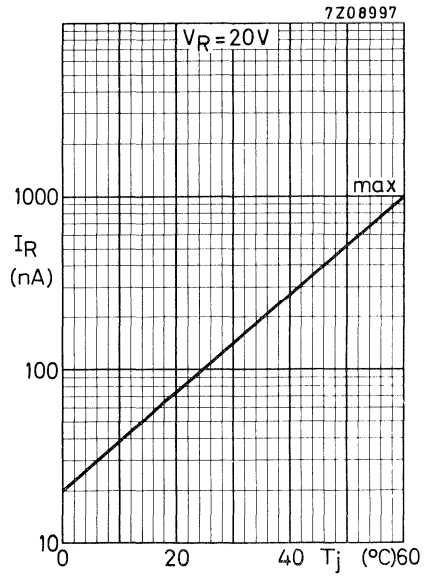


Fig. 5.

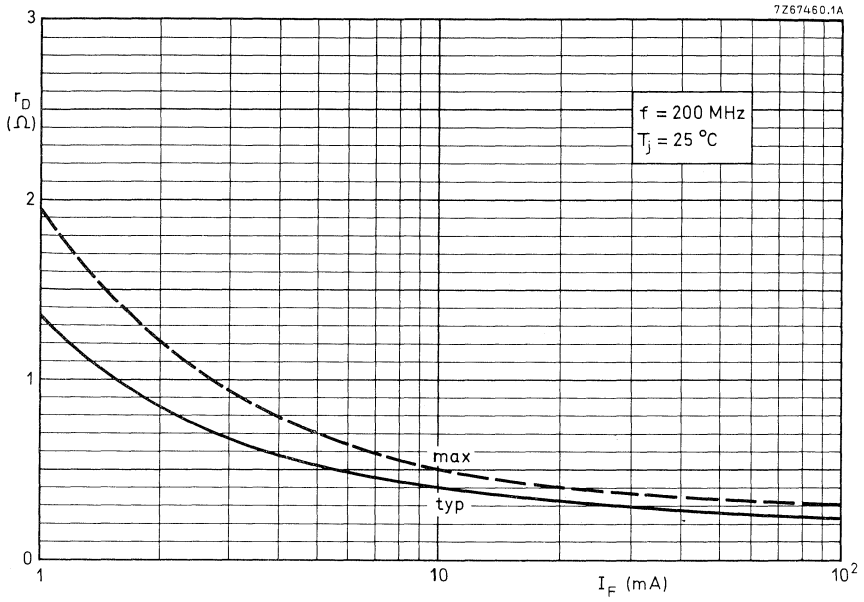


Fig. 6.

# DEVELOPMENT SAMPLE DATA

This information is derived from development samples made available for evaluation. It does not necessarily imply that the device will go into regular production.

BAV23

## SILICON PLANAR EPITAXIAL HIGH-SPEED DIODE

The BAV23 consists of two separate planar epitaxial high-speed diodes in one microminiature plastic envelope intended for surface mounting.

The device is designed for switching and general applications where high breakdown voltages are required.

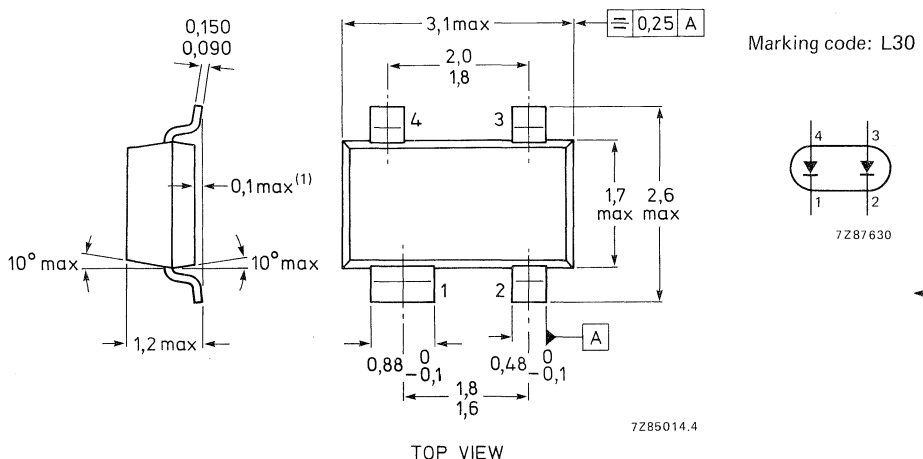
### QUICK REFERENCE DATA

		single diode	series connection
Continuous reverse voltage	$V_R$ max.	200	400 V
Repetitive peak reverse voltage	$V_{RRM}$ max.	250	500 V
Average forward current	$I_F(AV)$ max.	200	120 mA
Repetitive peak forward current	$I_{FRM}$ max.	625	450 mA
Total power dissipation up to $T_{amb} = 25^\circ C$	$P_{tot}$ max.	300	mW
Reverse recovery time when switched from $I_F = 30$ mA to $I_R = 30$ mA; $R_L = 100 \Omega$ ; measured at $I_R = 3$ mA	$t_{rr}$ <	50	ns

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-143.



(1) Also available in 0,1 – 0,2 mm version.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

			single diode	series connection
Continuous reverse voltage	$V_R$	max.	200	400 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	250	500 V
Average forward current	$I_{F(AV)}$	max.	200	120 mA
Repetitive peak forward current	$I_{FRM}$	max.	625	450 mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	300	mW
Storage temperature	$T_{stg}$		-65 to +150	$^\circ\text{C}$
Junction temperature	$T_j$	max.	150	$^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient on a ceramic substrate of 8 mm x 10 mm x 0,6 mm

$R_{th\ j-a}$	430	K/W
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**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

			single diode	series connection
Forward voltage				
$I_F = 100\text{ mA}$	$V_F$	<	1000	2000 mV
$I_F = 200\text{ mA}$		<	1250	2500 mV
Reverse current	$I_R$	<	100	100 nA
$V_R = V_{Rmax}$				
Reverse breakdown voltage	$V_{(BR)R}$	>	250	500 V
1 $I_R = 100\text{ }\mu\text{A}$				
Differential forward resistance	$r_f$	typ.	5	10 $\Omega$
$I_F = 10\text{ mA}$				
Diode capacitance	$C_d$	<	5	2,5 pF
$V_R = 0; f = 1\text{ MHz}$				
Reverse recovery time when switched from $I_F = 30\text{ mA}$ to $I_R = 30\text{ mA}$ ; $R_L = 100\text{ }\Omega$ ; measured at $I_R = 3\text{ mA}$	$t_{rr}$	<	50	50 ns

## SILICON PLANAR EPITAXIAL HIGH-SPEED DIODES

The BAV70 consists of two diodes in a microminiature plastic envelope. The cathodes are commoned and the unit is intended for high-speed switching in thick and thin-film circuits.

### QUICK REFERENCE DATA (per diode)

Continuous reverse voltage	$V_R$	max.	70 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	70 V
Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Junction temperature	$T_j$	max.	175 °C
Forward voltage at $I_F = 50$ mA	$V_F$	<	1,0 V
Reverse recovery time when switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$ ; measured at $I_R = 1$ mA	$t_{rr}$	<	6 ns
Recovery charge when switched from $I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$	$Q_s$	<	45 pC

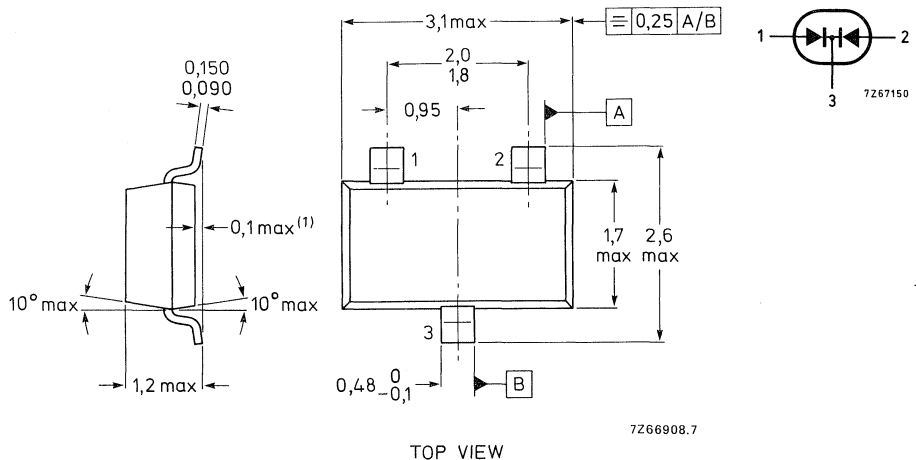
### MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BAV70 = A4



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS (per diode)**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Continuous reverse voltage	$V_R$	max.	70 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	70 V
Average rectified forward current <sup>▲</sup> (averaged over any 20 ms period)	$I_F(AV)$	max.	250 mA
Forward current (d.c.)	$I_F$	max.	250 mA
Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Storage temperature	$T_{stg}$	-65 to +	175 °C
Junction temperature	$T_j$	max.	175 °C

**THERMAL CHARACTERISTICS\***

$$T_{j1} = P_1 (R_{th\ j-t}) + T_{tab}$$

$$T_{j2} = P_2 (R_{th\ j-t}) + T_{tab}$$

$$T_{tab} = P_{tot} (R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS (per diode)**

$T_j = 25\text{ °C}$  unless otherwise specified

Forward voltage

$I_F = 1\text{ mA}$	$V_F$	<	715 mV
$I_F = 10\text{ mA}$	$V_F$	<	855 mV
$I_F = 50\text{ mA}$	$V_F$	<	1000 mV
$I_F = 150\text{ mA}$	$V_F$	<	1250 mV

Reverse current

$V_R = 25\text{ V}; T_j = 150\text{ °C}$	$I_R$	<	60 $\mu\text{A}$
$V_R = 70\text{ V}$	$I_R$	<	5 $\mu\text{A}$
$V_R = 70\text{ V}; T_j = 150\text{ °C}$	$I_R$	<	100 $\mu\text{A}$

Diode capacitance

$V_R = 0; f = 1\text{ MHz}$	$C_d$	<	1,5 pF
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Forward recovery voltage when switched to

$I_F = 10\text{ mA}; t_r = 20\text{ ns}$	$V_{fr}$	<	1,75 V
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▲ Measured under pulse conditions : pulse time  $t_p \leq 0,5\text{ ms}$ .  
For sinusoidal operation  $I_F(AV) = 150\text{ mA}$ ; averaging time  $t_{(av)} \leq 1\text{ ms}$ .

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.



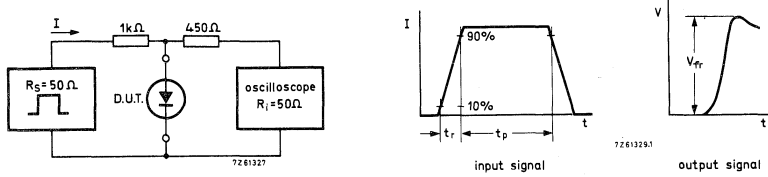


Fig. 2 Test circuit and waveforms; forward recovery voltage.

Input signal : Rise time of the forward pulse  $t_r = 20$  ns; Forward current pulse duration  $t_p = 120$  ns;

Duty factor  $\delta = 0,01$

Oscilloscope : Rise time  $t_r = 0,35$  ns

Circuit capacitance  $C \leq 1$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance)

Reverse recovery time when switched from

$I_F = 10$  mA to  $I_R = 10$  mA;  $R_L = 100 \Omega$ ;

measured at  $I_R = 1$  mA

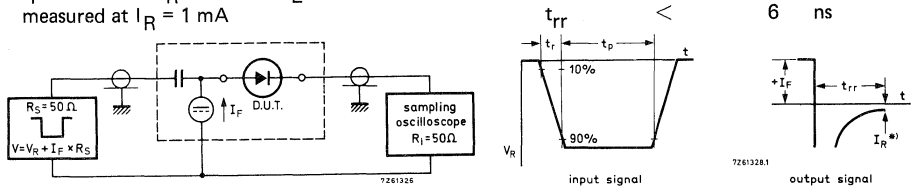


Fig. 3 Test circuit and waveforms; reverse recovery time.

\*)  $I_R = 1$  mA

Input signal : Rise time of the reverse pulse  $t_r = 0,6$  ns; reverse pulse

duration  $t_p = 100$  ns; duty factor  $\delta = 0,05$

Oscilloscope : Rise time  $t_r = 0,35$  ns

Circuit capacitance  $C \leq 1$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance)

Recovery charge when switched from

$I_F = 10$  mA to  $V_R = 5$  V;  $R_L = 500 \Omega$

$Q_s < 45$  pC

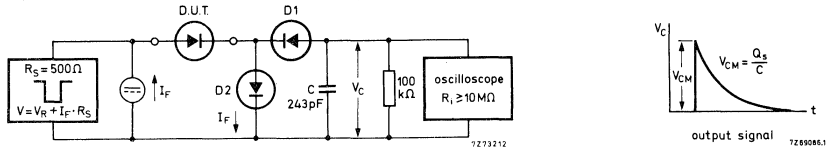


Fig. 4 Test circuit and waveform; recovery charge.

D1 = BAW62

D2 = diode with minority carrier life time at 10 mA:  $< 200$  ps

Input signal : Rise time of the reverse pulse =  $t_r = 2$  ns; Reverse pulse duration =  $t_p = 400$  ns;

Duty factor =  $\delta = 0,02$

Circuit capacitance  $C \leq 7$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance)

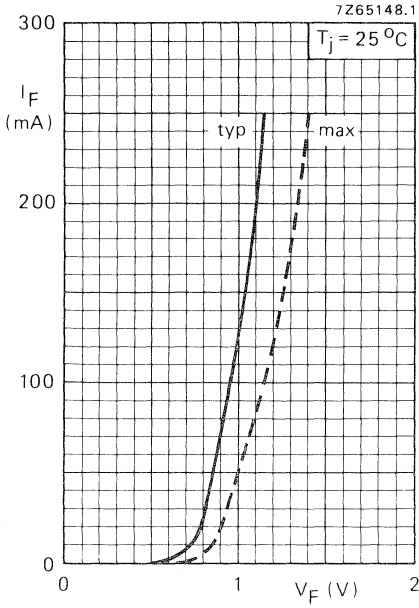


Fig. 5

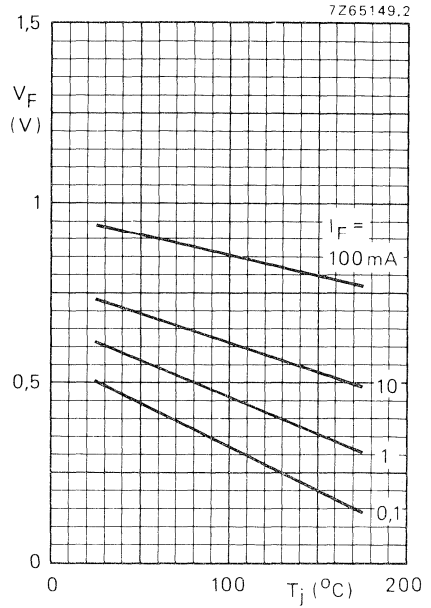


Fig. 6

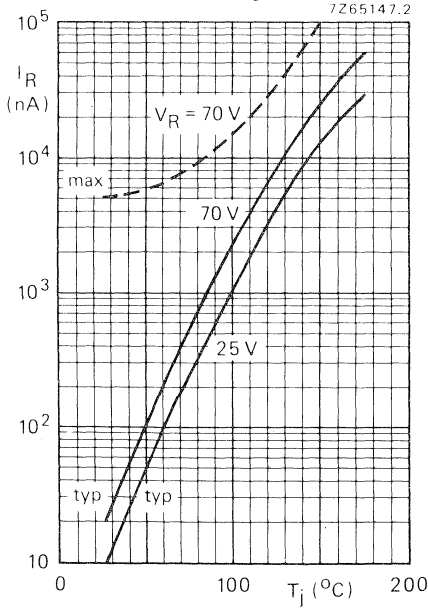


Fig. 7

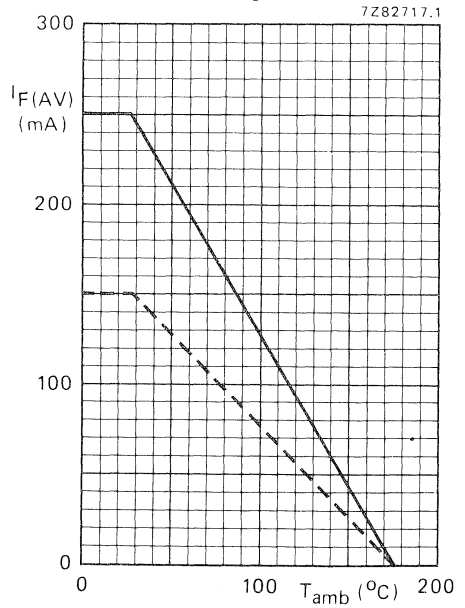


Fig. 8 ——— single diode  
 - - - - - double diode, equally loaded.

## SILICON PLANAR EPITAXIAL HIGH-SPEED DIODES

The BAV99 consists of two diodes in a microminiature plastic envelope. The diodes are connected in series and the unit is intended for high-speed switching in thick and thin-film circuits.

## QUICK REFERENCE DATA (per diode)

Continuous reverse voltage	$V_R$	max.	70 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	70 V
Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Junction temperature	$T_j$	max.	175 °C
Forward voltage at $I_F = 50$ mA	$V_F$	<	1,0 V
Reverse recovery time when switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$ ; measured at $I_R = 1$ mA	$t_{rr}$	<	6 ns
Recovery charge when switched from $I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$	$Q_s$	<	45 pC

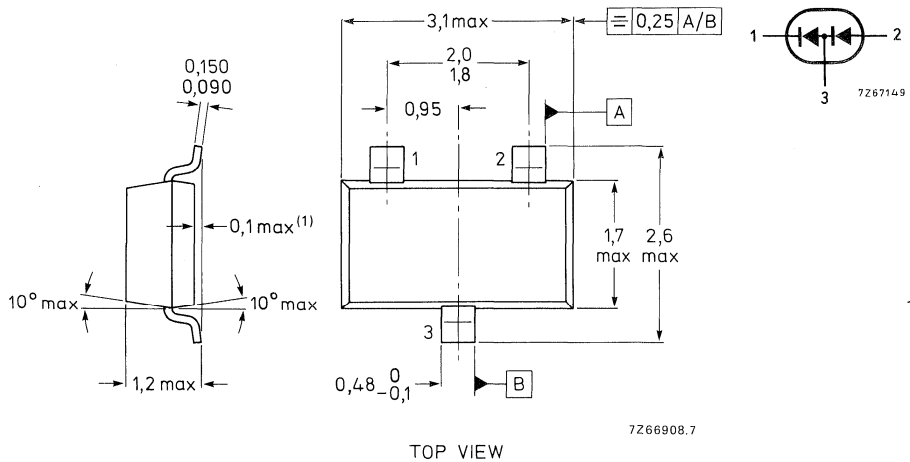
## MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BAV99 = A7



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS** (per diode)

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Continuous reverse voltage	$V_R$	max.	70 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	70 V
Average rectified forward current <sup>▲</sup> (averaged over any 20 ms period)	$I_F(AV)$	max.	250 mA
Forward current (d.c.)	$I_F$	max.	250 mA
Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Storage temperature	$T_{stg}$		-65 to +175 °C
Junction temperature	$T_j$	max.	175 °C

**THERMAL CHARACTERISTICS** \*

$$T_{j1} = P_1 (R_{th\ j-t}) + T_{tab}$$

$$T_{j2} = P_2 (R_{th\ j-t}) + T_{tab}$$

$$T_{tab} = P_{tot} (R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient **	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS** (per diode) $T_j = 25\text{ °C}$  unless otherwise specified

## Forward voltage

$I_F = 1\text{ mA}$	$V_F$	<	715 mV
$I_F = 10\text{ mA}$	$V_F$	<	855 mV
$I_F = 50\text{ mA}$	$V_F$	<	1000 mV
$I_F = 150\text{ mA}$	$V_F$	<	1250 mV

## Reverse current

$V_R = 25\text{ V}; T_j = 150\text{ °C}$	$I_R$	<	30 $\mu\text{A}$
$V_R = 70\text{ V}$	$I_R$	<	2,5 $\mu\text{A}$
$V_R = 70\text{ V}; T_j = 150\text{ °C}$	$I_R$	<	50 $\mu\text{A}$

## Diode capacitance

$V_R = 0; f = 1\text{ MHz}$	$C_d$	<	1,5 pF
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## Forward recovery voltage when switched to

$I_F = 10\text{ mA}; t_r = 20\text{ ns}$	$V_{fr}$	<	1,75 V
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▲ Measured under pulse conditions: pulse time  $t_p \leq 0,5\text{ ms}$ .For sinusoidal operation  $I_F(AV) = 150\text{ mA}$ ; averaging time  $t_{(av)} \leq 1\text{ ms}$ .\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

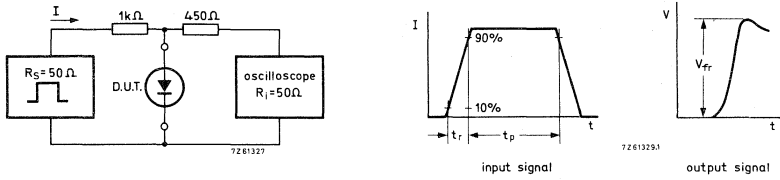


Fig. 2 Test circuit and waveforms; forward recovery voltage.

Input signal: Rise time of the forward pulse  $t_r = 20$  ns;  
 Forward current pulse duration =  $t_p = 120$  ns. Duty factor =  $\delta = 0,01$ .  
 Oscilloscope: Rise time  $t_r = 0,35$  ns.  
 Circuit capacitance  $C \leq 1$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance).  
 Reverse recovery time when switched from  
 $I_F = 10$  mA to  $I_R = 10$  mA;  $R_L = 100 \Omega$ ;  
 measured at  $I_R = 1$  mA

$$t_{rr} < 6 \text{ ns}$$

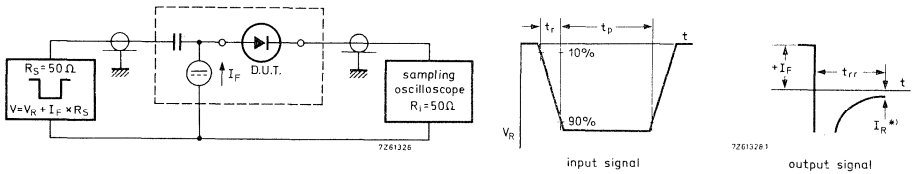


Fig. 3 Test circuit and waveforms; reverse recovery time.

Input signal: Rise time of the reverse pulse  $t_r = 0,6$  ns  
 Reverse pulse duration  $t_p = 100$  ns. Duty factor  $\delta = 0,05$ .  
 Oscilloscope: Rise time  $t_r = 0,35$  ns.  
 Circuit capacitance  $C \leq 1$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance).  
 Recovery charge when switched from  
 $I_F = 10$  mA to  $V_R = 5$  V;  $R_L = 500 \Omega$

$$Q_s < 45 \text{ pC}$$

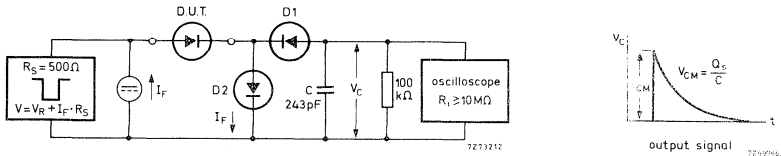


Fig. 4 Test and waveform; recovery charge.

$D2 =$  diode with minority carrier life time at 10 mA:  $< 200$  ps;  $D1 =$  BAW62.  
 Input signal: Rise time of the reverse pulse  $t_r = 2$  ns  
 Reverse pulse duration  $t_p = 400$  ns. Duty factor  $\delta = 0,02$ .  
 Circuit capacitance  $C \leq 7$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance).

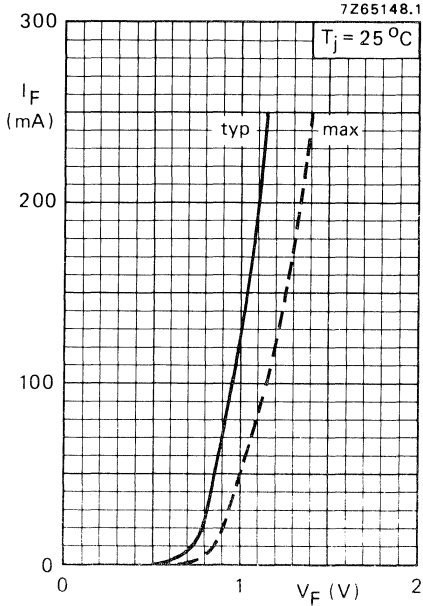


Fig. 5.

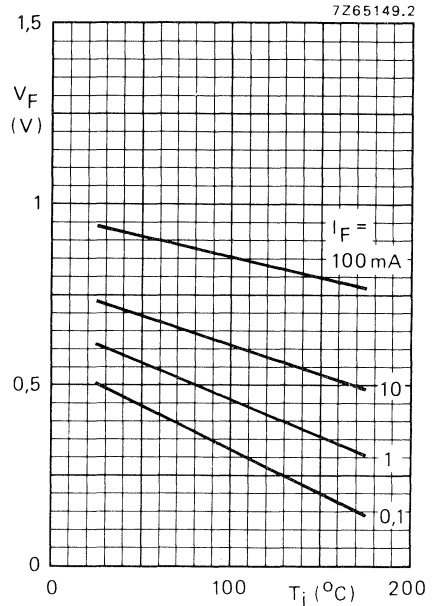


Fig. 6 Typical values.

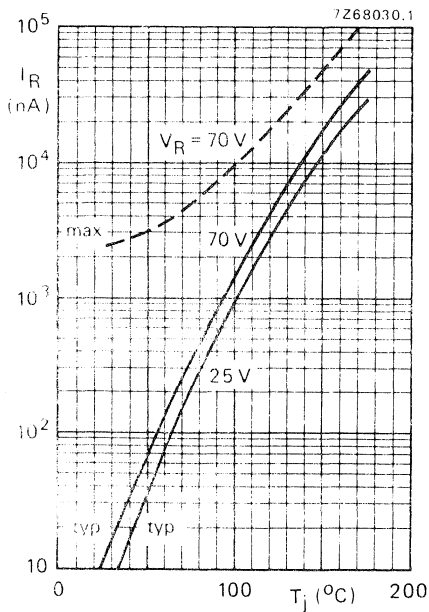


Fig. 7.

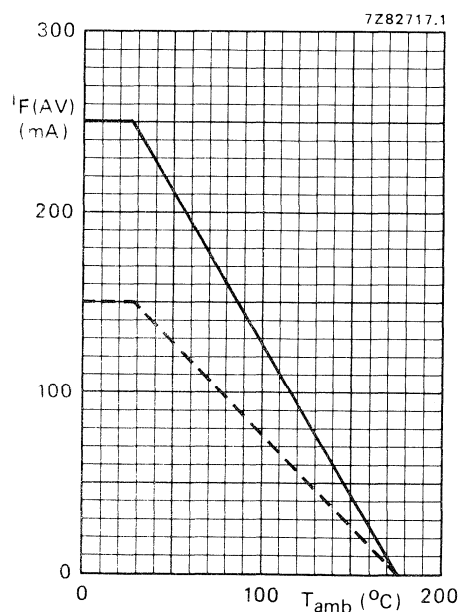


Fig. 8 — single diode  
 - - - double diode; equally loaded.

## DEVELOPMENT SAMPLE DATA

This information is derived from development samples made available for evaluation. It does not necessarily imply that the device will go into regular production.

BAV100 to 103

## GENERAL PURPOSE DIODES FOR SURFACE MOUNTING

Silicon planar epitaxial diodes; intended for switching and general purposes in industrial equipment e.g. oscilloscopes, digital voltmeters and video output stages in colour television.

The SM DIODE is a leadless diode in an hermetically sealed glass envelope with tin plated metal discs at each end. It is suitable for Automatic Placement and as such it can withstand immersion soldering.

The diodes are delivered in "super 8" tape.

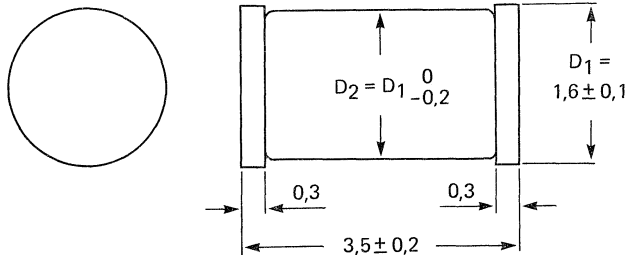
### QUICK REFERENCE DATA

		BAV100	BAV101	BAV102	BAV103
Continuous reverse voltage	$V_R$ max.	50	100	150	200 V
Forward current (d.c.)	$I_F$ max.		250		mA
Junction temperature	$T_j$ max.		175		°C
Thermal resistance from junction to ambient	$R_{th\ j-a}$		0,375		K/mW
Forward voltage at $I_F = 100$ mA	$V_F$	<	1,0		V
Reverse current at $V_R = V_{Rmax}$	$I_R$	<	100		nA
Diode capacitance at $V_R = 0$ ; $f = 1$ MHz	$C_d$	typ. <	1,5 5,0		pF pF
Reverse recovery time when switched from $I_F = 30$ mA to $I_R = 30$ mA; $R_L = 100 \Omega$ ; measured at $I_R = 3$ mA	$t_{rr}$	<	50		ns

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOD-80.



7Z91084

The BAV100 cathode is indicated by a green and a black band.

The BAV101 cathode is indicated by a green and a brown band.

The BAV102 cathode is indicated by a green and a red band.

The BAV103 cathode is indicated by a green and an orange band.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BAV100	BAV101	BAV102	BAV103
Continuous reverse voltage	$V_R$	max. 50	100	150	200 V
Repetitive peak reverse voltage	$V_{RRM}$	max. 60	120	200	250 V
Average rectified forward current	$I_{F(AV)}$	max.	250		mA <sup>1)</sup>
Forward current (d.c.)	$I_F$	max.	250		mA
Repetitive peak forward current	$I_{FRM}$	max.	625		mA
Non-repetitive peak forward current $t < 1$ s; $T_j = 25$ °C $t = 1$ $\mu$ s; $T_j = 25$ °C	$I_{FSM}$	max.	1		A
	$I_{FSM}$	max.	5		A
Total power dissipation up to $T_{amb} = 25$ °C	$P_{tot}$	max.	400		mW
Storage temperature	$T_{stg}$		-65 to + 175		°C
Junction temperature	$T_j$	max.	175		°C

**THERMAL RESISTANCE**

From junction to ambient in free air	$R_{th\ j-a}$	=	0,375		K/mW
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**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

		BAV100	BAV101	BAV102	BAV103
Forward voltage $I_F = 100$ mA	$V_F$	<		1,0	V
	$V_F$	<		1,25	V
Reverse breakdown voltage $I_R = 100$ $\mu$ A	$V_{(BR)R}$	> 60	120	200	250 V <sup>2)</sup>
	$I_R$	<		100	nA
Reverse current $V_R = V_{Rmax}$ $V_R = V_{Rmax}$ ; $T_j = 150$ °C	$I_R$	<		100	$\mu$ A
	$r_{diff}$	typ.		5	$\Omega$
Diode capacitance $V_R = 0$ ; $f = 1$ MHz	$C_d$	typ.		1,5	pF
	$C_d$	<		5,0	pF
Reverse recovery time when switched from $I_F = 30$ mA to $I_R = 30$ mA; $R_L = 100$ $\Omega$ ; measured at $I_R = 3$ mA	$t_{rr}$	<		50	ns

<sup>1)</sup> For sinusoidal operation see Figs 7 to 10. For pulse operation see Figs 3 to 6.

<sup>2)</sup> At zero life time, measured under pulse conditions to avoid excessive dissipation and voltage limited at 275 V.



Test circuit and waveforms:

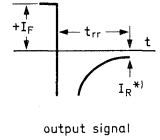
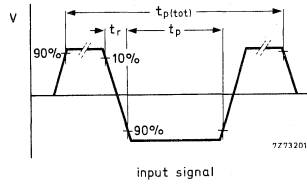
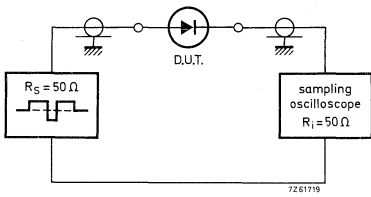


Fig. 2.

\*)  $I_R = 3 \text{ mA}$

Input signal:	Total pulse duration	$t_p(\text{tot})$	=	2 $\mu\text{s}$
	Duty factor	$\delta$	=	0,0025
	Rise time of the reverse pulse	$t_r$	=	0,6 ns
	Reverse pulse duration	$t_p$	=	100 ns
Oscilloscope:	Rise time	$t_r$	=	0,35 ns
Circuit capacitance $C \leq 1 \text{ pF}$ ( $C = \text{oscilloscope input capacitance} + \text{parasitic capacitance}$ )				

DEVELOPMENT SAMPLE DATA

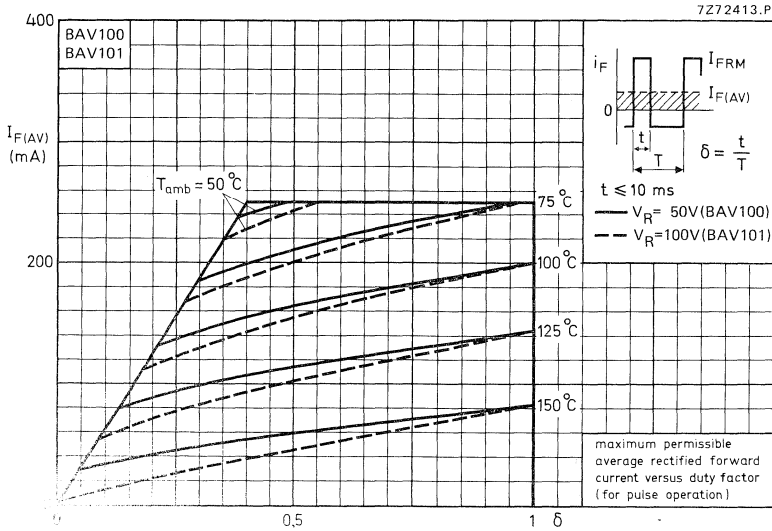


Fig. 3.

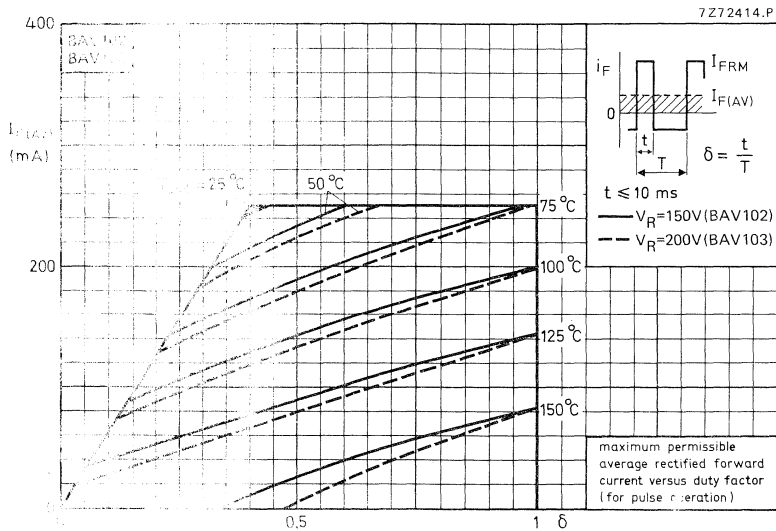


Fig. 4.

DEVELOPMENT SAMPLE DATA

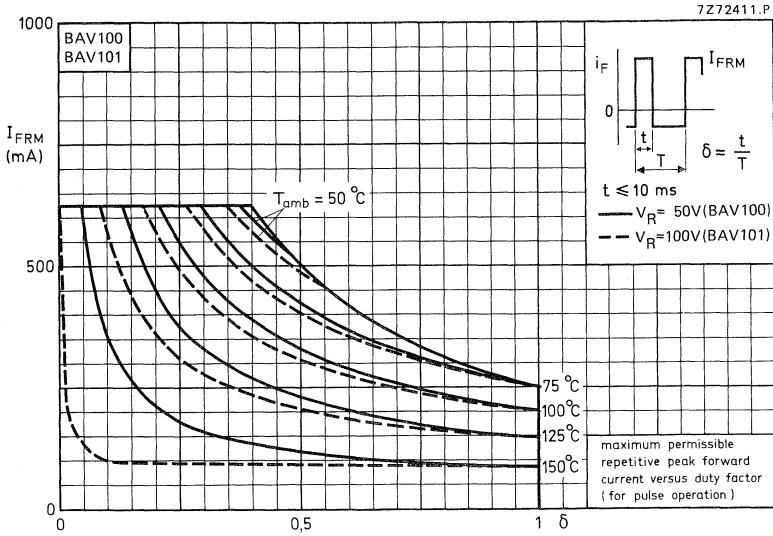


Fig. 5.

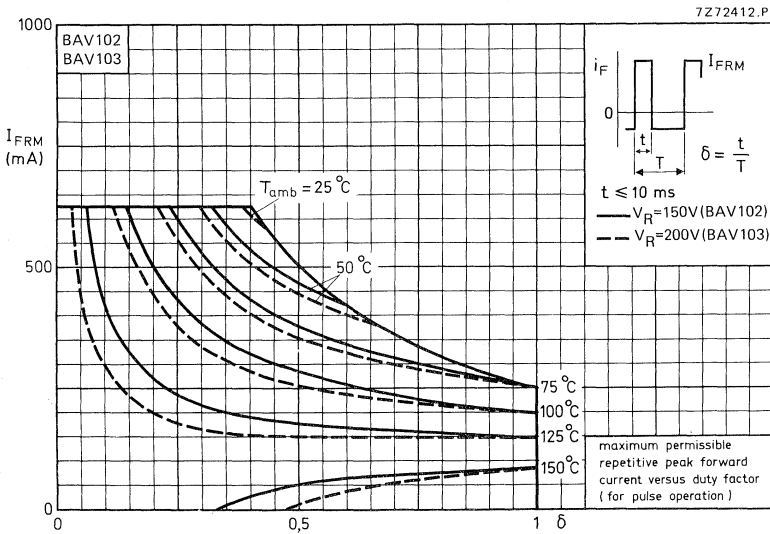


Fig. 6.

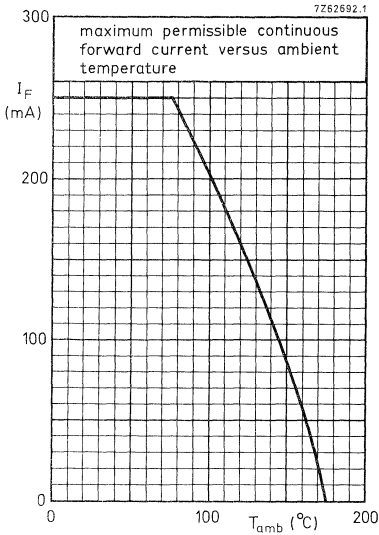


Fig. 7.

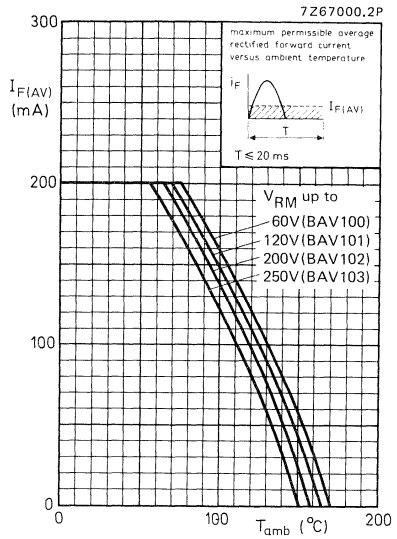


Fig. 8.

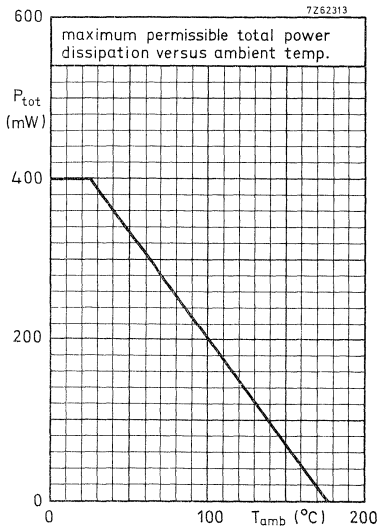


Fig. 9.

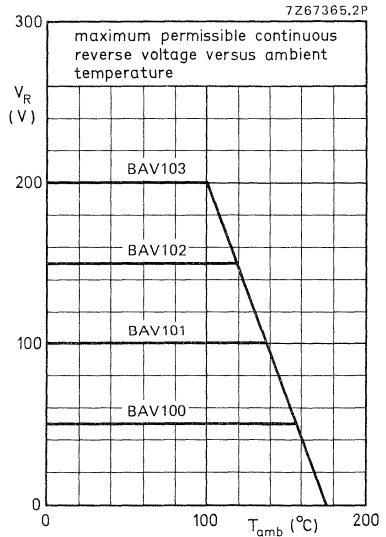


Fig. 10.

DEVELOPMENT SAMPLE DATA

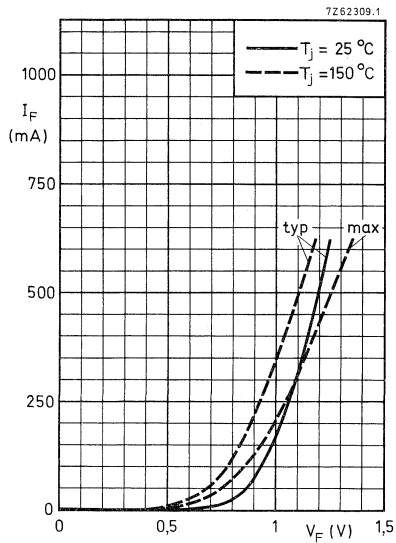


Fig. 11.

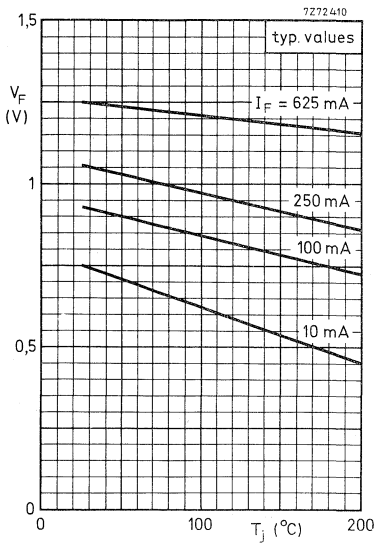


Fig. 12.

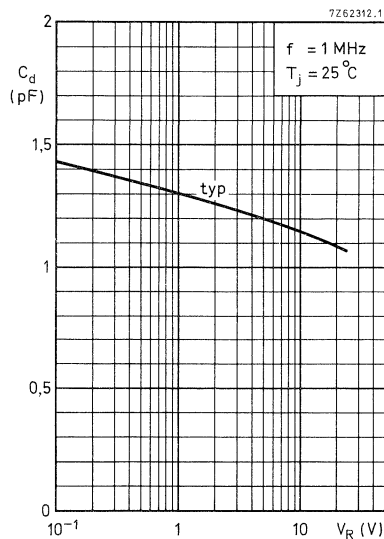


Fig. 13.

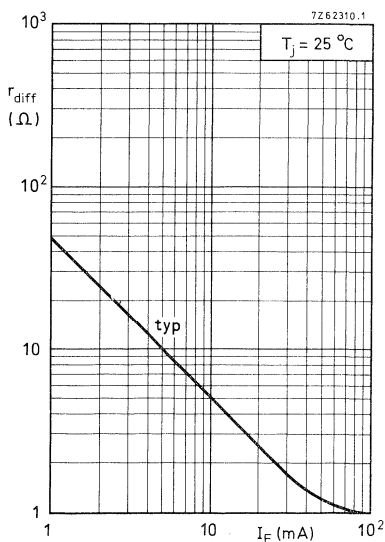


Fig. 14.

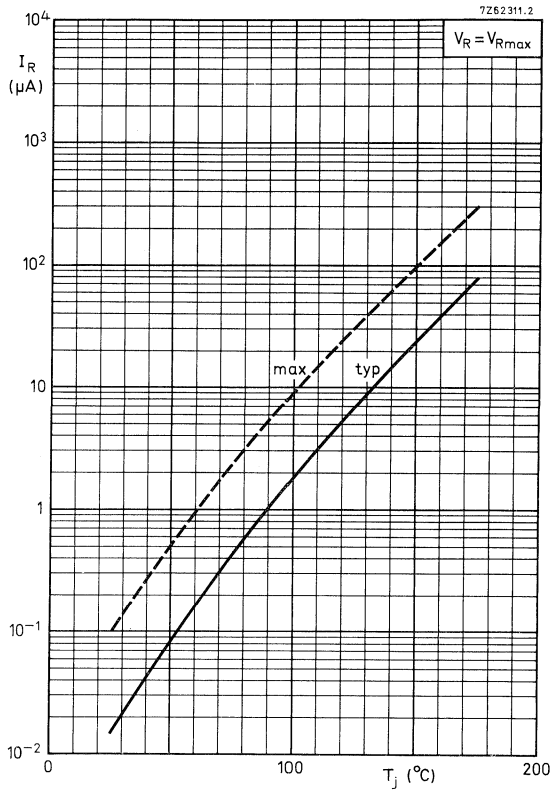


Fig. 15.

## SILICON PLANAR EPITAXIAL HIGH-SPEED DIODES

The BAW56 consists of two diodes in a microminiature plastic envelope. The anodes are commoned and the unit is intended for high-speed switching in thick and thin-film circuits.

### QUICK REFERENCE DATA (per diode)

Continuous reverse voltage	$V_R$	max.	70 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	70 V
Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Junction temperature	$T_j$	max.	175 °C
Forward voltage at $I_F = 50$ mA	$V_F$	<	1,0 V
Reverse recovery time when switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$ ; measured at $I_R = 1$ mA	$t_{rr}$	<	6 ns
Recovery charge when switched from $I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$	$Q_s$	<	45 pC

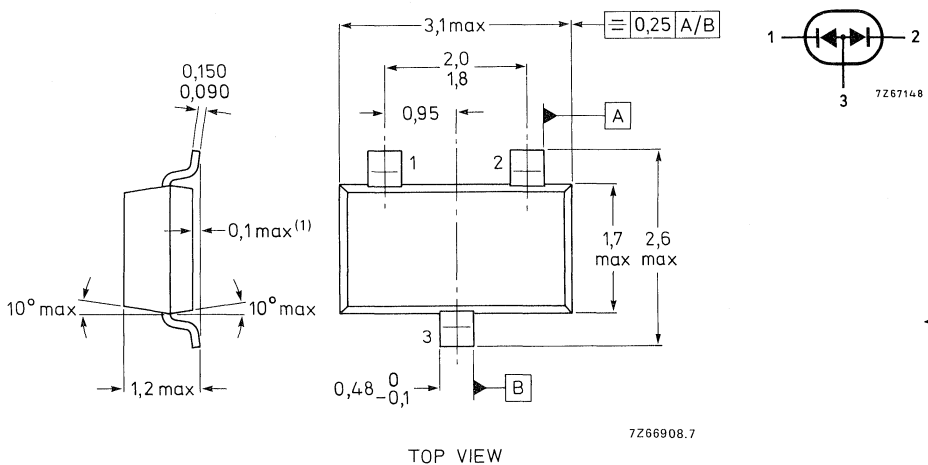
### MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BAW56 = A1



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS** (per diode)

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Continuous reverse voltage	$V_R$	max.	70 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	70 V
Average rectified forward current <sup>▲</sup> (averaged over any 20 ms period)	$I_{F(AV)}$	max.	250 mA
Forward current (d.c.)	$I_F$	max.	250 mA
Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Storage temperature	$T_{stg}$		-65 to +175 °C
Junction temperature	$T_j$	max.	175 °C

**THERMAL CHARACTERISTICS \***

$$T_{j1} = P_1 (R_{th j-t}) + T_{tab}$$

$$T_{j2} = P_2 (R_{th j-t}) + T_{tab}$$

$$T_{tab} = P_{tot} (R_{th t-s} + R_{th s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th j-t}$	=	60 K/W
From tab to soldering points	$R_{th t-s}$	=	2 x 280 K/W
From soldering points to ambient **	$R_{th s-a}$	=	2 x 90 K/W

**CHARACTERISTICS** (per diode) $T_j = 25$  °C unless otherwise specified**Forward voltage**

$$I_F = 1 \text{ mA}$$

$$I_F = 10 \text{ mA}$$

$$I_F = 50 \text{ mA}$$

$$I_F = 150 \text{ mA}$$

$V_F$	<	715 mV
$V_F$	<	855 mV
$V_F$	<	1000 mV
$V_F$	<	1250 mV

**Reverse current**

$$V_R = 25 \text{ V}; T_j = 150$$
 °C

$$V_R = 70 \text{ V}$$

$$V_R = 70 \text{ V}; T_j = 150$$
 °C

$I_R$	<	30 $\mu$ A
$I_R$	<	2,5 $\mu$ A
$I_R$	<	50 $\mu$ A

**Diode capacitance**

$$V_R = 0; f = 1 \text{ MHz}$$

$C_d$	<	2 pF
-------	---	------

**Forward recovery voltage when switched to**

$$I_F = 10 \text{ mA}; t_f = 20 \text{ ns}$$

$V_{fr}$	<	1,75 V
----------	---	--------

<sup>▲</sup> Measured under pulse conditions: pulse time  $t_p \leq 0,5$  ms.

For sinusoidal operation  $I_{F(AV)} = 150$  mA; averaging time  $t_{(av)} \leq 1$  ms.

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.



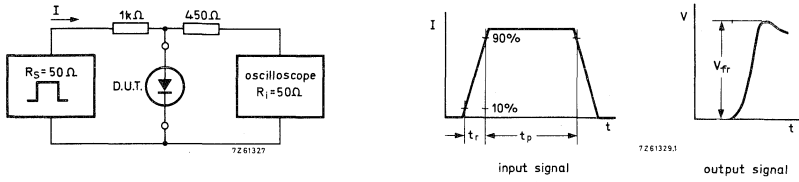


Fig. 2 Test circuit and waveforms; forward recovery voltage.

Input signal: Rise time of the forward pulse  $t_r = 20$  ns  
 Forward current pulse duration  $t_p = 120$  ns. Duty factor  $\delta = 0,01$   
 Oscilloscope: Rise time  $t_r = 0,35$  ns.  
 Circuit capacitance  $C \leq 1$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance)

Reverse recovery time when switched from  
 $I_F = 10$  mA to  $I_R = 10$  mA;  $R_L = 100 \Omega$ ;  
 measured at  $I_R = 1$  mA

$$t_{rr} < 6 \text{ ns}$$

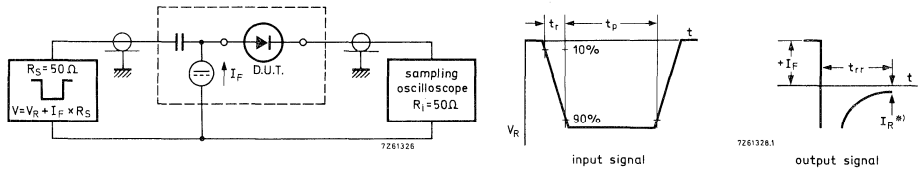


Fig. 3 Test circuit and waveforms; reverse recovery time.

Input signal: Rise time of the reverse pulse  $t_r = 0,6$  ns  
 Reverse pulse duration  $t_p = 100$  ns. Duty factor  $\delta = 0,05$ .  
 Oscilloscope: Rise time  $t_r = 0,35$  ns  
 Circuit capacitance  $C \leq 1$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance)

Recovery charge when switched from  
 $I_F = 10$  mA to  $V_R = 5$  V;  $R_L = 500 \Omega$

$$Q_s < 45 \text{ pC}$$

\*)  $I_R = 1$  mA

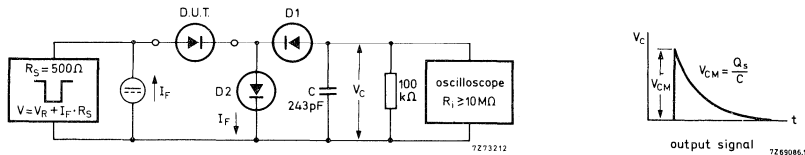


Fig. 4 Test circuit and waveform; recovery charge.

D2 = diode with minority carrier life time at 10 mA:  $< 200$  ps. D1 = BAW62.

Input signal: Rise time of the reverse pulse  $t_r = 2$  ns  
 Reverse pulse duration  $t_p = 400$  ns. Duty factor  $\delta = 0,02$

Circuit capacitance  $C \leq 7$  pF ( $C =$  oscilloscope input capacitance + parasitic capacitance).

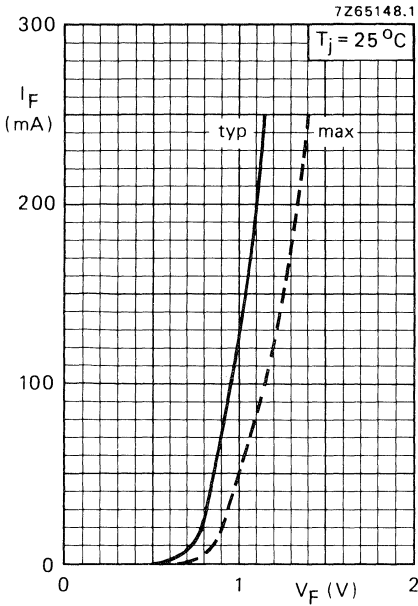


Fig. 5.

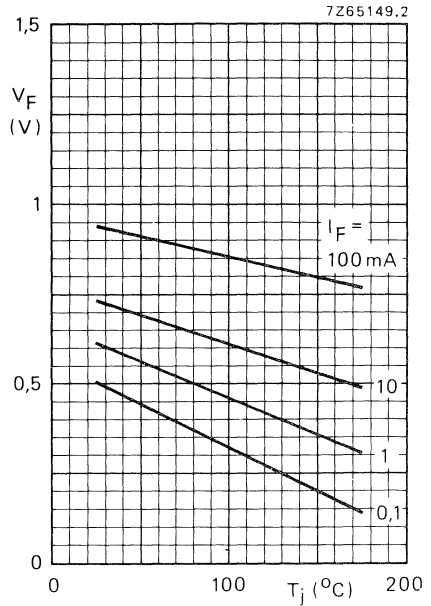


Fig. 6 Typical values.

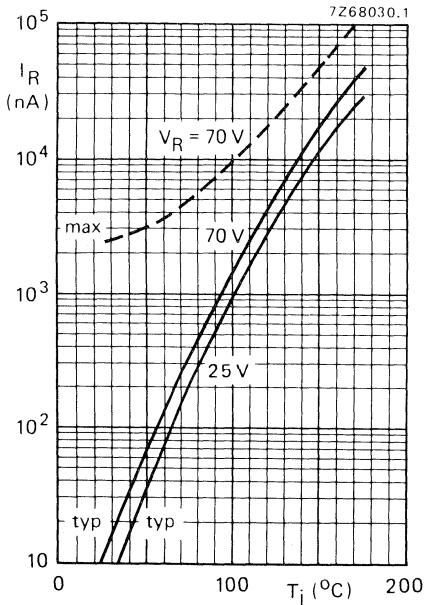


Fig. 7.

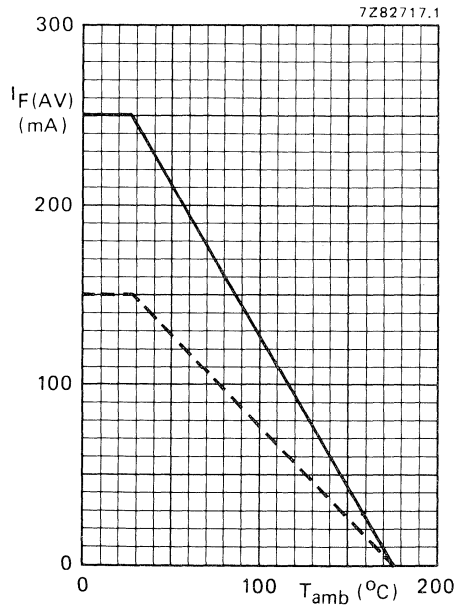


Fig. 8 — single diode;  
 - - - double diode, equally loaded.

## VARIABLE CAPACITANCE DIODE

Silicon planar variable capacitance diode in a microminiature envelope. It is intended for electronic tuning applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

Reverse voltage	$V_R$	max.	28 V
Reverse current at $V_R = 28$ V	$I_R$	<	50 nA
Diode capacitance at $f = 1$ MHz $V_R = 25$ V	$C_d$		1,8 to 2,8 pF
Capacitance ratio at $f = 1$ MHz	$\frac{C_d(V_R = 3 \text{ V})}{C_d(V_R = 25 \text{ V})}$	typ.	5
Series resistance at $f = 470$ MHz $V_R =$ that value at which $C_d = 9$ pF	$r_D$	<	1,2 $\Omega$

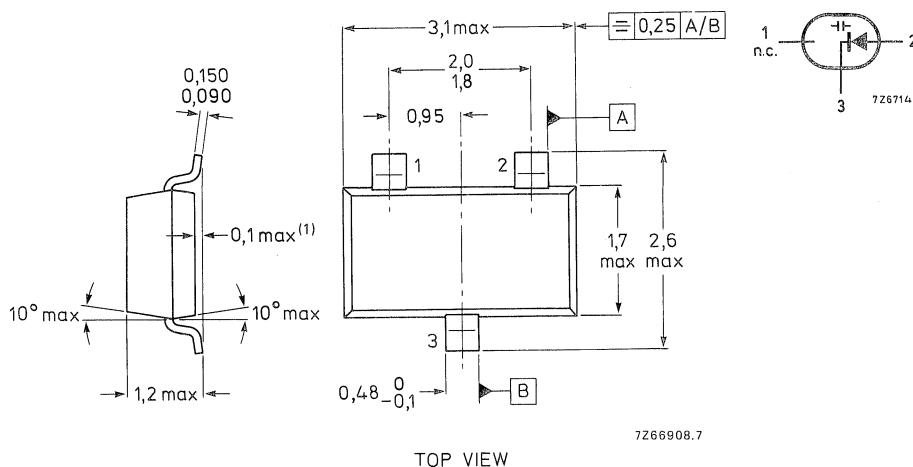
### MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BBY31 = S1



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Continuous reverse voltage	$V_R$	max.	28 V
Reverse voltage (peak value)	$V_{RM}$	max.	30 V
Forward current (d.c.)**	$I_F$	max.	20 mA
Storage temperature	$T_{stg}$		-65 to +100 °C
Operating junction temperature	$T_j$	max.	85 °C

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25\text{ °C}$  unless otherwise specified

Reverse current

$V_R = 28\text{ V}$	$I_R$	<	50 nA
---------------------	-------	---	-------

$V_R = 28\text{ V}; T_j = 85\text{ °C}$	$I_R$	<	1000 nA
---	-------	---	---------

Diode capacitance at  $f = 1\text{ MHz}$

$V_R = 1\text{ V}$	$C_d$	typ.	17,5 pF
--------------------	-------	------	---------

$V_R = 3\text{ V}$	$C_d$	typ.	11,5 pF
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$V_R = 25\text{ V}$	$C_d$		1,8 to 2,8 pF
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Capacitance ratio at  $f = 1\text{ MHz}$

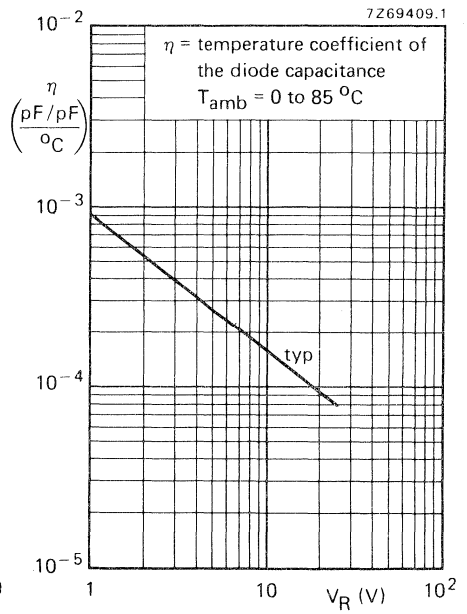
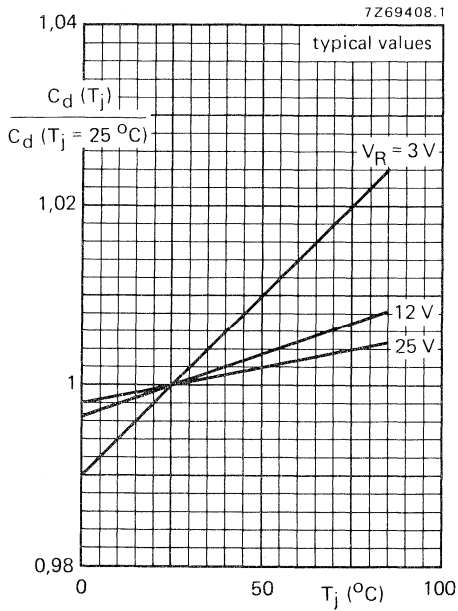
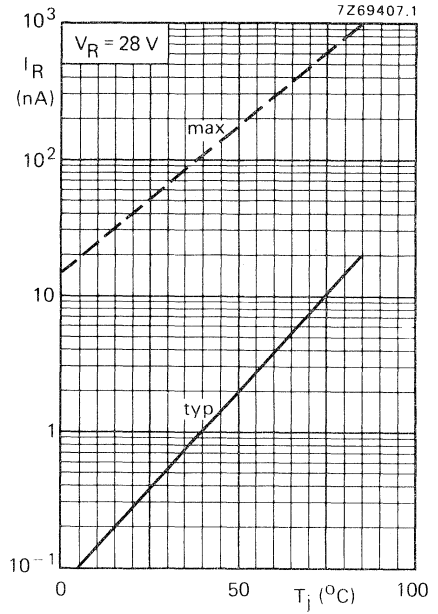
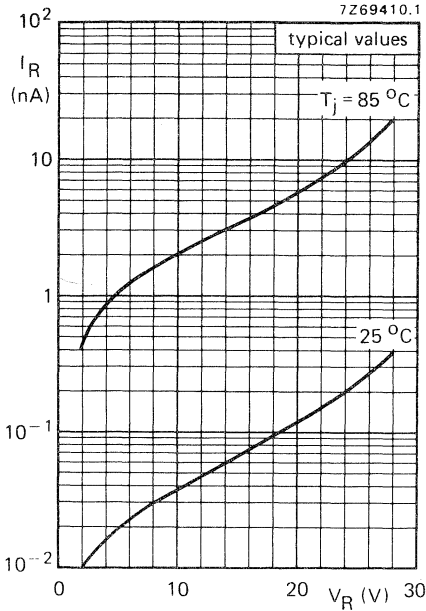
$\frac{C_d(V_R = 3\text{ V})}{C_d(V_R = 25\text{ V})}$	typ.	5
--	------	---

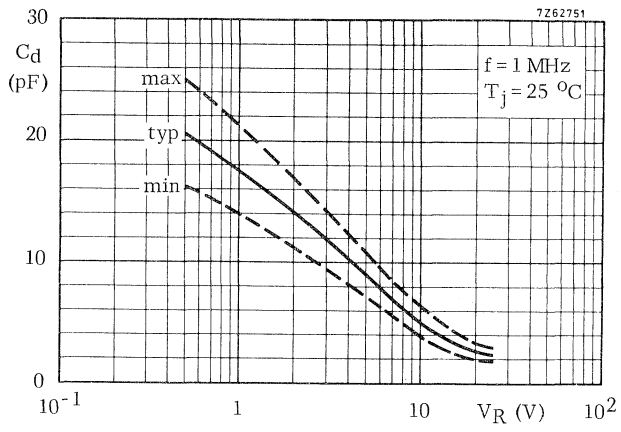
Series resistance at  $f = 470\text{ MHz}$

and at that value of $V_R$ at which $C_d = 9\text{ pF}$	$r_D$	<	1,2 $\Omega$
---	-------	---	--------------

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.





## SILICON PLANAR VARIABLE CAPACITANCE DIODE

The BBY40 is a variable capacitance diode in a plastic envelope intended for electronic tuning in v.h.f. television tuners with extended band I (FCC and OIRT-norm).

### QUICK REFERENCE DATA

Continuous reverse voltage	$V_R$	max.	28 V
Reverse current at $V_R = 28$ V	$I_R$	<	50 nA
Diode capacitance at $f = 1$ MHz	$C_d$		26 to 32 pF
$V_R = 3$ V	$C_d$		4,3 to 6 pF
$V_R = 25$ V	$C_d$		4,3 to 6 pF
Capacitance ratio at $f = 1$ MHz	$\frac{C_d (V_R = 3 \text{ V})}{C_d (V_R = 25 \text{ V})}$		5 to 6,5
Series resistance at $f = 200$ MHz	$r_D$	<	0,6 $\Omega$
$V_R$ is that value at which $C_d = 25$ pF			

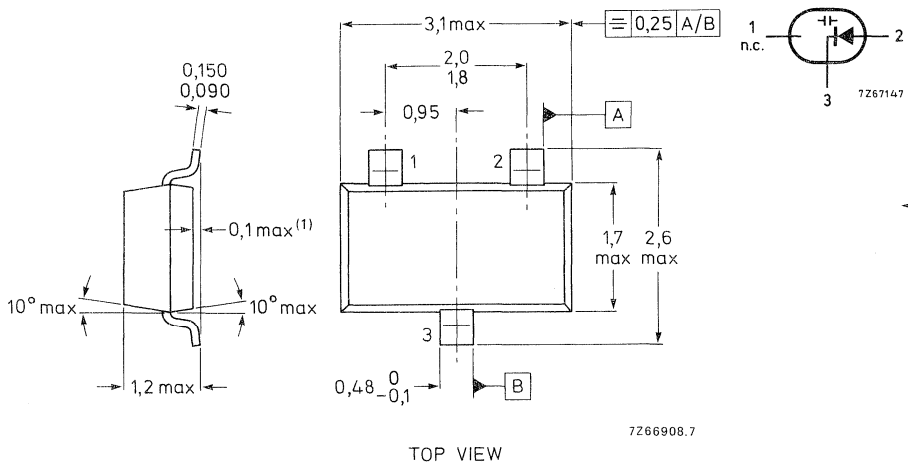
### MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BBY40 = S2



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Continuous reverse voltage	$V_R$	max.	28 V
Reverse voltage (repetitive peak value)	$V_{RRM}$	max.	30 V
Forward current (d.c.)	$I_F$	max.	20 mA
Storage temperature	$T_{stg}$		-55 to + 100 °C
Operating junction temperature	$T_j$	max.	85 °C

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_{amb} = 25\text{ °C}$  unless otherwise specified

Reverse current

$V_R = 28\text{ V}$	$I_R$	typ.	0,1 nA
		<	50 nA
$V_R = 28\text{ V}; T_{amb} = 60\text{ °C}$	$I_R$	<	500 nA

Diode capacitance at  $f = 1\text{ MHz}$

$V_R = 3\text{ V}$	$C_d$	26 to 32 pF
$V_R = 25\text{ V}$	$C_d$	4,3 to 6 pF

Capacitance ratio at  $f = 1\text{ MHz}$

$$\frac{C_d(V_R = 3\text{ V})}{C_d(V_R = 25\text{ V})} \quad 5\text{ to }6,5$$

Series resistance at  $f = 200\text{ MHz}$

$V_R$ is that value at which $C_d = 25\text{ pF}$	$r_D$	typ.	0,4 $\Omega$
		<	0,6 $\Omega$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.



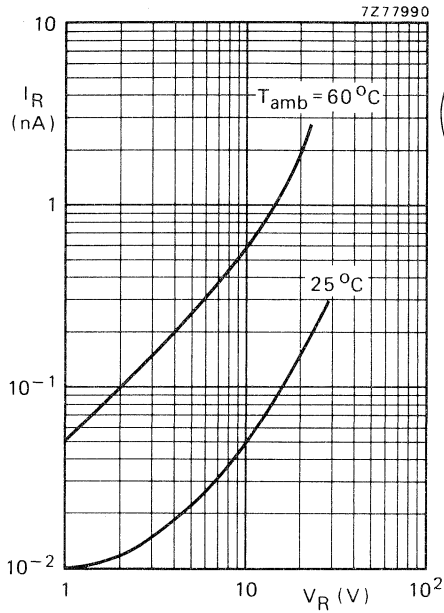


Fig. 2 Typical values

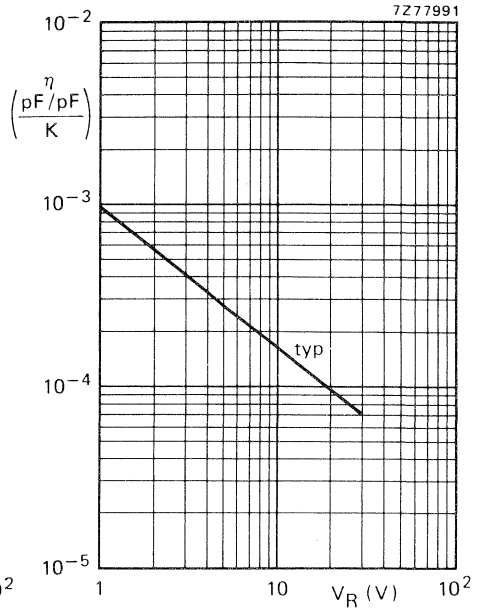


Fig. 3 Temperature coefficient of the diode capacitance;  $T_{amb} = 0$  to  $85$  °C.

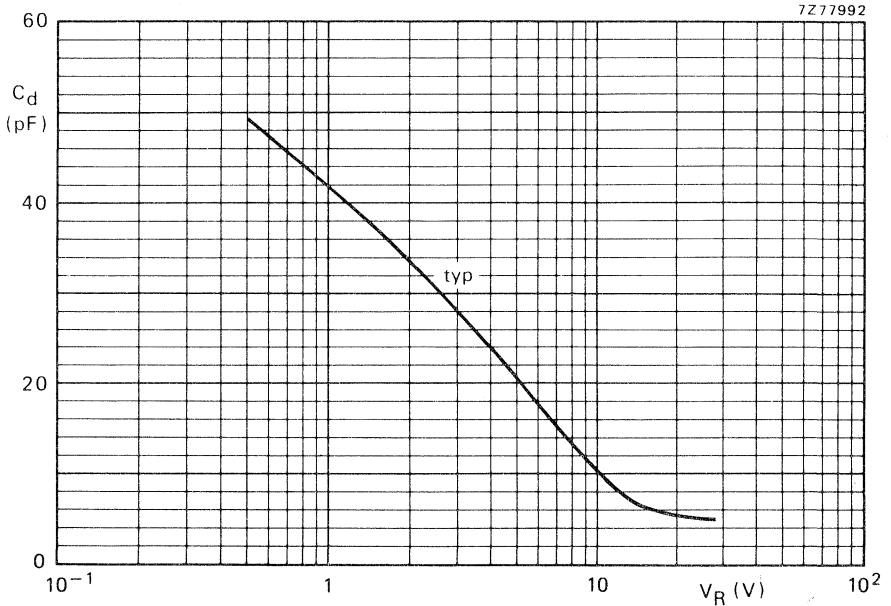


Fig. 4  $f = 1$  MHz;  $T_{amb} = 25$  °C.



## SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors, in a SOT-23 plastic envelope for use in driver and output stages of audio amplifiers in thick and thin-film hybrid circuits.

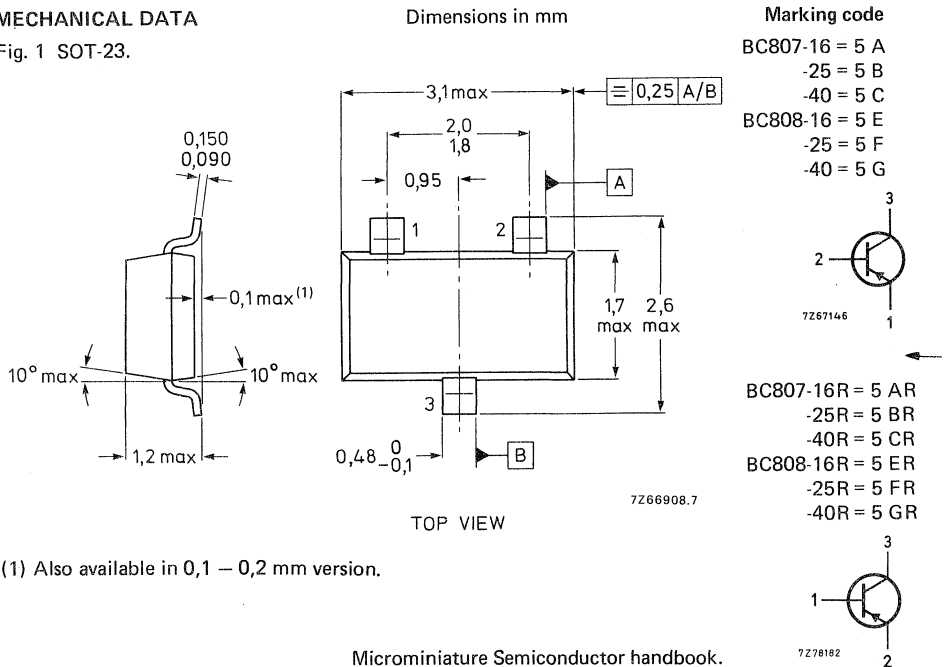
N-P-N complements are BC817; R and BC818; R respectively.

### QUICK REFERENCE DATA

		BC807; R	BC808; R
Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$ max.	50	30 V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	45	25 V
Collector current (peak value)	$-I_{CM}$ max.	1000	mA
Total power dissipation up to $T_{amb} = 35^\circ\text{C}$	$P_{tot}$ max.	310	mW
Junction temperature	$T_j$ max.	150	$^\circ\text{C}$
Transition frequency at $f = 35$ MHz	$f_T$ typ.	100	MHz
$-I_C = 10$ mA; $-V_{CE} = 5$ V			

### MECHANICAL DATA

Fig. 1 SOT-23.



**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BC807; R	BC808; R
Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$ max.	50	30 V
Collector-emitter voltage (open base) $-I_C = 10$ mA	$-V_{CEO}$ max.	45	25 V
Emitter-base voltage (open collector)	$-V_{EBO}$ max.	5	5 V
Collector current (d.c.)	$-I_C$ max.	500	mA
Collector current (peak value)	$-I_{CM}$ max.	1000	mA
Emitter current (peak value)	$I_{EM}$ max.	1000	mA
Base current (d.c.)	$-I_B$ max.	100	mA
Base current (peak value)	$-I_{BM}$ max.	200	mA
Total power dissipation at $T_{amb} = 35$ °C *	$P_{tot}$ max.	310	mW
Storage temperature	$T_{stg}$	-65 to +150	°C
Junction temperature	$T_j$ max.	150	°C

**THERMAL CHARACTERISTICS \*\***

$$T_j = P (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th j-t}$ =	50	K/W
From tab to soldering points	$R_{th t-s}$ =	260	K/W
From soldering points to ambient *	$R_{th s-a}$ =	60	K/W

\* Mounted on a ceramic substrate of 15 mm x 15 mm x 0,7 mm.

\*\* See *Thermal characteristics*.

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_E = 0; -V_{CB} = 20\text{ V}; T_j = 25\text{ }^\circ\text{C}$

$-I_{CBO} < 100\text{ nA}$

$I_E = 0; -V_{CB} = 20\text{ V}; T_j = 150\text{ }^\circ\text{C}$

$-I_{CBO} < 5\text{ }\mu\text{A}$

Emitter cut-off current

$I_C = 0; V_{EB} = 5\text{ V}$

$-I_{EBO} < 10\text{ }\mu\text{A}$

Base emitter voltage \*

$-I_C = 500\text{ mA}; -V_{CE} = 1\text{ V}$

$-V_{BE} < 1,2\text{ V}$

Saturation voltage

$-I_C = 500\text{ mA}; -I_B = 50\text{ mA}$

$-V_{CEsat} < 700\text{ mV}$

D.C. current gain

$-I_C = 500\text{ mA}; -V_{CE} = 1\text{ V}$

$h_{FE} > 40$

$-I_C = 100\text{ mA}; -V_{CE} = 1\text{ V}; \text{BC807; BC808}$

$h_{FE} 100\text{ to }600$

BC807-16 }  
BC808-16 }

$h_{FE} 100\text{ to }250$

BC807-25 }  
BC808-25 }

$h_{FE} 160\text{ to }400$

BC807-40 }  
BC808-40 }

$h_{FE} 250\text{ to }600$

Transition frequency at  $f = 35\text{ MHz}$

$-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$

$f_T$  typ.  $100\text{ MHz}$

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; -V_{CB} = 10\text{ V}$

$C_c$  typ.  $8\text{ pF}$

D.C. current gain ratio of complementary matched pairs

$|I_C| = 100\text{ mA}; |V_{CE}| = 1\text{ V}$

$h_{FE1}/h_{FE2}$  typ.  $1,25$   
<  $1,40$

\*  $-V_{BE}$  decreases by about  $2\text{ mV/K}$  with increasing temperature.

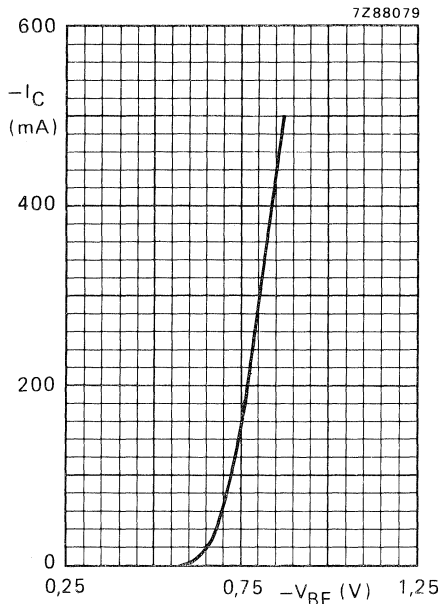


Fig. 2  $-V_{CE} = 1 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$ .  
Typical values.

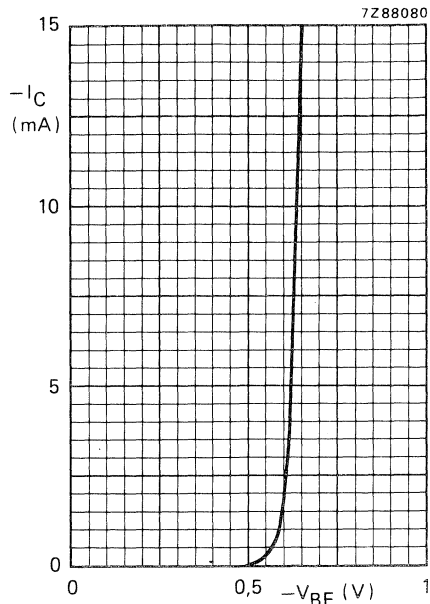


Fig. 3  $-V_{CE} = 5 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$ .  
Typical values.

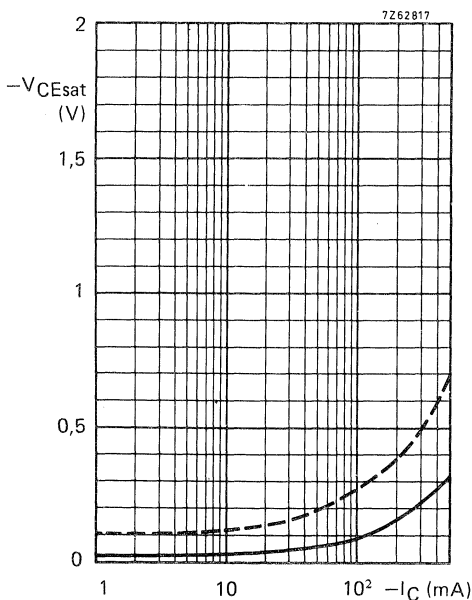


Fig. 4 ----- max. values, ——— typical values.

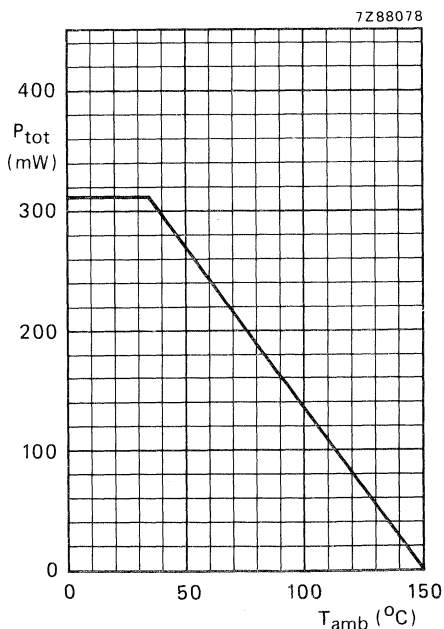


Fig. 5. Power derating curve.

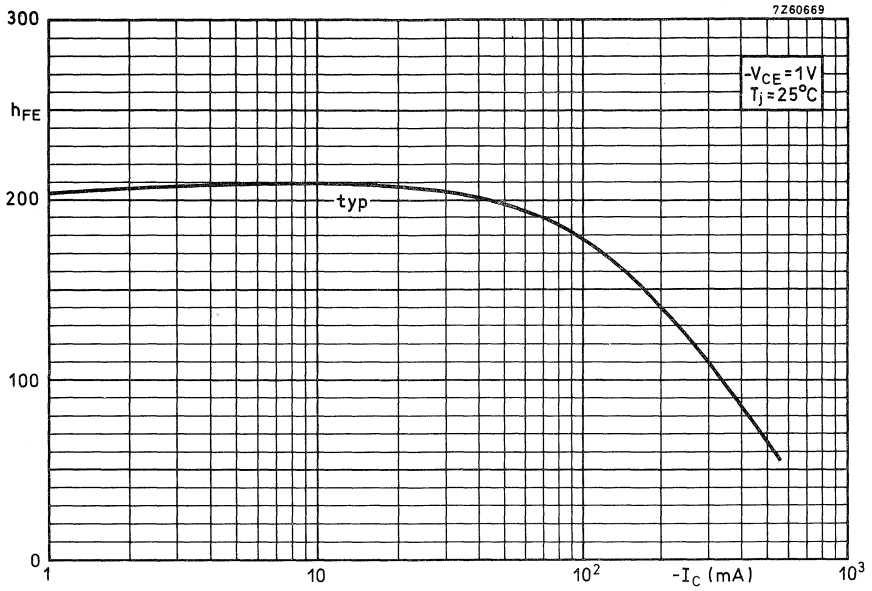


Fig. 6 D.C. current gain.

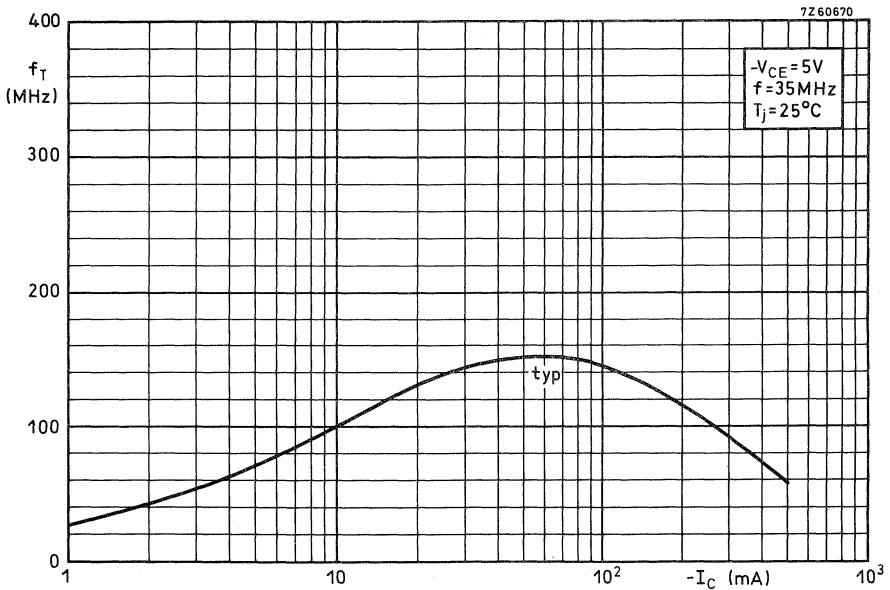


Fig. 7 Typical values transition frequency.





## SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors, in a SOT-23 plastic envelope for use in driver and output stages of audio amplifiers in thick and thin-film hybrid circuits.

P-N-P complements are BC807; R and BC808; R respectively.

### QUICK REFERENCE DATA

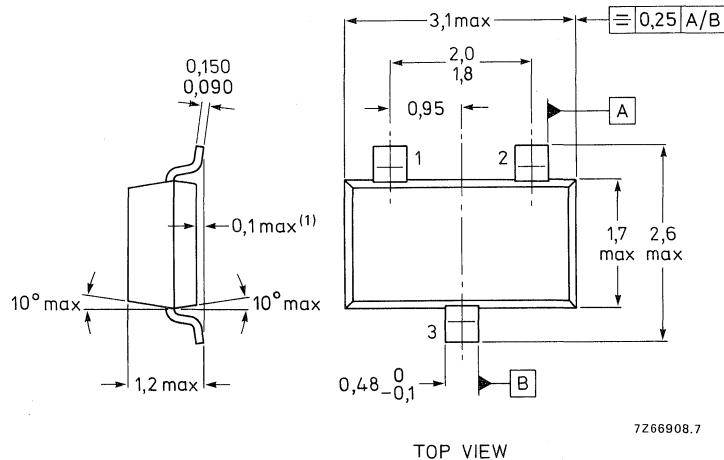
		BC817; R	BC818; R
Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max. 50	30 V
Collector-emitter voltage (open base)	$V_{CEO}$	max. 45	25 V
Collector current (peak value)	$I_{CM}$	max. 1000	mA
Total power dissipation up to $T_{amb} = 35\text{ }^{\circ}\text{C}$	$P_{tot}$	max. 310	mW
Junction temperature	$T_j$	max. 150	$^{\circ}\text{C}$
Transition frequency at $f = 35\text{ MHz}$ $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$	$f_T$	typ. 200	MHz

### MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code



BC817-16 = 6 A

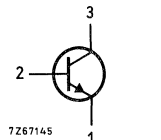
-25 = 6 B

-40 = 6 C

BC818-16 = 6 E

-25 = 6 F

-40 = 6 G



BC817-16R = 6 AR

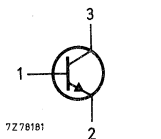
-25R = 6 BR

-40R = 6 CR

BC818-16R = 6 ER

-25R = 6 FR

-40R = 6 GR



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BC817; R	BC818; R
Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max. 50	30 V
Collector-emitter voltage (open base) $I_C = 10$ mA	$V_{CEO}$	max. 45	25 V
Emitter-base voltage (open collector)	$V_{EBO}$	max. 5	5 V
Collector current (d.c.)	$I_C$	max. 500	mA
Collector current (peak value)	$I_{CM}$	max. 1000	mA
Emitter current (peak value)	$-I_{EM}$	max. 1000	mA
Base current (d.c.)	$I_B$	max. 100	mA
Base current (peak value)	$I_{BM}$	max. 200	mA
Total power dissipation up to $T_{amb} = 35$ °C	$P_{tot}$	max. 310	mW
Storage temperature	$T_{stg}$		-65 to +150 °C
Junction temperature	$T_j$	max. 150	°C

**THERMAL CHARACTERISTICS \*\***

$$T_j = P (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th j-t}$	=	50	K/W
From tab to soldering points	$R_{th t-s}$	=	260	K/W
From soldering points to ambient *	$R_{th s-a}$	=	60	K/W

\* Mounted on a ceramic substrate of 15 mm x 15 mm x 0,7 mm.

\*\* See *Thermal characteristics*.

**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

 $I_E = 0; V_{CB} = 20\text{ V}; T_j = 25\text{ }^\circ\text{C}$  $I_{CBO} < 100\text{ nA}$  $I_E = 0; V_{CB} = 20\text{ V}; T_j = 150\text{ }^\circ\text{C}$  $I_{CBO} < 5\text{ }\mu\text{A}$ 

Emitter cut-off current

 $I_C = 0; V_{EB} = 5\text{ V}$  $I_{EBO} < 10\text{ }\mu\text{A}$ 

Base emitter voltage \*

 $I_C = 500\text{ mA}; V_{CE} = 1\text{ V}$  $V_{BE} < 1,2\text{ V}$ 

Saturation voltage

 $I_C = 500\text{ mA}; I_B = 50\text{ mA}$  $V_{CEsat} < 700\text{ mV}$ 

D.C. current gain

 $I_C = 500\text{ mA}; V_{CE} = 1\text{ V}$  $h_{FE} > 40$  $I_C = 100\text{ mA}; V_{CE} = 1\text{ V}; \text{BC817}; \text{BC818}$  $h_{FE} 100\text{ to }600$ BC817-16 }  
BC818-16 } $h_{FE} 100\text{ to }250$ BC817-25 }  
BC818-25 } $h_{FE} 160\text{ to }400$ BC817-40 }  
BC818-40 } $h_{FE} 250\text{ to }600$ Transition frequency at  $f = 35\text{ MHz}$  $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$  $f_T$  typ. 200 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 10\text{ V}$  $C_c$  typ. 5 pFD.C. current gain ratio of matched complementary pairs  
complementary pairs $|I_C| = 100\text{ mA}; |V_{CE}| = 1\text{ V}$  $h_{FE1}/h_{FE2}$  typ. 1,25  
< 1,40\*  $V_{BE}$  decreases by about 2 mV/K with increasing temperature.

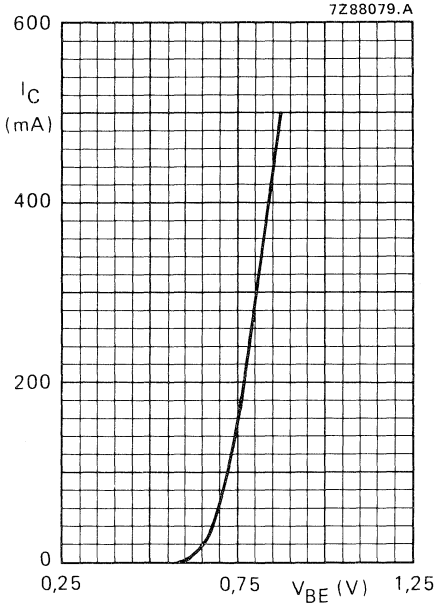


Fig. 2  $V_{CE} = 1 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ . Typical values.

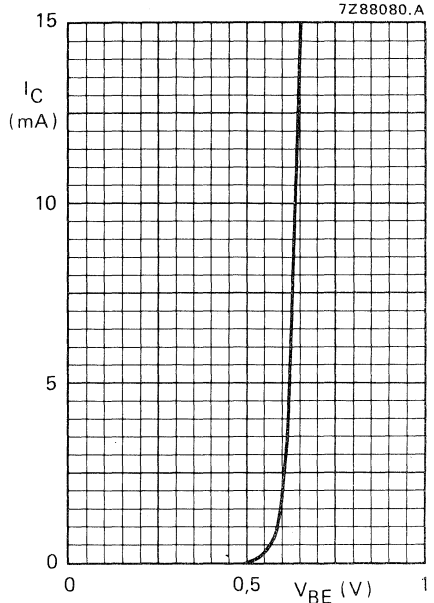


Fig. 3  $V_{CE} = 5 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ . Typical values.

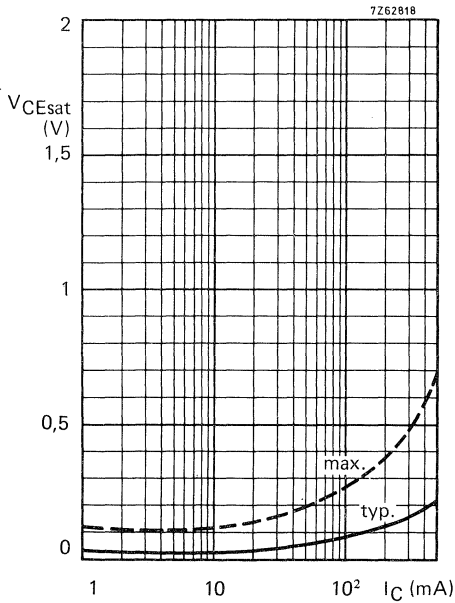


Fig. 4  $I_C/I_B = 10$ ;  $T_j = 25 \text{ }^\circ\text{C}$ .

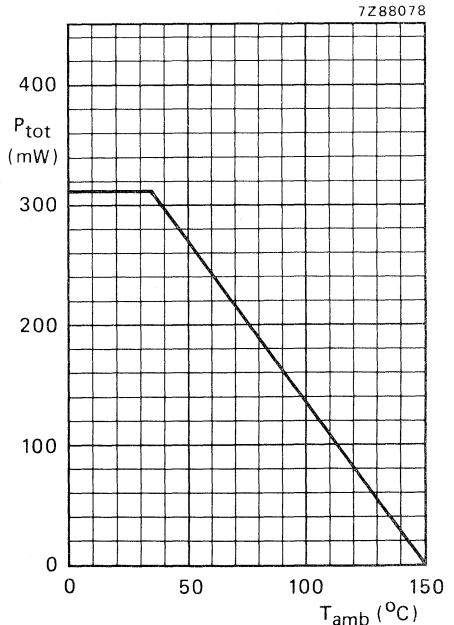


Fig. 5 Power derating curve.

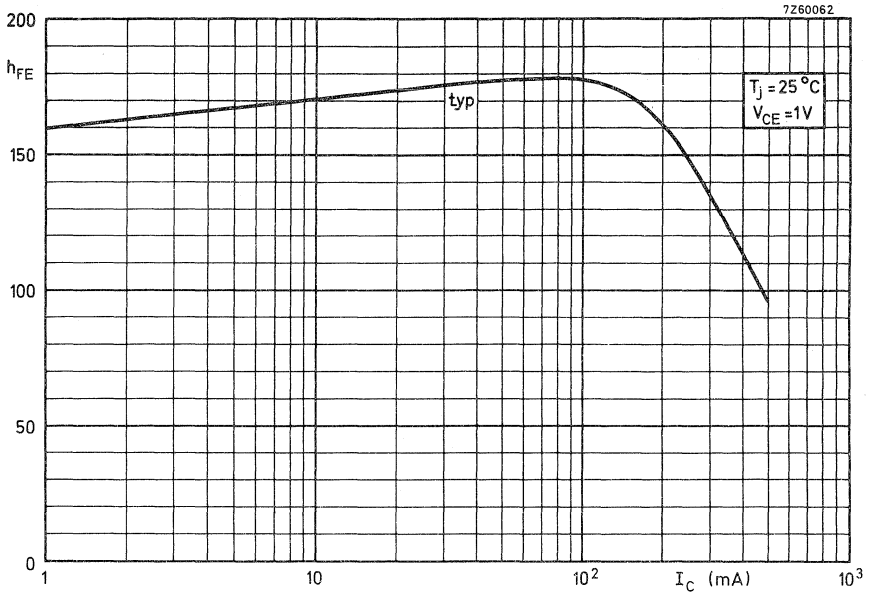


Fig. 6 D.C. current gain.

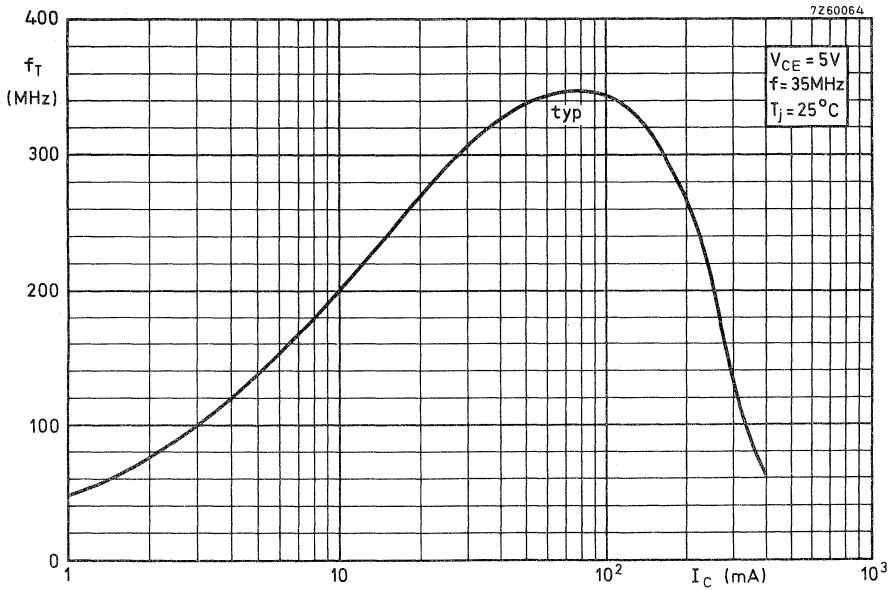


Fig. 7 Typical values transition frequency.



## SILICON PLANAR EPITAXIAL TRANSISTORS

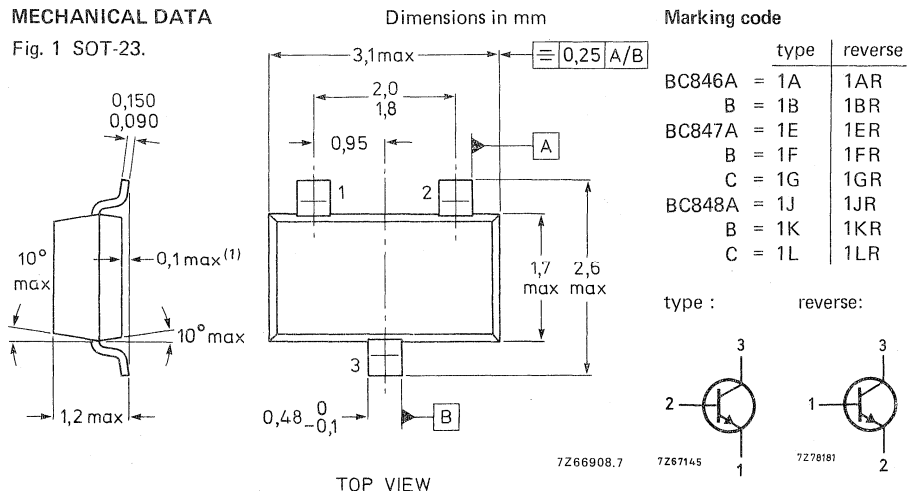
General purpose n-p-n transistors in a plastic SOT-23 variant, especially suitable for use in driver stages of audio amplifiers in thick and thin-film hybrid circuits.

### QUICK REFERENCE DATA

		BC846; R	BC847; R	BC848; R	
Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$ max.	80	50	30	V
Collector-emitter voltage (open base)	$V_{CEO}$ max.	65	45	30	V
Collector current (peak value)	$I_{CM}$ max.	200	200	200	mA
Total power dissipation up to $T_{amb} = 60^\circ\text{C}$	$P_{tot}$ max.	200	200	200	mW
Junction temperature	$T_j$ max.	150	150	150	$^\circ\text{C}$
Small-signal current gain $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; f = 1\text{ kHz}$	$h_{fe}$	$> 125$ $< 500$	125 900	125 900	
Transition frequency $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$	$f_T$ typ.	300	300	300	MHz
Noise figure at $R_S = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V}$ $f = 1\text{ kHz}; B = 200\text{ Hz}$	F typ.	2	2	2	dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BC846; R	BC847; R	BC848; R	
Collector-base voltage (open emitter)	$V_{CBO}$ max.	80	50	30	V
Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$ max.	80	50	30	V
Collector-emitter voltage (open base)	$V_{CEO}$ max.	65	45	30	V
Emitter-base voltage (open collector)	$V_{EBO}$ max.	6	6	5	V
Collector current (d.c.)	$I_C$ max.		100		mA
Collector current (peak value)	$I_{CM}$ max.		200		mA
Emitter current (peak value)	$-I_{EM}$ max.		200		mA
Base current (peak value)	$I_{BM}$ max.		200		mA
Total power dissipation* up to $T_{amb} = 60\text{ }^\circ\text{C}$	$P_{tot}$ max.		200		mW
Storage temperature	$T_{stg}$	-65 to +150			$^\circ\text{C}$
Junction temperature	$T_j$ max.		150		$^\circ\text{C}$

**THERMAL CHARACTERISTICS\*\***

$$T_j = P (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t} =$	60	K/W
From tab to soldering points	$R_{th\ t-s} =$	280	K/W
From soldering points to ambient*	$R_{th\ s-a} =$	90	K/W

\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

\*\* See *Thermal characteristics*.



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 30\text{ V}$

$I_E = 0; V_{CB} = 30\text{ V}; T_j = 150\text{ }^\circ\text{C}$

$I_{CBO} < 15\text{ nA}$

$I_{CBO} < 5\text{ }\mu\text{A}$

Base-emitter voltage\*

$I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$

$V_{BE}$  typ. 660 mV

580 to 700 mV

$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$

$V_{BE} < 770\text{ mV}$

Saturation voltage\*\*

$I_C = 10\text{ mA}; I_B = 0,5\text{ mA}$

$V_{CEsat}$  typ. 90 mV

$V_{CEsat} < 250\text{ mV}$

$V_{BEsat}$  typ. 700 mV

$I_C = 100\text{ mA}; I_B = 5\text{ mA}$

$V_{CEsat}$  typ. 200 mV

$V_{CEsat} < 600\text{ mV}$

$V_{BEsat}$  typ. 900 mV

Knee voltage

$I_C = 10\text{ mA}; I_B = \text{value for which}$

$I_C = 11\text{ mA at } V_{CE} = 1\text{ V}$

$V_{CEK}$  typ. 300 mV

$V_{CEK} < 600\text{ mV}$

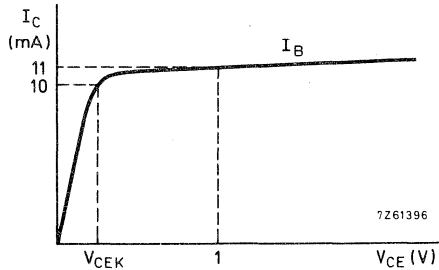


Fig. 2.

Collector capacitance at  $f = 1\text{ MHz}$ 

$I_E = I_e = 0; V_{CB} = 10\text{ V}$

$C_C$  typ. 2,5 pF ←

Transition frequency at  $f = 35\text{ MHz}$ 

$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$

$f_T$  typ. 300 MHz

\*  $V_{BE}$  decreases by about 2 mV/K with increasing temperature.\*\*  $V_{BEsat}$  decreases by about 1,7 mV/K with increasing temperature.

BC846; R  
 BC847; R  
 BC848; R

		BC846	BC847	BC848	
<b>Small signal current gain at <math>f = 1</math> kHz</b>					
$I_C = 2$ mA; $V_{CE} = 5$ V					
$h_{fe}$	>	125	125	125	
	<	500	900	900	
<b>Noise figure at <math>R_S = 2</math> k<math>\Omega</math></b>					
$I_C = 200$ $\mu$ A; $V_{CE} = 5$ V;					
$f = 1$ kHz; B = 200 Hz					
F	typ.	2	2	2	dB
	<	10	10	10	dB
		BC846A	BC846B		
		BC847A	BC847B	BC847C	
		BC848A	BC848B	BC848C	
<b>D.C. current gain</b>					
$I_C = 10$ $\mu$ A; $V_{CE} = 5$ V					
$h_{FE}$	typ.	90	150	270	
	>	110	200	420	
$I_C = 2$ mA; $V_{CE} = 5$ V					
$h_{FE}$	typ.	180	290	520	
	<	220	450	800	



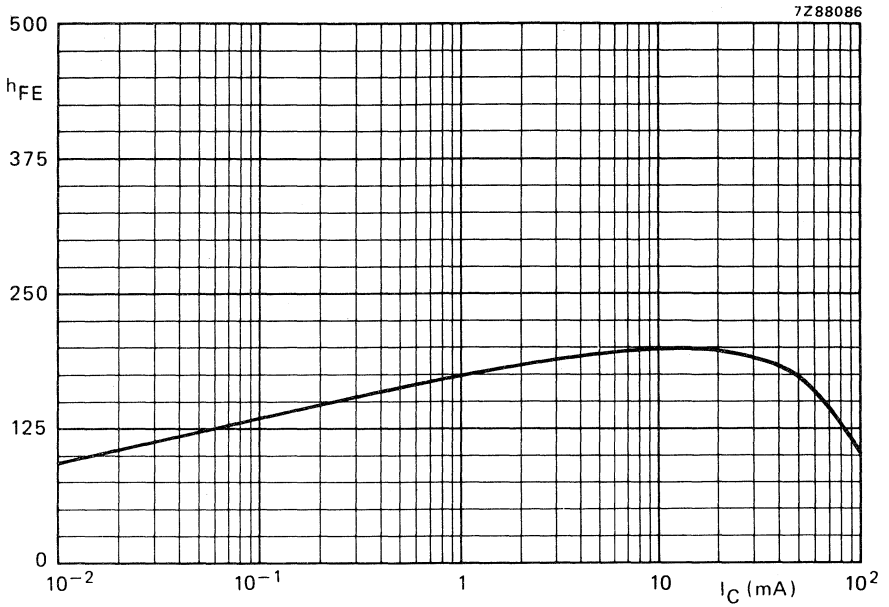


Fig. 3 Typical D.C. current gain for A-selections.  $V_{CE} = 5\text{ V}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

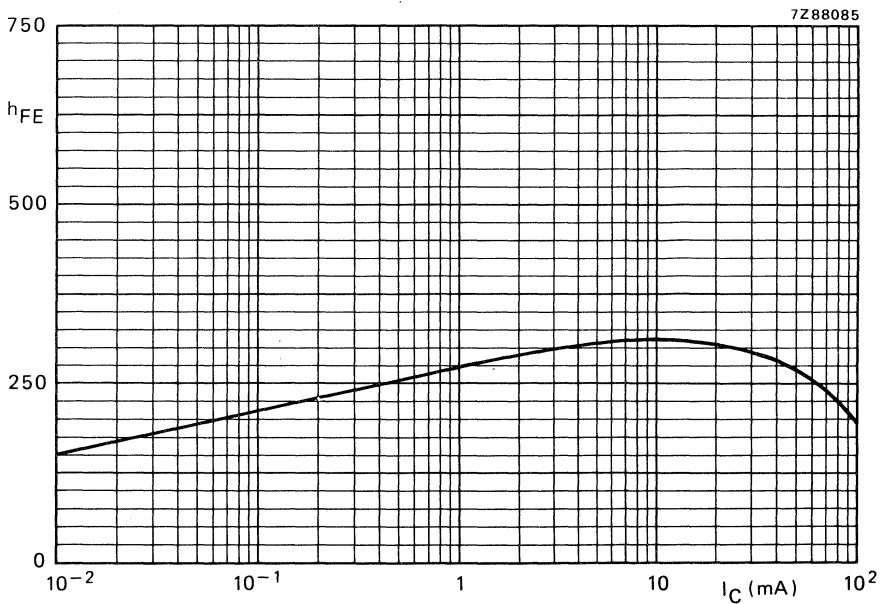


Fig. 4 Typical D.C. current gain for B-selections.  $V_{CE} = 5\text{ V}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

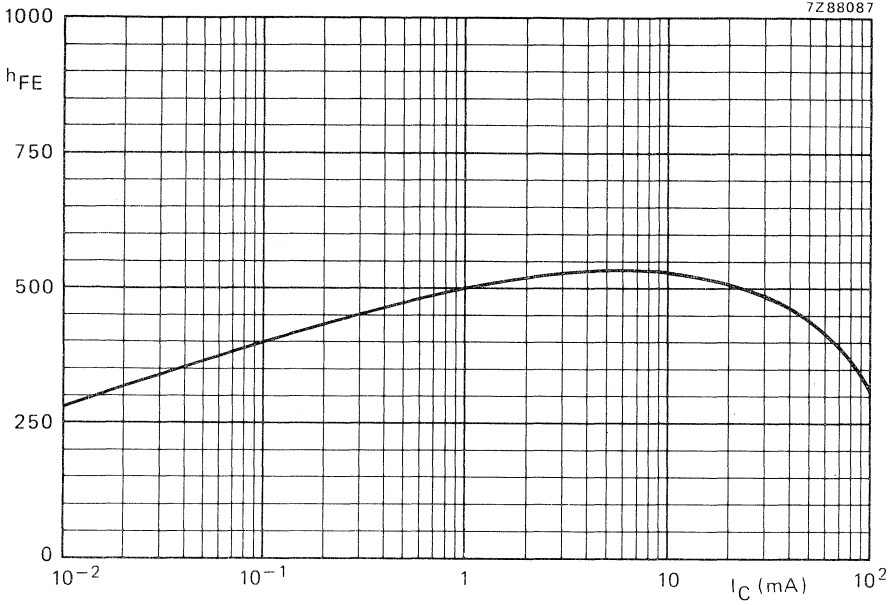


Fig. 5 Typical D.C. current gain for C-selections.  $V_{CE} = 5\text{ V}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

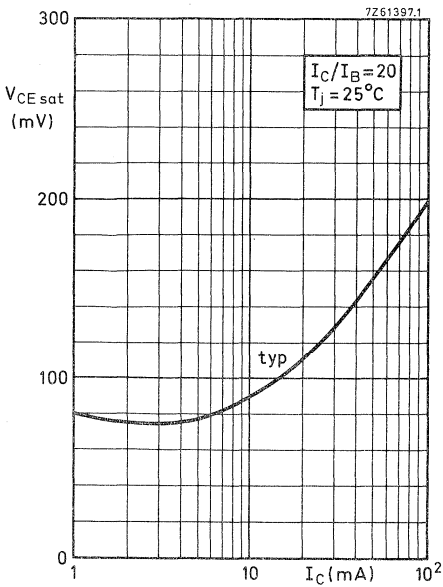


Fig. 6 Typical values.

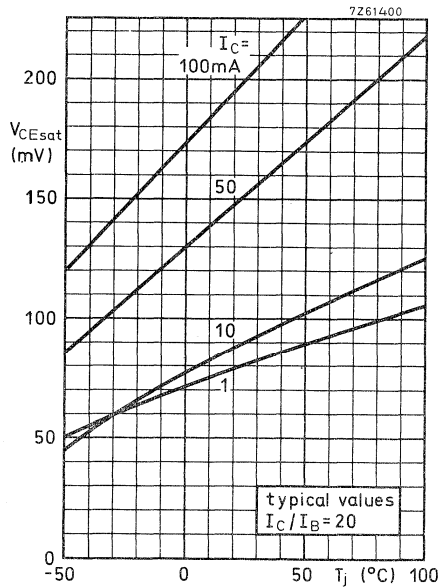


Fig. 7 Typical values.

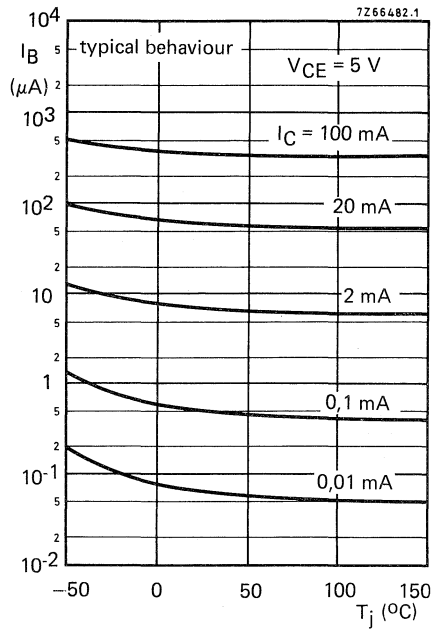


Fig. 8 Typical behaviour of base current versus junction temperature.

BC846; R  
 BC847; R  
 BC848; R

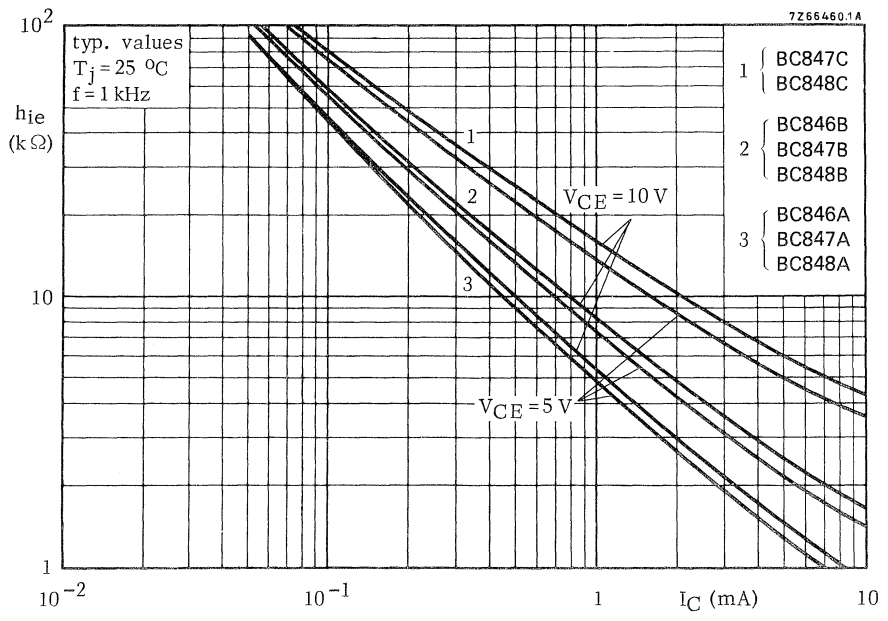


Fig. 9 Input impedance. 1 = C selections; 2 = B selections; 3 = A selections.

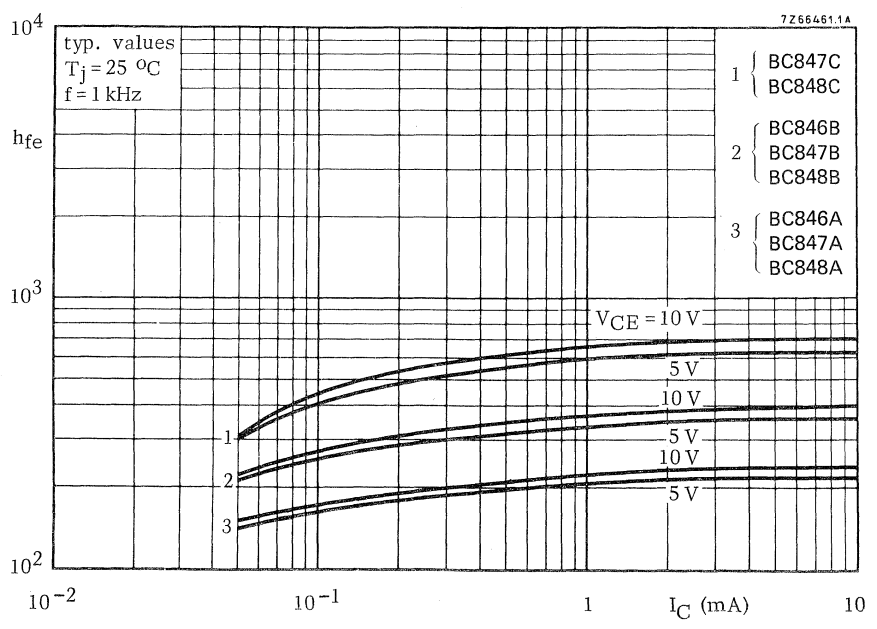


Fig. 10 Small signal current gain. 1 = C-; 2 = B- and 3 = A-selections.

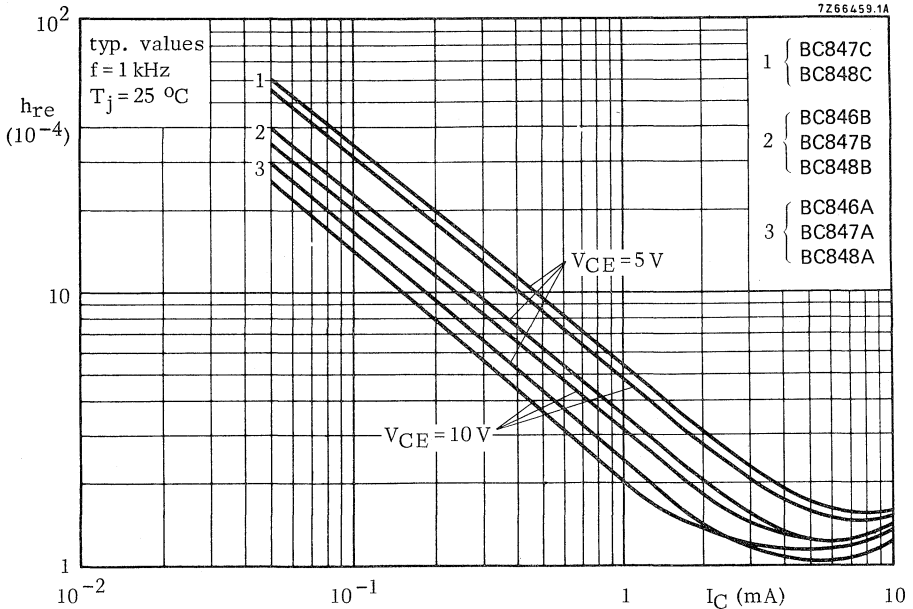


Fig. 11 Reverse voltage transfer ratio. 1 = C-; 2 = B- and 3 = A-selections.

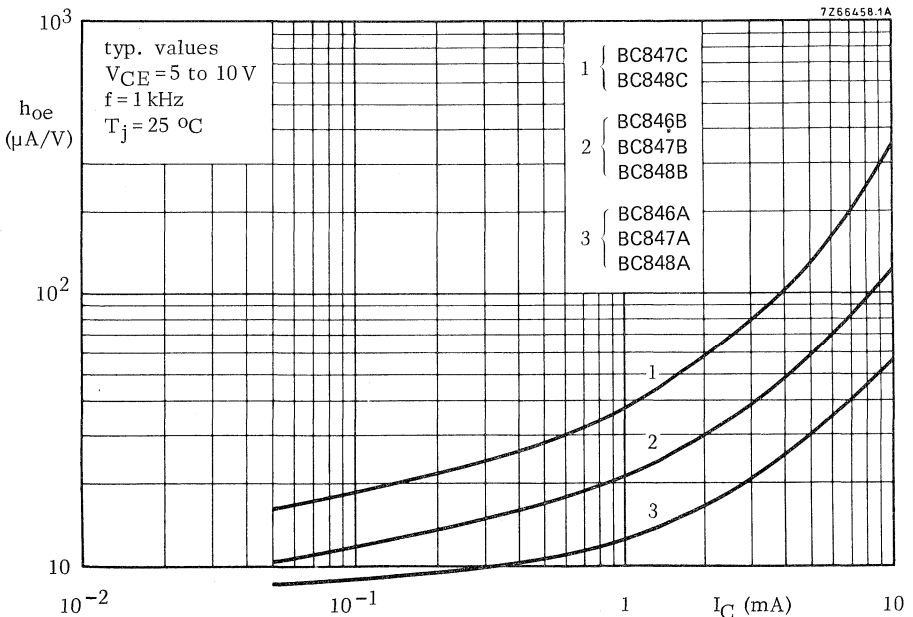


Fig. 12 Output admittance. 1 = C-; 2 = B- and 3 = A-selections.

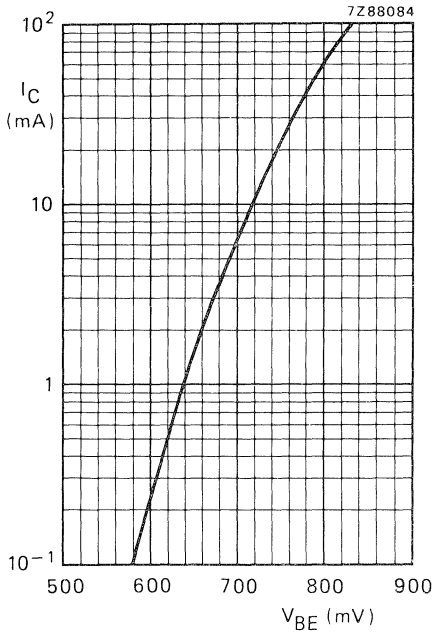


Fig. 13 Typical values at  $V_{CE} = 5\text{ V}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

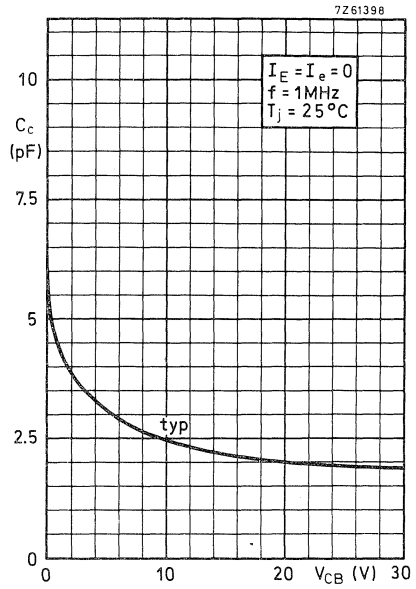


Fig. 14 Typical values.

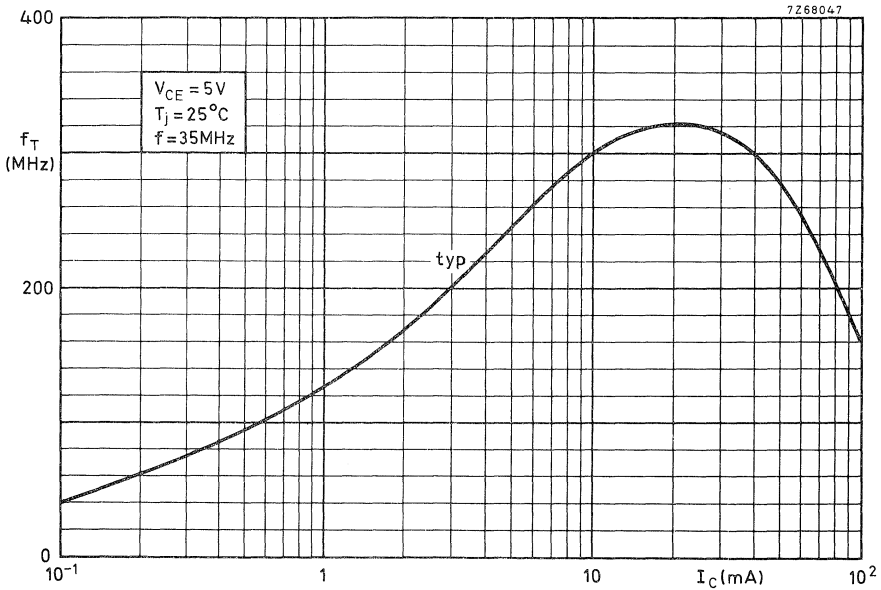


Fig. 15 Typical values transition frequency.



## SILICON PLANAR EPITAXIAL TRANSISTORS

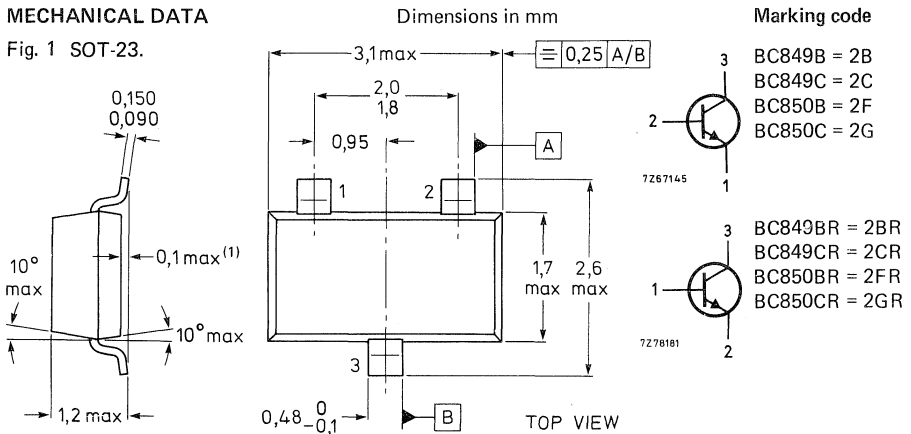
N-P-N transistors in a plastic SOT-23 envelope, primarily intended for low-noise input stages in tape recorders, hi-fi amplifiers and other audio-frequency equipment in thick and thin-film hybrid circuits.

### QUICK REFERENCE DATA

		BC849; R	BC850; R	
Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max. 30	50	V
Collector-emitter voltage (open base)	$V_{CEO}$	max. 30	45	V
Collector current (peak value)	$I_{CM}$	max. 200	200	mA
Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}$	$P_{tot}$	max. 200	200	mW
Junction temperature	$T_j$	max. 150	150	$^{\circ}\text{C}$
Small-signal current gain				
$I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; f = 1\text{ kHz}$	$h_{fe}$	$> 240$ $< 900$	240 900	
Transition frequency				
$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$	$f_T$	typ. 300	300	MHz
Noise figure at $R_S = 2\text{ k}\Omega$				
$I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V}$				
$f = 30\text{ Hz to } 15\text{ kHz}$	F	typ. 1,4 $< 4$	1,4 3	dB
$f = 1\text{ kHz}; B = 200\text{ Hz}$	F	typ. 1,2	1	dB
$f = 10\text{ Hz to } 50\text{ Hz}$ (equivalent noise voltage)	$V_n$	$< -$	0,135	$\mu\text{V}$

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

7266908.7

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

			BC849; R	BC850; R	
Collector-base voltage (open emitter)	$V_{CBO}$	max.	30	50	V
Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max.	30	50	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	30	45	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	5	5	V
Collector current (d.c.)	$I_C$	max.	100		mA
Collector current (peak value)	$I_{CM}$	max.	200		mA
Emitter current (peak value)	$-I_{EM}$	max.	200		mA
Base current (peak value)	$I_{BM}$	max.	200		mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	200		mW
Storage temperature	$T_{stg}$		-65 to +150		$^\circ\text{C}$
Junction temperature	$T_j$	max.	150		$^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60	K/W
From tab to soldering points	$R_{th\ t-s}$	=	280	K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90	K/W

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 30\text{ V}$

$I_{CBO} < 15\text{ nA}$

$I_E = 0; V_{CB} = 30\text{ V}; T_j = 150\text{ }^\circ\text{C}$

$I_{CBO} < 5\text{ }\mu\text{A}$

Base emitter voltage\*

$I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$

$V_{BE}$  typ. 660 mV  
580 to 700 mV

$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$

$V_{BE} < 770\text{ mV}$

Saturation voltages\*\*

$I_C = 10\text{ mA}; I_B = 0,5\text{ mA}$

$V_{CEsat}$  typ. 90 mV  
< 250 mV

$V_{BEsat}$  typ. 700 mV

$I_C = 100\text{ mA}; I_B = 5\text{ mA}$

$V_{CEsat}$  typ. 200 mV  
< 600 mV

$V_{BEsat}$  typ. 900 mV

Knee voltage

$I_C = 10\text{ mA}; I_B = \text{value for which}$

$I_C = 11\text{ mA at } V_{CE} = 1\text{ V}$

$V_{CEK}$  typ. 300 mV  
< 600 mV

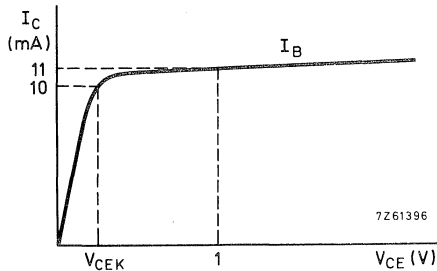


Fig. 2 Knee voltage waveform.

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10\text{ V}$

$C_C$  typ. 2,5 pF ←

Transition frequency at  $f = 35\text{ MHz}$

$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$

$f_T$  typ. 300 MHz

\*  $V_{BE}$  decreases by about 2 mV/K with increasing temperature.

\*\*  $V_{BEsat}$  decreases by about 1,7 mV/K with increasing temperature.

BC849; R  
BC850; R

		BC849; R	BC850; R		
Small signal current gain at $f = 1 \text{ kHz}$ $I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$		$h_{fe} >$	240	240	
		$h_{fe} <$	900	900	
Noise figure at $R_S = 2 \text{ k}\Omega$ $I_C = 200 \mu\text{A}; V_{CE} = 5 \text{ V}$ $f = 30 \text{ Hz to } 15 \text{ kHz}$		F typ.	1,4	1,4	dB
		F <	4	3	dB
$f = 1 \text{ kHz}; B = 200 \text{ Hz}$		F typ.	1,2	1	dB
		F <	4	4	dB
Equivalent noise voltage at $R_S = 2 \text{ k}\Omega$ $I_C = 200 \mu\text{A}; V_{CE} = 5 \text{ V}$ $f = 10 \text{ Hz to } 50 \text{ Hz}; T_{amb} = 25 \text{ }^\circ\text{C}$		$V_n$ max.	—	0,135	$\mu\text{V}$
			B-selections	C-selections	
D.C. current gain $I_C = 10 \mu\text{A}; V_{CE} = 5 \text{ V}$		$h_{FE}$ typ.	150	270	
		$h_{FE} >$	200	420	
$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$		$h_{FE}$ typ.	290	520	
		$h_{FE} <$	450	800	



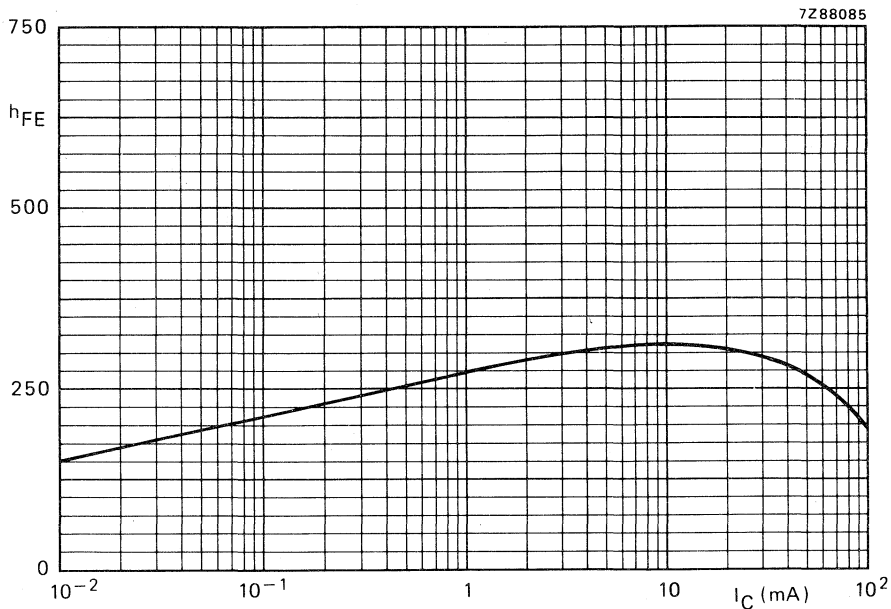


Fig. 3 Typical D.C. current gain B selections.  $V_{CE} = 5$  V;  $T_j = 25$  °C.

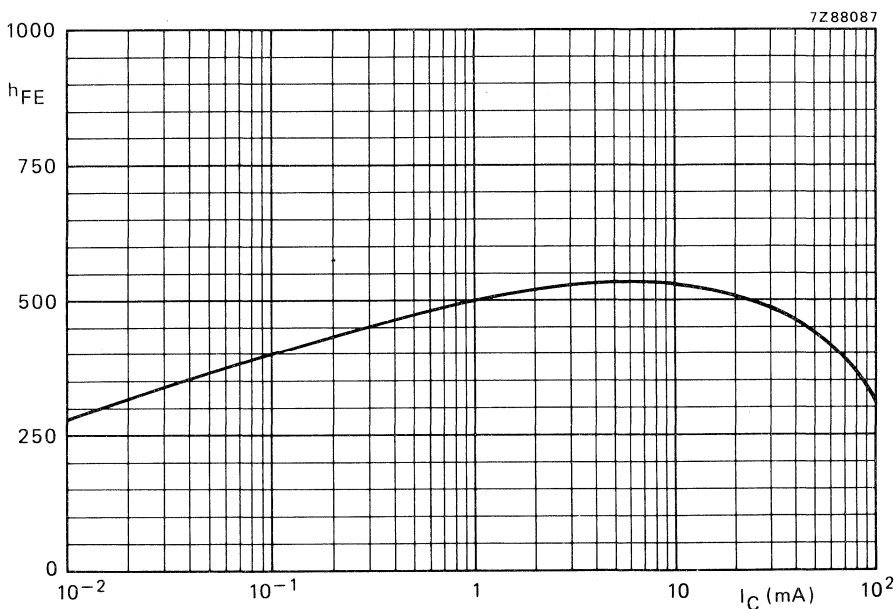


Fig. 4 Typical D.C. current gain C selections.  $V_{CE} = 5$  V;  $T_j = 25$  °C.

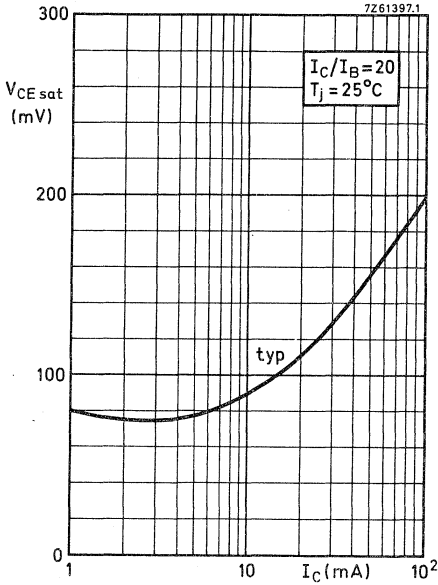


Fig. 5 Typical values.

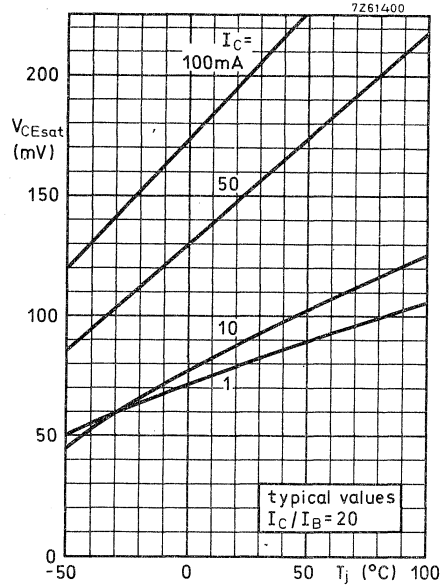


Fig. 6 Typical values;  $I_C/I_B = 20$ .

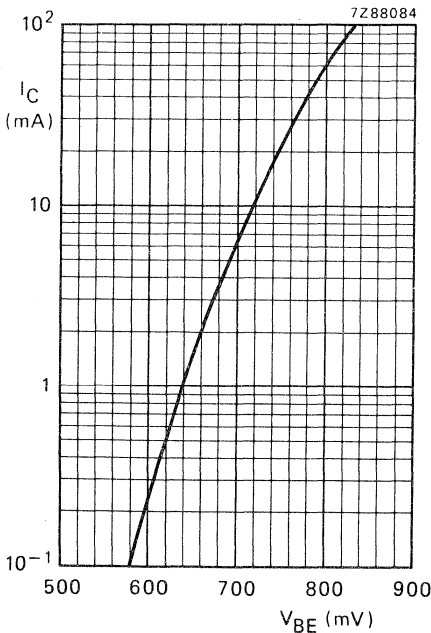


Fig. 7 Typical values  $V_{BE}$ .  $V_{CE} = 5$  V;  $T_j = 25^\circ\text{C}$ .

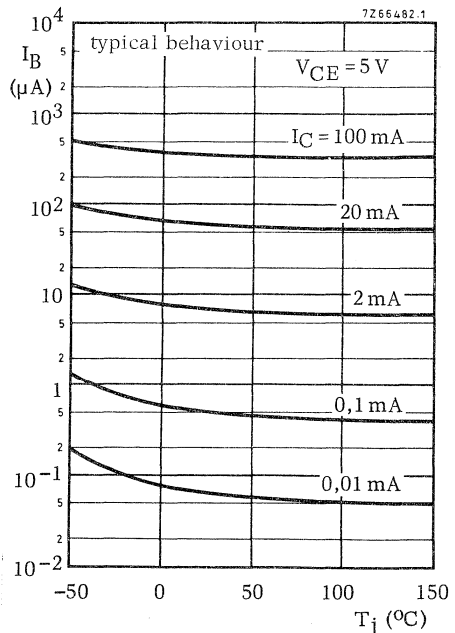


Fig. 8 Typical values.

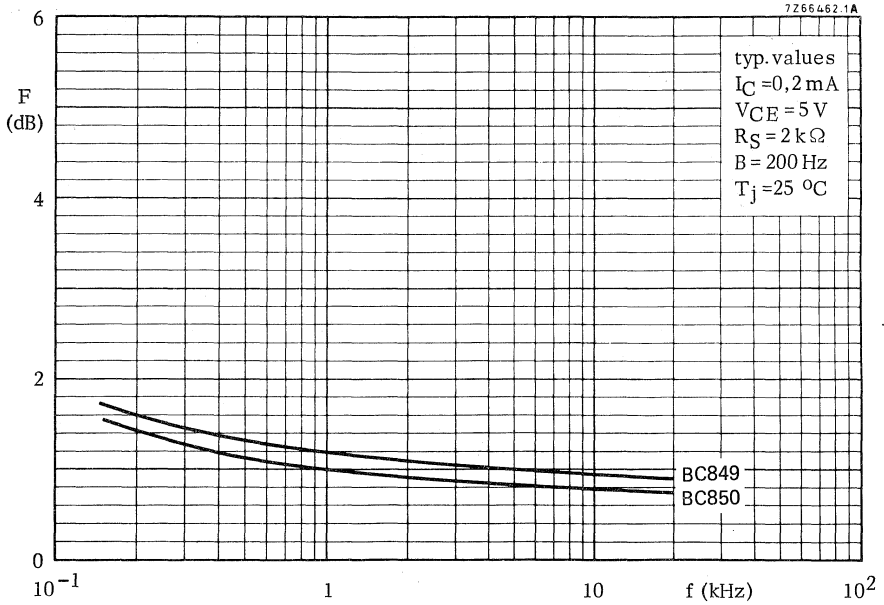


Fig. 9.

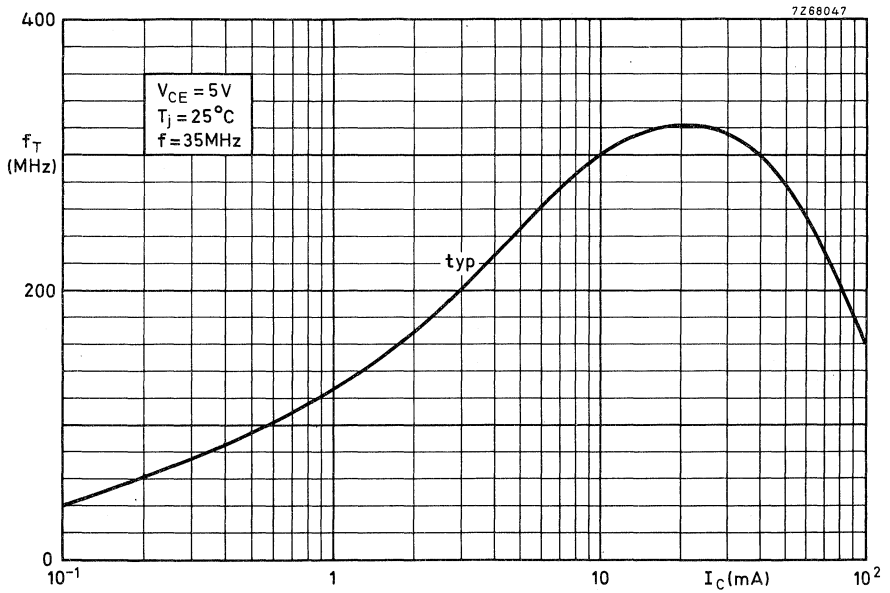


Fig. 10.

BC849; R  
BC850; R

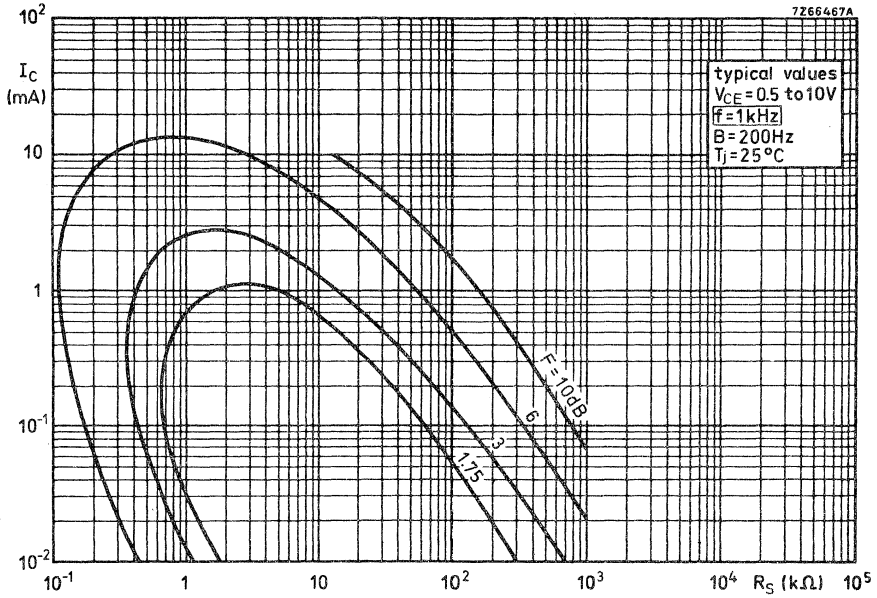


Fig. 11 Curves of constant noise figure for BC849.

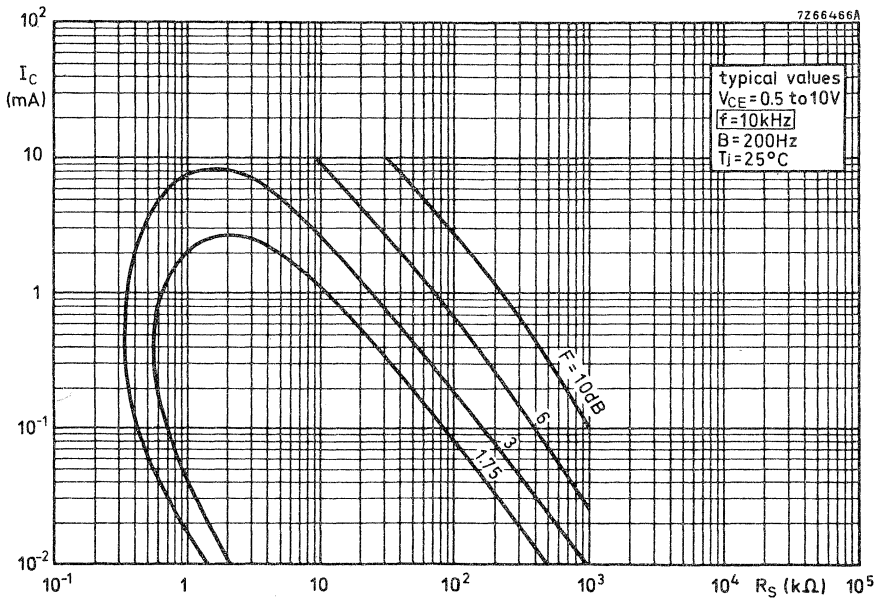


Fig. 12 Curves of constant noise figure for BC849.



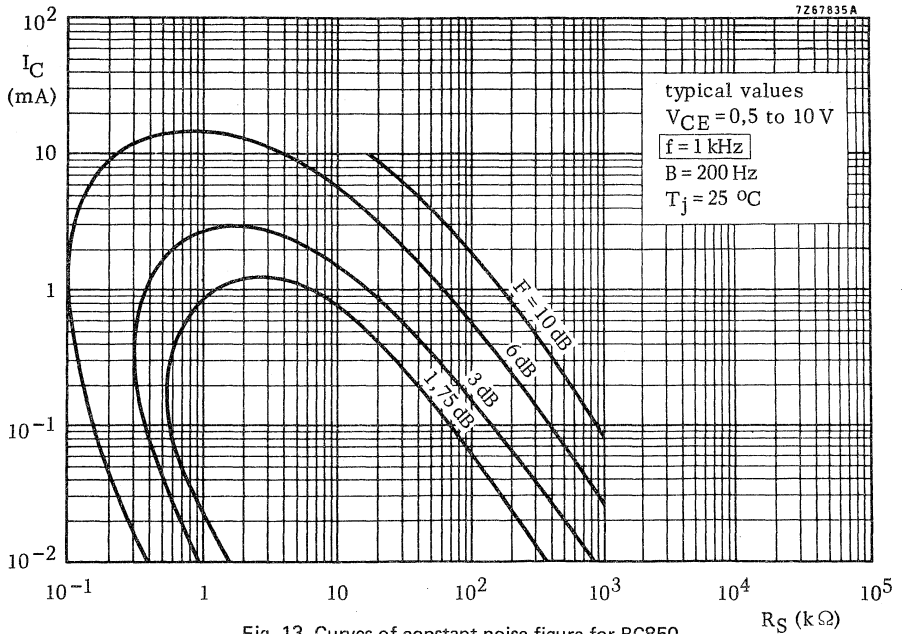


Fig. 13 Curves of constant noise figure for BC850.

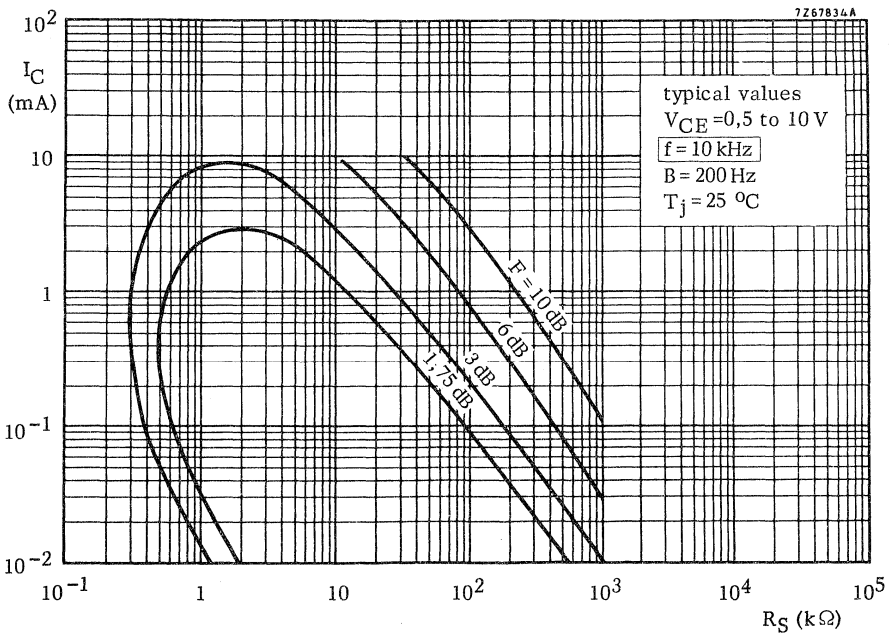


Fig. 14 Curves of constant noise figure for BC850.

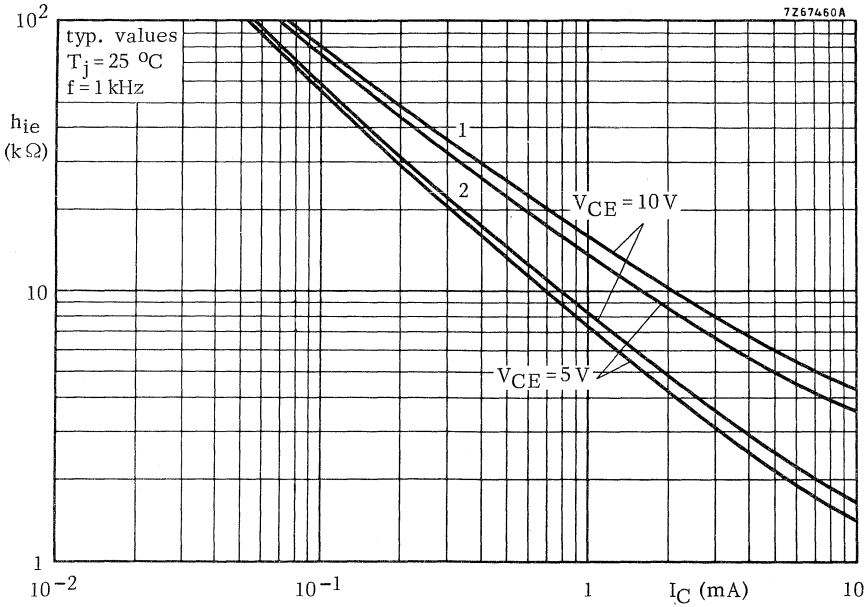


Fig. 15 Typical values. 1 = C selections; 2 = B selections.

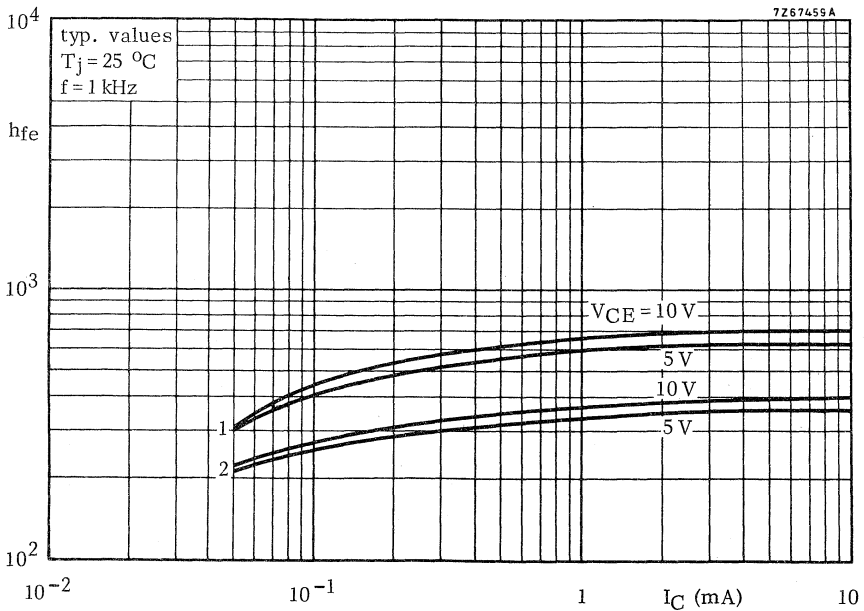


Fig. 16 Typical values. 1 = C selections; 2 = B selections.

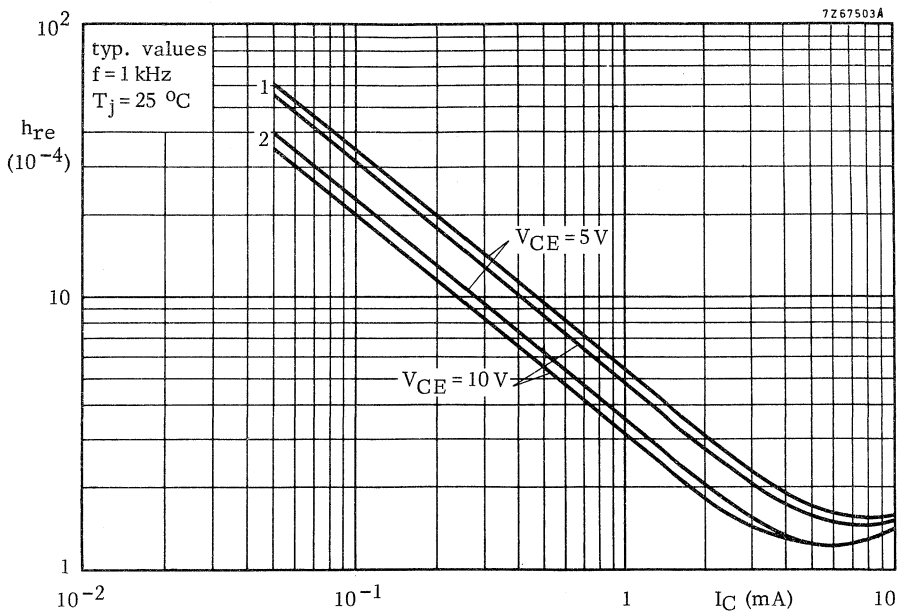


Fig. 17 Typical values. 1 = C selections; 2 = B selections.

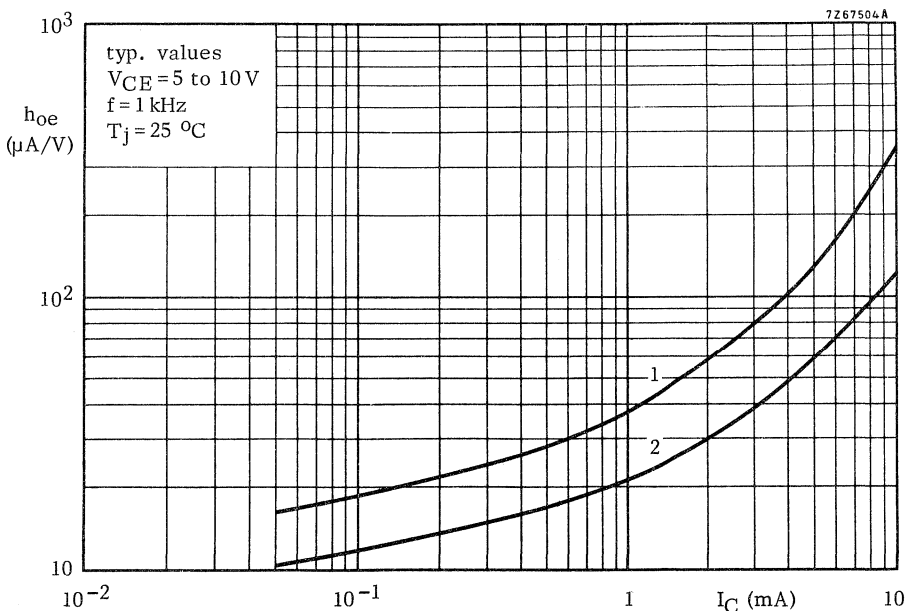


Fig. 18 Typical values. 1 = C selections; 2 = B selections.

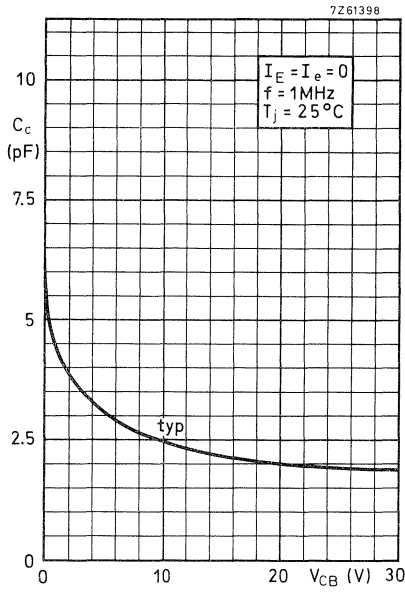


Fig. 19 Typical values.

## SILICON PLANAR EPITAXIAL TRANSISTORS

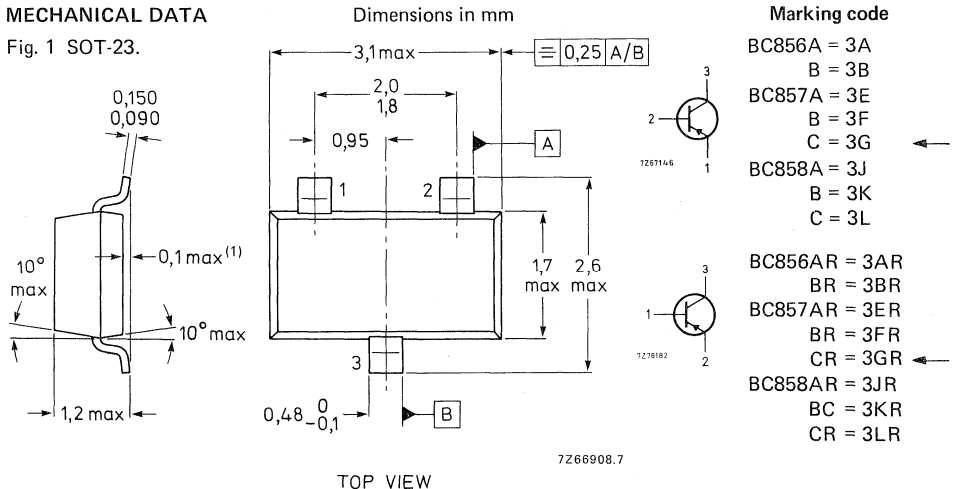
P-N-P transistors, in a SOT-23 plastic envelope for use in driver and output stages of audio amplifiers in thick and thin-film circuits.

### QUICK REFERENCE DATA

		BC856; R	BC857; R	BC858; R
Collector-emitter voltage (+V <sub>BE</sub> = 1 V)	-V <sub>CEX</sub>	max. 80	50	30 V
Collector-emitter voltage (open base)	-V <sub>CEO</sub>	max. 65	45	30 V
Collector current (peak value)	-I <sub>CM</sub>	max.	200	mA
Total power dissipation up to T <sub>amb</sub> = 60 °C	P <sub>tot</sub>	max.	200	mW
Junction temperature	T <sub>j</sub>	max.	150	°C
Small-signal current gain -I <sub>C</sub> = 2 mA; -V <sub>CE</sub> = 5 V; f = 1 kHz	h <sub>fe</sub>		75 to 900	
Transition frequency at f = 35 MHz -I <sub>C</sub> = 10 mA; -V <sub>CE</sub> = 5 V	f <sub>T</sub>	typ.	150	MHz
Noise figure at R <sub>S</sub> = 2 kΩ -I <sub>C</sub> = 200 μA; -V <sub>CE</sub> = 5 V f = 1 kHz; B = 200 Hz	F	<	10	dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

			BC856; R	BC857; R	BC858; R
Collector-base voltage (open emitter)	$-V_{CB0}$	max.	80	50	30 V
Collector-emitter voltage (+ $V_{BE} = 1$ V)	$-V_{CEX}$	max.	80	50	30 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	65	45	30 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5	5	5 V
Collector current (d.c.)	$-I_C$	max.		100	mA
Collector current (peak value)	$-I_{CM}$	max.		200	mA
Emitter current (peak value)	$I_{EM}$	max.		200	mA
Base current (peak value)	$-I_{BM}$	max.		200	mA
Total power dissipation ** up to $T_{amb} = 60$ °C	$P_{tot}$	max.		200	mW
Storage temperature	$T_{stg}$			-65 to +150	°C
Junction temperature	$T_j$	max.		150	°C

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=		60	K/W
From tab to soldering points	$R_{th\ t-s}$	=		280	K/W
From soldering points to ambient **	$R_{th\ s-a}$	=		90	K/W

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

Collector cut-off current $I_E = 0; -V_{CB} = 30$ V; $T_j = 25$ °C	$-I_{CBO}$	typ.		1	nA
		<		15	nA
$T_j = 150$ °C	$-I_{CBO}$	<		4	$\mu$ A

**Base-emitter voltage <sup>▲</sup>**

$-I_C = 2$ mA; $-V_{CE} = 5$ V	$-V_{BE}$	typ.		650	mV
		<		600 to 750	mV
$-I_C = 10$ mA; $-V_{CE} = 5$ V	$-V_{BE}$	<		820	mV

<sup>▲</sup>  $-V_{BE}$  decreases by about 2 mV/K with increasing temperature.

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

Saturation voltages \*

$-I_C = 10 \text{ mA}; -I_B = 0,5 \text{ mA}$

$-V_{CEsat}$  typ. 75 mV  
< 300 mV

$-V_{BEsat}$  typ. 700 mV

$-I_C = 100 \text{ mA}; -I_B = 5 \text{ mA}$

$-V_{CEsat}$  typ. 250 mV  
< 650 mV

$-V_{BEsat}$  typ. 850 mV

Knee voltage

$-I_C = 10 \text{ mA}; -I_B = \text{value for which}$

$-I_C = 11 \text{ mA at } -V_{CE} = 1 \text{ V}$

$-V_{CEK}$  typ. 250 mV  
< 600 mV

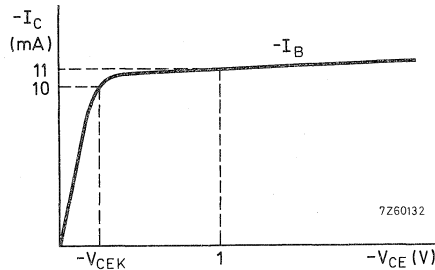


Fig. 2 Knee voltage waveform.

Collector capacitance at  $f = 1 \text{ MHz}$

$I_E = I_e = 0; -V_{CB} = 10 \text{ V}$

$C_C$  typ. 4,5 pF

Transition frequency at  $f = 35 \text{ MHz}$

$-I_C = 10 \text{ mA}; -V_{CE} = 5 \text{ V}$

$f_T$  typ. 150 MHz

Small-signal current gain at  $f = 1 \text{ kHz}$

$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V}$

$h_{fe}$  75 to 900

Noise figure at  $R_G = 2 \text{ k}\Omega$

$-I_C = 200 \mu\text{A}; -V_{CE} = 5 \text{ V}$

$f = 1 \text{ kHz}; B = 200 \text{ Hz}$

$F$  typ. 2 dB  
< 10 dB

D.C. current gain

$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V}$  BC856/857

$h_{FE}$  75 to 475

BC858

$h_{FE}$  75 to 800

BC856A/857A/858A

$h_{FE}$  125 to 250

BC856B/857B/858B

$h_{FE}$  220 to 475

BC857C/858C

$h_{FE}$  420 to 800

\*  $-V_{BEsat}$  decreases by about 1,7 mV/K with increasing temperature.

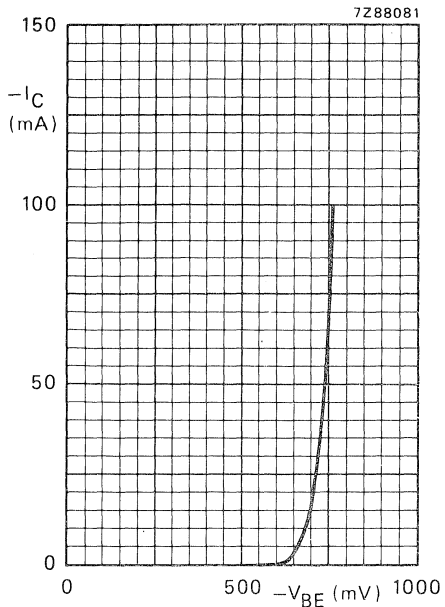


Fig. 3 Typical values.  $-V_{CE} = 5\text{ V}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

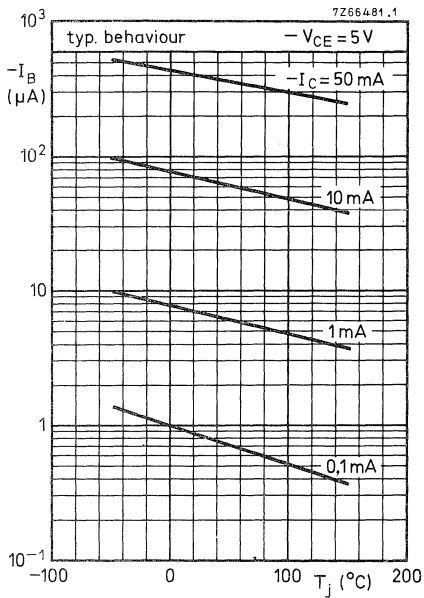


Fig. 4 Typical values.

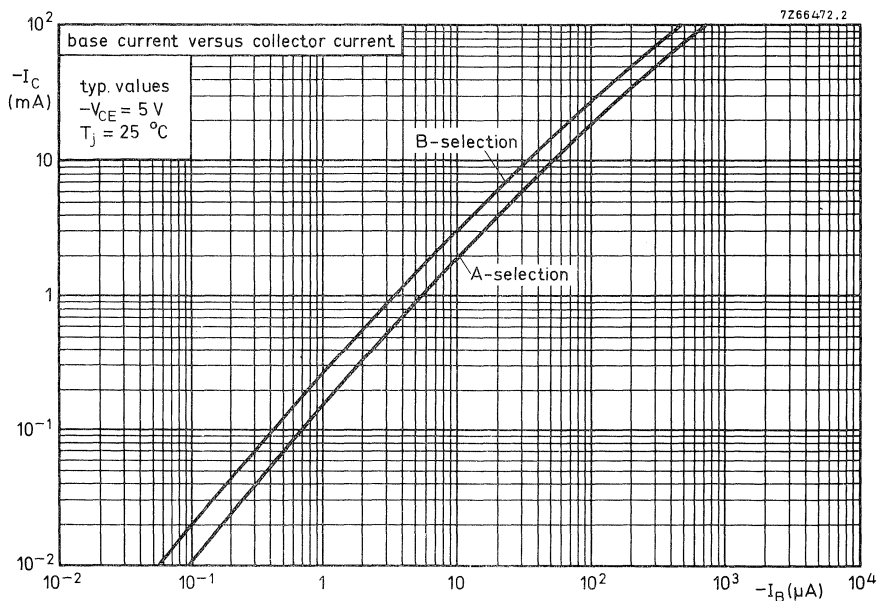


Fig. 5.



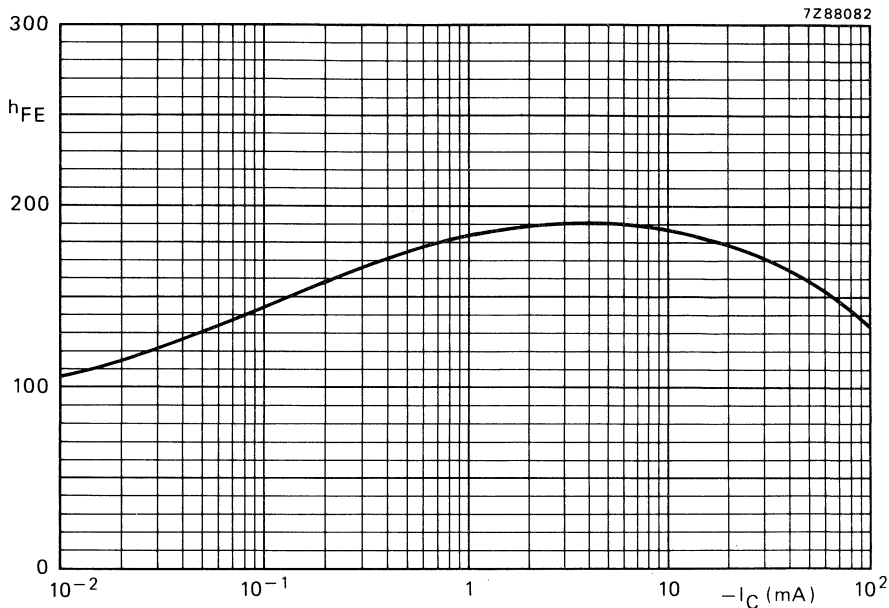


Fig. 6 Typical values D.C. current gain A-selections.  $-V_{CE} = 5$  V;  $T_j = 25$  °C.

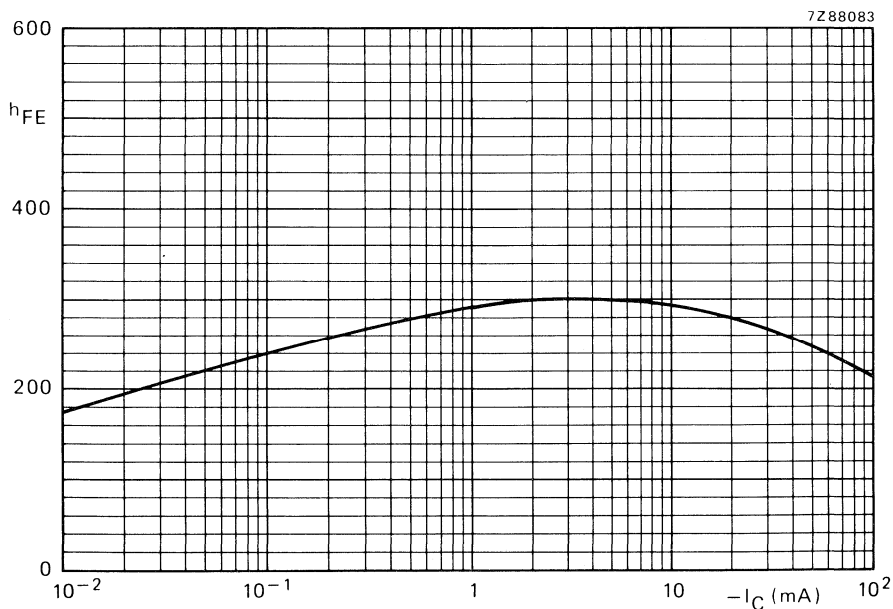


Fig. 7 Typical values D.C. current gain B-selections.  $-V_{CE} = 5$  V;  $T_j = 25$  °C.

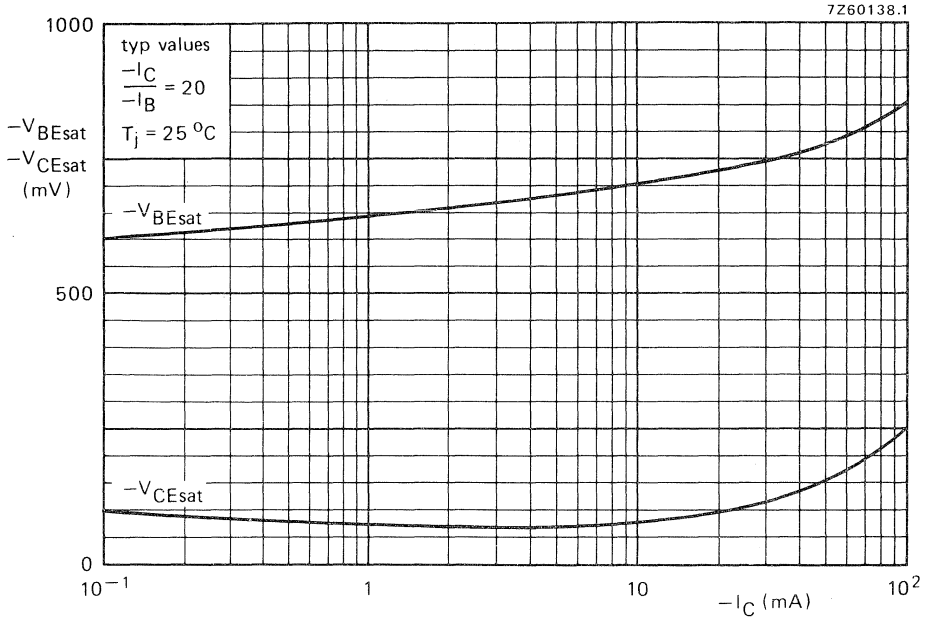


Fig. 8 Typical values base-emitter and collector-emitter saturation voltage.

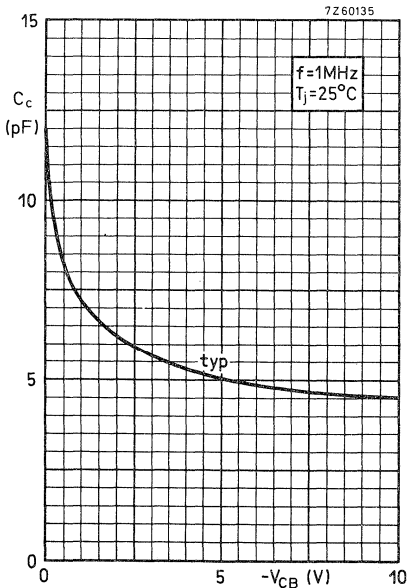


Fig. 9 Typical values.

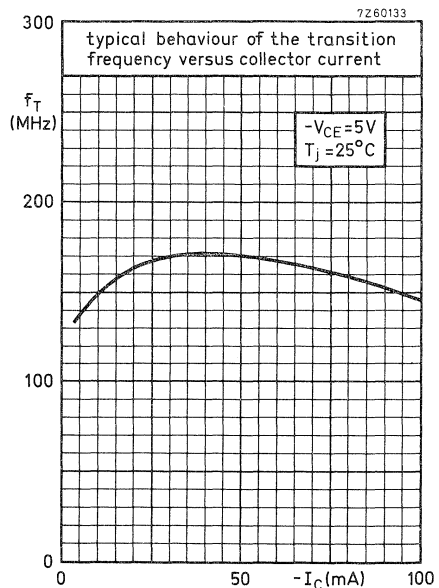


Fig. 10 Typical values.  $f = 35\text{ MHz}$ .

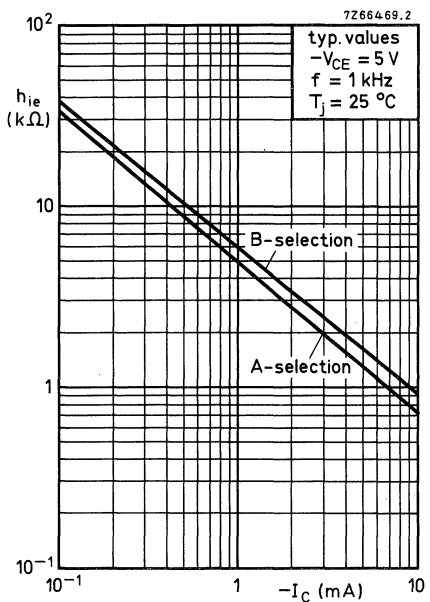


Fig. 11.

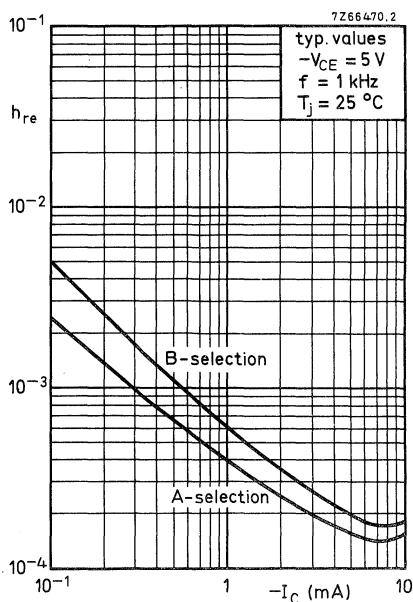


Fig. 12.

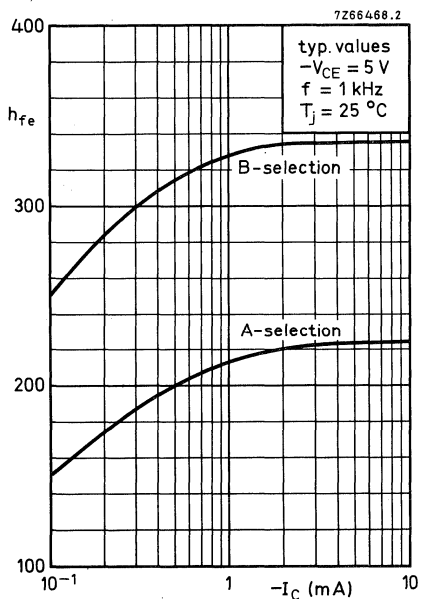


Fig. 13.

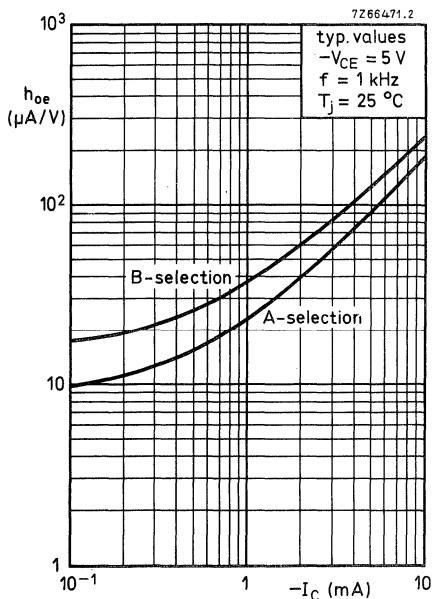


Fig. 14.



## SILICON PLANAR EPITAXIAL TRANSISTORS

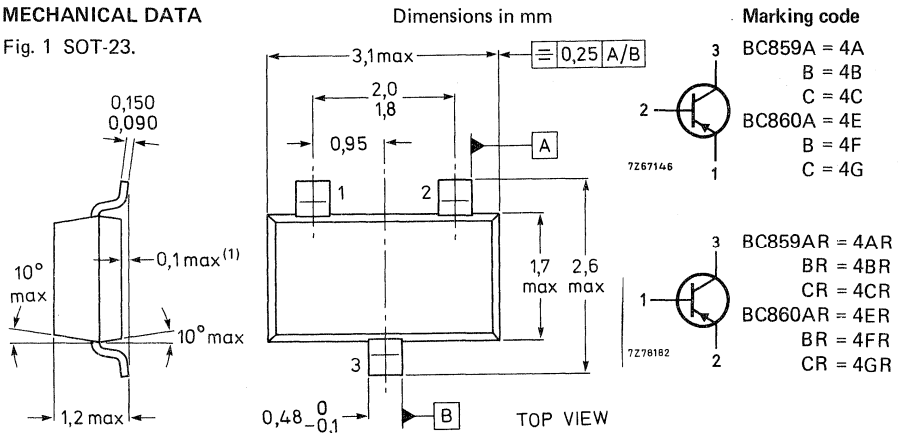
P-N-P transistors in a plastic SOT-23 envelope, primarily intended for low-noise input stages in tape recorders, hi-fi amplifiers and other audio frequency equipment in thick and thin-film hybrid circuits.

### QUICK REFERENCE DATA

		BC859; R	BC860; R	
Collector-emitter voltage (+ $V_{BE} = 1$ V)	$-V_{CEX}$ max.	30	50	V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	30	45	V
Collector current (peak value)	$-I_{CM}$ max.	200	200	mA
Total power dissipation up to $T_{amb} = 60$ °C	$P_{tot}$ max.	200	200	mW
Junction temperature	$T_j$ max.	150	150	°C
Small-signal current gain	$h_{fe}$	> 125	125	
$-I_C = 2$ mA; $-V_{CE} = 5$ V; $f = 1$ kHz		< 900	900	
Transition frequency	$f_T$ typ.	150	150	MHz
$-I_C = 10$ mA; $-V_{CE} = 5$ V				
Noise figure at $R_s = 2$ k $\Omega$	F typ.	1,2	1	dB
$-I_C = 200$ $\mu$ A; $-V_{CE} = 5$ V		< 4	3	dB
$f = 30$ Hz to 15 kHz				
$f = 1$ kHz; B = 200 Hz	F	< 4	4	dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

7266908.7

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BC859; R	BC860; R	
Collector-base voltage (open emitter)	$-V_{CBO}$ max.	30	50	V
Collector-emitter voltage (+ $V_{BE} = 1$ V)	$-V_{CEX}$ max.	30	50	V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	30	45	V
Emitter-base voltage (open collector)	$-V_{CBO}$ max.	5	5	V
Collector current (d.c.)	$-I_C$ max.	100		mA
Collector current (peak value)	$-I_{CM}$ max.	200		mA
Emitter current (peak value)	$I_{EM}$ max.	200		mA
Base current (peak value)	$-I_{BM}$ max.	200		mA
Total power dissipation up to $T_{amb} = 60$ °C**	$P_{tot}$ max.	200		mW
Storage temperature	$T_{stg}$	-65 to + 150		°C
Junction temperature	$T_j$ max.	150		°C

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$ =	60	K/W
From tab to soldering points	$R_{th\ t-s}$ =	280	K/W
From soldering points to ambient**	$R_{th\ s-a}$ =	90	K/W

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

**Collector cut-off current**

$I_E = 0; -V_{CB} = 30$ V; $T_j = 25$ °C	$-I_{CBO}$ typ.	1	nA
	$-I_{CBO} <$	15	nA
$T_j = 150$ °C	$-I_{CBO} <$	4	$\mu$ A

**Base-emitter voltage ▲**

$-I_C = 2$ mA; $-V_{CE} = 5$ V	$-V_{BE}$ typ.	650	mV
$-I_C = 10$ mA; $-V_{CE} = 5$ V	$-V_{BE} <$	600 to 750	mV
		820	mV

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

▲  $-V_{BE}$  decreases by about 2 mV/K with increasing temperature.

**Saturation voltages\***

$-I_C = 10 \text{ mA}; -I_B = 0,5 \text{ mA}$

$-V_{CEsat}$  typ. 75 mV  
< 300 mV

$-V_{BEsat}$  typ. 700 mV

$-I_C = 100 \text{ mA}; -I_B = 5 \text{ mA}$

$-V_{CEsat}$  typ. 250 mV  
< 650 mV

$-V_{BEsat}$  typ. 850 mV

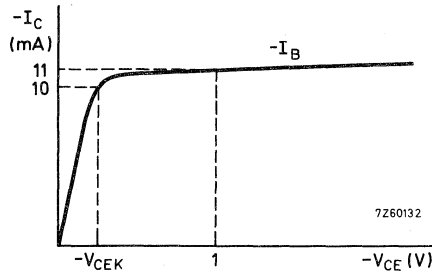
**Knee voltage**

$-I_C = 10 \text{ mA}; -I_B = \text{value for which}$

$-I_C = 11 \text{ mA at } -V_{CE} = 1 \text{ V}$

$-V_{CEK}$  typ. 250 mV  
< 600 mV

Fig. 2.



**Collector capacitance at  $f = 1 \text{ MHz}$**

$I_E = I_e = 0; -V_{CB} = 10 \text{ V}$

$C_c$  typ. 4,5 pF

**Transition frequency at  $f = 35 \text{ MHz}$**

$-I_C = 10 \text{ mA}; -V_{CE} = 5 \text{ V}$

$f_T$  typ. 150 MHz

**Small-signal current gain at  $f = 1 \text{ kHz}$**

$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V}$

$h_{fe}$  125 to 900

**Noise figure at  $R_S = 2 \text{ k}\Omega$**

$-I_C = 200 \mu\text{A}; -V_{CE} = 5 \text{ V}$

$f = 30 \text{ Hz to } 15 \text{ kHz}$

		BC859	BC860	
F	typ.	1,2	1	dB
	<	4	3	dB

$f = 1 \text{ kHz}; B = 200 \text{ Hz}$

F	typ.	1	1	dB
	<	4	4	dB

**Equivalent noise voltage at  $R_S = 2 \text{ k}\Omega$**

$-I_C = 200 \mu\text{A}; -V_{CE} = 5 \text{ V}$

$f = 10 \text{ Hz to } 50 \text{ Hz}; T_{amb} = 25 \text{ }^\circ\text{C}$

$V_n$	<	—	0,11	$\mu\text{V}$
-------	---	---	------	---------------

**D.C. current gain**

$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V}; \text{ total range}$

A selections

B selections

C selections

$h_{FE}$	125 to 800
$h_{FE}$	125 to 250
$h_{FE}$	220 to 475
$h_{FE}$	420 to 800

\*  $-V_{BEsat}$  decreases by about 1,7 mV/K with increasing temperature.

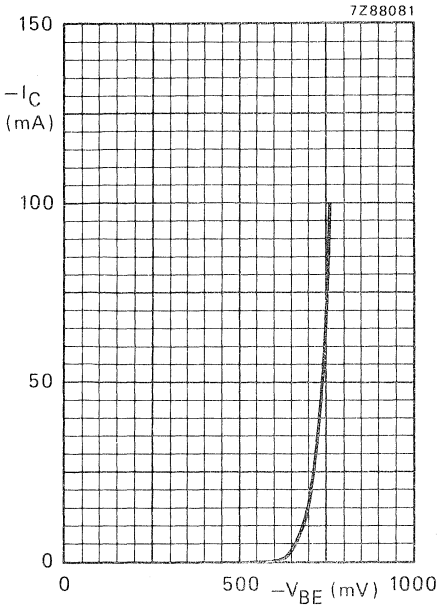


Fig. 3 Typical values.  $-V_{CE} = 5\text{ V}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

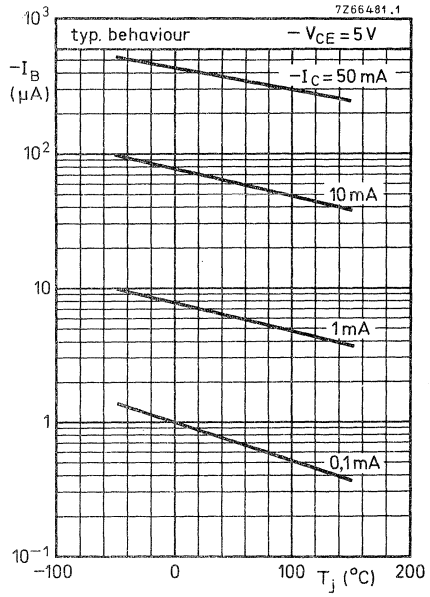


Fig. 4 Typical values.

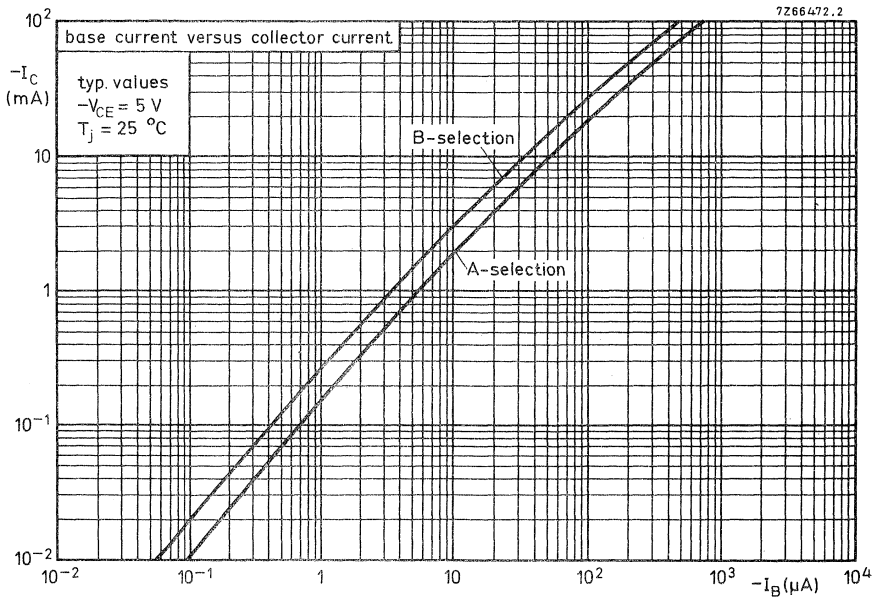


Fig. 5.



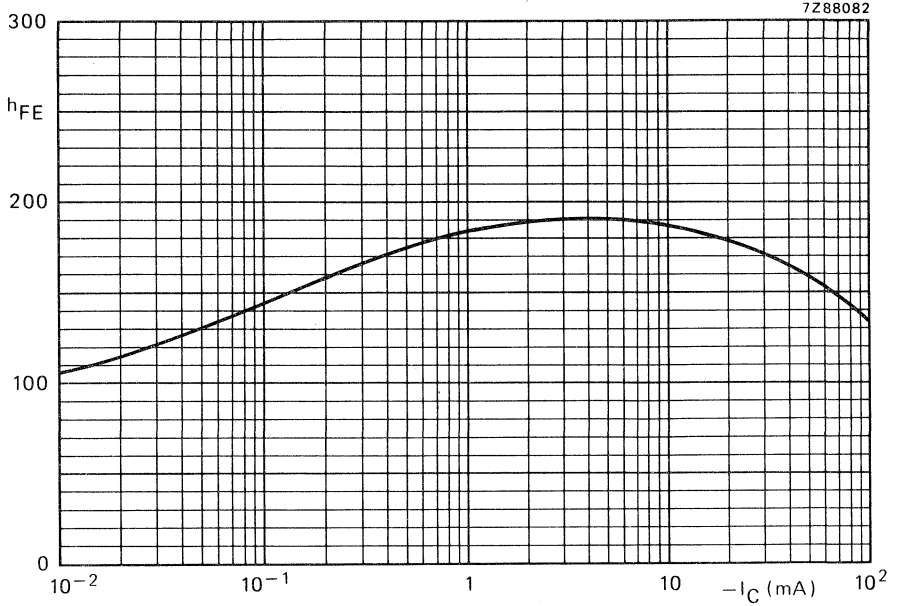


Fig. 6 Typical values. D.C. current gain A-selections.  $-V_{CE} = 5\text{ V}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

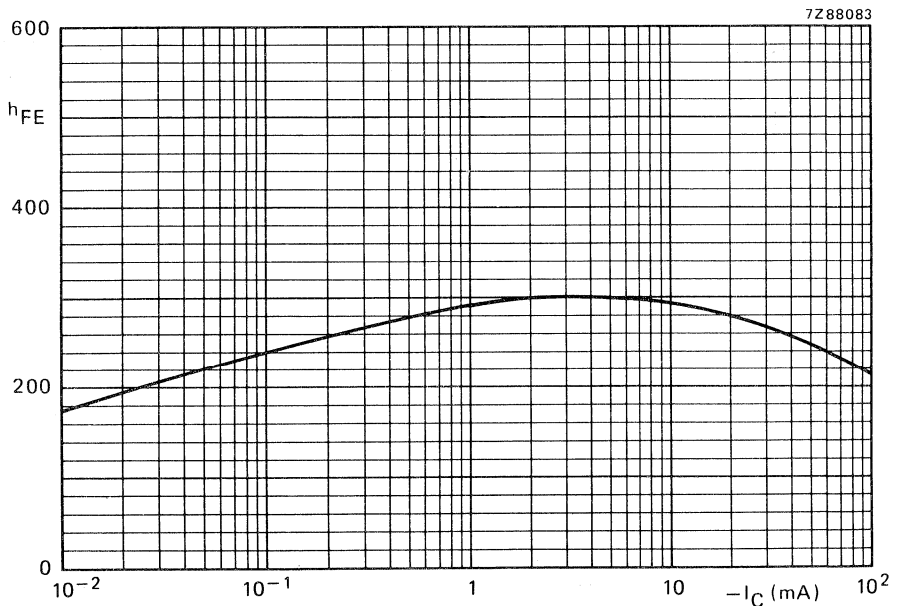


Fig. 7 Typical values. D.C. current gain B-selections.  $-V_{CE} = 5\text{ V}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

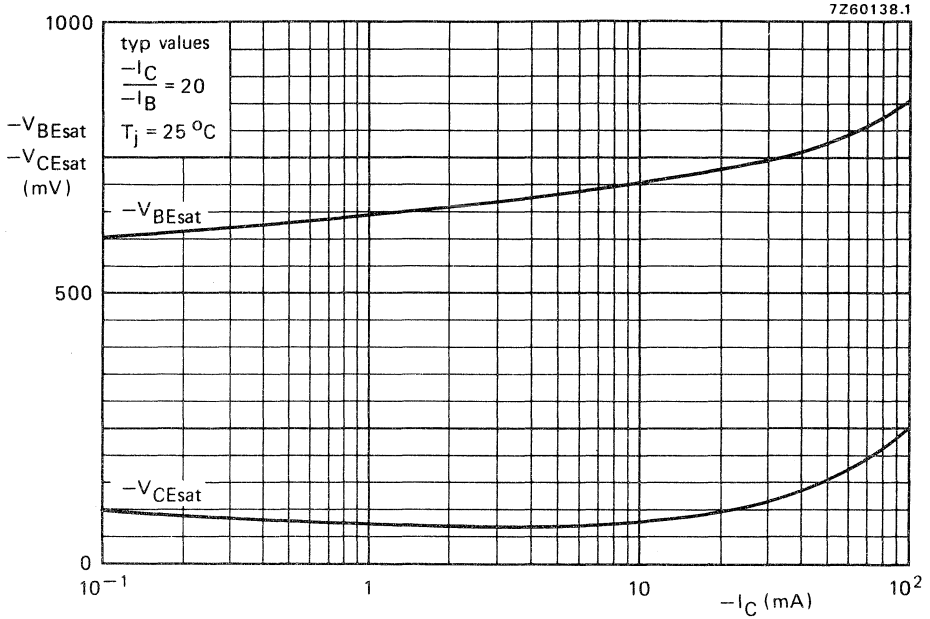


Fig. 8 Typical values base-emitter and collector-emitter saturation voltage.

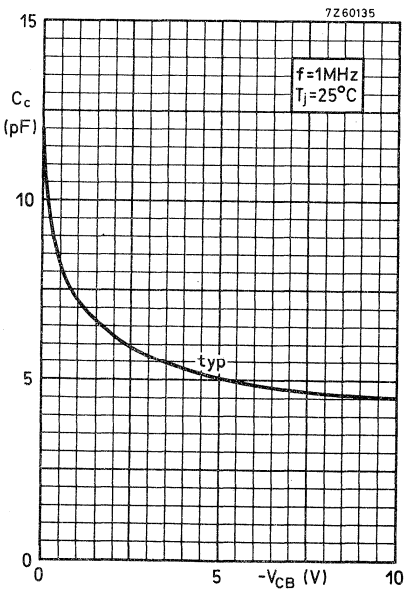


Fig. 9 Typical values.

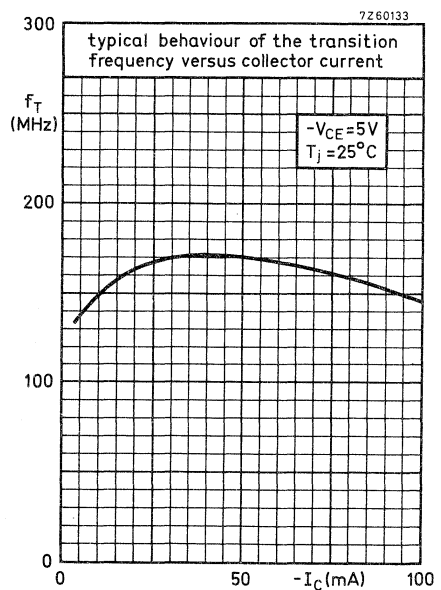


Fig. 10 Typical values.  $f = 35\text{ MHz}$ .

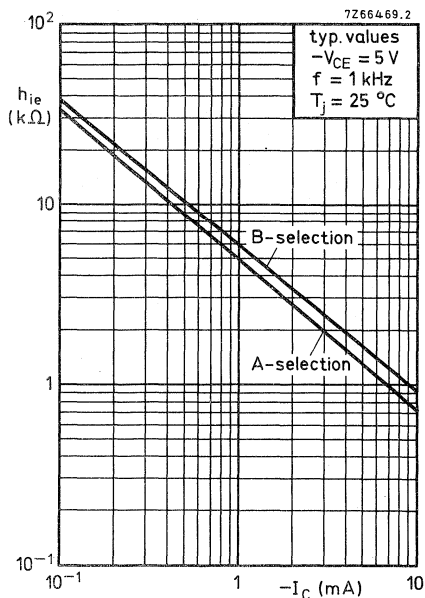


Fig. 11 Typical values.

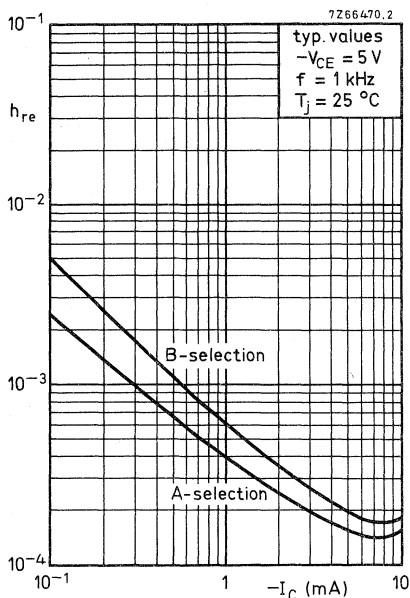


Fig. 12 Typical values.

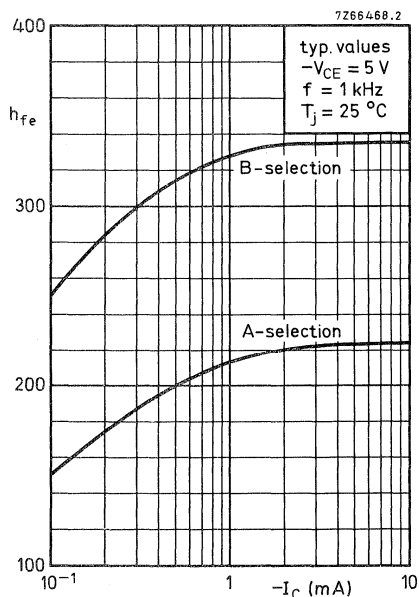


Fig. 13 Typical values.

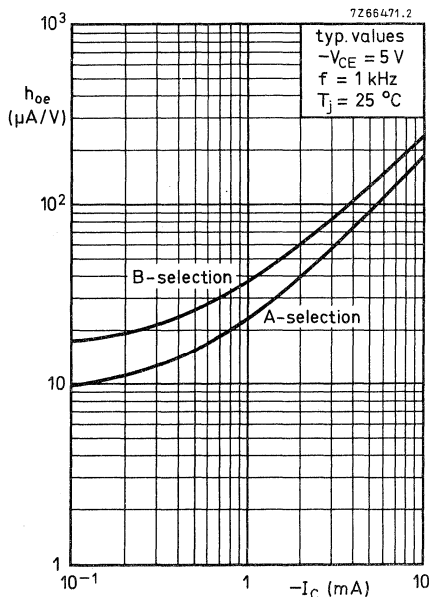


Fig. 14 Typical values.

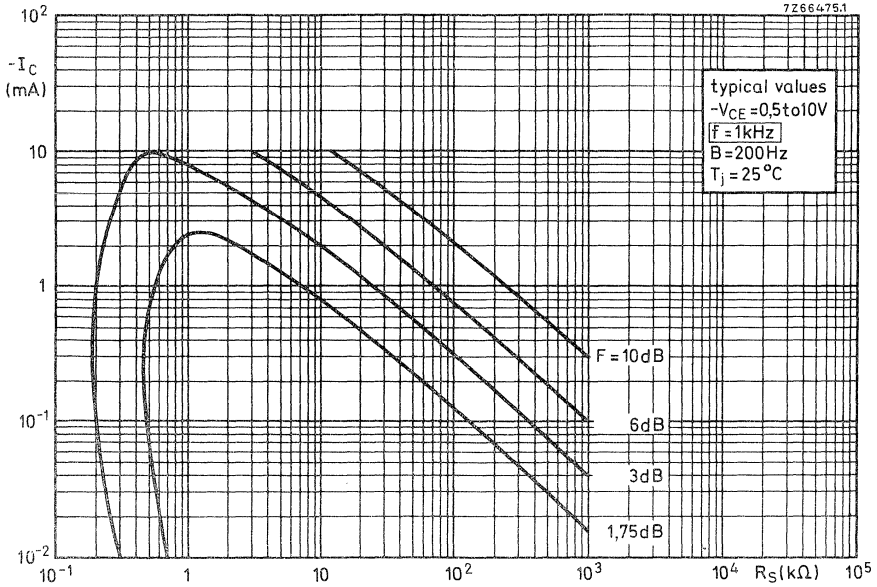


Fig. 15 Curves of constant noise figure at  $f = 1$  kHz.

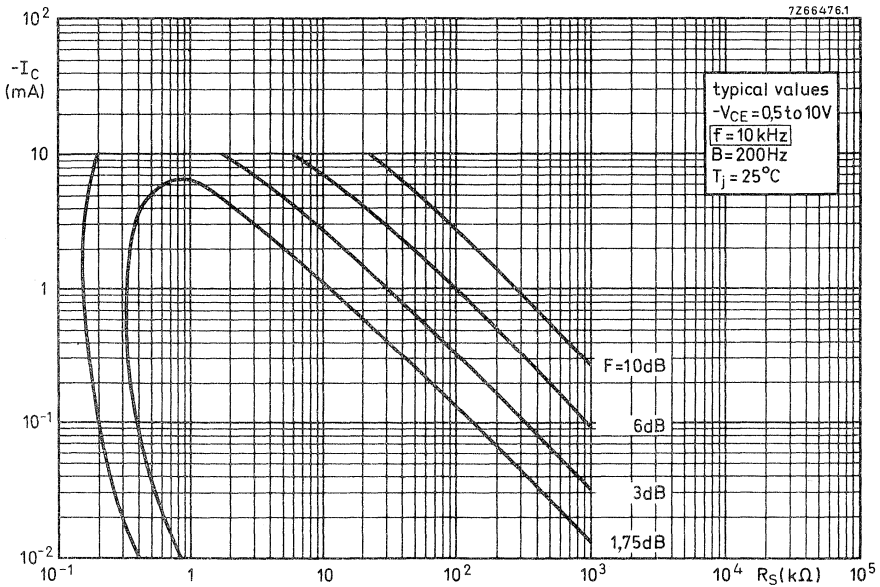


Fig. 16 Curves of constant noise figure at  $f = 10$  kHz.

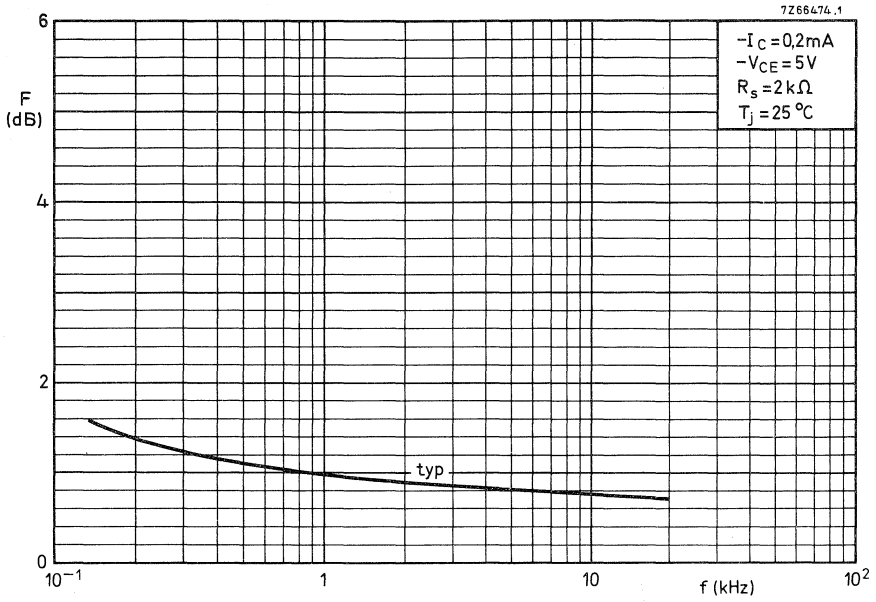


Fig. 17 Typical values noise figure.



# DEVELOPMENT SAMPLE DATA

This information is derived from development samples made available for evaluation. It does not necessarily imply that the device will go into regular production.

BC868

## SILICON PLANAR EPITAXIAL TRANSISTOR

N-P-N transistor in a microminiature plastic envelope intended for low-voltage, high-current I.f. applications. BC868/BC869 is the matched complementary pair suitable for class-B audio output stages up to 3 W.

### QUICK REFERENCE DATA

Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max.	25 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	20 V
Collector current (peak value)	$I_{CM}$	max.	2 A
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	1 W
Junction temperature	$T_j$	max.	150 $^{\circ}\text{C}$
D.C. current gain	$h_{FE}$		85 to 375
$I_C = 500\text{ mA}; V_{CE} = 1\text{ V}$			
Transition frequency at $f = 35\text{ MHz}$	$f_T$	typ.	60 MHz
$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$			

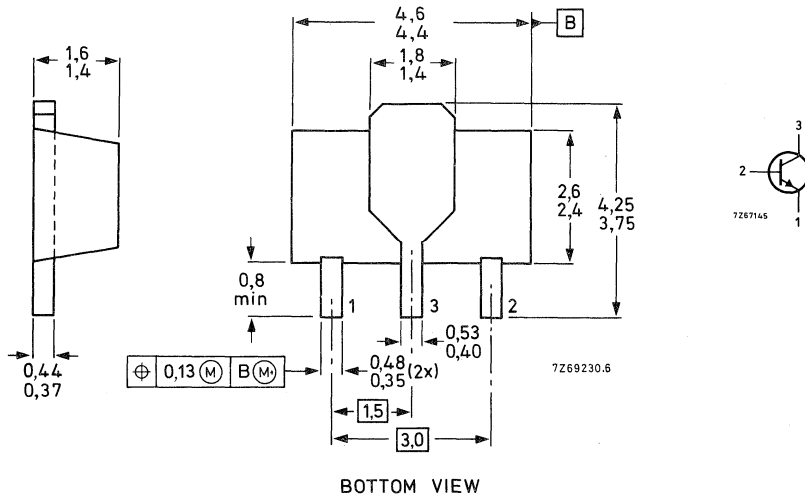
### MECHANICAL DATA

Dimensions in mm

Mark

Fig. 1 SOT-89.

BC868



See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max.	25 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	20 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	5 V
Collector current (d.c.)	$I_C$	max.	1 A
Collector current (peak value)	$I_{CM}$	max.	2 A
Base current (d.c.)	$I_B$	max.	100 mA
Base current (peak value)	$I_{BM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}^*$	$P_{tot}$	max.	1 W
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air*	$R_{th\ j-a}$	=	125 K/W
From junction to tab	$R_{th\ j-t}$	=	10 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 25\text{ V}$

$I_{CBO} < 10\text{ }\mu\text{A}$

$I_E = 0; V_{CB} = 25\text{ V}; T_j = 150\text{ }^\circ\text{C}$

$I_{CBO} < 1\text{ mA}$

Emitter cut-off current

$I_C = 0; V_{EB} = 5\text{ V}$

$I_{EBO} < 10\text{ }\mu\text{A}$

Base-emitter voltage

$I_C = 5\text{ mA}; V_{CE} = 10\text{ V}$

$V_{BE}$  typ. 0,62 V

$I_C = 1\text{ A}; V_{CE} = 1\text{ V}$

$V_{BE} < 1\text{ V}$

Collector-emitter saturation voltage

$I_C = 1\text{ A}; I_B = 100\text{ mA}$

$V_{CEsat} < 0,5\text{ V}$

D.C. current gain

$I_C = 5\text{ mA}; V_{CE} = 10\text{ V}$

$h_{FE} > 50$

$I_C = 500\text{ mA}; V_{CE} = 1\text{ V}$

$h_{FE}$  85 to 375

$I_C = 1\text{ A}; V_{CE} = 1\text{ V}$

$h_{FE} > 60$

Collector capacitance at  $f = 450\text{ kHz}$

$I_E = I_e = 0; V_{CB} = 5\text{ V}$

$C_c$  typ. 27 pF

Cut-off frequency

$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$

$f_{hfe}$  typ. 400 kHz

Transition frequency at  $f = 35\text{ MHz}$

$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$

$f_T$  typ. 60 MHz

D.C. current gain ratio of matched pair BC868/BC869

$|I_C| = 500\text{ mA}; |V_{CE}| = 1\text{ V}$

$h_{FE1}/h_{FE2} < 1,4$

\* Mounted on a ceramic substrate, area = 2,5 cm<sup>2</sup>, thickness = 0,7 mm.



DEVELOPMENT SAMPLE DATA

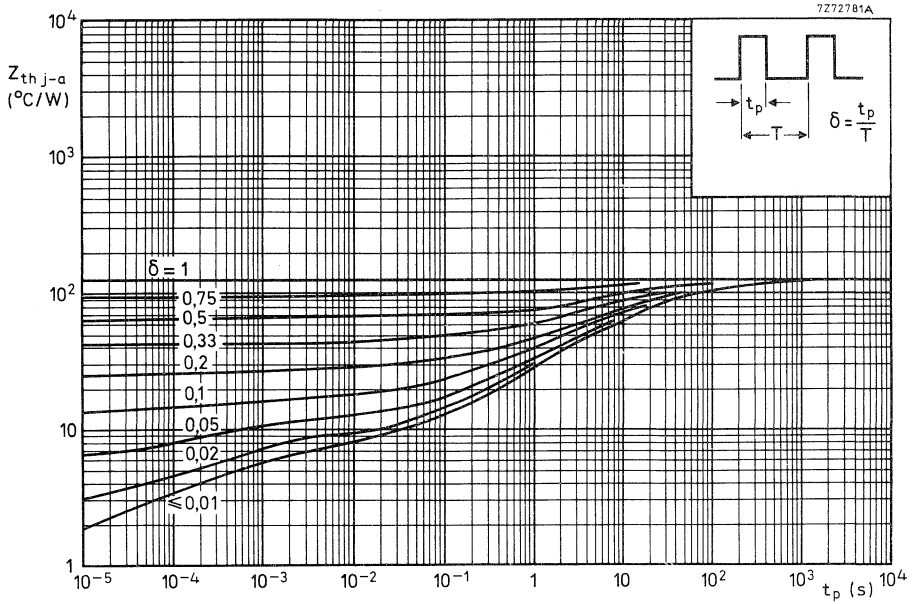


Fig. 2 Pulse power rating chart.

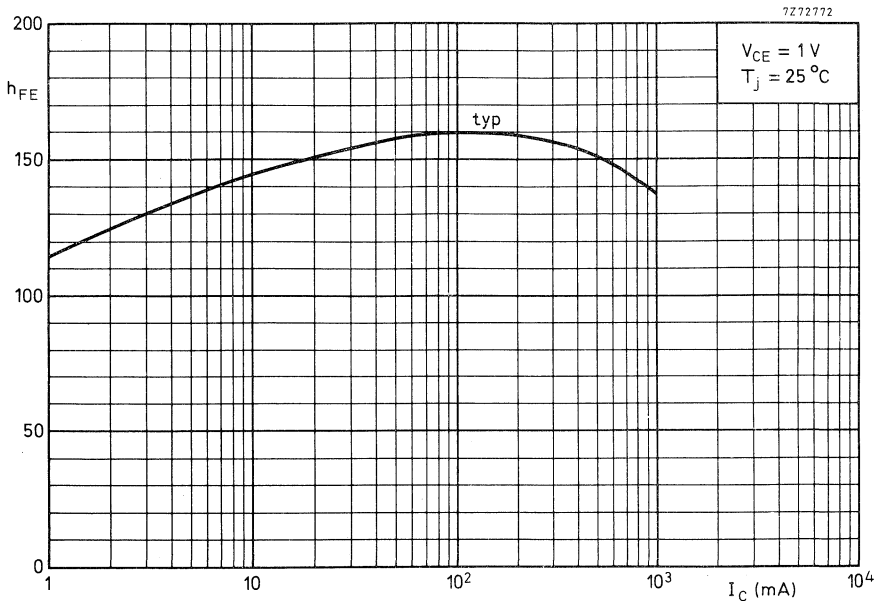


Fig. 3 D.C. current gain.

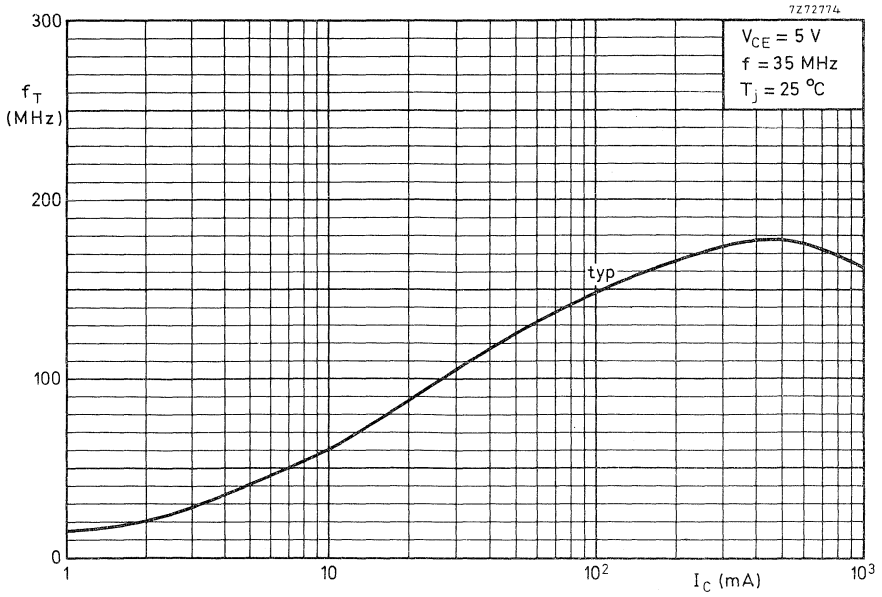


Fig. 4 Typical values transition frequency as a function of collector current.

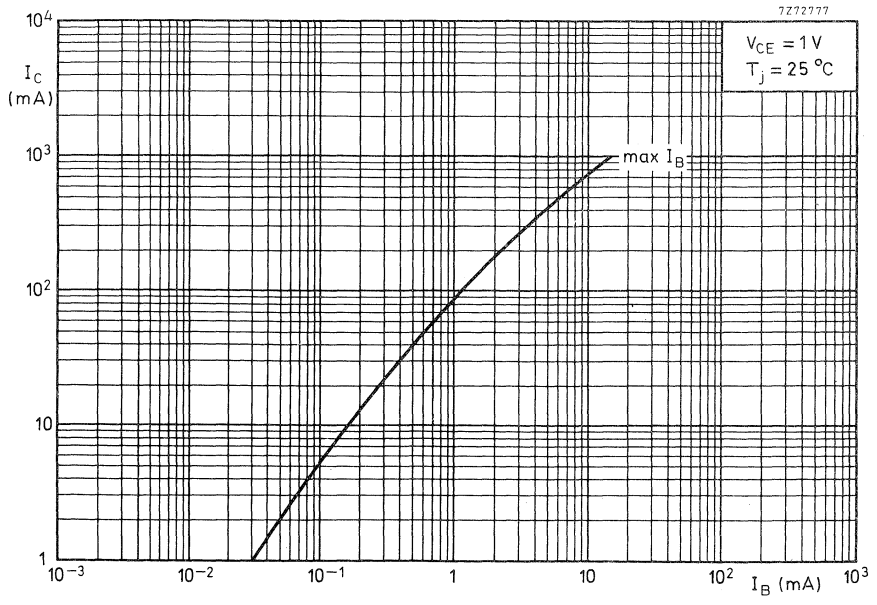


Fig. 5 Typical values collector current as a function of maximum base current.

DEVELOPMENT SAMPLE DATA

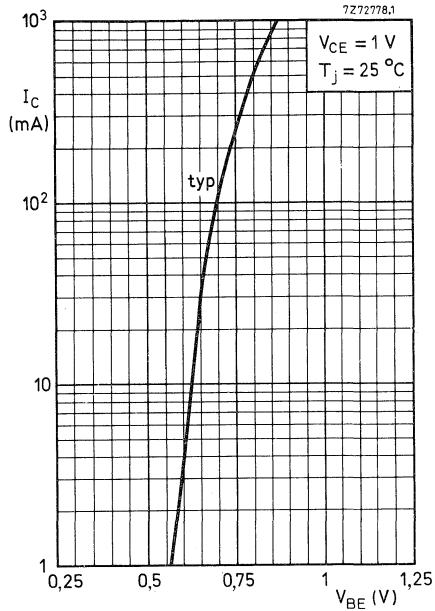


Fig. 6 Typical values collector current as a function of base-emitter voltage.

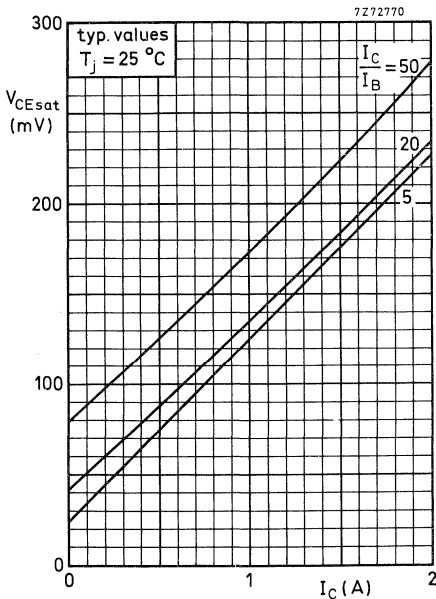


Fig. 7 Collector-emitter saturation voltage as a function of collector current.

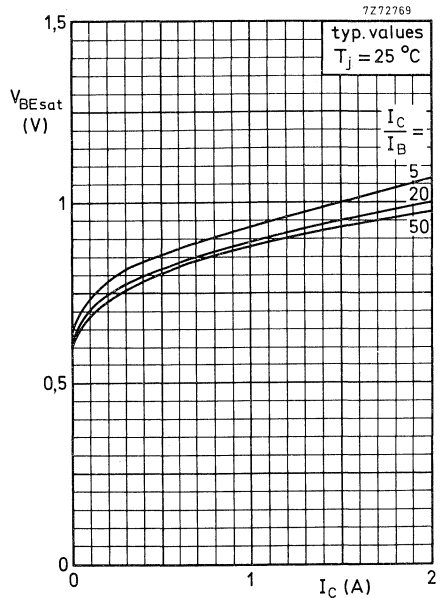


Fig. 8 Base-emitter saturation voltage as a function of collector current.



# DEVELOPMENT SAMPLE DATA

This information is derived from development samples made available for evaluation. It does not necessarily imply that the device will go into regular production.

BC869

## SILICON PLANAR EPITAXIAL TRANSISTOR

P-N-P transistor in a plastic microminiature envelope, intended for low-voltage, high-current I.f. applications. BC868/BC869 is the matched complementary pair suitable for class-B audio output stages up to 3 W.

### QUICK REFERENCE DATA

Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$ max.	25 V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	20 V
Collector current (peak value)	$-I_{CM}$ max.	2 A
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$P_{tot}$ max.	1 W
Junction temperature	$T_j$ max.	150 $^{\circ}\text{C}$
D.C. current gain	$h_{FE}$	85 to 375
$-I_C = 500\text{ mA}; -V_{CE} = 1\text{ V}$		
Transition frequency at $f = 35\text{ MHz}$	$f_T$ typ.	60 MHz
$-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$		

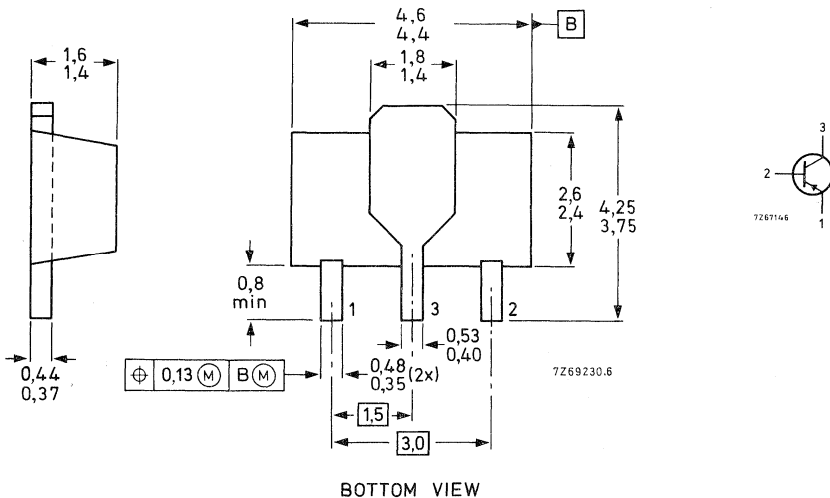
### MECHANICAL DATA

Dimensions in mm

Mark

Fig. 1 SOT-89.

BC869



See also *Soldering recommendations*.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$	max.	25 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	20 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	1 A
Collector current (peak value)	$-I_{CM}$	max.	2 A
Base current (d.c.)	$-I_B$	max.	100 mA
Base current (peak value)	$-I_{BM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}^*$	$P_{tot}$	max.	1 W
Storage temperature	$T_{stg}$		$-65$ to $+150\text{ }^\circ\text{C}$
Junction temperature	$T_j$	max.	$150\text{ }^\circ\text{C}$

## THERMAL RESISTANCE

From junction to ambient in free air*	$R_{th\ j-a}$	=	125 K/W
From junction to tab	$R_{th\ j-t}$	=	10 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_E = 0; -V_{CB} = 25\text{ V}$	$-I_{CBO}$	<	10 $\mu\text{A}$
$I_E = 0; -V_{CB} = 25\text{ V}; T_j = 150\text{ }^\circ\text{C}$	$-I_{CBO}$	<	1 mA

Emitter cut-off current

$I_C = 0; -V_{EB} = 5\text{ V}$	$-I_{EBO}$	<	10 $\mu\text{A}$
---------------------------------	------------	---	------------------

Base-emitter voltage

$-I_C = 5\text{ mA}; -V_{CE} = 10\text{ V}$	$-V_{BE}$	typ.	0,62 V
$-I_C = 1\text{ A}; -V_{CE} = 1\text{ V}$	$-V_{BE}$	<	1 V

Collector-emitter saturation voltage

$-I_C = 1\text{ A}; -I_B = 100\text{ mA}$	$-V_{CEsat}$	<	0,5 V
---	--------------	---	-------

D.C. current gain

$-I_C = 5\text{ mA}; -V_{CE} = 10\text{ V}$	$h_{FE}$	>	50
$-I_C = 500\text{ mA}; -V_{CE} = 1\text{ V}$	$h_{FE}$		85 to 375
$-I_C = 1\text{ A}; -V_{CE} = 1\text{ V}$	$h_{FE}$	>	60

Collector capacitance at  $f = 450\text{ kHz}$ 

$I_E = I_e = 0; -V_{CB} = 5\text{ V}$	$C_c$	typ.	45 pF
---------------------------------------	-------	------	-------

Cut-off frequency

$-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$	$f_{hfe}$	typ.	350 kHz
---	-----------	------	---------

Transition frequency at  $f = 35\text{ MHz}$ 

$-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$	$f_T$	typ.	60 MHz
---	-------	------	--------

D.C. current gain ratio of matched pair BC868/BC869

$ I_C  = 500\text{ mA};  V_{CE}  = 1\text{ V}$	$h_{FE1}/h_{FE2}$	<	1,4
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\* Mounted on a ceramic substrate, area =  $2,5\text{ cm}^2$ ; thickness = 0,7 mm.

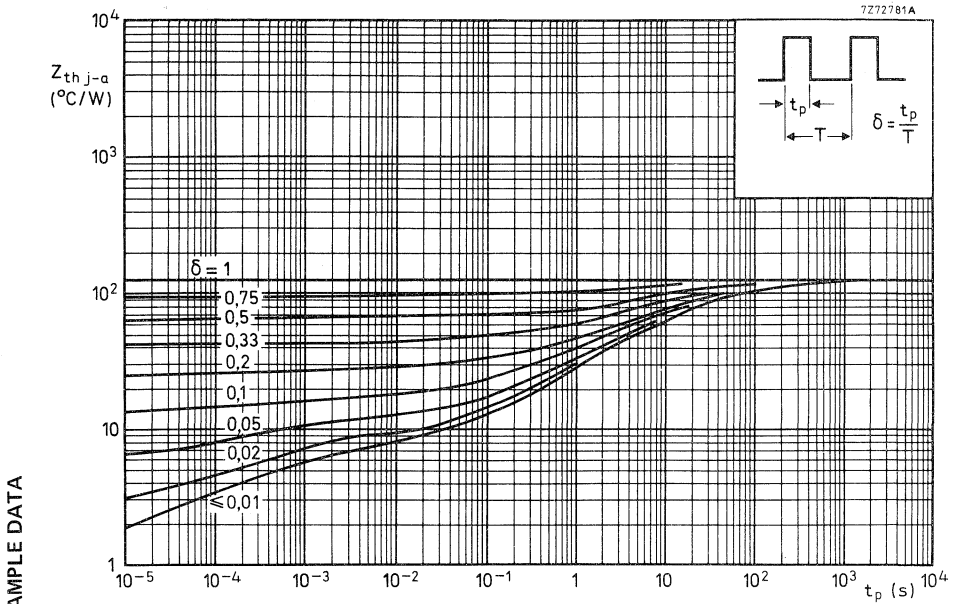


Fig. 2 Pulse power rating chart.

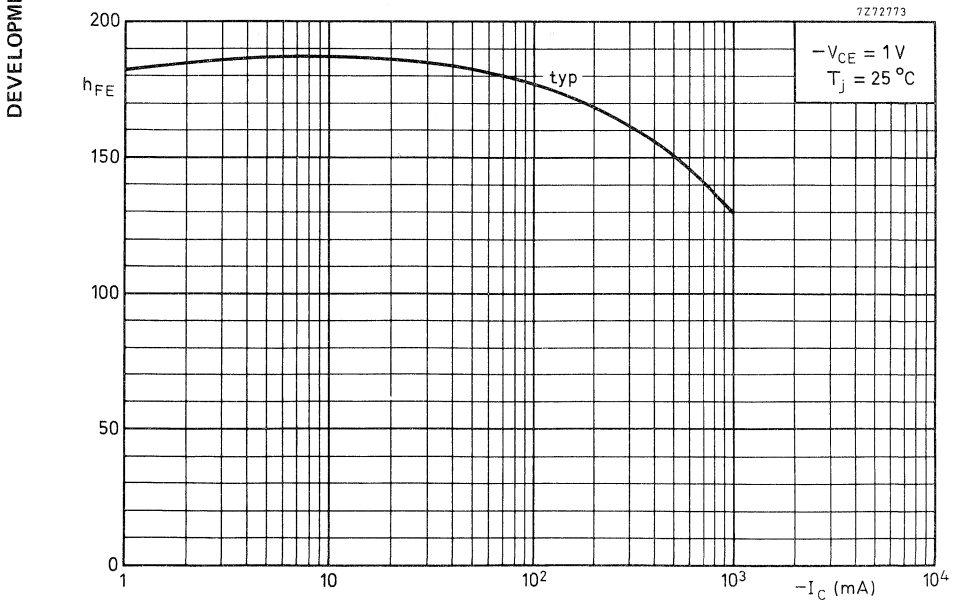


Fig. 3 D.C. current gain.

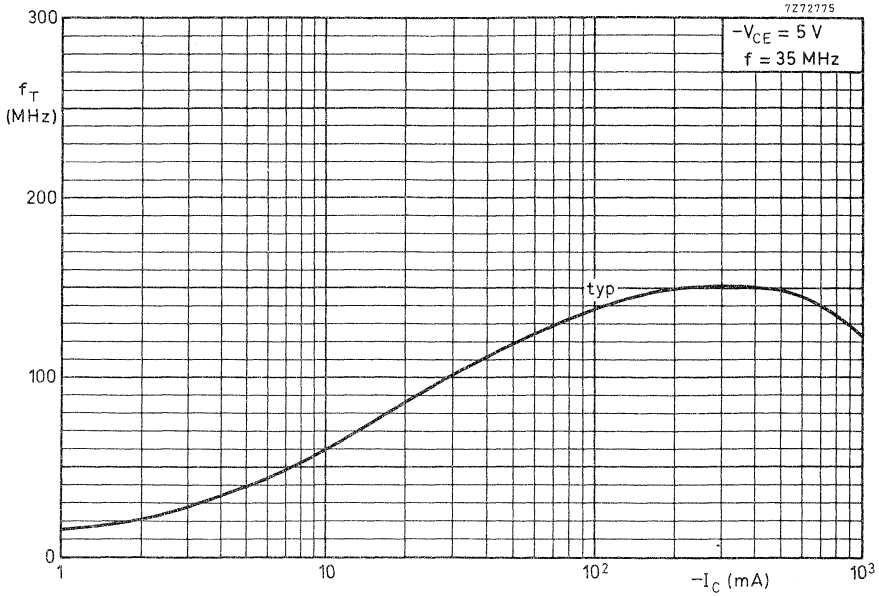


Fig. 4 Typical values transition frequency as a function of collector current.

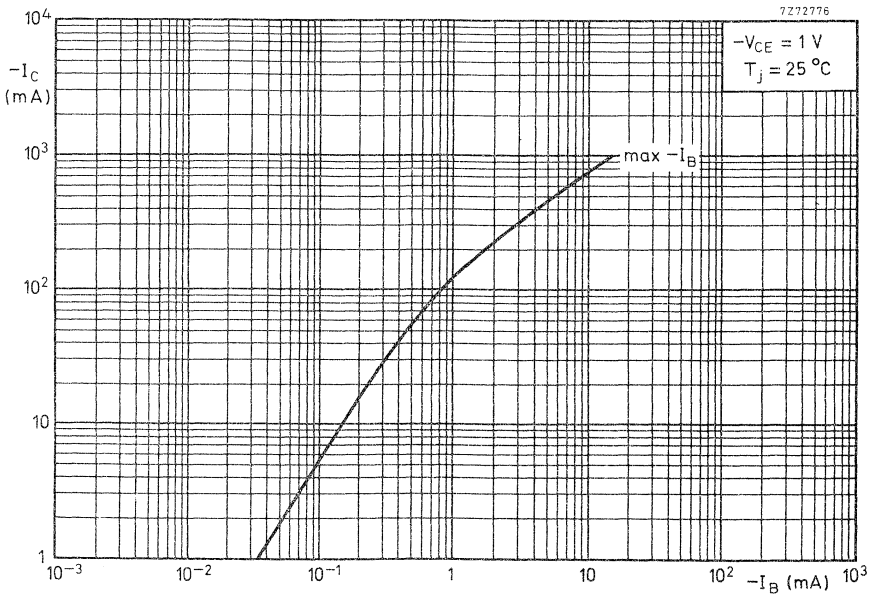


Fig. 5 Typical values collector current as a function of maximum base current.



DEVELOPMENT SAMPLE DATA

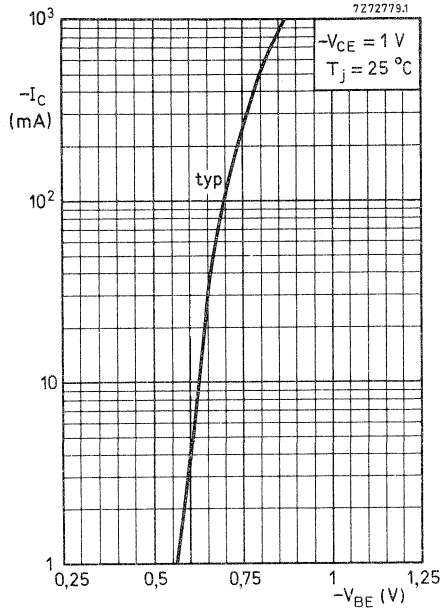


Fig. 6 Typical values collector current as a function of base-emitter voltage.

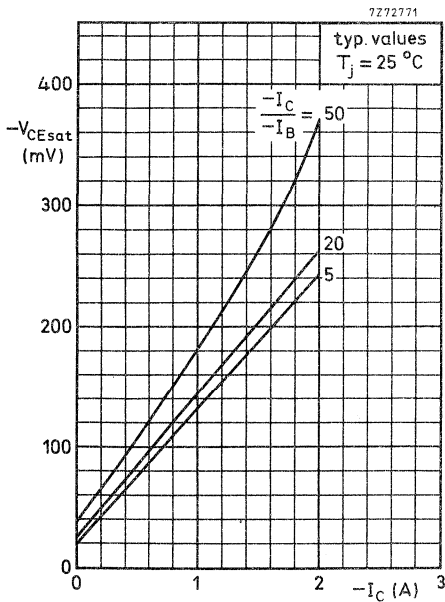


Fig. 7 Collector-emitter saturation voltage as a function of collector current.

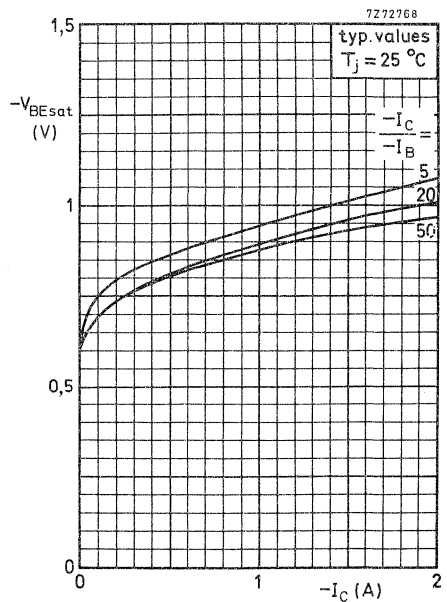


Fig. 8 Base-emitter saturation voltage as a function of collector current.



## SILICON PLANAR EPITAXIAL TRANSISTORS

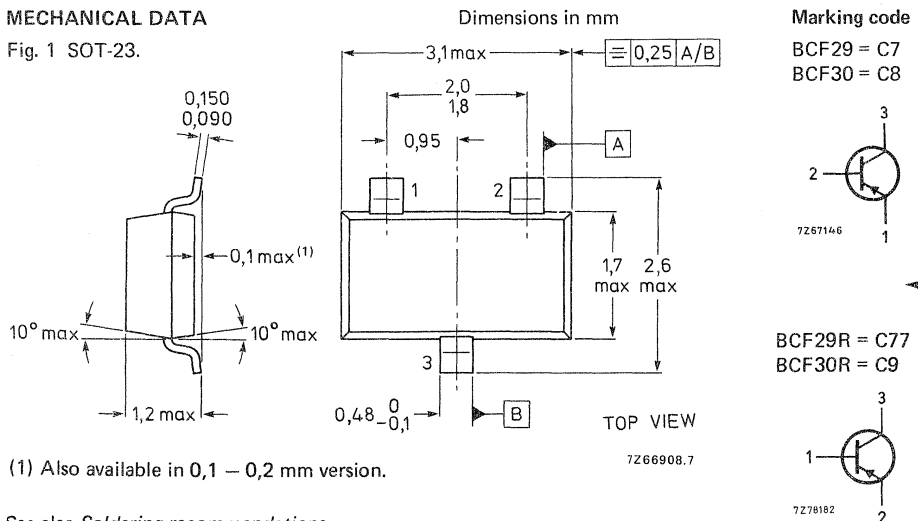
P-N-P transistors, in a microminiature plastic envelope, intended for low level, low noise general purpose applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

		BCF29 BCF29R		BCF30 BCF30R	
		D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$	$h_{FE}$	> <	120 260
Collector-base voltage (open emitter)	$-V_{CBO}$	max.	32		V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	32		V
Collector current (peak value)	$-I_{CM}$	max.	200		mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	350		mW
Junction temperature	$T_j$	max.	175		$^\circ\text{C}$
Transition frequency at $f = 35\text{ MHz}$ $-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$	$f_T$	typ.	150		MHz
Noise figure at $R_S = 2\text{ k}\Omega$ $-I_C = 200\text{ }\mu\text{A}; -V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$	F	<	4		dB

### MECHANICAL DATA

Fig. 1 SOT-23.



See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	32 V
Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$	max.	32 V
Collector-emitter voltage (open base) $-I_C = 2$ mA	$-V_{CEO}$	max.	32 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	100 mA
Collector current (peak value)	$-I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25$ °C**	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-65 to + 175 °C
Junction temperature	$T_j$	max.	175 °C

**THERMAL CHARACTERISTICS \***

$$T_j = P \times (R_{thj-t} + R_{tht-s} + R_{th s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{thj-t}$	=	50 K/W
From tab to soldering points	$R_{tht-s}$	=	280 K/W
From soldering points to ambient**	$R_{th s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 32 \text{ V} \quad -I_{CBO} < 100 \text{ nA}$$

$$I_E = 0; -V_{CB} = 32 \text{ V}; T_j = 100 \text{ °C} \quad -I_{CBO} < 10 \text{ } \mu\text{A}$$

Base-emitter voltage

$$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V} \quad -V_{BE} \quad 600 \text{ to } 750 \text{ mV}$$

Saturation voltages

$$-I_C = 10 \text{ mA}; -I_B = 0,5 \text{ mA} \quad -V_{CEsat} \text{ typ. } 80 \text{ mV}$$

$$-I_C = 10 \text{ mA}; -I_B = 0,5 \text{ mA} \quad -V_{CEsat} < 300 \text{ mV}$$

$$-I_C = 10 \text{ mA}; -I_B = 0,5 \text{ mA} \quad -V_{BEsat} \text{ typ. } 720 \text{ mV}$$

$$-I_C = 50 \text{ mV}; -I_B = 2,5 \text{ mA} \quad -V_{CEsat} \text{ typ. } 150 \text{ mV}$$

$$-I_C = 50 \text{ mV}; -I_B = 2,5 \text{ mA} \quad -V_{BEsat} \text{ typ. } 810 \text{ mV}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

D.C. current gain

$-I_C = 10 \mu\text{A}; -V_{CE} = 5 \text{ V}$

$h_{FE}$

typ.

90

150

$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V}$

$h_{FE}$

>

120

215

<

260

500

Collector capacitance at  $f = 1 \text{ MHz}$

$I_E = I_e = 0; -V_{CB} = 10 \text{ V}$

$C_c$

<

7,0

pF

Transition frequency at  $f = 35 \text{ MHz}$

$-I_C = 10 \text{ mA}; -V_{CE} = 5 \text{ V}$

$f_T$

typ.

150

MHz

Noise figure at  $R_S = 2 \text{ k}\Omega$

$-I_C = 200 \mu\text{A}; -V_{CE} = 5 \text{ V}$

F

<

4

dB

$f = 1 \text{ kHz}; B = 200 \text{ Hz}$

typ.

1

dB

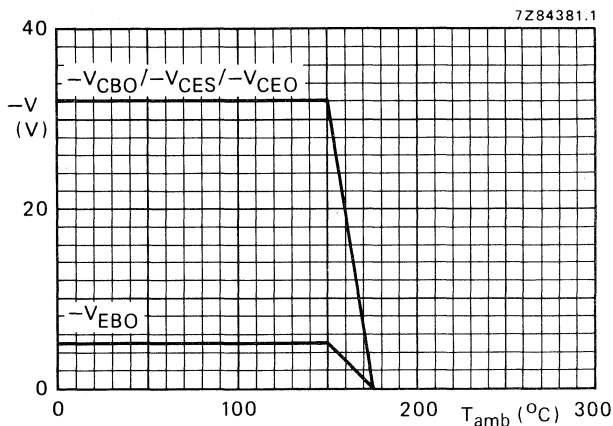


Fig. 2 Voltage derating curves.

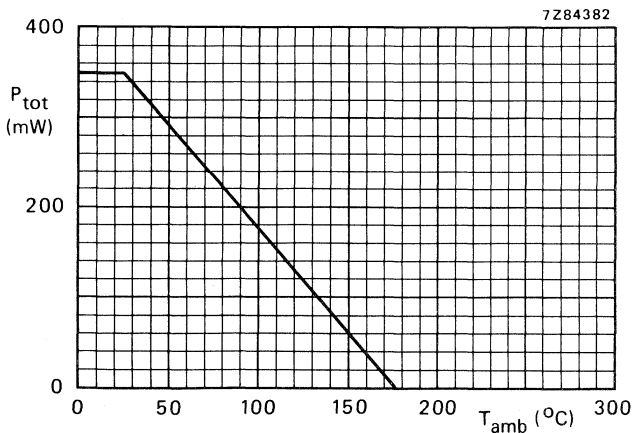


Fig. 3 Power derating curve.

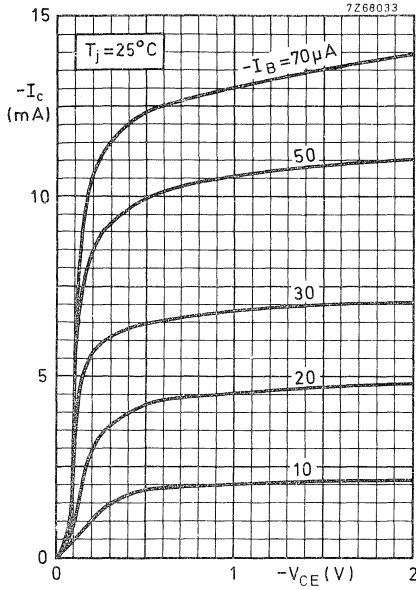


Fig. 4.

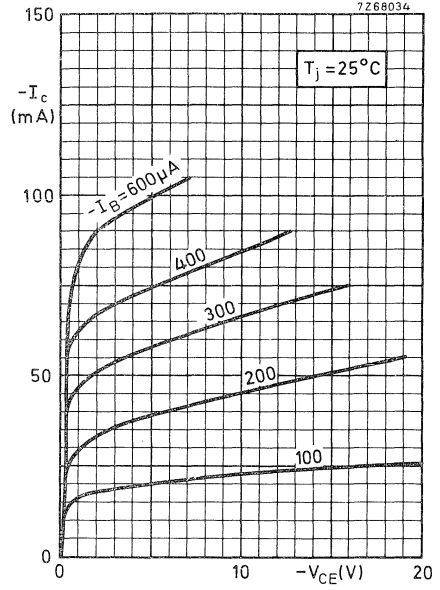


Fig. 5.

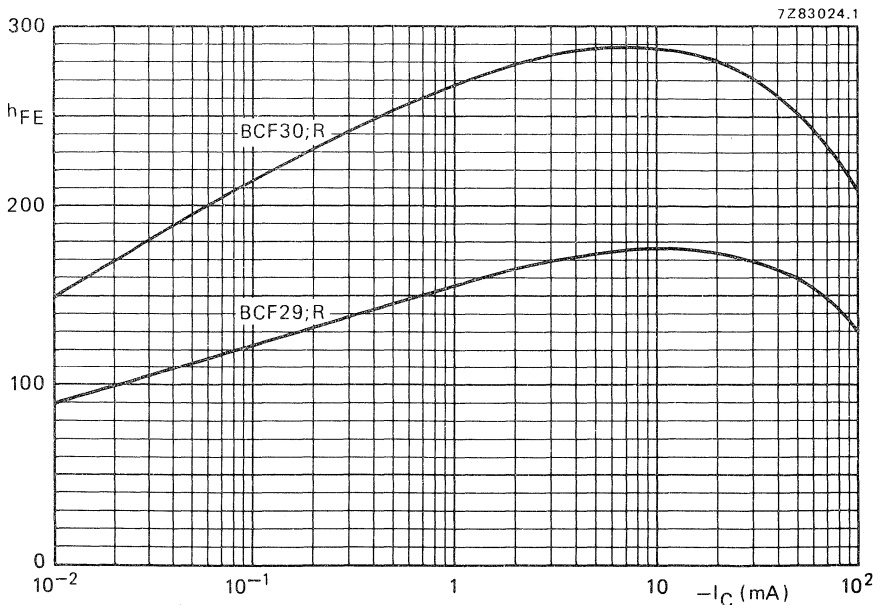


Fig. 6 Typical values of d.c. current gain.  $-V_{CE} = 5\ \text{V}$ ;  $T_j = 25^\circ\text{C}$ .

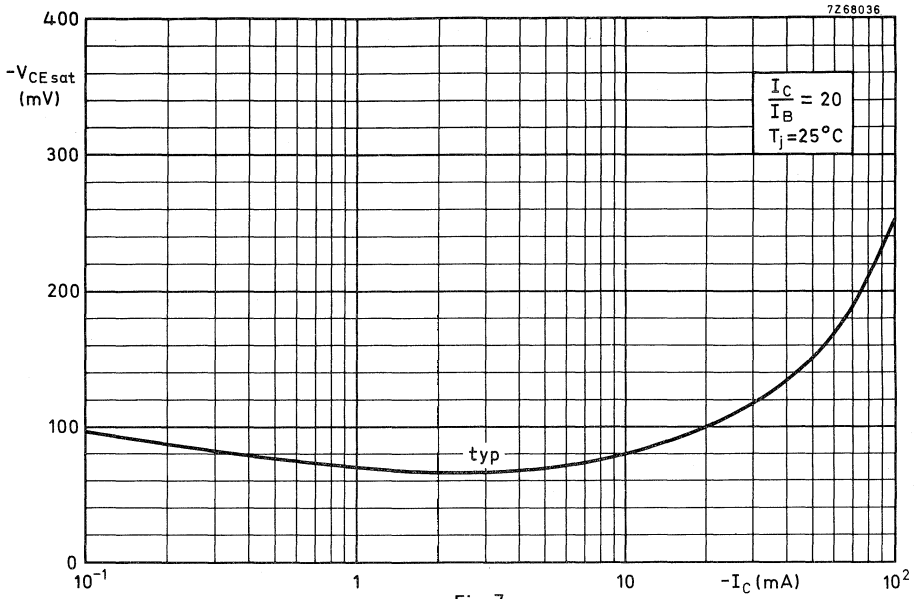


Fig. 7.

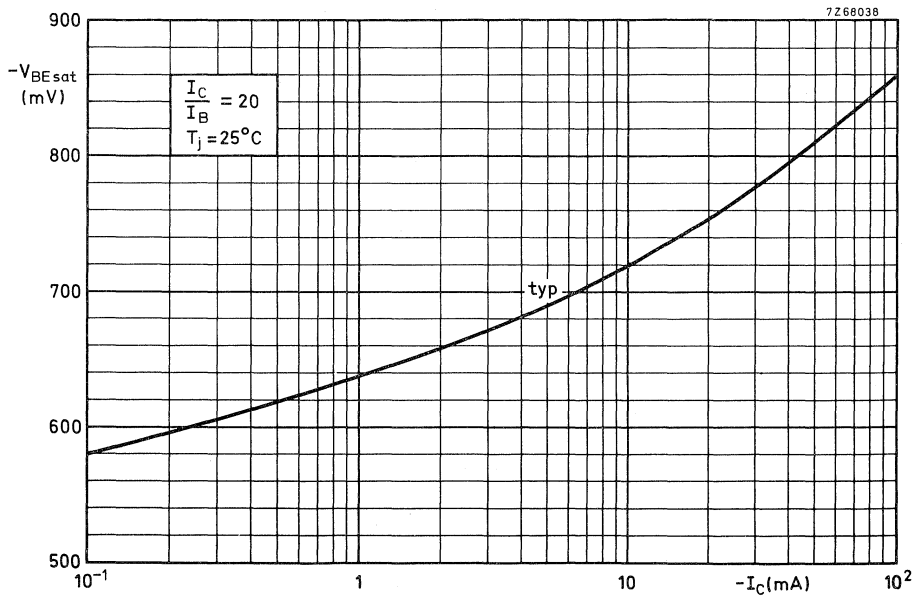


Fig. 8.

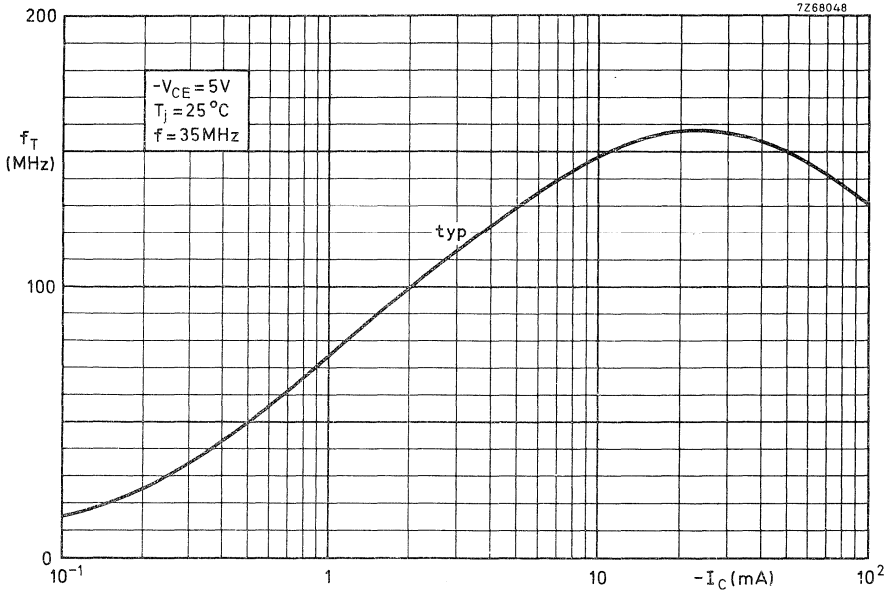


Fig. 9.

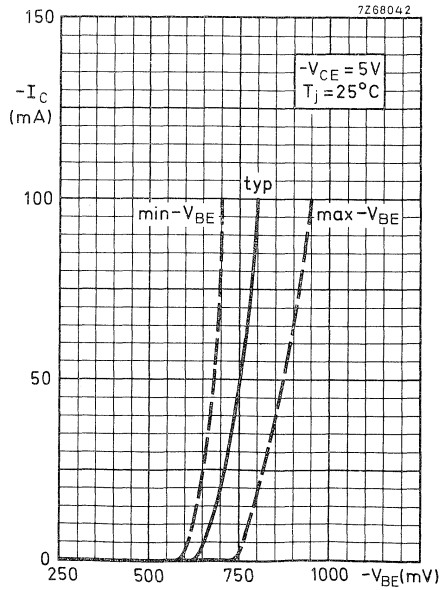


Fig. 10.



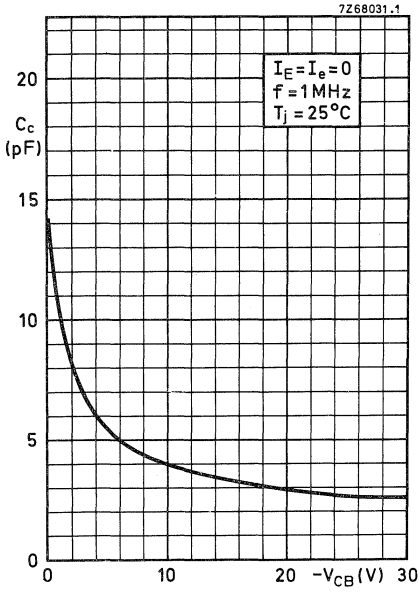


Fig. 11.

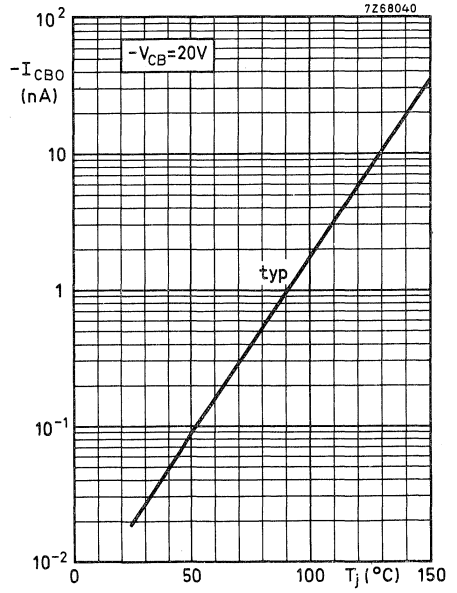


Fig. 12.



## SILICON PLANAR EPITAXIAL TRANSISTORS

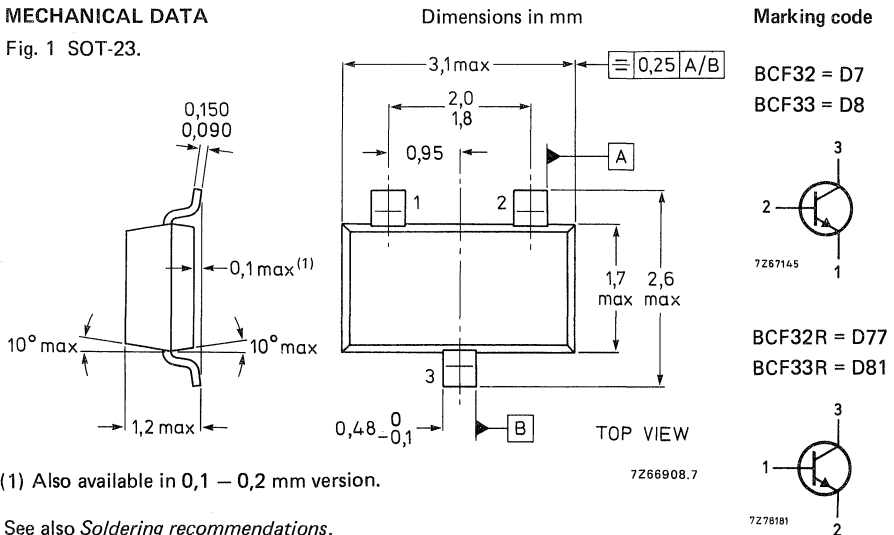
N-P-N transistors in a microminiature plastic envelope. They are intended for low level, low noise general purpose applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

		BCF32		BCF33	
		BCF32R		BCF33R	
D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE}$	> <	200 450	420 800	
Collector-base voltage (open emitter)	$V_{CBO}$	max.	32		V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	32		V
Collector current (peak value)	$I_{CM}$	max.	200		mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	350		mW
Junction temperature	$T_j$	max.	175		$^\circ\text{C}$
Transition frequency at $f = 35\text{ MHz}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$	$f_T$	typ.	300		MHz
Noise figure at $R_S = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$	F	<	4		dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	32 V
Collector-emitter voltage (open base) $I_C = 2 \text{ mA}$	$V_{CEO}$	max.	32 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	5 V
Collector current (d.c.)	$I_C$	max.	100 mA
Collector current (peak value)	$I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-65 to + 175 $^\circ\text{C}$
Junction temperature	$T_j$	max.	175 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{thj-t} + R_{tht-s} + R_{thsa}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{thj-t}$	=	50 K/W
From tab to soldering points	$R_{tht-s}$	=	280 K/W
From soldering points to ambient**	$R_{thsa}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25 \text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 32 \text{ V}$$

$$I_E = 0; V_{CB} = 32 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$$

$$I_{CBO} < 100 \text{ nA}$$

$$I_{CBO} < 10 \text{ } \mu\text{A}$$

Base-emitter voltage

$$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$$

$$V_{BE} \quad 550 \text{ to } 700 \text{ mV}$$

Saturation voltages

$$I_C = 10 \text{ mA}; I_B = 0,5 \text{ mA}$$

$$V_{CEsat} \quad \text{typ. } 120 \text{ mV}$$

$$V_{CEsat} < 250 \text{ mV}$$

$$I_C = 50 \text{ mA}; I_B = 2,5 \text{ mA}$$

$$V_{BEsat} \quad \text{typ. } 750 \text{ mV}$$

$$V_{CEsat} \quad \text{typ. } 210 \text{ mV}$$

$$V_{BEsat} \quad \text{typ. } 850 \text{ mV}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

D.C. current gain

$I_C = 10 \mu A; V_{CE} = 5 V$

$I_C = 2 mA; V_{CE} = 5 V$

Collector capacitance at  $f = 1 MHz$

$I_E = I_e = 0; V_{CB} = 10 V$

Transition frequency at  $f = 35 MHz$

$I_C = 10 mA; V_{CE} = 5 V$

Noise figure at  $R_S = 2 k\Omega$

$I_C = 200 \mu A; V_{CE} = 5 V$

$f = 1 kHz; B = 200 Hz$

		BCF32 BCF32R	BCF33 BCF33R
$h_{FE}$	typ.	150	270
	>	200	420
	<	450	800
$C_c$	<	4,0 pF	
$f_T$	typ.	300 MHz	
F	<	4 dB	
	typ.	1,2 dB	

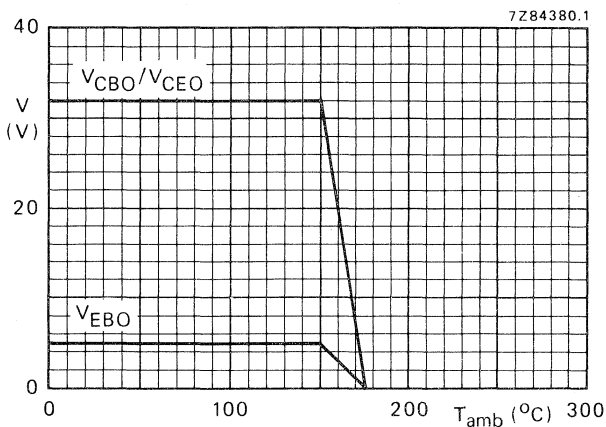


Fig. 2 Voltage derating curves.

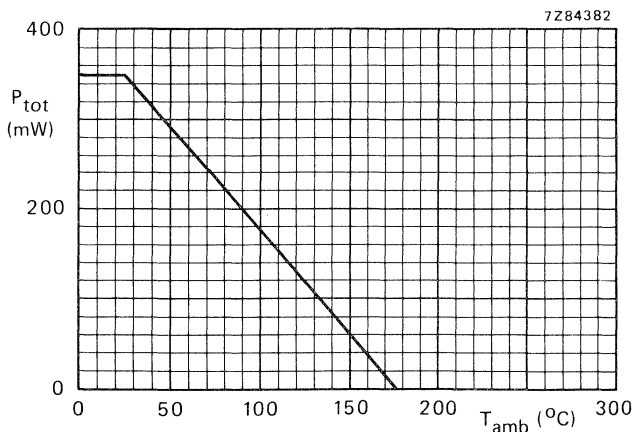


Fig. 3 Power derating curve.

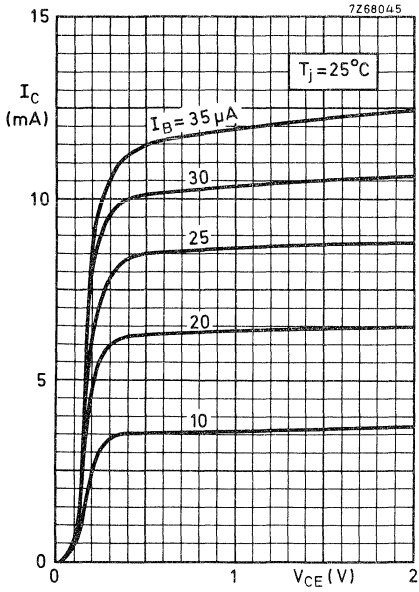


Fig. 4.

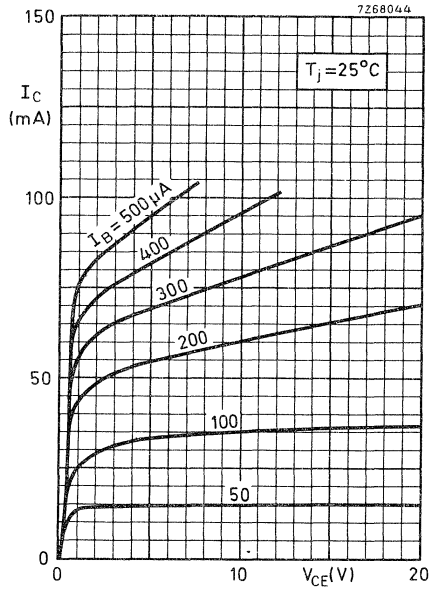


Fig. 5.

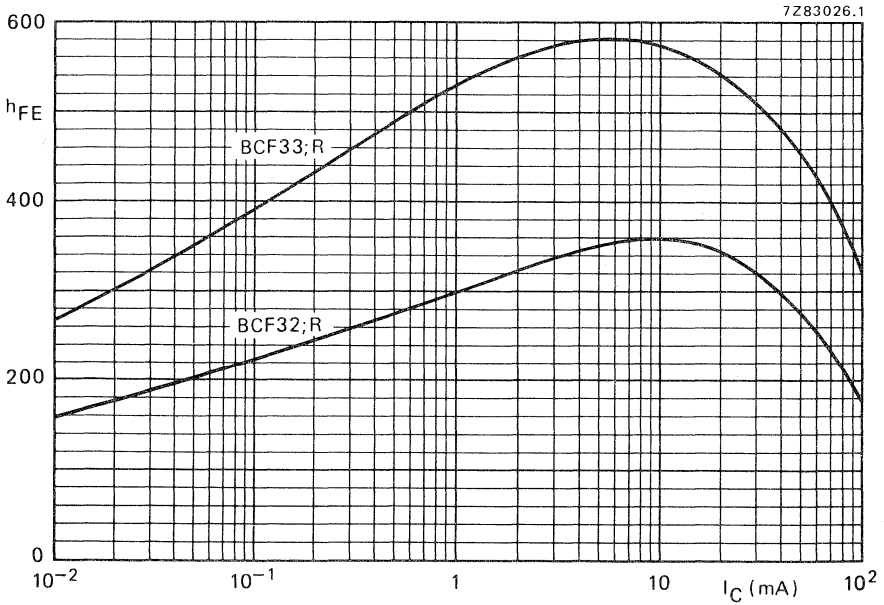


Fig. 6 Typical values d.c. current gain.  $V_{CE} = 5 \text{ V}$ ;  $T_j = 25^\circ\text{C}$ .

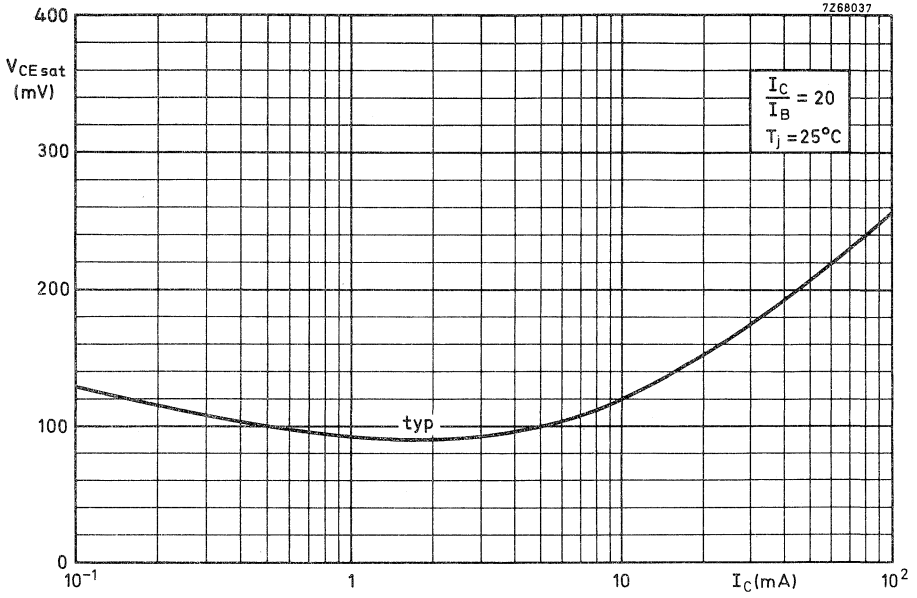


Fig. 7.

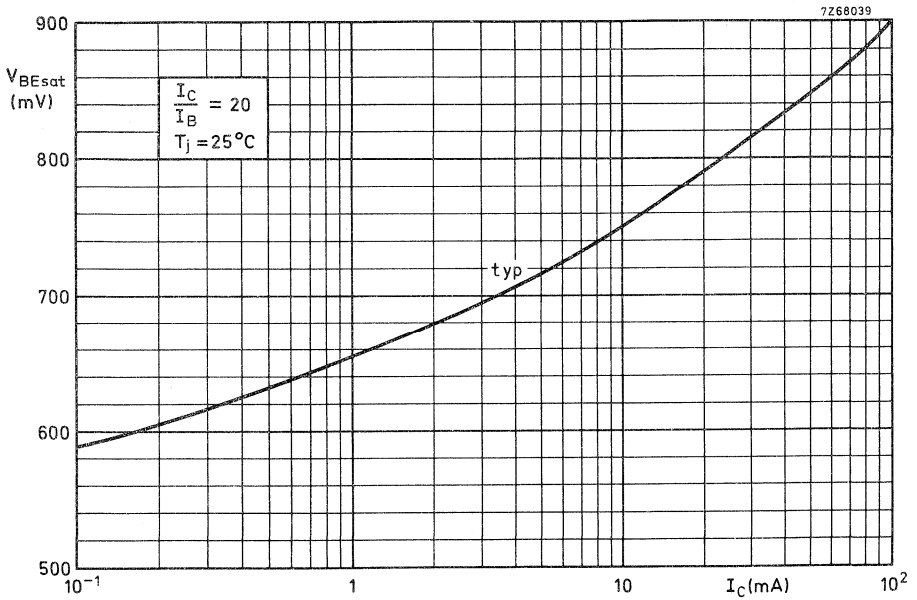


Fig. 8.

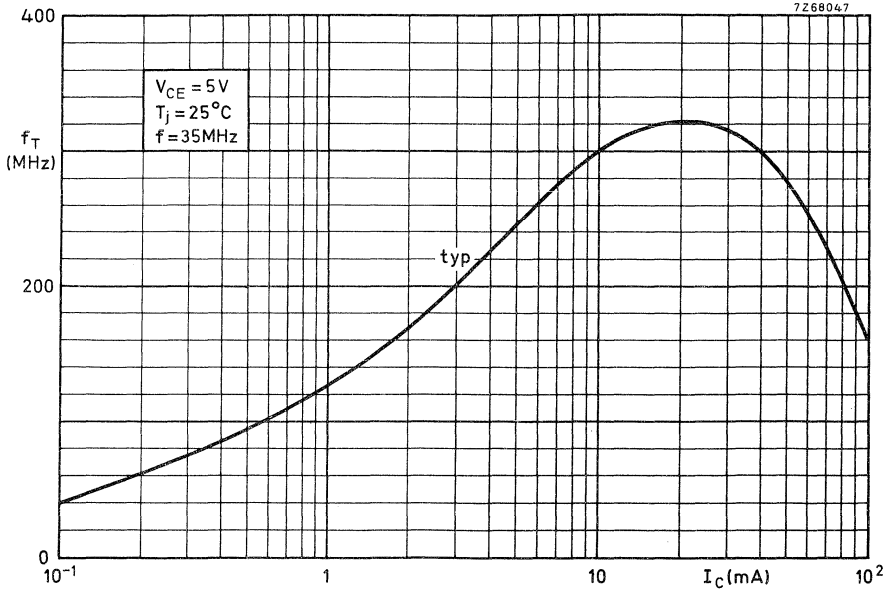


Fig. 9.

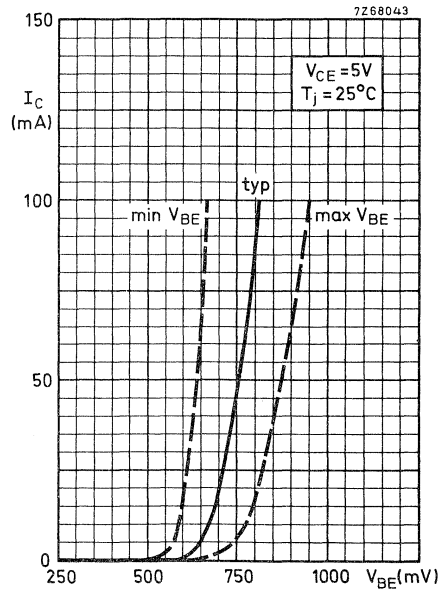


Fig. 10.



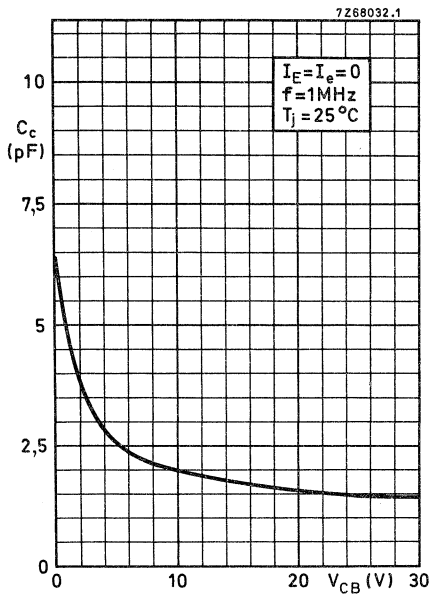


Fig. 11.

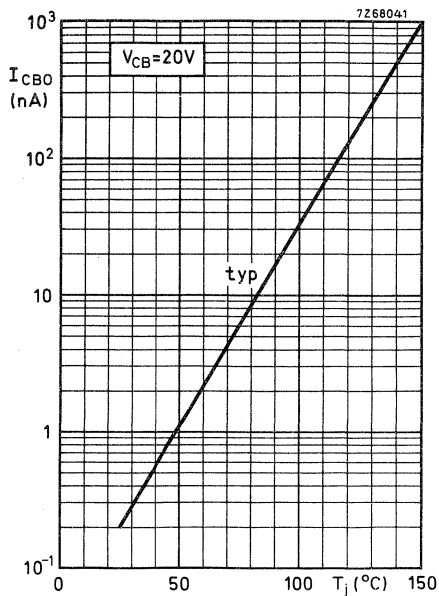


Fig. 12.



## SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors, in a microminiature plastic envelope, intended for low level, low noise applications in thick and thin-film circuits.

## QUICK REFERENCE DATA

D.C. current gain at  $T_j = 25\text{ }^\circ\text{C}$   
 $-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$

$h_{FE}$	$>$	215
	$<$	500

Collector-base voltage (open emitter)

$-V_{CBO}$	max.	50 V
------------	------	------

Collector-emitter voltage (open base)

$-V_{CEO}$	max.	45 V
------------	------	------

Collector current (peak value)

$-I_{CM}$	max.	200 mA
-----------	------	--------

Total power dissipation up to  $T_{amb} = 25\text{ }^\circ\text{C}$

$P_{tot}$	max.	350 mW
-----------	------	--------

Junction temperature

$T_j$	max.	175 $^\circ\text{C}$
-------	------	----------------------

Transition frequency at  $f = 35\text{ MHz}$

$-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$

$f_T$	typ.	150 MHz
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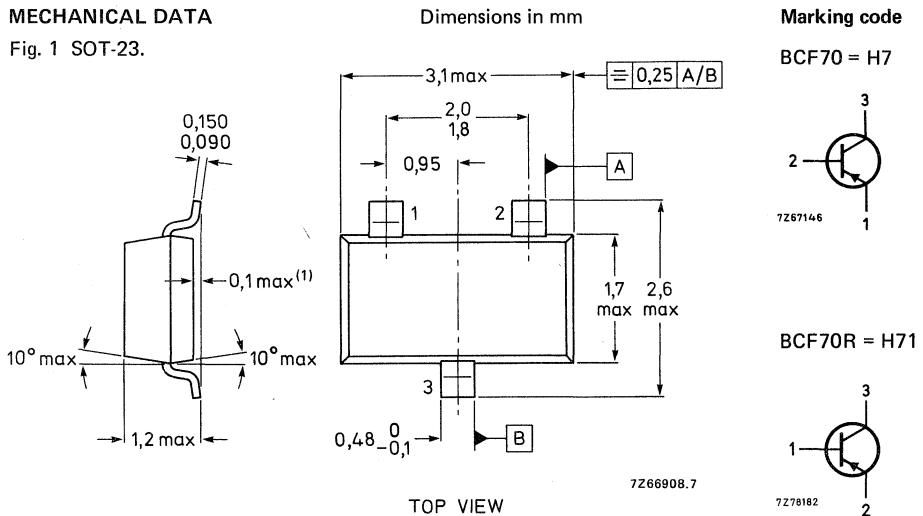
Noise figure at  $R_S = 2\text{ k}\Omega$

$-I_C = 200\text{ }\mu\text{A}; -V_{CE} = 5\text{ V};$   
 $f = 1\text{ kHz}; B = 200\text{ Hz}$

F	$<$	4 dB
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## MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 2	$-V_{CBO}$	max.	50 V
Collector-emitter voltage ( $V_{BE} = 0$ ) see Fig. 2	$-V_{CES}$	max.	50 V
Collector-emitter voltage (open base) see Fig. 2 $-I_C = 2$ mA	$-V_{CEO}$	max.	45 V
Emitter-base voltage (open collector) see Fig. 2	$-V_{EBO}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	100 mA
Collector current (peak value)	$-I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25$ °C**	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-65 to + 175 °C
Junction temperature	$T_j$	max.	175 °C

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	≐	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS** $T_j = 25$  °C unless otherwise specified

$$I_E = 0; -V_{CB} = 20$$
 V;  $T_j = 25$  °C  
 $T_j = 100$  °C

$-I_{CBO}$	<	100 nA
$-I_{CBO}$	<	10 $\mu$ A

Base-emitter voltage

$$-I_C = 2$$
 mA;  $-V_{CE} = 5$  V;  $T_j = 25$  °C

$-V_{BE}$		600 to 750 mV
-----------	--	---------------

Saturation voltages

$$-I_C = 10$$
 mA;  $-I_B = 0,5$  mA

$-V_{CEsat}$	typ.	80 mV
	<	300 mV

$$-I_C = 50$$
 mA;  $-I_B = 2,5$  mA

$-V_{BEsat}$	typ.	720 mV
$-V_{CEsat}$	typ.	150 mV
$-V_{BEsat}$	typ.	810 mV

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

D.C. current gain

$-I_C = 10 \mu A; -V_{CE} = 5 V$

$h_{FE}$  typ. 150

$-I_C = 2 mA; -V_{CE} = 5 V$

$h_{FE} > 215$   
 $h_{FE} < 500$

Collector capacitance at  $f = 1 MHz$

$I_E = I_e = 0; -V_{CB} = 10 V$

$C_c < 7,0 pF$

Transition frequency at  $f = 35 MHz$

$-I_C = 10 mA; -V_{CE} = 5 V$

$f_T$  typ. 150 MHz

Noise figure at  $R_S = 2 k\Omega$

$-I_C = 200 \mu A; -V_{CE} = 5 V$

$F < 4 dB$

$f = 1 kHz; B = 200 Hz$

$F$  typ. 1 dB

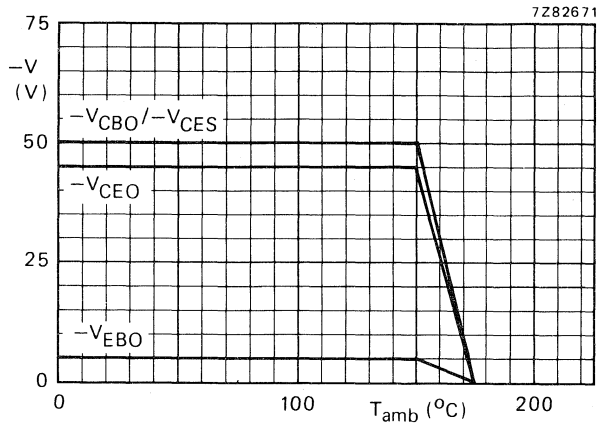


Fig. 2 Voltage derating curves.

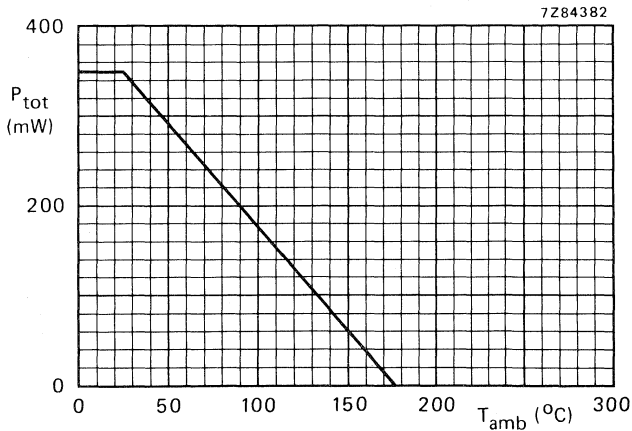


Fig. 3 Power derating curve.

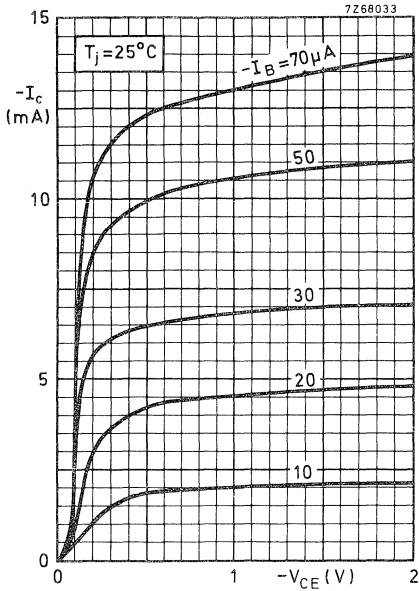


Fig. 4.

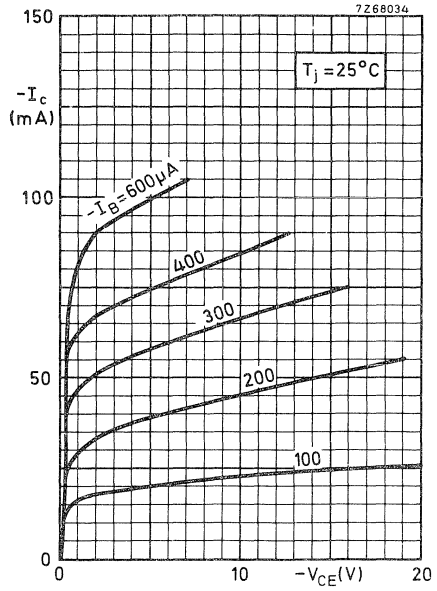


Fig. 5.

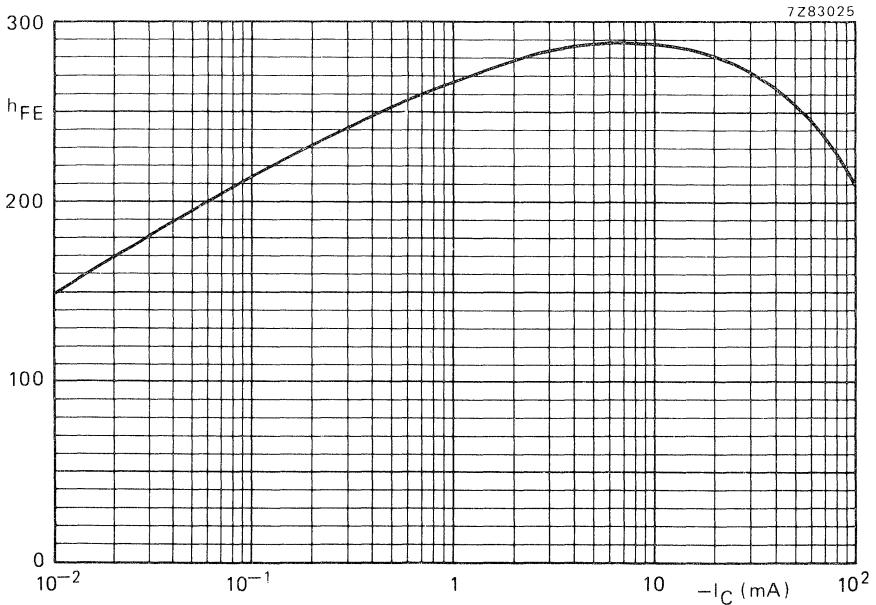


Fig. 6 Typical values of d.c. current gain.  $-V_{CE} = 5\text{ V}$ ;  $T_j = 25^\circ\text{C}$ .

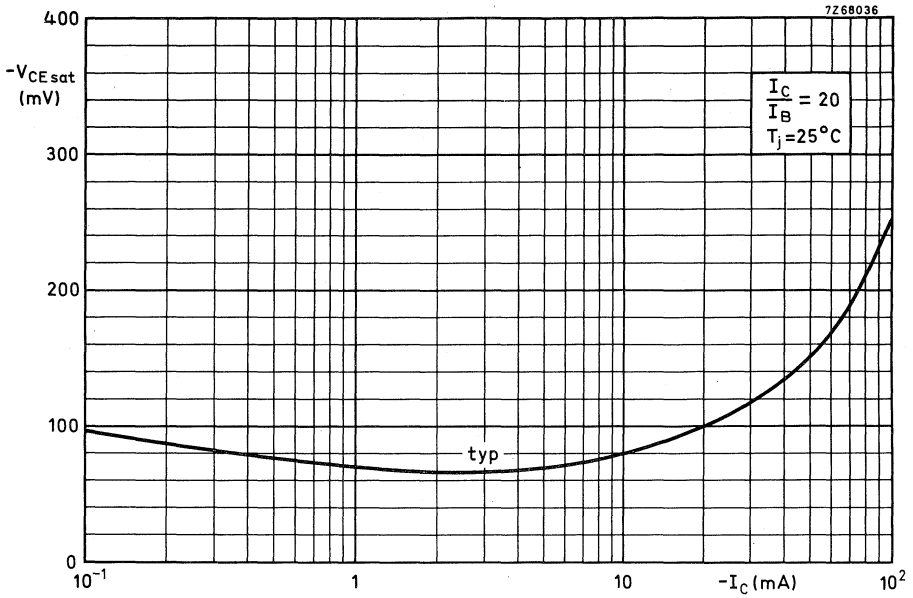


Fig. 7.

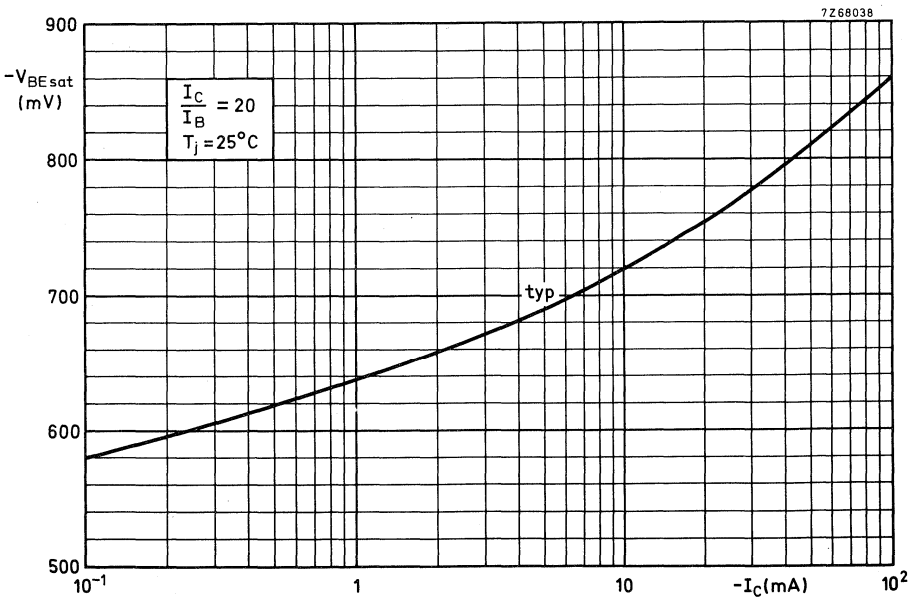


Fig. 8.

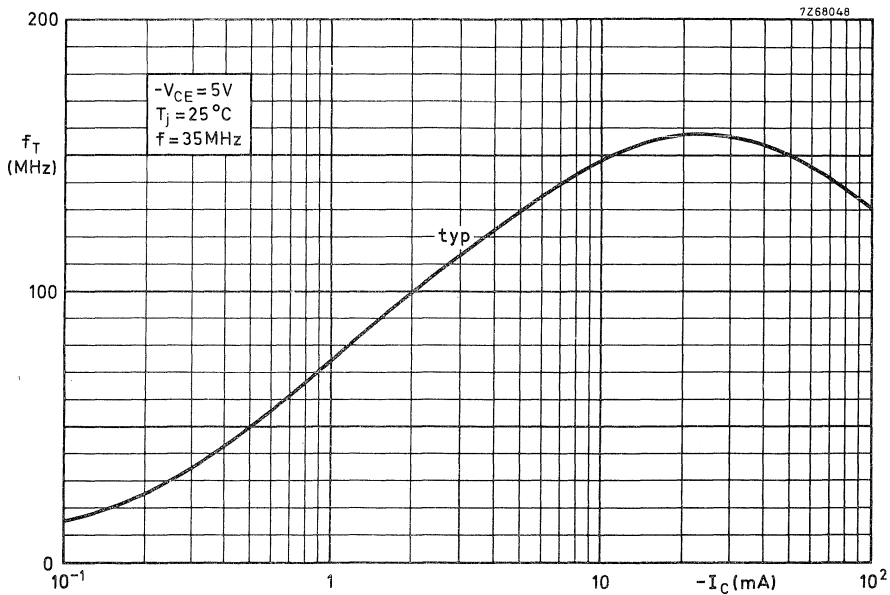


Fig. 9.

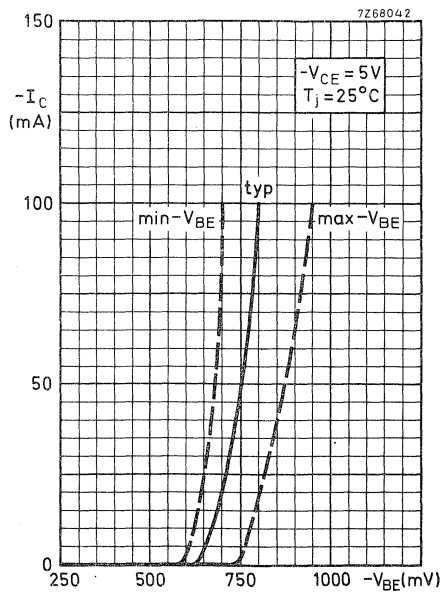


Fig. 10.



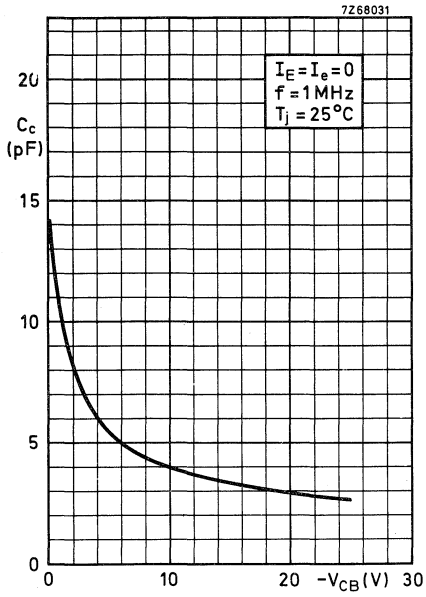


Fig. 11.

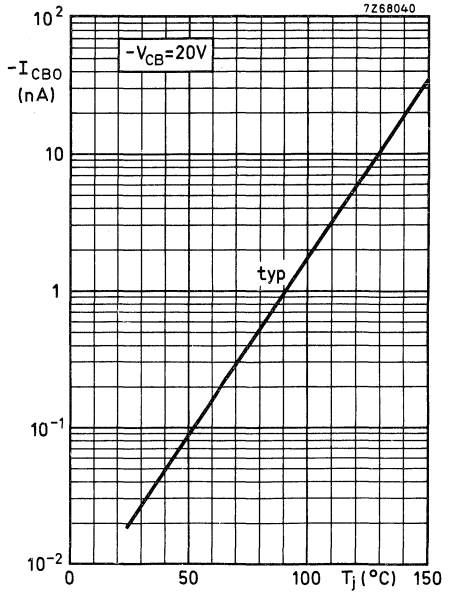


Fig. 12.



## SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors, in a microminiature plastic envelope, intended for low level, low noise general purpose applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CBO}$	max.	50 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	45 V
Collector current (peak value)	$I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	350 mW
Junction temperature	$T_j$	max.	175 $^{\circ}\text{C}$
D.C. current gain at $T_j = 25\text{ }^{\circ}\text{C}$ $I_C = 2\text{ mA}$ ; $V_{CE} = 5\text{ V}$	$h_{FE}$	> <	420 800
Transition frequency at $f = 35\text{ MHz}$ $I_C = 10\text{ mA}$ ; $V_{CE} = 5\text{ V}$	$f_T$	typ.	300 MHz
Noise figure at $R_S = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}$ ; $V_{CE} = 5\text{ V}$ ; $f = 1\text{ kHz}$ ; $B = 200\text{ Hz}$	F	<	4 dB

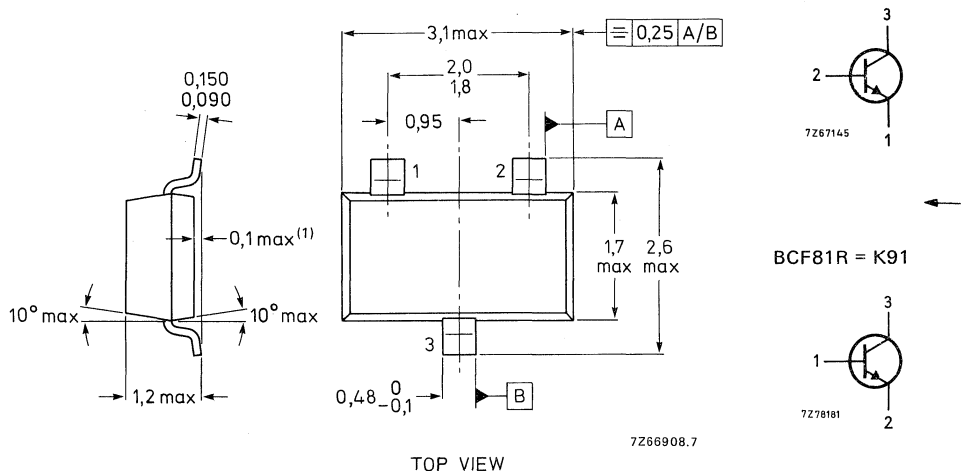
### MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BCF81 = K9



TOP VIEW

(1) Also available in 0,1 — 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 2	$V_{CBO}$	max.	50 V
Collector-emitter voltage (open base) see Fig. 2	$V_{CEO}$	max.	45 V
$I_C = 2$ mA	$V_{EBO}$	max.	5 V
Emitter-base voltage (open collector) see Fig. 2	$I_C$	max.	100 mA
Collector current (d.c.)	$I_{CM}$	max.	200 mA
Collector current (peak value)	$P_{tot}$	max.	350 mW
Total power dissipation up to $T_{amb} = 25$ °C**	$T_{stg}$		-65 to +175 °C
Storage temperature	$T_j$	max.	175 °C
Junction temperature			

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS** $T_j = 25$  °C unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 20$  V

$I_{CBO} < 100$  nA

$I_E = 0; V_{CB} = 20$  V;  $T_j = 100$  °C

$I_{CBO} < 10$   $\mu$ A

Base emitter voltage

$I_C = 2$  mA;  $V_{CE} = 5$  V

$V_{BE}$  550 to 700 mV

Saturation voltages

$I_C = 10$  mA;  $I_B = 0,5$  mA

$V_{CEsat}$  typ. 120 mV  
 $V_{CEsat} < 250$  mV

$I_C = 50$  mA;  $I_B = 2,5$  mA

$V_{BEsat}$  typ. 750 mV  
 $V_{CEsat}$  typ. 210 mV  
 $V_{BEsat}$  typ. 850 mV

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

D.C. current gain

$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$

$h_{FE}$	>	420
	<	800

Collector capacitance at  $f = 1 \text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10 \text{ V}$

$C_c$	<	4,0 pF
-------	---	--------

Transition frequency at  $f = 35 \text{ MHz}$

$I_C = 10 \text{ mA}; V_{CE} = 5 \text{ V}$

$f_T$	typ.	300 MHz
-------	------	---------

Noise figure at  $R_S = 2 \text{ k}\Omega$

$I_C = 200 \mu\text{A}; V_{CE} = 5 \text{ V}$

$f = 1 \text{ kHz}; B = 200 \text{ Hz}$

$F$	<	4 dB
	typ.	1,2 dB

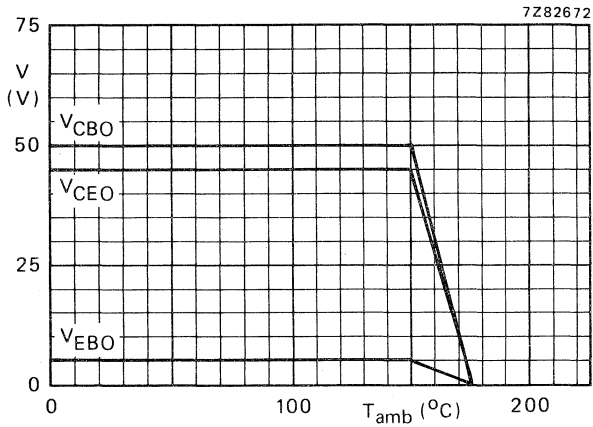


Fig. 2 Voltage derating curves.

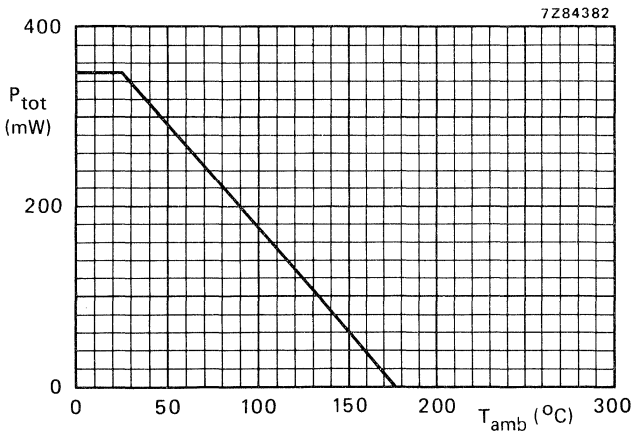


Fig. 3 Power derating curve.



## SILICON PLANAR EPITAXIAL TRANSISTOR

Double n-p-n transistor, in SOT-143 plastic envelope, designed for use in applications where the working point must be independent of temperature.

Owing to application of two similar crystals of one slice this device has a good thermal coupling and  $V_{BE}$  matching. Special interconnection of the two transistor crystals allows the device to be used as a current mirror and the separated emitter leads allow connection to different sources.

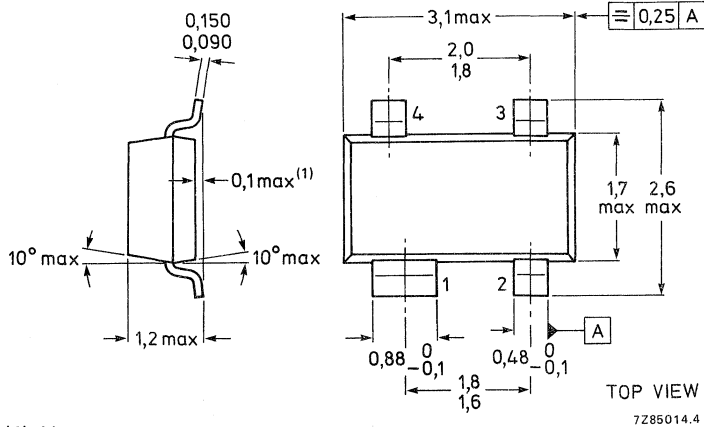
A similar device in p-n-p configuration is the BCV62.

### QUICK REFERENCE DATA

Collector-emitter voltage (open base) regarding transistor T1	$V_{CEO}$	max.	30 V
Collector-base voltage (open emitter) regarding transistor T1	$V_{CBO}$	max.	30 V
Collector current d.c.	$I_C$	max.	100 mA
peak	$I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

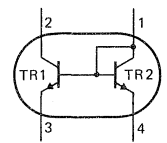
### MECHANICAL DATA

Fig. 1 SOT-143.



Dimensions in mm

Marking code: D91



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage (open base) regarding transistor T1	$V_{CEO}$	max.	30 V
Collector-base voltage (open emitter) regarding transistor T1	$V_{CBO}$	max.	30 V
Base current (transistor T1) peak value	$I_{BM1}$	max.	200 mA
Emitter-base voltage	$V_{EBS}$	max.	6 V
Collector current d.c.	$I_C$	max.	100 mA
peak	$I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$ when mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Storage temperature	$T_{stg}$		-65 to +150 $^\circ\text{C}$

## THERMAL RESISTANCE

Device mounted on a ceramic substrate of  
8 mm x 10 mm x 0,7 mm

from junction to tab	$R_{th\ j-t}$	=	60 K/W
from tab to soldering points	$R_{th\ t-s}$	=	280 K/W
from soldering points to ambient	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

## Transistor T1

Collector cut-off current

$I_E = 0; V_{CB} = 30\text{ V}$

$I_E = 0; V_{CB} = 30\text{ V}; T_j = 150\text{ }^\circ\text{C}$

$I_{CBO}$	<	15 nA
	<	5 $\mu\text{A}$

Base-emitter voltage

$I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$

$V_{BE}$	typ.	660 mV*
		580 to 700 mV**

$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$

$V_{BE}$	<	770 mV*
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Saturation voltages

$I_C = 10\text{ mA}; I_B = 0,5\text{ mA}$

$V_{CEsat}$	typ.	90 mV
	<	250 mV

$V_{BEsat}$	typ.	700 mV**
-------------	------	----------

$I_C = 100\text{ mA}; I_B = 5\text{ mA}$

$V_{CEsat}$	typ.	200 mV
	<	600 mV

$V_{BEsat}$	typ.	900 mV**
-------------	------	----------

\* Decreasing 2 mV/ $^\circ\text{C}$  with increasing temperature.\*\* Decreasing 1,7 mV/ $^\circ\text{C}$  with increasing temperature.



Transition frequency at $f = 35$ MHz $I_C = 10$ mA; $V_{CE} = 5$ V	$f_T$	typ.	300 MHz	
Collector capacitance at $f = 1$ MHz $I_E = i_e = 0$ ; $V_{CB} = 10$ V	$C_C$	typ.	2,5 pF	
Emitter capacitance at $f = 1$ MHz $I_C = i_c = 0$ ; $V_{EB} = 0,5$ V	$C_e$	typ.	9 pF	
Noise figure at $R_S = 2$ k $\Omega$ $I_C = 200$ $\mu$ A; $V_{CE} = 5$ V $f = 1$ kHz; $B = 200$ Hz	$F$	typ.	2 dB	
		<	10 dB	
D.C. current gain $I_C = 100$ $\mu$ A; $V_{CE} = 5$ V	$h_{FE}$	>	100	
$I_C = 2$ mA; $V_{CE} = 5$ V	$h_{FE}$		100 to 800	
Input impedance $I_C = 2$ mA; $V_{CE} = 5$ V; $f = 1$ kHz	$h_{ie}$	typ.	5 k $\Omega$	
Reverse voltage transfer ratio $I_C = 2$ mA; $V_{CE} = 5$ V; $f = 1$ kHz	$h_{re}$	typ.	$2 \cdot 10^{-4}$	
Small signal current gain $I_C = 2$ mA; $V_{CE} = 5$ V; $f = 1$ kHz	$h_{fe}$		100 to 900	
Output admittance $I_C = 2$ mA; $V_{CE} = 5$ V; $f = 1$ kHz	$h_{oe}$	typ.	30 $\mu$ S	
<b>Transistor T2</b>				
Base-emitter forward voltage $I_E = 250$ mA	$V_{BES}$	<	1,8 V	
$I_E = 10$ $\mu$ A		>	400 mV	
Matching of transistor T1 and transistor T2 at $I_{E2} = 0,5$ mA and $V_{CE1} = 5$ V				
$T_{amb} = 25$ $^{\circ}$ C	$I_{C1}/I_{C2}$		0,7 to 1,3	←
$T_{amb} = 150$ $^{\circ}$ C	$I_{C1}/I_{C2}$		0,7 to 1,3	←
Thermal coupling of transistor T1 and transistor T2* T2 : $I_{E2} = I_{Ex2} < 50$ mA				
T1 : $V_{CE} = 5$ V; $I_{C1} < 50$ mA				←
Maximum current for thermal stability of $I_{C1}$	$I_{Ex2}$	typ.	5 mA	

\* Without emitter resistor and device mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.



## SILICON PLANAR EPITAXIAL TRANSISTOR

Double p-n-p transistor, in SOT-143 plastic envelope, designed for use in applications where the working point must be independent of temperature.

Owing to application of two similar crystals of one slice this device has a good thermal coupling and  $V_{BE}$  matching. Special interconnection of the two transistor crystals allows the device to be used as a current mirror and the separated emitter leads allow connection to different sources.

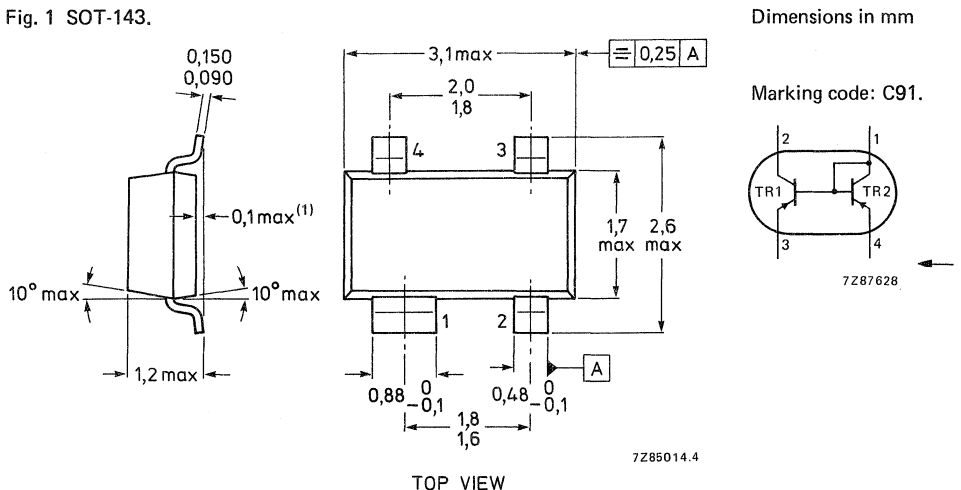
A similar device in n-p-n configuration is the BCV61.

## QUICK REFERENCE DATA

Collector-emitter voltage (open base) regarding transistor T1	$-V_{CEO}$	max	30 V
Collector-base voltage (open emitter) regarding transistor T1	$-V_{CBO}$	max.	30 V
Collector current d.c.	$-I_C$	max.	100 mA
peak	$-I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^{\circ}\text{C}$

## MECHANICAL DATA

Fig. 1 SOT-143.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage (open base) regarding transistor T1	$-V_{CEO}$	max.	30 V
Collector-base voltage (open emitter) regarding transistor T1	$-V_{CBO}$	max.	30 V
Base current (transistor T1) peak value	$-I_{BM1}$	max.	200 mA
Emitter-base voltage	$-V_{EBS}$	max.	6 V
Collector current d.c.	$-I_C$	max.	100 mA
peak	$-I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$ when mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$

## THERMAL RESISTANCE

Device mounted on a ceramic substrate of  
8 mm x 10 mm x 0,7 mm

from junction to tab	$R_{th\ j-t}$	=	60 K/W
from tab to soldering points	$R_{th\ t-s}$	=	280 K/W
from soldering points to ambient	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

## Transistor T1

Collector cut-off current

$-I_E = 0; -V_{CB} = 30\text{ V}$

$-I_E = 0; -V_{CB} = 30\text{ V}; T_j = 150\text{ }^\circ\text{C}$

$-I_{CBO}$	<	15 nA
	<	5 $\mu\text{A}$

Base-emitter voltage

$-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$

$-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$

$-V_{BE}$	typ.	650 mV*
		600 to 750 mV*
$-V_{BE}$	<	820 mV*

Saturation voltages

$-I_C = 10\text{ mA}; -I_B = 0,5\text{ mA}$

$-I_C = 100\text{ mA}; -I_B = 5\text{ mA}$

$-V_{CEsat}$	typ.	75 mV
	<	300 mV
$-V_{BEsat}$	typ.	700 mV**
$-V_{CEsat}$	typ.	250 mV
	<	650 mV
$-V_{BEsat}$	typ.	850 mV**

\* Decreasing 2 mV/ $^\circ\text{C}$  with increasing temperature.\*\*Decreasing 1,7 mV/ $^\circ\text{C}$  with increasing temperature.

Transition frequency at $f = 35$ MHz $-I_C = 10$ mA; $-V_{CE} = 5$ V	$f_T$	typ.	150 MHz	
Collector capacitance at $f = 1$ MHz $I_E = i_e = 0$ ; $-V_{CB} = 10$ V	$C_c$	typ.	4,5 pF	
Emitter capacitance at $f = 1$ MHz $-I_C = i_c = 0$ ; $-V_{EB} = 0,5$ V	$C_e$		t.b.f. pF	
Noise figure at $R_S = 2$ k $\Omega$ $-I_C = 200$ $\mu$ A; $-V_{CE} = 5$ V $f = 1$ kHz; $B = 200$ Hz	$F$	typ. <	2 dB 10 dB	
D.C. current gain $-I_C = 100$ $\mu$ A; $-V_{CE} = 5$ V	$h_{FE}$	>	100	
$-I_C = 2$ mA; $-V_{CE} = 5$ V	$h_{FE}$		100 to 800	
Input impedance $-I_C = 2$ mA; $-V_{CE} = 5$ V; $f = 1$ kHz	$h_{ie}$	typ.	3 k $\Omega$	
Reverse voltage transfer ratio $-I_C = 2$ mA; $-V_{CE} = 5$ V; $f = 1$ kHz	$h_{re}$	typ.	$3 \times 10^{-4}$	
Small signal current gain $-I_C = 2$ mA; $-V_{CE} = 5$ V; $f = 1$ kHz	$h_{fe}$		100 to 900	
Output admittance $-I_C = 2$ mA; $-V_{CE} = 5$ V; $f = 1$ kHz	$h_{oe}$	typ.	50 $\mu$ S	
<b>Transistor T2</b>				
Base-emitter forward voltage $-I_E = 250$ mA $-I_E = 10$ $\mu$ A	$-V_{BES}$	< >	1,5 V 400 mV	
Matching of transistor T1 and transistor T2 at $I_{E2} = 0,5$ mA and $V_{CE1} = 5$ V				
$T_{amb} = 25$ $^{\circ}$ C	$I_{C1}/I_{C2}$		0,7 to 1,3	←
$T_{amb} = 150$ $^{\circ}$ C	$I_{C1}/I_{C2}$		0,7 to 1,3	←
Thermal coupling of transistor T1 and transistor T2*				
T2 : $I_{E2} = I_{Ex2} < 50$ mA				←
T1 : $-V_{CE} = 5$ V; $-I_{C1} < 50$ mA				
Maximum current for thermal stability of $-I_{C1}$	$I_{Ex2}$	typ.	5 mA	

\* Without emitter resistor and device mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.



## SILICON PLANAR EPITAXIAL TRANSISTORS

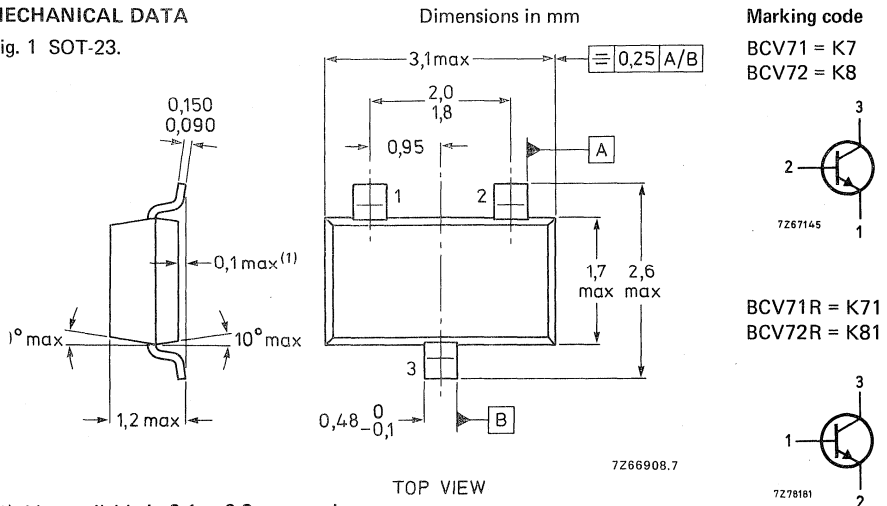
N-P-N transistors, in a microminiature plastic envelope, intended for low level general purpose applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

		BCV71 BCV71R	BCV72 BCV72R
D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE}$	> 110 < 220	200 450
Collector-base voltage (open emitter)	$V_{CBO}$	max. 80	V
Collector-emitter voltage (open base)	$V_{CEO}$	max. 60	V
Collector current (peak value)	$I_{CM}$	max. 200	mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max. 350	mW
Junction temperature	$T_j$	max. 175	$^\circ\text{C}$
Transition frequency at $f = 35\text{ MHz}$ $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$	$f_T$	typ. 300	MHz
Noise figure at $R_G = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$	F	< 10	dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 2	$V_{CBO}$	max.	80 V
Collector-emitter voltage (open base) see Fig. 2 $I_C = 2 \text{ mA}$	$V_{CEO}$	max.	60 V
Emitter-base voltage (open collector) see Fig. 2	$V_{EBO}$	max.	5 V
Collector current (d.c.)	$I_C$	max.	100 mA
Collector current (peak value)	$I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-65 to + 175 $^\circ\text{C}$
Junction temperature	$T_j$	max.	175 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th j-t}$	=	50 K/W
From tab to soldering points	$R_{th t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25 \text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 20 \text{ V}$$

$$I_{CBO} < 100 \text{ nA}$$

$$I_E = 0; V_{CB} = 20 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$$

$$I_{CBO} < 10 \text{ } \mu\text{A}$$

Base emitter voltage

$$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$$

$$V_{BE} \quad 550 \text{ to } 700 \text{ mV}$$

Saturation voltages

$$I_C = 10 \text{ mA}; I_B = 0,5 \text{ mA}$$

$$V_{CEsat} \quad \text{typ. } 120 \text{ mV}$$

$$< 250 \text{ mV}$$

$$I_C = 50 \text{ mA}; I_B = 2,5 \text{ mA}$$

$$V_{BEsat} \quad \text{typ. } 750 \text{ mV}$$

$$V_{CEsat} \quad \text{typ. } 210 \text{ mV}$$

$$V_{BEsat} \quad \text{typ. } 850 \text{ mV}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.



D.C. current gain

$I_C = 10 \mu A; V_{CE} = 5 V$

$h_{FE}$  typ.

BCV71 BCV71R	BCV72 BCV72R
90	150
110	200
220	450

$I_C = 2 mA; V_{CE} = 5 V$

$h_{FE}$  <

110	200
220	450

Collector capacitance at  $f = 1 MHz$

$I_E = I_e = 0; V_{CB} = 10 V$

$C_c$  <

4,0 pF

Transition frequency at  $f = 35 MHz$

$I_C = 10 mA; V_{CE} = 5 V$

$f_T$  typ.

300 MHz

Noise figure at  $R_S = 2 k\Omega$

$I_C = 200 \mu A; V_{CE} = 5 V$

F <

10 dB

$f = 1 kHz; B = 200 Hz$

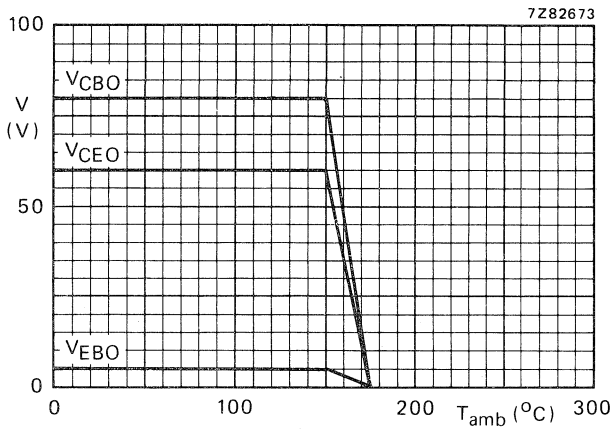


Fig. 2 Voltage derating curves.

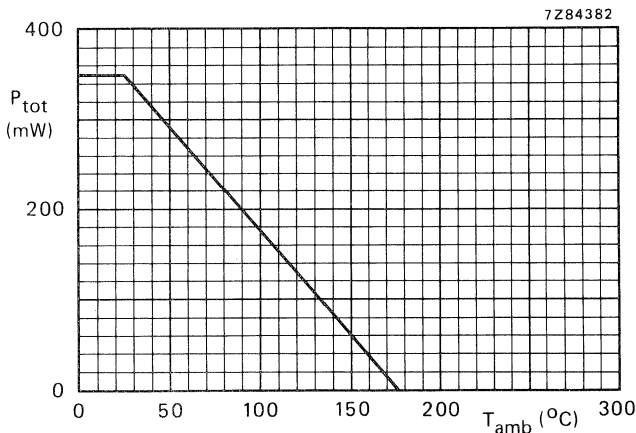


Fig. 3 Power derating curve.



## SILICON PLANAR EPITAXIAL TRANSISTORS

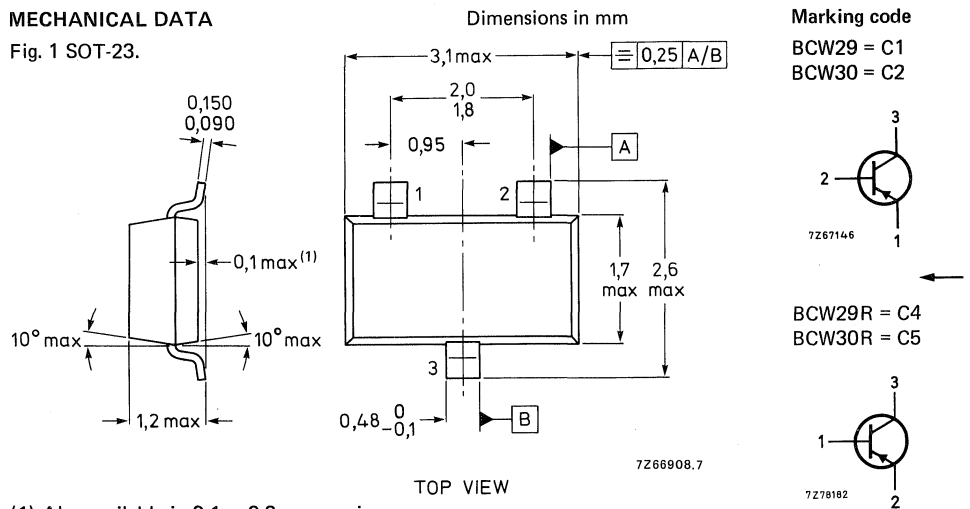
P-N-P transistors, in a microminiature plastic envelope, intended for low level general purpose applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

		BCW29 BCW29R	BCW30 BCW30R	
D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$	$h_{FE}$	120	215	
		260	500	
Collector-base voltage (open emitter)	$-V_{CB0}$ max.	32		V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	32		V
Collector current (peak value)	$-I_{CM}$ max.	200		mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$ max.	350		mW
Junction temperature	$T_j$ max.	175		$^\circ\text{C}$
Transition frequency at $f = 35\text{ MHz}$ $-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$	$f_T$	150		MHz
		typ.		
Noise figure at $R_S = 2\text{ k}\Omega$ $-I_C = 200\text{ }\mu\text{A}; -V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$	F	<	10	dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-base voltage (open emitter)	$-V_{CB0}$	max.	32 V
Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$	max.	32 V
Collector-emitter voltage (open base) $-I_C = 2$ mA	$-V_{CEO}$	max.	32 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	100 mA
Collector current (peak value)	$-I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25$ °C**	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-65 to +175 °C
Junction temperature	$T_j$	max.	175 °C

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 32\text{ V} \quad -I_{CBO} < 100\text{ nA}$$

$$I_E = 0; -V_{CB} = 32\text{ V}; T_j = 100\text{ °C} \quad -I_{CBO} < 10\text{ }\mu\text{A}$$

Base-emitter voltage

$$-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V} \quad -V_{BE} \quad 600\text{ to }750\text{ mV}$$

Saturation voltages

$$-I_C = 10\text{ mA}; -I_B = 0,5\text{ mA} \quad -V_{CEsat} \quad \begin{matrix} \text{typ.} & 80\text{ mV} \\ < & 300\text{ mV} \end{matrix}$$

$$-I_C = 50\text{ mA}; -I_B = 2,5\text{ mA} \quad -V_{BEsat} \quad \text{typ.} \quad 720\text{ mV}$$

$$-I_C = 50\text{ mA}; -I_B = 2,5\text{ mA} \quad -V_{CEsat} \quad \text{typ.} \quad 150\text{ mV}$$

$$-I_C = 50\text{ mA}; -I_B = 2,5\text{ mA} \quad -V_{BEsat} \quad \text{typ.} \quad 810\text{ mV}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

D.C. current gain

$-I_C = 10 \mu A; -V_{CE} = 5 V$

$-I_C = 2 mA; -V_{CE} = 5 V$

Collector-capacitance at  $f = 1 MHz$

$I_E = I_e = 0; -V_{CB} = 10 V$

Transition frequency at  $f = 35 MHz$

$-I_C = 10 mA; -V_{CE} = 5 V$

Noise figure at  $R_S = 2 k\Omega$

$-I_C = 200 \mu A; -V_{CE} = 5 V$

$f = 1 kHz; B = 200 Hz$

	BCW29 BCW29R	BCW30 BCW30R
$h_{FE}$	typ. 90	150
$h_{FE}$	$> 120$	215
$h_{FE}$	$< 260$	500
$C_c$	$< 7,0$	pF
$f_T$	typ. 150	MHz
F	$< 10$	dB

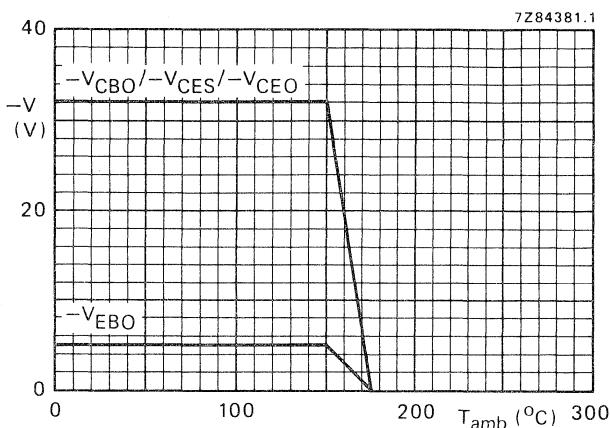


Fig. 2 Voltage derating curves.

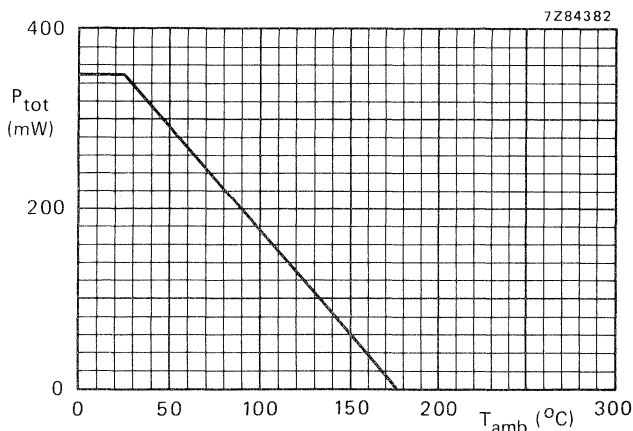


Fig. 3 Power derating curve.

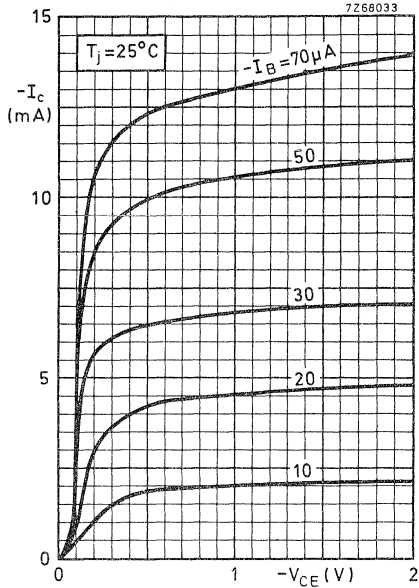


Fig. 4.

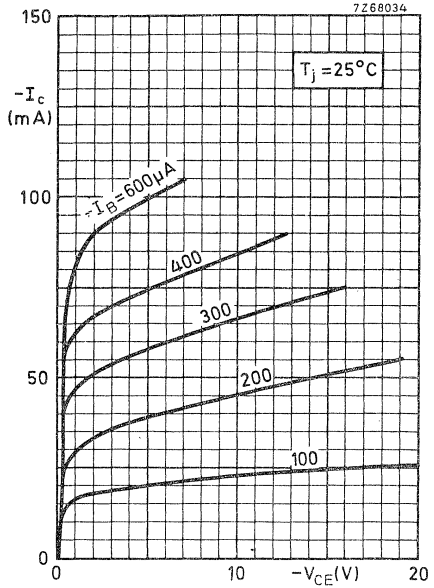


Fig. 5.

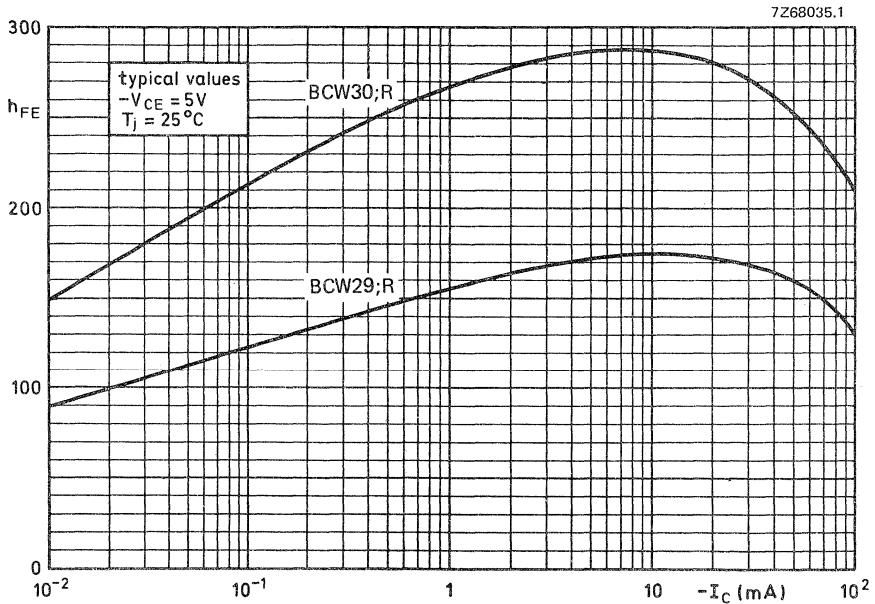


Fig. 6.

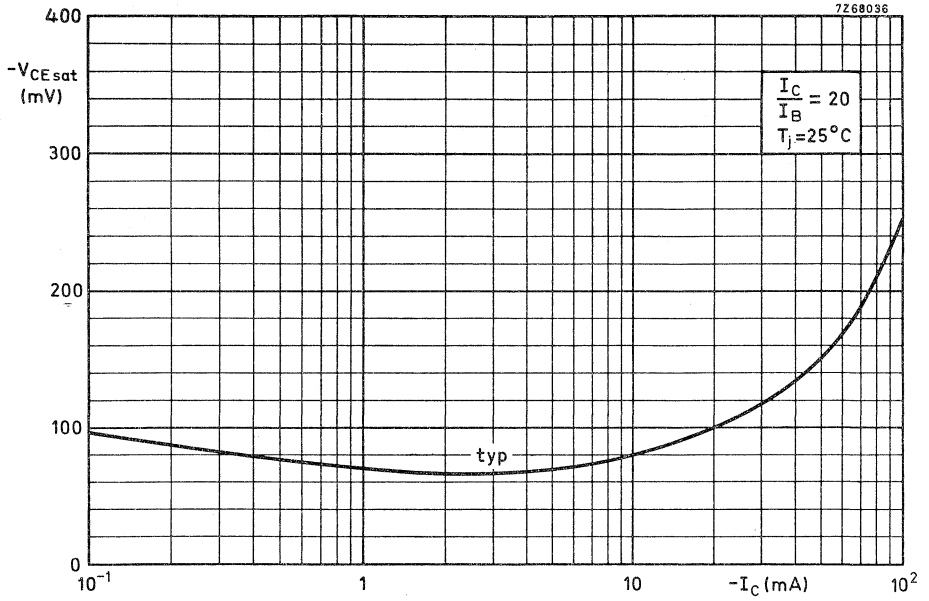


Fig. 7.

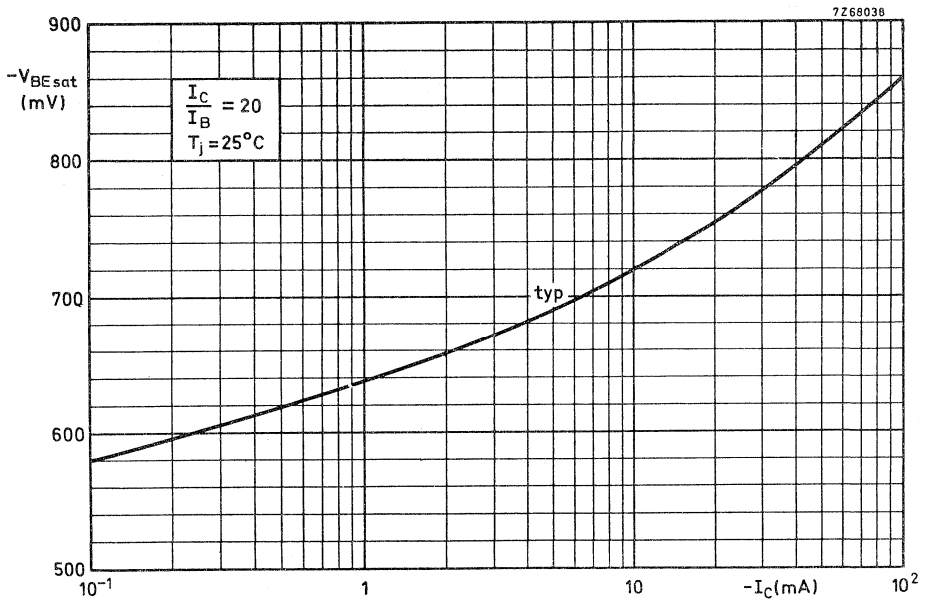


Fig. 8.

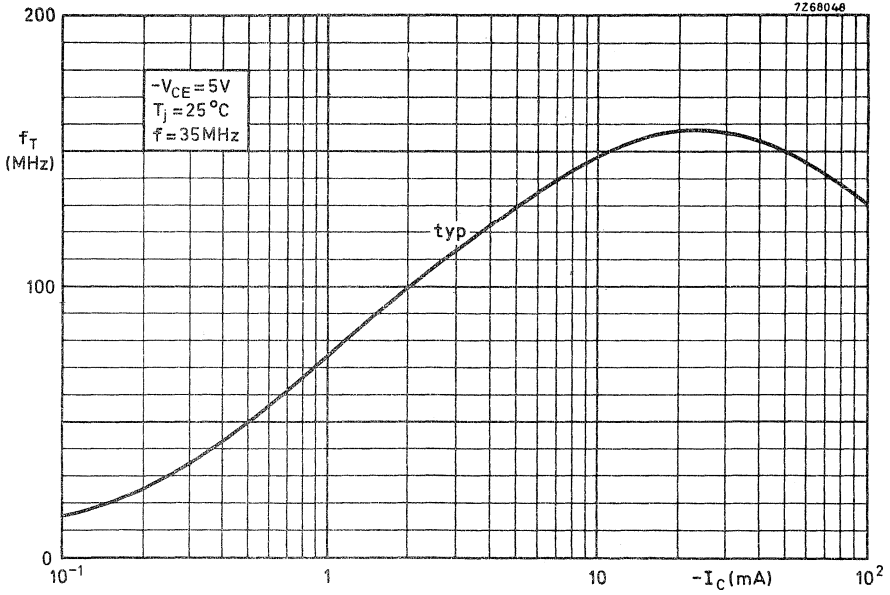


Fig. 9.

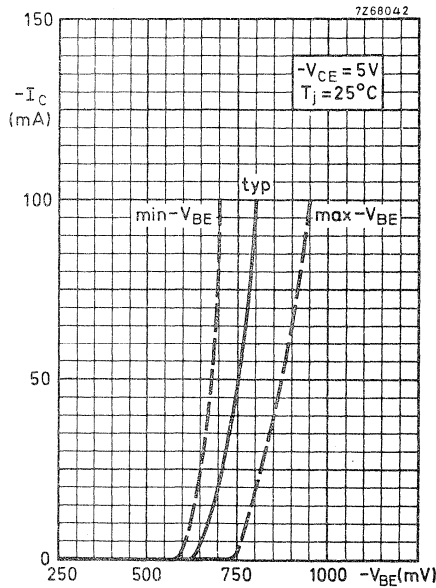


Fig. 10.



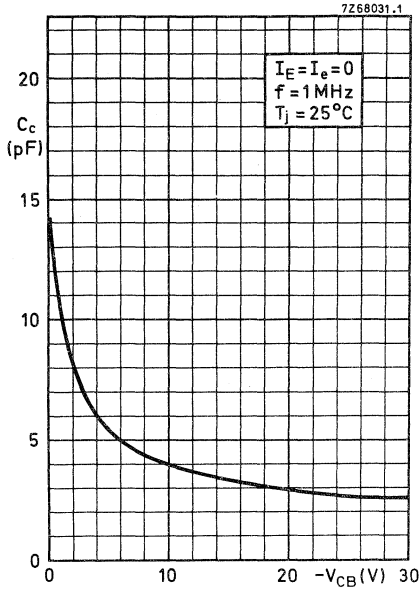


Fig. 11.

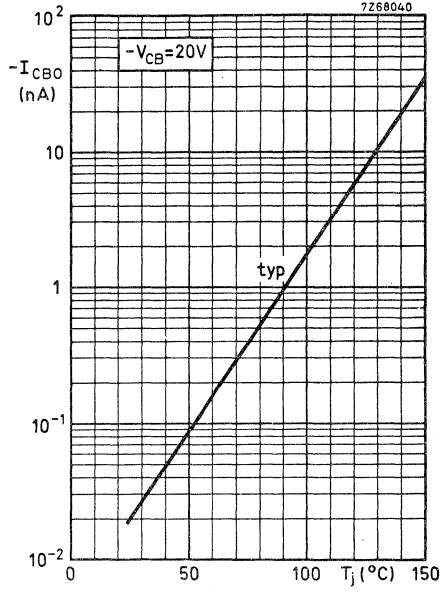


Fig. 12.



## SILICON PLANAR EPITAXIAL TRANSISTORS

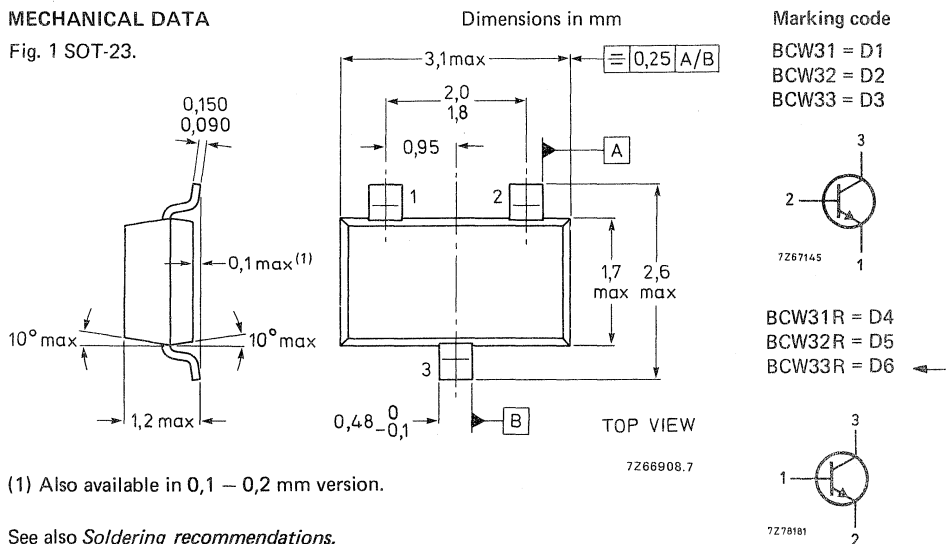
N-P-N transistors in a microminiature plastic envelope. They are intended for low level general purpose applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

		BCW31 BCW31R	BCW32 BCW32R	BCW33 BCW33R
D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE}$	110	200	420
		220	450	800
Collector-base voltage (open emitter)	$V_{CBO}$ max.		32	V
Collector-emitter voltage (open base)	$V_{CEO}$ max.		32	V
Collector current (peak value)	$I_{CM}$ max.		200	mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$ max.		350	mW
Junction temperature	$T_j$ max.		175	$^\circ\text{C}$
Transition frequency at $f = 35\text{ MHz}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$	$f_T$ typ.		300	MHz
Noise figure at $R_S = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$	F	<	10	dB

### MECHANICAL DATA

Fig. 1 SOT-23.



### RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	32 V
Collector-emitter voltage (open base) $I_C = 2 \text{ mA}$	$V_{CEO}$	max.	32 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	5 V
Collector current (d.c.)	$I_C$	max.	100 mA
Collector current (peak value)	$I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-65 to +175 $^\circ\text{C}$
Junction temperature	$T_j$	max.	175 $^\circ\text{C}$

### THERMAL CHARACTERISTICS\*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

#### Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

### CHARACTERISTICS

$T_j = 25 \text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 32 \text{ V}$$

$$I_{CBO} < 100 \text{ nA}$$

$$I_E = 0; V_{CB} = 32 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$$

$$I_{CBO} < 10 \text{ } \mu\text{A}$$

Base-emitter voltage

$$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$$

$$V_{BE} \quad 550 \text{ to } 700 \text{ mV}$$

Saturation voltages

$$I_C = 10 \text{ mA}; I_B = 0,5 \text{ mA}$$

$$V_{CEsat} \quad \begin{matrix} \text{typ.} & 120 \text{ mV} \\ < & 250 \text{ mV} \end{matrix}$$

$$V_{BEsat} \quad \text{typ.} \quad 750 \text{ mV}$$

$$I_C = 50 \text{ mA}; I_B = 2,5 \text{ mA}$$

$$V_{CEsat} \quad \text{typ.} \quad 210 \text{ mV}$$

$$V_{BEsat} \quad \text{typ.} \quad 850 \text{ mV}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

D.C. current gain

$I_C = 10 \mu A, V_{CE} = 5 V$

$h_{FE}$  typ.

BCW31 BCW31R	BCW32 BCW32R	BCW33 BCW33R
90	150	270
$>$	200	420
$<$	450	800

$I_C = 2 mA; V_{CE} = 5 V$

$h_{FE}$

Collector capacitance at  $f = 1 MHz$

$I_E = I_e = 0; V_{CB} = 10 V$

$C_c$

Transition frequency at  $f = 35 MHz$

$I_C = 10 mA; V_{CE} = 5 V$

$f_T$

Noise figure at  $R_S = 2 k\Omega$

$I_C = 200 \mu A; V_{CE} = 5 V$

F

$f = 1 kHz; B = 200 Hz$

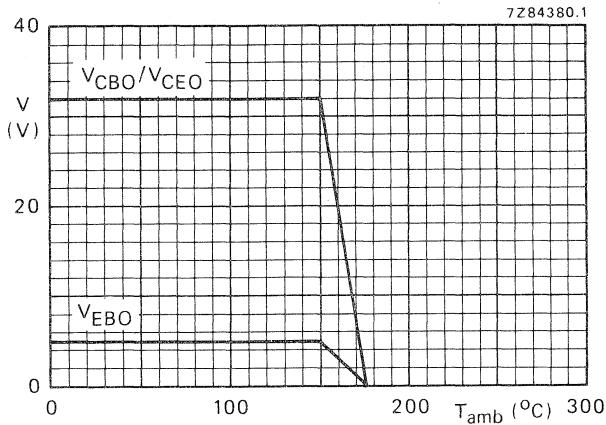


Fig. 2 Voltage derating curves.

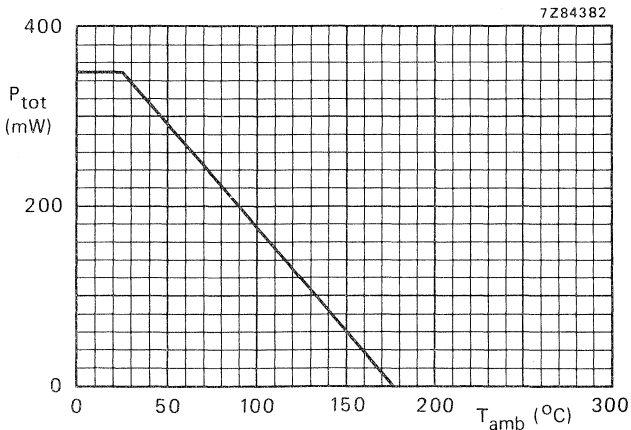


Fig. 3 Power derating curve.

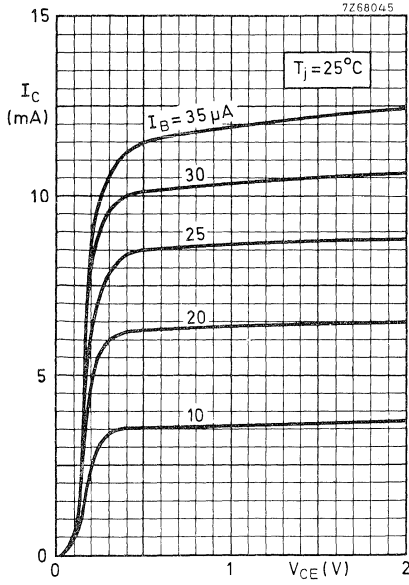


Fig. 4.

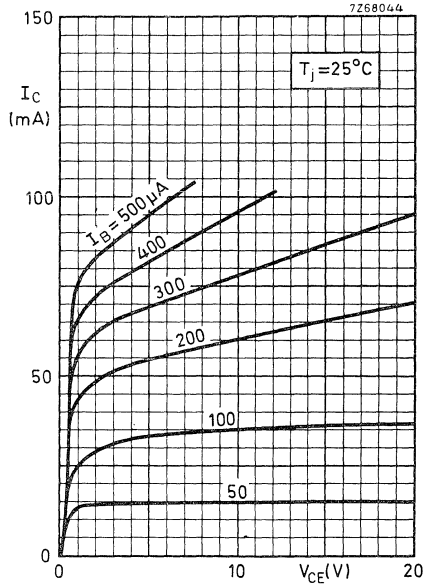


Fig. 5.

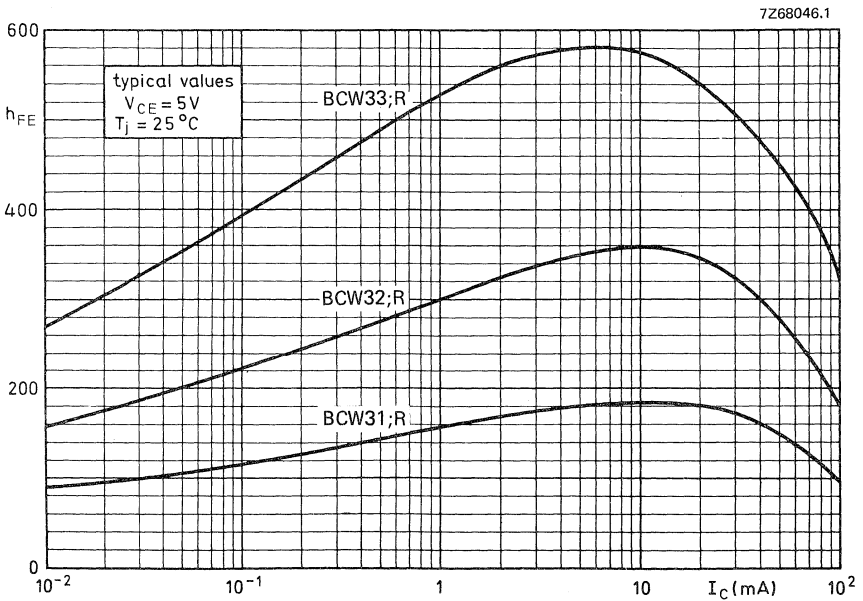


Fig. 6.

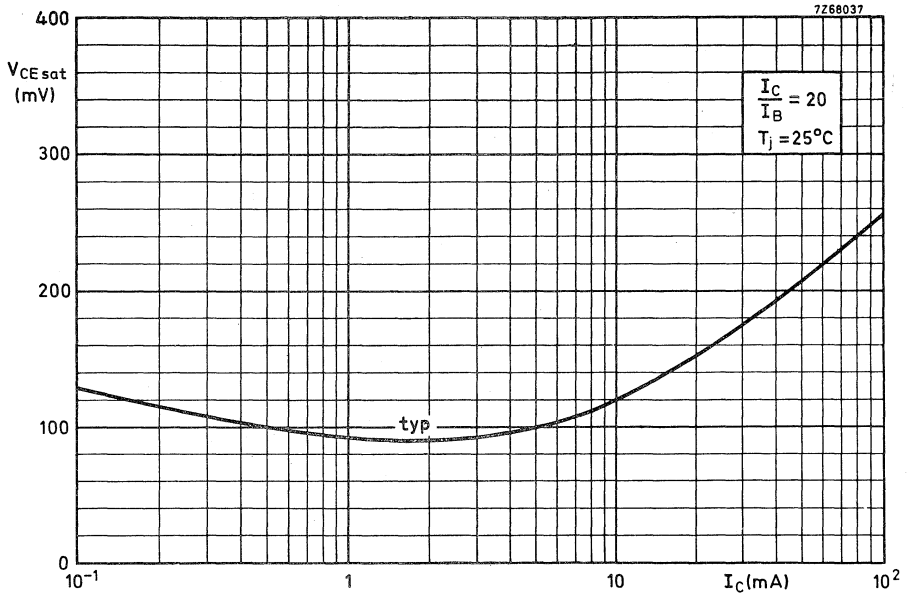


Fig. 7.

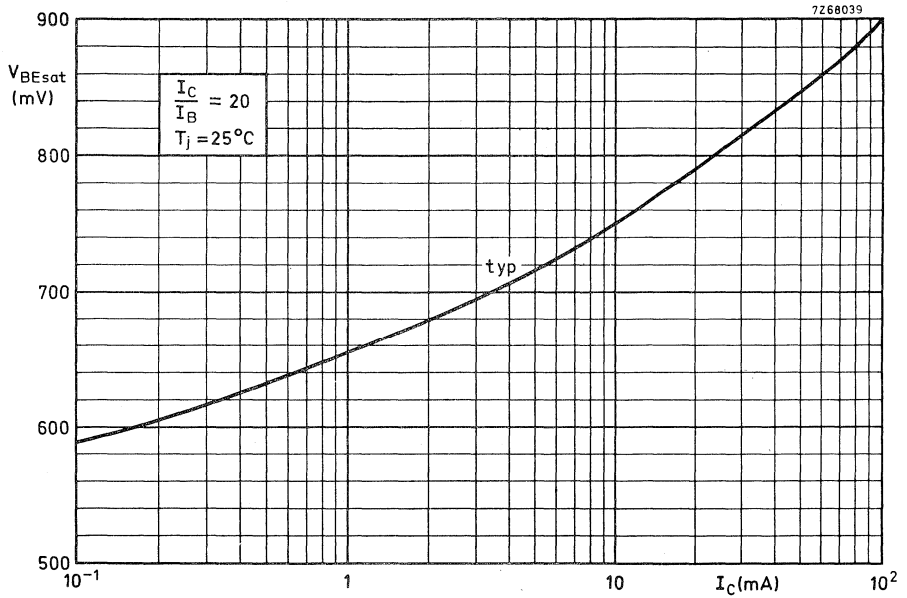


Fig. 8.

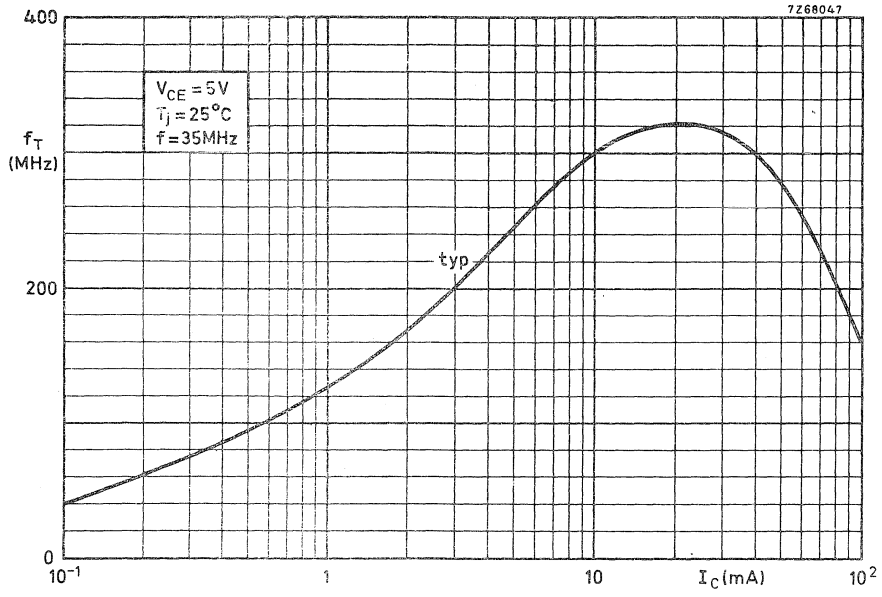


Fig. 9.

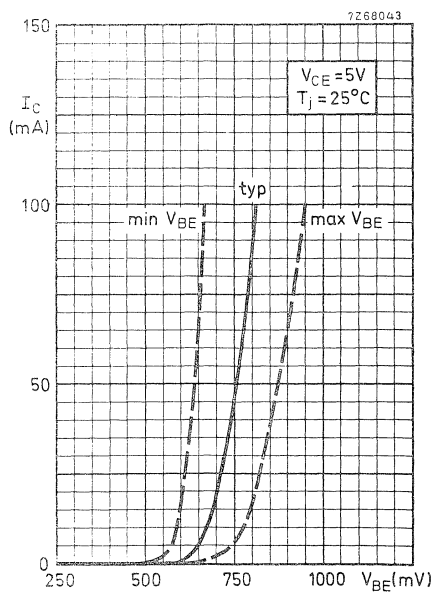


Fig. 10.



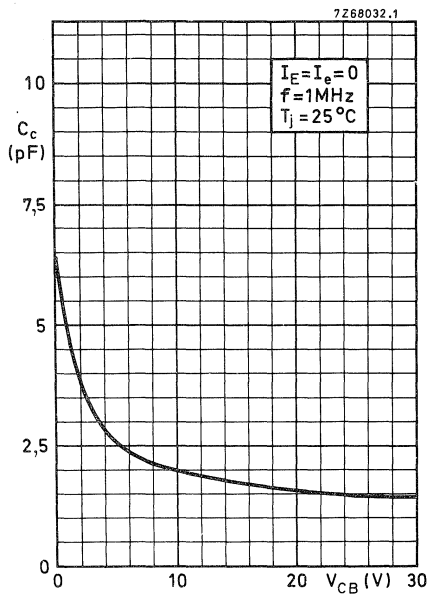


Fig. 11.

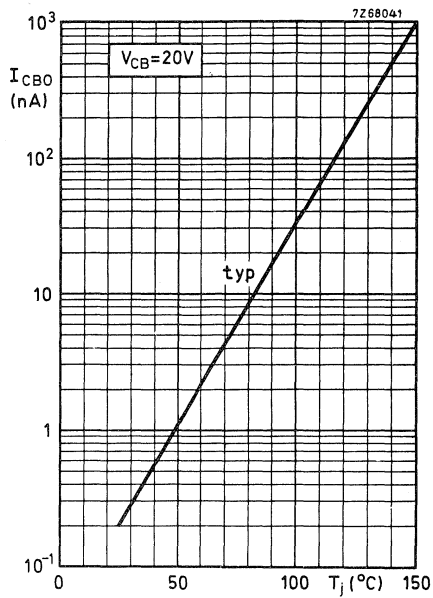


Fig. 12.



## SILICON PLANAR EPITAXIAL TRANSISTORS

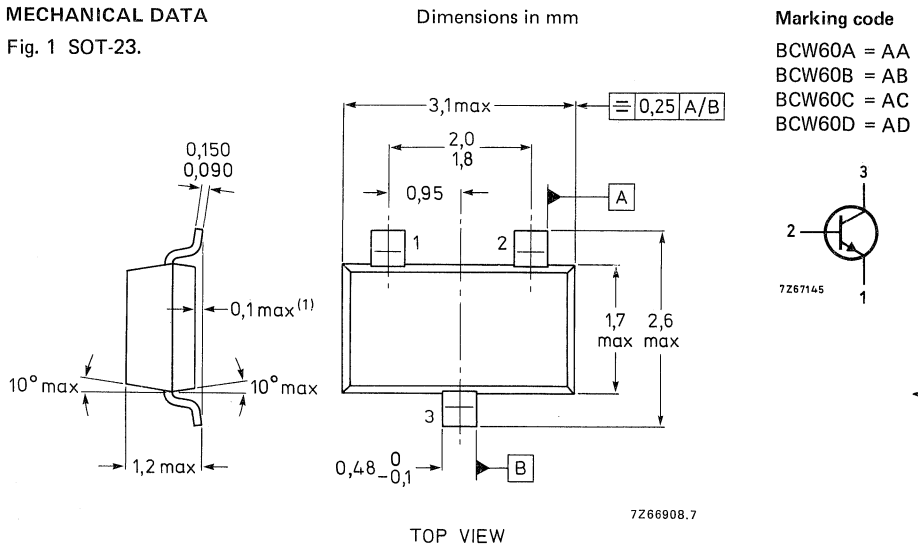
N-P-N silicon transistors, in a microminiature plastic envelope, intended for low level, low noise, low frequency purpose applications in hybrid circuits.

### QUICK REFERENCE DATA

Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max.	32 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	32 V
Collector current (d.c.)	$I_C$	max.	200 mA
Total power dissipation	$P_{tot}$	max.	150 mW
Junction temperature	$T_j$	max.	150 °C
Transition frequency at $f = 100$ MHz $V_{CE} = 5$ V; $I_C = 10$ mA	$f_T$	typ.	250 MHz
Noise figure at $f = 1$ kHz $V_{CE} = 5$ V; $I_C = 200$ $\mu$ A; $B = 200$ Hz	F	typ.	2 dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max.	32 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	32 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	5 V
Collector current (d.c.)	$I_C$	max.	200 mA
Base current	$I_B$	max.	50 mA
Total power dissipation up to $T_{amb} = 100\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	150 mW
Storage temperature	$T_{stg}$		-55 to + 125 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

## THERMAL CHARACTERISTICS\*

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

### Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

$T_{amb} = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter cut-off current

$$V_{BE} = 0; V_{CE} = 32\text{ V} \quad I_{CES} < 20\text{ nA}$$

$$V_{BE} = 0; V_{CE} = 32\text{ V}; T_{amb} = 150\text{ }^\circ\text{C} \quad I_{CES} < 20\text{ }\mu\text{A}$$

Emitter-base cut-off current

$$I_C = 0; V_{EB} = 4\text{ V} \quad I_{EBO} < 20\text{ nA}$$

Saturation voltages

$$\text{at } I_C = 10\text{ mA}; I_B = 0,25\text{ mA} \quad V_{CEsat} = 0,05\text{ to }0,35\text{ V}$$

$$\quad V_{BEsat} = 0,6\text{ to }0,85\text{ V}$$

$$\text{at } I_C = 50\text{ mA}; I_B = 1,25\text{ mA} \quad V_{CEsat} = 0,1\text{ to }0,55\text{ V}$$

$$\quad V_{BEsat} = 0,7\text{ to }1,05\text{ V}$$

Transition frequency at  $f = 100\text{ MHz}$   $\Delta$

$$I_C = 10\text{ mA}; V_{CE} = 5\text{ V} \quad f_T > 125\text{ MHz}$$

typ. 250 MHz

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_C = 0; V_{CB} = 10\text{ V} \quad C_c < 4,5\text{ pF}$$

Emitter capacitance at  $f = 1\text{ MHz}$

$$I_C = I_e = 0; V_{EB} = 0,5\text{ V} \quad C_e \text{ typ. } 8\text{ pF}$$

Noise figure at  $R_S = 2\text{ k}\Omega$

$$I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V}; f = 1\text{ kHz}; B = 200\text{ Hz} \quad F < 2\text{ dB}$$

typ. 6 dB

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

$\Delta$  Measured under pulse conditions.

		A	B	C	D
D.C. current gain					
$V_{CE} = 5\text{ V}; I_C = 10\ \mu\text{A}$	$h_{FE}$ typ.	78	145	220	300
	>	—	20	40	100
	>	120	180	250	380
$V_{CE} = 5\text{ V}; I_C = 2\text{ mA}$	$h_{FE}$ typ.	170	250	350	500
	<	220	310	460	630
$V_{CE} = 1\text{ V}; I_C = 50\text{ mA}$	$h_{FE}$ >	50	70	90	100
Input impedance					
$V_{CE} = 5\text{ V}; I_C = 2\text{ mA}; f = 1\text{ kHz}$	$h_{ie}$ typ.	1,6	2,5	3,2	4,5 k $\Omega$
	<	2,7	3,6	4,5	7,5 k $\Omega$
	<	4,5	6,0	8,5	12,0 k $\Omega$
Reverse voltage transfer ratio					
$V_{CE} = 5\text{ V}; I_C = 2\text{ mA}; f = 1\text{ kHz}$	$h_{re}$ typ.	1,5	2	2	3 $10^{-4}$
	>	125	175	250	350
Small-signal current gain					
$V_{CE} = 5\text{ V}; I_C = 2\text{ mA}; f = 1\text{ kHz}$	$h_{fe}$ typ.	200	260	330	520
	<	250	350	500	700
Output admittance					
$V_{CE} = 5\text{ V}; I_C = 2\text{ mA}; f = 1\text{ kHz}$	$h_{oe}$ typ.	18	24	30	50 $\mu\text{A/V}$
	<	30	50	60	100 $\mu\text{A/V}$
Base-emitter voltage					
$V_{CE} = 5\text{ V}; I_C = 2\text{ mA}$	$V_{BE}$ typ.	0,55 to 0,75			V
		0,65			V
$V_{CE} = 5\text{ V}; I_C = 10\ \mu\text{A}$	$V_{BE}$ typ.	0,52			V
$V_{CE} = 1\text{ V}; I_C = 50\text{ mA}$	$V_{BE}$ typ.	0,78			V

Switching times

$I_{Con} = 10 \text{ mA}$ ;  $I_{Bon} = -I_{Boff} = 1 \text{ mA}$

$V_{CC} = 10 \text{ V}$ ;  $R_L = 990 \Omega$

turn-on time ( $t_d + t_r$ )

$t_{on}$     typ.    85 ns  
            <    150 ns

turn-off time ( $t_s + t_f$ )

$t_{off}$     typ.    480 ns  
            <    800 ns

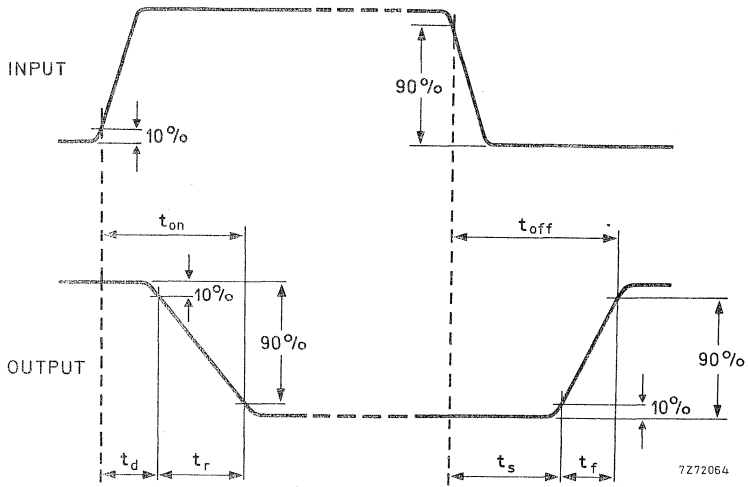


Fig. 2 Switching waveforms.

## SILICON PLANAR EPITAXIAL TRANSISTORS

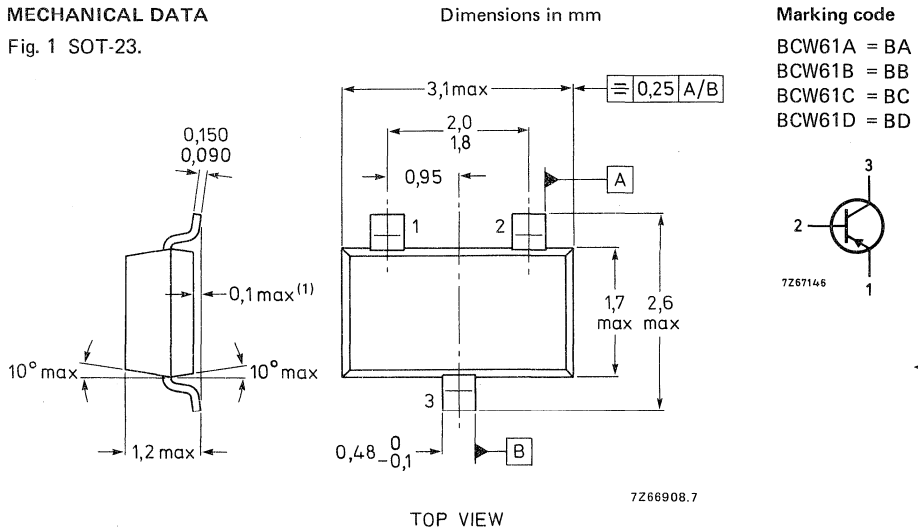
P-N-P silicon transistors, in a microminiature plastic envelope, intended for low level, low noise, low frequency purpose applications in hybrid circuits.

### QUICK REFERENCE DATA

Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$	max.	32 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	32 V
Collector current (d.c.)	$-I_C$	max.	200 mA
Total power dissipation	$P_{tot}$	max.	150 mW
Junction temperature	$T_j$	max.	150 °C
Transition frequency at $f = 100$ MHz $-V_{CE} = 5$ V; $-I_C = 10$ mA	$f_T$	typ.	180 MHz
Noise figure at $f = 1$ kHz $-V_{CE} = 5$ V; $-I_C = 200$ $\mu$ A	F	typ.	2 dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$	max.	32 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	32 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	200 mA
Base current	$-I_B$	max.	50 mA
Total power dissipation up to $T_{amb} = 100\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	150 mW
Storage temperature	$T_{stg}$		-55 to + 125 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

## THERMAL CHARACTERISTICS\*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

### Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

$T_{amb} = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter cut-off current

$$V_{EB} = 0; -V_{CE} = 32\text{ V} \quad -I_{CES} < 20\text{ nA}$$

$$V_{EB} = 0; -V_{CE} = 32\text{ V}; T_{amb} = 150\text{ }^\circ\text{C} \quad -I_{CES} < 20\text{ }\mu\text{A}$$

Emitter-base cut-off current

$$I_C = 0; -V_{EB} = 4\text{ V} \quad -I_{EBO} < 20\text{ nA}$$

Saturation voltages

$$-I_C = 10\text{ mA}; -I_B = 0,25\text{ mA} \quad -V_{CESat} \quad 0,06\text{ to }0,25\text{ V}$$

$$-V_{BESat} \quad 0,6\text{ to }0,85\text{ V}$$

$$-I_C = 50\text{ mA}; -I_B = 1,25\text{ mA} \quad -V_{CESat} \quad 0,12\text{ to }0,55\text{ V}$$

$$-V_{BESat} \quad 0,68\text{ to }1,05\text{ V}$$

Transition frequency at  $f = 100\text{ MHz}$  ▲

$$-V_{CE} = 5\text{ V}; -I_C = 10\text{ mA} \quad f_T \quad \text{typ.} \quad 180\text{ MHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$-V_{CB} = 10\text{ V}; I_E = I_e = 0 \quad C_c < 6\text{ pF}$$

Emitter capacitance at  $f = 1\text{ MHz}$

$$-V_{EB} = 0,5\text{ V}; I_C = I_c = 0 \quad C_e \quad \text{typ.} \quad 11\text{ pF}$$

Noise figure at  $R_S = 2\text{ k}\Omega$

$$-V_{CE} = 5\text{ V}; -I_C = 200\text{ }\mu\text{A}; B = 200\text{ Hz} \quad F \quad \text{typ.} \quad 2\text{ dB}$$

$$< \quad 6\text{ dB}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

▲ Measured under pulse conditions.



		A	B	C	D
D.C. current gain	typ.	140	200	270	340
	$-V_{CE} = 5 \text{ V}; -I_C = 10 \mu\text{A}$	>	—	30	40
	>	120	180	250	380
	typ.	170	250	350	500
$-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}$	<	220	310	460	630
	typ.	60	80	100	110
$-V_{CE} = 1 \text{ V}; -I_C = 50 \text{ mA}$	>	1,6	2,5	3,2	4,5 k $\Omega$
	typ.	2,7	3,6	4,5	7,5 k $\Omega$
Input impedance	<	4,5	6,0	8,5	12,0 k $\Omega$
	typ.	1,5	2	2	3 $10^{-4}$
$-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$	>	125	175	250	350
	typ.	200	260	330	520
Reverse voltage transfer ratio	<	250	350	500	700
	typ.	18	24	30	50 $\mu\text{A/V}$
$-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$	<	30	50	60	100 $\mu\text{A/V}$
	typ.	0,6 to 0,75			V
Base-emitter voltage	typ.	0,65			V
	typ.	0,55			V
$-V_{CE} = 5 \text{ V}; -I_C = 10 \mu\text{A}$	typ.	0,72			V
	typ.				V
$-V_{CE} = 1 \text{ V}; -I_C = 50 \text{ mA}$	typ.				V
	typ.				V

Switching times

$-I_{Con} = 10 \text{ mA}; -I_{Bon} = I_{Boff} = 1 \text{ mA}$

$-V_{CC} = 10 \text{ V}; R_L = 990 \Omega$

turn-on time ( $t_d + t_r$ )

$t_{on}$     typ.    85 ns  
            <        150 ns

turn-off time ( $t_s + t_f$ )

$t_{off}$     typ.    480 ns  
            <        800 ns

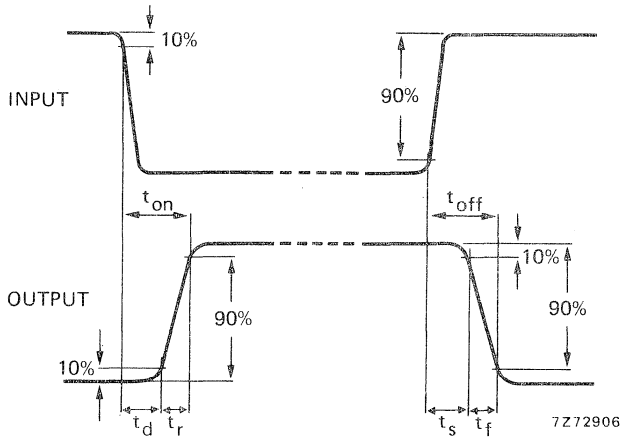


Fig. 2 Switching waveforms.

## SILICON PLANAR EPITAXIAL TRANSISTORS

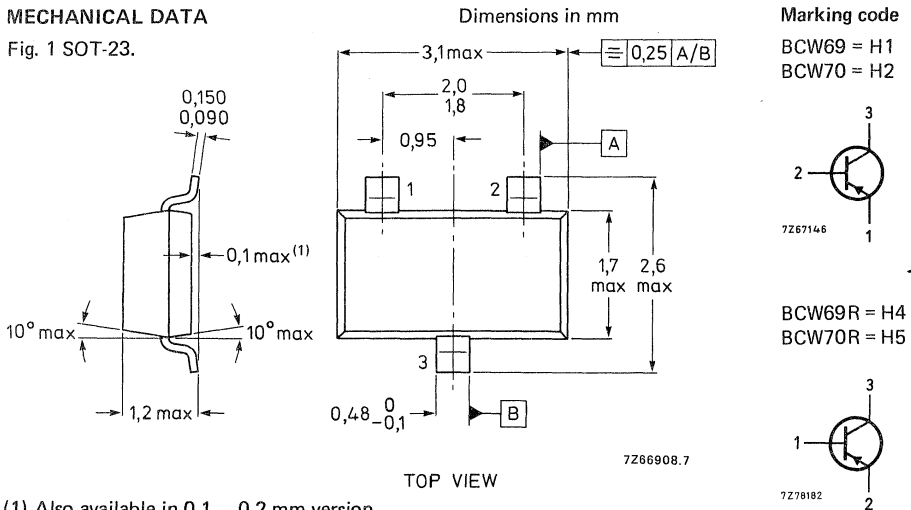
P-N-P transistors, in a microminiature plastic envelope, intended for low level general purpose applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

		BCW69 BCW69R	BCW70 BCW70R
D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$	$h_{FE}$	> 120 < 260	215 500
Collector-base voltage (open emitter)	$-V_{CBO}$ max.	50	V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	45	V
Collector current (peak value)	$-I_{CM}$ max.	200	mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$ max.	350	mW
Junction temperature	$T_j$ max.	175	$^\circ\text{C}$
Transition frequency at $f = 35\text{ MHz}$ $-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$	$f_T$ typ.	150	MHz
Noise figure at $R_S = 2\text{ k}\Omega$ $-I_C = 200\text{ }\mu\text{A}; -V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$	F	< 10	dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-base voltage (open emitter) see Fig. 2	$-V_{CBO}$	max.	50 V
Collector-emitter voltage ( $V_{BE} = 0$ ) see Fig. 2	$-V_{CES}$	max.	50 V
Collector-emitter voltage (open base) see Fig. 2 $-I_C = 2$ mA	$-V_{CEO}$	max.	45 V
Emitter-base voltage (open collector) see Fig. 2	$-V_{EBO}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	100 mA
Collector current (peak value)	$-I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25$ °C**	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-65 to +175 °C
Junction temperature	$T_j$	max.	175 °C

**THERMAL CHARACTERISTICS\***

$$T_j = P_x (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th j-t}$	=	50 K/W
From tab to soldering points	$R_{th t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

Collector cut-off current

$I_E = 0; -V_{CB} = 20$ V	$-I_{CBO}$	<	100 nA
$I_E = 0; -V_{CB} = 20$ V; $T_j = 100$ °C	$-I_{CBO}$	<	10 $\mu$ A

Base-emitter voltage

$-I_C = 2$ mA; $-V_{CE} = 5$ V	$-V_{BE}$		600 to 750 mV
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Saturation voltages

	$-V_{CEsat}$	typ.	80 mV
		<	300 mV
$-I_C = 10$ mA; $-I_B = 0,5$ mA	$-V_{BEsat}$	typ.	720 mV
$-I_C = 50$ mA; $-I_B = 2,5$ mA	$-V_{CEsat}$	typ.	150 mV
	$-V_{BEsat}$	typ.	810 mV

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

D.C. current gain

$-I_C = 10 \mu\text{A}; -V_{CE} = 5 \text{ V}$

$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V}$

Collector capacitance at  $f = 1 \text{ MHz}$

$I_E = I_e = 0; -V_{CB} = 10 \text{ V}$

Transition frequency at  $f = 35 \text{ MHz}$

$-I_C = 10 \text{ mA}; -V_{CE} = 5 \text{ V}$

Noise figure at  $R_S = 2 \text{ k}\Omega$

$-I_C = 200 \mu\text{A}; -V_{CE} = 5 \text{ V}$

$f = 1 \text{ kHz}; B = 200 \text{ Hz}$

		BCW69 BCW69R	BCW70 BCW70R	
$h_{FE}$	typ.	90	150	
$h_{FE}$	>	120	215	
$h_{FE}$	<	260	500	
$C_c$	<	7,0		pF
$f_T$	typ.	150	150	MHz
F	<	10		dB

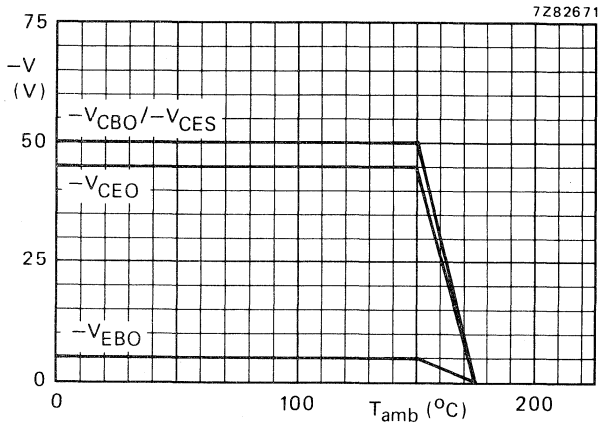


Fig. 2 Voltage derating curve.

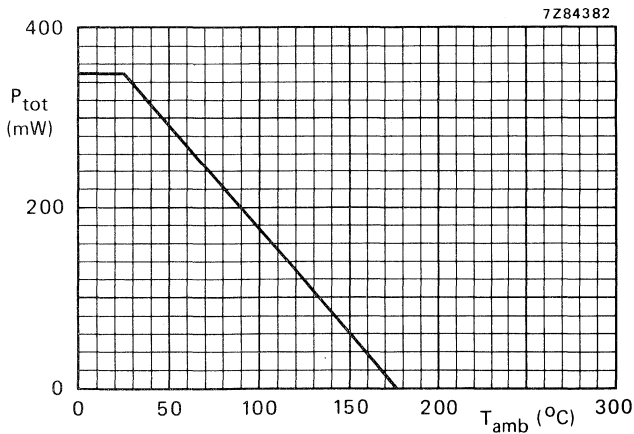


Fig. 3 Power derating curve.

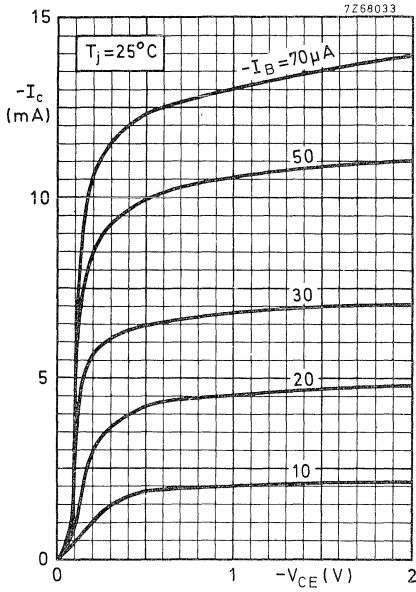


Fig. 4.

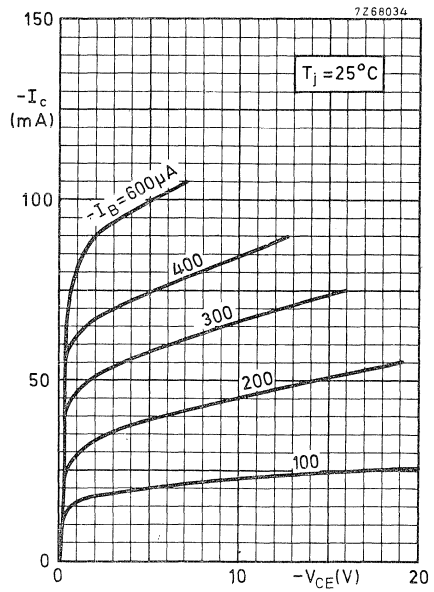


Fig. 5.

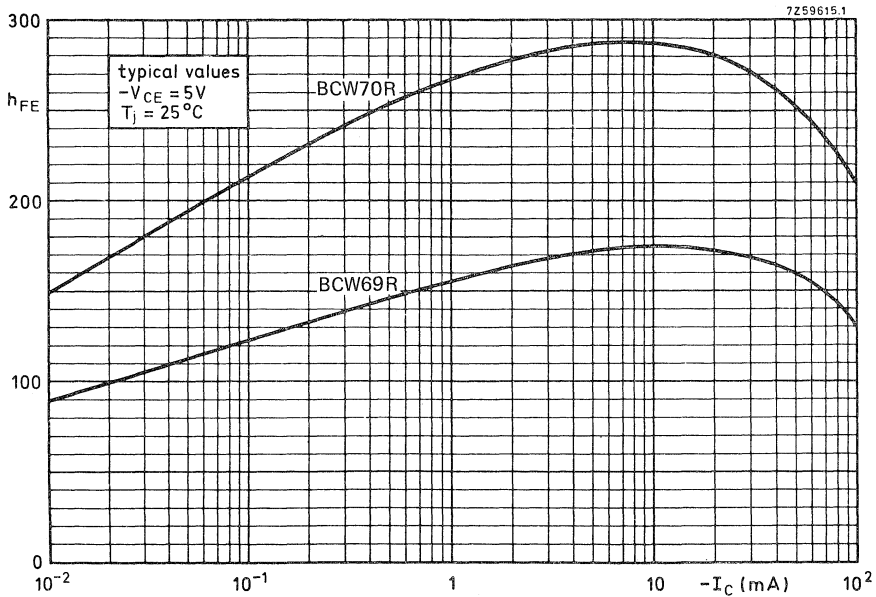


Fig. 6 D.C. current gain.

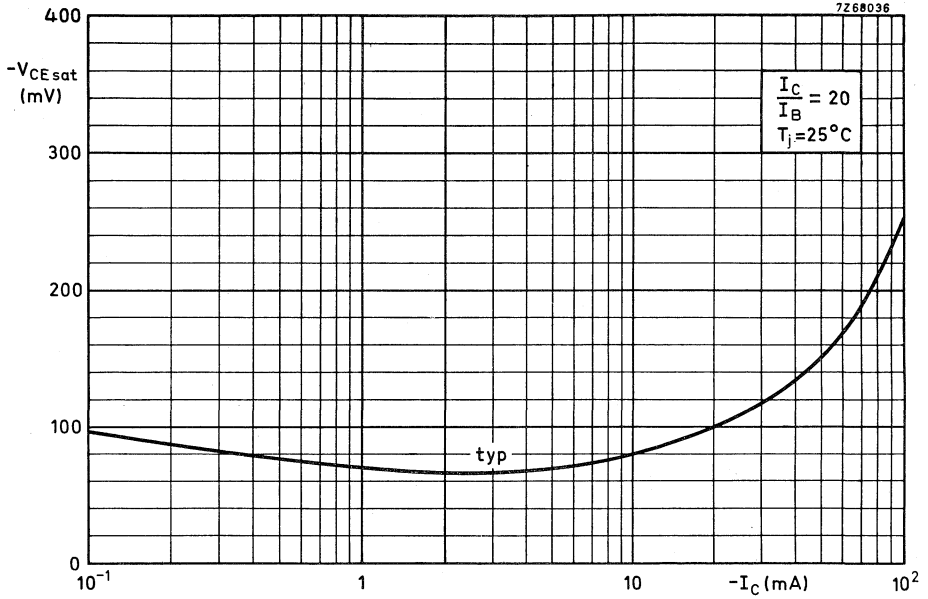


Fig. 7.

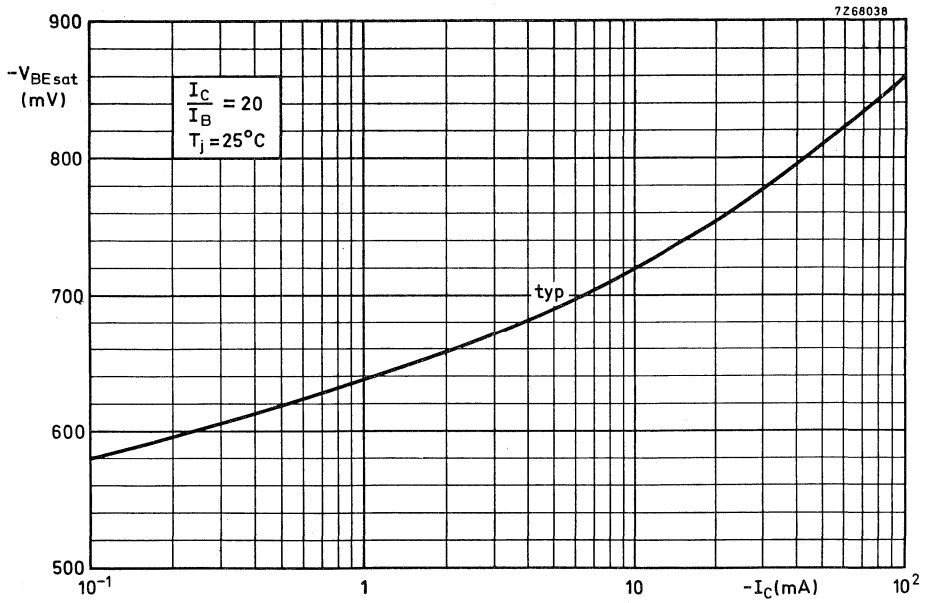


Fig. 8.

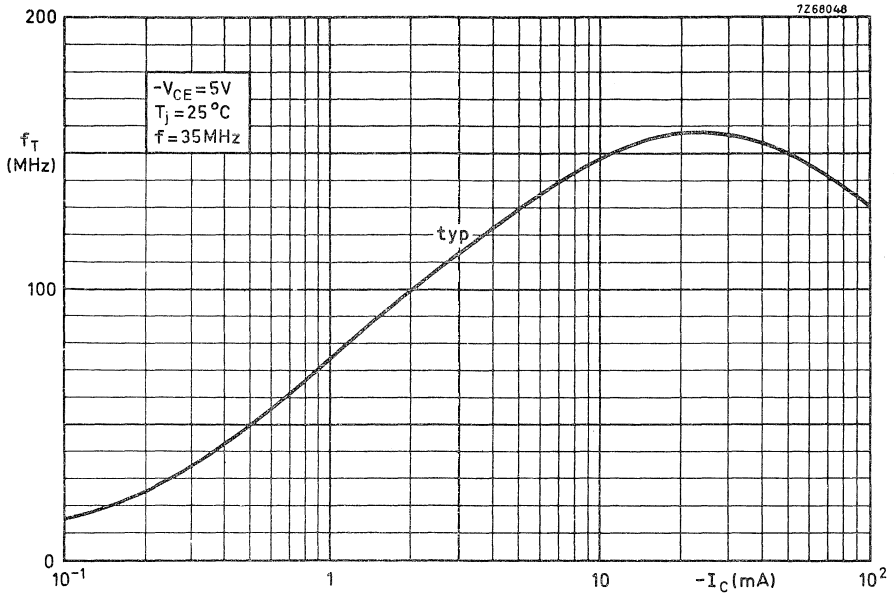


Fig. 9.

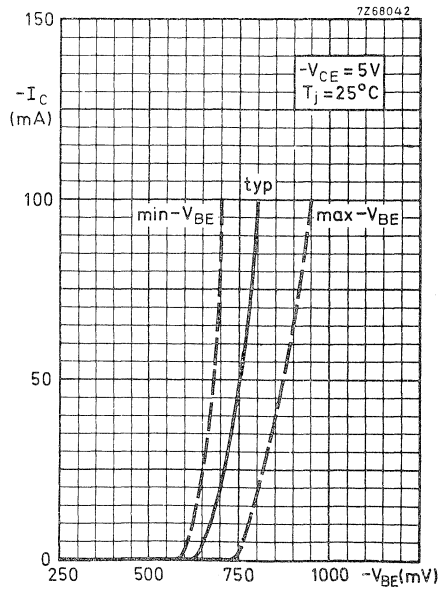


Fig. 10.



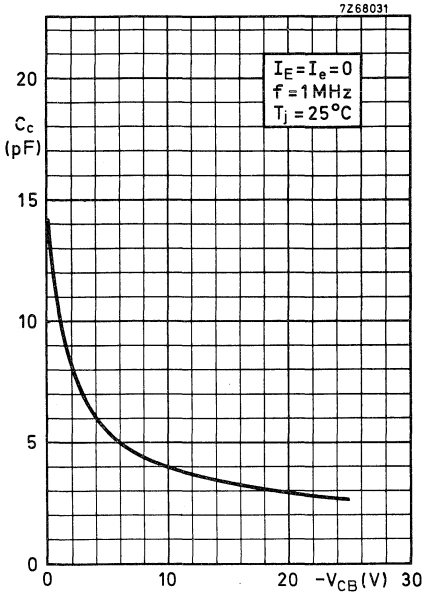


Fig. 11.

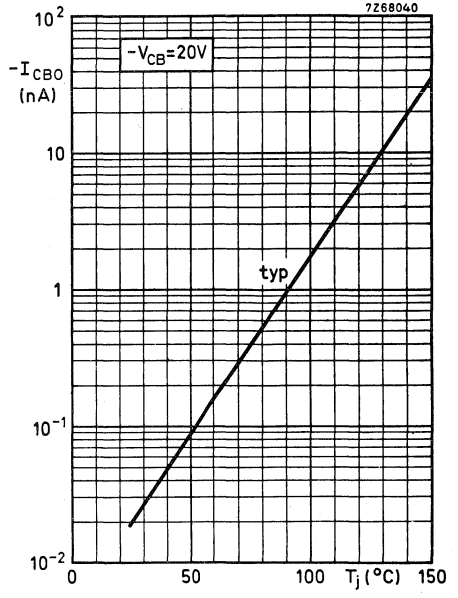


Fig. 12.



## SILICON PLANAR EPITAXIAL TRANSISTORS

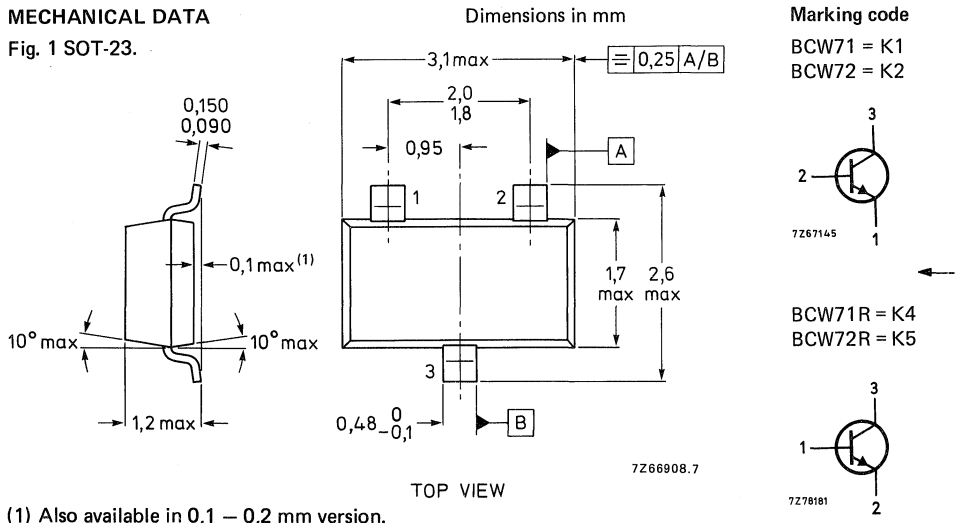
N-P-N transistors, in a microminiature plastic envelope, intended for low level general purpose applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

		BCW71 BCW71R	BCW72 BCW72R	
D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE}$	> 110 < 220	200 450	
Collector-base voltage (open emitter)	$V_{CBO}$	max. 50		V
Collector-emitter voltage (open base)	$V_{CEO}$	max. 45		V
Collector current (peak value)	$I_{CM}$	max. 200		mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max. 350		mW
Junction temperature	$T_j$	max. 175		$^\circ\text{C}$
Transition frequency at $f = 35\text{ MHz}$ $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$	$f_T$	typ. 300		MHz
Noise figure at $R_S = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$	F	< 10		dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 2	$V_{CBO}$	max.	50 V
Collector-emitter voltage (open base) see Fig. 2 $I_C = 2 \text{ mA}$	$V_{CEO}$	max.	45 V
Emitter-base voltage (open collector) see Fig. 2	$V_{EBO}$	max.	5 V
Collector current (d.c.)	$I_C$	max.	100 mA
Collector current (peak value)	$I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-65 to +175 $^\circ\text{C}$
Junction temperature	$T_j$	max.	175 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25 \text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 20 \text{ V}$$

$$I_{CBO} < 100 \text{ nA}$$

$$I_E = 0; V_{CB} = 20 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$$

$$I_{CBO} < 10 \text{ } \mu\text{A}$$

Base emitter voltage

$$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$$

$$V_{BE} \quad 550 \text{ to } 700 \text{ mV}$$

Saturation voltages

$$I_C = 10 \text{ mA}; I_B = 0,5 \text{ mA}$$

$$V_{CEsat} \quad \text{typ. } 120 \text{ mV}$$

$$< 250 \text{ mV}$$

$$I_C = 50 \text{ mA}; I_B = 2,5 \text{ mA}$$

$$V_{BEsat} \quad \text{typ. } 750 \text{ mV}$$

$$V_{CEsat} \quad \text{typ. } 210 \text{ mV}$$

$$V_{BEsat} \quad \text{typ. } 850 \text{ mV}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

D.C. current gain

$I_C = 10 \mu A; V_{CE} = 5 V$

$I_C = 2 mA; V_{CE} = 5 V$

Collector capacitance at  $f = 1 MHz$

$I_E = I_e = 0; V_{CB} = 10 V$

Transition frequency at  $f = 35 MHz$

$I_C = 10 mA; V_{CE} = 5 V$

Noise figure at  $R_S = 2 k\Omega$

$I_C = 200 \mu A; V_{CE} = 5 V$

$f = 1 kHz; B = 200 Hz$

		BCW71;R	BCW72;R
$h_{FE}$	typ.	90	150
$h_{FE}$	>	110	200
$h_{FE}$	<	220	450
$C_c$	<	4,0	pF
$f_T$	typ.	300	MHz
F	<	10	dB

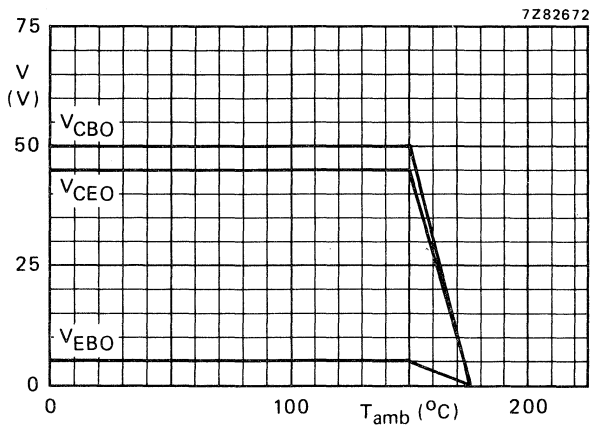


Fig. 2 Voltage derating curves.

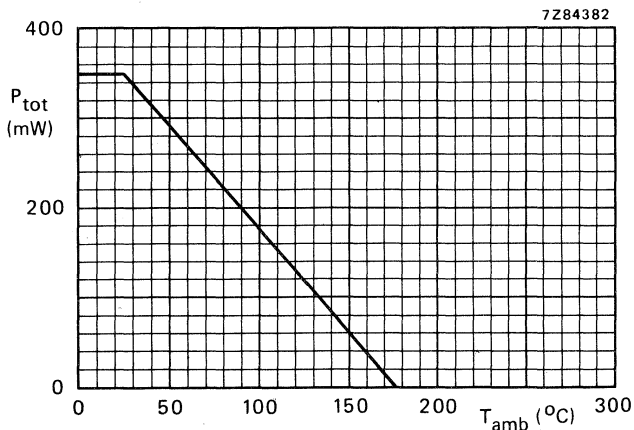


Fig. 3 Power derating curve.

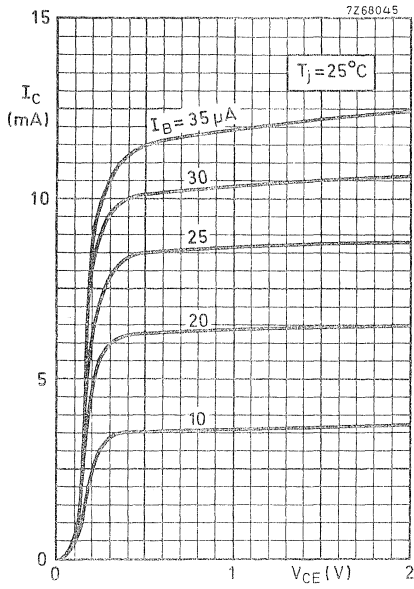


Fig. 4.

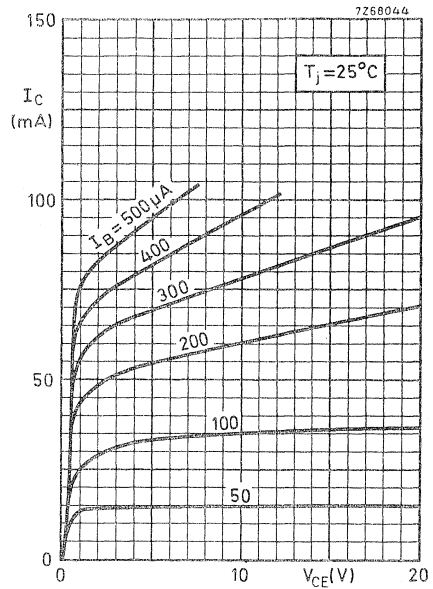


Fig. 5.

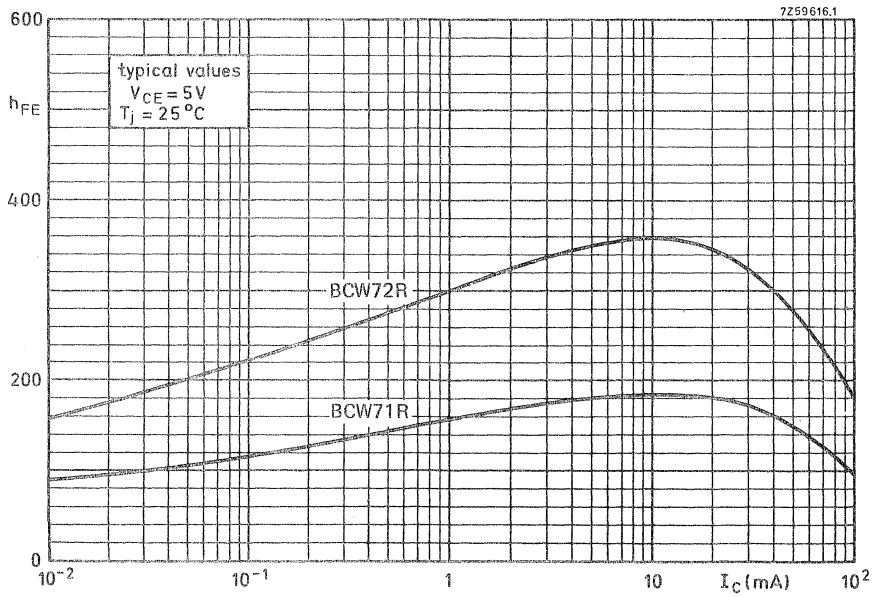


Fig. 6 D.C. current gain.

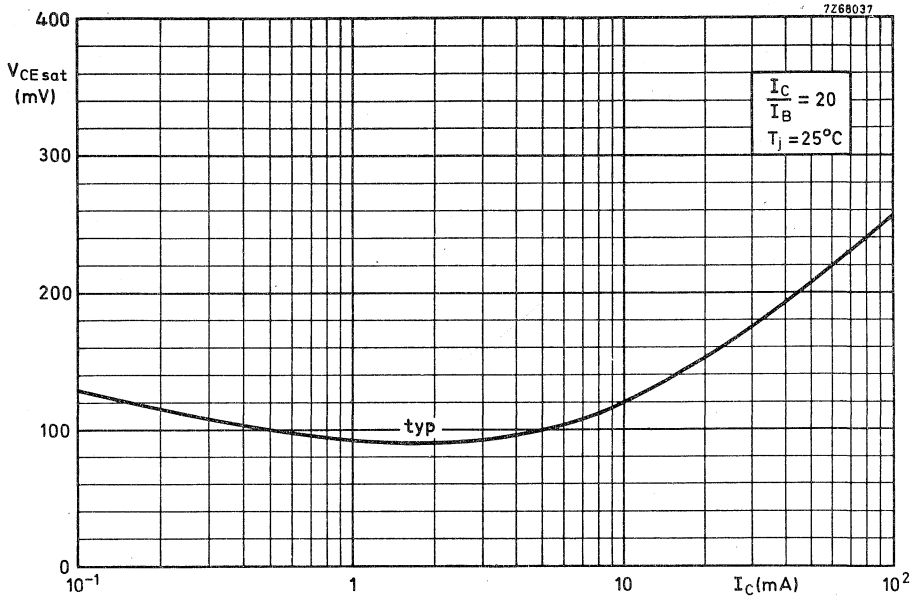


Fig. 7.

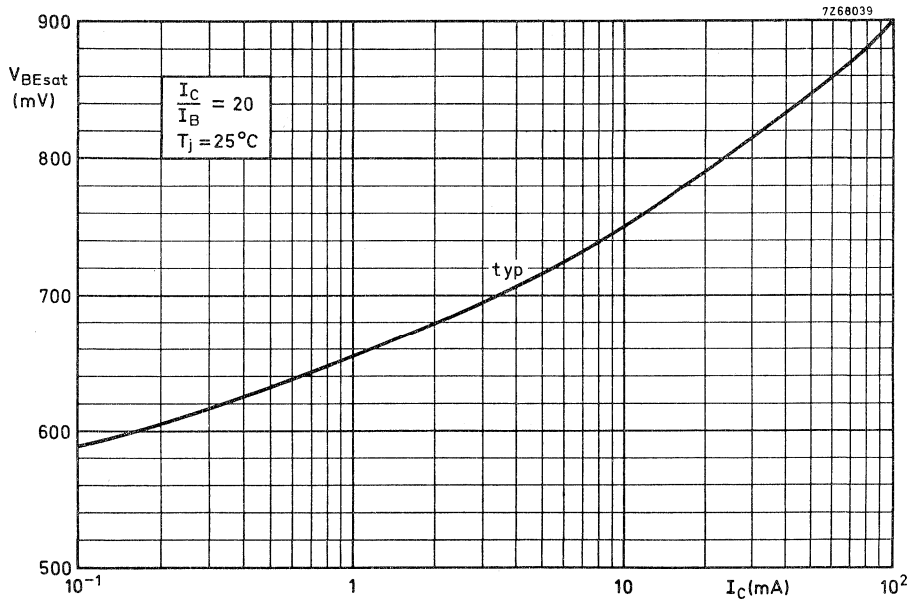


Fig. 8.

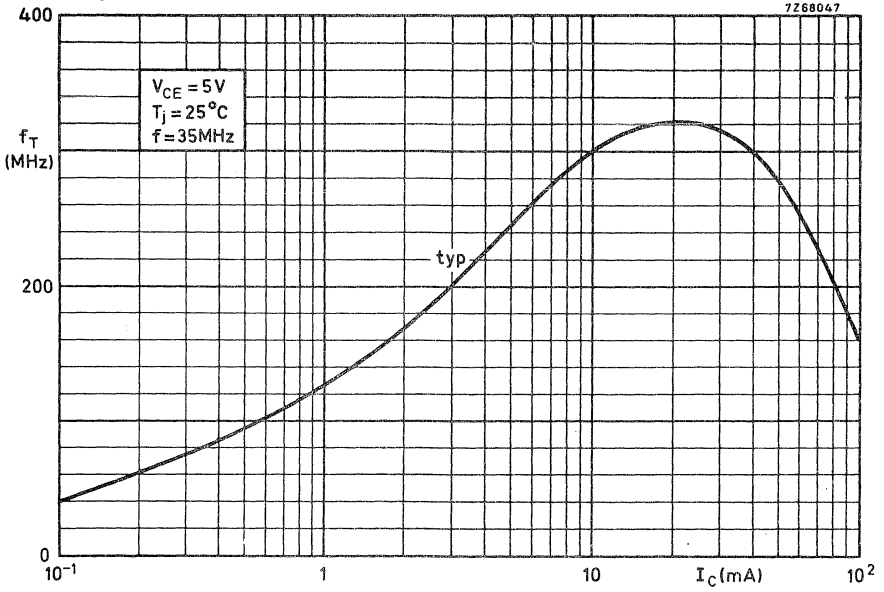


Fig. 9.

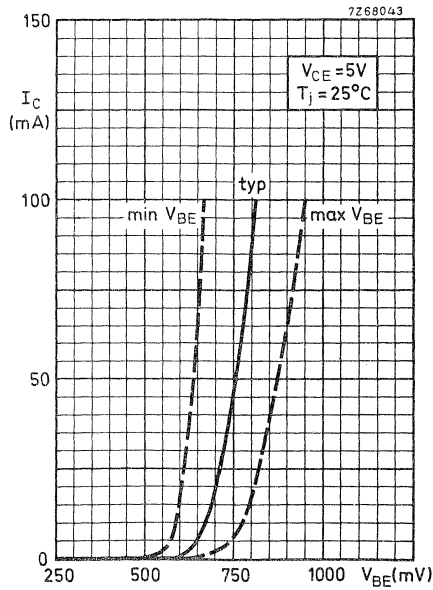


Fig. 10.



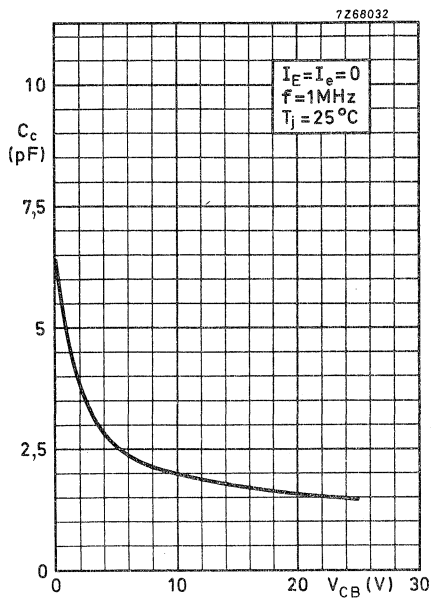


Fig. 11.

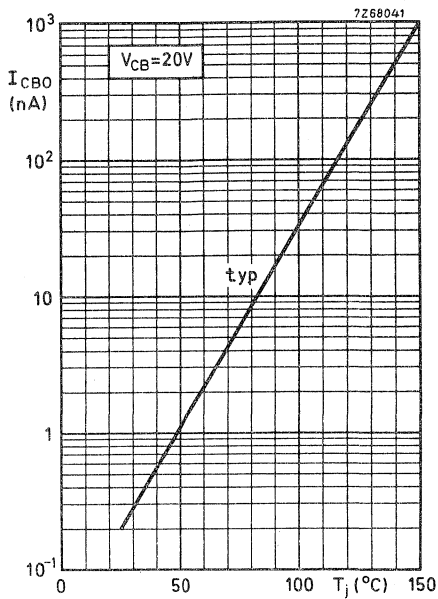


Fig. 12.



## SILICON PLANAR EPITAXIAL TRANSISTORS

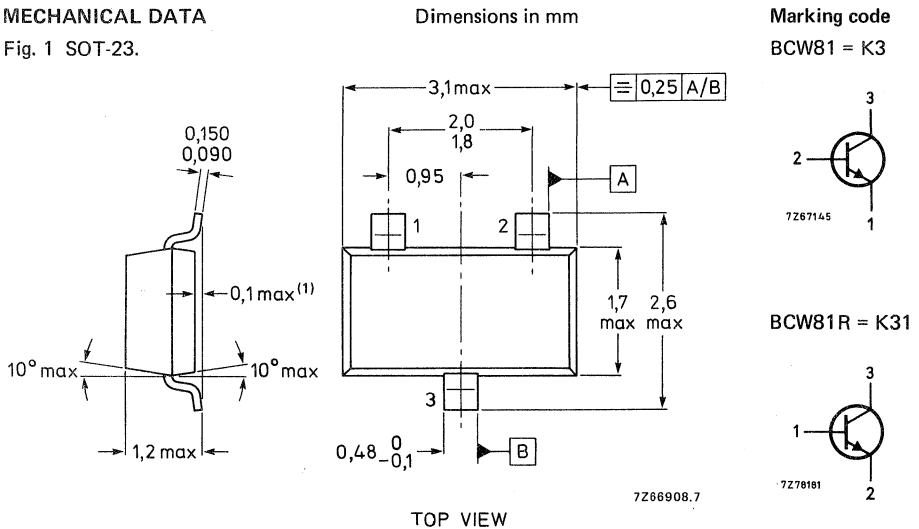
N-P-N transistors, in a microminiature plastic envelope, intended for low level general purpose applications in thick and thin-film circuits.

## QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CBO}$	max.	50 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	45 V
Collector current (peak value)	$I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	350 mW
Junction temperature	$T_j$	max.	175 $^{\circ}\text{C}$
D.C. current gain at $T_j = 25\text{ }^{\circ}\text{C}$ $I_C = 2\text{ mA}$ ; $V_{CE} = 5\text{ V}$	$h_{FE}$	>	420
		<	800
Transition frequency at $f = 35\text{ MHz}$ $I_C = 10\text{ mA}$ ; $V_{CE} = 5\text{ V}$	$f_T$	typ.	300 MHz
Noise figure at $R_S = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}$ ; $V_{CE} = 5\text{ V}$ ; $f = 1\text{ kHz}$ ; $B = 200\text{ Hz}$	F	<	10 dB

## MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 2	$V_{CBO}$	max.	50 V
Collector-emitter voltage (open base) see Fig. 2 $I_C = 2 \text{ mA}$	$V_{CEO}$	max.	45 V
Emitter-base voltage (open collector) see Fig. 2	$V_{EBO}$	max.	5 V
Collector current (d.c.)	$I_C$	max.	100 mA
Collector current (peak value)	$I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-65 to + 175 $^\circ\text{C}$
Junction temperature	$T_j$	max.	175 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P_x (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th j-t}$	=	50 K/W
From tab to soldering points	$R_{th t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25 \text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 20 \text{ V}$   $I_{CBO} < 100 \text{ nA}$

$I_E = 0; V_{CB} = 20 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$   $I_{CBO} < 10 \text{ } \mu\text{A}$

Base emitter voltage

$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$   $V_{BE} \quad 550 \text{ to } 700 \text{ mV}$

Saturation voltages

$I_C = 10 \text{ mA}; I_B = 0,5 \text{ mA}$   $V_{CEsat} \text{ typ. } 120 \text{ mV}$   
 $< 250 \text{ mV}$

$I_C = 50 \text{ mA}; I_B = 2,5 \text{ mA}$   $V_{BEsat} \text{ typ. } 750 \text{ mV}$   
 $V_{CEsat} \text{ typ. } 210 \text{ mV}$   
 $V_{BEsat} \text{ typ. } 850 \text{ mV}$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm

D.C. current gain

$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$

$h_{FE}$	>	420
	<	800

Collector capacitance at  $f = 1 \text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10 \text{ V}$

$C_c$	<	4,0 pF
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Transition frequency at  $f = 35 \text{ MHz}$

$I_C = 10 \text{ mA}; V_{CE} = 5 \text{ V}$

$f_T$	typ.	300 MHz
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Noise figure at  $R_S = 2 \text{ k}\Omega$

$I_C = 200 \mu\text{A}; V_{CE} = 5 \text{ V}$

$f = 1 \text{ kHz}; B = 200 \text{ Hz}$

F	<	10 dB
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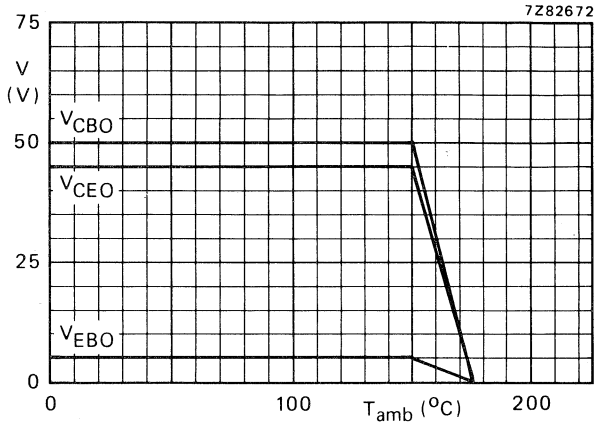


Fig. 2 Voltage derating curves.

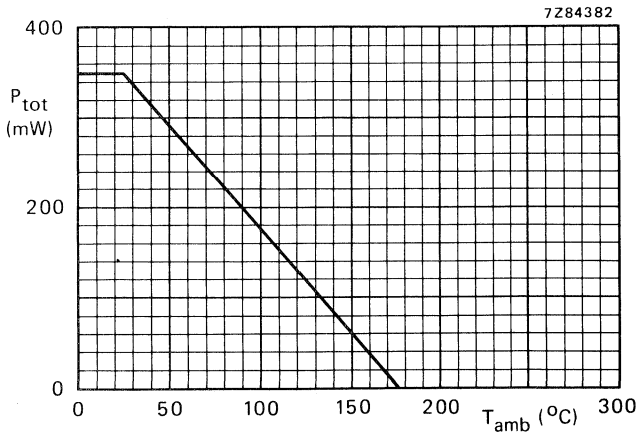


Fig. 3 Power derating curve.



## SILICON PLANAR EPITAXIAL TRANSISTORS

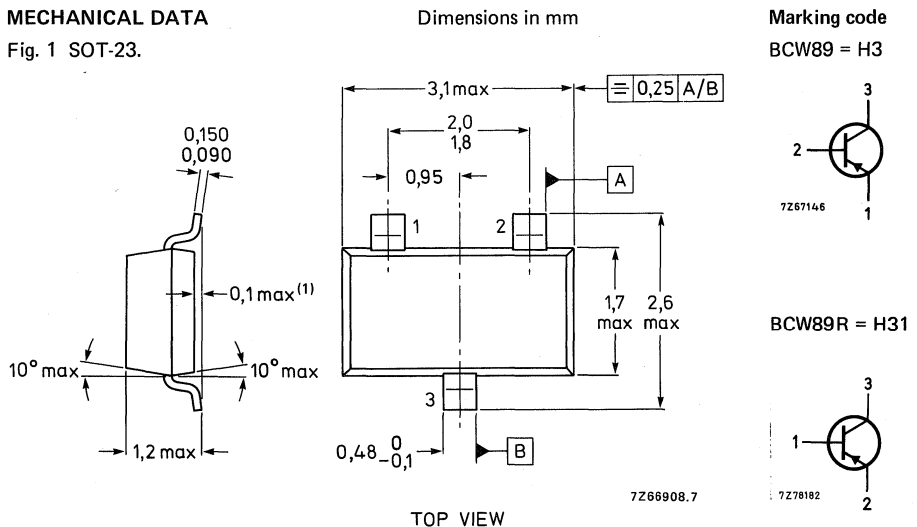
P-N-P transistors, in a microminiature plastic envelope, intended for low level general purpose applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	80 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	60 V
Collector current (peak value)	$-I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	350 mW
Junction temperature	$T_j$	max.	175 $^{\circ}\text{C}$
D.C. current gain at $T_j = 25\text{ }^{\circ}\text{C}$ $-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$	$h_{FE}$	>	120
		<	260
Transition frequency at $f = 35\text{ MHz}$ $-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$	$f_T$	typ.	150 MHz
Noise figure at $R_S = 2\text{ k}\Omega$ $-I_C = 200\text{ }\mu\text{A}; -V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$	F	<	10 dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 2	$-V_{CBO}$	max.	80 V
Collector-emitter voltage ( $V_{BE} = 0$ ) see Fig. 2	$-V_{CES}$	max.	60 V
Collector-emitter voltage (open base) see Fig. 2 $-I_C = 2$ mA	$-V_{CEO}$	max.	60 V
Emitter-base voltage (open collector) see Fig. 2	$-V_{EBO}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	100 mA
Collector current (peak value)	$-I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25$ °C**	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-65 to + 175 °C
Junction temperature	$T_j$	max.	175 °C

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th j-t}$	=	50 K/W
From tab to soldering points	$R_{th t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 20 \text{ V} \quad -I_{CBO} < 100 \text{ nA}$$

$$I_E = 0; -V_{CB} = 20 \text{ V}; T_j = 100 \text{ °C} \quad -I_{CBO} < 10 \text{ } \mu\text{A}$$

Base-emitter voltage

$$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V}; T_j = 25 \text{ °C} \quad -V_{BE} \quad 600 \text{ to } 750 \text{ mV}$$

Saturation voltages

$$-I_C = 10 \text{ mA}; -I_B = 0,5 \text{ mA} \quad -V_{CEsat} \quad \begin{matrix} \text{typ.} & 80 \text{ mV} \\ < & 300 \text{ mV} \end{matrix}$$

$$-I_C = 50 \text{ mA}; -I_B = 2,5 \text{ mA} \quad -V_{BEsat} \quad \text{typ.} \quad 720 \text{ mV}$$

$$-I_C = 50 \text{ mA}; -I_B = 2,5 \text{ mA} \quad -V_{CEsat} \quad \text{typ.} \quad 150 \text{ mV}$$

$$-I_C = 50 \text{ mA}; -I_B = 2,5 \text{ mA} \quad -V_{BEsat} \quad \text{typ.} \quad 810 \text{ mV}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.



D.C. current gain

$-I_C = 10 \mu A; -V_{CE} = 5 V$

$h_{FE}$  typ. 90

$-I_C = 2 mA; -V_{CE} = 5 V$

$h_{FE} > 120$   
 $h_{FE} < 260$

Collector capacitance at  $f = 1 MHz$

$I_E = I_e = 0; -V_{CB} = 10 V$

$C_C < 7,0 pF$

Transition frequency at  $f = 35 MHz$

$-I_C = 10 mA; -V_{CE} = 5 V$

$f_T$  typ. 150 MHz

Noise figure at  $R_G = 2 k\Omega$

$-I_C = 200 \mu A; -V_{CE} = 5 V$

$f = 1 kHz; B = 200 Hz$

$F < 10 dB$

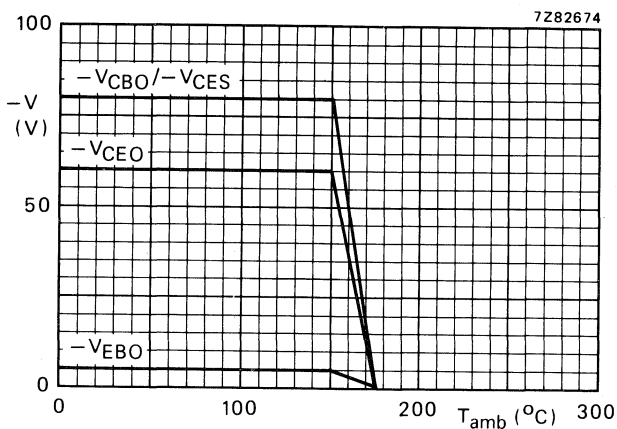


Fig. 2 Voltage derating curves.

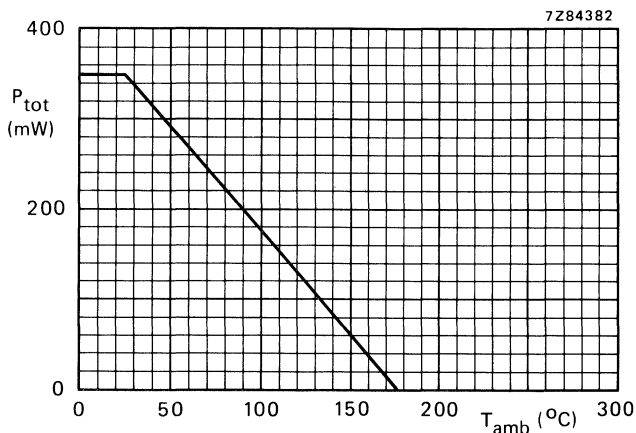


Fig. 3 Power derating curve.



## SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors, in a SOT-23 plastic envelope, intended for application in thick and thin-film circuits. These transistors are intended for general purposes as well as saturated switching and driver applications for industrial service.

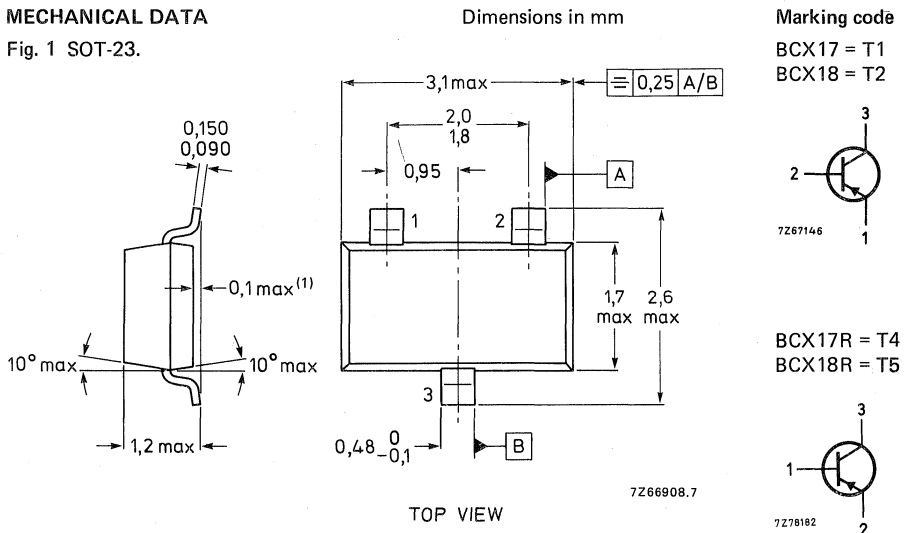
N-P-N complements are BCX19; 19R and BCX20; 20R respectively.

### QUICK REFERENCE DATA

		BCX17 BCX17R	BCX18 BCX18R	
Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$ max.	50	30	V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	45	25	V
Collector current (peak value)	$-I_{CM}$ max.	1000		mA
Total power dissipation up to $T_{amb} = 25^\circ\text{C}$	$P_{tot}$ max.	425		mW
Junction temperature	$T_j$ max.	175		$^\circ\text{C}$
D.C. current gain $-I_C = 100\text{ mA}; -V_{CE} = 1\text{ V}$	$h_{FE}$	100 to 600		
Transition frequency $-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}; f = 35\text{ MHz}$	$f_T$ typ.	100		MHz

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BCX17; R		BCX18; R	
Collector-emitter voltage ( $V_{BE} = 0$ ) (see Fig. 2)	$-V_{CES}$	max.	50	30	V
Collector-emitter voltage (open base) $-I_C = 10$ mA (see Fig. 2)	$-V_{CEO}$	max.	45	25	V
Emitter-base voltage (open collector) (see Fig. 2)	$-V_{EBO}$	max.	5	5	V
Collector current (d.c.)	$-I_C$	max.	500		mA
Collector current (peak value)	$-I_{CM}$	max.	1000		mA
Emitter current (peak value)	$I_{EM}$	max.	1000		mA
Base current (d.c.)	$-I_B$	max.	100		mA
Base current (peak value)	$-I_{BM}$	max.	200		mA
Total power dissipation up to $T_{amb} = 25$ °C*	$P_{tot}$	max.	425		mW
Storage temperature	$T_{stg}$		-65 to + 175		°C
Junction temperature	$T_j$	max.	175		°C

**THERMAL CHARACTERISTICS\*\***

$$T_j = P (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	30	K/W
From tab to soldering points	$R_{th\ t-s}$	=	260	K/W
From soldering points to ambient*	$R_{th\ s-a}$	=	60	K/W

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

Collector cut-off current $I_E = 0; -V_{CB} = 20$ V	$-I_{CBO}$	<	100	nA
$I_E = 0; -V_{CB} = 20$ V; $T_j = 150$ °C	$-I_{CBO}$	<	5	$\mu$ A
Emitter cut-off current $I_C = 0; -V_{EB} = 5$ V	$-I_{EBO}$	<	10	$\mu$ A
Base-emitter voltage $\blacktriangle$ $-I_C = 500$ mA; $-V_{CE} = 1$ V	$-V_{BE}$	<	1,2	V
Saturation voltage $-I_C = 500$ mA; $-I_B = 50$ mA	$-V_{CEsat}$	<	620	mV

\* Mounted on a ceramic substrate of 15 mm x 15 mm x 0,7 mm.

\*\* See *Thermal characteristics*.

$\blacktriangle$   $-V_{BE}$  decreases by about 2 mV/°C with increasing temperature.

D.C. current gain

$-I_C = 100 \text{ mA}; -V_{CE} = 1 \text{ V}$

$-I_C = 300 \text{ mA}; -V_{CE} = 1 \text{ V}$

$-I_C = 500 \text{ mA}; -V_{CE} = 1 \text{ V}$

Transition frequency at  $f = 35 \text{ MHz}$

$-I_C = 10 \text{ mA}; -V_{CE} = 5 \text{ V}$

Collector capacitance at  $f = 1 \text{ MHz}$

$I_E = I_e = 0; -V_{CB} = 10 \text{ V}$

$h_{FE} \quad 100 \text{ to } 600$

$h_{FE} \quad > \quad 70$

$h_{FE} \quad > \quad 40$

$f_T \quad \text{typ.} \quad 100 \text{ MHz}$

$C_c \quad \text{typ.} \quad 8 \text{ pF}$

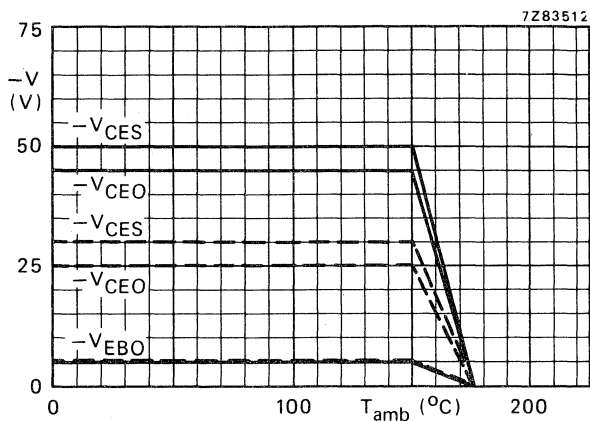


Fig. 2 Voltage derating curves. - - - BCX18; R — BCX17; R.

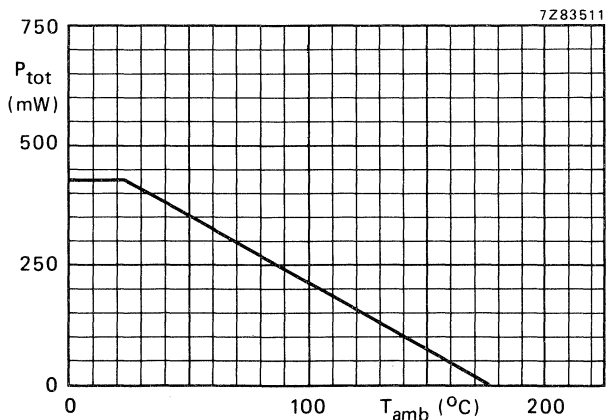


Fig. 3 Power derating curve.

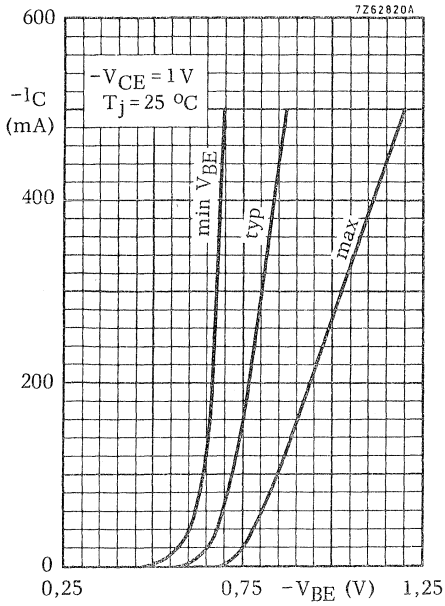


Fig. 4.

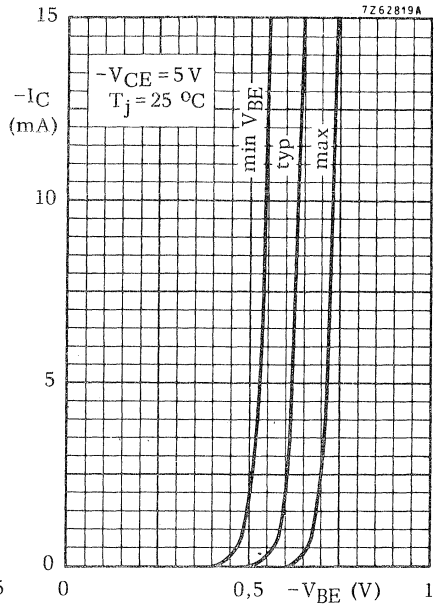


Fig. 5.

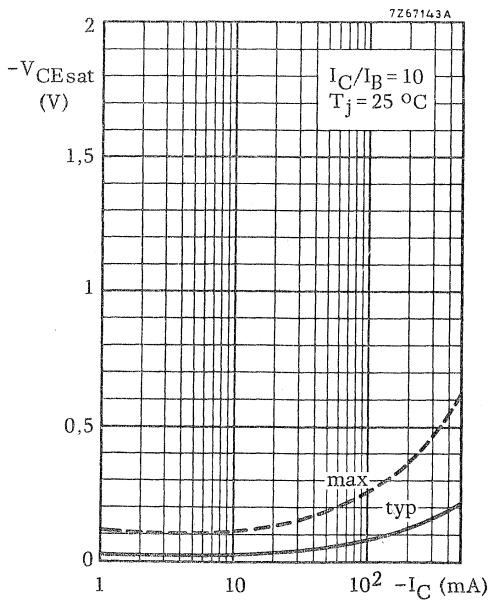


Fig. 6.

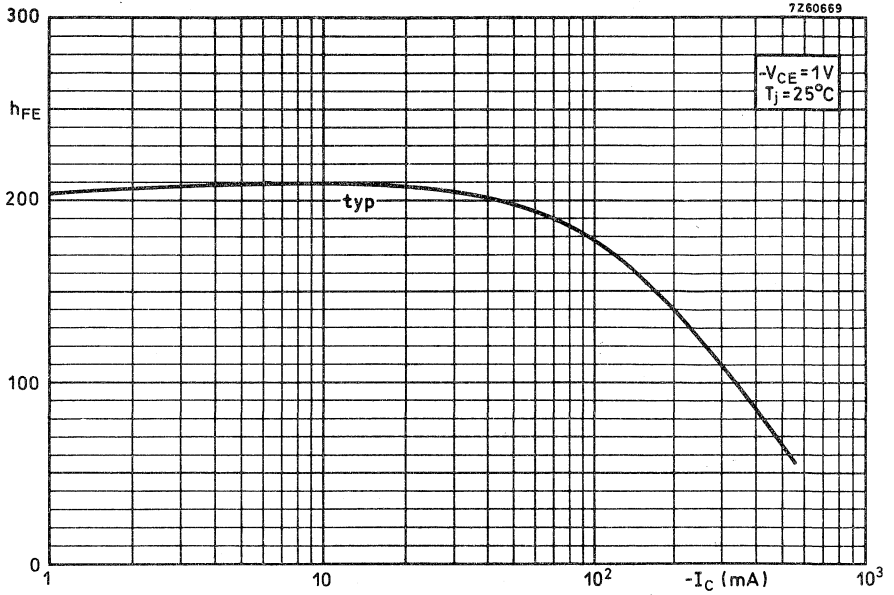


Fig. 7.

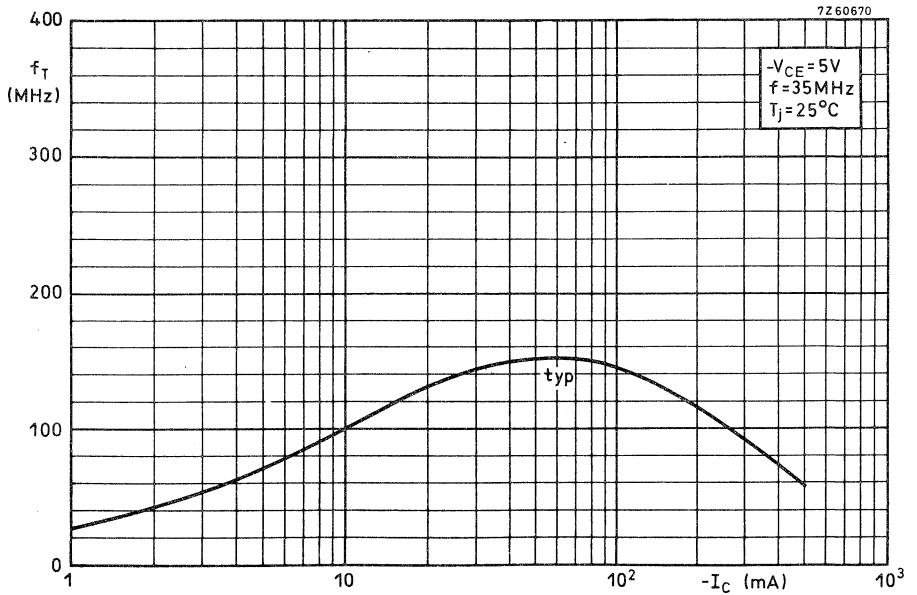


Fig. 8.





## SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors, in a SOT-23 plastic envelope, intended for application in thick and thin-film circuits. These transistors are intended for general purposes as well as saturated switching and driver applications for industrial service.

P-N-P complements are BCX17; 17R and BCX18; 18R respectively.

### QUICK REFERENCE DATA

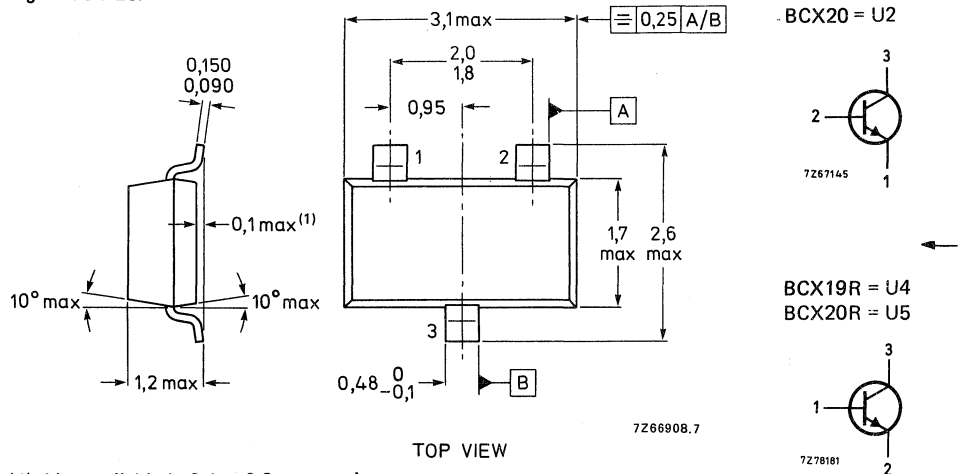
		BCX19; R		BCX20; R	
Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max.	50	30	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	45	25	V
Collector current (peak value)	$I_{CM}$	max.	1000		mA
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	425		mW
Junction temperature	$T_j$	max.	175		$^{\circ}\text{C}$
D.C. current gain $I_C = 100\text{ mA}; V_{CE} = 1\text{ V}$	$h_{FE}$		100 to 600		
Transition frequency $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}; f = 35\text{ MHz}$	$f_T$	typ.	200		MHz

### MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BCX19; R	BCX20; R	
Collector-emitter voltage ( $V_{BE} = 0$ ) (see Fig. 2)	$V_{CES}$ max.	50	30	V
Collector-emitter voltage (open base) $I_C = 10$ mA (see Fig. 2)	$V_{CEO}$ max.	45	25	V
Emitter-base voltage (open collector) (see Fig. 2)	$V_{EBO}$ max.	5	5	V
Collector current (d.c.)	$I_C$ max.	500		mA
Collector current (peak value)	$I_{CM}$ max.	1000		mA
Emitter current (peak value)	$-I_{EM}$ max.	1000		mA
Base current (d.c.)	$I_B$ max.	100		mA
Base current (peak value)	$I_{BM}$ max.	200		mA
Total power dissipation up to $T_{amb} = 25$ °C*	$P_{tot}$ max.	425		mW
Storage temperature	$T_{stg}$	-65 to + 175		°C
Junction temperature	$T_j$ max.	175		°C

**THERMAL CHARACTERISTICS\*\***

$$T_j = P (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$ =	30	K/W
From tab to soldering points	$R_{th\ t-s}$ =	260	K/W
From soldering points to ambient*	$R_{th\ s-a}$ =	60	K/W

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

Collector cut-off current $I_E = 0; V_{CB} = 20$ V	$I_{CBO}$ <	100	nA
$I_E = 0; V_{CB} = 20$ V; $T_j = 150$ °C	$I_{CBO}$ <	5	$\mu$ A
Emitter cut-off current $I_C = 0; V_{EB} = 5$ V	$I_{EBO}$ <	10	$\mu$ A
Base emitter voltage $\blacktriangle$ $I_C = 500$ mA; $V_{CE} = 1$ V	$V_{BE}$ <	1,2	V
Saturation voltage $I_C = 500$ mA; $I_B = 50$ mA	$V_{CEsat}$ <	620	mV

\* Mounted on a ceramic substrate of 15 mm x 15 mm x 0,7 mm.

\*\* See *Thermal characteristics*.

$\blacktriangle$   $V_{BE}$  decreases by about 2 mV/°C with increasing temperature.

D.C. current gain

$I_C = 100 \text{ mA}; V_{CE} = 1 \text{ V}$

$I_C = 300 \text{ mA}; V_{CE} = 1 \text{ V}$

$I_C = 500 \text{ mA}; V_{CE} = 1 \text{ V}$

Transition frequency at  $f = 35 \text{ MHz}$

$I_C = 10 \text{ mA}; V_{CE} = 5 \text{ V}$

Collector capacitance at  $f = 1 \text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10 \text{ V}$

$h_{FE} \quad 100 \text{ to } 600$

$h_{FE} \quad > \quad 70$

$h_{FE} \quad > \quad 40$

$f_T \quad \text{typ.} \quad 200 \text{ MHz}$

$C_c \quad \text{typ.} \quad 5 \text{ pF}$

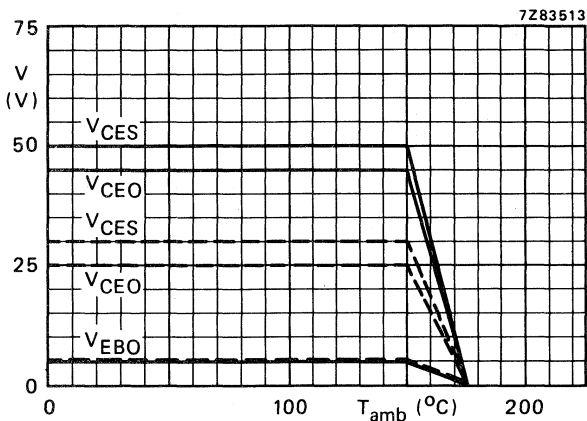


Fig. 2 Voltage derating curves. - - - BCX19; R/BCX20; R ——— .

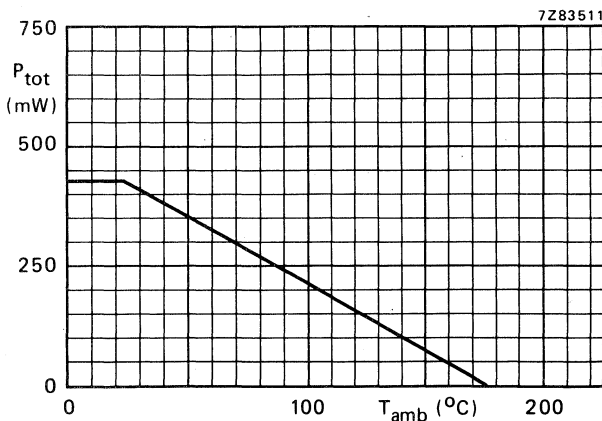


Fig. 3 Power derating curve.

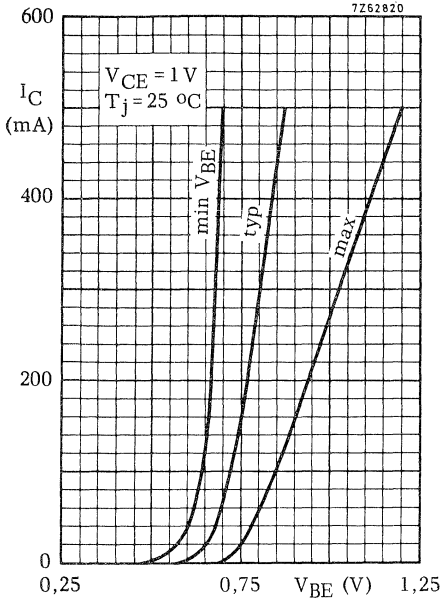


Fig. 4.

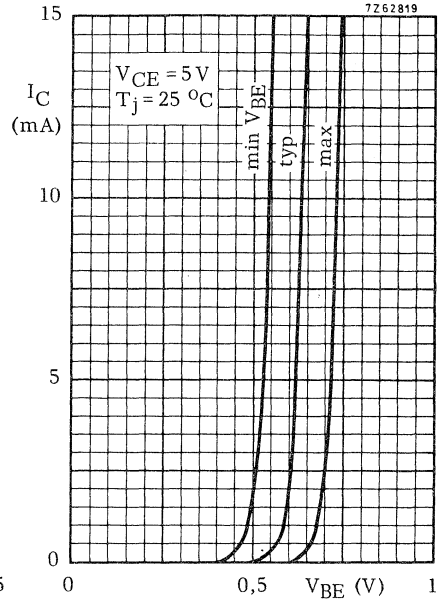


Fig. 5.

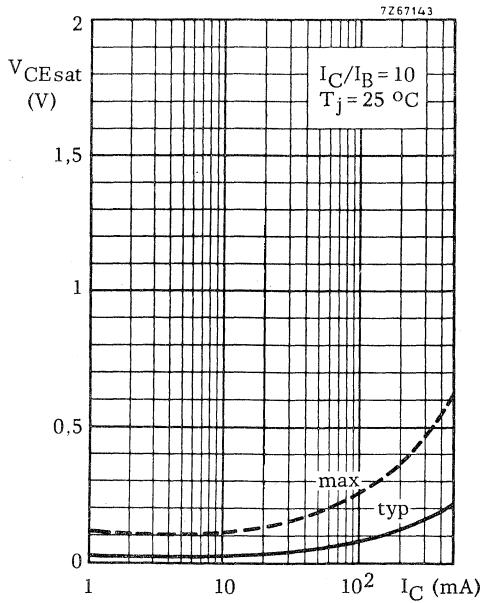


Fig. 6.

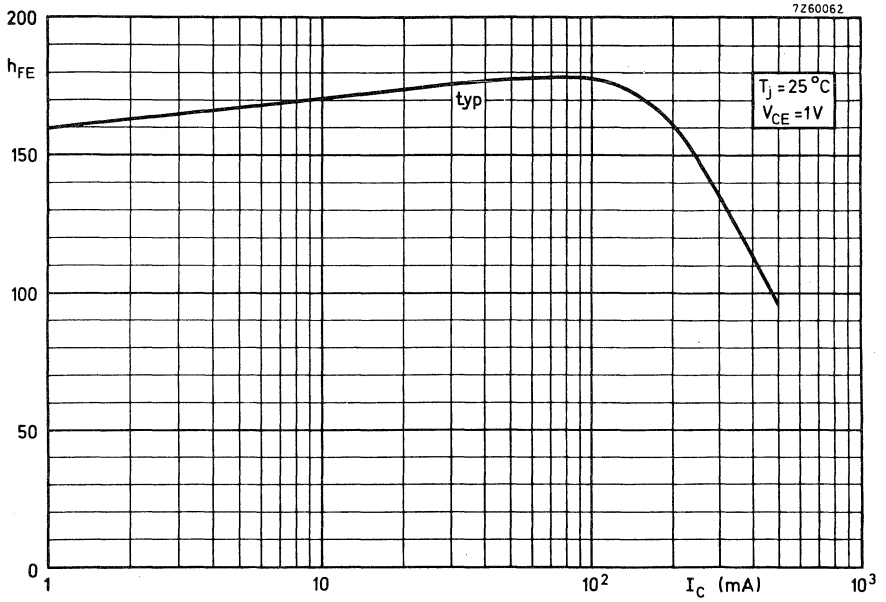


Fig. 7.

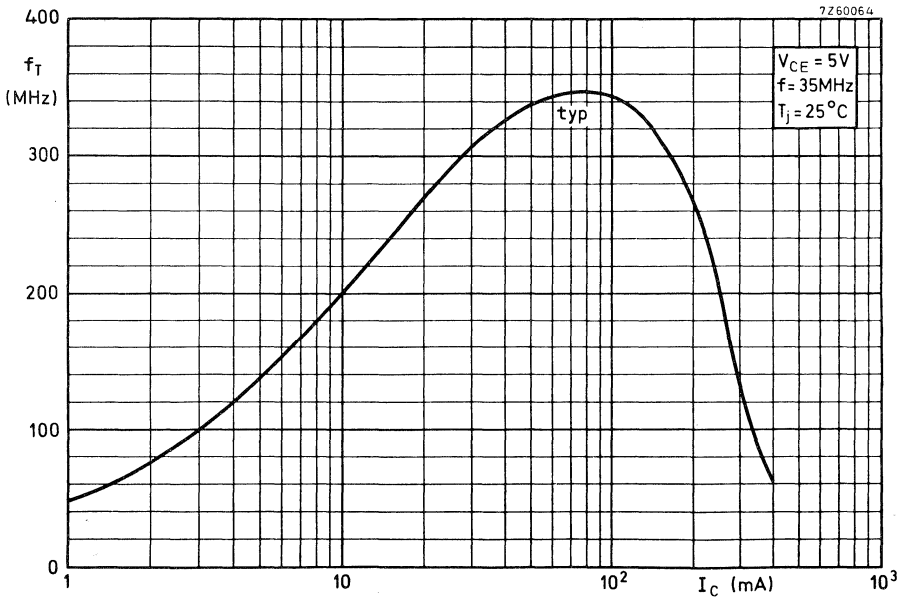


Fig. 8.



## SILICON PLANAR EPITAXIAL TRANSISTORS

Medium power p-n-p transistors in a miniature plastic envelope intended for applications in thick and thin-film circuits. These transistors are intended for general purposes as well as for use in driver stages of audio amplifiers.

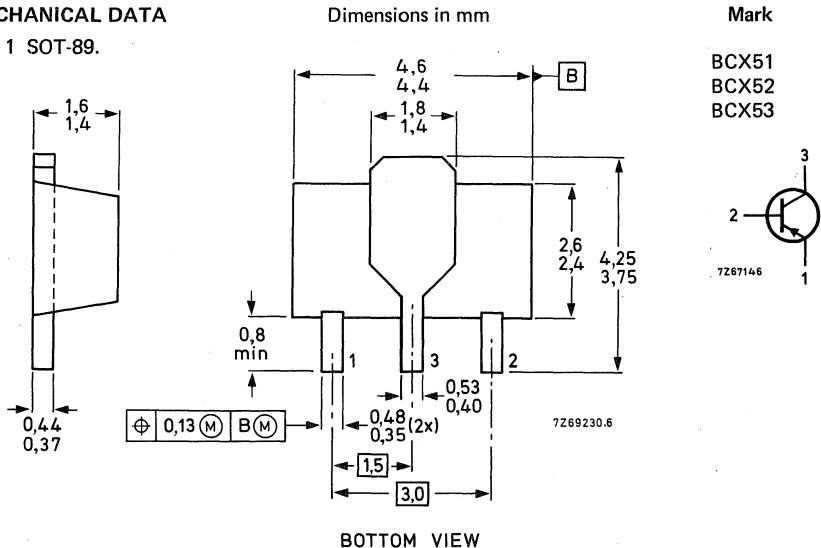
N-P-N complements are BCX54, BCX55 and BCX56 respectively.

### QUICK REFERENCE DATA

		BCX51	BCX52	BCX53
Collector-base voltage (open emitter)	$-V_{CBO}$ max.	45	60	100 V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	45	60	80 V
Collector-emitter voltage ( $R_{BE} = 1 \text{ k}\Omega$ )	$-V_{CER}$ max.	45	60	100 V
Collector current (peak value)	$-I_{CM}$ max.		1,5	A
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$	$P_{tot}$ max.		1	W
Junction temperature	$T_j$ max.		150	$^\circ\text{C}$
D.C. current gain	$h_{FE}$		40 to 250	
$-I_C = 150 \text{ mA}; -V_{CE} = 2 \text{ V}$				
Transition frequency at $f = 35 \text{ MHz}$	$f_T$ typ.		50	MHz
$-I_C = 10 \text{ mA}; -V_{CE} = 5 \text{ V}$				

### MECHANICAL DATA

Fig. 1 SOT-89.



See also *Soldering recommendations.*

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BCX51	BCX52	BCX53
Collector-base voltage (open emitter)	$-V_{CBO}$	max. 45	60	100 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max. 45	60	80 V
Collector-emitter voltage ( $R_{BE} = 1 \text{ k}\Omega$ )	$-V_{CER}$	max. 45	60	100 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max. 5	5	5 V
Collector current (d.c.)	$-I_C$	max.	1,0	A
Collector current (peak value)	$-I_{CM}$	max.	1,5	A
Base current (d.c.)	$-I_B$	max.	0,1	A
Base current (peak value)	$-I_{BM}$	max.	0,2	A
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ mounted on a ceramic substrate area = 2,5 cm <sup>2</sup> ; thickness = 0,7 mm	$P_{tot}$	max.	1,0	W
Storage temperature	$T_{stg}$		-65 to +150	$^\circ\text{C}$
Junction temperature	$T_j$	max.	150	$^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to collector tab	$R_{th \text{ j-tab}}$	=	10	K/W
From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm <sup>2</sup> ; thickness = 0,7 mm	$R_{th \text{ j-a}}$	=	125	K/W

**CHARACTERISTICS**

$T_{amb} = 25 \text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current $I_E = 0$ ; $-V_{CB} = 30 \text{ V}$	$-I_{CBO}$	<	100	nA
$I_E = 0$ ; $-V_{CB} = 30 \text{ V}$ ; $T_j = 125 \text{ }^\circ\text{C}$	$-I_{CBO}$	<	10	$\mu\text{A}$
Emitter cut-off current $I_C = 0$ ; $-V_{EB} = 5 \text{ V}$	$-I_{EBO}$	<	10	$\mu\text{A}$
Base-emitter voltage $-I_C = 500 \text{ mA}$ ; $-V_{CE} = 2 \text{ V}$	$-V_{BE}$	<	1	V
Saturation voltage $-I_C = 500 \text{ mA}$ ; $-I_B = 50 \text{ mA}$	$-V_{CEsat}$	<	0,5	V
D.C. current gain $-I_C = 5 \text{ mA}$ ; $-V_{CE} = 2 \text{ V}$	$h_{FE}$	>	25	
$-I_C = 150 \text{ mA}$ ; $-V_{CE} = 2 \text{ V}$	$h_{FE}$		40 to 250	
$-I_C = 500 \text{ mA}$ ; $-V_{CE} = 2 \text{ V}$	$h_{FE}$	>	25	
Transition frequency at $f = 35 \text{ MHz}$ $-I_C = 10 \text{ mA}$ ; $-V_{CE} = 5 \text{ V}$	$f_T$	typ.	50	MHz



CHARACTERISTICS (continued)

	BCX51-6	BCX51-10	BCX51-16
	52-6	52-10	52-16
	53-6	53-10	53-16
D.C. current gain			
$-I_C = 150 \text{ mA}; -V_{CE} = 2 \text{ V}$			
$h_{FE} >$	40	63	100
$h_{FE} <$	100	160	250

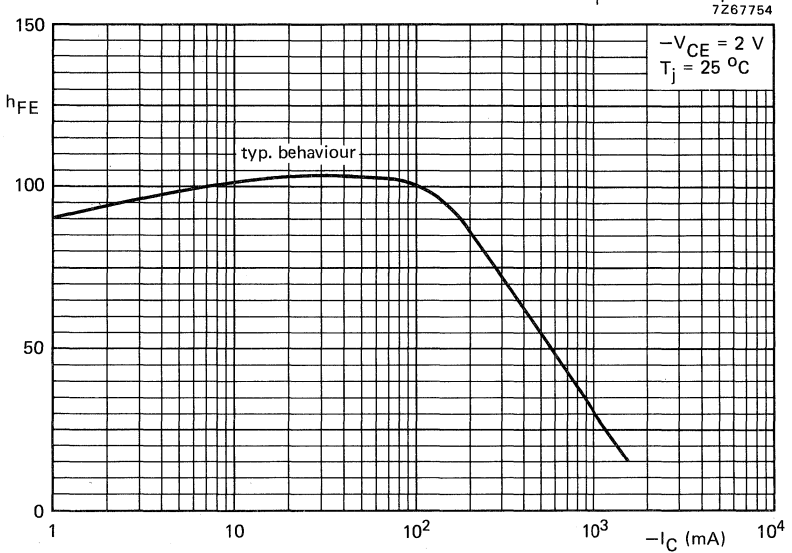


Fig. 2.

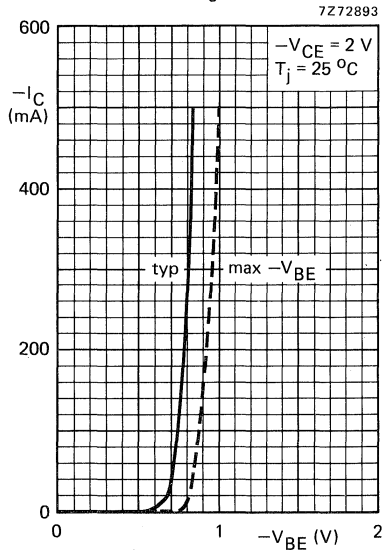


Fig. 3.

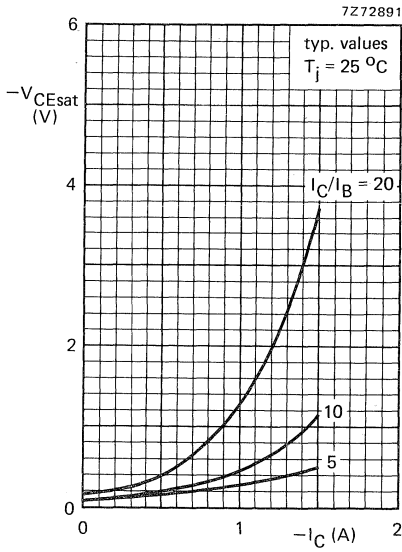


Fig. 4.

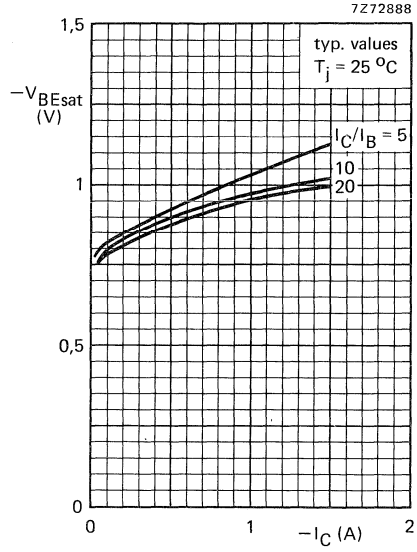


Fig. 5.

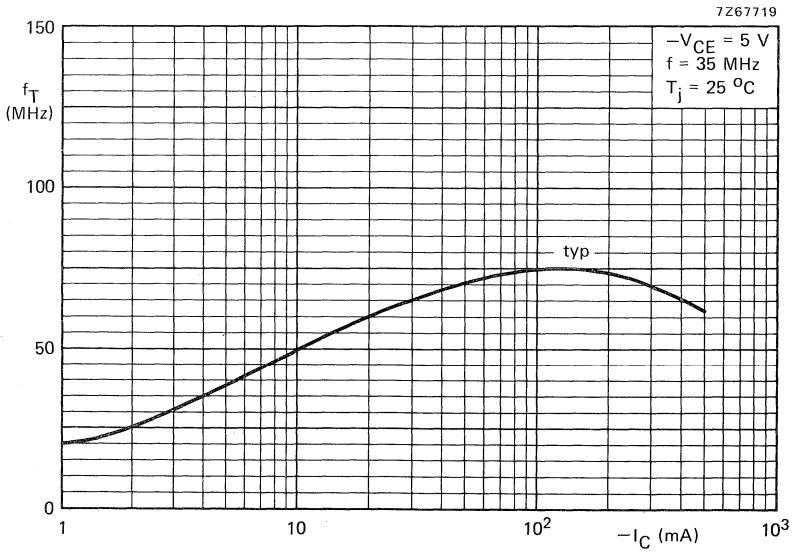


Fig. 6.

## SILICON PLANAR EPITAXIAL TRANSISTORS

Medium power n-p-n transistors in a miniature plastic envelope intended for applications in thick and thin-film circuits. These transistors are intended for general purposes as well as for use in driver stages of audio amplifiers.

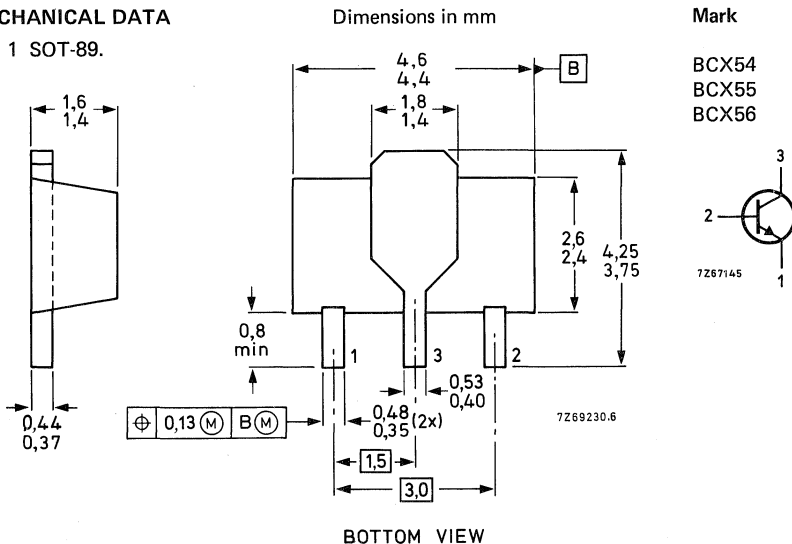
P-N-P complements are BCX51, BCX52 and BCX53 respectively.

### QUICK REFERENCE DATA

	BCX54	BCX55	BCX56	
Collector-base voltage (open emitter)	$V_{CBO}$ max.	45	60	100 V
Collector-emitter voltage (open base)	$V_{CEO}$ max.	45	60	80 V
Collector-emitter voltage ( $R_{BE} = 1 \text{ k}\Omega$ )	$V_{CER}$ max.	45	60	100 V
Collector current (peak value)	$I_{CM}$ max.		1,5	A
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$	$P_{tot}$ max.		1	W
Junction temperature	$T_j$ max.		150	$^\circ\text{C}$
D.C. current gain $I_C = 150 \text{ mA}; V_{CE} = 2 \text{ V}$	$h_{FE}$		40 to 250	
Transition frequency at $f = 35 \text{ MHz}$ $I_C = 10 \text{ mA}; V_{CE} = 5 \text{ V}$	$f_T$ typ.		130	MHz

### MECHANICAL DATA

Fig. 1 SOT-89.



See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BCX54	BCX55	BCX56
Collector-base voltage (open emitter)	$V_{CBO}$	max. 45	60	100 V
Collector-emitter voltage (open base)	$V_{CEO}$	max. 45	60	80 V
Collector-emitter voltage ( $R_{BE} = 1 \text{ k}\Omega$ )	$V_{CER}$	max. 45	60	100 V
Emitter-base voltage (open collector)	$V_{EBO}$	max. 5	5	5 V
Collector current (d.c.)	$I_C$	max.	1,0	A
Collector current (peak value)	$I_{CM}$	max.	1,5	A
Base current (d.c.)	$I_B$	max.	0,1	A
Base current (peak value)	$I_{BM}$	max.	0,2	A
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ mounted on a ceramic substrate area = 2,5 cm <sup>2</sup> ; thickness = 0,7 mm	$P_{tot}$	max.	1,0	W
Storage temperature	$T_{stg}$		-65 to +150	$^\circ\text{C}$
Junction temperature	$T_j$	max.	150	$^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to collector tab	$R_{th \text{ j-tab}}$	=	10	K/W
From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm <sup>2</sup> ; thickness = 0,7 mm	$R_{th \text{ j-a}}$	=	125	K/W

**CHARACTERISTICS**

$T_{amb} = 25 \text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current $I_E = 0; V_{CB} = 30 \text{ V}$	$I_{CBO}$	<	100	nA
$I_E = 0; V_{CB} = 30 \text{ V}; T_j = 125 \text{ }^\circ\text{C}$	$I_{CBO}$	<	10	$\mu\text{A}$
Emitter cut-off current $I_C = 0; V_{EB} = 5 \text{ V}$	$I_{EBO}$	<	10	$\mu\text{A}$
Base-emitter voltage $I_C = 500 \text{ mA}; V_{CE} = 2 \text{ V}$	$V_{BE}$	<	1	V
Saturation voltage $I_C = 500 \text{ mA}; I_B = 50 \text{ mA}$	$V_{CEsat}$	<	0,5	V
D.C. current gain $I_C = 5 \text{ mA}; V_{CE} = 2 \text{ V}$	$h_{FE}$	>	25	
$I_C = 150 \text{ mA}; V_{CE} = 2 \text{ V}$	$h_{FE}$		40 to 250	
$I_C = 500 \text{ mA}; V_{CE} = 2 \text{ V}$	$h_{FE}$	>	25	
Transition frequency at $f = 35 \text{ MHz}$ $I_C = 10 \text{ mA}; V_{CE} = 5 \text{ V}$	$f_T$	typ.	130	MHz

CHARACTERISTICS (continued)

D.C. current gain

$I_C = 150 \text{ mA}; V_{CE} = 2 \text{ V}$

	BCX54-6 55-6 56-6	BCX54-10 55-10 56-10	BCX54-16 55-16 56-16
$h_{FE} >$	40	63	100
$h_{FE} <$	100	160	250

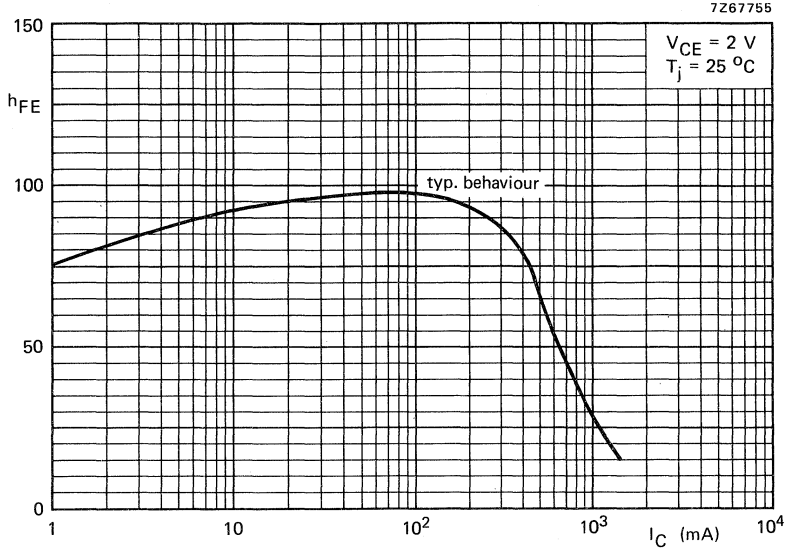


Fig. 2.

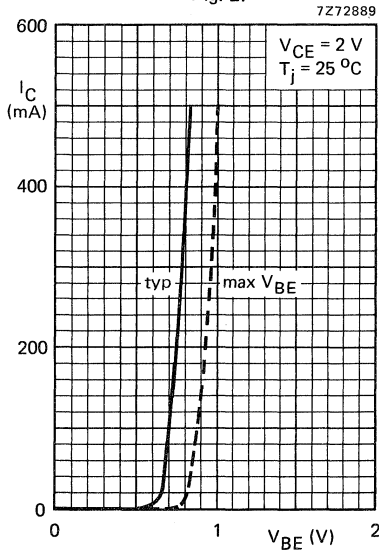


Fig. 3.

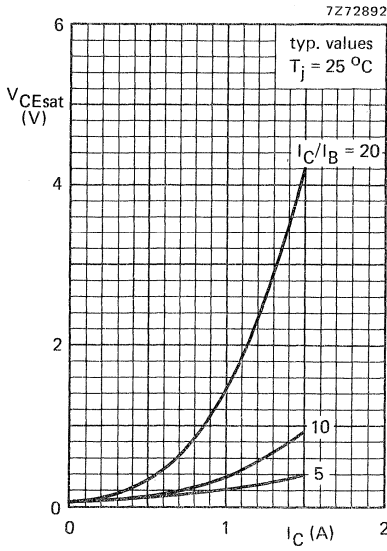


Fig. 4.

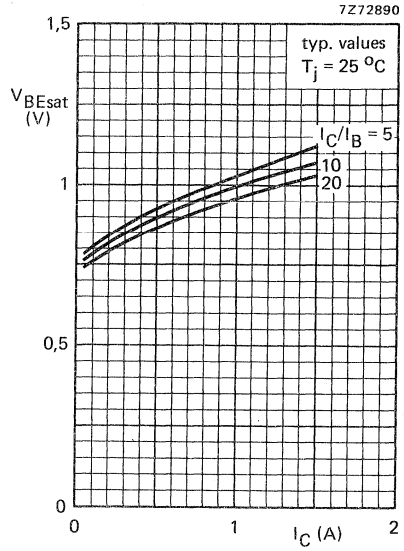


Fig. 5.

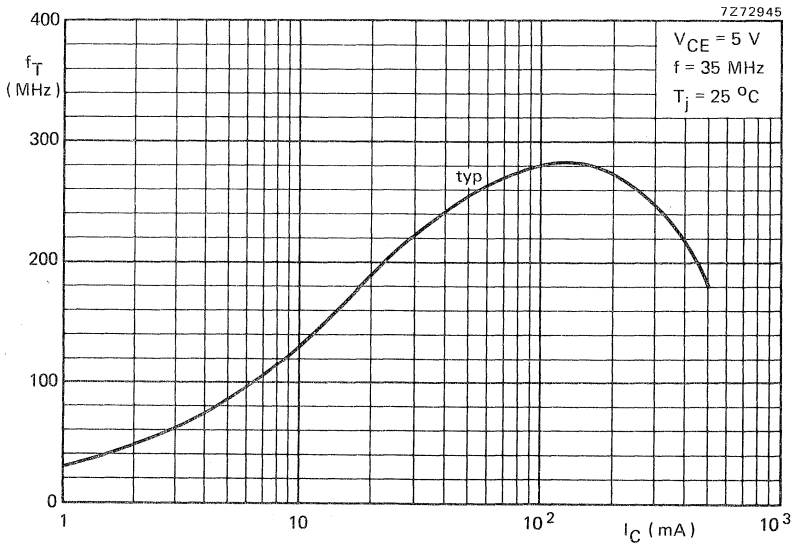


Fig. 6.

## SILICON PLANAR EPITAXIAL TRANSISTOR

N-P-N transistor in a microminiature plastic envelope intended for low-voltage, high-current l.f. applications. BCX68/BCX69 is the matched complementary pair suitable for class-B audio output stages up to 3 W.

## QUICK REFERENCE DATA

Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max.	25 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	20 V
Collector current (peak value)	$I_{CM}$	max.	2 A
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	1 W
Junction temperature	$T_j$	max.	150 $^{\circ}\text{C}$
D.C. current gain	$h_{FE}$		85 to 375
$I_C = 500\text{ mA}$ ; $V_{CE} = 1\text{ V}$			
Transition frequency at $f = 35\text{ MHz}$	$f_T$	typ.	60 MHz
$I_C = 10\text{ mA}$ ; $V_{CE} = 5\text{ V}$			

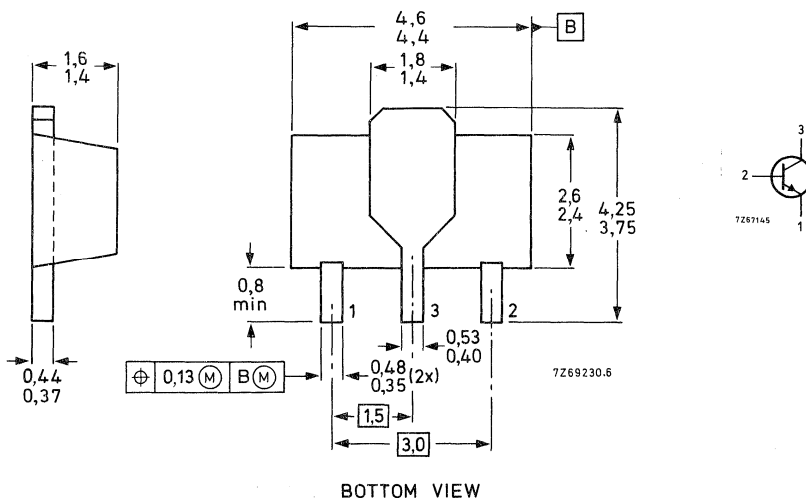
## MECHANICAL DATA

Dimensions in mm

Mark

Fig. 1 SOT-89.

BCX68



See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max.	25 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	20 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	5 V
Collector current (d.c.)	$I_C$	max.	1 A
Collector current (peak value)	$I_{CM}$	max.	2 A
Base current (d.c.)	$I_B$	max.	100 mA
Base current (peak value)	$I_{BM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}^*$	$P_{tot}$	max.	1 W
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air*	$R_{th\ j-a}$	=	125 K/W
From junction to tab	$R_{th\ j-t}$	=	10 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current $I_E = 0; V_{CB} = 25\text{ V}$	$I_{CBO}$	<	10 $\mu\text{A}$
$I_E = 0; V_{CB} = 25\text{ V}; T_j = 150\text{ }^\circ\text{C}$	$I_{CBO}$	<	1 mA
Emitter cut-off current $I_C = 0; V_{EB} = 5\text{ V}$	$I_{EBO}$	<	10 $\mu\text{A}$
Base-emitter voltage $I_C = 5\text{ mA}; V_{CE} = 10\text{ V}$	$V_{BE}$	typ.	0,62 V
$I_C = 1\text{ A}; V_{CE} = 1\text{ V}$	$V_{BE}$	<	1 V
Collector-emitter saturation voltage $I_C = 1\text{ A}; I_B = 100\text{ mA}$	$V_{CEsat}$	<	0,5 V
D.C. current gain $I_C = 5\text{ mA}; V_{CE} = 10\text{ V}$	$h_{FE}$	>	50
$I_C = 500\text{ mA}; V_{CE} = 1\text{ V}$	$h_{FE}$		85 to 375
$I_C = 1\text{ A}; V_{CE} = 1\text{ V}$	$h_{FE}$	>	60
Collector capacitance at $f = 450\text{ kHz}$ $I_E = I_e = 0; V_{CB} = 5\text{ V}$	$C_c$	typ.	27 pF
Cut-off frequency $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$	$f_{hfe}$	typ.	400 kHz
Transition frequency at $f = 35\text{ MHz}$ $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$	$f_T$	typ.	60 MHz
D.C. current gain ratio of matched pair BCX68/BCX69 $ I_C  = 500\text{ mA};  V_{CE}  = 1\text{ V}$	$h_{FE1}/h_{FE2}$	<	1,4

\* Mounted on a ceramic substrate, area = 2,5 cm<sup>2</sup>, thickness = 0,7 mm.



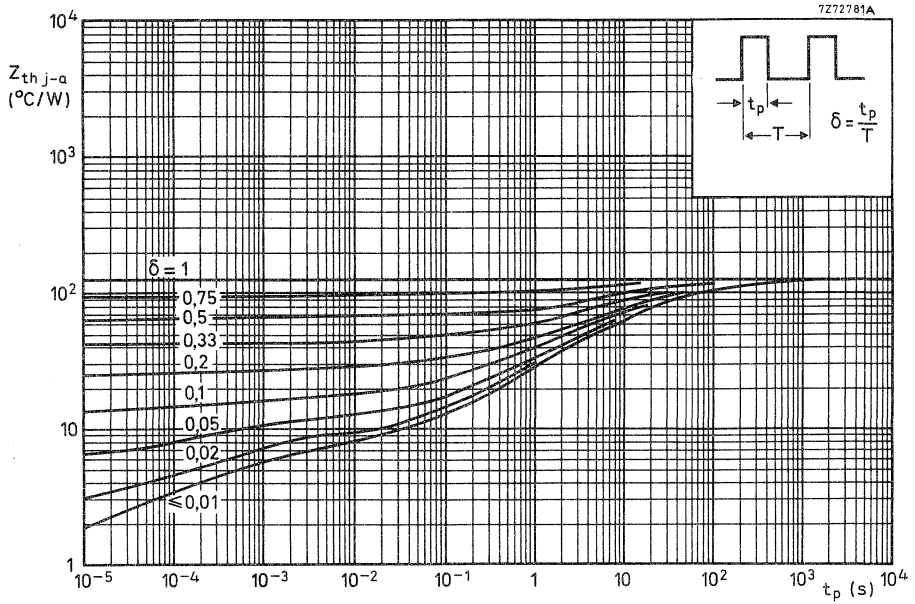


Fig. 2 Pulse power rating chart.

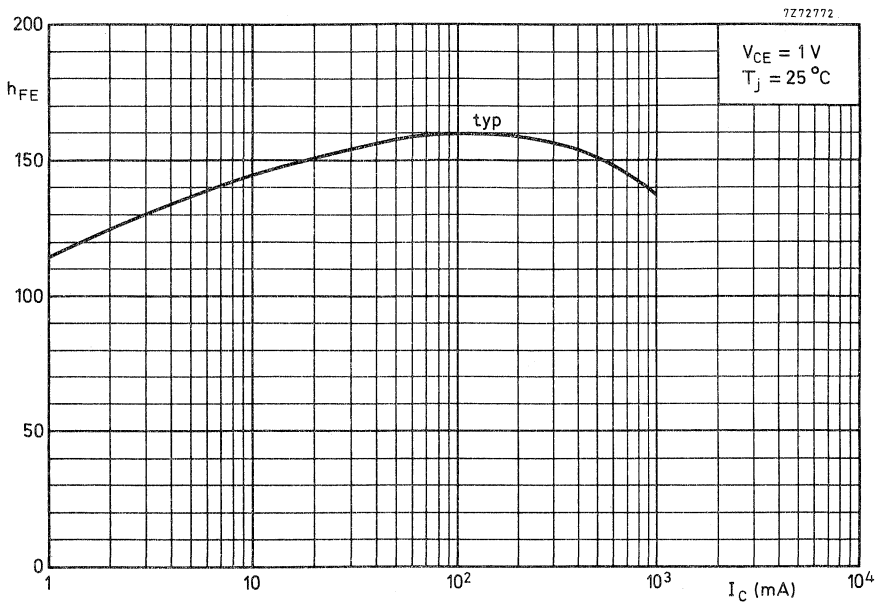


Fig. 3 D.C. current gain.

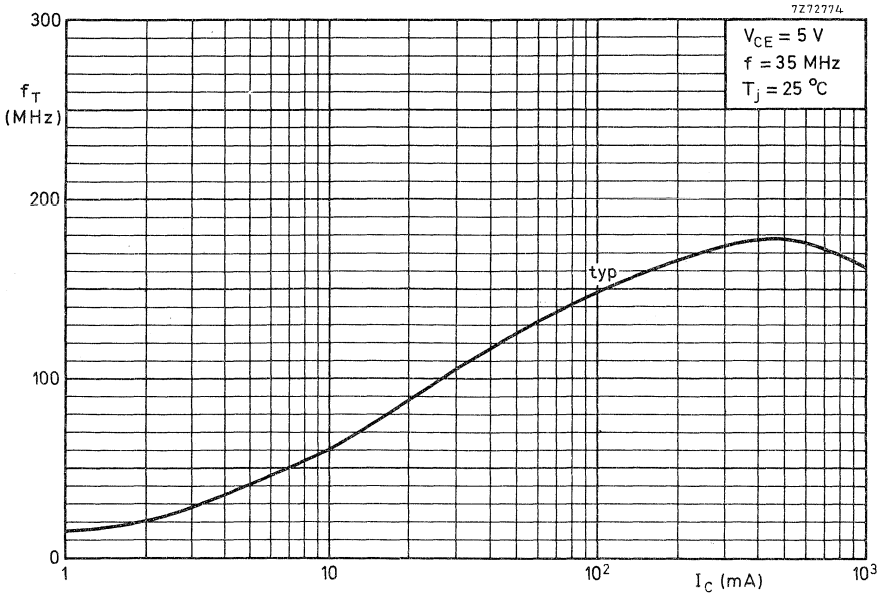


Fig. 4 Typical values transition frequency as a function of collector current.

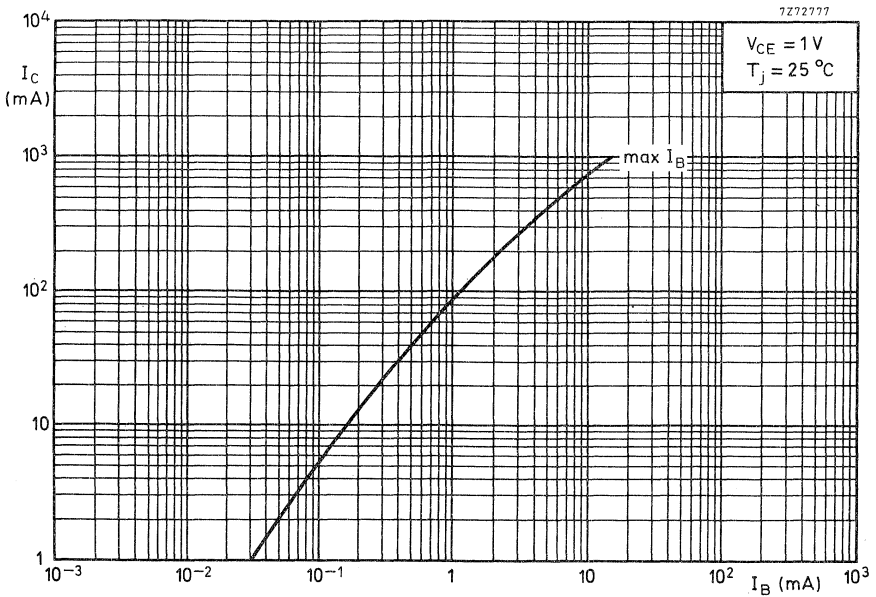


Fig. 5 Typical values collector current as a function of maximum base current.

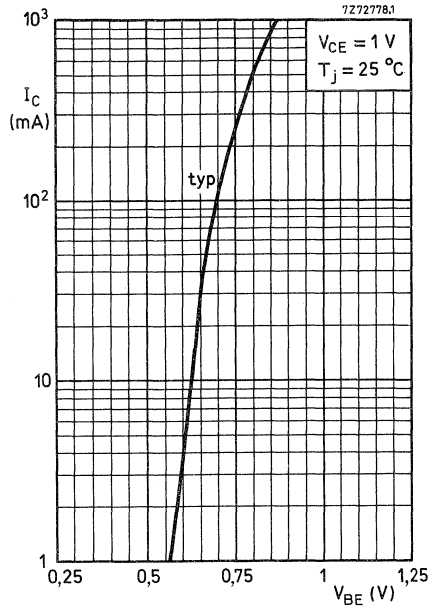


Fig. 6 Typical values collector current as a function of base-emitter voltage.

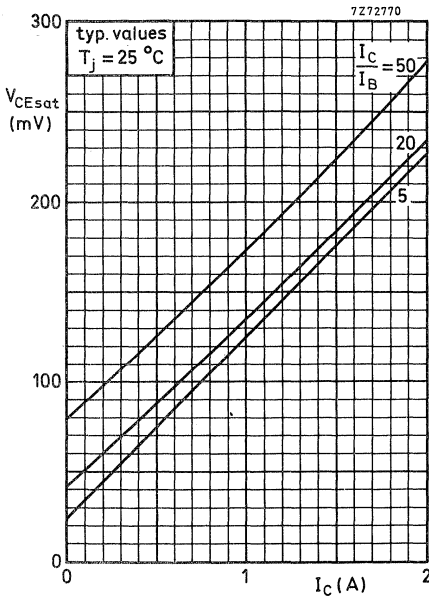


Fig. 7 Collector-emitter saturation voltage as a function of collector current.

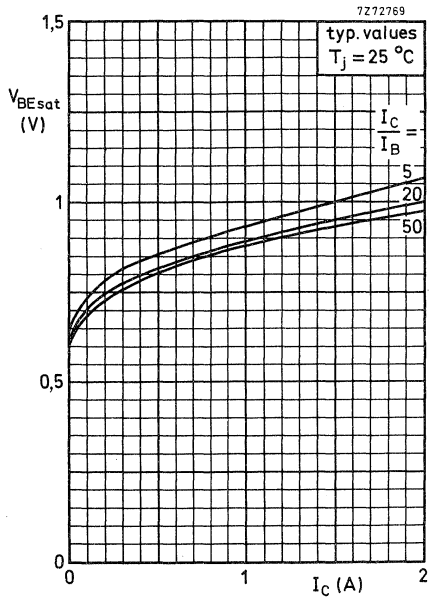


Fig. 8 Base-emitter saturation voltage as a function of collector current.



## SILICON PLANAR EPITAXIAL TRANSISTOR

P-N-P transistor in a plastic microminiature envelope, intended for low-voltage, high-current I.f. applications. BCX68/BCX69 is the matched complementary pair suitable for class-B audio output stages up to 3 W.

## QUICK REFERENCE DATA

Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$ max.	25 V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	20 V
Collector current (peak value)	$-I_{CM}$ max.	2 A
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$P_{tot}$ max.	1 W
Junction temperature	$T_j$ max.	150 $^{\circ}\text{C}$
D.C. current gain	$h_{FE}$	85 to 375
$-I_C = 500\text{ mA}; -V_{CE} = 1\text{ V}$		
Transition frequency at $f = 35\text{ MHz}$	$f_T$ typ.	60 MHz
$-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$		

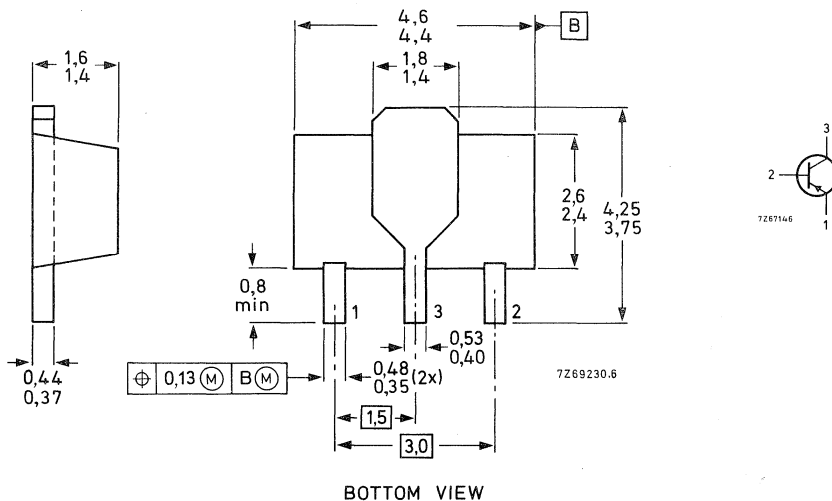
## MECHANICAL DATA

Dimensions in mm

Mark

Fig. 1 SOT-89.

BCX69



See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$	max.	25 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	20 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	1 A
Collector current (peak value)	$-I_{CM}$	max.	2 A
Base current (d.c.)	$-I_B$	max.	100 mA
Base current (peak value)	$-I_{BM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}^*$	$P_{tot}$	max.	1 W
Storage temperature	$T_{stg}$		$-65$ to $+150\text{ }^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air*	$R_{th\ j-a}$	=	125 K/W
From junction to tab	$R_{th\ j-t}$	=	10 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_E = 0; -V_{CB} = 25\text{ V}$

$-I_{CBO} < 10\text{ }\mu\text{A}$

$I_E = 0; -V_{CB} = 25\text{ V}; T_j = 150\text{ }^\circ\text{C}$

$-I_{CBO} < 1\text{ mA}$

Emitter cut-off current

$I_C = 0; -V_{EB} = 5\text{ V}$

$-I_{EBO} < 10\text{ }\mu\text{A}$

Base-emitter voltage

$-I_C = 5\text{ mA}; -V_{CE} = 10\text{ V}$

$-V_{BE}$  typ. 0,62 V

$-I_C = 1\text{ A}; -V_{CE} = 1\text{ V}$

$-V_{BE} < 1\text{ V}$

Collector-emitter saturation voltage

$-I_C = 1\text{ A}; -I_B = 100\text{ mA}$

$-V_{CEsat} < 0,5\text{ V}$

D.C. current gain

$-I_C = 5\text{ mA}; -V_{CE} = 10\text{ V}$

$h_{FE} > 50$

$-I_C = 500\text{ mA}; -V_{CE} = 1\text{ V}$

$h_{FE}$  85 to 375

$-I_C = 1\text{ A}; -V_{CE} = 1\text{ V}$

$h_{FE} > 60$

Collector capacitance at  $f = 450\text{ kHz}$

$I_E = I_e = 0; -V_{CB} = 5\text{ V}$

$C_c$  typ. 45 pF

Cut-off frequency

$-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$

$f_{hfe}$  typ. 350 kHz

Transition frequency at  $f = 35\text{ MHz}$

$-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$

$f_T$  typ. 60 MHz

D.C. current gain ratio of matched pair BCX68/BXC69

$|I_C| = 500\text{ mA}; |V_{CE}| = 1\text{ V}$

$h_{FE1}/h_{FE2} < 1,4$

\* Mounted on a ceramic substrate, area = 2,5 cm<sup>2</sup>; thickness = 0,7 mm.

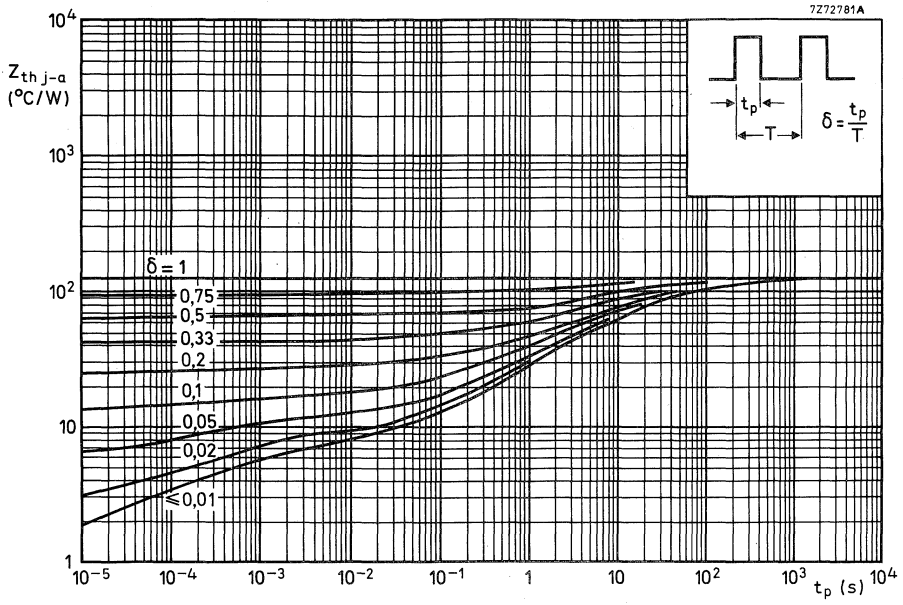


Fig. 2 Pulse power rating chart.

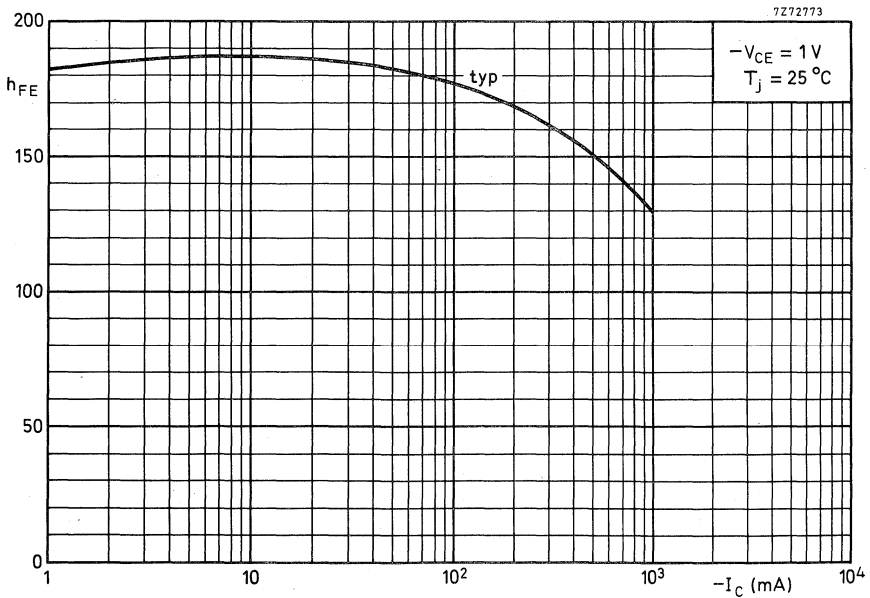


Fig. 3 D.C. current gain.

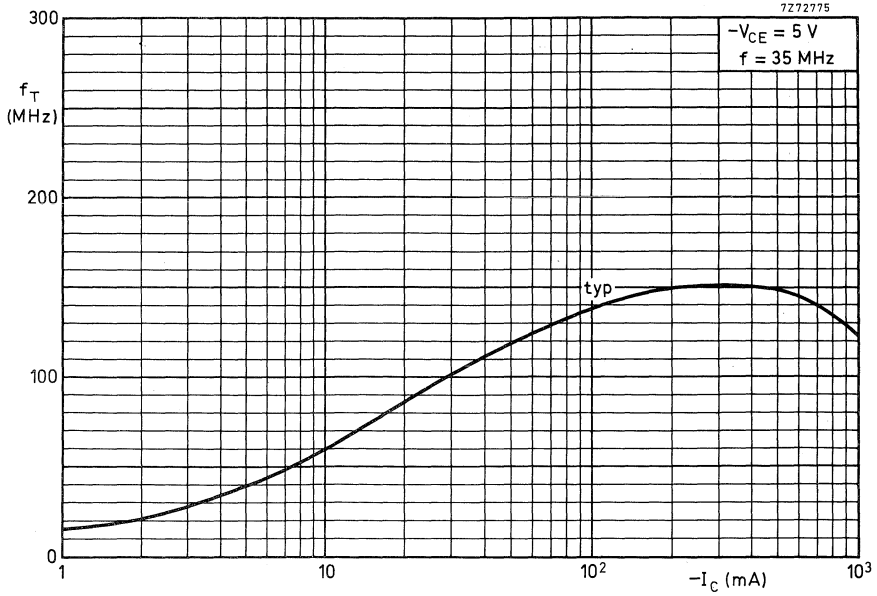


Fig. 4 Typical values transition frequency as a function of collector current.

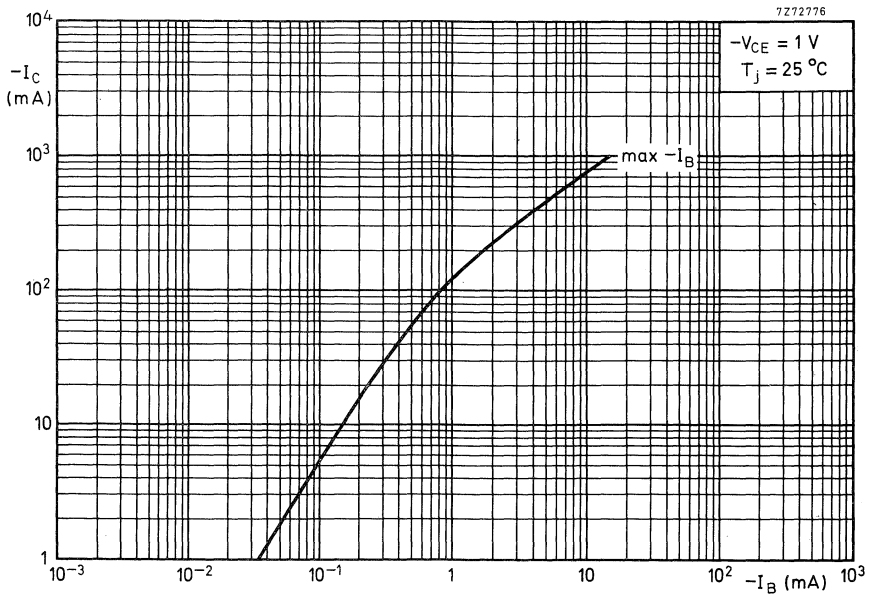


Fig. 5 Typical values collector current as a function of maximum base current.



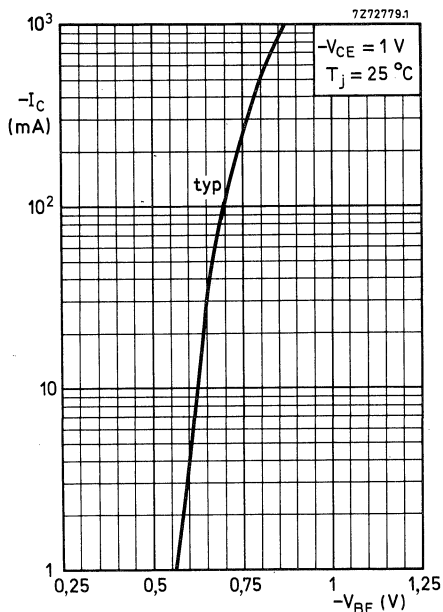


Fig. 6 Typical values collector current as a function of base-emitter voltage.

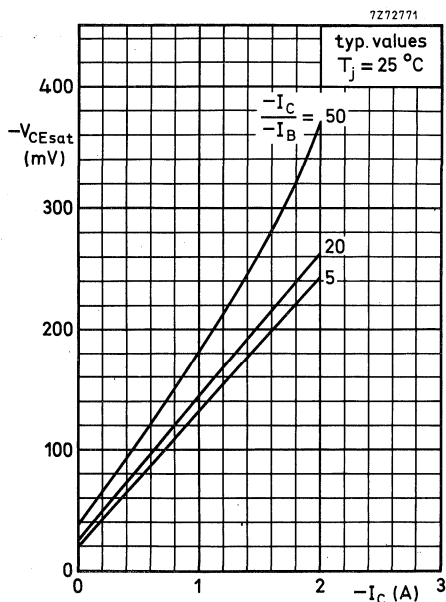


Fig. 7 Collector-emitter saturation voltage as a function of collector current.

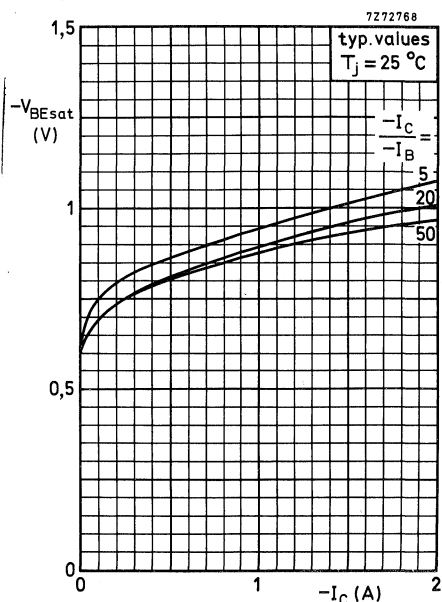


Fig. 8 Base-emitter saturation voltage as a function of collector current.



## SILICON PLANAR EPITAXIAL TRANSISTORS

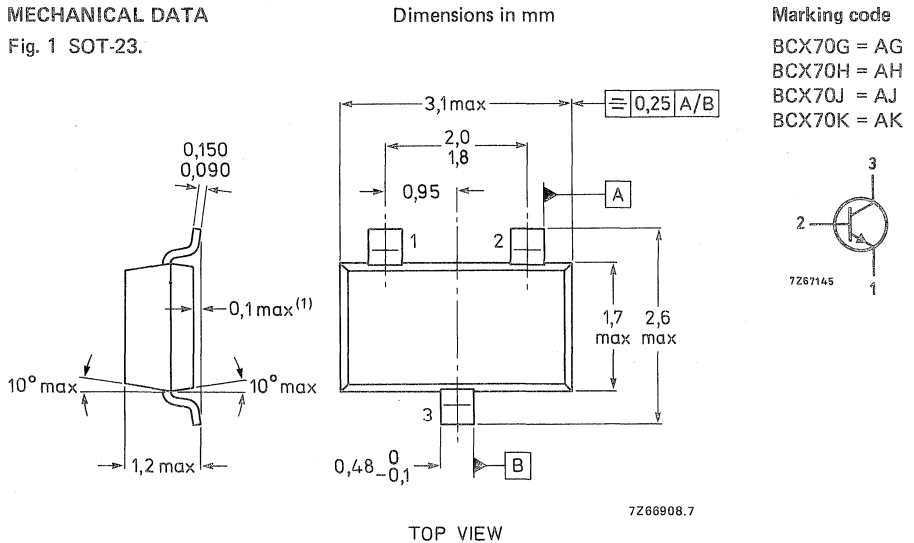
N-P-N silicon transistors, in a microminiature plastic envelope, intended for low level, low noise, low frequency purpose applications in hybrid circuits.

### QUICK REFERENCE DATA

Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max.	45 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	45 V
Collector current (d.c.)	$I_C$	max.	200 mA
Total power dissipation	$P_{tot}$	max.	150 mW
Junction temperature	$T_j$	max.	150 °C
Transition frequency at $f = 100$ MHz $V_{CE} = 5$ V; $I_C = 10$ mA	$f_T$	typ.	250 MHz
Noise figure at $f = 1$ kHz $V_{CE} = 5$ V; $I_C = 200 \mu A$ ; $B = 200$ Hz	F	typ.	2 dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max.	45 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	45 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	5 V
Collector current (d.c.)	$I_C$	max.	200 mA
Base current	$I_B$	max.	50 mA
Total power dissipation up to $T_{amb} = 100\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	150 mW
Storage temperature	$T_{stg}$		-55 to + 125 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

## THERMAL CHARACTERISTICS\*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

### Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

$T_{amb} = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter cut-off current

$$V_{BE} = 0; V_{CE} = 45\text{ V}$$

$$I_{CES} < 20\text{ nA}$$

$$V_{BE} = 0; V_{CE} = 45\text{ V}; T_{amb} = 150\text{ }^\circ\text{C}$$

$$I_{CES} < 20\text{ }\mu\text{A}$$

Emitter-base cut-off current

$$I_C = 0; V_{EB} = 4\text{ V}$$

$$I_{EBO} < 20\text{ nA}$$

Saturation voltages

$$\text{at } I_C = 10\text{ mA}; I_B = 0,25\text{ mA}$$

$$V_{CEsat} \quad 0,05\text{ to }0,35\text{ V}$$

$$V_{BEsat} \quad 0,6\text{ to }0,85\text{ V}$$

$$\text{at } I_C = 50\text{ mA}; I_B = 1,25\text{ mA}$$

$$V_{CEsat} \quad 0,1\text{ to }0,55\text{ V}$$

$$V_{BEsat} \quad 0,7\text{ to }1,05\text{ V}$$

Transition frequency at  $f = 100\text{ MHz}\blacktriangle$

$$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$$

$$f_T > 125\text{ MHz}$$

$$\text{typ. } 250\text{ MHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_c = 0; V_{CB} = 10\text{ V}$$

$$C_c < 4,5\text{ pF}$$

Emitter capacitance at  $f = 1\text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$$

$$C_e \text{ typ. } 8\text{ pF}$$

Noise figure at  $R_S = 2\text{ k}\Omega$

$$I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V}; f = 1\text{ kHz}; B = 200\text{ Hz}$$

$$F \text{ typ. } 2\text{ dB}$$

$$< 6\text{ dB}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

$\blacktriangle$  Measured under pulse conditions.

		G	H	J	K
D.C. current gain $V_{CE} = 5 \text{ V}; I_C = 10 \mu\text{A}$	$h_{FE}$ typ.	78	145	220	300
	>	—	20	40	100
$V_{CE} = 5 \text{ V}; I_C = 2 \text{ mA}$	>	120	180	250	380
	$h_{FE}$ typ.	170	250	350	500
$V_{CE} = 1 \text{ V}; I_C = 50 \text{ mA}$	<	220	310	460	630
	$h_{FE}$ >	50	70	90	100
Input impedance $V_{CE} = 5 \text{ V}; I_C = 2 \text{ mA}; f = 1 \text{ kHz}$	>	1,6	2,5	3,2	4,5 k $\Omega$
	$h_{ie}$ typ.	2,7	3,6	4,5	7,5 k $\Omega$
Reverse voltage transfer ratio $V_{CE} = 5 \text{ V}; I_C = 2 \text{ mA}; f = 1 \text{ kHz}$	<	4,5	6,0	8,5	12,0 k $\Omega$
	$h_{re}$ typ.	1,5	2	2	3 $10^{-4}$
Small-signal current gain $V_{CE} = 5 \text{ V}; I_C = 2 \text{ mA}; f = 1 \text{ kHz}$	>	125	175	250	350
	$h_{fe}$ typ.	200	260	330	520
Output admittance $V_{CE} = 5 \text{ V}; I_C = 2 \text{ mA}; f = 1 \text{ kHz}$	<	250	350	500	700
	$h_{oe}$ typ.	18	24	30	50 $\mu\text{A/V}$
Base-emitter voltage $V_{CE} = 5 \text{ V}; I_C = 2 \text{ mA}$	<	30	50	60	100 $\mu\text{A/V}$
	$V_{BE}$ typ.	0,55 to 0,75			V
$V_{CE} = 5 \text{ V}; I_C = 10 \mu\text{A}$	$V_{BE}$ typ.	0,65			V
	$V_{BE}$ typ.	0,52			V
$V_{CE} = 1 \text{ V}; I_C = 50 \text{ mA}$	$V_{BE}$ typ.	0,78			V

Switching times

$I_{C\text{on}} = 10 \text{ mA}$ ;  $I_{B\text{on}} = -I_{B\text{off}} = 1 \text{ mA}$   
 $V_{CC} = 10 \text{ V}$ ;  $R_L = 990 \Omega$

turn-on time ( $t_d + t_r$ )

$t_{\text{on}}$     typ.    85 ns  
             <      150 ns

turn-off time ( $t_s + t_f$ )

$t_{\text{off}}$     typ.    480 ns  
             <      800 ns

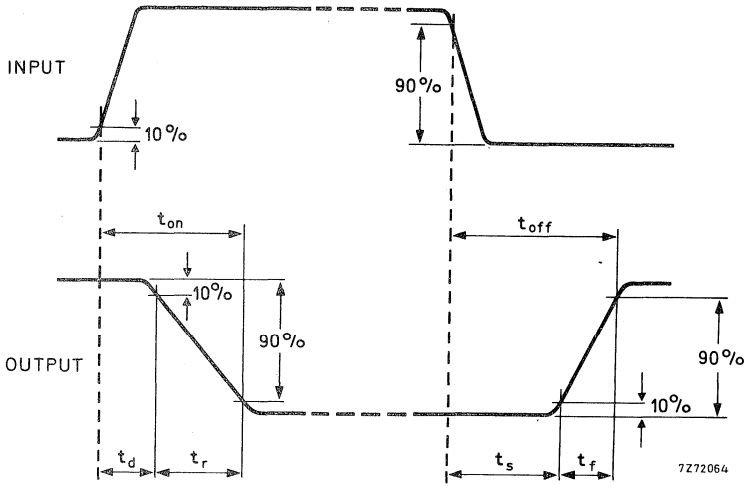


Fig. 2 Switching waveforms.

## SILICON PLANAR EPITAXIAL TRANSISTORS

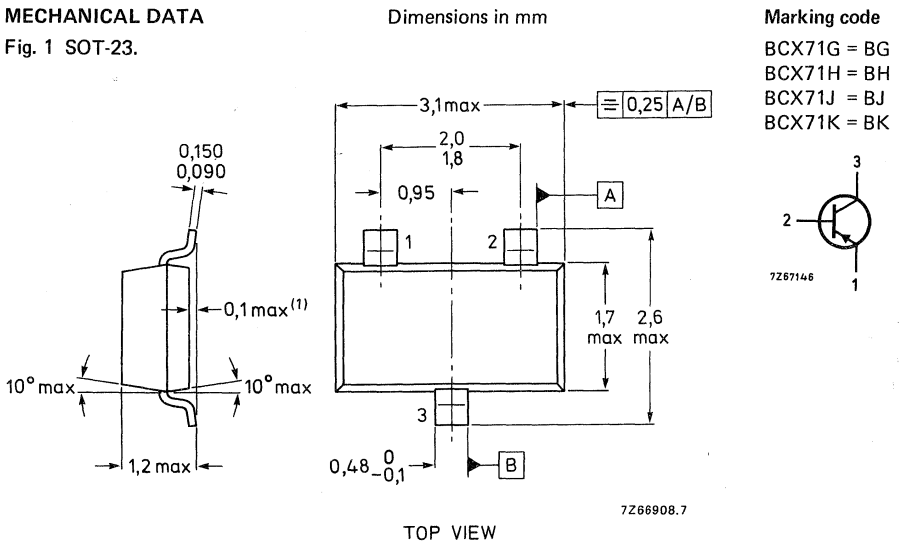
P-N-P silicon transistors, in a microminiature plastic envelope, intended for low level, low noise, low frequency purpose applications in hybrid circuits.

### QUICK REFERENCE DATA

Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$	max.	45 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	45 V
Collector current (d.c.)	$-I_C$	max.	200 mA
Total power dissipation	$P_{tot}$	max.	150 mW
Junction temperature	$T_j$	max.	150 °C
Transition frequency at $f = 100$ MHz $-V_{CE} = 5$ V; $-I_C = 10$ mA	$f_T$	typ.	180 MHz
Noise figure at $f = 1$ kHz $-V_{CE} = 5$ V; $-I_C = 200$ $\mu$ A	F	typ.	2 dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )	$-V_{CES}$	max.	45 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	45 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	200 mA
Base current	$-I_B$	max.	50 mA
Total power dissipation up to $T_{amb} = 100\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	150 mW
Storage temperature	$T_{stg}$		-55 to + 125 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

## THERMAL CHARACTERISTICS\*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

### Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

$T_{amb} = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter cut-off current

$$V_{EB} = 0; -V_{CE} = 45\text{ V}$$

$$-I_{CES} < 20\text{ nA}$$

$$V_{EB} = 0; -V_{CE} = 45\text{ V}; T_{amb} = 150\text{ }^\circ\text{C}$$

$$-I_{CES} < 20\text{ }\mu\text{A}$$

Emitter-base cut-off current

$$I_C = 0; -V_{EB} = 4\text{ V}$$

$$-I_{EBO} < 20\text{ nA}$$

Saturation voltages

$$-I_C = 10\text{ mA}; -I_B = 0,25\text{ mA}$$

$$-V_{CEsat} \quad 0,06\text{ to }0,25\text{ V}$$

$$-I_C = 50\text{ mA}; -I_B = 1,25\text{ mA}$$

$$-V_{BEsat} \quad 0,6\text{ to }0,85\text{ V}$$

$$-V_{CEsat} \quad 0,12\text{ to }0,55\text{ V}$$

$$-V_{BEsat} \quad 0,68\text{ to }1,05\text{ V}$$

Transition frequency at  $f = 100\text{ MHz}^\Delta$

$$-V_{CE} = 5\text{ V}; -I_C = 10\text{ mA}$$

$$f_T \quad \text{typ.} \quad 180\text{ MHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$-V_{CB} = 10\text{ V}; I_E = I_C = 0$$

$$C_c < 6\text{ pF}$$

Emitter capacitance at  $f = 1\text{ MHz}$

$$-V_{EB} = 0,5\text{ V}; I_C = I_C = 0$$

$$C_e \quad \text{typ.} \quad 11\text{ pF}$$

Noise figure at  $R_S = 2\text{ k}\Omega$

$$-V_{CE} = 5\text{ V}; -I_C = 200\text{ }\mu\text{A}; B = 200\text{ Hz}$$

$$F \quad \text{typ.} \quad 2\text{ dB}$$

$$< \quad 6\text{ dB}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

$\Delta$  Measured under pulse conditions.



		G	H	J	K	
D.C. current gain	$-V_{CE} = 5 \text{ V}; -I_C = 10 \mu\text{A}$	$h_{FE}$ typ.	140	200	270	340
		>	—	30	40	100
	$-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}$	>	120	180	250	380
		$h_{FE}$ typ.	170	250	350	500
	$-V_{CE} = 1 \text{ V}; -I_C = 50 \text{ mA}$	<	220	310	460	630
		$h_{FE}$ typ.	60	80	100	110
Input impedance	$-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$	>	1,6	2,5	3,2	4,5 k $\Omega$
		$h_{ie}$ typ.	2,7	3,6	4,5	7,5 k $\Omega$
		<	4,5	6,0	8,5	12,0 k $\Omega$
		$h_{re}$ typ.	1,5	2	2	3 $10^{-4}$
Reverse voltage transfer ratio	$-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$	>	125	175	250	350
		$h_{fe}$ typ.	200	260	330	520
Small-signal current gain	$-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$	<	250	350	500	700
		$h_{oe}$ typ.	18	24	30	50 $\mu\text{A}/\text{V}$
Output admittance	$-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$	<	30	50	60	100 $\mu\text{A}/\text{V}$
		$V_{BE}$ typ.	0,6 to 0,75			V
Base-emitter voltage	$-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}$	$V_{BE}$ typ.	0,65			V
		$V_{BE}$ typ.	0,55			V
	$-V_{CE} = 5 \text{ V}; -I_C = 10 \mu\text{A}$	$V_{BE}$ typ.	0,72			V
		$V_{BE}$ typ.	0,72			V

Switching times

$-I_{Con} = 10 \text{ mA}; -I_{Bon} = I_{Boff} = 1 \text{ mA}$   
 $-V_{CC} = 10 \text{ V}; R_L = 990 \Omega$

turn-on time ( $t_d + t_r$ )

$t_{on}$  typ. 85 ns  
 $< 150 \text{ ns}$

turn-off time ( $t_s + t_f$ )

$t_{off}$  typ. 480 ns  
 $< 800 \text{ ns}$

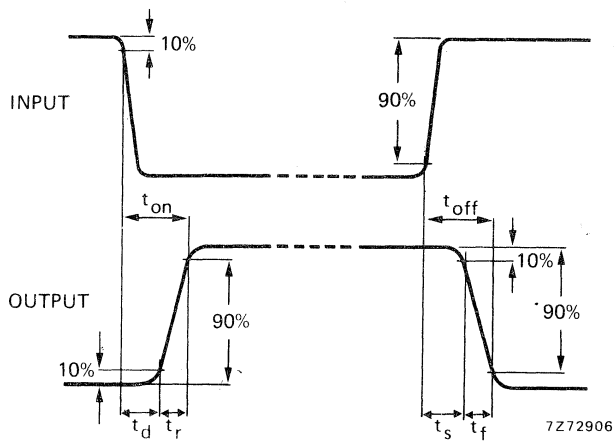


Fig. 2 Switching waveforms.

## N-CHANNEL SILICON FIELD-EFFECT TRANSISTORS

Asymmetrical N-channel planar epitaxial junction field-effect transistors in the miniature plastic envelope intended for applications up to the v.h.f. range in hybrid thick and thin-film circuits. Special features are the low feedback capacitance and the low noise figure. These features make the product very suitable for applications such as the r.f. stages in f.m. portables (BF510), car radios (BF511) and mains radios (BF512) or the mixer stage (BF513).

### QUICK REFERENCE DATA

Drain-source voltage	$V_{DS}$	max.	20	V		
Drain current (d.c. or average)	$I_D$	max.	30	mA		
Total power dissipation up to $T_{amb} = 65^\circ\text{C}$	$P_{tot}$	max.	250	mW		
			BF510	511	512	513
Drain current $V_{DS} = 10\text{ V}; V_{GS} = 0$	$I_{DSS}$	>	0,7	2,5	6	10 mA
		<	3,0	7,0	12	18 mA
Transfer admittance (common source) $V_{DS} = 10\text{ V}; V_{GS} = 0; f = 1\text{ kHz}$	$ y_{fs} $	>	2,5	4	6	7 mA/V
Feedback capacitance $V_{DS} = 10\text{ V}; V_{GS} = 0$ $V_{DS} = 10\text{ V}; I_D = 5\text{ mA}$	$C_{rs}$	typ.	0,3	0,3	—	— pF
	$C_{rs}$	typ.	—	—	0,3	0,3 pF
Noise figure at optimum source admittance $G_S = 1\text{ mA/V}; -B_S = 3\text{ mA/V}; f = 100\text{ MHz}$ $V_{DS} = 10\text{ V}; V_{GS} = 0$ $V_{DS} = 10\text{ V}; I_D = 5\text{ mA}$	F	typ.	1,5	1,5	—	— dB
		typ.	—	—	1,5	1,5 dB

### MECHANICAL DATA

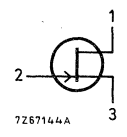
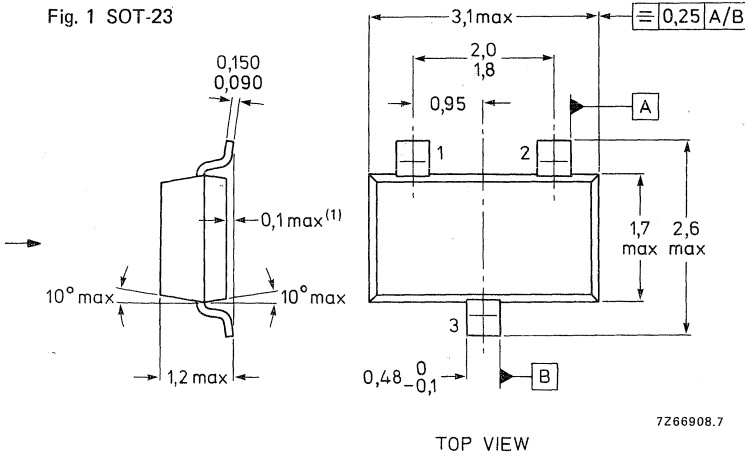
SOT-23.

See also *Soldering recommendations*.

**MECHANICAL DATA**

Fig. 1 SOT-23

Dimensions in mm



**Marking code**

- BF510 = S6
- BF511 = S7
- BF512 = S8
- BF513 = S9

7266908.7

TOP VIEW

(1) Also available in 0,1 – 0,2 mm version.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage see Fig. 4	$V_{DS}$	max.	20 V
Drain-gate voltage (open source) see Fig. 4	$V_{DGO}$	max.	20 V
Drain current (d.c. or average)	$I_D$	max.	30 mA
Gate current	$\pm I_G$	max.	10 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	250 mW
Storage temperature	$T_{stg}$		-65 to + 175 $^\circ\text{C}$
Junction temperature	$T_j$	max.	175 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

**STATIC CHARACTERISTICS**

$T_{amb} = 25\text{ }^{\circ}\text{C}$

			BF510	511	512	513
Gate cut-off current $-V_{GS} = 0,2\text{ V}; V_{DS} = 0$	$-I_{GSS}$	<	10	10	10	10 nA
Gate-drain breakdown voltage $I_S = 0; -I_D = 10\text{ }\mu\text{A}$	$-V_{(BR)GDO}$	>	20	20	20	20 V
Drain current $V_{DS} = 10\text{ V}; V_{GS} = 0$	$I_{DSS}$	>	0,7	2,5	6	10 mA
		<	3,0	7,0	12	18 mA
Gate-source cut-off voltage $I_D = 10\text{ }\mu\text{A}; V_{DS} = 10\text{ V}$	$-V_{(P)GS}$	typ.	0,8	1,5	2,2	3 V

**DYNAMIC CHARACTERISTICS**

Measuring conditions (common source):  $V_{DS} = 10\text{ V}; V_{GS} = 0; T_{amb} = 25\text{ }^{\circ}\text{C}$  for BF510 and BF511

$V_{DS} = 10\text{ V}; I_D = 5\text{ mA}; T_{amb} = 25\text{ }^{\circ}\text{C}$  for BF512 and BF513

**y-parameters (common source)**

			BF510	511	512	513
Input capacitance at $f = 1\text{ MHz}$	$C_{is}$	<	5	5	5	5 pF
Input conductance at $f = 100\text{ MHz}$	$g_{is}$	typ.	100	90	60	50 $\mu\text{A/V}$
Feedback capacitance at $f = 1\text{ MHz}$	$C_{rs}$	typ.	0,3	0,3	0,3	0,3 pF
		<	0,4	0,4	0,4	0,4 pF
Transfer admittance at $f = 1\text{ kHz}$ $V_{GS} = 0$ instead of $I_D = 5\text{ mA}$	$ y_{fs} $	>	2,5	4,0	4,0	3,5 mA/V
		>	—	—	6,0	7,0 mA/V
Transfer admittance at $f = 100\text{ MHz}$	$ y_{fs} $	typ.	3,5	5,5	5,0	5,0 mA/V
Output capacitance at $f = 1\text{ MHz}$	$C_{os}$	<	3	3	3	3 pF
Output conductance at $f = 1\text{ MHz}$	$g_{os}$	<	60	80	100	120 $\mu\text{A/V}$
Output conductance at $f = 100\text{ MHz}$	$g_{os}$	typ.	35	55	70	90 $\mu\text{A/V}$
Noise figure at optimum source admittance $G_S = 1\text{ mA/V}; -B_S = 3\text{ mA/V};$ $f = 100\text{ MHz}$	F	typ.	1,5	1,5	1,5	1,5 dB

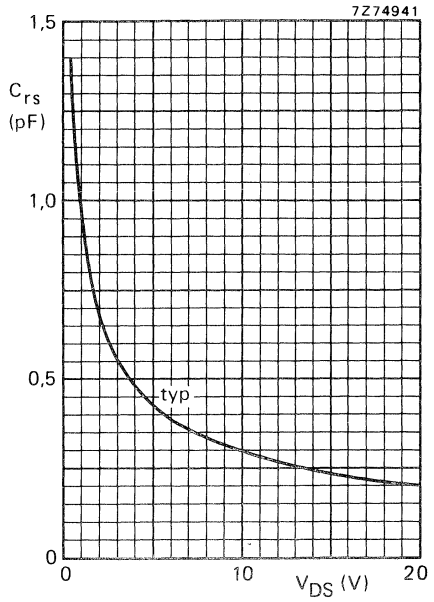


Fig. 2  $V_{GS} = 0$  for BF510 and BF511;  
 $I_D = 5$  mA for BF512 and BF513;  
 $f = 1$  MHz;  $T_{amb} = 25$  °C.

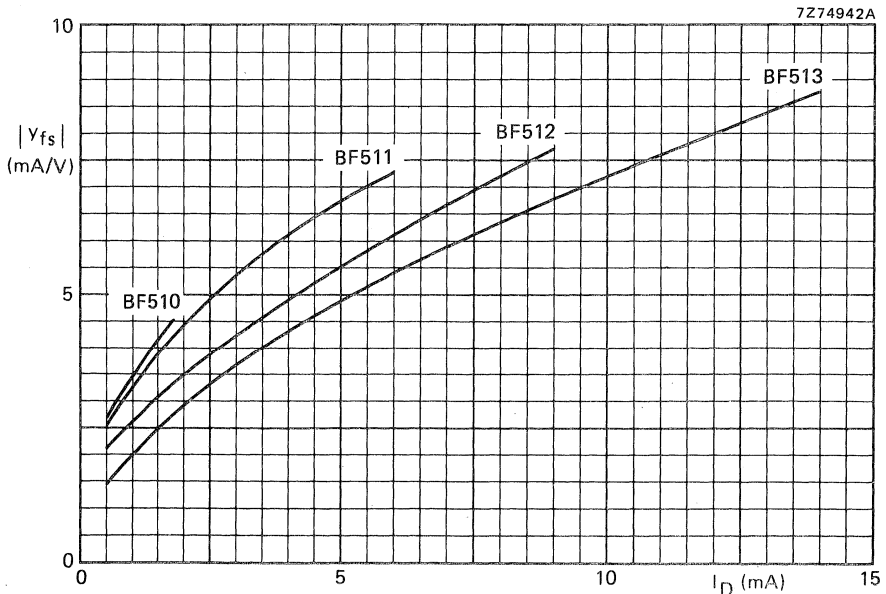


Fig. 3  $V_{DS} = 10$  V;  $f = 1$  kHz;  $T_{amb} = 25$  °C; typical values.

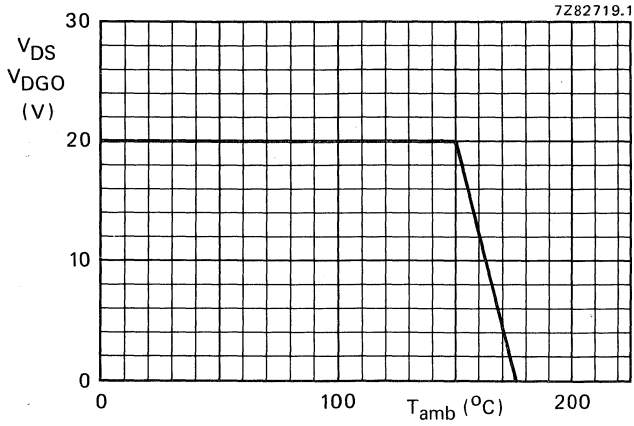


Fig. 4 Voltage derating curve.

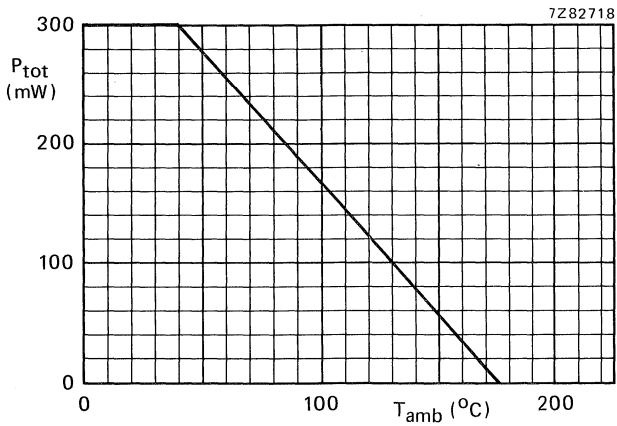


Fig. 5 Power derating curve.





## SILICON PLANAR TRANSISTOR

P-N-P transistor in a microminiature plastic envelope. Primarily intended for use as mixer in v.h.f. tuners. Also suitable as r.f. amplifier and oscillator in f.m. tuners.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	30 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	30 V
Collector current (d.c.)	$-I_C$	max.	25 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
D.C. current gain $I_E = 1\text{ mA}; -V_{CB} = 10\text{ V}$	$h_{FE}$	>	25
Transition frequency at $f = 100\text{ MHz}$ $I_E = 1\text{ mA}; -V_{CB} = 10\text{ V}$	$f_T$	typ.	350 MHz
Noise figure at $f = 200\text{ MHz}$ $I_E = 1\text{ mA}; -V_{CB} = 10\text{ V}$	F	typ.	5 dB

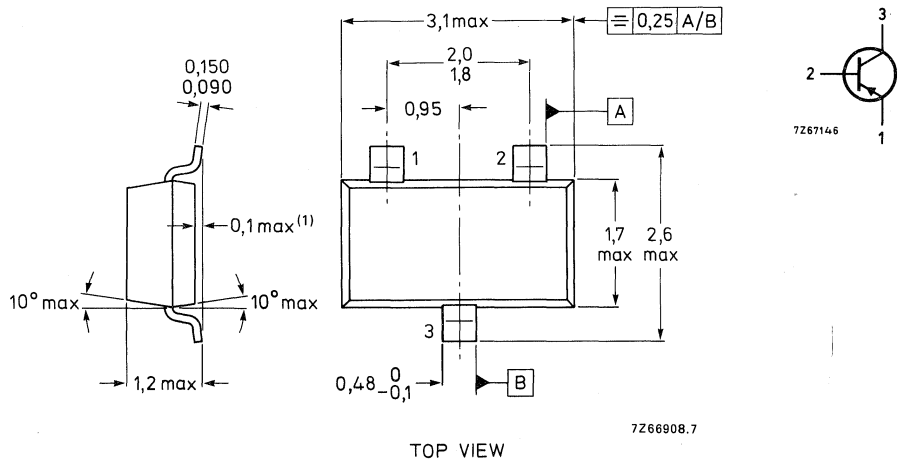
### MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BF536 = G3



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	30 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	30 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	4 V
Collector current (d.c.)	$-I_C$	max.	25 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-65 to + 150 °C
Junction temperature	$T_j$	max.	150 °C

**THERMAL CHARACTERISTICS\***

$$T_j = P (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_{amb} = 25\text{ }^\circ\text{C}$ ; unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 20\text{ V} \quad -I_{CBO} < 50\text{ nA}$$

D.C. current gain

$$I_E = 1\text{ mA}; -V_{CB} = 10\text{ V} \quad h_{FE} > 25$$

Transition frequency at  $f = 100\text{ MHz}$

$$I_E = 1\text{ mA}; -V_{CB} = 10\text{ V} \quad f_T \text{ typ. } 350\text{ MHz}$$

Noise figure at  $f = 200\text{ MHz}$

$$I_E = 1\text{ mA}; -V_{CB} = 10\text{ V}; R_S = 50\ \Omega \quad F \text{ typ. } 5\text{ dB}$$

Transducer gain (common base) at  $f = 200\text{ MHz}$

$$I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; R_S = 60\ \Omega; R_L = 920\ \Omega \quad G_{tr} \text{ typ. } 17,5\text{ dB}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

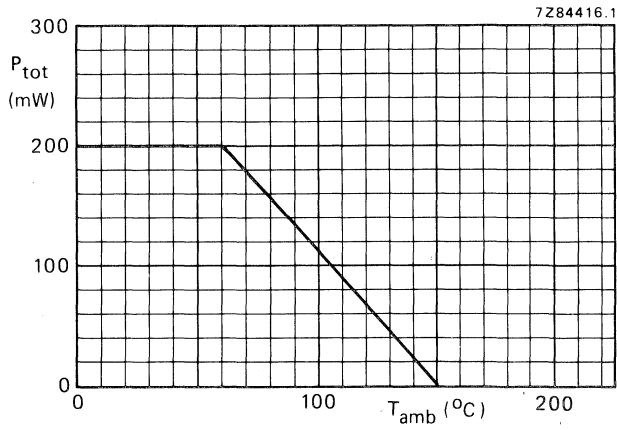


Fig. 2 Power derating curve.



## SILICON PLANAR EPITAXIAL TRANSISTOR

P-N-P transistor, in a microminiature plastic envelope, intended for applications in thick and thin-film circuits. This transistor is primarily intended for use in i.f. detection applications.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	40 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	40 V
Collector current (d.c.)	$-I_C$	max.	25 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$	$h_{FE}$	>	50
Transition frequency at $f = 100\text{ MHz}$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$	$f_T$	typ.	325 MHz
Noise figure at $R_S = 300\text{ }\Omega$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}; f = 100\text{ kHz}$	F	typ.	2 dB

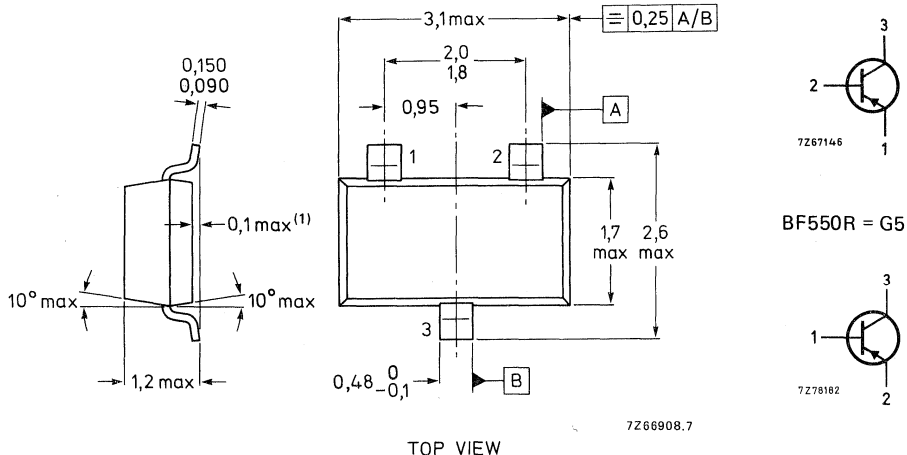
### MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23

BF550 = G2



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering Recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	40 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	40 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	4 V
Collector current (d.c.)	$-I_C$	max.	25 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-55 to +150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_{amb} = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current $I_E = 0; -V_{CB} = 30\text{ V}$	$-I_{CBO}$	<	50 nA
Emitter cut-off current $I_C = 0; -V_{EB} = 3\text{ V}$	$-I_{EBO}$	<	100 $\mu\text{A}$
Base-emitter voltage $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$	$-V_{BE}$	typ.	750 mV
D.C. current gain $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$	$h_{FE}$	>	50
Transition frequency at $f = 100\text{ MHz}$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$	$f_T$	typ.	325 MHz
Feedback capacitance at $f = 1\text{ MHz}$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$	$C_{re}$	typ.	0,5 pF
Noise figure at $R_S = 300\ \Omega$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}; f = 100\text{ kHz}$	F	typ.	2 dB

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

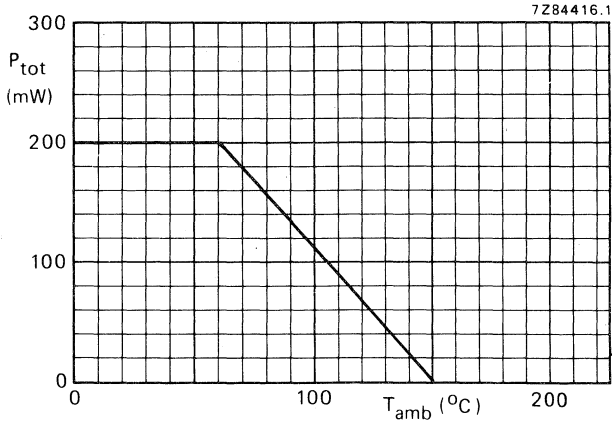


Fig. 2 Power derating curve.





## SILICON PLANAR EPITAXIAL TRANSISTOR

P-N-P transistor in a microminiature plastic envelope, intended for applications in thick and thin-film circuits such as self-oscillating mixer in u.h.f. tuners in conjunction with bipolar transistors or with MOS fets.

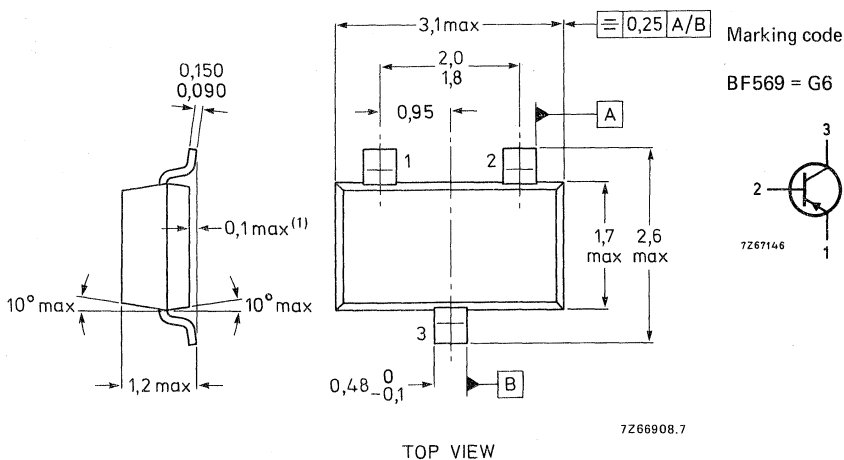
### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	40 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	35 V
Collector current (d.c.)	$-I_C$	max.	30 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Transition frequency at $f = 100\text{ MHz}$ $I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}$	$f_T$	typ.	900 MHz

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-23



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	40 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	35 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	3 V
Collector current (d.c.)	$-I_C$	max.	30 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		$-65$ to $+150\text{ }^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

Collector cut-off current

$I_E = 0; -V_{CB} = 20\text{ V}$	$-I_{CBO}$	<	100 nA
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D.C. current gain

$I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}$	$h_{FE}$	>	25
		typ.	50

Transition frequency at  $f = 100\text{ MHz}$

$I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}$	$f_T$	typ.	900 MHz
--	-------	------	---------

Feedback capacitance at  $f = 1\text{ MHz}$

$I_E = 1\text{ mA}; -V_{CB} = 10\text{ V}$	$C_{re}$	typ.	0,33 pF
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Noise figure at  $f = 800\text{ MHz}$

$I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; R_S = 60\ \Omega; R_L = 500\ \Omega$	$F$	typ.	4,5 dB
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Power gain at  $f = 800\text{ MHz}$

$I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; R_S = 60\ \Omega; R_L = 500\ \Omega$	$G_{pb}$	typ.	14,5 dB
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\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

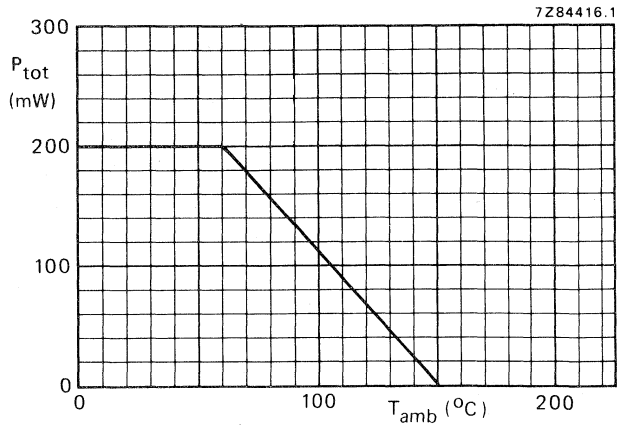


Fig. 2 Power derating curve.



## SILICON PLANAR TRANSISTOR

P-N-P transistor in a microminiature envelope primarily intended for u.h.f. applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$-V_{CB0}$	max.	20 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	20 V
Collector current	$-I_C$	max.	25 mA
Total power dissipation up to $T_{amb} = 85^\circ\text{C}$	$P_{tot}$	max.	150 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Transition frequency at $f = 100$ MHz $I_E = 10$ mA; $-V_{CB} = 10$ V	$f_T$	typ.	1350 MHz
Transducer gain (common base) $I_E = 10$ mA; $-V_{CB} = 10$ V; $f = 800$ MHz $R_S = 60 \Omega$ ; $R_L = 500 \Omega$ ; $T_{amb} = 25^\circ\text{C}$	$G_{Tr}$	typ.	16 dB
Noise figure (common base) $I_E = 10$ mA; $-V_{CB} = 10$ V; $f = 800$ MHz $R_S = 60 \Omega$ ; $R_L = 500 \Omega$	F	typ.	4,5 dB

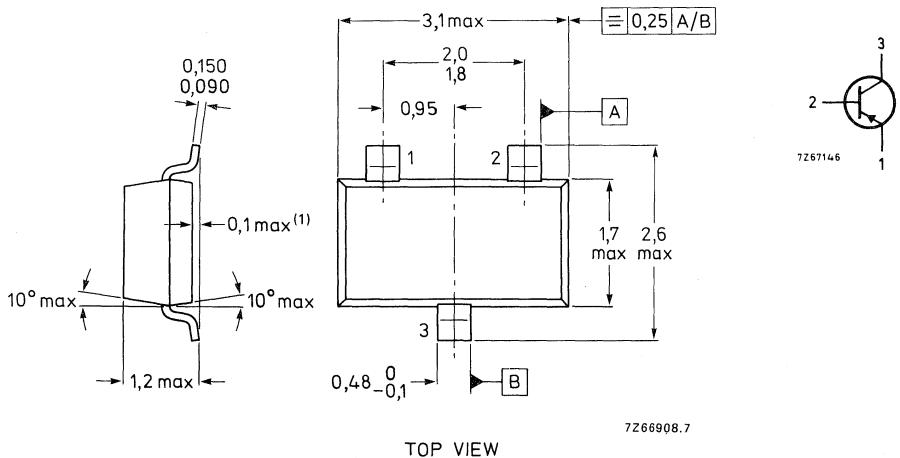
### MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BF579 = G7



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 2	$-V_{CBO}$	max.	20 V
Collector-emitter voltage (open base) see Fig. 2	$-V_{CEO}$	max.	20 V
Emitter-base voltage (open collector) see Fig. 2	$-V_{EBO}$	max.	3 V
Collector current	$-I_C$	max.	25 mA
Base current (d.c.)	$-I_B$	max.	10 mA
Total power dissipation up to $T_{amb} = 85\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	150 mW
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_{amb} = 25\text{ }^\circ\text{C}$

Collector cut-off current

$$I_E = 0; -V_{CB} = 15\text{ V}$$

$$-I_{CBO} < 100\text{ nA}$$

Emitter cut-off current

$$I_C = 0; -V_{EB} = 1\text{ V}$$

$$-I_{EBO} < 100\text{ nA}$$

D.C. current gain

$$I_C = 10\text{ mA}; -V_{CE} = 10\text{ V}$$

$$h_{FE} > 20$$

Transition frequency at  $f = 100\text{ MHz}$

$$I_E = 10\text{ mA}; -V_{CB} = 10\text{ V}$$

$$f_T \text{ typ. } 1350\text{ MHz}$$

Feedback capacitance at  $f = 500\text{ kHz}$

$$I_E = 7\text{ mA}; -V_{CB} = 10\text{ V}$$

$$C_{re} \text{ typ. } 0,46\text{ pF}$$

$$I_E = 0; -V_{CB} = 10\text{ V}$$

$$C_{rb} \text{ typ. } 160\text{ fF}$$

Transducer gain (common base)

$$I_E = 10\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz}$$

$$R_S = 60\ \Omega; R_L = 500\ \Omega$$

$$G_{tr} \text{ typ. } 16\text{ dB}$$

Noise figure (common base)

$$I_E = 10\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz}$$

$$R_S = 60\ \Omega; R_L = 500\ \Omega$$

$$F \text{ typ. } 4,5\text{ dB}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

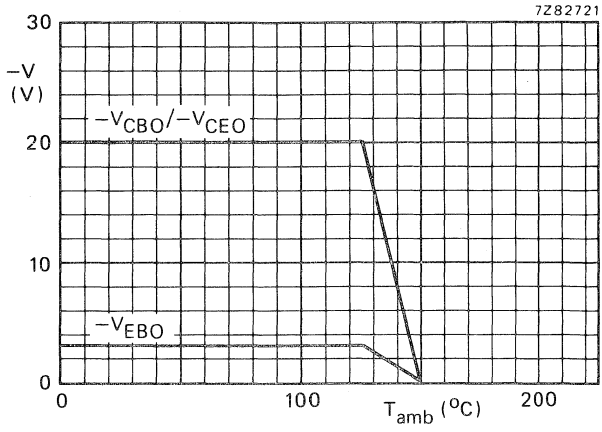


Fig. 2 Voltage derating curves.

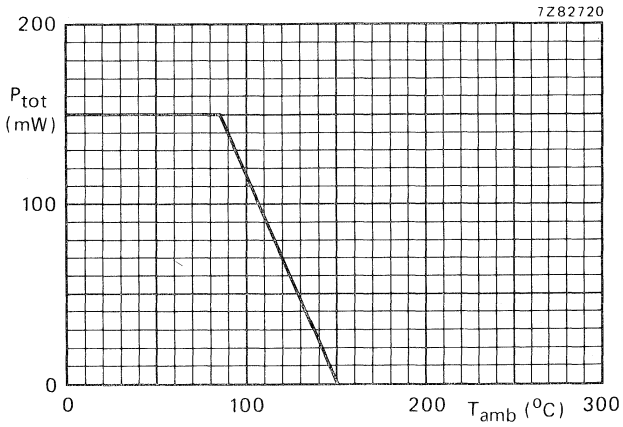


Fig. 3 Power derating curve.





## SILICON EPITAXIAL TRANSISTORS

● **For video output stages**

N-P-N transistors in a microminiature plastic envelope intended for class-B video output stages in colour television receivers.

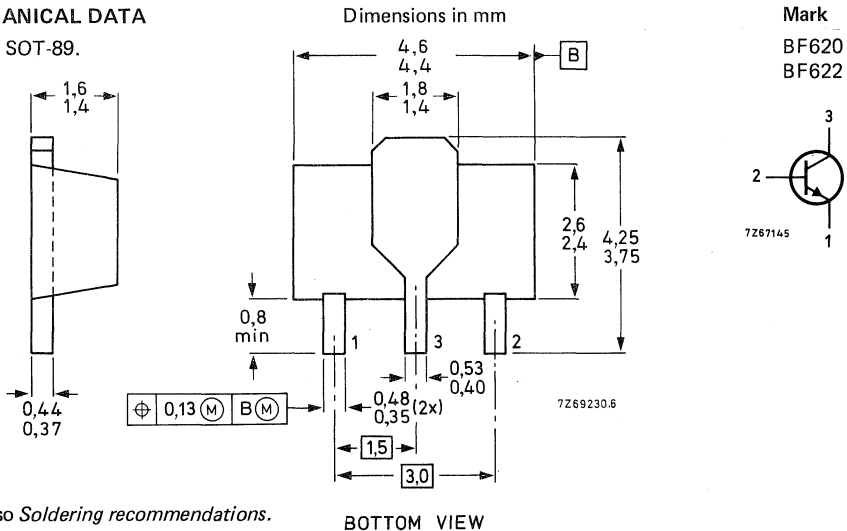
P-N-P complements are BF621 and BF623 respectively.

### QUICK REFERENCE DATA

		BF620	BF622
Collector-base voltage (open emitter)	$V_{CBO}$	max. 300	250 V
Collector-emitter voltage (open base)	$V_{CEO}$	max. —	250 V
Collector-emitter voltage ( $R_{BE} = 2,7 \text{ k}\Omega$ )	$V_{CER}$	max. 300	— V
Collector current (peak value)	$I_{CM}$	max. 100	mA
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$	$P_{tot}$	max. 1	W
Junction temperature	$T_j$	max. 150	$^\circ\text{C}$
D.C. current gain	$h_{FE}$	>	50
$I_C = 25 \text{ mA}; V_{CE} = 20 \text{ V}$			
Transition frequency at $f = 35 \text{ MHz}$	$f_T$	>	60 MHz
$I_C = 10 \text{ mA}; V_{CE} = 10 \text{ V}$			
Feedback capacitance at $f = 1 \text{ MHz}$	$C_{re}$	<	1,6 pF
$I_C = 0; V_{CE} = 30 \text{ V}$			

### MECHANICAL DATA

Fig. 1 SOT-89.



See also *Soldering recommendations.*

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

			BF620	BF622
Collector-base voltage (open emitter)	$V_{CBO}$	max.	300	250 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	—	250 V
Collector-emitter voltage ( $R_{BE} = 2,7 \text{ k}\Omega$ )	$V_{CER}$	max.	300	— V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	5	V
Collector current (d.c.)	$I_C$	max.	50	mA
Collector current (peak value)	$I_{CM}$	max.	100	mA
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ mounted on a ceramic substrate area = 2,5 cm <sup>2</sup> ; thickness = 0,7 mm	$P_{tot}$	max.	1	W
Storage temperature	$T_{stg}$		-65 to + 150	$^\circ\text{C}$
Junction temperature	$T_j$	max.	150	$^\circ\text{C}$

**THERMAL RESISTANCE\***

From junction to collector tab	$R_{thj-tab}$	=	25	K/W
From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm <sup>2</sup> ; thickness = 0,7 mm	$R_{thj-a}$	=	125	K/W

**CHARACTERISTICS**

$T_j = 25 \text{ }^\circ\text{C}$  unless otherwise specified

			BF620	BF622
Collector cut-off current $I_E = 0; V_{CB} = 200 \text{ V}$	$I_{CBO}$	<	10	10 nA
Collector-emitter voltage $R_{BE} = 2,7 \text{ k}\Omega; V_{CE} = 250 \text{ V}$	$I_{CER}$	<	50	— nA
$R_{BE} = 2,7 \text{ k}\Omega; V_{CE} = 200 \text{ V}; T_j = 150 \text{ }^\circ\text{C}$	$I_{CER}$	<	10	10 $\mu\text{A}$
Saturation voltage $I_C = 30 \text{ mA}; I_B = 5 \text{ mA}$	$V_{CE sat}$	<	0,6	V
D.C. current gain $I_C = 25 \text{ mA}; V_{CE} = 20 \text{ V}$	$h_{FE}$	>	50	
Transition frequency at $f = 35 \text{ MHz}$ $I_C = 10 \text{ mA}; V_{CE} = 10 \text{ V}$	$f_T$	>	60	MHz
Feedback capacitance at $f = 1 \text{ MHz}$ $I_C = 0; V_{CE} = 30 \text{ V}$	$C_{re}$	<	1,6	pF

\* See *Thermal characteristics*.

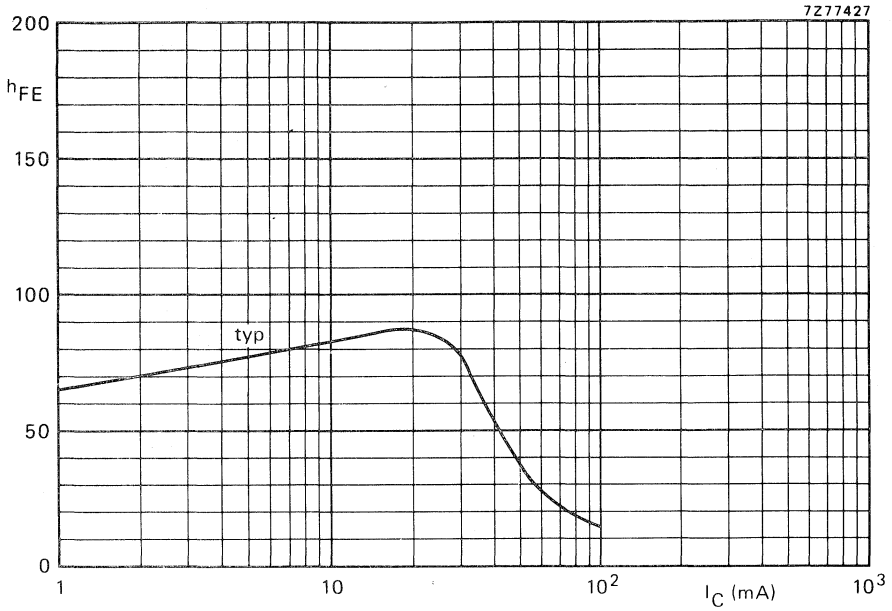


Fig. 2 Typical values at  $V_{CE} = 20 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ .

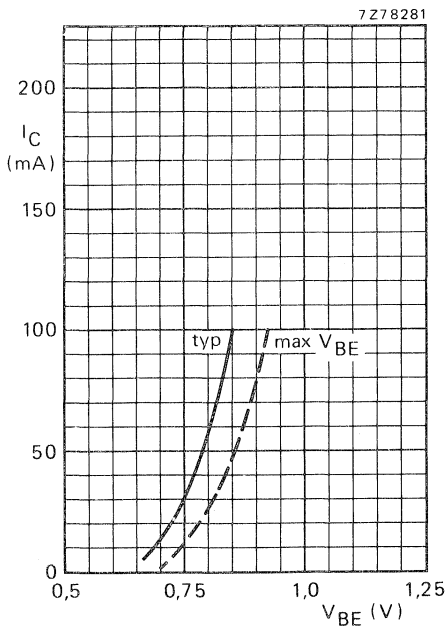


Fig. 3  $V_{CE} = 20 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ .

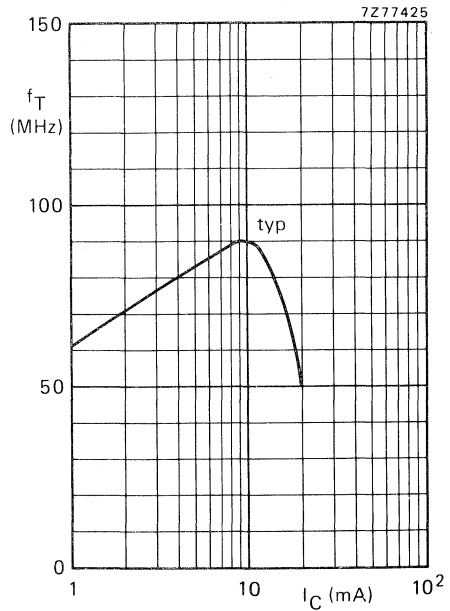


Fig. 4  $V_{CE} = 10 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ ;  $f = 35 \text{ MHz}$ .

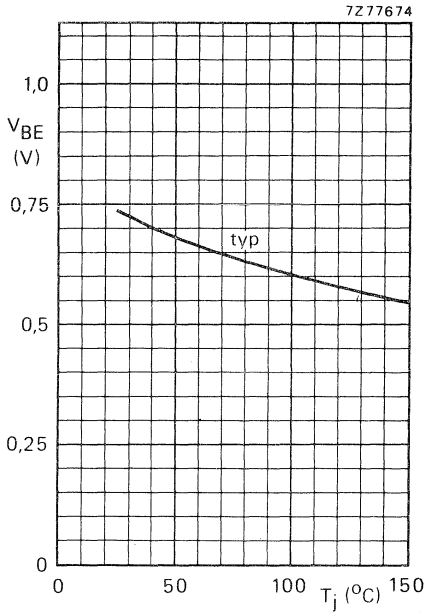


Fig. 5  $I_C = 25 \text{ mA}$ ;  $V_{CE} = 20 \text{ V}$ .

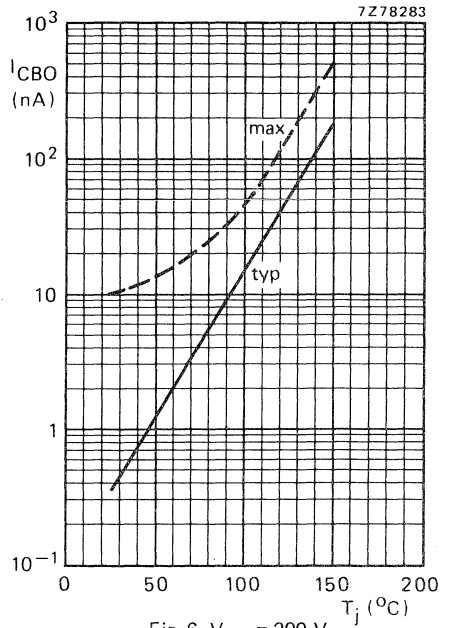


Fig. 6  $V_{CB} = 200 \text{ V}$ .

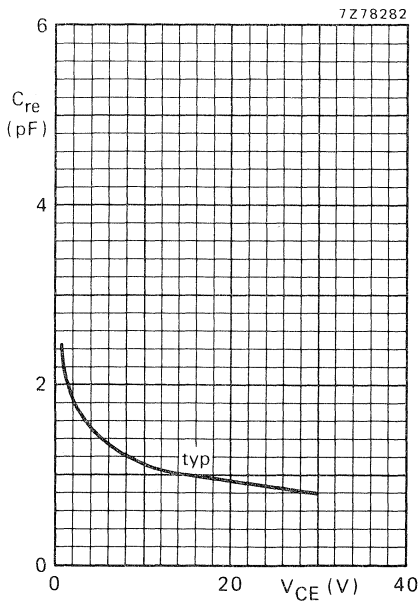


Fig. 7  $I_C = 0$ ;  $f = 1 \text{ MHz}$ ;  $T_j = 25 \text{ }^{\circ}\text{C}$ .

## SILICON EPITAXIAL TRANSISTORS

• For video output stages

P-N-P transistors in a microminiature plastic envelope intended for application in class-B video output stages in colour television receivers.

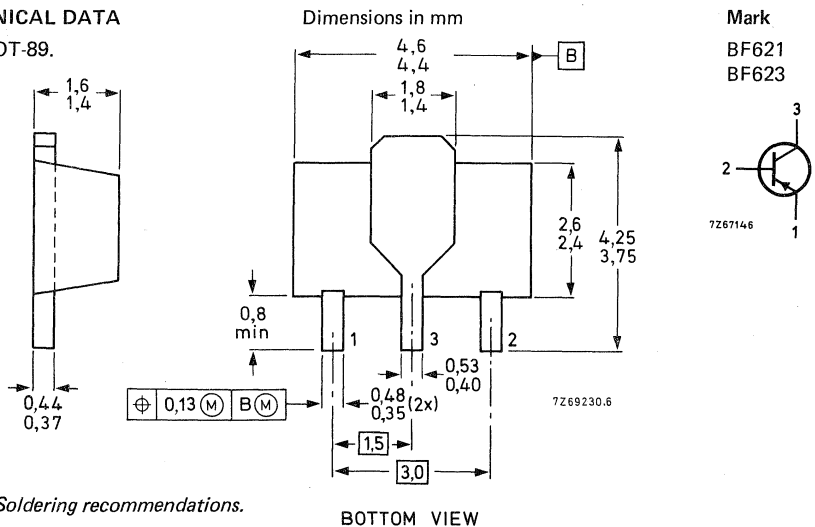
N-P-N complements are BF620 and BF622 respectively.

### QUICK REFERENCE DATA

			BF621	BF623
Collector-base voltage (open emitter)	$-V_{CBO}$	max.	300	250 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	—	250 V
Collector-emitter voltage ( $R_{BE} = 2,7 \text{ k}\Omega$ )	$-V_{CER}$	max.	300	— V
Collector current (peak value)	$-I_{CM}$	max.	100	mA
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$	$P_{tot}$	max.	1	W
Junction temperature	$T_j$	max.	150	$^\circ\text{C}$
D.C. current gain	$h_{FE}$	>	50	
Transition frequency at $f = 35 \text{ MHz}$	$f_T$	>	60	MHz
Feedback capacitance at $f = 1 \text{ MHz}$	$C_{re}$	<	1,6	pF

### MECHANICAL DATA

Fig. 1 SOT-89.



See also *Soldering recommendations.*

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BF621	BF623
Collector-base voltage (open emitter)	$-V_{CBO}$	max. 300	250 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max. —	250 V
Collector-emitter voltage ( $R_{BE} = 2,7 \text{ k}\Omega$ )	$-V_{CER}$	max. 300	— V
Emitter-base voltage (open collector)	$-V_{EBO}$	max. 5	V
Collector current (d.c.)	$-I_C$	max. 50	mA
Collector current (peak value)	$-I_{CM}$	max. 100	mA
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ mounted on a ceramic substrate area = $2,5 \text{ cm}^2$ ; thickness = $0,7 \text{ mm}$	$P_{tot}$	max. 1	W
Storage temperature	$T_{stg}$	max. -65 to +150	$^\circ\text{C}$
Junction temperature	$T_j$	max. 150	$^\circ\text{C}$

**THERMAL RESISTANCE\***

From junction to collector tab	$R_{th \text{ j-tab}}$	=	25	K/W
From junction to ambient in free air mounted on a ceramic substrate area = $2,5 \text{ cm}^2$ ; thickness = $0,7 \text{ mm}$	$R_{th \text{ j-a}}$	=	125	K/W

**CHARACTERISTICS**

$T_j = 25 \text{ }^\circ\text{C}$  unless otherwise specified

		BF621	BF623
Collector cut-off current $I_E = 0$ ; $-V_{CB} = 200 \text{ V}$	$-I_{CBO}$	< 10	10 nA
Collector-emitter voltage $R_{BE} = 2,7 \text{ k}\Omega$ ; $-V_{CE} = 250 \text{ V}$	$-I_{CER}$	< 50	— nA
$R_{BE} = 2,7 \text{ k}\Omega$ ; $-V_{CE} = 200 \text{ V}$ ; $T_j = 150 \text{ }^\circ\text{C}$	$-I_{CER}$	< 10	10 $\mu\text{A}$
Saturation voltage $-I_C = 30 \text{ mA}$ ; $-I_B = 5 \text{ mA}$	$-V_{CEsat}$	< 0,8	V
D.C. current gain $-I_C = 25 \text{ mA}$ ; $-V_{CE} = 20 \text{ V}$	$h_{FE}$	> 50	
Transition frequency at $f = 35 \text{ MHz}$ $-I_C = 10 \text{ mA}$ ; $-V_{CE} = 10 \text{ V}$	$f_T$	> 60	MHz
Feedback capacitance at $f = 1 \text{ MHz}$ $I_C = 0$ ; $-V_{CE} = 30 \text{ V}$	$C_{re}$	< 1,6	pF

\* See *Thermal characteristics.*

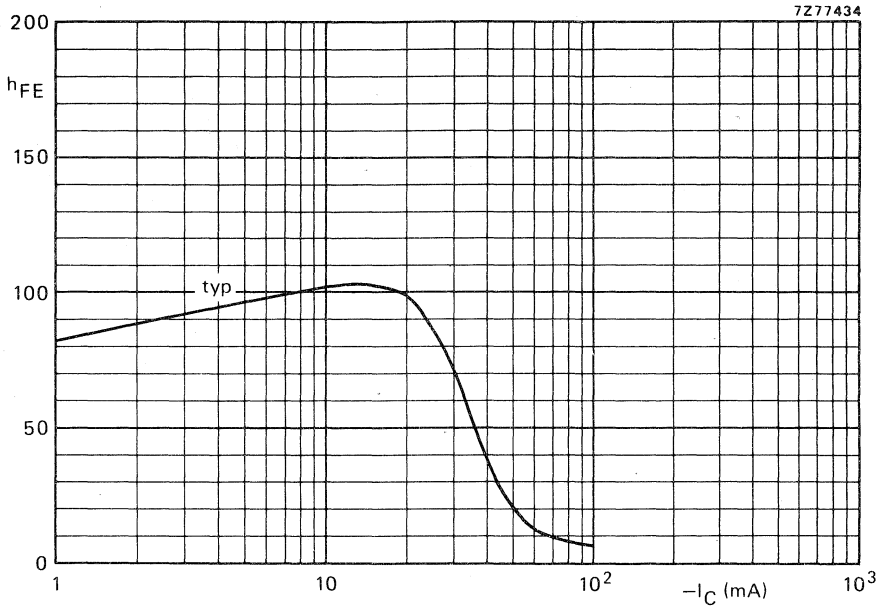


Fig. 2 Typical values at  $-V_{CE} = 20\text{ V}$ ;  $T_j = 25^\circ\text{C}$ .

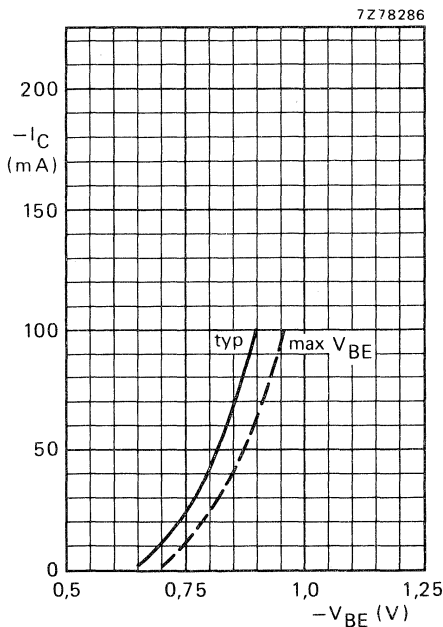


Fig. 3  $-V_{CE} = 20\text{ V}$ ;  $T_j = 25^\circ\text{C}$ .

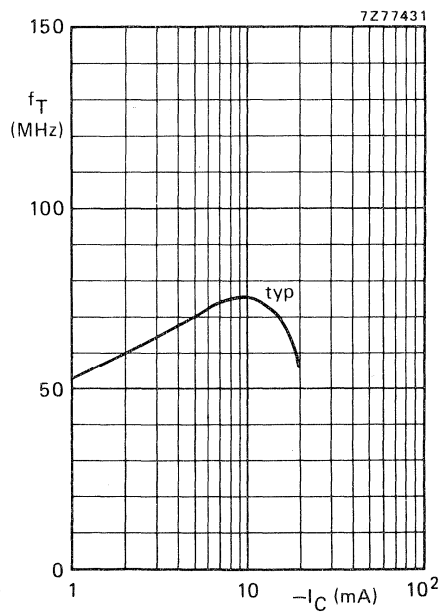


Fig. 4  $-V_{CE} = 10\text{ V}$ ;  $T_j = 25^\circ\text{C}$ ;  $f = 35\text{ MHz}$ .

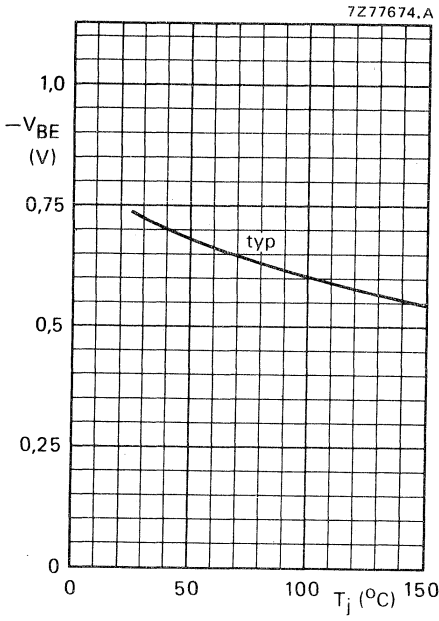


Fig. 5  $-I_C = 25$  mA;  $-V_{CE} = 20$  V.

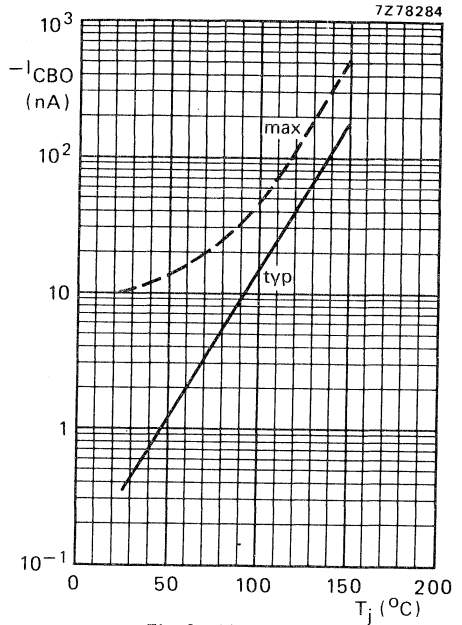


Fig. 6  $-V_{CB} = 200$  V.

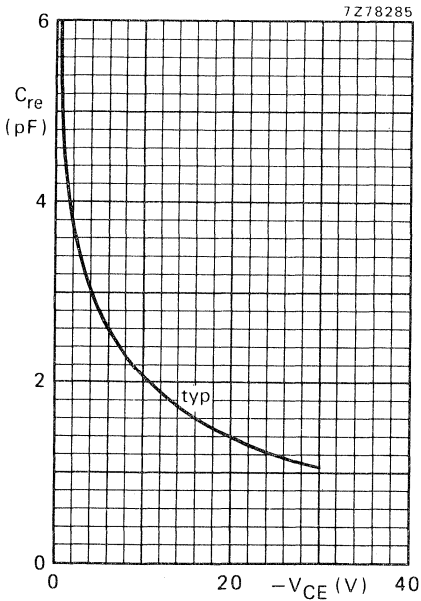


Fig. 7  $I_C = 0$ ;  $f = 1$  MHz;  $T_j = 25$  °C.



## SILICON PLANAR TRANSISTOR

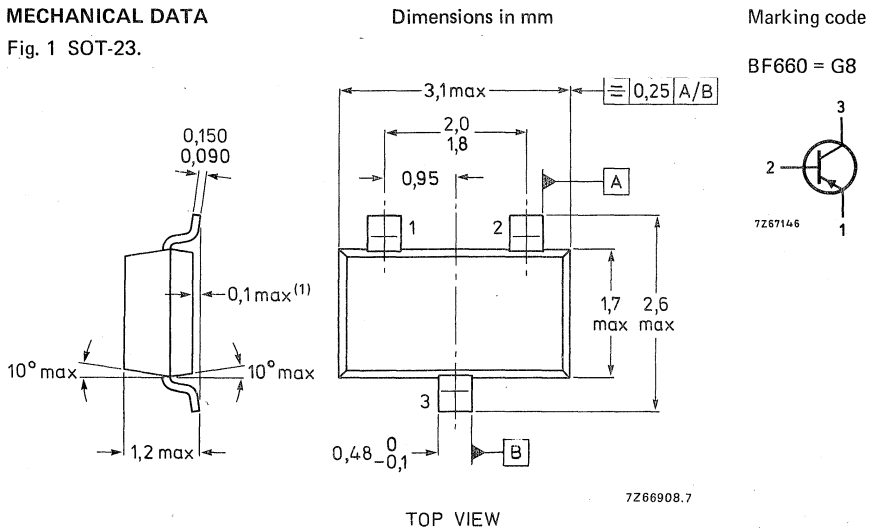
P-N-P transistor, in a microminiature plastic envelope; intended for use as oscillator in v.h.f. tuners with extended frequency range and/or in conjunction with MOS-FETs in thick and thin-film circuits.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	40 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	30 V
Collector current (peak value)	$-I_{CM}$	max.	25 mA
Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^{\circ}\text{C}$
Transition frequency at $f = 100\text{ MHz}$ $I_E = 5\text{ mA}; -V_{CB} = 10\text{ V}$	$f_T$	typ.	650 MHz

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$-V_{CB0}$	max.	40 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	30 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	4 V
Collector current (peak value)	$-I_{CM}$	max.	25 mA
Base current (d.c.)	$-I_B$	max.	10 mA
Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}$ **	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		$-65$ to $+150\text{ }^{\circ}\text{C}$
Junction temperature	$T_j$	max.	$150\text{ }^{\circ}\text{C}$

## THERMAL CHARACTERISTICS\*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

## Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

 $T_{amb} = 25\text{ }^{\circ}\text{C}$ 

Collector cut-off current

$I_E = 0; -V_{CB} = 20\text{ V}$

$-I_{CBO} < 50\text{ nA}$

D.C. current gain

$I_E = 3\text{ mA}; -V_{CE} = 10\text{ V}$

$h_{FE} > 30$

Transition frequency at  $f = 100\text{ MHz}$ 

$I_E = 5\text{ mA}; -V_{CB} = 10\text{ V}$

$f_T \text{ typ. } 650\text{ MHz}$

Feedback capacitance at  $f = 1\text{ MHz}$ 

$I_E = 1\text{ mA}; -V_{CB} = 10\text{ V}$

$C_{re} \text{ typ. } 0,65\text{ pF}$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

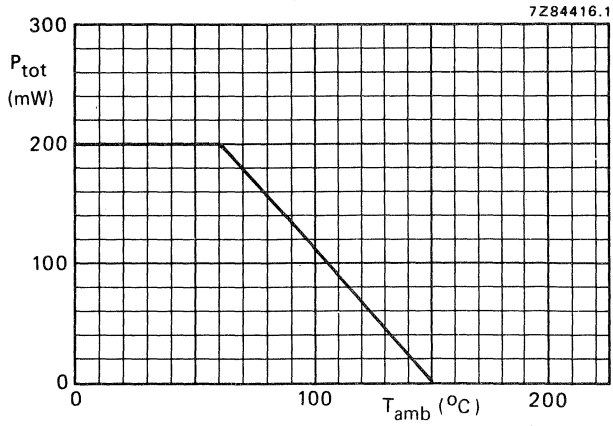


Fig. 2 Power derating curve.



## SILICON PLANAR TRANSISTOR

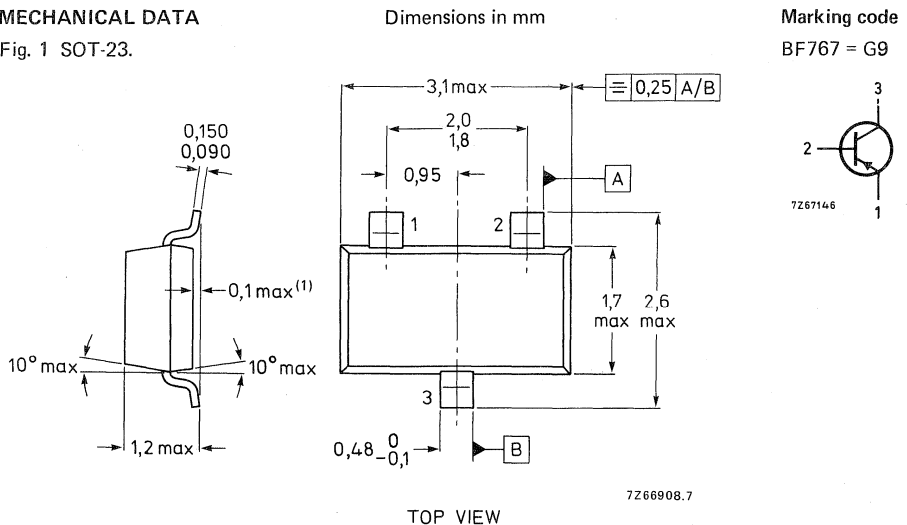
P-N-P transistor in a microminiature plastic envelope, primarily intended for application as gain controlled amplifier e.g. in v.h.f. and u.h.f. television tuners in thick and thin-film circuits.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	30 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	30 V
Collector current (d.c.)	$-I_C$	max.	20 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Transition frequency at $f = 100\text{ MHz}$ $I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}$	$f_T$	typ.	900 MHz
Transducer gain (common base) $I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz}$ $R_S = 60\ \Omega; R_L = 500\ \Omega$	$G_{tr}$	typ.	13 dB
Noise figure (common base) $I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz}$ $R_S = 60\ \Omega; R_L = 500\ \Omega$	F	typ.	4 dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	30 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	30 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	3 V
Collector current (d.c.)	$-I_C$	max.	20 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		$-65$ to $+150\text{ }^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_{amb} = 25\text{ }^\circ\text{C}$ ; unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 15\text{ V} \quad -I_{CBO} < 100\text{ nA}$$

D.C. current gain

$$-I_E = 3\text{ mA}; -V_{CB} = 10\text{ V} \quad h_{FE} > 15$$

$$-I_E = 7\text{ mA}; -V_{CB} = 4\text{ V} \quad h_{FE} \text{ typ. } 60$$

$$-I_E = 7\text{ mA}; -V_{CB} = 4\text{ V} \quad h_{FE} > 10$$

Transition frequency at  $f = 100\text{ MHz}$

$$I_E = 3\text{ mA}; -V_{CB} = 10\text{ V} \quad f_T \text{ typ. } 900\text{ MHz}$$

$$I_E = 7\text{ mA}; -V_{CB} = 5\text{ V} \quad f_T \text{ typ. } 90\text{ MHz}$$

Feedback capacitance at  $f = 500\text{ kHz}$

$$I_E = 1\text{ mA}; -V_{CB} = 10\text{ V} \quad C_{re} \text{ typ. } 0,3\text{ pF}$$

$$I_E = 0; -V_{CB} = 10\text{ V} \quad C_{rb} \text{ typ. } 160\text{ fF}$$

Transducer gain (common base)

$$I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz} \\ R_S = 60\ \Omega; R_L = 500\ \Omega \quad G_{tr} \text{ typ. } 13\text{ dB}$$

Noise figure (common base)

$$I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz} \\ R_S = 60\ \Omega; R_L = 500\ \Omega \quad F \text{ typ. } 4\text{ dB}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

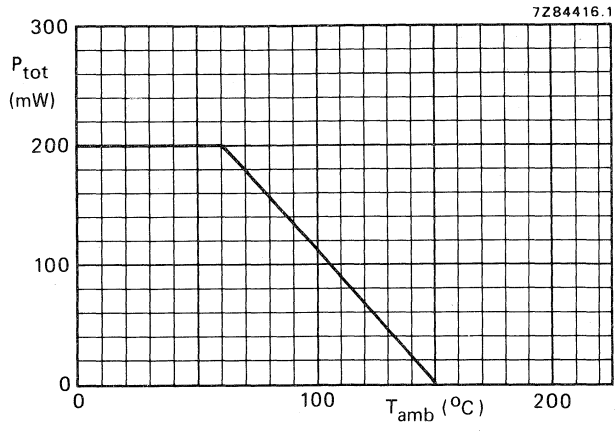


Fig. 2 Power derating curve.





## SILICON EPITAXIAL TRANSISTORS

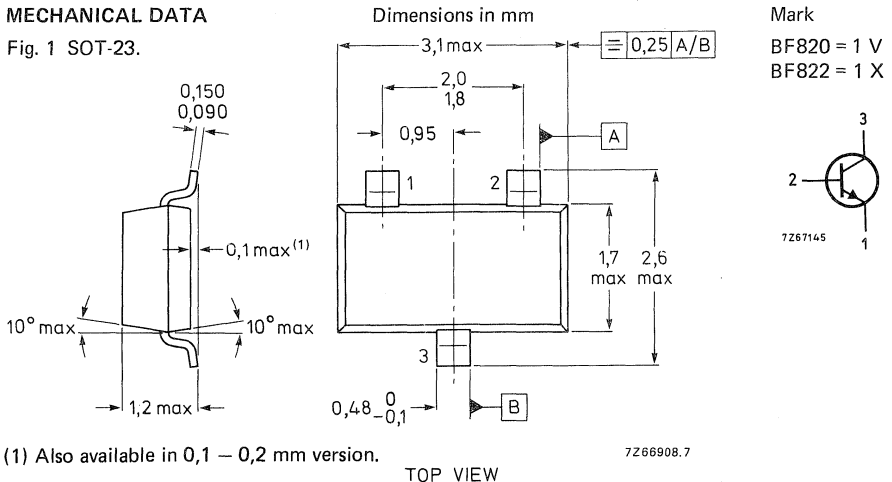
N-P-N transistors in a microminiature plastic envelope intended for application in thick and thin-film circuits. Primarily intended for use in telephony and professional communication equipment. P-N-P components are BF821, BF823 respectively.

### QUICK REFERENCE DATA

		BF820	BF822
Collector-base voltage (open emitter)	$V_{CBO}$ max.	300	250 V
Collector-emitter voltage (open base)	$V_{CEO}$ max.	—	250 V
Collector-emitter voltage ( $R_{BE} = 2,7 \text{ k}\Omega$ )	$V_{CER}$ max.	300	— V
Collector current (peak value)	$I_{CM}$ max.	100	mA
Total power dissipation up to $T_{amb} = 35 \text{ }^\circ\text{C}$	$P_{tot}$ max.	310	mW
Junction temperature	$T_j$ max.	150	$^\circ\text{C}$
D.C. current gain	$h_{FE}$	>	50
$I_C = 25 \text{ mA}; V_{CE} = 20 \text{ V}$			
Feedback capacitance at $f = 1 \text{ MHz}$	$C_{re}$	<	1,6 pF
$I_C = 0; V_{CE} = 30 \text{ V}$			
Transition frequency at $f = 35 \text{ MHz}$	$f_T$	>	60 MHz
$I_C = 10 \text{ mA}; V_{CE} = 10 \text{ V}$			

### MECHANICAL DATA

Fig. 1 SOT-23.



See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BF820	BF822
Collector-base voltage (open emitter)	$V_{CB0}$	max. 300	250 V
Collector-emitter voltage (open base)	$V_{CEO}$	max. -	250 V
Collector-emitter voltage ( $R_{BE} = 2,7 \text{ k}\Omega$ )	$V_{CER}$	max. 300	- V
Emitter-base voltage (open collector)	$V_{EBO}$	max. .	5 V
Collector current (d.c.)	$I_C$	max.	50 mA
Collector current (peak value)	$I_{CM}$	max.	100 mA
Total power dissipation* up to $T_{amb} = 35 \text{ }^\circ\text{C}$	$P_{tot}$	max.	310 mW
Storage temperature	$T_{stg}$		-65 to +150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\*\***

$$T_j = P(R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

from junction to tab	$R_{th j-t} =$	50	K/W
from tab to soldering points	$R_{th t-s} =$	260	K/W
from soldering points to ambient*	$R_{th s-a} =$	60	K/W

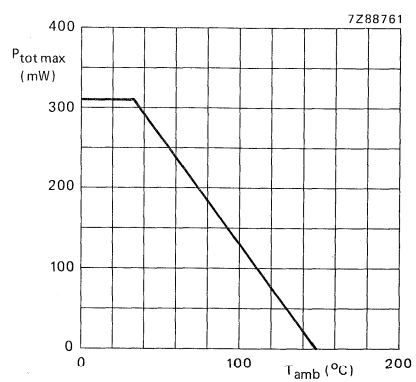


Fig. 2 Power derating curve.

\* Mounted on a ceramic substrate: area = 2,5 cm<sup>2</sup>; thickness = 0,7 mm.  
\*\* See *Thermal characteristics*.

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

 $I_E = 0; V_{CB} = 200\text{ V}$ 

	BF820	BF822
$I_{CBO}$	< 10	10 nA
$I_{CER}$	< 50	50 nA
$I_{CER}$	< 10	10 $\mu\text{A}$
$V_{CE\text{ sat}}$	< 0,6	V
$h_{FE}$	> 50	
$f_T$	> 60	MHz
$C_{re}$	< 1,6	pF

Collector-emitter voltage

 $R_{BE} = 2,7\text{ k}\Omega; V_{CE} = 250\text{ V}$  $R_{BE} = 2,7\text{ k}\Omega; V_{CE} = 200\text{ V}; T_j = 150\text{ }^\circ\text{C}$ 

Saturation voltage

 $I_C = 30\text{ mA}; I_B = 5\text{ mA}$ 

D.C. current gain

 $I_C = 25\text{ mA}; V_{CE} = 20\text{ V}$ Transition frequency at  $f = 35\text{ MHz}$  $I_C = 10\text{ mA}; V_{CE} = 10\text{ V}$ Feedback capacitance at  $f = 1\text{ MHz}$  $I_C = 0; V_{CE} = 30\text{ V}$

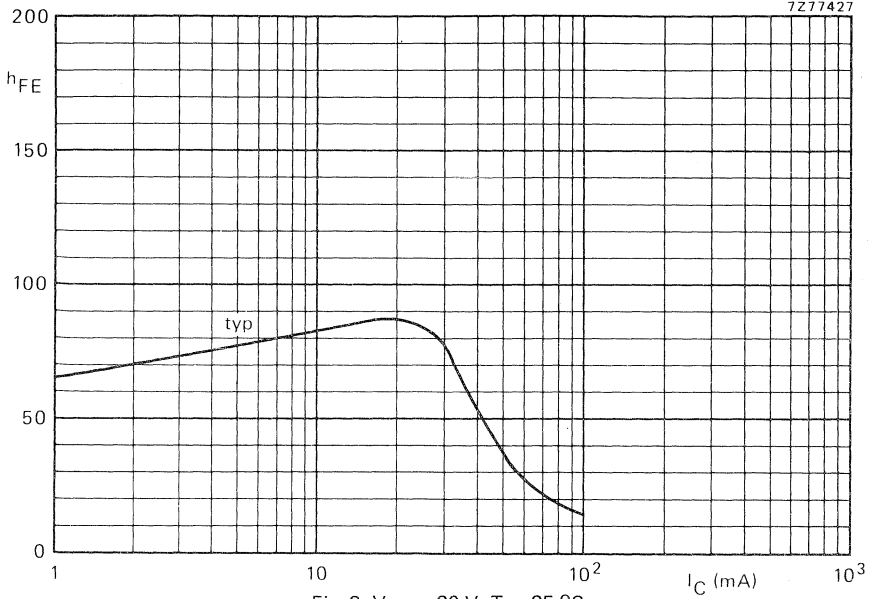


Fig. 3  $V_{CE} = 20$  V;  $T_j = 25$  °C.

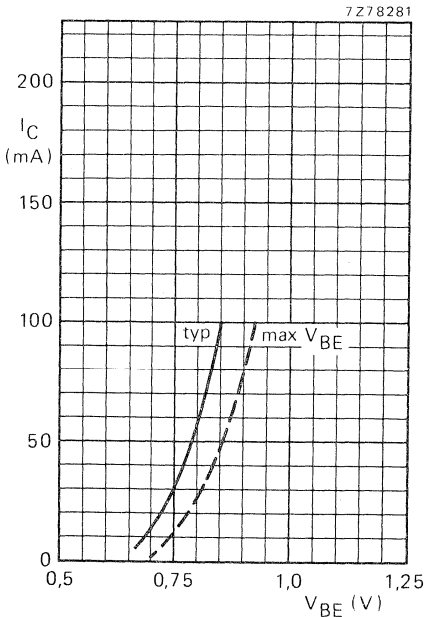


Fig. 4  $V_{CE} = 20$  V;  $T_j = 25$  °C.

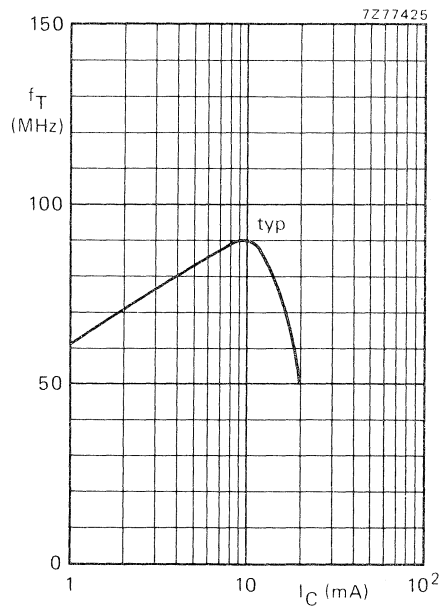


Fig. 5  $V_{CE} = 10$  V;  $T_j = 25$  °C,  $f = 35$  MHz.

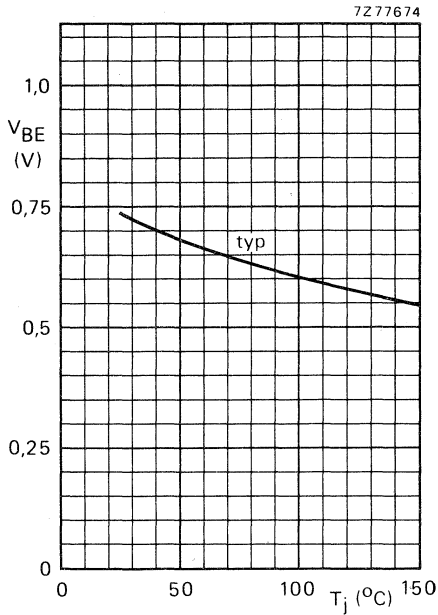


Fig. 6  $I_C = 25$  mA;  $V_{CE} = 20$  V.

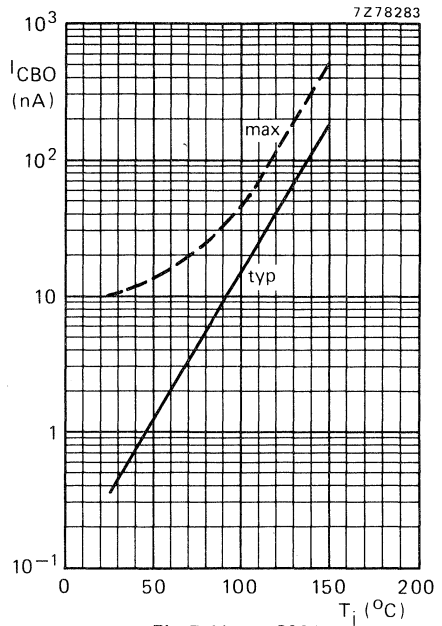


Fig. 7  $V_{CB} = 200$  V.

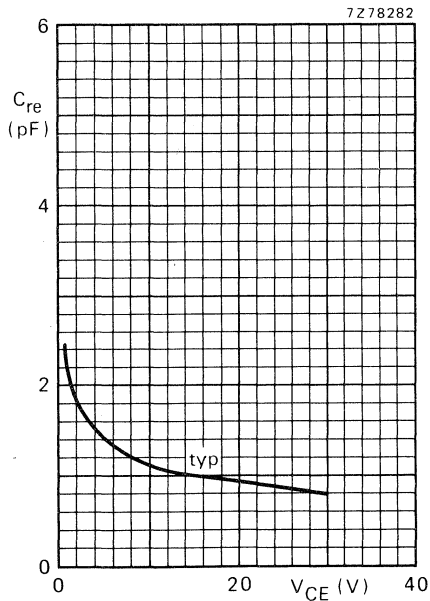


Fig. 8  $I_C = 0$ ;  $f = 1$  MHz;  $T_j = 25$  °C.



## SILICON EPITAXIAL TRANSISTORS

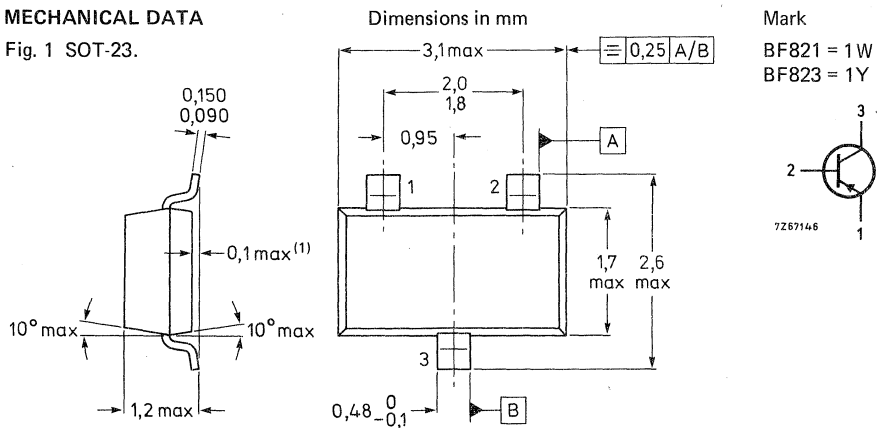
P-N-P transistors in a microminiature plastic envelope intended for application in thick and thin-film circuits. Primarily intended for use in telephony and professional communication equipment. N-P-N complements are BF820, BF822 respectively.

### QUICK REFERENCE DATA

		BF821	BF823
Collector-base voltage (open emitter)	$-V_{CBO}$ max.	300	250 V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	—	250 V
Collector-emitter voltage ( $R_{BE} = 2,7 \text{ k}\Omega$ )	$-V_{CER}$ max.	300	— V
Collector current (peak value)	$-I_{CM}$ max.	100	mA
Total power dissipation up to $T_{amb} = 35 \text{ }^\circ\text{C}$	$P_{tot}$ max.	310	mW
Junction temperature	$T_j$ max.	150	$^\circ\text{C}$
D.C. current gain			
$-I_C = 25 \text{ mA}; -V_{CE} = 20 \text{ V}$	$h_{FE} >$		50
Feedback capacitance at $f = 1 \text{ MHz}$			
$-I_C = 0; -V_{CE} = 30 \text{ V}$	$C_{re} <$	1,6	pF
Transition frequency at $f = 35 \text{ MHz}$			
$-I_C = 10 \text{ mA}; -V_{CE} = 10 \text{ V}$	$f_T >$	60	MHz

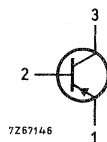
### MECHANICAL DATA

Fig. 1 SOT-23.



Mark

BF821 = 1W  
BF823 = 1Y



7Z66908.7

TOP VIEW

(1) Also available in 0,1 — 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BF821	BF823
Collector-base voltage (open emitter)	$-V_{CBO}$ max.	300	250 V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	—	250 V
Collector-emitter voltage ( $R_{BE} = 2,7 \text{ k}\Omega$ )	$-V_{CER}$ max.	300	— V
Emitter-base voltage (open collector)	$-V_{EBO}$ max.	5 V	
Collector current (d.c.)	$-I_C$ max.	50	mA
Collector current (peak value)	$-I_{CM}$ max.	100	mA
Total power dissipation * up to $T_{amb} = 35 \text{ }^\circ\text{C}$	$P_{tot}$ max.	310	mW
Storage temperature	$T_{stg}$	-65 to +150 $^\circ\text{C}$	
Junction temperature	$T_j$ max.	150	$^\circ\text{C}$

**THERMAL CHARACTERISTICS\*\***

$$T_j = P(R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

from junction to tab

from tab to soldering points

from soldering points to ambient \*

$R_{th\ j-t}$	=	50	K/W
$R_{th\ t-s}$	=	260	K/W
$R_{th\ s-a}$	=	60	K/W

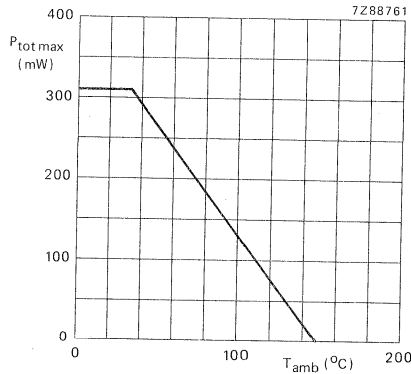


Fig. 2 Power derating curve.

\* Mounted on a ceramic substrate: area = 2,5 cm<sup>2</sup>; thickness = 0,7 mm.

\*\* See *Thermal characteristics*.



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_E = 0; -V_{CB} = 200\text{ V}$

	BF821	BF823
$-I_{CBO}$	< 10	10 nA
$-I_{CER}$	< 50	50 nA
$-I_{CER}$	< 10	10 $\mu\text{A}$
$-V_{CEsat}$	< 0,8	V
$h_{FE}$	> 50	
$f_T$	> 60	MHz
$C_{re}$	< 1,6	pF

Collector-emitter voltage

$R_{BE} = 2,7\text{ k}\Omega; -V_{CE} = 250\text{ V}$

$R_{BE} = 2,7\text{ k}\Omega; -V_{CE} = 200\text{ V}; T_j = 150\text{ }^\circ\text{C}$

Saturation voltage

$-I_C = 30\text{ mA}; -I_B = 5\text{ mA}$

D.C. current gain

$-I_C = 25\text{ mA}; -V_{CE} = 20\text{ V}$

Transition frequency at  $f = 35\text{ MHz}$ 

$-I_C = 10\text{ mA}; -V_{CE} = 10\text{ V}$

Feedback capacitance at  $f = 1\text{ MHz}$ 

$I_C = 0; -V_{CE} = 30\text{ V}$

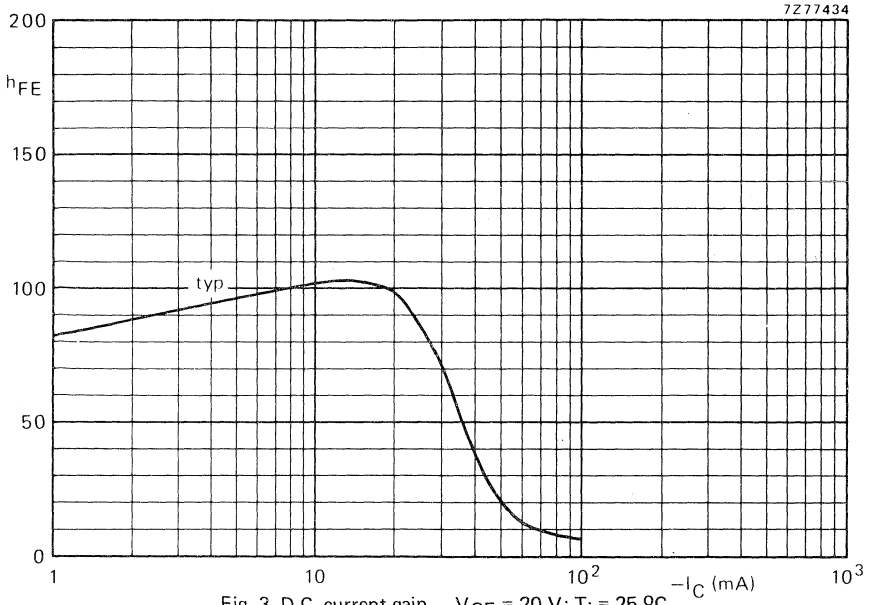


Fig. 3 D.C. current gain.  $-V_{CE} = 20 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ .

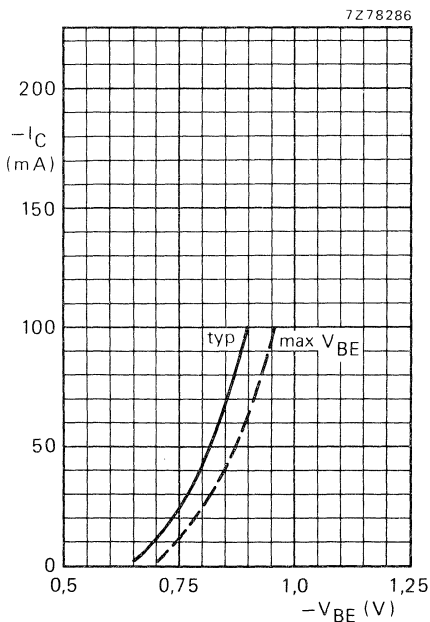


Fig. 4  $-V_{CE} = 20 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ .

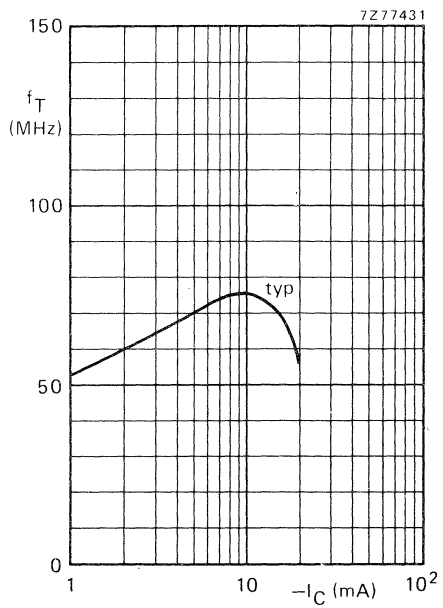


Fig. 5  $-V_{CE} = 10 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ ;  $f = 35 \text{ MHz}$ .

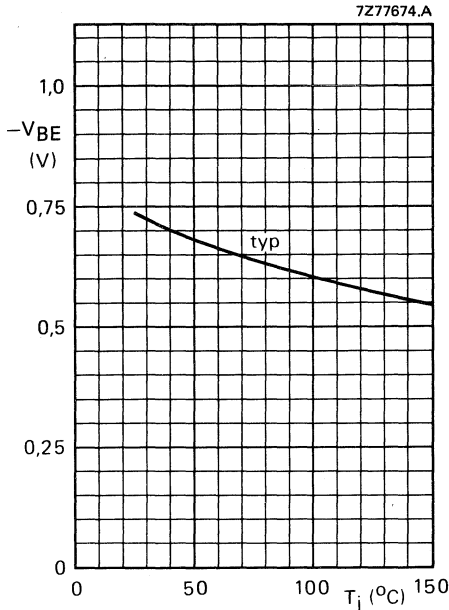


Fig. 6  $-I_C = 25 \text{ mA}$ ;  $-V_{CE} = 20 \text{ V}$ .

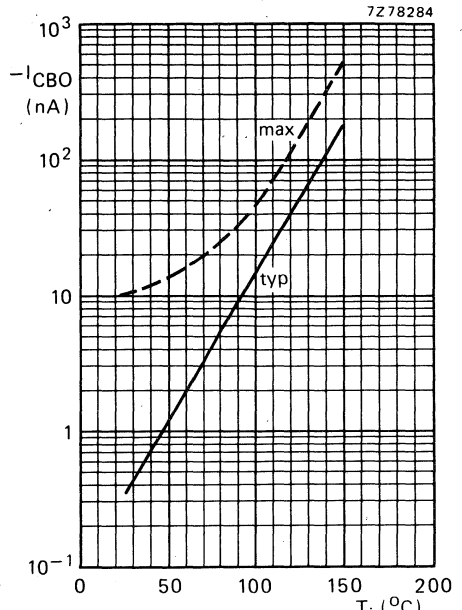


Fig. 7  $-V_{CB} = 200 \text{ V}$ .

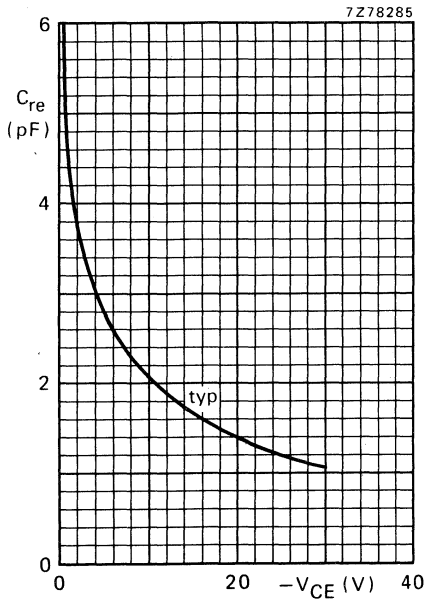


Fig. 8  $I_C = 0$ ;  $f = 1 \text{ MHz}$ ;  $T_j = 25^{\circ}\text{C}$ .



## H.F. SILICON PLANAR EPITAXIAL TRANSISTOR

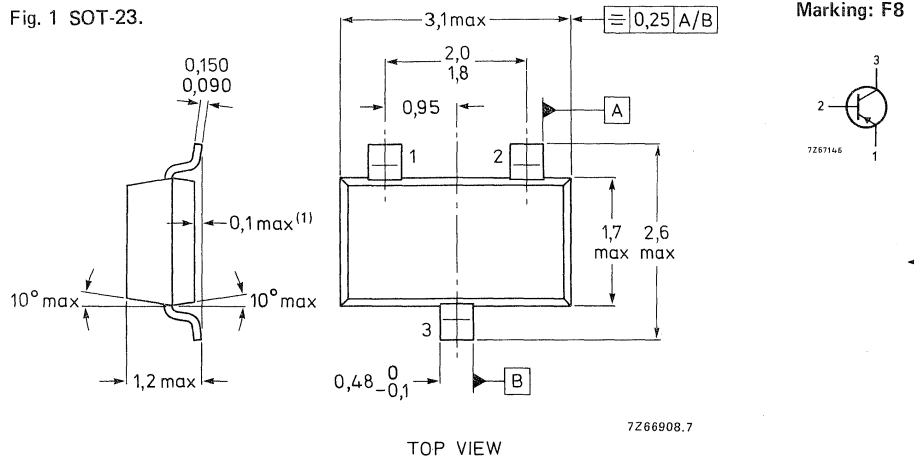
P-N-P transistor in a plastic SOT-23 envelope especially intended for r.f. stages in f.m. front-ends in common base configuration for SMD applications.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	30 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	30 V
Collector current (d.c.)	$-I_C$	max.	25 mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	300 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Base current	$-I_B$	typ.	80 $\mu\text{A}$
$-I_C = 4\text{ mA}; -V_{CE} = 10\text{ V}$		<	160 $\mu\text{A}$
Transition frequency	$f_T$	typ.	450 MHz
$-I_C = 4\text{ mA}; -V_{CE} = 10\text{ V}$			
Noise figure at $f = 100\text{ MHz}$	F	typ.	3 dB
$-I_C = 2\text{ mA}; -V_{CE} = 10\text{ V}; G_S = 16,7\text{ mS}$			
Feedback capacitance at $f = 1\text{ MHz}$	$C_{rb}$	typ.	0,1 pF
$V_{EB} = 0; -V_{CB} = 10\text{ V}$			

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	30 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	30 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	4 V
Collector current (d.c.)	$-I_C$	max.	25 mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}^*$	$P_{tot}$	max.	300 mW
Storage temperature	$T_{stg}$		-55 to + 150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air*	$R_{th\ j-a}$	=	430 K/W
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**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current $I_E = 0; -V_{CB} = 30\text{ V}$	$-I_{CBO}$	<	50 nA
Emitter cut-off current $I_C = 0; -V_{EB} = 4\text{ V}$	$-I_{EBO}$	<	10 $\mu\text{A}$
Base current $-I_C = 4\text{ mA}; -V_{CE} = 10\text{ V}$	$-I_B$	typ. <	80 $\mu\text{A}$ 160 $\mu\text{A}$
$-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$	$-I_B$	typ.	22 $\mu\text{A}$
Base-emitter voltage $-I_C = 4\text{ mA}; -V_{CE} = 10\text{ V}$	$-V_{BE}$	typ.	0,76 V
Transition frequency at $f = 100\text{ MHz}$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$	$f_T$	typ.	350 MHz
$-I_C = 4\text{ mA}; -V_{CE} = 10\text{ V}$	$f_T$	typ.	450 MHz
$-I_C = 8\text{ mA}; -V_{CE} = 10\text{ V}$	$f_T$	typ.	440 MHz
Feedback capacitance at $f = 1\text{ MHz}$ $V_{EB} = 0; -V_{CB} = 10\text{ V}$	$C_{rb}$	typ.	0,1 pF
Noise factor at $f = 100\text{ MHz}$ $-I_C = 2\text{ mA}; -V_{CE} = 10\text{ V};$ $G_s = 16,7\text{ mS}$	F	typ.	3 dB
$-I_C = 5\text{ mA}; -V_{CE} = 10\text{ V};$ $G_s = 6,7\text{ mS}; -jB_s = 5\text{ mS}$	F	typ.	3,5 dB

\* Mounted on ceramic substrate of 8 mm x 10 mm x 0,7 mm.

y-parameters (common base) at  $f = 100 \text{ MHz}$

$-I_C = 4 \text{ mA}; -V_{CB} = 10 \text{ V}$

Input conductance

$g_{ib}$  typ. 125 mS

Input capacitance

$C_{ib}$  typ. 64 pF

Transfer admittance

$|y_{fb}|$  typ. 100 mS

Phase angle of transfer admittance

$\varphi_{fb}$  typ.  $147^\circ$

Output conductance

$g_{ob}$  typ. 40  $\mu\text{S}$

Output capacitance

$C_{ob}$  typ. 1,25 pF

Feedback admittance

$|y_{rb}|$  typ. 220  $\mu\text{S}$

Phase angle of feedback admittance

$\varphi_{rb}$  typ.  $85^\circ$

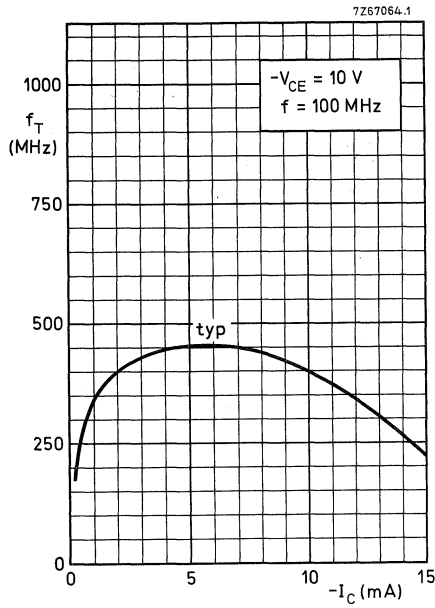


Fig. 2.

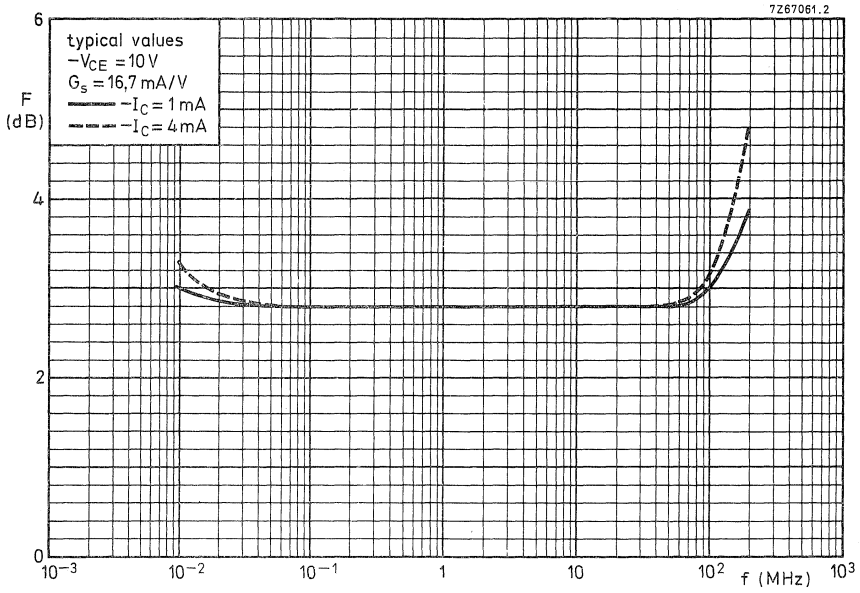


Fig. 3.

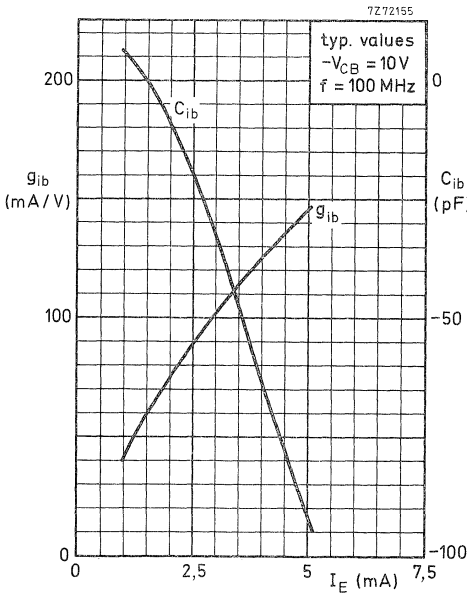


Fig. 4.

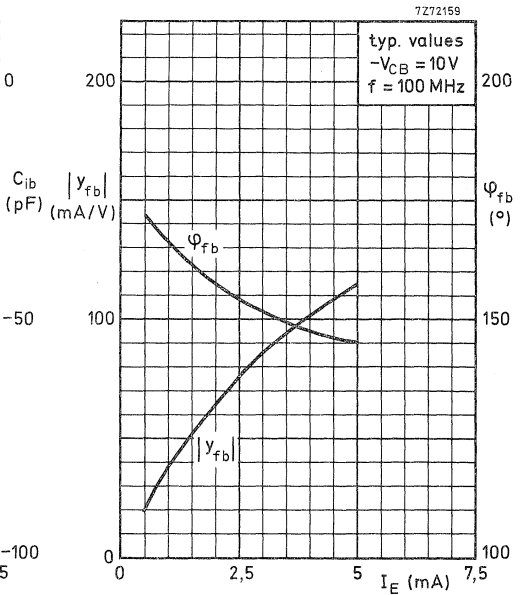


Fig. 5.



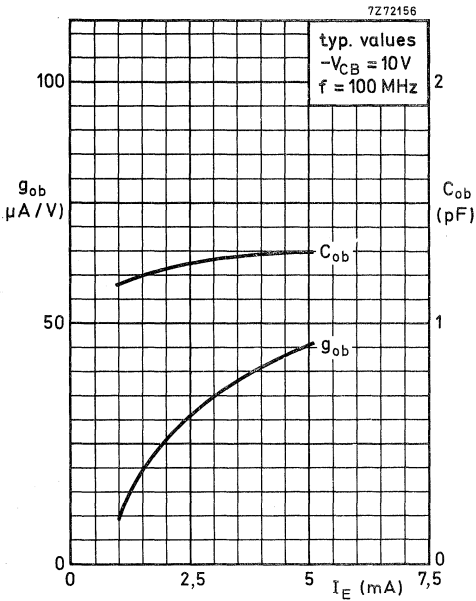


Fig. 6.

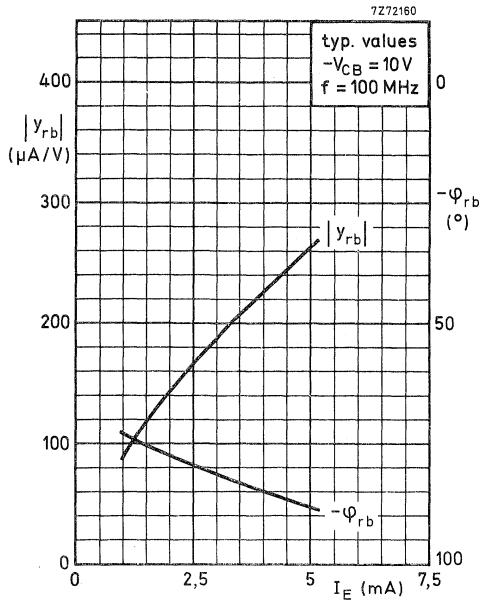


Fig. 7.

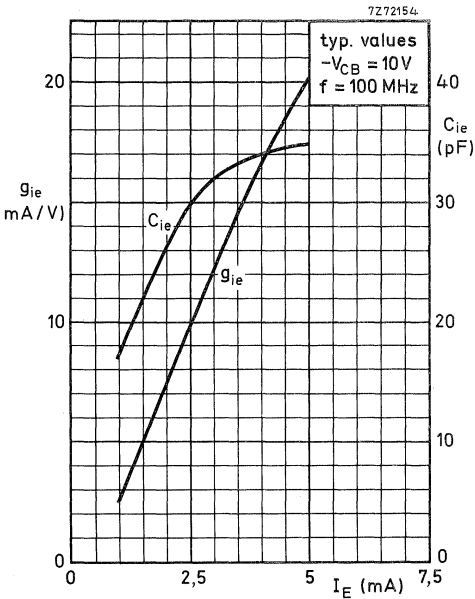


Fig. 8.

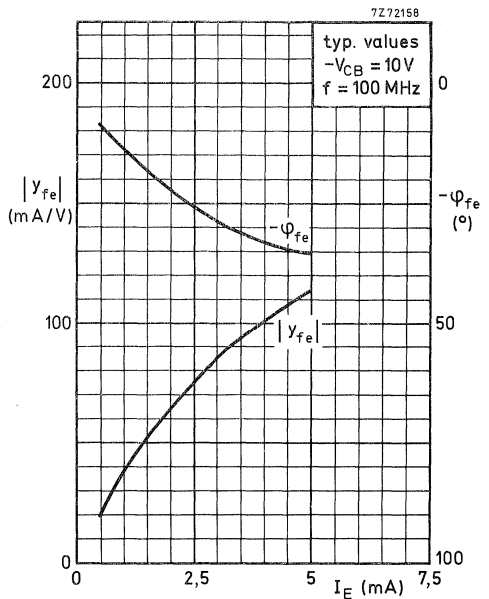


Fig. 9.

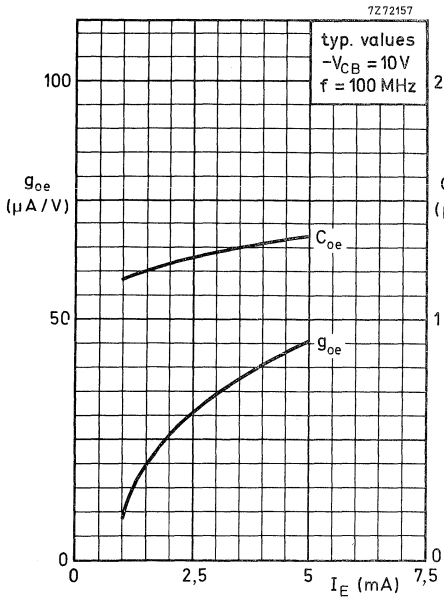


Fig. 10.

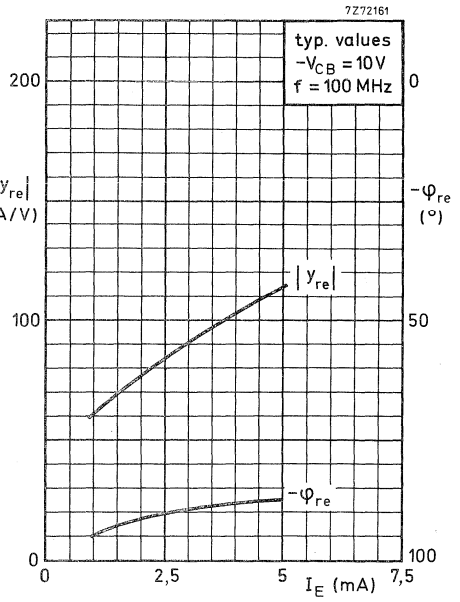


Fig. 11.

## SILICON N-CHANNEL DUAL GATE MOS-FET

Depletion type field-effect transistor in a plastic SOT-143 microminiature envelope with source and substrate interconnected. This MOS-FET tetrode is intended for use in u.h.f. applications in television tuners. The device is also suitable for use in professional communication equipment.

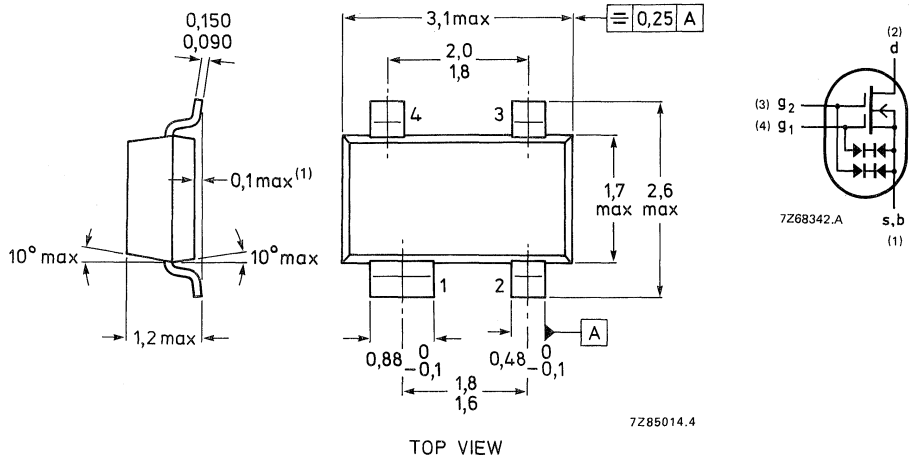
The device is protected against excessive input voltage surges by integrated back-to-back diodes between gates and source.

### QUICK REFERENCE DATA

Drain-source voltage	$V_{DS}$	max.	20 V
Drain current (peak value)	$I_{DM}$	max.	30 mA
Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^{\circ}\text{C}$
Transfer admittance at $f = 1\text{ kHz}$ $I_D = 7\text{ mA}$ ; $V_{DS} = 10\text{ V}$ ; $+V_{G2-S} = 4\text{ V}$	$ Y_{fs} $	typ.	12 mA/V
Feedback capacitance at $f = 1\text{ MHz}$ $I_D = 7\text{ mA}$ ; $V_{DS} = 10\text{ V}$ ; $+V_{G2-S} = 4\text{ V}$	$C_{rs}$	typ.	25 fF
Noise figure at $G_S = 2\text{ mA/V}$ $I_D = 7\text{ mA}$ ; $V_{DS} = 10\text{ V}$ ; $+V_{G2-S} = 4\text{ V}$ ; $f = 800\text{ MHz}$	F	typ.	2,8 dB

### MECHANICAL DATA

Fig. 1 SOT-143.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	$V_{DS}$	max.	20 V
Drain current (d.c. or average)	$I_D$	max.	20 mA
Drain current (peak value)	$I_{DM}$	max.	30 mA
Gate 1 - source current	$\pm I_{G1-S}$	max.	10 mA
Gate 2 - source current	$\pm I_{G2-S}$	max.	10 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^*$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air*	$R_{th\ j-a}$	=	460 K/W
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**STATIC CHARACTERISTICS**

$T_{amb} = 25\text{ }^\circ\text{C}$  unless otherwise specified

Gate cut-off currents

$\pm V_{G1-S} = 5\text{ V}; V_{G2-S} = V_{DS} = 0$	$\pm I_{G1-SS}$	<	50 nA
$\pm V_{G2-S} = 5\text{ V}; V_{G1-S} = V_{DS} = 0$	$\pm I_{G2-SS}$	<	50 nA

Drain current

$V_{DS} = 10\text{ V}; V_{G1-S} = 0; + V_{G2-S} = 4\text{ V}; T_j = 25\text{ }^\circ\text{C}$	$I_{DSS}$		2 to 20 mA
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Gate-source breakdown voltages

$\pm I_{G1-SS} = 10\text{ mA}; V_{G2-S} = V_{DS} = 0$	$\pm V_{(BR)G1-SS}$		6 to 20 V
$\pm I_{G2-SS} = 10\text{ mA}; V_{G1-S} = V_{DS} = 0$	$\pm V_{(BR)G2-SS}$		6 to 20 V

Gate-source cut-off voltages

$I_D = 20\text{ }\mu\text{A}; V_{DS} = 10\text{ V}; + V_{G2-S} = 4\text{ V}$	$-V_{(P)G1-S}$	<	2,7 V
$I_D = 20\text{ }\mu\text{A}; V_{DS} = 10\text{ V}; V_{G1-S} = 0$	$-V_{(P)G2-S}$	<	2,7 V

**DYNAMIC CHARACTERISTICS**

Measuring conditions (common source):  $I_D = 7\text{ mA}; V_{DS} = 10\text{ V}; + V_{G2-S} = 4\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$

Transfer admittance at $f = 1\text{ kHz}$	$ Y_{fs} $	>	9,5 mA/V
		typ.	12 mA/V
Input capacitance at gate 1; $f = 1\text{ MHz}$	$C_{ig1-s}$	typ.	1,8 pF
Input capacitance at gate 2; $f = 1\text{ MHz}$	$C_{ig2-s}$	typ.	1,0 pF
Feedback capacitance at $f = 1\text{ MHz}$	$C_{rs}$	typ.	25 fF
Output capacitance at $f = 1\text{ MHz}$	$C_{os}$	typ.	0,9 pF
Noise figure at $G_S = 2\text{ mA/V}$			
$f = 200\text{ MHz}$	F	typ.	1,6 dB
$f = 800\text{ MHz}$	F	typ.	2,8 dB

\* Device mounted on a ceramic substrate of 8 mm x 10 mm x 0,6 mm.

## SILICON N-CHANNEL DUAL GATE MOS-FET

Depletion type field-effect transistor in a plastic microminiature envelope with source and substrate interconnected, intended for u.h.f. applications, such as u.h.f. television tuners and professional communication equipment.

This MOS-FET tetrode is protected against excessive input voltage surges by integrated back-to-back diodes between gates and source.

### QUICK REFERENCE DATA

Drain-source voltage	$V_{DS}$	max.	18 V
Drain current (average)	$I_{D(AV)}$	max.	30 mA
Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^{\circ}\text{C}$
Transfer admittance at $f = 1\text{ kHz}$ $I_D = 10\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}$	$ y_{fs} $	typ.	21 mA/V
Feedback capacitance at $f = 1\text{ MHz}$ $I_D = 10\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}$	$C_{rs}$	typ.	25 fF
Noise figure at optimum source admittance $I_D = 10\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}; f = 800\text{ MHz}$	F	typ.	2,8 dB

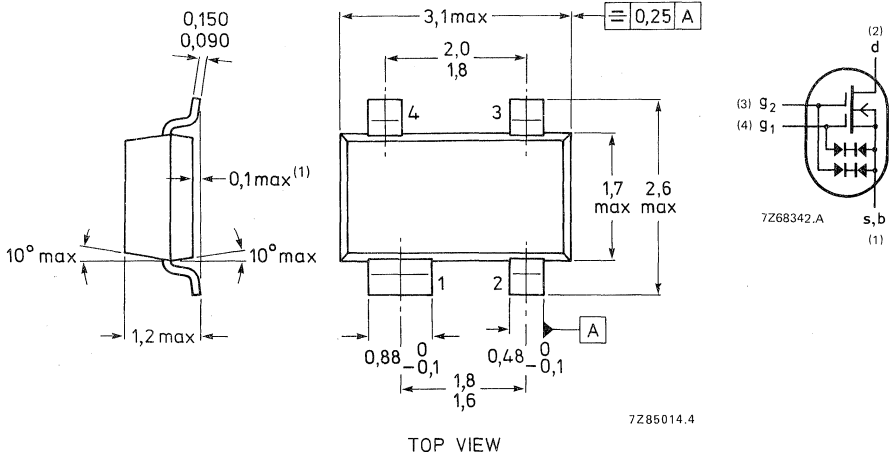
### MECHANICAL DATA

Fig. 1 SOT-143.

Dimensions in mm

Marking code

BF990 = M90



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	$V_{DS}$	max.	18 V
Drain current (average)	$I_D(AV)$	max.	30 mA
Gate 1 source current	$\pm I_{G1-S}$	max.	10 mA
Gate 2 source current	$\pm I_{G2-S}$	max.	10 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^*$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air\*  $R_{thj-a} = 460\text{ K/W}$

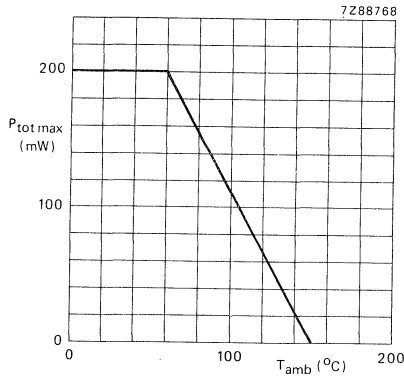


Fig. 2 Power derating curve.

\* Device mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

**STATIC CHARACTERISTICS**

$T_{amb} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified

## Gate cut-off currents

gate 1;  
 $\pm V_{G1-S} = 7\text{ V}; V_{G2-S} = V_{DS} = 0$   $\pm I_{G1-SS} < 25\text{ nA}$

gate 2;  
 $\pm V_{G2-S} = 7\text{ V}; V_{G1-S} = V_{DS} = 0$   $\pm I_{G2-SS} < 25\text{ nA}$

## Gate-source breakdown voltages

gate 1;  
 $\pm I_{G1-SS} = 10\text{ mA}; V_{G2-S} = V_{DS} = 0$   $\pm V_{(BR)G1-SS} > 8\text{ V}$

gate 2;  
 $\pm I_{G2-SS} = 10\text{ mA}; V_{G1-S} = V_{DS} = 0$   $\pm V_{(BR)G2-SS} > 8\text{ V}$

## Gate-source cut-off voltages

gate 1;  
 $I_D = 20\text{ }\mu\text{A}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}$   $-V_{(P)G1-S} < 1,3\text{ V}$

gate 2;  
 $I_D = 20\text{ }\mu\text{A}; V_{DS} = 10\text{ V}; V_{G1-S} = 0$   $-V_{(P)G2-S} < 1,1\text{ V}$

**DYNAMIC CHARACTERISTICS**

Measuring conditions (common source):  $I_D = 10\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}; T_{amb} = 25\text{ }^{\circ}\text{C}$

Transfer admittance at $f = 1\text{ kHz}$	$ y_{fs} $	$>$	17 mA/V
		typ.	21 mA/V
Input capacitance at gate 1; $f = 1\text{ MHz}$	$C_{ig1-s}$	typ.	3 pF
Input capacitance at gate 2; $f = 1\text{ MHz}$	$C_{ig2-s}$	typ.	1,4 pF
Feedback capacitance at $f = 1\text{ MHz}$	$C_{rs}$	typ.	25 fF
Output capacitance at $f = 1\text{ MHz}$	$C_{os}$	typ.	1,2 pF
Noise figure at $f = 800\text{ MHz}; G_S = 5\text{ mA/V}$	F	typ.	2,8 dB





## SILICON N-CHANNEL DUAL GATE MOS-FET

Depletion type field-effect transistor in a plastic SOT-143 microminiature envelope with source and substrate interconnected. This MOS-FET tetrode is intended for use in v.h.f. applications, such as v.h.f. television tuners and f.m. tuners. The device is also suitable for use in professional communication equipment.

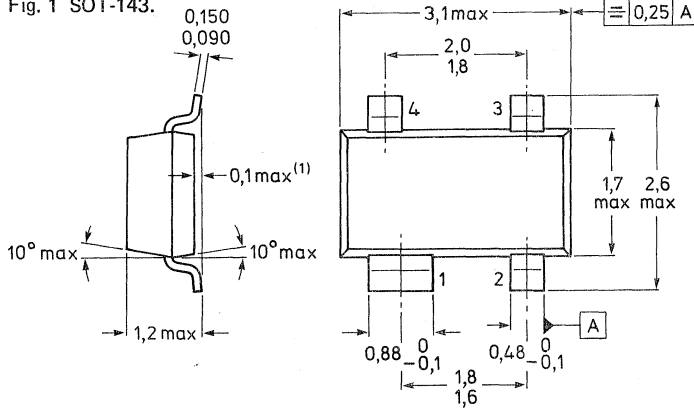
The device is protected against excessive input voltage surges by integrated back-to-back diodes between gates and source.

### QUICK REFERENCE DATA

Drain-source voltage	$V_{DS}$	max.	20 V
Drain current	$I_D$	max.	20 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Transfer admittance at $f = 1\text{ kHz}$ $I_D = 10\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}$	$ y_{fs} $	typ.	14 mA/V
Feedback capacitance at $f = 1\text{ MHz}$ $I_D = 10\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}$	$C_{rs}$	typ.	20 fF
Noise figure at optimum source admittance $I_D = 10\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}; f = 200\text{ MHz}$	F	typ.	0,7 dB

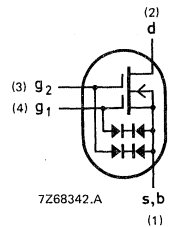
### MECHANICAL DATA

Fig. 1 SOT-143.



### Marking code

BF991 = M91



TOP VIEW

(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	$V_{DS}$	max.	20 V
Drain current (d.c. or average)	$I_D$	max.	20 mA
Drain current (peak value)	$I_{DM}$	max.	30 mA
Gate 1 - source current	$\pm I_{G1-S}$	max.	10 mA
Gate 2 - source current	$\pm I_{G2-S}$	max.	10 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^*$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air*	$R_{th\ j-a}$	=	460 K/W
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**STATIC CHARACTERISTICS**

$T_{amb} = 25\text{ }^\circ\text{C}$  unless otherwise specified

Gate cut-off currents

$\pm V_{G1-S} = 5\text{ V}; V_{G2-S} = V_{DS} = 0$	$\pm I_{G1-SS}$	<	50 nA
$\pm V_{G2-S} = 5\text{ V}; V_{G1-S} = V_{DS} = 0$	$\pm I_{G2-SS}$	<	50 nA

Drain current

$V_{DS} = 10\text{ V}; V_{G1-S} = 0; + V_{G2-S} = 4\text{ V}; T_j = 25\text{ }^\circ\text{C}$	$I_{DSS}$		4 to 25 mA
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Gate-source breakdown voltages

$\pm I_{G1-SS} = 10\text{ mA}; V_{G2-S} = V_{DS} = 0$	$\pm V_{(BR)G1-SS}$	>	6 V
$\pm I_{G2-SS} = 10\text{ mA}; V_{G1-S} = V_{DS} = 0$	$\pm V_{(BR)G2-SS}$	>	6 V

Gate-source cut-off voltages

$I_D = 20\text{ }\mu\text{A}; V_{DS} = 10\text{ V}; + V_{G2-S} = 4\text{ V}$	$-V_{(P)G1-S}$	<	2,5 V
$I_D = 20\text{ }\mu\text{A}; V_{DS} = 10\text{ V}; V_{G1-S} = 0$	$-V_{(P)G2-S}$	<	2,5 V

**DYNAMIC CHARACTERISTICS**

Measuring conditions (common source):  $I_D = 10\text{ mA}; V_{DS} = 10\text{ V}; + V_{G2-S} = 4\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$

Transfer admittance at $f = 1\text{ kHz}$	$ Y_{fs} $	>	10 mA/V
		typ.	14 mA/V
Input capacitance at gate 1; $f = 1\text{ MHz}$	$C_{ig1-s}$	typ.	2,1 pF
Input capacitance at gate 2; $f = 1\text{ MHz}$	$C_{ig2-s}$	typ.	1,0 pF
Feedback capacitance at $f = 1\text{ MHz}$	$C_{rs}$	typ.	20 fF
Output capacitance at $f = 1\text{ MHz}$	$C_{os}$	typ.	1,1 pF
Noise figure			
$f = 100\text{ MHz}; G_S = 1\text{ mA/V}$	F	typ.	0,7 dB
		<	1,7 dB
$f = 200\text{ MHz}; G_S = 2\text{ mA/V}$	F	typ.	1,0 dB
		<	2,0 dB
Transducer gain **			
$f = 100\text{ MHz}; G_S = 1\text{ mA/V}; G_L = 0,5\text{ mA/V}$	$G_{tr}$	typ.	29 dB
$f = 200\text{ MHz}; G_S = 2\text{ mA/V}; G_L = 0,5\text{ mA/V}$	$G_{tr}$	typ.	26 dB

\* Device mounted on a ceramic substrate of 8 mm x 10 mm x 0,6 mm.

\*\* Crystal mounted in a SOT-103 envelope.

## SILICON N-CHANNEL DUAL GATE MOS-FET

Depletion type field-effect transistor in a plastic SOT-143 microminiature envelope with source and substrate interconnected. This MOS-FET tetrode is intended for use in v.h.f. applications, such as v.h.f. television tuners, FM tuners with a 12 volt supply voltage. The device is also suitable for use in professional communication equipment.

The device is protected against excessive input voltage surges by integrated back-to-back diodes between gates and source.

### QUICK REFERENCE DATA

Drain-source voltage	$V_{DS}$	max.	20 V
Drain current	$I_D$	max.	40 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Transfer admittance at $f = 1\text{ kHz}$ $I_D = 15\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}$	$ Y_{fs} $	typ.	25 mA/V
Feedback capacitance at $f = 1\text{ MHz}$ $I_D = 15\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}$	$C_{rs}$	typ.	30 fF
Noise figure at $G_S = 2\text{ mA/V}$ $I_D = 15\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}; f = 200\text{ MHz}$	F	typ.	1,2 dB

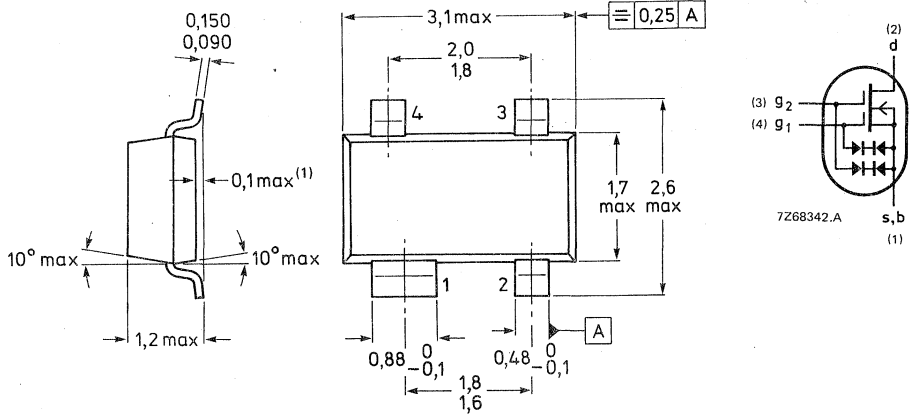
### MECHANICAL DATA

Dimensions in mm

### Marking code

BF992 = M92

Fig. 1 SOT-143.



TOP VIEW

(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	$V_{DS}$	max.	20 V
Drain current (d.c. or average)	$I_D$	max.	40 mA
Gate 1 - source current	$\pm I_{G1-S}$	max.	10 mA
Gate 2 - source current	$\pm I_{G2-S}$	max.	10 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^*$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air*	$R_{th\ j-a}$	=	460 K/W
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**STATIC CHARACTERISTICS**

$T_{amb} = 25\text{ }^\circ\text{C}$  unless otherwise specified

Gate cut-off currents

$\pm V_{G1-S} = 7\text{ V}; V_{G2-S} = V_{DS} = 0$	$\pm I_{G1-SS}$	<	25 nA
$\pm V_{G2-S} = 7\text{ V}; V_{G1-S} = V_{DS} = 0$	$\pm I_{G2-SS}$	<	25 nA

Gate-source breakdown voltages

$\pm I_{G1-SS} = 10\text{ mA}; V_{G2-S} = V_{DS} = 0$	$\pm V_{(BR)G1-SS}$	>	8 V
$\pm I_{G2-SS} = 10\text{ mA}; V_{G1-S} = V_{DS} = 0$	$\pm V_{(BR)G2-SS}$	>	8 V

Gate-source cut-off voltages

$I_D = 20\text{ }\mu\text{A}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}$	$-V_{(P)G1-S}$		0,2 to 1,3 V
$I_D = 20\text{ }\mu\text{A}; V_{DS} = 10\text{ V}; V_{G1-S} = 0$	$-V_{(P)G2-S}$		0,2 to 1,1 V

**DYNAMIC CHARACTERISTICS**

Measuring conditions (common source):  $I_D = 15\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$

Transfer admittance at $f = 1\text{ kHz}$	$ Y_{fs} $	>	20 mA/V
		typ.	25 mA/V
Input capacitance at gate 1; $f = 1\text{ MHz}$	$C_{ig1-s}$	typ.	4 pF
Input capacitance at gate 2; $f = 1\text{ MHz}$	$C_{ig2-s}$	typ.	1,7 pF
Feedback capacitance at $f = 1\text{ MHz}$	$C_{rs}$	typ.	30 fF
		<	40 fF
Output capacitance at $f = 1\text{ MHz}$	$C_{os}$	typ.	2 pF
Noise figure at $f = 200\text{ MHz}; G_S = 2\text{ mA/V}$	F	typ.	1,2 dB

\* Device mounted on a ceramic substrate of 8 mm x 10 mm x 0,6 mm.

## SILICON N-CHANNEL DUAL GATE MOS-FET

Depletion type field-effect transistor in a plastic microminiature envelope with source and substrate interconnected, intended for u.h.f. and v.h.f. applications, such as u.h.f./v.h.f. television tuners and professional communication equipment.

This MOS-FET tetrode is protected against excessive input voltage surges by integrated back-to-back diodes between gates and source.

### QUICK REFERENCE DATA

Drain-source voltage	$V_{DS}$	max.	20 V
Drain current (average)	$I_{D(AV)}$	max.	30 mA
Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^{\circ}\text{C}$
Transfer admittance at $f = 1\text{ kHz}$ $I_D = 10\text{ mA}; V_{DS} = 15\text{ V}; +V_{G2-S} = 4\text{ V}$	$ y_{fs} $	typ.	17 mA/V
Feedback capacitance at $f = 1\text{ MHz}$ $I_D = 10\text{ mA}; V_{DS} = 15\text{ V}; +V_{G2-S} = 4\text{ V}$	$C_{rs}$	typ.	25 fF
Noise figure at optimum source admittance $I_D = 10\text{ mA}; V_{DS} = 15\text{ V}; +V_{G2-S} = 4\text{ V}; f = 200\text{ MHz}$	F	typ.	1,5 dB

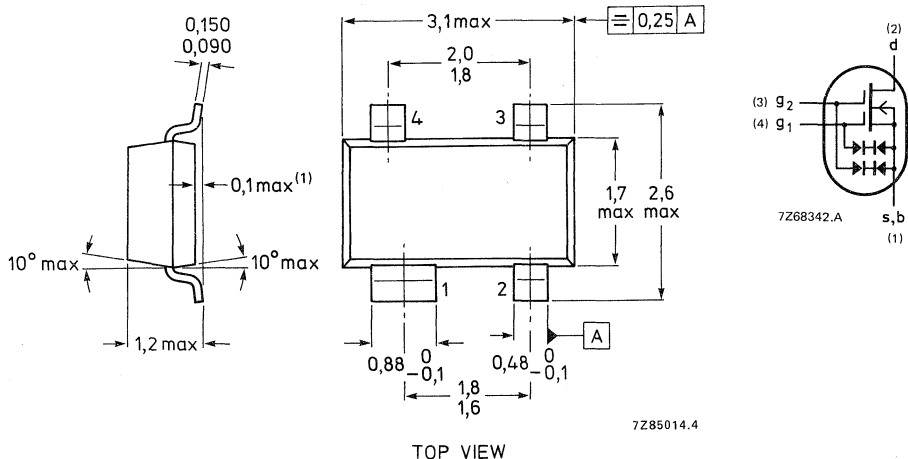
### MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-143.

BF994 = M94



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	$V_{DS}$	max.	20 V
Drain current (average)	$I_{D(AV)}$	max.	30 mA
Gate 1 source current	$\pm I_{G1-S}$	max.	10 mA
Gate 2 source current	$\pm I_{G2-S}$	max.	10 mA
Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}^*$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-65 to + 150 $^{\circ}\text{C}$
Junction temperature	$T_j$	max.	150 $^{\circ}\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air\*  $R_{th\ j-a} = 460\text{ K/W}$

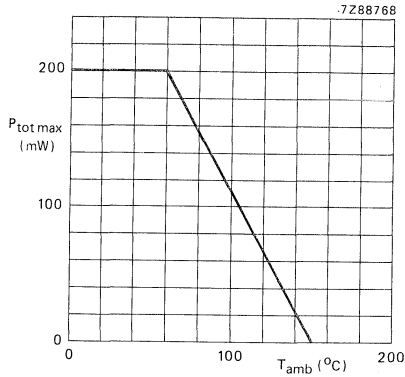


Fig. 2 Power derating curve.

\* Device mounted on a ceramic substrate of 8 mm x 10 mm x 0,6 mm.

**STATIC CHARACTERISTICS**

$T_{amb} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified

## Gate cut-off currents

gate 1; $\pm V_{G1-S} = 5\text{ V}; V_{G2-S} = V_{DS} = 0$	$\pm I_{G1-SS}$	<	50 nA
gate 2; $\pm V_{G2-S} = 5\text{ V}; V_{G1-S} = V_{DS} = 0$	$\pm I_{G2-SS}$	<	50 nA

## Gate-source breakdown voltages

gate 1; $\pm I_{G1-SS} = 10\text{ mA}; V_{G2-S} = V_{DS} = 0$	$\pm V_{(BR)G1-SS}$		6 to 20 V
gate 2; $\pm I_{G2-SS} = 10\text{ mA}; V_{G1-S} = V_{DS} = 0$	$\pm V_{(BR)G2-SS}$		6 to 20 V

## Gate-source cut-off voltages

gate 1; $I_D = 20\text{ }\mu\text{A}; V_{DS} = 15\text{ V}; +V_{G2-S} = 4\text{ V}$	$-V_{(P)G1-S}$	<	2,5 V
gate 2; $I_D = 20\text{ }\mu\text{A}; V_{DS} = 15\text{ V}; V_{G1-S} = 0$	$-V_{(P)G2-S}$	<	2,0 V

## Drain-source cut-off voltage

$V_{DS} = 15\text{ V}; V_{G2-S} = 4\text{ V}$	$I_{DSS}$		2 to 20 mA
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**DYNAMIC CHARACTERISTICS**

Measuring conditions (common source):  $I_D = 10\text{ mA}; V_{DS} = 15\text{ V}; +V_{G2-S} = 4\text{ V}; T_{amb} = 25\text{ }^{\circ}\text{C}$

Transfer admittance at $f = 1\text{ kHz}$	$ Y_{fs} $	>	15 mA/V
		typ.	17 mA/V
Input capacitance at gate 1; $f = 1\text{ MHz}$	$C_{ig1-s}$	typ.	2,5 pF
Input capacitance at gate 2; $f = 1\text{ MHz}$	$C_{ig2-s}$	typ.	1,2 pF
Feedback capacitance at $f = 1\text{ MHz}$	$C_{rs}$	typ.	25 fF
Output capacitance at $f = 1\text{ MHz}$	$C_{os}$	typ.	1,0 pF
Noise figure at $f = 200\text{ MHz}; G_S = 2\text{ mA/V}$	F	typ.	1,5 dB
		<	2,8 dB
Power gain at $G_S = 2\text{ mA/V}$			
$G_L = 0,5\text{ mA/V}, f = 200\text{ MHz}$	$G_p$	typ.	25 dB





## SILICON N-CHANNEL DUAL GATE MOS-FET

Depletion type field-effect transistor in a plastic microminiature envelope, with source and substrate interconnected, intended for u.h.f. applications, such as television tuners and professional communication equipment.

This MOS-FET tetrode is protected against excessive input voltage surges by integrated back-to-back diodes between gates and source.

### QUICK REFERENCE DATA

Drain-source voltage	$V_{DS}$	max.	20 V
Drain current (average)	$I_{D(AV)}$	max.	30 mA
Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^{\circ}\text{C}$
Transfer admittance at $f = 1\text{ kHz}$ $I_D = 10\text{ mA}; V_{DS} = 15\text{ V}; +V_{G2-S} = 4\text{ V}$	$ y_{fs} $	typ.	17 mA/V
Feedback capacitance at $f = 1\text{ MHz}$ $I_D = 10\text{ mA}; V_{DS} = 15\text{ V}; +V_{G2-S} = 4\text{ V}$	$C_{rs}$	typ.	25 fF
Noise figure at optimum source admittance $I_D = 10\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}; f = 800\text{ MHz}$	F	typ.	2,8 dB
$I_D = 10\text{ mA}; V_{DS} = 15\text{ V}; +V_{G2-S} = 4\text{ V}; f = 200\text{ MHz}$	F	typ.	1,5 dB

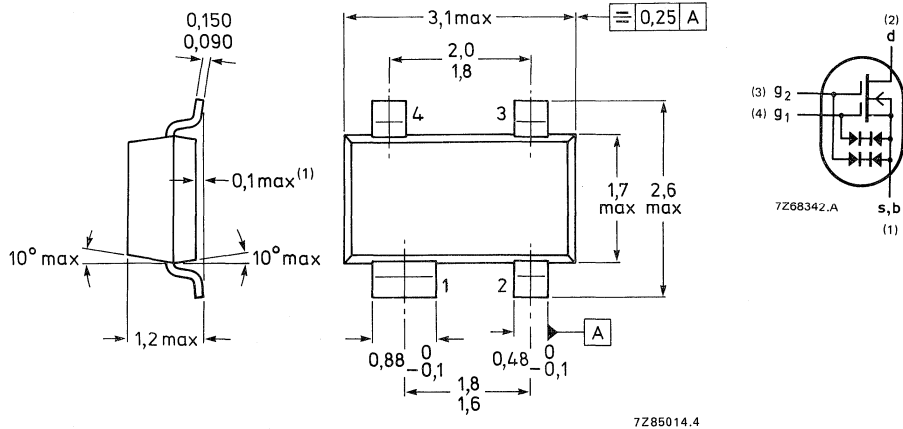
### MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-143.

BF996 = M96



(1) Also available in 0,1 – 0,2 mm version.

TOP VIEW

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	$V_{DS}$	max.	20 V
Drain current (average)	$I_{D(AV)}$	max.	30 mA
Gate 1 source current	$\pm I_{G1-S}$	max.	10 mA
Gate 2 source current	$\pm I_{G2-S}$	max.	10 mA
Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}^*$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-65 to + 150 $^{\circ}\text{C}$
Junction temperature	$T_j$	max.	150 $^{\circ}\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air*	$R_{th\ j-a}$	=	460 K/W
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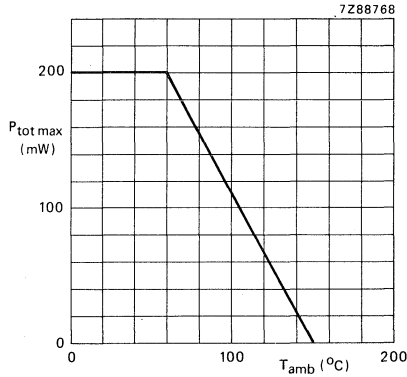


Fig. 2 Power derating curve.

\* Device mounted on a ceramic substrate of 8 mm x 10 mm x 0,6 mm.

**STATIC CHARACTERISTICS**

$T_{amb} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified

## Gate cut-off currents

gate 1;  
 $\pm V_{G1-S} = 5\text{ V}; V_{G2-S} = V_{DS} = 0$   $\pm I_{G1-SS}$  < 50 nA

gate 2;  
 $\pm V_{G2-S} = 5\text{ V}; V_{G1-S} = V_{DS} = 0$   $\pm I_{G2-SS}$  < 50 nA

## Gate-source breakdown voltages

gate 1;  
 $\pm I_{G1-SS} = 10\text{ mA}; V_{G2-S} = V_{DS} = 0$   $\pm V_{(BR)G1-SS}$  6 to 20 V

gate 2;  
 $\pm I_{G2-SS} = 10\text{ mA}; V_{G1-S} = V_{DS} = 0$   $\pm V_{(BR)G2-SS}$  6 to 20 V

## Gate-source cut-off voltages

gate 1;  
 $I_D = 20\text{ }\mu\text{A}; V_{DS} = 15\text{ V}; +V_{G2-S} = 4\text{ V}$   $-V_{(P)G1-S}$  < 2,5 V

gate 2;  
 $I_D = 20\text{ }\mu\text{A}; V_{DS} = 15\text{ V}; V_{G1-S} = 0$   $-V_{(P)G2-S}$  < 2,0 V

## Drain-source cut-off voltage

$V_{DS} = 15\text{ V}; V_{G2-S} = 4\text{ V}$   $I_{DSS}$  2 to 20 mA

**DYNAMIC CHARACTERISTICS**

Measuring conditions (common source):  $I_D = 10\text{ mA}; V_{DS} = 15\text{ V}; +V_{G2-S} = 4\text{ V}; T_{amb} = 25\text{ }^{\circ}\text{C}$

Transfer admittance at  $f = 1\text{ kHz}$   $|y_{fs}|$  > 15 mA/V  
 typ. 17 mA/V

Input capacitance at gate 1;  $f = 1\text{ MHz}$   $C_{ig1-s}$  typ. 2,2 pF

Input capacitance at gate 2;  $f = 1\text{ MHz}$   $C_{ig2-s}$  typ. 1,1 pF

Feedback capacitance at  $f = 1\text{ MHz}$   $C_{rs}$  typ. 25 fF

Output capacitance at  $f = 1\text{ MHz}$   $C_{os}$  typ. 0,8 pF

## Noise figure

at  $G_S = 2\text{ mA/V}, f = 200\text{ MHz}$  F typ. 1,5 dB

at  $G_S = 2\text{ mA/V}, f = 800\text{ MHz}$  F typ. 2,8 dB  
 < 3,9 dB

## Power gain

$G_S = 2\text{ mA/V}, G_L = 0,5\text{ mA/V}, f = 200\text{ MHz}$   $G_p$  typ. 25 dB

$G_S = 2\text{ mA/V}, G_L = 1,0\text{ mA/V}, f = 800\text{ MHz}$   $G_p$  typ. 18 dB





**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Voltages

Collector-base voltage (open emitter; peak value)	$V_{CBOM}$	max.	40	V
Collector-emitter voltage ( $R_{BE} \leq 50 \Omega$ ; peak value)	$V_{CERM}$	max.	40	V 1)
Collector-emitter voltage (open base)	$V_{CEO}$	max.	25	V 1)
Emitter-base voltage (open collector)	$V_{EBO}$	max.	2	V

Currents

Collector current (d. c.)	$I_C$	max.	150	mA
Collector current (peak value; $f > 1$ MHz)	$I_{CM}$	max.	300	mA

Power dissipation

Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ mounted on a ceramic substrate area = 2,5 cm <sup>2</sup> ; thickness = 0,7 mm	$P_{tot}$	max.	1	W
--	-----------	------	---	---

Temperatures

Storage temperature	$T_{stg}$	-65 to +150	$^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to collector tab	$R_{thj-tab}$	=	30	$^\circ\text{C/W}$
From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm <sup>2</sup> ; thickness = 0,7 mm	$R_{thj-a}$	=	125	$^\circ\text{C/W}$

1)  $I_C = 10$  mA.

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 20\text{ V}; T_j = 150\text{ }^\circ\text{C}$

$I_{CBO} < 20\text{ }\mu\text{A}$

Saturation voltage

$I_C = 100\text{ mA}; I_B = 10\text{ mA}$

$V_{CEsat} < 0,5\text{ V}$

D.C. current gain

$I_C = 50\text{ mA}; V_{CE} = 5\text{ V}$

$h_{FE} > 25$

$I_C = 150\text{ mA}; V_{CE} = 5\text{ V}$

$h_{FE} > 25$

Transition frequency at  $f = 500\text{ MHz}$  1)

$I_C = 150\text{ mA}; V_{CE} = 15\text{ V}$

$f_T$  typ. 1,2 GHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 15\text{ V}$

$C_c < 4\text{ pF}$

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 10\text{ mA}; V_{CE} = 15\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$

$C_{re}$  typ. 1,9 pF

Max. unilateral power gain (s<sub>re</sub> assumed to be zero)

$$GUM \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$I_C = 60\text{ mA}; V_{CE} = 15\text{ V}; T_{amb} = 25\text{ }^\circ\text{C};$

$f = 200\text{ MHz}$

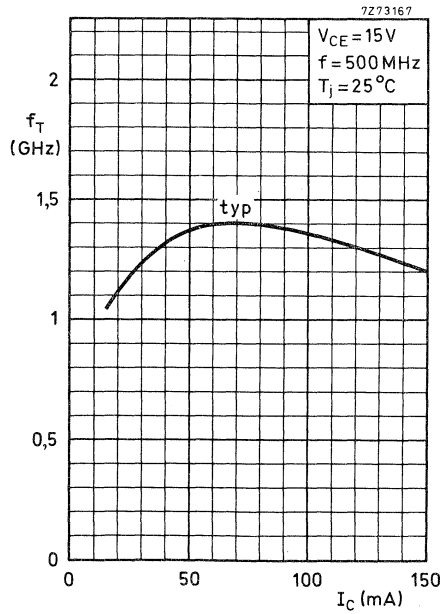
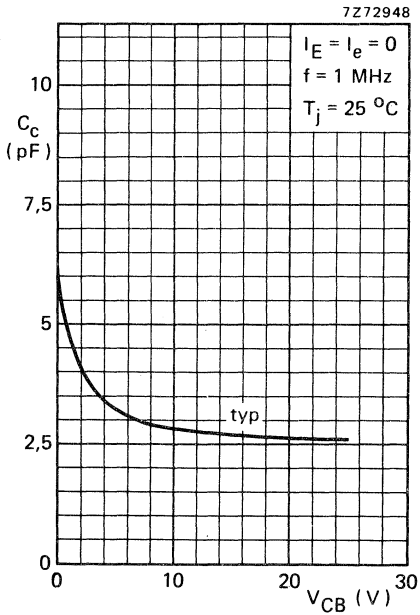
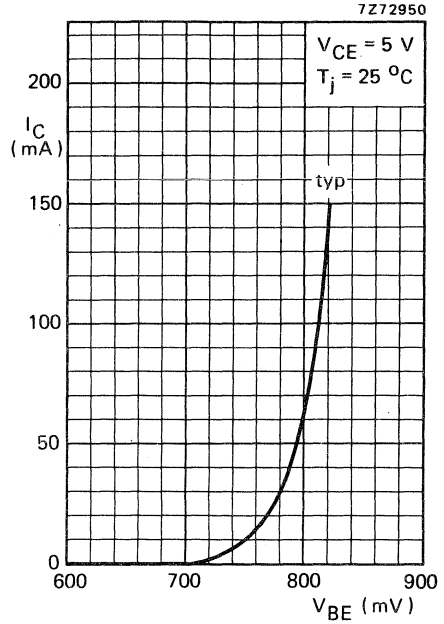
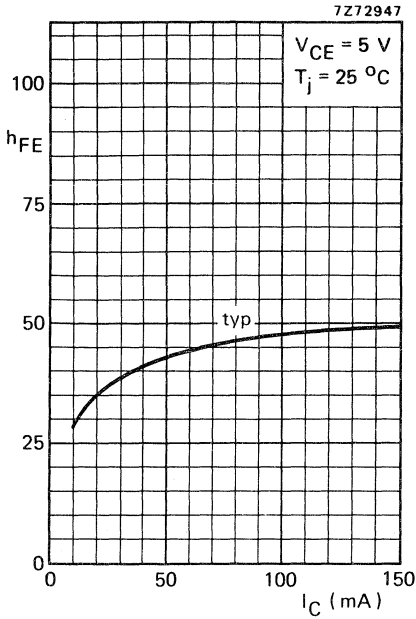
$f = 800\text{ MHz}$

GUM typ. 16 dB

GUM typ. 6,5 dB

1) Measured under pulse conditions.

# BFQ17





## SILICON PLANAR EPITAXIAL TRANSISTOR

N-P-N transistor in a miniature plastic envelope intended for application in thick and thin-film circuits. It is primarily intended for MATV purposes.

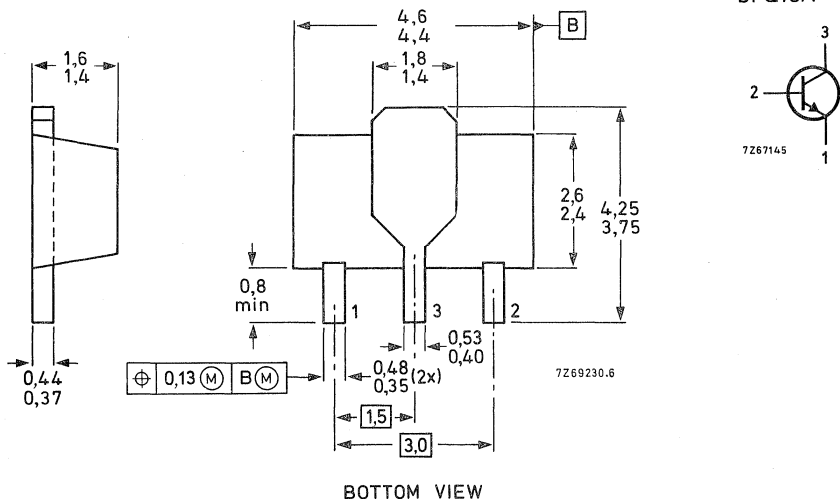
## QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CB0}$	max.	25 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	15 V
Collector current (d.c.)	$I_C$	max.	150 mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	1 W
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Transition frequency at $f = 500\text{ MHz}$ $I_C = 100\text{ mA}$ ; $V_{CE} = 10\text{ V}$	$f_T$	typ.	3,6 GHz
Feedback capacitance at $f = 10,7\text{ MHz}$ $I_C = 0$ ; $V_{CE} = 10\text{ V}$	$C_{re}$	typ.	1,2 pF
Intermodulation distortion $I_C = 80\text{ mA}$ ; $V_{CE} = 10\text{ V}$ ; $R_L = 75\text{ }\Omega$ measured at $f(p+q-r) = 793,25\text{ MHz}$	$d_{im}$	<	-60 dB

## MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-89.



See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	25 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	15 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	2 V
Collector current (d.c.)	$I_C$	max.	150 mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ *	$P_{tot}$	max.	1 W
Storage temperature	$T_{stg}$		-65 to +150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to collector tab	$R_{th\ j-tab}$	=	25 $^\circ\text{C}/\text{W}$
From junction to ambient in free air *	$R_{th\ j-a}$	=	125 $^\circ\text{C}/\text{W}$

**CHARACTERISTICS**

$T_{amb} = 25\text{ }^\circ\text{C}$  unless otherwise specified

D.C. current gain \*\*

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$	$h_{FE}$	>	25
$I_C = 100\text{ mA}; V_{CE} = 10\text{ V}$	$h_{FE}$	->	25

Transition frequency at  $f = 500\text{ MHz}$  \*\*

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$	$f_T$	typ.	3,2 GHz
$I_C = 100\text{ mA}; V_{CE} = 10\text{ V}$	$f_T$	typ.	3,6 GHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10\text{ V}$	$C_c$	typ.	2,0 pF
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Emitter capacitance at  $f = 1\text{ MHz}$

$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$	$C_e$	typ.	11 pF
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Feedback capacitance at  $f = 10,7\text{ MHz}$

$I_C = 0; V_{CE} = 10\text{ V}$	$C_{re}$	typ.	1,2 pF
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\* The device mounted on a ceramic substrate area = 2,5 cm<sup>2</sup>; thickness = 0,7 mm.

\*\* Measured under pulse conditions.

Intermodulation distortion (see Fig. 2)

$I_C = 80 \text{ mA}$ ;  $V_{CE} = 10 \text{ V}$ ;  $R_L = 75 \Omega$   
 $V_p = V_o = 700 \text{ mV}$  at  $f_p = 795,25 \text{ MHz}$   
 $V_q = V_o - 6 \text{ dB}$  at  $f_q = 803,25 \text{ MHz}$   
 $V_r = V_o - 6 \text{ dB}$  at  $f_r = 805,25 \text{ MHz}$   
 Measured at  $f_{(p+q-r)} = 793,25 \text{ MHz}$

$d_{im} < -60 \text{ dB}$

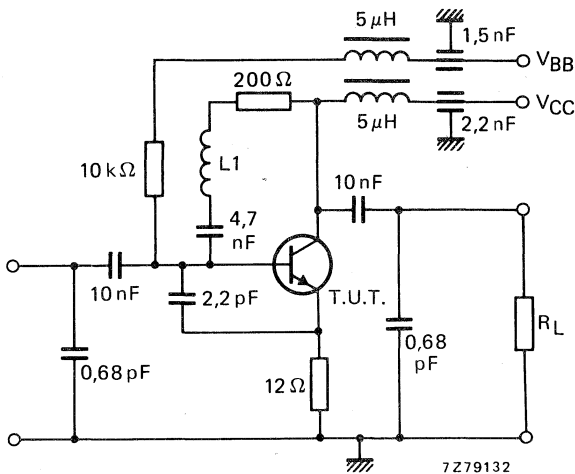


Fig. 2 MATV-test circuit (40–860 MHz).



## SILICON PLANAR EPITAXIAL TRANSISTOR

N-P-N transistor in a miniature plastic envelope intended for application in thick- and thin-film circuits.

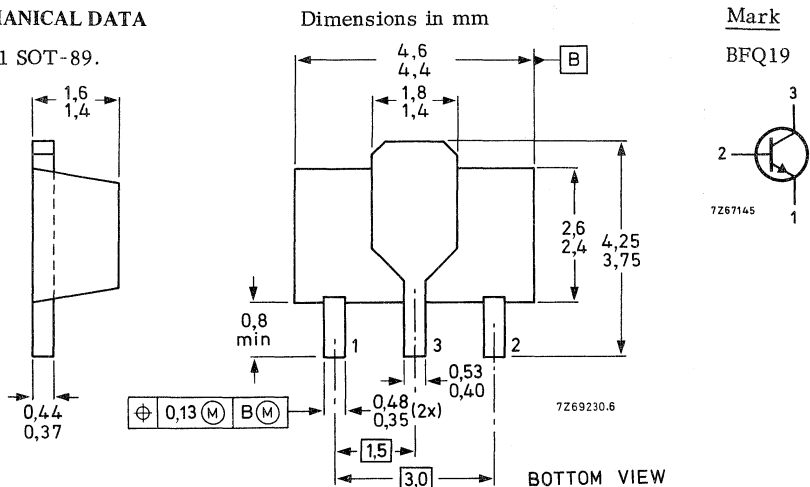
It is primarily intended for use in u.h.f. and microwave amplifiers such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analysers etc.

The transistor features very low intermodulation distortion and high power gain. Thanks to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

QUICK REFERENCE DATA			
Collector-base voltage (open emitter)	$V_{CBO}$	max.	20 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	15 V
Collector current (d.c.)	$I_C$	max.	75 mA
Total power dissipation up to $T_{amb} = 87,5\text{ }^\circ\text{C}$	$P_{tot}$	max.	500 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Transition frequency at $f = 500\text{ MHz}$ $I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$	$f_T$	typ.	5 GHz
Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 10\text{ mA}; V_{CE} = 10\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$	$C_{re}$	typ.	1,3 pF
Noise figure at optimum source impedance $I_C = 50\text{ mA}; V_{CE} = 10\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$	F	typ.	3,3 dB

### MECHANICAL DATA

Fig. 1 SOT-89.



See also Soldering recommendations.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC134)

Voltages

Collector-base voltage (open emitter)	$V_{CBO}$	max.	20	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	15	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3,0	V

Currents

Collector current (d. c.)	$I_C$	max.	75	mA
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	150	mA

Power dissipation

Total power dissipation up to $T_{amb} = 87,5$ °C mounted on a ceramic substrate area = 2,5 cm <sup>2</sup> ; thickness = 0,7 mm	$P_{tot}$	max.	500	mW
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Temperatures

Storage temperature	$T_{stg}$	-65 to +150	°C
Junction temperature	$T_j$	max.	150 °C

**THERMAL RESISTANCE**

From junction to collector tab	$R_{thj-tab}$	=	40	°C/W
From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm <sup>2</sup> ; thickness = 0,7 mm	$R_{thj-a}$	=	125	°C/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 10\text{ V}$   $I_{CBO} < 100\text{ nA}$

D.C. current gain 1)

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$   $h_{FE} > 25$   
typ. 50

$I_C = 75\text{ mA}; V_{CE} = 10\text{ V}$   $h_{FE} > 25$   
typ. 52

Transition frequency at  $f = 500\text{ MHz}$  1)

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$   $f_T > 4,0\text{ GHz}$   
typ. 5,0 GHz

$I_C = 75\text{ mA}; V_{CE} = 10\text{ V}$   $f_T > 4,4\text{ GHz}$   
typ. 5,5 GHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10\text{ V}$   $C_c$  typ. 1,6 pF

Emitter capacitance at  $f = 1\text{ MHz}$

$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$   $C_e$  typ. 5,0 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 10\text{ mA}; V_{CE} = 10\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$   $C_{re}$  typ. 1,3 pF

Noise figure at optimum source impedance

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$   $F$  typ. 3,3 dB

Max. unilateral power gain ( $s_{re}$  assumed to be zero)

$$G_{UM} \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

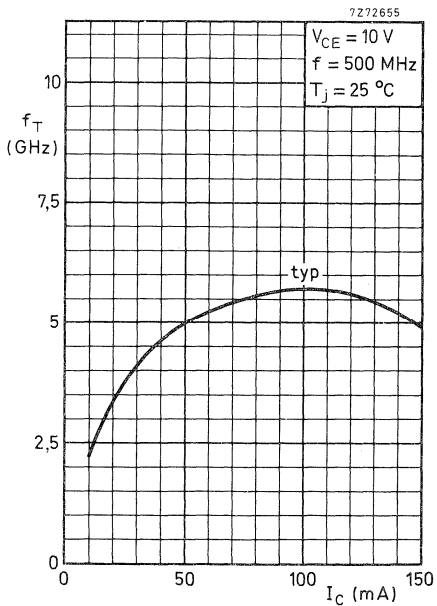
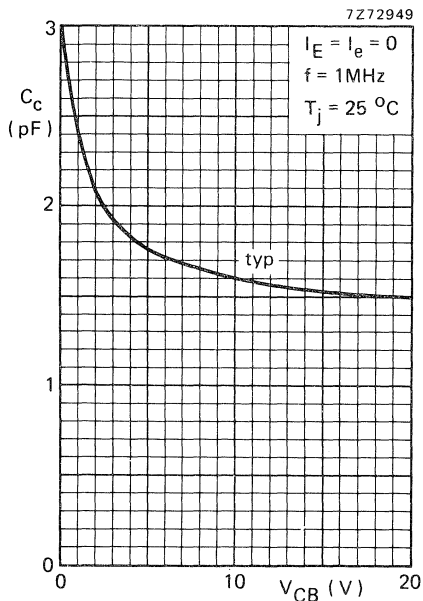
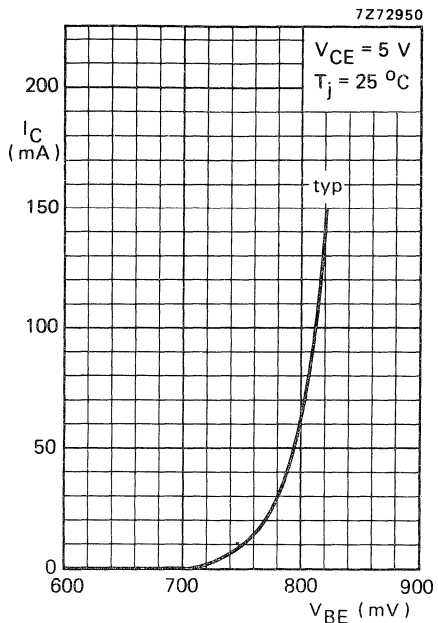
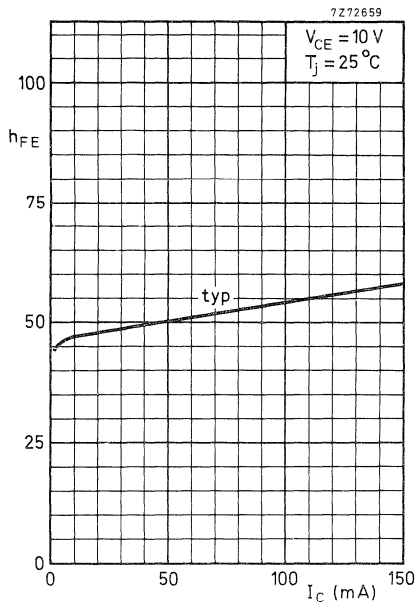
$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}; T_{amb} = 25\text{ }^\circ\text{C};$

$f = 200\text{ MHz}$   $G_{UM}$  typ. 18,5 dB

$f = 500\text{ MHz}$   $G_{UM}$  typ. 11,5 dB

$f = 800\text{ MHz}$   $G_{UM}$  typ. 7,5 dB

1) Measured under pulse conditions.





## N-CHANNEL SILICON FIELD-EFFECT TRANSISTORS

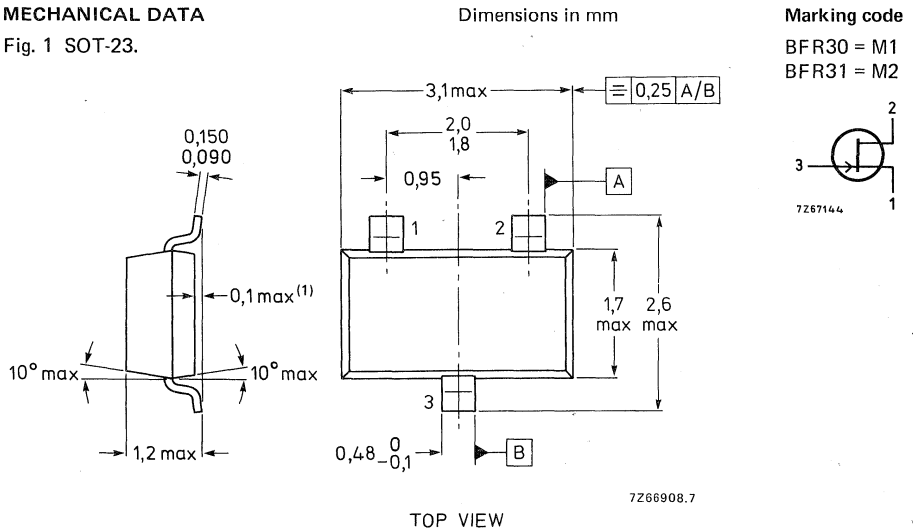
Planar epitaxial junction field effect transistor in a microminiature plastic envelope. It is intended for low level general purpose amplifiers in thick and thin-film circuits.

### QUICK REFERENCE DATA

Drain-source voltage	$\pm V_{DS}$	max.	25	V
Gate-source voltage (open drain)	$-V_{GSO}$	max.	25	V
Total power dissipation up to $T_{amb} = 65^\circ\text{C}$	$P_{tot}$	max.	250	mW
<b>Drain current</b>				
$V_{DS} = 10\text{ V}; V_{GS} = 0$	$I_{DSS}$	$>$	4	1 mA
		$<$	10	5 mA
<b>Transfer admittance (common source)</b>				
$I_D = 1\text{ mA}; V_{DS} = 10\text{ V}; f = 1\text{ kHz}$	$ y_{fs} $	$>$	1,0	1,5 mA/V
		$<$	4,0	4,5 mA/V

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage see Fig. 2	$\pm V_{DS}$	max.	25	V
Drain-gate voltage (open source) see Fig. 2	$V_{DGO}$	max.	25	V
Gate-source voltage (open drain) see Fig. 2	$-V_{GSO}$	max.	25	V
Drain current	$I_D$	max.	10	mA
Gate current	$I_G$	max.	5	mA
Total power dissipation up to $T_{amb} = 65\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	250	mW
Storage temperature	$T_{stg}$		-65 to +175	$^\circ\text{C}$
Junction temperature	$T_j$	max.	175	$^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60	K/W
From tab to soldering points	$R_{th\ t-s}$	=	280	K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90	K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

		BFR30	BFR31	
Gate cut-off current $-V_{GS} = 10\text{ V}; V_{DS} = 0$	$-I_{GSS} <$	0,2	0,2	nA
Drain current $V_{DS} = 10\text{ V}; V_{GS} = 0$	$I_{DSS} >$	4	1	mA
	$I_{DSS} <$	10	5	mA
Gate-source voltage $I_D = 1\text{ mA}; V_{DS} = 10\text{ V}$	$-V_{GS} >$	0,7	0	V
	$-V_{GS} <$	3,0	1,3	V
$I_D = 50\text{ }\mu\text{A}; V_{DS} = 10\text{ V}$	$-V_{GS} <$	4,0	2,0	V
	$-V_{GS} <$	4,0	2,0	V
Gate-source cut-off voltage $I_D = 0,5\text{ nA}; V_{DS} = 10\text{ V}$	$-V_{(P)GS} <$	5	2,5	V
<b>y parameters</b>				
Transfer admittance at $f = 1\text{ kHz}; T_{amb} = 25\text{ }^\circ\text{C}$ $I_D = 1\text{ mA}; V_{DS} = 10\text{ V}$	$ y_{fs}  >$	1,0	1,5	mA/V
	$ y_{fs}  <$	4,0	4,5	mA/V
$I_D = 200\text{ }\mu\text{A}; V_{DS} = 10\text{ V}$	$ y_{fs}  >$	0,5	0,75	mA/V
	$ y_{fs}  >$	0,5	0,75	mA/V
Output admittance at $f = 1\text{ kHz}$ $I_D = 1\text{ mA}; V_{DS} = 10\text{ V}$	$ y_{os}  <$	40	25	$\mu\text{A/V}$
	$ y_{os}  <$	20	15	$\mu\text{A/V}$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

y parameters (continued)

Input capacitance at  $f = 1 \text{ MHz}$

$I_D = 1 \text{ mA}; V_{DS} = 10 \text{ V}$

$I_D = 200 \mu\text{A}; V_{DS} = 10 \text{ V}$

Feedback capacitance at  $f = 1 \text{ MHz}; T_{\text{amb}} = 25 \text{ }^\circ\text{C}$

$I_D = 1 \text{ mA}; V_{DS} = 10 \text{ V}$

$I_D = 200 \mu\text{A}; V_{DS} = 10 \text{ V}$

Equivalent noise voltage

$I_D = 200 \mu\text{A}; V_{DS} = 10 \text{ V}$

$B = 0,6 \text{ to } 100 \text{ Hz}$

		BFR30	BFR31	
$C_{is}$	<	4	4	pF
$C_{is}$	<	4	4	pF
$C_{rs}$	<	1,5	1,5	pF
$C_{rs}$	<	1,5	1,5	pF
$V_n$	<	0,5	0,5	$\mu\text{V}$

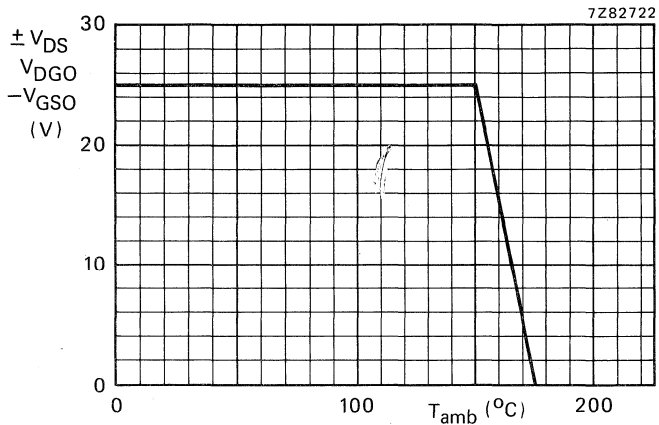


Fig. 2 Voltage derating curve.

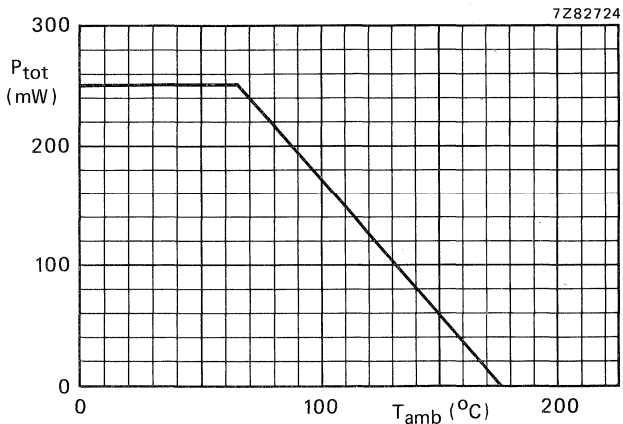


Fig. 3 Power derating curve.

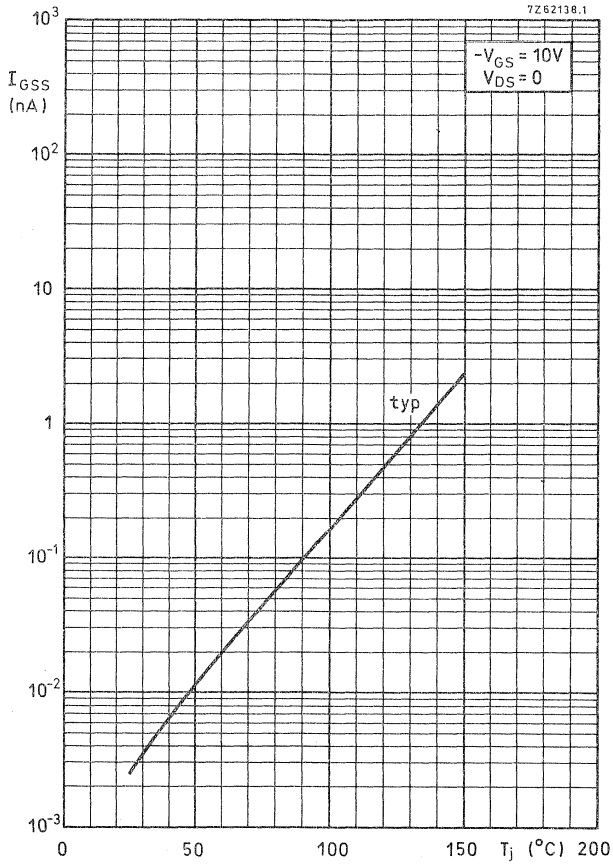


Fig. 4.

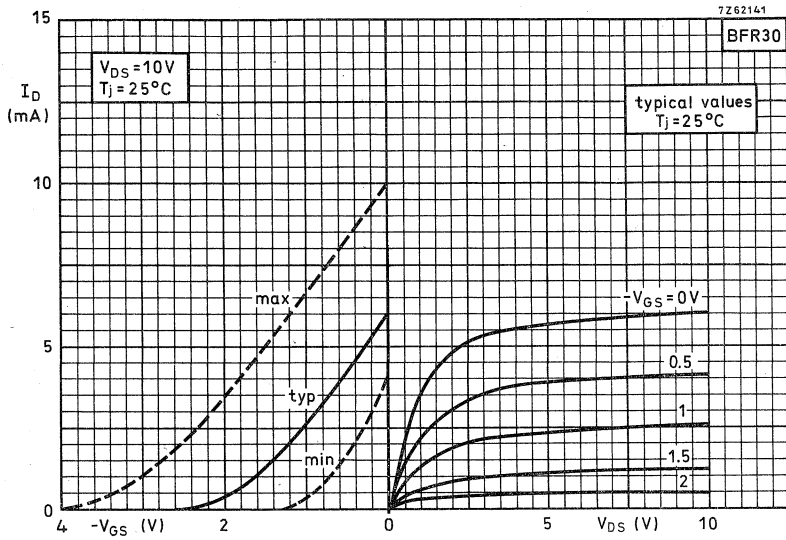


Fig. 5.

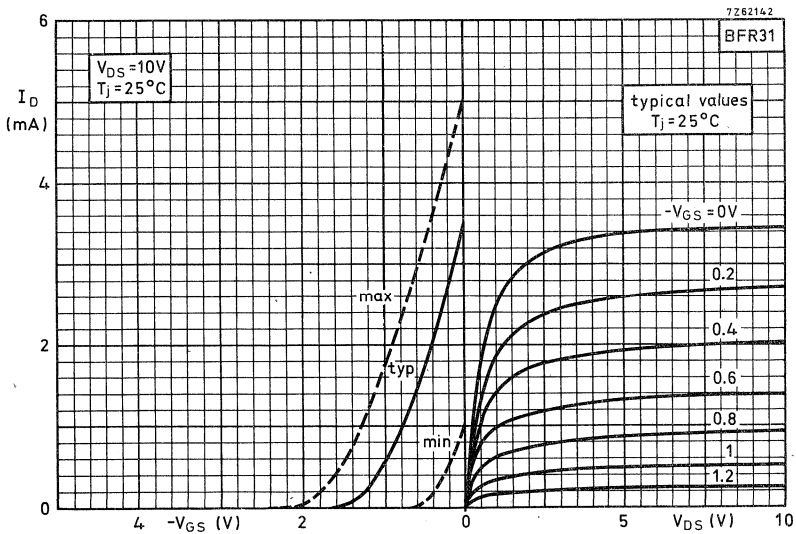


Fig. 6.

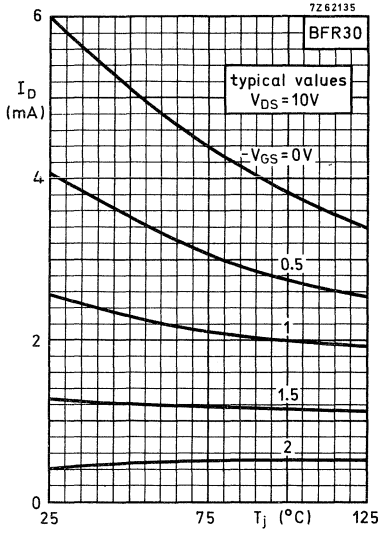


Fig. 7.

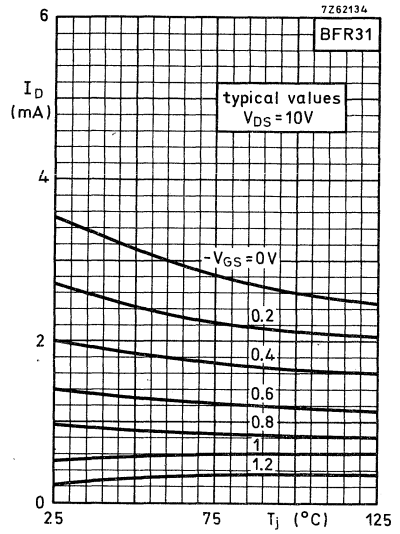


Fig. 8.

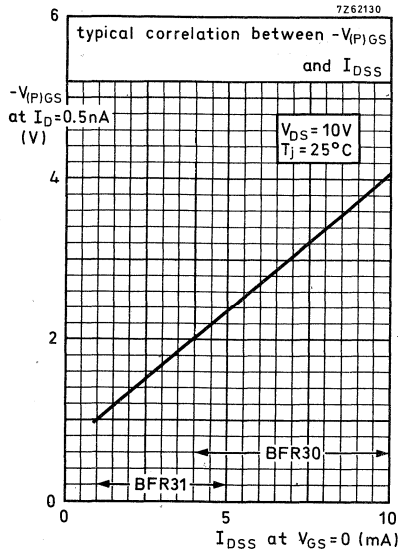


Fig. 9.

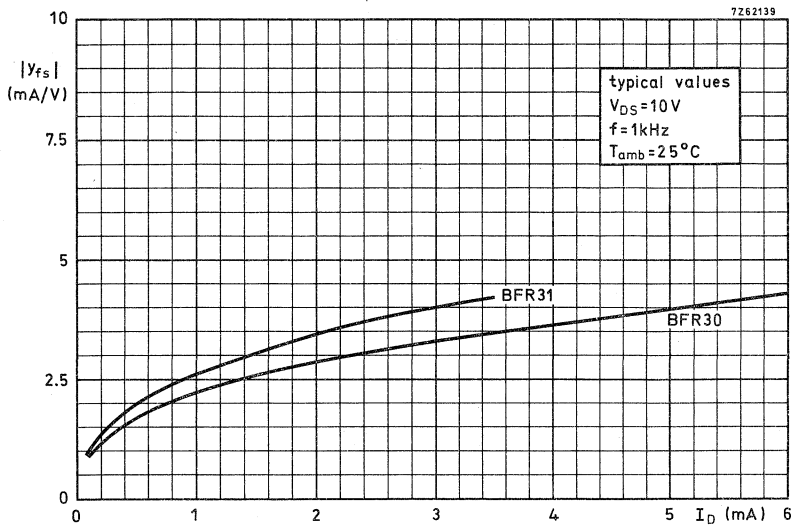


Fig. 10.

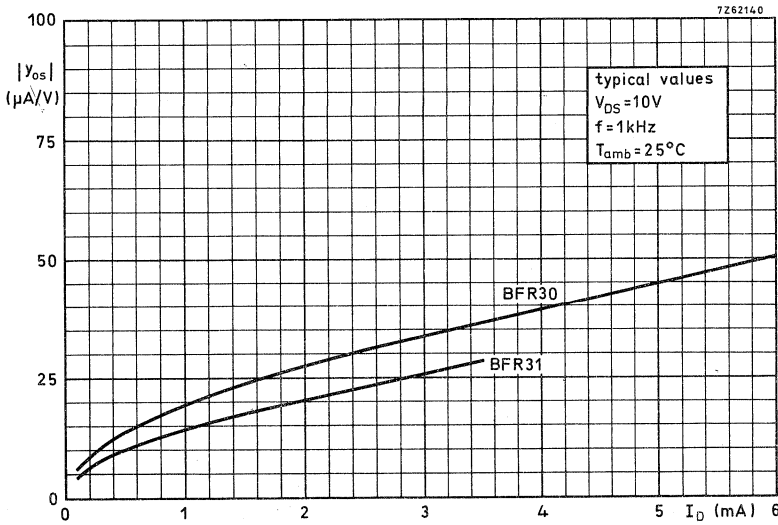


Fig. 11.

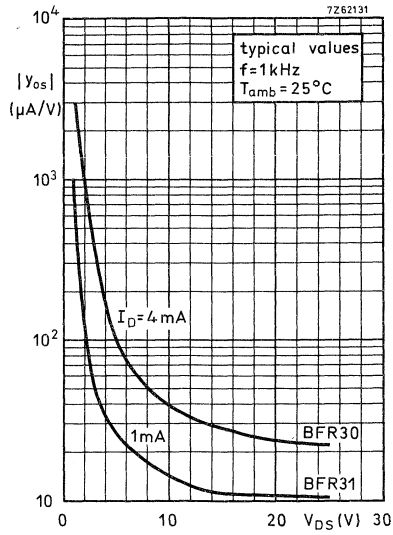


Fig. 12.

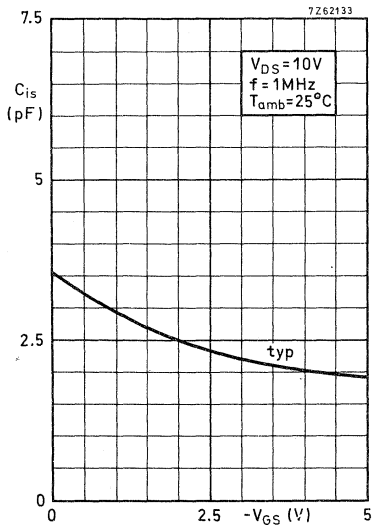


Fig. 13.

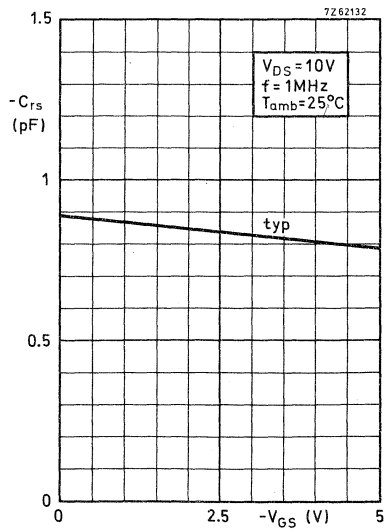


Fig. 14.



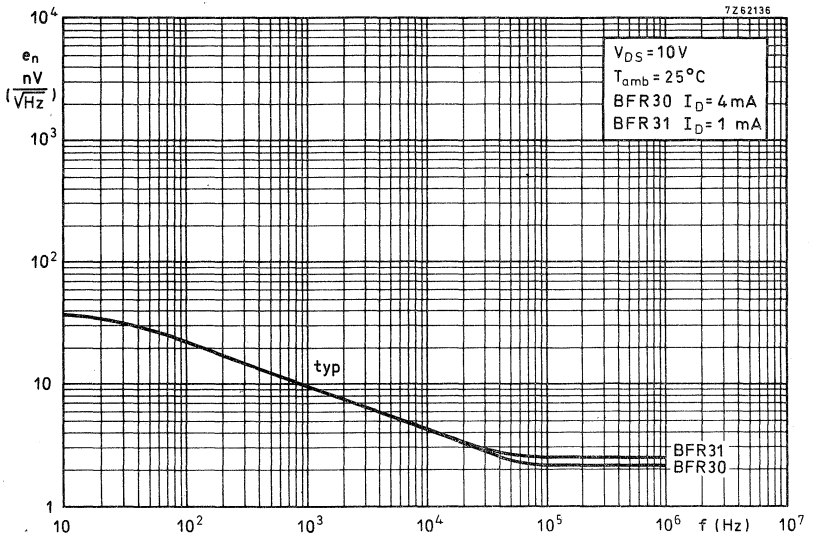


Fig. 15.

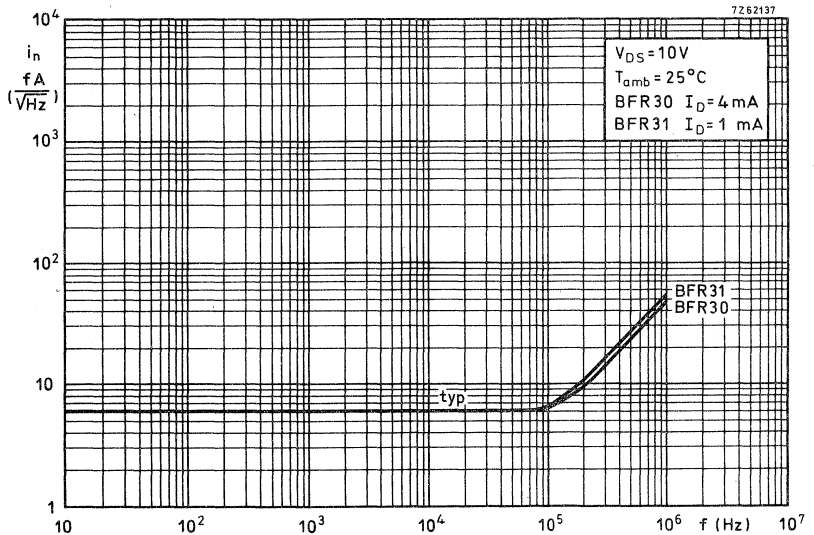


Fig. 16.



## SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N multi-emitter transistor in a microminiature plastic envelope intended for application in thick and thin-film circuits. The transistor has very low intermodulation distortion and very high power gain. It is primarily intended for:

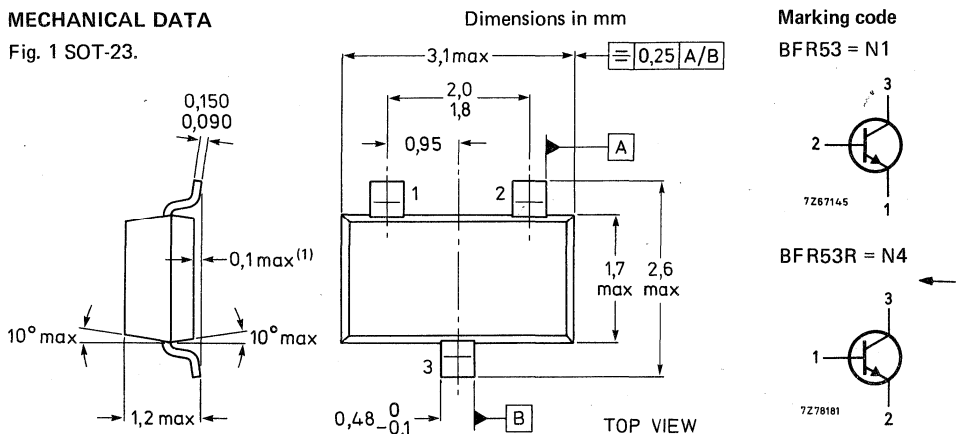
- Wideband vertical amplifiers in high speed oscilloscopes.
- Television distribution amplifiers.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CBO}$	max.	18 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	10 V
Collector current (peak value; $f > 1$ MHz)	$I_{CM}$	max.	100 mA
Total power dissipation up to $T_{amb} = 65$ °C	$P_{tot}$	max.	250 mW
Junction temperature	$T_j$	max.	175 °C
Feedback capacitance at $f = 1$ MHz $I_C = 2$ mA; $V_{CE} = 5$ V; $T_{amb} = 25$ °C	$-C_{re}$	typ.	0,9 pF
Transition frequency at $f = 500$ MHz $I_C = 25$ mA; $V_{CE} = 5$ V	$f_T$	typ.	2,0 GHz
Max. unilateral power gain $I_C = 30$ mA; $V_{CE} = 5$ V; $f = 200$ MHz; $T_{amb} = 25$ °C $I_C = 30$ mA; $V_{CE} = 5$ V; $f = 800$ MHz; $T_{amb} = 25$ °C	GUM	typ.	22 dB
	GUM	typ.	10,5 dB
Intermodulation distortion at $T_{amb} = 25$ °C $I_C = 30$ mA; $V_{CE} = 5$ V; $R_L = 37,5$ $\Omega$ $V_o = 100$ mV at $f_p = 183$ MHz $V_o = 100$ mV at $f_q = 200$ MHz measured at $f(2q-p) = 217$ MHz	$d_{im}$	typ.	-60 dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 3	$V_{CBO}$	max.	18 V
Collector-emitter voltage (open base) see Fig. 3	$V_{CEO}$	max.	10 V
Emitter-base voltage (open collector) see Fig. 3	$V_{EBO}$	max.	2,5 V
Collector current (d.c.)	$I_C$	max.	50 mA
Collector current (peak value: $f > 1$ MHz)	$I_{CM}$	max.	100 mA
Total power dissipation up to $T_{amb} = 65$ °C**	$P_{tot}$	max.	250 mW
Storage temperature	$T_{stg}$	-65 to +175	°C
Junction temperature	$T_j$	max.	175 °C

**THERMAL CHARACTERISTICS\***

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 10\text{ V}$$

$$I_{CBO} < 50\text{ nA}$$

D.C. current gain  $\Delta$

$$I_C = 25\text{ mA}; V_{CE} = 5\text{ V}$$

$$h_{FE} > 25$$

$$I_C = 50\text{ mA}; V_{CE} = 5\text{ V}$$

$$h_{FE} > 25$$

Transition frequency at  $f = 500$  MHz  $\Delta$

$$I_C = 25\text{ mA}; V_{CE} = 5\text{ V}$$

$$f_T \text{ typ. } 2,0\text{ GHz}$$

Collector capacitance at  $f = 1$  MHz

$$I_E = I_e = 0; V_{CB} = 5\text{ V}$$

$$C_c \text{ typ. } 0,9\text{ pF}$$

Emitter capacitance at  $f = 1$  MHz

$$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$$

$$C_e \text{ typ. } 1,5\text{ pF}$$

Feedback capacitance at  $f = 1$  MHz

$$I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; T_{amb} = 25\text{ °C}$$

$$-C_{re} \text{ typ. } 0,9\text{ pF}$$

$\Delta$  Measured under pulse conditions.

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

Noise figure at  $f = 500 \text{ MHz}$  <sup>▲</sup>

$I_C = 2 \text{ mA}$ ;  $V_{CE} = 5 \text{ V}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$

$G_S = 20 \text{ mA/V}$ ;  $B_S$  is tuned

F < 5 dB

Max. unilateral power gain ( $s_{re}$  assumed to be zero)

$$G_{UM} \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$I_C = 30 \text{ mA}$ ;  $V_{CE} = 5 \text{ V}$ ;  $f = 200 \text{ MHz}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$

$G_{UM}$  typ. 22 dB

$I_C = 30 \text{ mA}$ ;  $V_{CE} = 5 \text{ V}$ ;  $f = 800 \text{ MHz}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$

$G_{UM}$  typ. 10,5 dB

Intermodulation distortion <sup>▲</sup>

$I_C = 30 \text{ mA}$ ;  $V_{CE} = 5 \text{ V}$ ;  $R_L = 37,5 \text{ } \Omega$

$V_o = 100 \text{ mV}$  at  $f_p = 183 \text{ MHz}$

$V_o = 100 \text{ mV}$  at  $f_q = 200 \text{ MHz}$

Measured at  $f(2q - p) = 217 \text{ MHz}$

$d_{im}$  typ. -60 dB

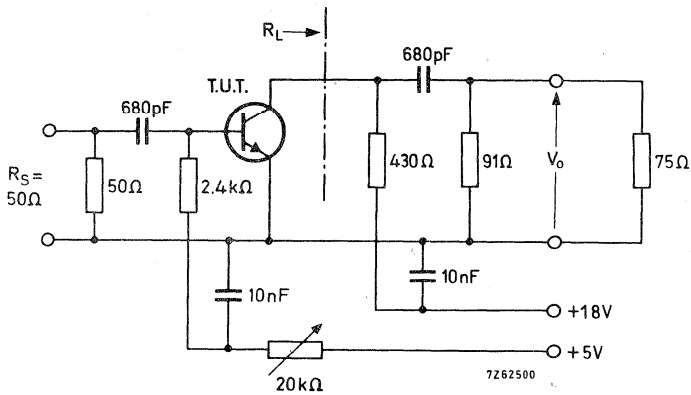


Fig. 2 Test circuit.

<sup>▲</sup> Crystal mounted in a BFW30 envelope.

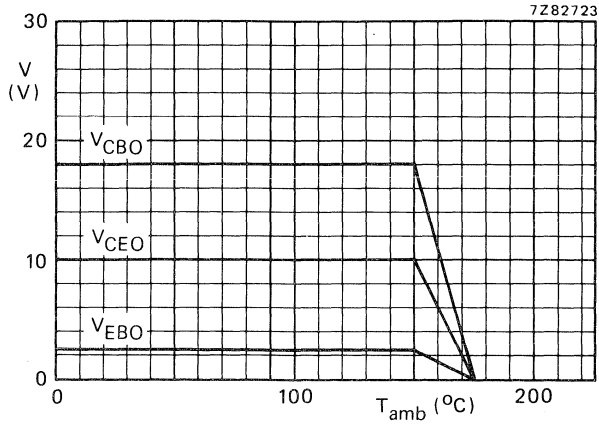


Fig. 3 Voltage derating curves.

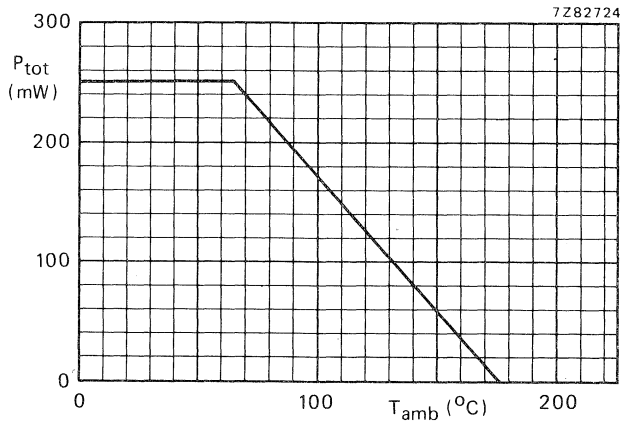
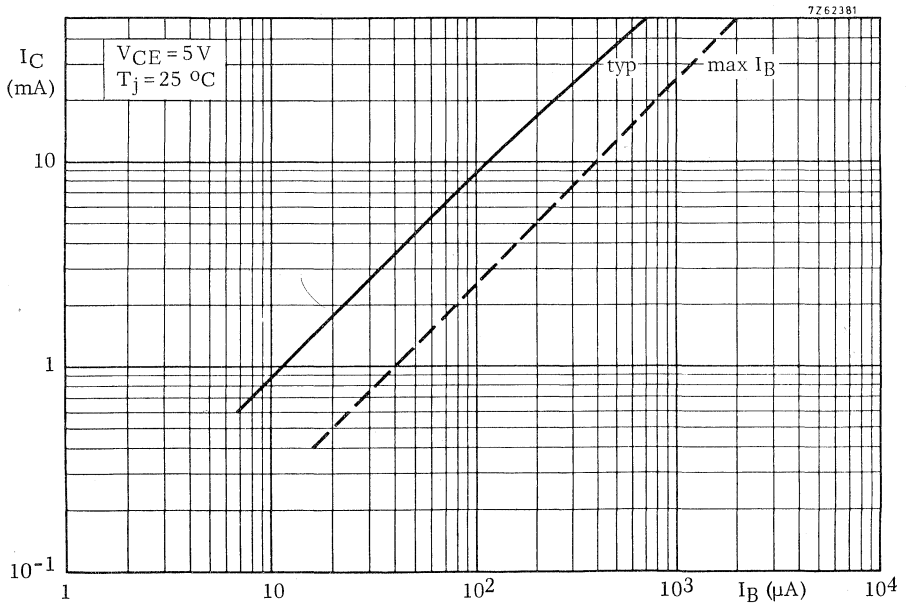
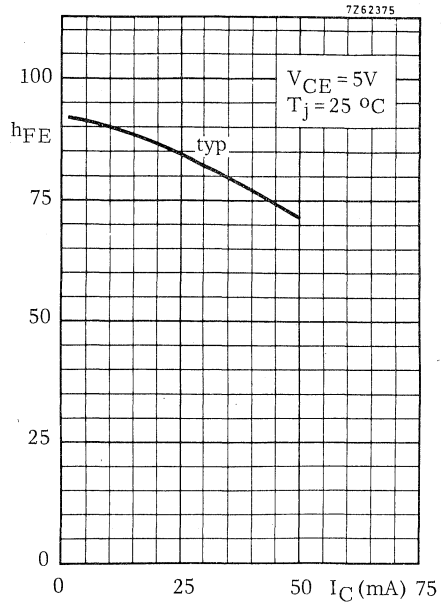
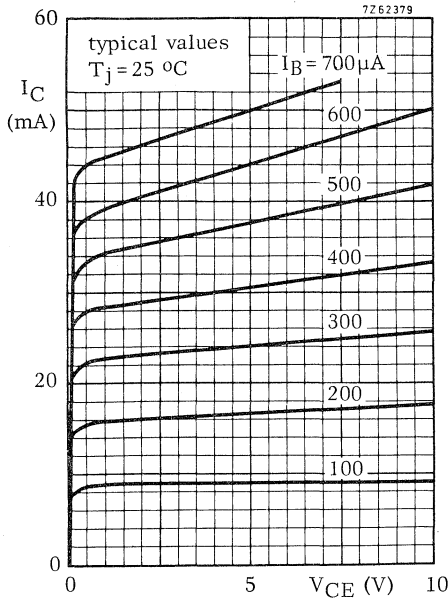
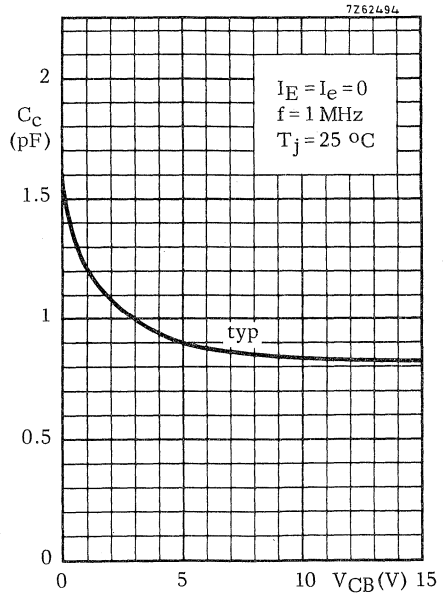
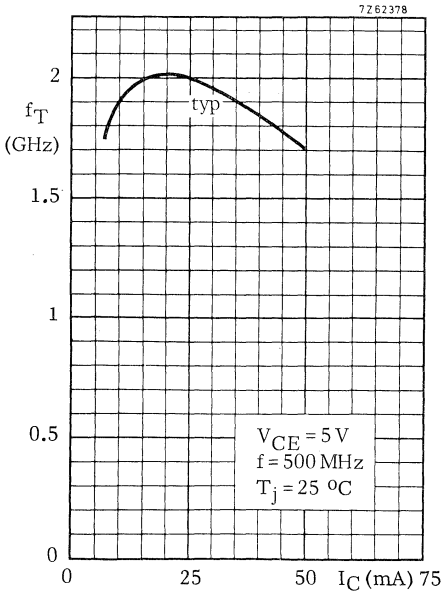
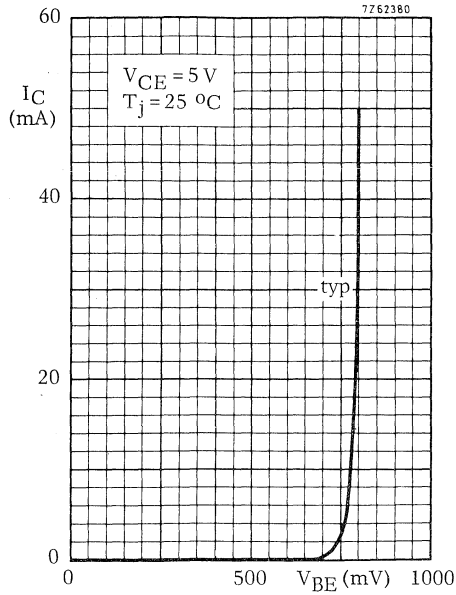


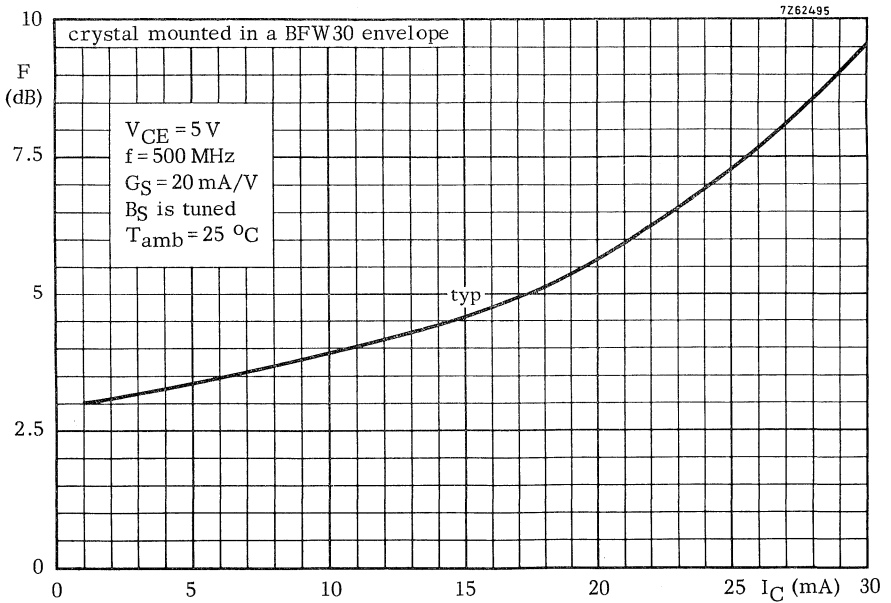
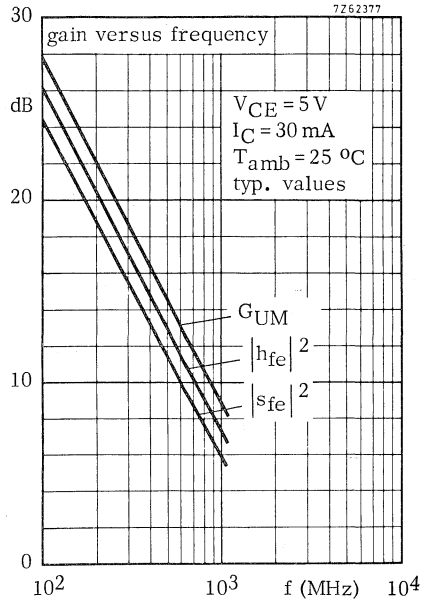
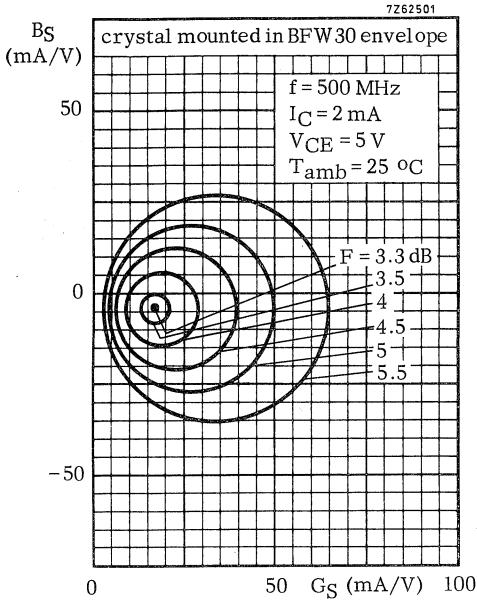
Fig. 4 Power derating curve.





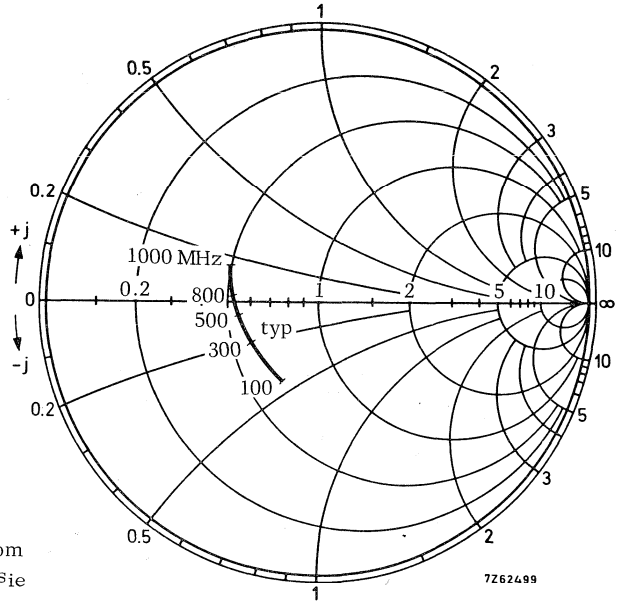


circles of constant noise figure



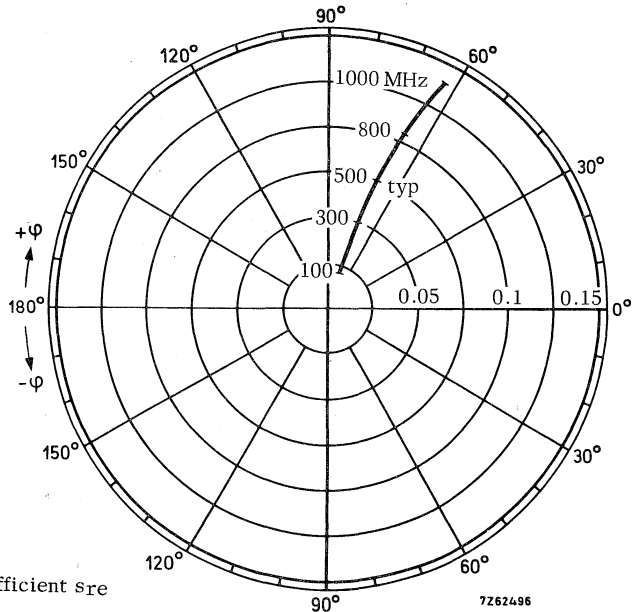
# BFR53

$V_{CE} = 5 \text{ V}$   
 $I_C = 30 \text{ mA}$   
 $T_{amb} = 25 \text{ }^\circ\text{C}$



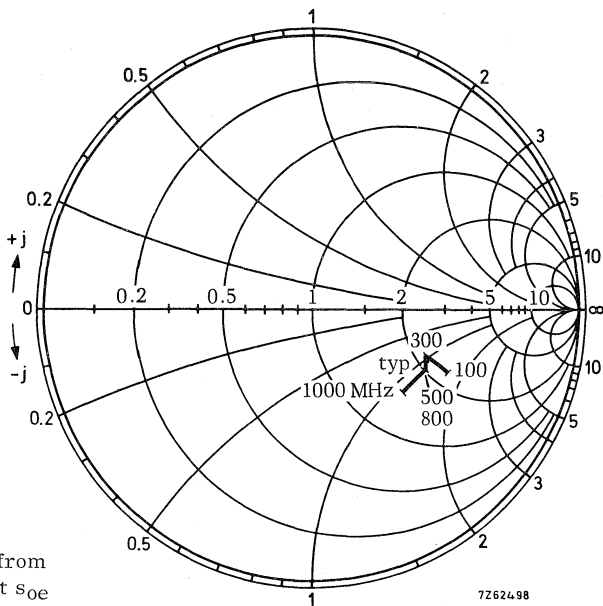
Input impedance derived from  
 input reflection coefficient  $s_{ie}$   
 coordinates in ohm x 50

$V_{CE} = 5 \text{ V}$   
 $I_C = 30 \text{ mA}$   
 $T_{amb} = 25 \text{ }^\circ\text{C}$



Reverse transmission coefficient  $s_{re}$

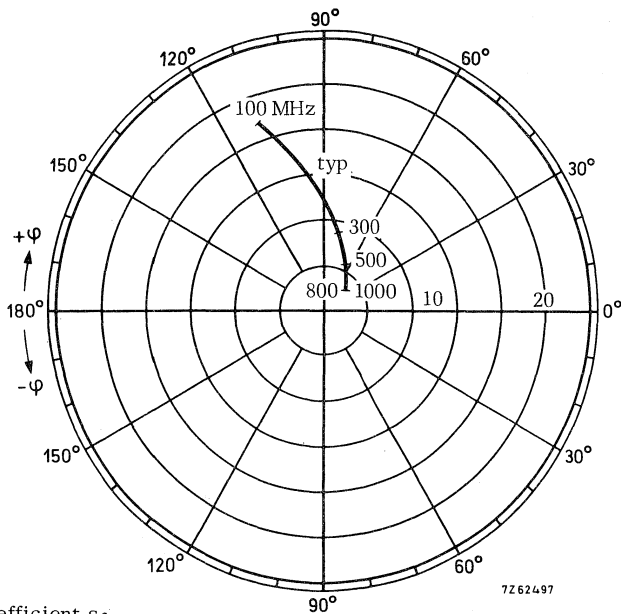
$V_{CE} = 5\text{ V}$   
 $I_C = 30\text{ mA}$   
 $T_{amb} = 25\text{ }^\circ\text{C}$



Output impedance derived from output reflection coefficient  $s_{oe}$  coordinates in ohm x 50

7Z624-98

$V_{CE} = 5\text{ V}$   
 $I_C = 30\text{ mA}$   
 $T_{amb} = 25\text{ }^\circ\text{C}$



Forward transmission coefficient  $s_{fe}$

7Z624-97



## SILICON PLANAR EPITAXIAL TRANSISTORS

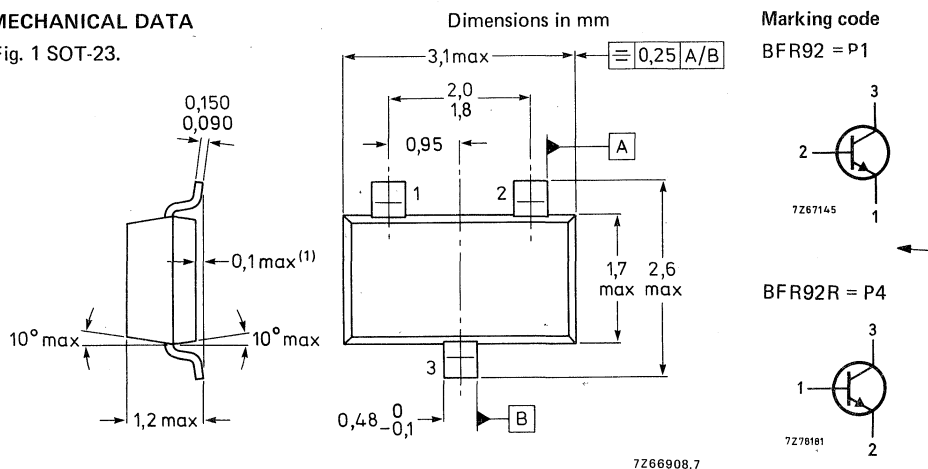
N-P-N transistor in a microminiature plastic envelope. It is primarily intended for use in u.h.f. and microwave amplifiers in thick and thin-film circuits, such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analysers etc. The transistor features low intermodulation distortion and high power gain; thanks to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CBO}$	max.	20 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	15 V
Collector current (d.c.)	$I_C$	max.	25 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Transition frequency at $f = 500\text{ MHz}$ $I_C = 14\text{ mA}$ ; $V_{CE} = 10\text{ V}$	$f_T$	typ.	5 GHz
Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 2\text{ mA}$ ; $V_{CE} = 10\text{ V}$ ; $T_{amb} = 25\text{ }^\circ\text{C}$	$C_{re}$	typ.	0,7 pF
Noise figure at optimum source impedance $I_C = 2\text{ mA}$ ; $V_{CE} = 10\text{ V}$ ; $f = 500\text{ MHz}$ ; $T_{amb} = 25\text{ }^\circ\text{C}$	F	typ.	2,4 dB
Max. unilateral power gain $I_C = 14\text{ mA}$ ; $V_{CE} = 10\text{ V}$ ; $f = 500\text{ MHz}$ ; $T_{amb} = 25\text{ }^\circ\text{C}$	$G_{UM}$	typ.	18 dB
Intermodulation distortion at $T_{amb} = 25\text{ }^\circ\text{C}$ $I_C = 14\text{ mA}$ ; $V_{CE} = 10\text{ V}$ ; $R_L = 75\text{ }\Omega$ ; $V_o = 150\text{ mV}$ $f_{(p+q-r)} = 493,25\text{ MHz}$	$d_{im}$	typ.	-60 dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version. TOP VIEW

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	20 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	15 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	2,0 V
Collector current (d.c.)	$I_C$	max.	25 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-65 to +150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL CHARACTERISTICS \***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient **	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 10\text{ V}$$

$$I_{CBO} < 50\text{ nA}$$

D.C. current gain<sup>▲</sup>

$$I_C = 14\text{ mA}; V_{CE} = 10\text{ V}$$

$$h_{FE} > 25$$

typ. 50

Transition frequency at  $f = 500\text{ MHz}^\Delta$

$$I_C = 14\text{ mA}; V_{CE} = 10\text{ V}$$

$$f_T \text{ typ. } 5\text{ GHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 10\text{ V}$$

$$C_C \text{ typ. } 0,75\text{ pF}$$

Emitter capacitance at  $f = 1\text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$$

$$C_e \text{ typ. } 0,8\text{ pF}$$

Feedback capacitance at  $f = 1\text{ MHz}$

$$I_C = 2\text{ mA}; V_{CE} = 10\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$$

$$C_{re} \text{ typ. } 0,7\text{ pF}$$

<sup>▲</sup> Measured under pulse conditions.

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

Noise figure at optimum source impedance \*

$I_C = 2 \text{ mA}; V_{CE} = 10 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$

F typ. 2,4 dB

Max. unilateral power gain ( $s_{re}$  assumed to be zero)

$$G_{UM} \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$I_C = 14 \text{ mA}; V_{CE} = 10 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$

$G_{UM}$  typ. 18 dB

Intermodulation distortion at  $T_{amb} = 25 \text{ }^\circ\text{C}$

$I_C = 14 \text{ mA}; V_{CE} = 10 \text{ V}; R_L = 75 \text{ } \Omega; \text{V.S.W.R.} < 2$

$V_p = V_o = 150 \text{ mV}$  at  $f_p = 495,25 \text{ MHz}$

$V_q = V_o - 6 \text{ dB}$  at  $f_q = 503,25 \text{ MHz}$

$V_r = V_o - 6 \text{ dB}$  at  $f_r = 505,25 \text{ MHz}$

Measured at  $f_{(p+q-r)} = 493,25 \text{ MHz}$

$d_{im}$  typ. -60 dB

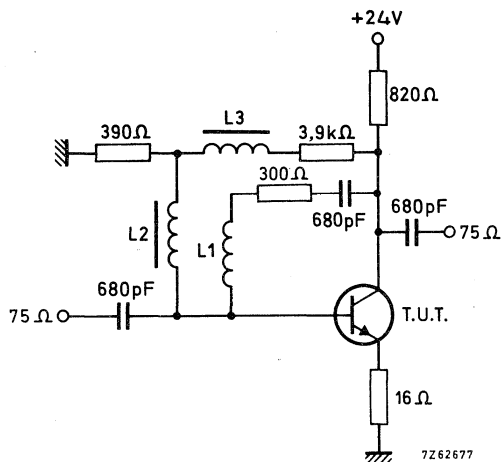


Fig. 2 Intermodulation test circuit.

L1 = 4 turns Cu wire (0,35 mm); winding pitch 1 mm; int. dia. 4 mm

L2 = L3 = 5  $\mu\text{H}$  (code number: 3122 108 20150)

\* Crystal mounted in a BFR90 envelope.

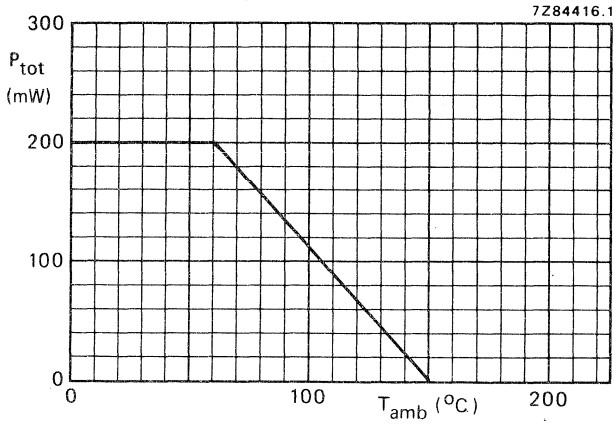
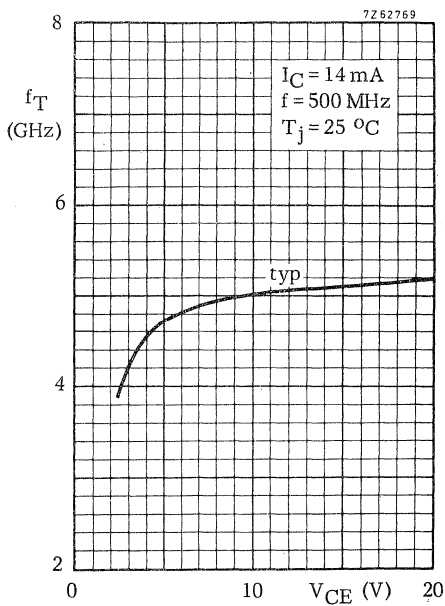
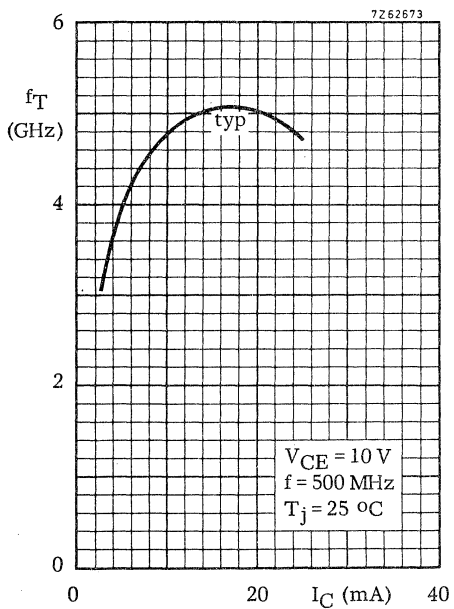
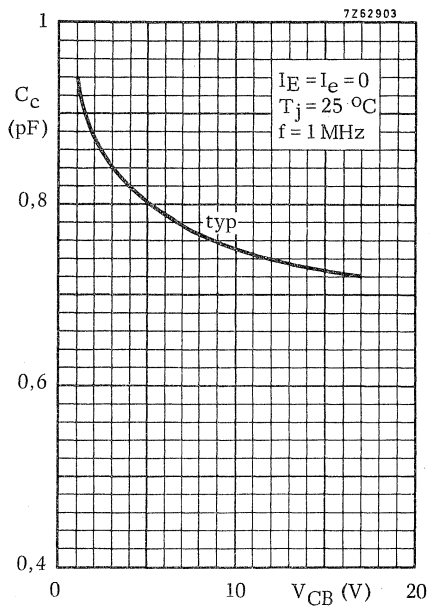
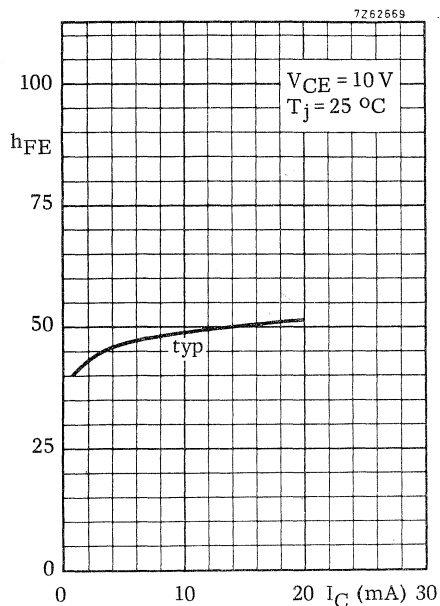
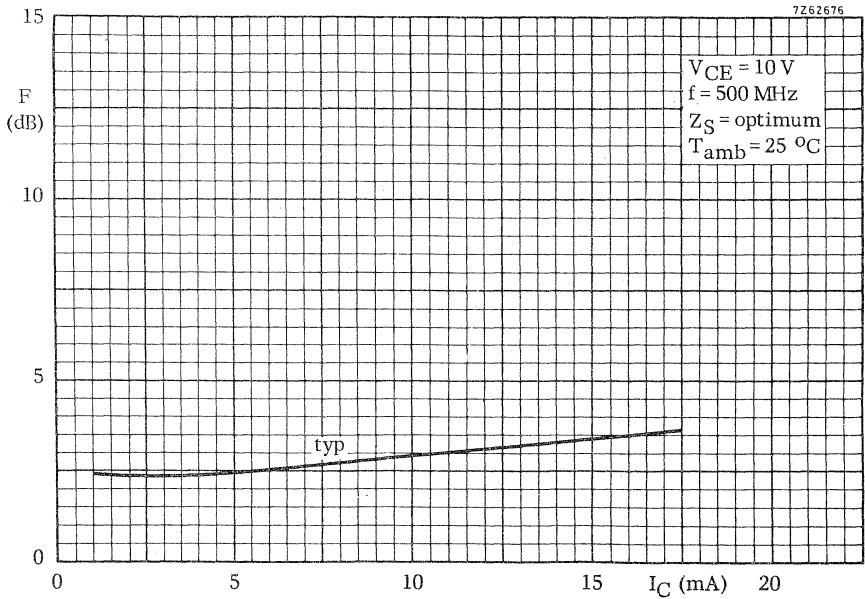
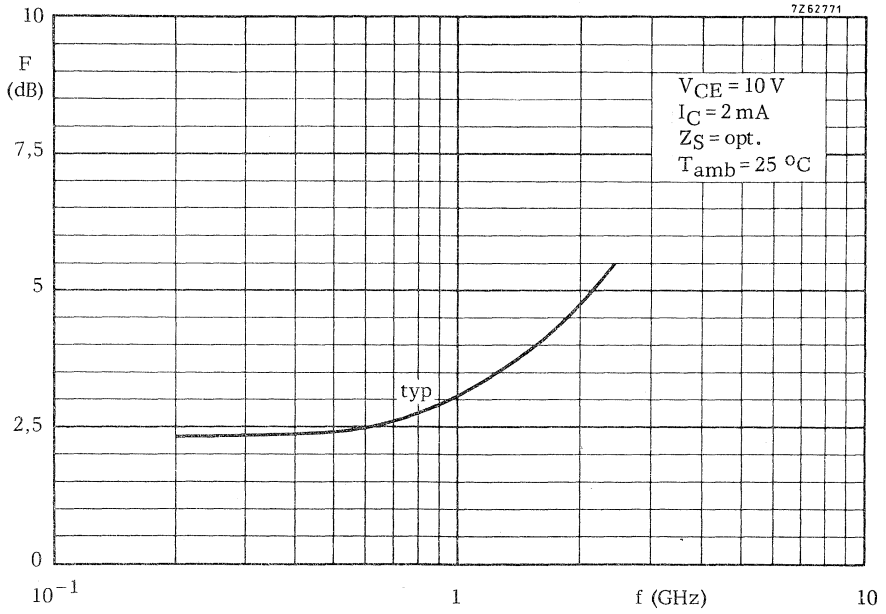
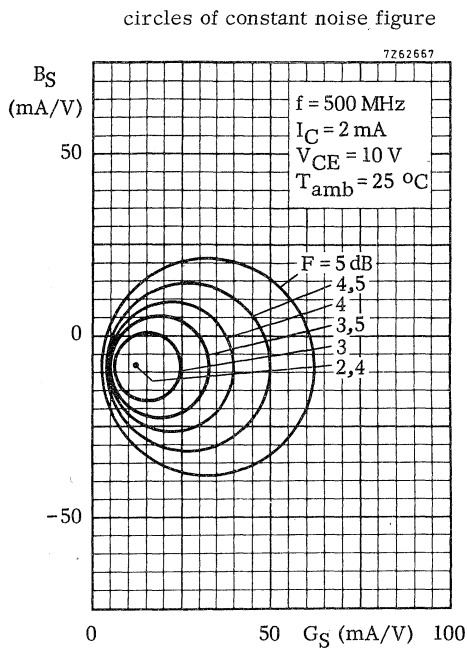
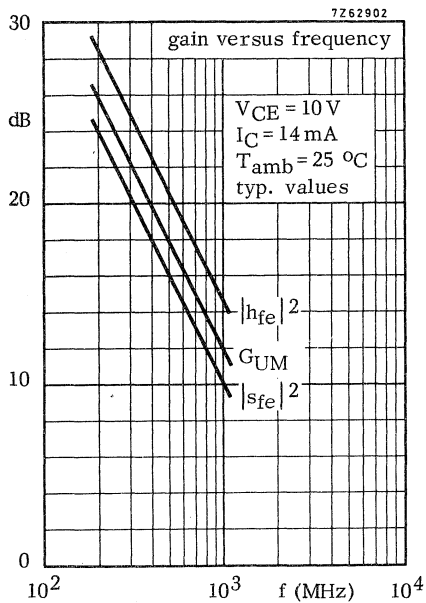


Fig. 3 Power derating curve.



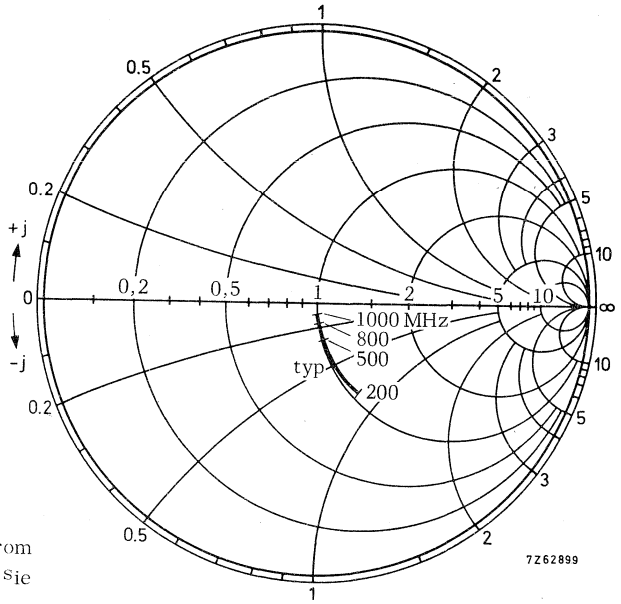






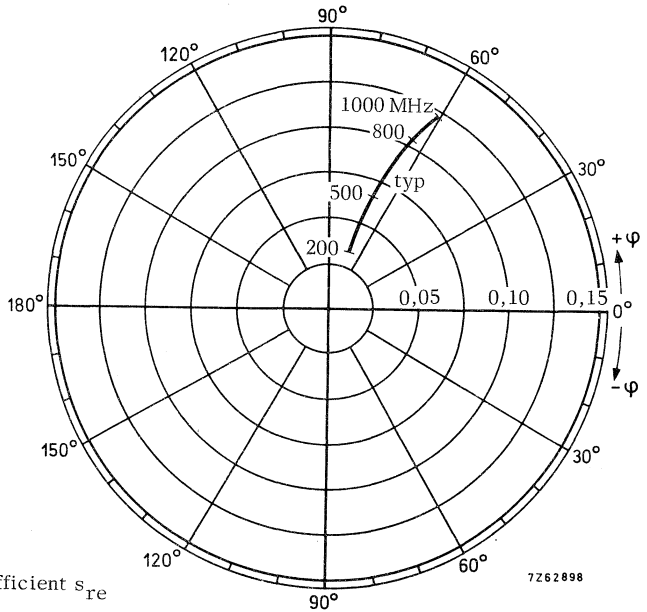
# BFR92

$V_{CE} = 10 \text{ V}$   
 $I_C = 14 \text{ mA}$   
 $T_{amb} = 25 \text{ }^\circ\text{C}$



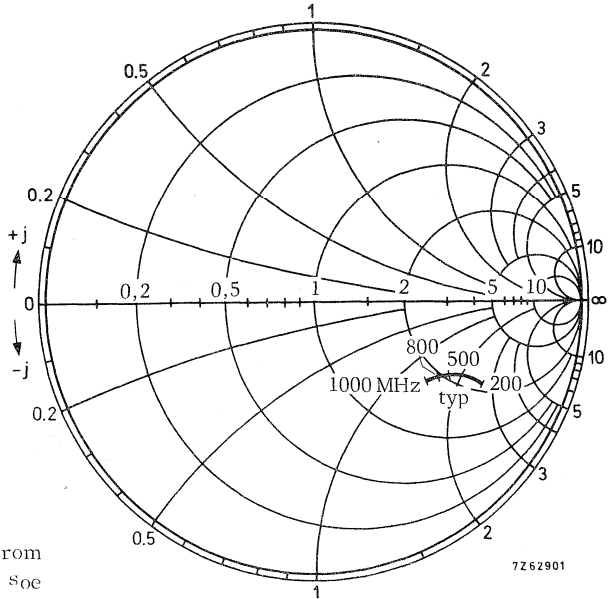
Input impedance derived from input reflection coefficient  $s_{ie}$  coordinates in ohm x 50

$V_{CE} = 10 \text{ V}$   
 $I_C = 14 \text{ mA}$   
 $T_{amb} = 25 \text{ }^\circ\text{C}$



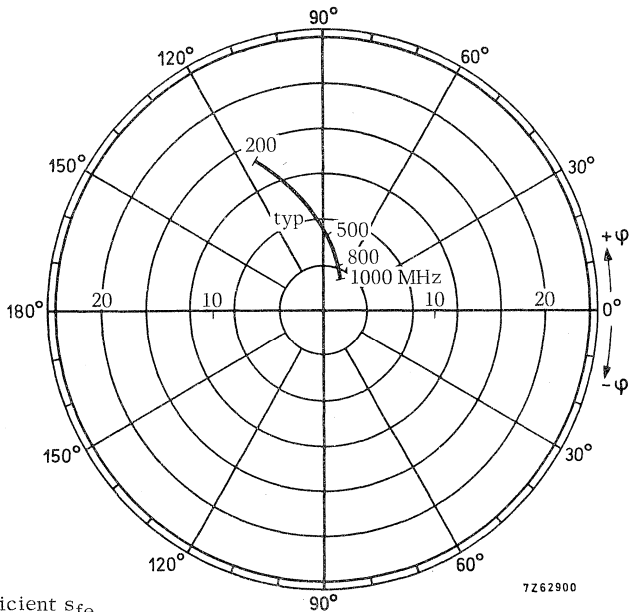
Reverse transmission coefficient  $s_{re}$

$V_{CE} = 10\text{ V}$   
 $I_C = 14\text{ mA}$   
 $T_{amb} = 25\text{ }^\circ\text{C}$



Output impedance derived from output reflection coefficient  $s_{oe}$  coordinates in ohm x 50

$V_{CE} = 10\text{ V}$   
 $I_C = 14\text{ mA}$   
 $T_{amb} = 25\text{ }^\circ\text{C}$



Forward transmission coefficient  $s_{fe}$



## SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors in a micro miniature plastic envelope. They are primarily intended for use in v.h.f./u.h.f. broadband amplifiers. The transistors feature:

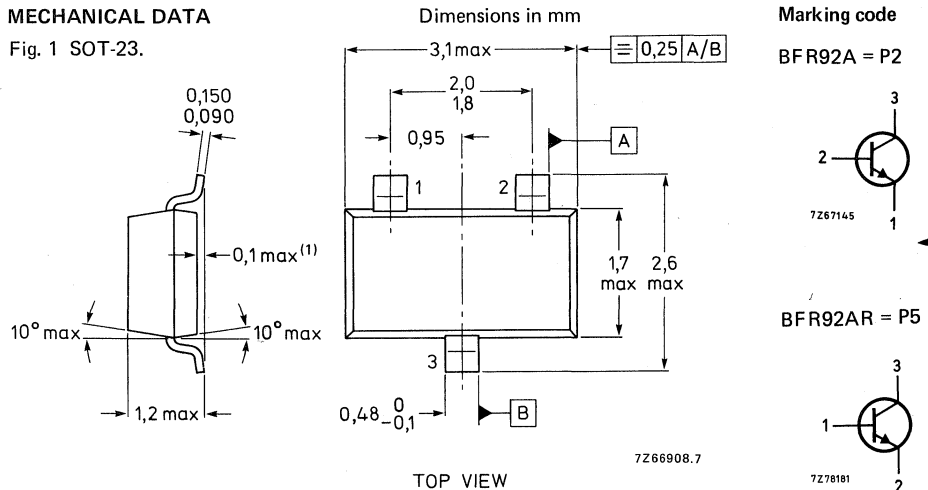
- low noise;
- low intermodulation distortion;
- high power gain;

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CBO}$	max.	20 V
Collector-emitter voltage (open-base)	$V_{CEO}$	max.	15 V
Collector current (d.c.)	$I_C$	max.	25 mA
Total power dissipation up to $T_{amb} = 60^\circ\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Transition frequency at $f = 500\text{ MHz}$ $I_C = 14\text{ mA}$ ; $V_{CE} = 10\text{ V}$	$f_T$	typ.	5 GHz
Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 0$ ; $V_{CE} = 10\text{ V}$ ; $T_{amb} = 25^\circ\text{C}$	$C_{re}$	typ.	0,35 pF
Noise figure at $R_S = 60\ \Omega$ $I_C = 4\text{ mA}$ ; $V_{CE} = 10\text{ V}$ ; $f = 800\text{ MHz}$ ; $T_{amb} = 25^\circ\text{C}$	F	typ.	1,8 dB
Output voltage at $d_{im} = -60\text{ dB}$ $I_C = 14\text{ mA}$ ; $V_{CE} = 10\text{ V}$ ; $R_L = 75\ \Omega$ ; $T_{amb} = 25^\circ\text{C}$ $f_{(p+q-r)} = 793,25\text{ MHz}$	$V_o$	typ.	150 mV

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

### RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CB0}$	max.	20 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	15 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	2,0 V
Collector current (d.c.)	$I_C$	max.	25 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

### THERMAL CHARACTERISTICS\*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

#### Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

### CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 10\text{ V}$$

$$I_{CBO} < 60\text{ nA}$$

D.C. current gain $\Delta$

$$I_C = 14\text{ mA}; V_{CE} = 10\text{ V}$$

$$h_{FE} > \begin{matrix} 40 \\ \text{typ.} \\ 90 \end{matrix}$$

Transition frequency at  $f = 500\text{ MHz}$  $\Delta$

$$I_C = 14\text{ mA}; V_{CE} = 10\text{ V}$$

$$f_T \text{ typ. } 5\text{ GHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 10\text{ V}$$

$$C_c \text{ typ. } 0,6\text{ pF}$$

Emitter capacitance at  $f = 1\text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$$

$$C_e \text{ typ. } 1,2\text{ pF}$$

Feedback capacitance at  $f = 1\text{ MHz}$

$$I_C = 0; V_{CE} = 10\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$$

$$C_{re} \text{ typ. } 0,35\text{ pF}$$

Noise figure at  $T_{amb} = 25\text{ }^\circ\text{C}$

$$I_C = 4\text{ mA}; V_{CE} = 10\text{ V}; R_S = 60\text{ }^\Omega; f = 800\text{ MHz}$$

$$F \text{ typ. } 1,8\text{ dB}$$

Maximum unilateral power gain ( $s_{re}$  assumed to be zero)

See Figs 11 to 15

$$G_{UM} \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$$I_C = 14\text{ mA}; V_{CE} = 10\text{ V}; f = 800\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$$

$$G_{UM} \text{ typ. } 15,5\text{ dB}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

$\Delta$  Measured under pulse conditions.



Output voltage at  $d_{im} = -60$  dB (see Figs 2 and 17)\*

(DIN 45004B, par. 6.3: 3-tone)

$I_C = 14$  mA;  $V_{CE} = 10$  V;  $R_L = 75 \Omega$ ;  $V_{SWR} < 2$ ;  $T_{amb} = 25$  °C

$V_p = V_o$  at  $d_{im} = -60$  dB;  $f_p = 795,25$  MHz

$V_q = V_o - 6$  dB;  $f_q = 803,25$  MHz

$V_r = V_o - 6$  dB;  $f_r = 805,25$  MHz

Measured at  $f_{(p+q-r)}$

$= 793,25$  MHz

$V_o$  typ. 150 mV

Second harmonic distortion (see Figs 2 and 18)\*

$I_C = 14$  mA;  $V_{CE} = 10$  V;  $R_L = 75 \Omega$ ;  $V_{SWR} < 2$ ;  $T_{amb} = 25$  °C

$V_p = 60$  mV at  $f_p = 250$  MHz

$V_q = 60$  mV at  $f_q = 560$  MHz

measured at  $f_{(p+q)} = 810$  MHz

$d_2$  typ.  $-50$  dB

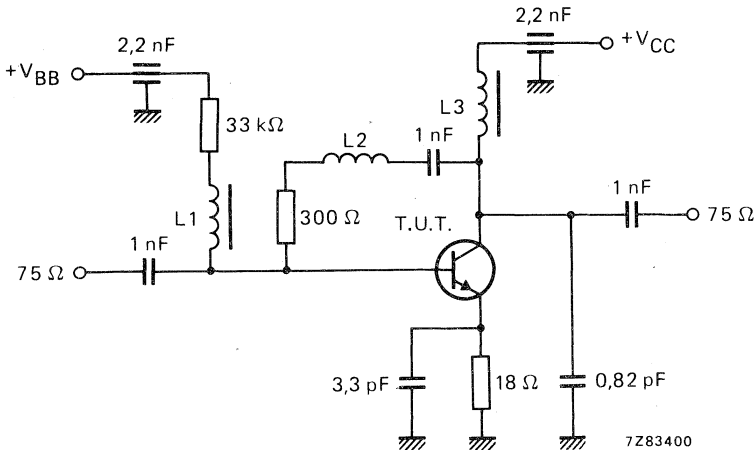


Fig. 2 Intermodulation distortion and second harmonic distortion MATV test circuit.

$L1 = L3 = 5 \mu\text{H}$  micro choke

$L2 = 3$  turns Cu wire (0,4 mm); internal diameter 3 mm; winding pitch 1 mm

\* Measured on same crystal in a SOT-37 envelope (BFR90A).

BFR92A  
BFR92AR

s-parameters (common emitter)

V <sub>CE</sub> V	I <sub>C</sub> mA	f MHz	S <sub>ie</sub>	S <sub>re</sub>	S <sub>fe</sub>	S <sub>oe</sub>
5	2	40	0,88/ -8,9°	0,009/83,6°	6,7/174,2°	1,00/ -2,7°
		100	0,86/ -21,9°	0,022/78,3°	6,5/164,2°	0,98/ -6,6°
		200	0,80/ -42,2°	0,041/69,0°	6,0/149,2°	0,94/ -12,2°
		500	0,61/ -87,2°	0,073/54,9°	4,2/119,1°	0,81/ -20,2°
		800	0,48/ -117,4°	0,086/52,7°	3,1/100,5°	0,74/ -22,9°
		1000	0,44/ -133,8°	0,092/54,2°	2,6/ 91,4°	0,71/ -24,2°
		1200	0,41/ -147,6°	0,099/57,5°	2,2/ 84,3°	0,70/ -25,7°
5	5	40	0,75/ -14,4°	0,008/81,8°	14,4/170,2°	0,99/ -4,9°
		100	0,70/ -34,0°	0,020/74,2°	13,3/155,3°	0,94/ -11,2°
		200	0,60/ -61,7°	0,034/65,0°	10,9/135,8°	0,84/ -17,9°
		500	0,40/ -111,1°	0,057/61,1°	6,2/106,9°	0,67/ -21,9°
		800	0,32/ -139,7°	0,074/65,5°	4,2/ 92,4°	0,62/ -22,2°
		1000	0,30/ -153,2°	0,086/68,2°	3,4/ 85,3°	0,61/ -22,8°
		1200	0,29/ -166,2°	0,100/70,9°	2,9/ 79,6°	0,60/ -24,0°
5	10	40	0,61/ -21,1°	0,008/79,7°	22,9/165,2°	0,97/ -7,3°
		100	0,54/ -48,5°	0,017/71,4°	19,8/145,8°	0,88/ -15,5°
		200	0,42/ -82,1°	0,028/65,2°	14,4/124,7°	0,74/ -20,8°
		500	0,30/ -132,3°	0,050/69,0°	7,1/ 99,6°	0,59/ -20,5°
		800	0,26/ -158,0°	0,072/73,7°	4,7/ 87,8°	0,56/ -20,3°
		1000	0,25/ -168,3°	0,088/75,2°	3,8/ 82,2°	0,56/ -20,9°
		1200	0,25/ -179,3°	0,104/76,6°	3,2/ 77,5°	0,55/ -22,1°
5	14	40	0,53/ -26,0°	0,007/78,6°	27,7/162,4°	0,96/ -8,7°
		100	0,45/ -58,1°	0,016/70,5°	22,6/140,7°	0,85/ -17,2°
		200	0,36/ -94,4°	0,025/66,6°	15,6/119,7°	0,70/ -21,0°
		500	0,27/ -142,8°	0,049/72,5°	7,3/ 96,9°	0,57/ -19,1°
		800	0,25/ -166,0°	0,072/76,5°	4,7/ 86,1°	0,55/ -19,1°
		1000	0,24/ -174,8°	0,088/77,4°	3,8/ 80,5°	0,55/ -19,9°
		1200	0,24/ 174,8°	0,105/78,4°	3,2/ 76,2°	0,54/ -21,3°
5	20	40	0,45/ -33,1°	0,007/77,0°	32,3/158,8°	0,94/ -10,1°
		100	0,38/ -71,8°	0,015/69,5°	24,7/135,0°	0,80/ -18,4°
		200	0,31/ -110,6°	0,023/68,3°	16,0/114,6°	0,66/ -20,1°
		500	0,26/ -154,5°	0,047/75,5°	7,2/ 94,3°	0,56/ -17,3°
		800	0,25/ -174,2°	0,071/78,7°	4,7/ 84,3°	0,55/ -17,8°
		1000	0,25/ 178,5°	0,088/79,3°	3,7/ 79,1°	0,54/ -18,9°
		1200	0,26/ 169,9°	0,104/80,0°	3,2/ 74,9°	0,54/ -20,5°

## s-parameters (common emitter)

$V_{CE}$ V	$I_C$ mA	f MHz	$s_{ie}$	$s_{re}$	$s_{fe}$	$s_{oe}$
10	2	40	0,89/ -8,7°	0,008/83,6°	6,8/174,4°	1,00/ -2,5°
		100	0,86/ -21,2°	0,021/78,5°	6,5/164,6°	0,98/ -6,1°
		200	0,80/ -40,9°	0,038/69,5°	6,0/149,6°	0,94/ -11,3°
		500	0,61/ -85,3°	0,069/55,8°	4,3/119,8°	0,82/ -18,7°
		800	0,48/ -115,4°	0,081/53,8°	3,1/101,2°	0,75/ -21,3°
		1000	0,44/ -131,4°	0,086/55,5°	2,6/ 92,1°	0,73/ -22,5°
10	5	1200	0,40/ -145,6°	0,093/58,9°	2,2/ 85,0°	0,72/ -23,9°
		40	0,77/ -13,6°	0,008/81,8°	14,2/170,5°	0,99/ -4,5°
		100	0,73/ -32,3°	0,019/74,7°	13,2/155,8°	0,95/ -10,3°
		200	0,62/ -58,8°	0,032/65,6°	11,0/136,8°	0,85/ -16,6°
		500	0,41/ -107,2°	0,054/61,4°	6,3/107,7°	0,69/ -20,4°
		800	0,32/ -135,9°	0,071/65,9°	4,2/ 92,9°	0,64/ -20,8°
10	10	1000	0,30/ -150,0°	0,082/68,6°	3,5/ 86,1°	0,63/ -21,3°
		1200	0,28/ -162,9°	0,095/71,5°	2,9/ 80,5°	0,62/ -22,4°
		40	0,66/ -19,4°	0,007/80,1°	22,5/165,9°	0,97/ -6,6°
		100	0,58/ -44,7°	0,017/71,8°	19,5/147,0°	0,90/ -14,1°
		200	0,45/ -76,2°	0,027/65,4°	14,5/126,0°	0,76/ -19,3°
		500	0,29/ -125,1°	0,049/68,7°	7,2/100,6°	0,62/ -19,2°
10	14	800	0,24/ -151,8°	0,070/73,5°	4,7/ 88,8°	0,59/ -19,0°
		1000	0,24/ -162,9°	0,084/75,2°	3,8/ 82,6°	0,58/ -19,7°
		1200	0,23/ -174,8°	0,099/76,8°	3,2/ 78,3°	0,58/ -20,9°
		40	0,60/ -23,2°	0,007/78,6°	27,2/163,0°	0,96/ -7,9°
		100	0,51/ -52,5°	0,016/70,6°	22,6/141,8°	0,86/ -15,8°
		200	0,38/ -86,2°	0,025/66,4°	15,7/120,7°	0,72/ -19,6°
10	20	500	0,26/ -134,3°	0,047/72,0°	7,5/ 97,8°	0,60/ -18,0°
		800	0,22/ -159,3°	0,069/76,2°	4,8/ 86,8°	0,57/ -18,0°
		1000	0,22/ -169,0°	0,085/77,3°	3,9/ 81,3°	0,57/ -18,7°
		1200	0,22/ 179,8°	0,100/78,5°	3,3/ 76,8°	0,57/ -20,1°
		40	0,54/ -28,2°	0,007/77,4°	31,7/159,9°	0,95/ -9,1°
		100	0,45/ -61,7°	0,015/69,5°	24,7/136,8°	0,82/ -16,8°
10	20	200	0,33/ -97,5°	0,023/67,5°	16,3/116,2°	0,68/ -18,8°
		500	0,24/ -143,7°	0,046/74,4°	7,4/ 95,3°	0,59/ -16,4°
		800	0,22/ -166,4°	0,069/78,0°	4,8/ 85,2°	0,57/ -16,9°
		1000	0,22/ -174,7°	0,084/78,7°	3,8/ 80,1°	0,57/ -17,8°
		1200	0,22/ 176,3°	0,100/79,7°	3,3/ 76,0°	0,57/ -19,4°

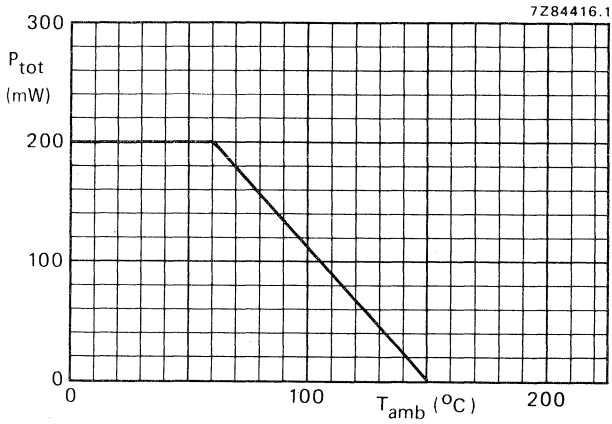


Fig. 3 Power derating curve.

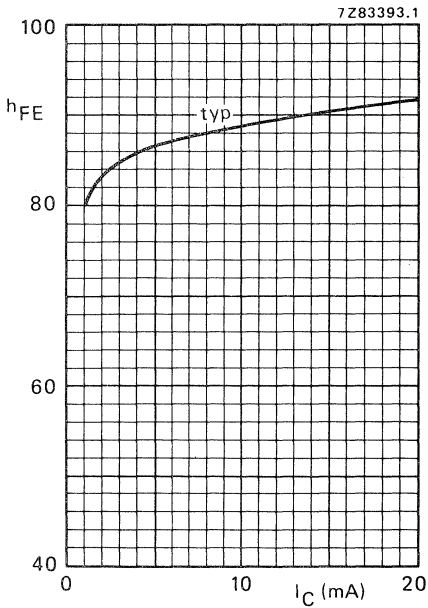


Fig. 4  $V_{CE} = 10$  V;  $T_j = 25$  °C.

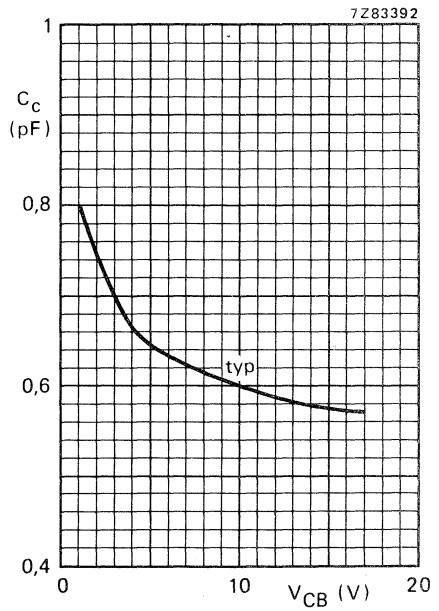


Fig. 5  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25$  °C.

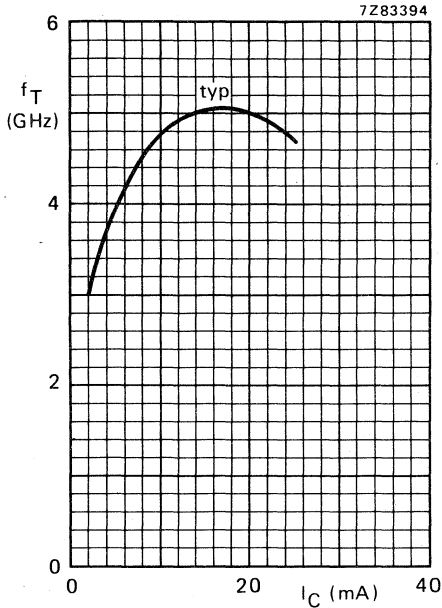


Fig. 6  $V_{CE} = 10$  V;  $f = 500$  MHz;  $T_j = 25$  °C.

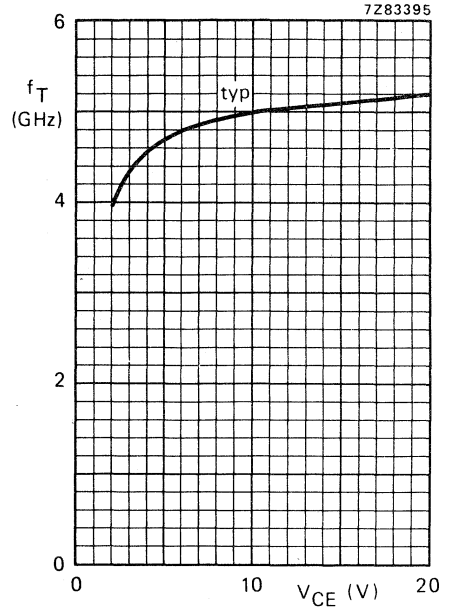


Fig. 7  $I_C = 14$  mA;  $f = 500$  MHz;  $T_j = 25$  °C.

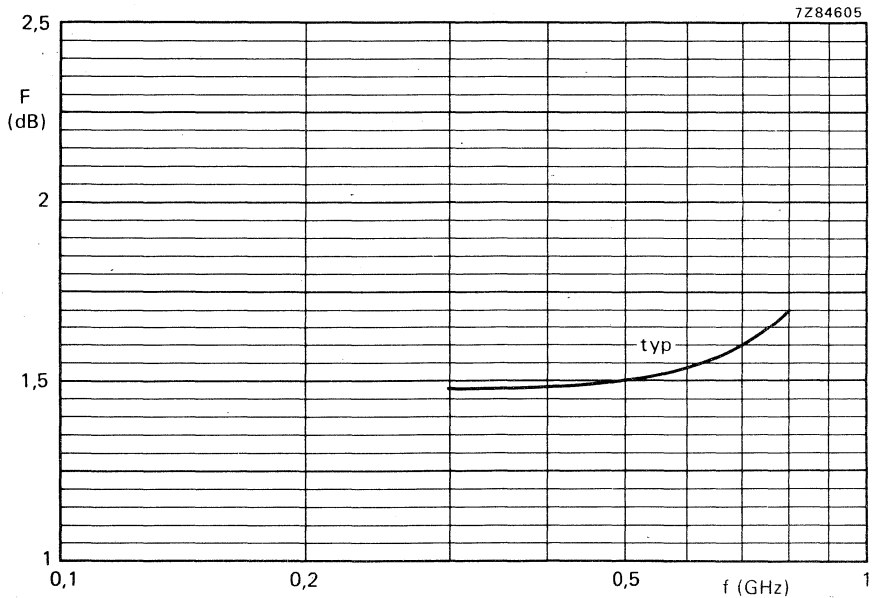


Fig. 8  $V_{CE} = 10$  V;  $I_C = 4$  mA;  $Z_S = \text{optimum}$ ;  $T_{amb} = 25$  °C.

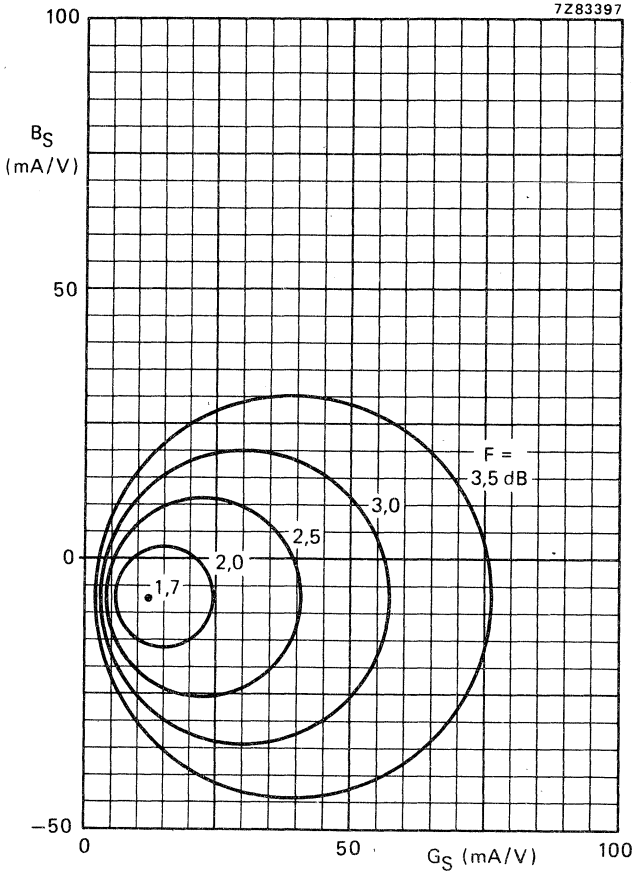


Fig. 9 Circles of constant noise figure.  
 $V_{CE} = 10$  V;  $I_C = 4$  mA;  $f = 800$  MHz;  $T_{amb} = 25$  °C;  
typical values.

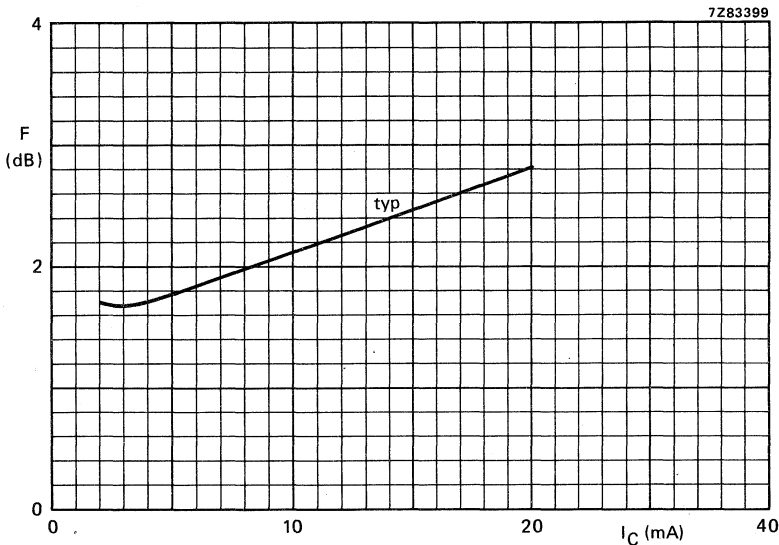


Fig. 10  $V_{CE} = 10$  V;  $f = 800$  MHz;  $Z_S = \text{optimum}$ ;  $T_{amb} = 25$  °C.

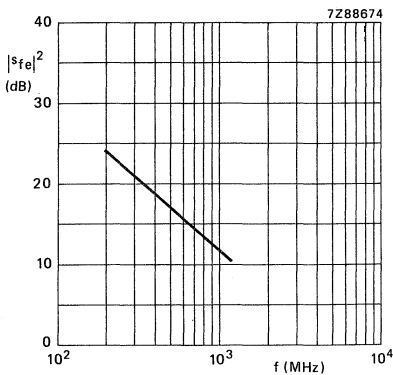


Fig. 11  $V_{CE} = 10$  V;  $I_C = 14$  mA;  
 $T_{amb} = 25$  °C.

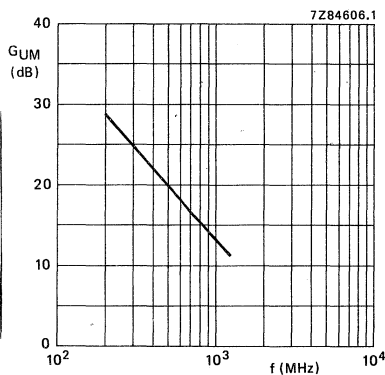


Fig. 12  $V_{CE} = 10$  V;  $I_C = 14$  mA;  
 $T_{amb} = 25$  °C.

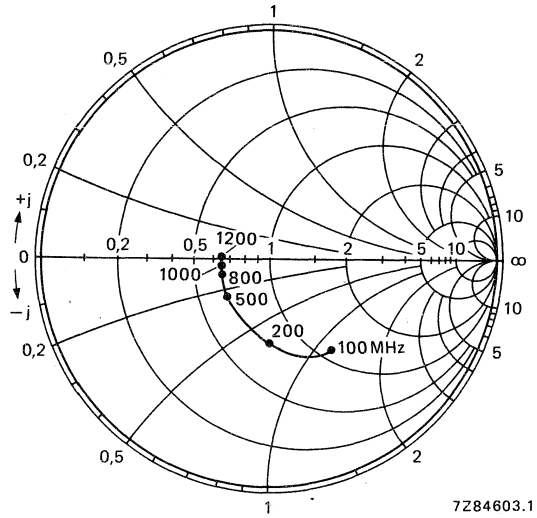


Fig. 13 Input impedance derived from input reflection coefficient  $s_{ie}$  co-ordinates in ohm x 50.  $V_{CE} = 10 \text{ V}$ ;  $I_C = 14 \text{ mA}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ .

7Z84603.1

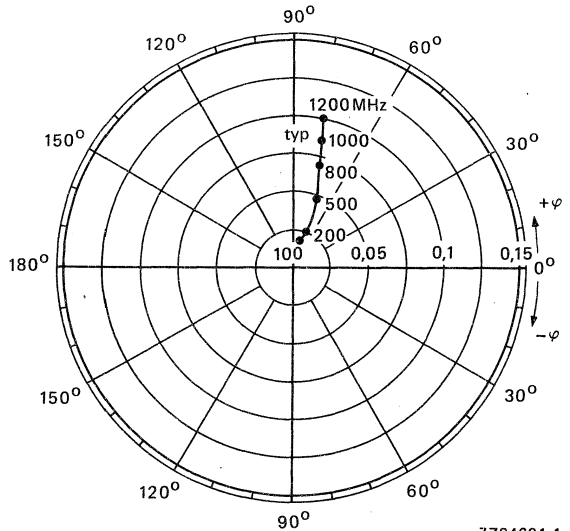


Fig. 14 Reverse transmission coefficient  $s_{re}$ .  $V_{CE} = 10 \text{ V}$ ;  $I_C = 14 \text{ mA}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ .

7Z84601.1



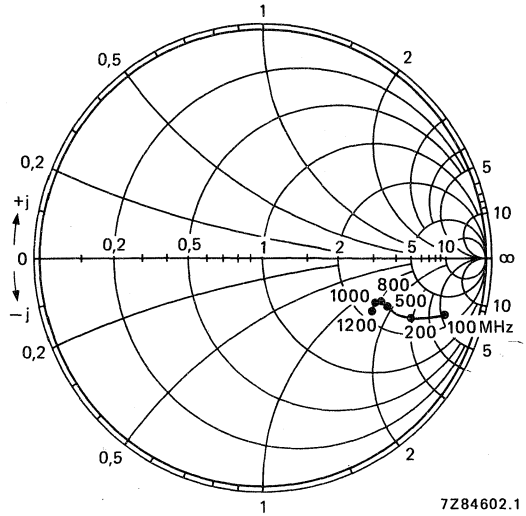


Fig. 15 Output impedance derived from output reflection coefficient  $s_{oe}$  co-ordinates in ohm  $\times 50$ .  
 $V_{CE} = 10 \text{ V}$ ;  $I_C = 14 \text{ mA}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ .

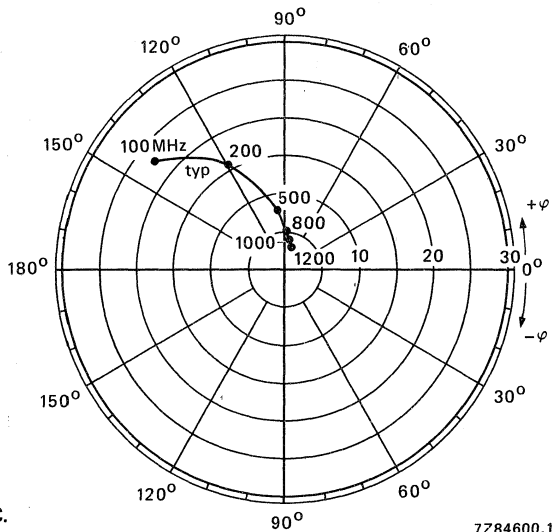


Fig. 16 Forward transmission coefficient  $s_{fe}$ .  
 $V_{CE} = 10 \text{ V}$ ;  $I_C = 14 \text{ mA}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ .

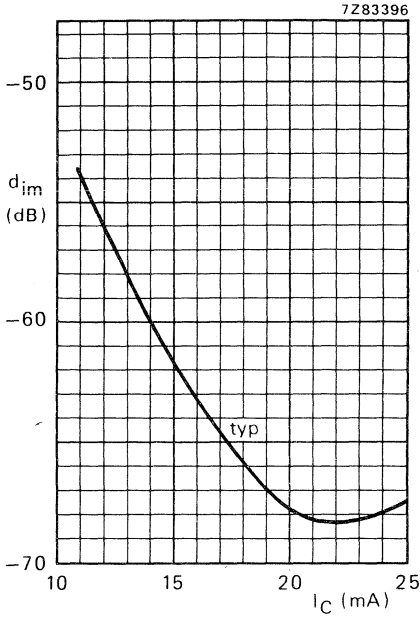


Fig. 17  $V_{CE} = 10 \text{ V}$ ;  $V_O = 43,5 \text{ dBmV} = 150 \text{ mV}$ ;  
 $f_{(p+q-r)} = 793,25 \text{ MHz}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ ;  
measured in MATV test circuit (see Fig. 2)

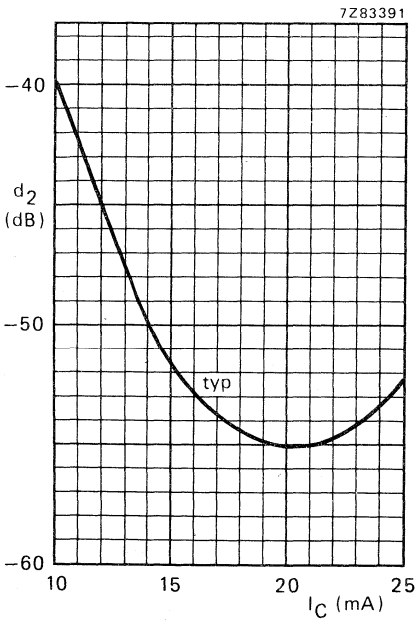


Fig. 18  $V_{CE} = 10 \text{ V}$ ;  $V_O = 60 \text{ mV}$ ;  
 $f_{(p+q)} = 810 \text{ MHz}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ ;  
measured in MATV test circuit (see Fig. 2).

## SILICON PLANAR EPITAXIAL TRANSISTORS

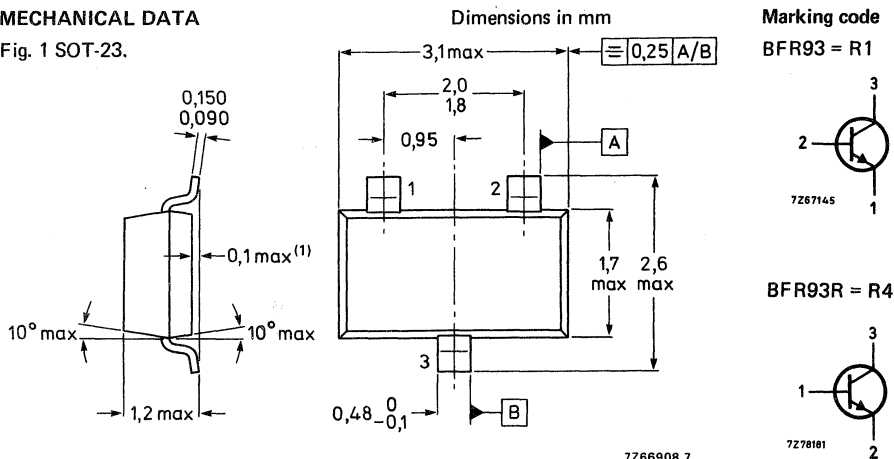
N-P-N transistor in a microminiature plastic envelope. It is primarily intended for use in u.h.f. and microwave amplifiers in thick and thin-film circuits, such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analysers etc. The transistor features very low intermodulation distortion and high power gain; thanks to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CBO}$	max.	15 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	12 V
Collector current (d.c.)	$I_C$	max.	35 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$	$P_{tot}$	max.	200 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Transition frequency at $f = 500\text{ MHz}$ $I_C = 30\text{ mA}$ ; $V_{CE} = 5\text{ V}$	$f_T$	typ.	5 GHz
Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 2\text{ mA}$ ; $V_{CE} = 5\text{ V}$ ; $T_{amb} = 25\text{ }^\circ\text{C}$	$C_{re}$	typ.	0,8 pF
Noise figure at optimum source impedance $I_C = 2\text{ mA}$ ; $V_{CE} = 5\text{ V}$ ; $f = 500\text{ MHz}$ ; $T_{amb} = 25\text{ }^\circ\text{C}$	F	typ.	1,9 dB
Max. unilateral power gain $I_C = 30\text{ mA}$ ; $V_{CE} = 5\text{ V}$ ; $f = 500\text{ MHz}$ ; $T_{amb} = 25\text{ }^\circ\text{C}$	G <sub>UM</sub>	typ.	16,5 dB
Intermodulation distortion at $T_{amb} = 25\text{ }^\circ\text{C}$ $I_C = 30\text{ mA}$ ; $V_{CE} = 5\text{ V}$ ; $R_L = 75\text{ }\Omega$ ; $V_o = 300\text{ mV}$ $f_{(p+q-r)} = 493,25\text{ MHz}$	$d_{im}$	typ.	-60 dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version. TOP VIEW

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	15 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	12 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	2,0 V
Collector current (d.c.)	$I_C$	max.	35 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-65 to +150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL CHARACTERISTICS \***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient **	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 10\text{ V}$$

$$I_{CBO} < 50\text{ nA}$$

D.C. current gain  $\Delta$

$$I_C = 30\text{ mA}; V_{CE} = 5\text{ V}$$

$$h_{FE} > \begin{matrix} 25 \\ \text{typ. } 50 \end{matrix}$$

Transition frequency at  $f = 500\text{ MHz}$   $\Delta$

$$I_C = 30\text{ mA}; V_{CE} = 5\text{ V}$$

$$f_T \text{ typ. } 5\text{ GHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 10\text{ V}$$

$$C_c \text{ typ. } 0,7\text{ pF}$$

Emitter capacitance at  $f = 1\text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$$

$$C_e \text{ typ. } 1,8\text{ pF}$$

Feedback capacitance at  $f = 1\text{ MHz}$

$$I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$$

$$C_{re} \text{ typ. } 0,8\text{ pF}$$

$\Delta$  Measured under pulse conditions.

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

Noise figure at optimum source impedance \*

$$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}; f = 500 \text{ MHz}; T_{\text{amb}} = 25 \text{ }^\circ\text{C}$$

F typ. 1,9 dB

Max. unilateral power gain ( $s_{re}$  assumed to be zero)

$$G_{UM} \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$$I_C = 30 \text{ mA}; V_{CE} = 5 \text{ V}; f = 500 \text{ MHz}; T_{\text{amb}} = 25 \text{ }^\circ\text{C}$$

G<sub>UM</sub> typ. 16,5 dBIntermodulation distortion at  $T_{\text{amb}} = 25 \text{ }^\circ\text{C}$  \*

$$I_C = 30 \text{ mA}; V_{CE} = 5 \text{ V}; R_L = 75 \text{ } \Omega; \text{V.S.W.R.} < 2$$

$$V_p = V_o = 300 \text{ mV at } f_p = 495,25 \text{ MHz}$$

$$V_q = V_o - 6 \text{ dB at } f_q = 503,25 \text{ MHz}$$

$$V_r = V_o - 6 \text{ dB at } f_r = 505,25 \text{ MHz}$$

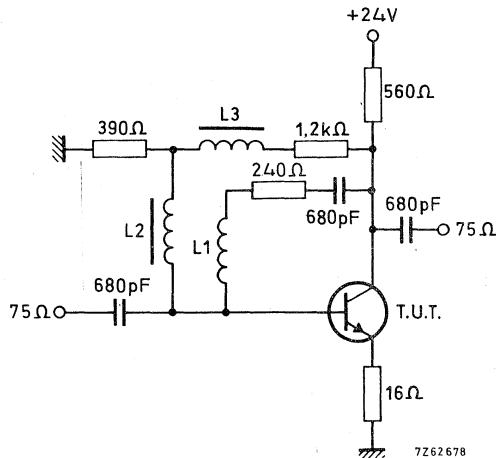
Measured at  $f_{(p+q-r)} = 493,25 \text{ MHz}$ d<sub>im</sub> typ. -60 dB

Fig. 2 Intermodulation test circuit.

L1 = 4 turns Cu wire (0,35); winding pitch 1 mm; int. dia. 4 mm

L2 and L3 5  $\mu\text{H}$  (code number: 3122 108 20150)

\* Crystal mounted in a BFR91 envelope.

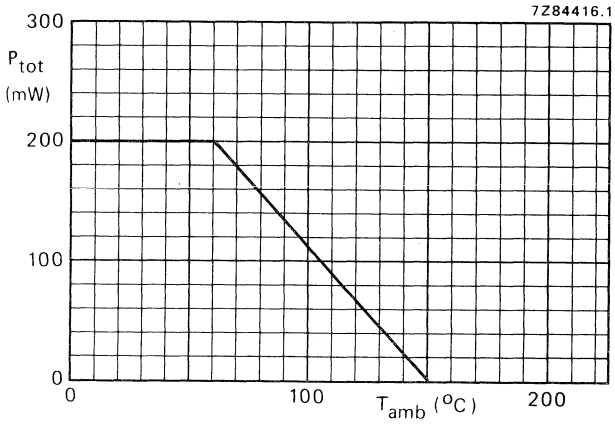
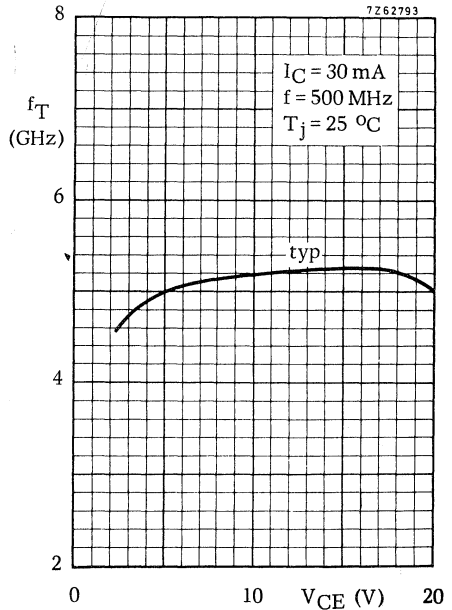
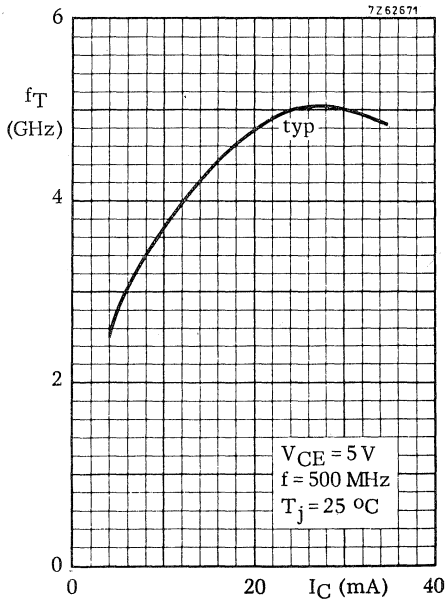
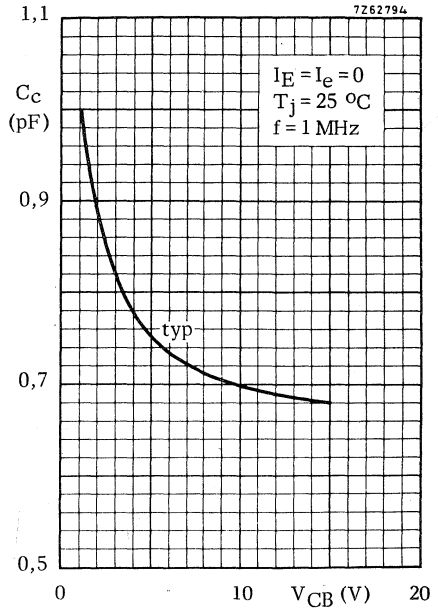
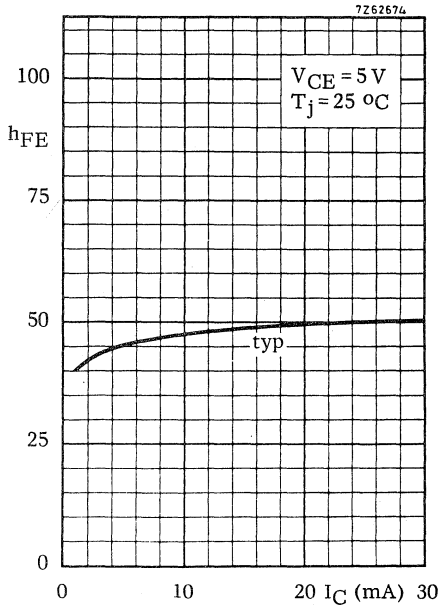
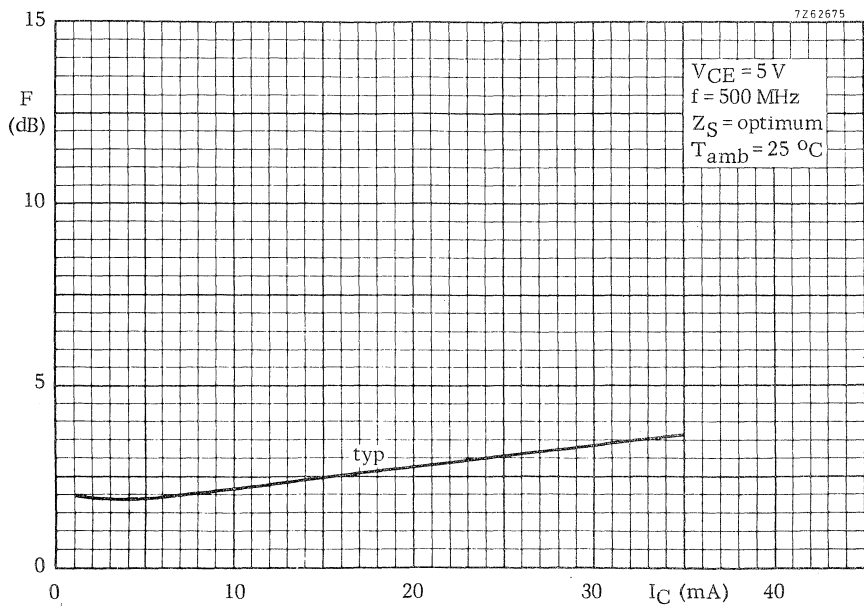
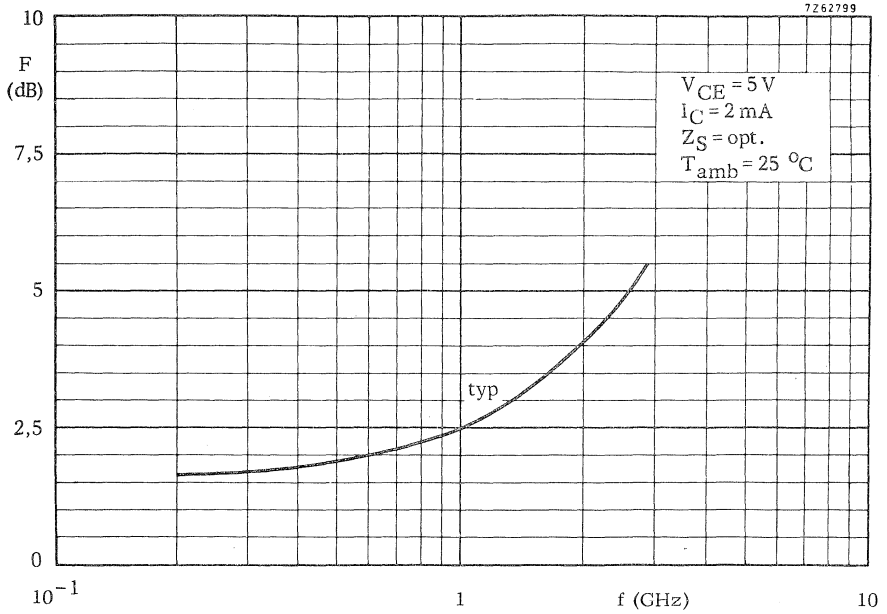
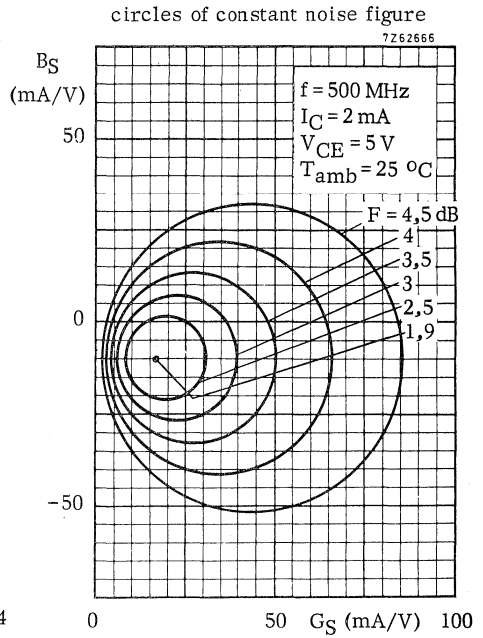
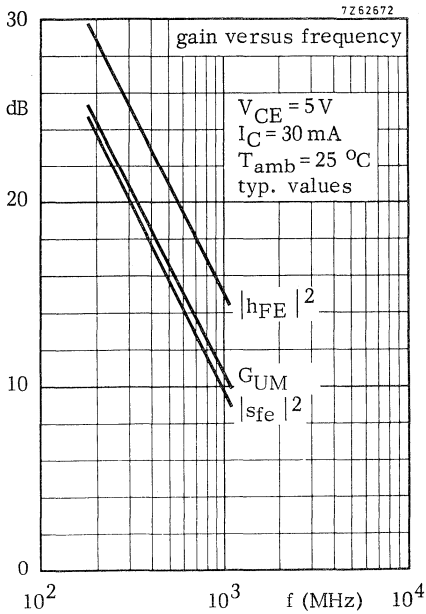


Fig. 3 Power derating curve.



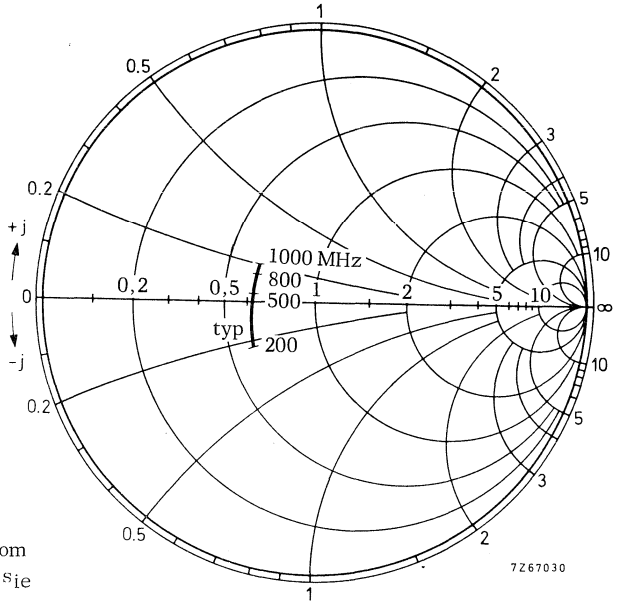






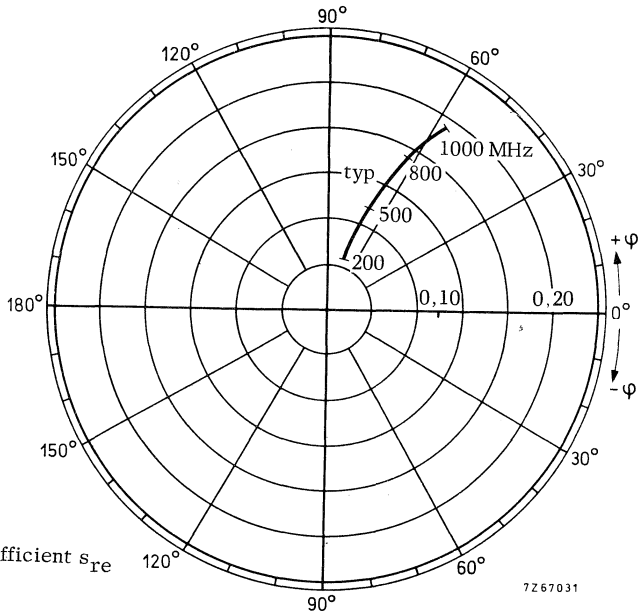
# BFR93

$V_{CE} = 5 \text{ V}$   
 $I_C = 30 \text{ mA}$   
 $T_{amb} = 25 \text{ }^\circ\text{C}$



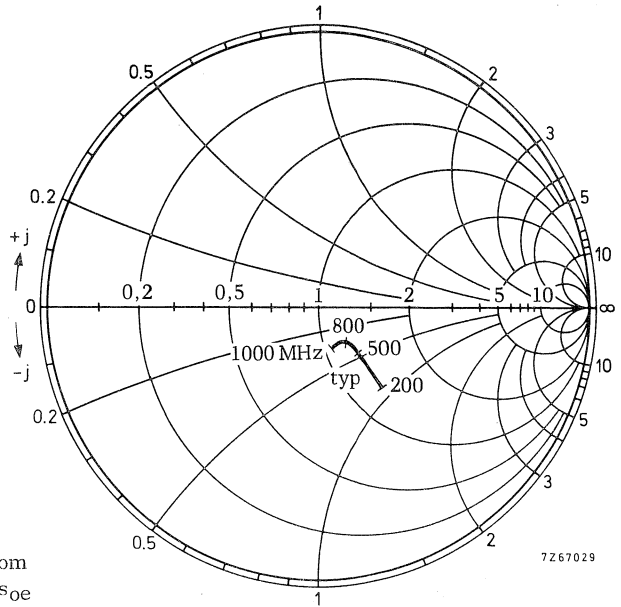
Input impedance derived from  
 input reflection coefficient  $s_{ie}$   
 coordinates in ohm x 50

$V_{CE} = 5 \text{ V}$   
 $I_C = 30 \text{ mA}$   
 $T_{amb} = 25 \text{ }^\circ\text{C}$



Reverse transmission coefficient  $s_{re}$

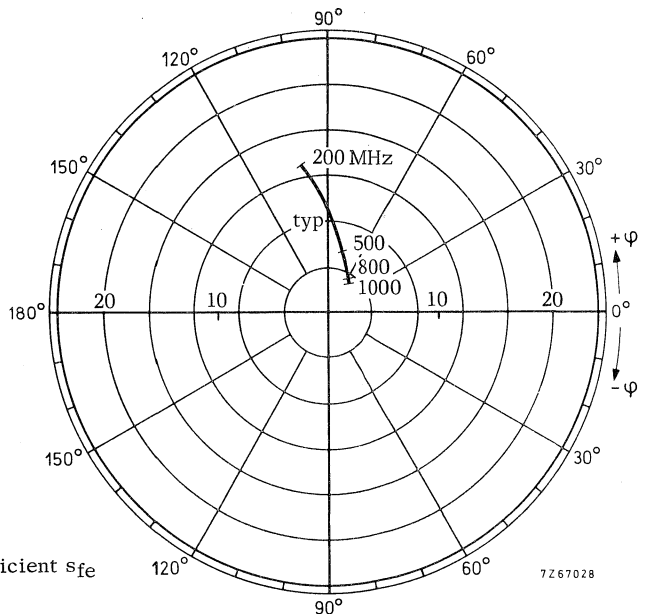
$V_{CE} = 5 \text{ V}$   
 $I_C = 30 \text{ mA}$   
 $T_{amb} = 25 \text{ }^\circ\text{C}$



Output impedance derived from  
 output reflection coefficient  $s_{oe}$   
 coordinates in ohm  $\times 50$

7Z67029

$V_{CE} = 5 \text{ V}$   
 $I_C = 30 \text{ mA}$   
 $T_{amb} = 25 \text{ }^\circ\text{C}$



Forward transmission coefficient  $s_{fe}$

7Z67028



## SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors in a microminiature plastic envelope. They are primarily intended for use in v.h.f./u.h.f. broadband amplifiers. The transistors feature:

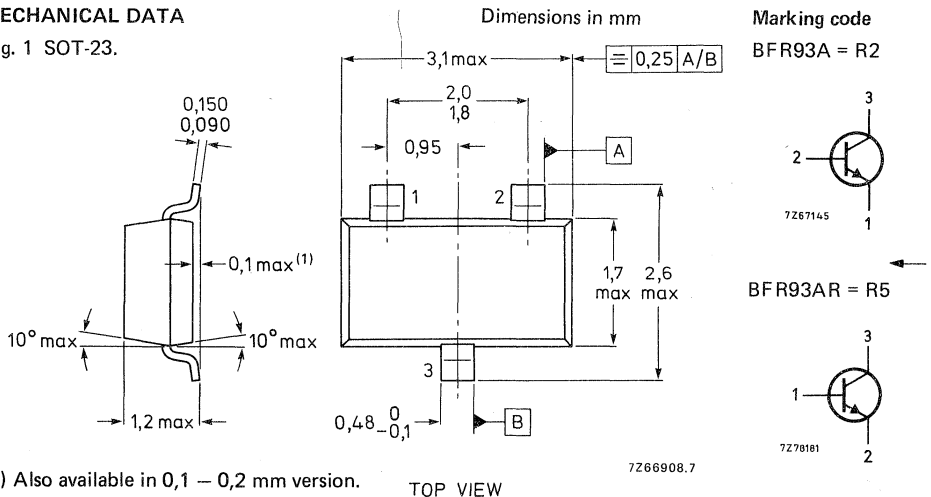
- low noise;
- very low intermodulation distortion;
- high power gain;

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CBO}$	max.	15 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	12 V
Collector current (d.c.)	$I_C$	max.	35 mA
Total power dissipation up to $T_{amb} = 45^\circ\text{C}$	$P_{tot}$	max.	250 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Transition frequency at $f = 500\text{ MHz}$ $I_C = 30\text{ mA}; V_{CE} = 5\text{ V}$	$f_T$	typ.	5 GHz
Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 0; V_{CE} = 5\text{ V}; T_{amb} = 25^\circ\text{C}$	$C_{re}$	typ.	0,6 pF
Noise figure at optimum source impedance $I_C = 4\text{ mA}; V_{CE} = 8\text{ V}; f = 800\text{ MHz}$	F	typ.	1,6 dB
Output voltage at $d_{im} = -60\text{ dB}$ $I_C = 30\text{ mA}; V_{CE} = 8\text{ V}; R_L = 75\ \Omega; T_{amb} = 25^\circ\text{C}$ $f_{(p+q-r)} = 793,25\text{ MHz}$	$V_o$	typ.	425 mV

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

TOP VIEW

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CB0}$	max.	15 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	12 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	2,0 V
Collector current (d.c.)	$I_C$	max.	35 mA
Total power dissipation up to $T_{amb} = 45\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	250 mW
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 5\text{ V}$$

$I_{CB0}$	<	50 nA
-----------	---	-------

D.C. current gain▲

$$I_C = 30\text{ mA}; V_{CE} = 5\text{ V}$$

$h_{FE}$	>	40
	typ.	90

Transition frequency at  $f = 500\text{ MHz}$ ▲

$$I_C = 30\text{ mA}; V_{CE} = 5\text{ V}$$

$f_T$	typ.	5 GHz
-------	------	-------

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 5\text{ V}$$

$C_c$	typ.	0,7 pF
-------	------	--------

Emitter capacitance at  $f = 1\text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$$

$C_e$	typ.	1,9 pF
-------	------	--------

Feedback capacitance at  $f = 1\text{ MHz}$

$$I_C = 0; V_{CE} = 5\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$$

$C_{re}$	typ.	0,6 pF
----------	------	--------

Noise figure at optimum source impedance▲

$$I_C = 4\text{ mA}; V_{CE} = 8\text{ V}; f = 800\text{ MHz}$$

$$I_C = 30\text{ mA}; V_{CE} = 8\text{ V}; f = 800\text{ MHz}$$

F	typ.	1,6 dB
F	typ.	2,3 dB

Maximum unilateral power gain ( $s_{re}$  assumed to be zero)

See Figs 10 to 15

$$G_{UM} \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$$I_C = 30\text{ mA}; V_{CE} = 8\text{ V}; f = 800\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$$

$G_{UM}$	typ.	14 dB
----------	------	-------

▲ Measured under pulse conditions.

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

Output voltage at  $d_{im} = -60$  dB (see Figs 2 and 16)\*  
(DIN 45004B, par. 6.3: 3-tone)

$I_C = 30$  mA;  $V_{CE} = 8$  V;  $R_L = 75$   $\Omega$ ;  $T_{amb} = 25$   $^{\circ}$ C

$V_p = V_o$  at  $d_{im} = -60$  dB;  $f_p = 795,25$  MHz

$V_q = V_o - 6$  dB ;  $f_q = 803,25$  MHz

$V_r = V_o - 6$  dB ;  $f_r = 805,25$  MHz

Measured at  $f_{(p+q-r)} = 793,25$  MHz

$V_o$  typ. 425 mV

Second harmonic distortion (see Figs 2 and 17)\*

$I_C = 30$  mA;  $V_{CE} = 8$  V;  $R_L = 75$   $\Omega$ ;  $T_{amb} = 25$   $^{\circ}$ C

$V_p = 200$  mV at  $f_p = 250$  MHz

$V_q = 200$  mV at  $f_q = 560$  MHz

measured at  $f_{(p+q)} = 810$  MHz

$d_2$  typ.  $-50$  dB

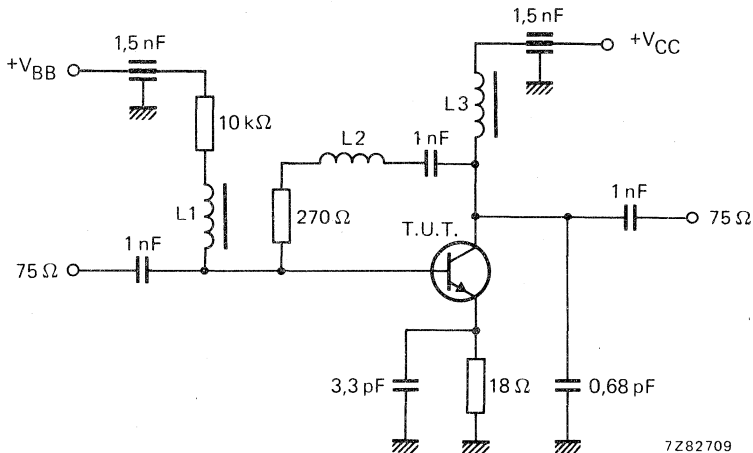


Fig. 2 Intermodulation distortion and second harmonic distortion MATV test circuit.

$L1 = L3 = 5$   $\mu$ H micro choke

$L2 = 3$  turns Cu wire (0,4 mm); internal diameter 3 mm; winding pitch 1 mm.

\* Measured on same crystal in a SOT-37 envelope (BFR91A).

BFR93A  
BFR93AR

s-parameters (common emitter)

V <sub>CE</sub> V	I <sub>C</sub> mA	f MHz	S <sub>ie</sub>	S <sub>re</sub>	S <sub>fe</sub>	S <sub>oe</sub>
5	2	40	0,89/ -12,4°	0,016/82,3°	7,0/171,8°	0,88/ -4,8°
		100	0,87/ -30,1°	0,038/74,2°	6,7/160,1°	0,96/-11,3°
		200	0,80/ -56,3°	0,067/61,8°	6,0/142,3°	0,88/-20,1°
		500	0,64/-109,5°	0,106/44,3°	3,8/110,6°	0,69/-31,9°
		800	0,57/-140,3°	0,116/41,8°	2,7/ 91,5°	0,60/-35,5°
		1000	0,54/-154,5°	0,119/43,9°	2,2/ 82,8°	0,58/-38,0°
5	5	1200	0,53/-166,6°	0,124/48,2°	1,9/ 75,1°	0,56/-40,2°
		40	0,77/ -19,9°	0,015/79,4°	15,1/166,8°	0,97/ -8,8°
		100	0,72/ -46,9°	0,033/68,6°	13,5/149,7°	0,89/-19,6°
		200	0,62/ -81,4°	0,053/57,0°	10,5/128,5°	0,73/-30,3°
		500	0,48/-134,4°	0,079/52,6°	5,5/100,5°	0,51/-37,3°
		800	0,45/-159,8°	0,099/57,8°	3,6/ 85,6°	0,44/-37,9°
5	10	1000	0,44/-170,8°	0,114/61,0°	3,0/ 78,8°	0,42/-39,3°
		1200	0,43/ 179,8°	0,131/64,2°	2,5/ 72,9°	0,41/-40,9°
		40	0,63/ -29,7°	0,013/76,5°	24,4/161,0°	0,95/-13,5°
		100	0,56/ -66,2°	0,028/64,8°	20,0/139,4°	0,80/-17,8°
		200	0,47/-105,4°	0,042/57,8°	13,6/118,0°	0,59/-37,3°
		500	0,41/-152,0°	0,070/62,6°	6,4/ 94,8°	0,39/-39,0°
5	20	800	0,39/-171,7°	0,099/67,6°	4,1/ 82,7°	0,35/-38,2°
		1000	0,39/ 179,6°	0,119/69,1°	3,4/ 76,7°	0,34/-39,1°
		1200	0,39/ 171,6°	0,140/70,5°	2,8/ 71,5°	0,33/-40,7°
		40	0,47/ -44,2°	0,012/73,8°	35,2/154,0°	0,90/-19,2°
		100	0,42/ -90,7°	0,023/63,9°	25,4/129,3°	0,68/-35,0°
		200	0,39/-129,4°	0,034/62,9°	15,6/109,7°	0,47/-41,0°
5	30	500	0,37/-165,1°	0,067/70,5°	6,8/ 90,9°	0,32/-38,4°
		800	0,37/ 179,5°	0,101/73,2°	4,4/ 80,3°	0,29/-37,4°
		1000	0,36/ 173,0°	0,124/73,4°	3,6/ 75,4°	0,29/-38,3°
		1200	0,37/ 166,2°	0,148/73,6°	3,0/ 70,3°	0,28/-40,0°
		40	0,39/ -56,3°	0,011/72,3°	40,8/149,5°	0,86/-22,5°
		100	0,38/-106,8°	0,021/64,5°	27,4/124,0°	0,61/-37,9°
5	30	200	0,37/-141,6°	0,032/66,4°	16,0/105,8°	0,41/-41,1°
		500	0,37/-171,0°	0,067/73,5°	6,9/ 88,9°	0,29/-36,6°
		800	0,37/ 175,9°	0,102/75,2°	4,4/ 79,1°	0,27/-36,0°
		1000	0,36/ 170,0°	0,126/74,8°	3,6/ 74,2°	0,27/-37,1°
		1200	0,37/ 163,9°	0,150/74,6°	3,0/ 69,5°	0,27/-39,0°



## s-parameters (common emitter)

$V_{CE}$ V	$I_C$ mA	f MHz	$S_{ie}$	$S_{re}$	$S_{fe}$	$S_{oe}$
8	2	40	0,90/ -12,2°	0,015/82,1°	6,9/171,7°	0,99/ -4,8°
		100	0,88/ -29,2°	0,036/74,5°	6,6/160,4°	0,96/ -10,8°
		200	0,81/ -54,7°	0,064/62,4°	5,9/143,1°	0,89/ -19,2°
		500	0,64/ -107,0°	0,103/44,9°	3,8/111,5°	0,71/ -30,6°
		800	0,56/ -138,1°	0,112/42,1°	2,7/ 92,2°	0,62/ -34,1°
		1000	0,54/ -152,6°	0,116/44,1°	2,3/ 83,6°	0,60/ -36,4°
		1200	0,52/ -165,2°	0,120/48,5°	1,9/ 75,9°	0,58/ -38,6°
8	5	40	0,78/ -19,2°	0,014/79,4°	14,8/166,9°	0,98/ -8,6°
		100	0,73/ -44,6°	0,032/69,0°	13,5/150,4°	0,90/ -18,7°
		200	0,63/ -78,1°	0,051/57,5°	10,5/129,4°	0,75/ -28,9°
		500	0,48/ -131,2°	0,077/52,5°	5,6/101,3°	0,53/ -35,7°
		800	0,44/ -157,3°	0,096/57,7°	3,7/ 86,3°	0,46/ -36,2°
		1000	0,42/ -168,3°	0,110/61,0°	3,0/ 79,5°	0,44/ -37,5°
		1200	0,42/ -178,3°	0,126/64,3°	2,6/ 73,6°	0,43/ -39,0°
8	10	40	0,66/ -27,7°	0,013/76,7°	24,0/161,5°	0,95/ -12,9°
		100	0,58/ -62,0°	0,027/65,4°	19,9/140,4°	0,81/ -26,3°
		200	0,48/ -100,1°	0,041/58,0°	13,8/119,0°	0,61/ -35,5°
		500	0,40/ -148,2°	0,068/62,2°	6,5/ 95,4°	0,42/ -37,0°
		800	0,38/ -169,1°	0,096/67,4°	4,2/ 83,0°	0,37/ -36,2°
		1000	0,37/ -178,3°	0,116/69,0°	3,4/ 77,4°	0,36/ -37,0°
		1200	0,37/ 173,6°	0,136/70,5°	2,9/ 72,5°	0,35/ -38,5°
8	20	40	0,53/ -39,6°	0,012/73,8°	34,7/154,8°	0,91/ -18,1°
		100	0,45/ -83,0°	0,023/63,9°	25,6/130,5°	0,70/ -33,2°
		200	0,39/ -122,0°	0,034/62,2°	15,9/110,6°	0,49/ -39,0°
		500	0,35/ -161,3°	0,066/69,7°	7,0/ 91,4°	0,34/ -36,2°
		800	0,35/ -177,9°	0,098/72,7°	4,5/ 80,7°	0,31/ -35,1°
		1000	0,34/ 175,2°	0,121/73,1°	3,7/ 75,8°	0,31/ -36,0°
		1200	0,34/ 168,3°	0,143/73,4°	3,1/ 71,2°	0,30/ -37,5°
8	30	40	0,47/ -48,0°	0,011/72,2°	40,3/150,8°	0,87/ -20,9°
		100	0,41/ -95,5°	0,021/63,8°	27,5/125,4°	0,63/ -35,7°
		200	0,36/ -132,8°	0,032/64,9°	16,4/106,8°	0,44/ -38,9°
		500	0,35/ -166,6°	0,065/72,3°	7,1/ 89,6°	0,32/ -34,4°
		800	0,34/ 178,8°	0,100/74,4°	4,5/ 79,7°	0,30/ -33,6°
		1000	0,34/ 172,7°	0,122/74,4°	3,7/ 74,7°	0,30/ -34,7°
		1200	0,34/ 166,0°	0,145/74,3°	3,1/ 70,3°	0,29/ -36,5°

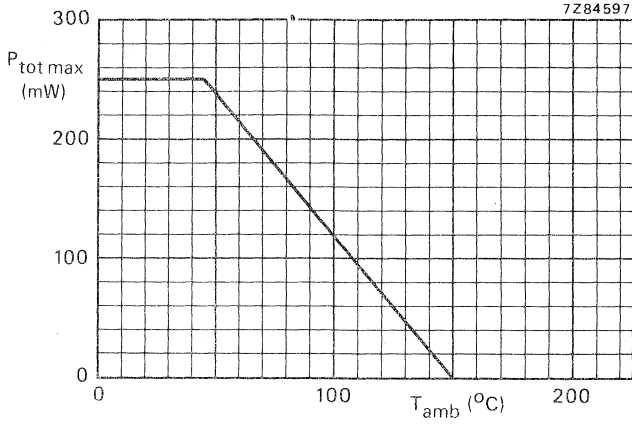


Fig. 3 Power derating curve.

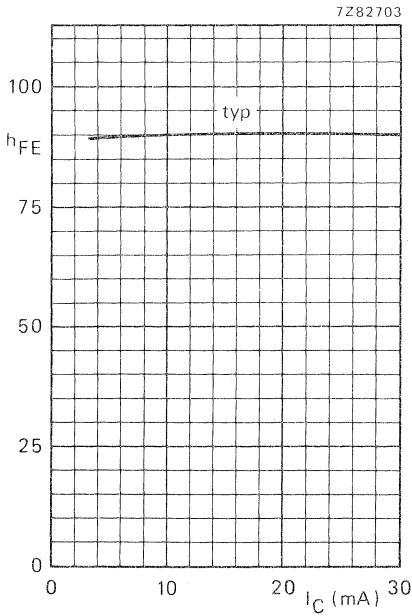


Fig. 4  $V_{CE} = 5\ V$ ;  $T_j = 25\ ^\circ C$ .

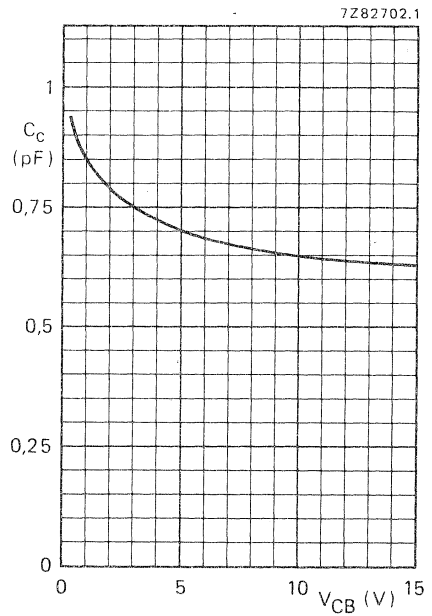


Fig. 5 Typical values collector capacitance  
 $I_E = I_e = 0$ ;  $f = 1\ MHz$ ;  $T_j = 25\ ^\circ C$ .

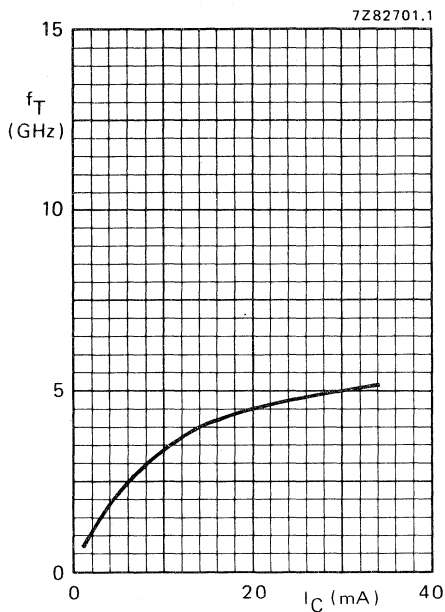


Fig. 6 Typical values transition frequency at  $V_{CE} = 5 \text{ V}$ ;  $f = 500 \text{ MHz}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ .

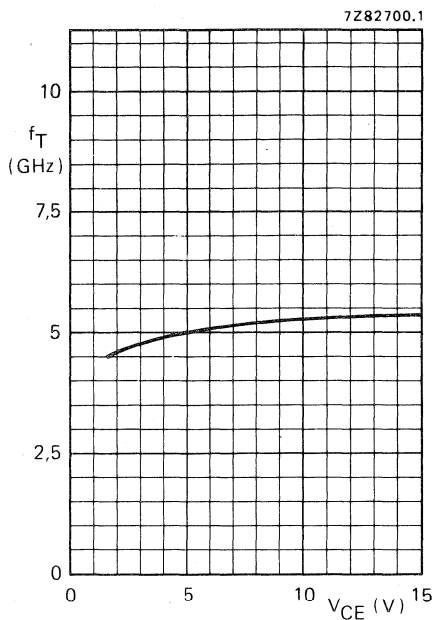


Fig. 7 Typical values transition frequency at  $I_C = 30 \text{ mA}$ ;  $f = 500 \text{ MHz}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ .

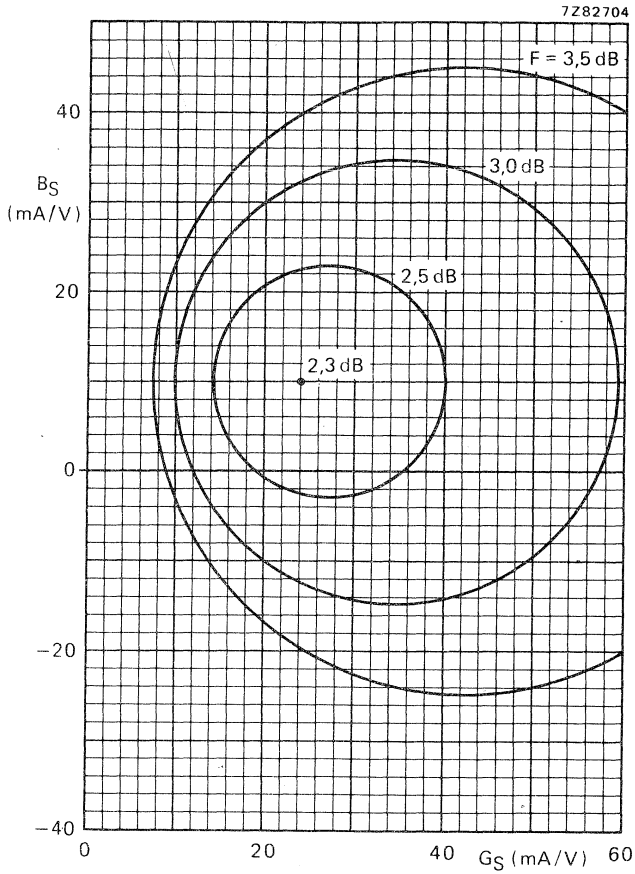


Fig. 8 Circles of constant noise figure.  
 $V_{CE} = 8$  V;  $I_C = 30$  mA;  $f = 800$  MHz;  
 $T_{amb} = 25$  °C; typical values.

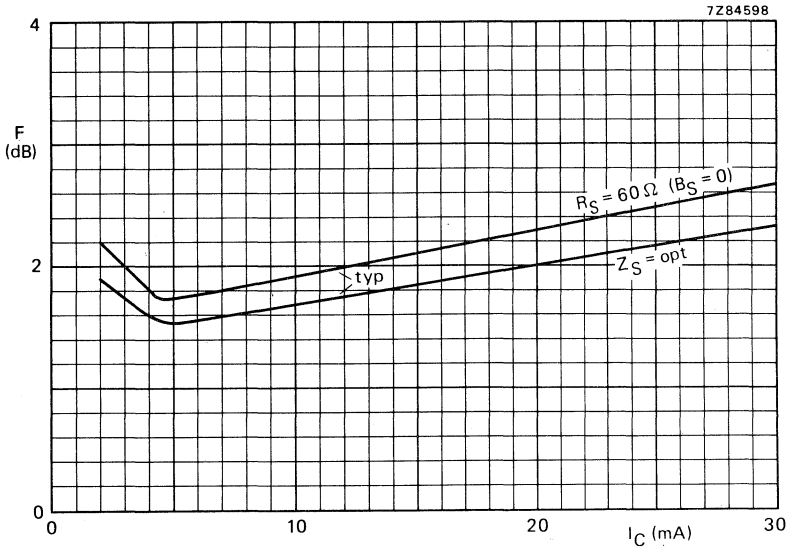


Fig. 9  $V_{CE} = 8 \text{ V}$ ;  $f = 800 \text{ MHz}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ .

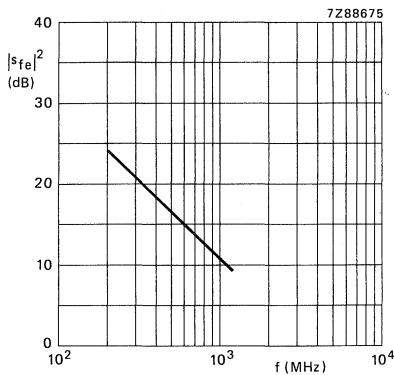


Fig. 10 Typical values forward transmission coefficient as a function of frequency.  $V_{CE} = 8 \text{ V}$ ;  $I_C = 30 \text{ mA}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ .

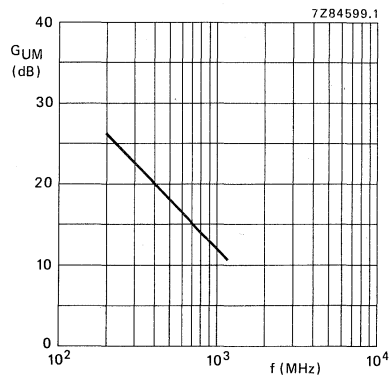
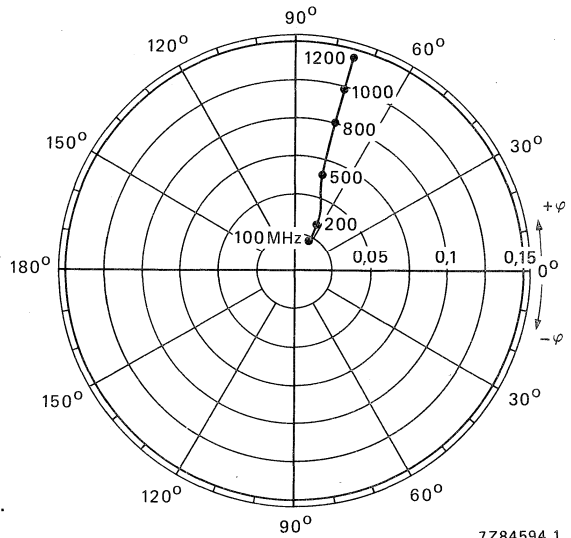
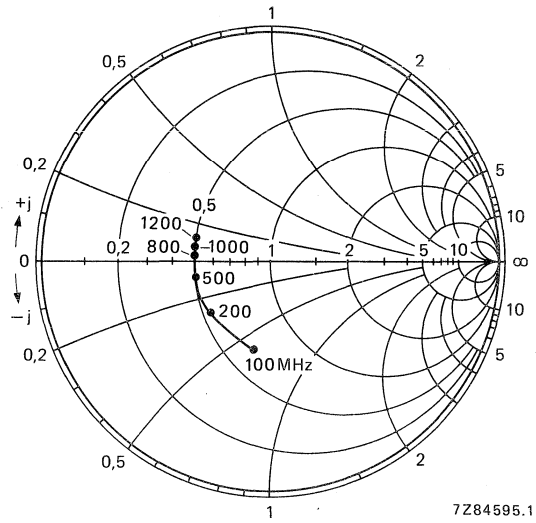


Fig. 11 Typical values unilateral power gain as a function of frequency.  $V_{CE} = 8 \text{ V}$ ;  $I_C = 30 \text{ mA}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ .



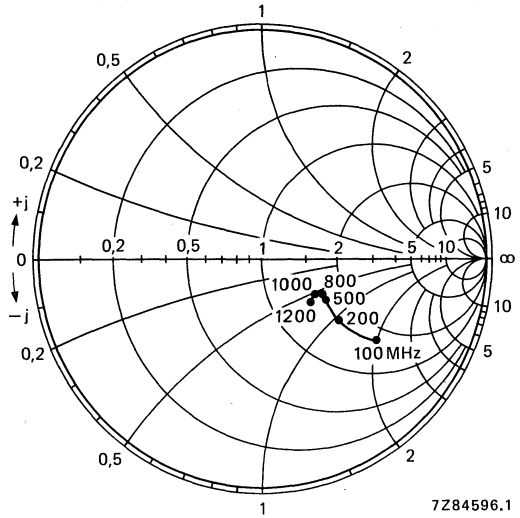


Fig. 14 Output impedance derived from output reflection coefficient  $s_{oe}$  co-ordinates in ohm  $\times 50$ .  
 $V_{CE} = 8 \text{ V}$ ;  $I_C = 30 \text{ mA}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ .

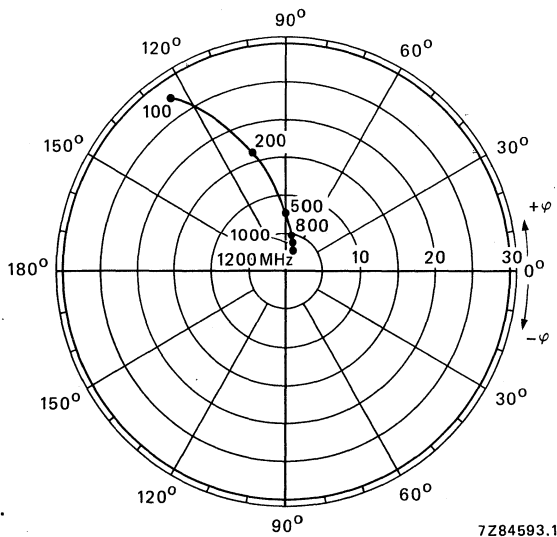


Fig. 15 Forward transmission coefficient  $s_{fe}$ .  
 $V_{CE} = 8 \text{ V}$ ;  $I_C = 30 \text{ mA}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ .

BFR93A  
BFR93AR

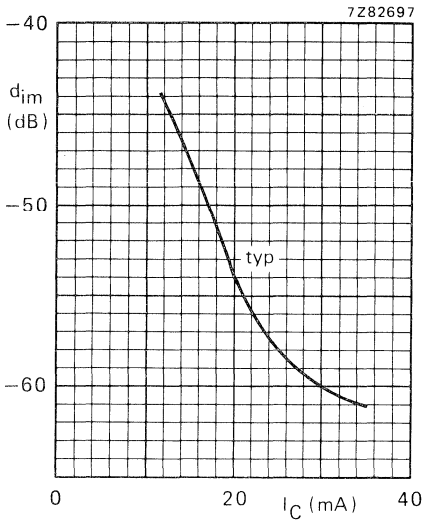


Fig. 16  $V_{CE} = 8\text{ V}$ ;  $V_O = 425\text{ mV} = 52,6\text{ dBmV}$ ;  
 $f_{(p+q-r)} = 793,25\text{ MHz}$ ;  $T_{amb} = 25\text{ }^\circ\text{C}$ ;  
measured in MATV test circuit (see Fig. 2).

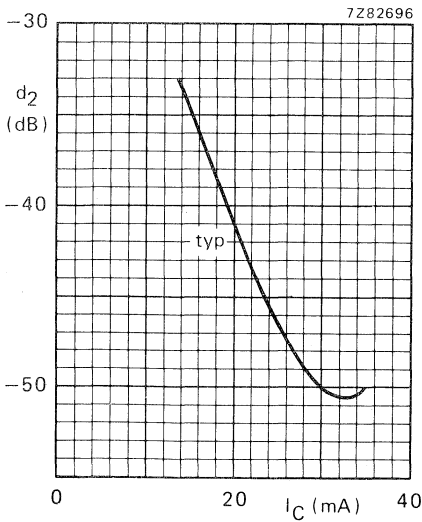


Fig. 17  $V_{CE} = 8\text{ V}$ ;  $V_O = 200\text{ mV} = 46\text{ dBmV}$ ;  
 $f_{(p+q)} = 810\text{ MHz}$ ;  $T_{amb} = 25\text{ }^\circ\text{C}$ ; measured in  
MATV test circuit (see Fig. 2).



## N-CHANNEL JUNCTION FIELD-EFFECT TRANSISTOR

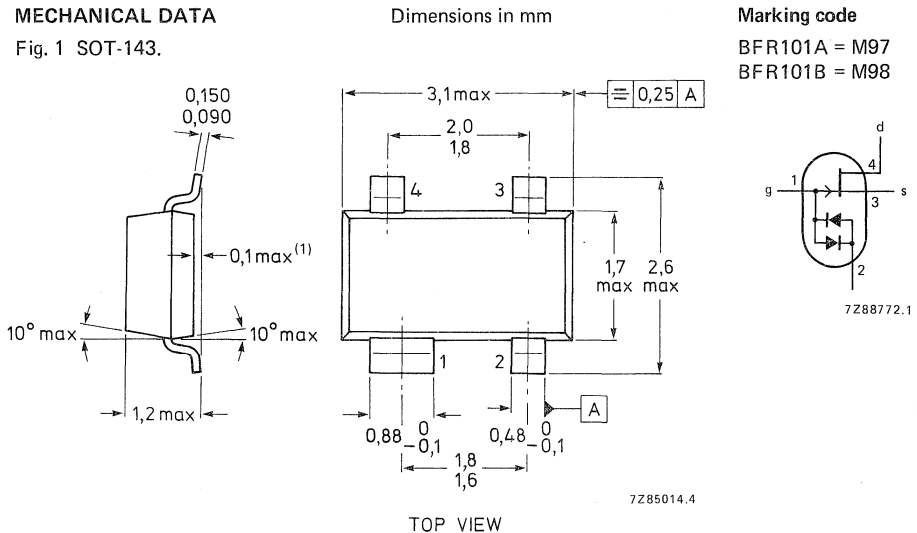
Symmetrical n-channel silicon junction field-effect transistor, designed primarily for use as a source follower with the input protected against successive voltage surges by a forward and reverse integrated diode.

### QUICK REFERENCE DATA

Drain-source voltage	$\pm V_{DS}$	max.	30 V
Gate-source voltage (open drain)	$-V_{GS}$	max.	30 V
Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	200 mW
Drain current			
$V_{DS} = 6\text{ V}; V_{GS} = 0$ ; BFR101A	$I_{DSS}$	0,2 to 1,5 mA	
$V_{DS} = 6\text{ V}; V_{GS} = 0$ ; BFR101B	$I_{DSS}$	1,0 to 5,0 mA	
Transfer admittance (common source)			
$V_{DS} = 6\text{ V}; V_{GS} = 0$ ; $f = 1\text{ kHz}$ ; BFR101A	$ y_{fs} $	>	1,2 mS
$V_{DS} = 6\text{ V}; V_{GS} = 0$ ; $f = 1\text{ kHz}$ ; BFR101B	$ y_{fs} $	>	2,5 mS

### MECHANICAL DATA

Fig. 1 SOT-143.



### Marking code

BFR101A = M97  
BFR101B = M98

(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**BFR101A**  
**BFR101B**

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	$\pm V_{DS}$	max.	30 V
Drain-gate voltage (open source)	$V_{DGO}$	max.	30 V
Gate-source voltage (open drain)	$-V_{GSO}$	max.	30 V
Drain current (d.c.)	$I_D$	max.	20 mA
Gate current (d.c.)	$I_G$	max.	10 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^*$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-65 to +150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air*	$R_{th\ j-a}$	=	460 K/W
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**CHARACTERISTICS** with source connected to case for all measurements

$T_{amb} = 25\text{ }^\circ\text{C}$  unless otherwise specified

		<b>BFR101A</b>	<b>BFR101B</b>
Gate leakage current $V_{DS} = 6\text{ V}; I_D = 10\text{ }\mu\text{A}$	$-I_G$	< 5	5 nA
Drain current* $V_{DS} = 6\text{ V}; V_{GS} = 0$	$I_{DSS}$	0,2 to 1,5	1 to 5 mA
Gate-source cut-off voltage $V_{DS} = 6\text{ V}; I_D = 1\text{ }\mu\text{A}$	$-V_{(P)GS}$	0,2 to 1	0,5 to 2,5 V
<b>Small-signal common-source characteristics</b>			
$V_{DS} = 6\text{ V}; V_{GS} = 0$			
Transfer admittance* $f = 1\text{ kHz}$	$ Y_{fs} $	> 1,2	2,5 mS
→ Output admittance at $f = 1\text{ kHz}^{**}$	$ Y_{os} $	typ. 10	50 mS
Input capacitance at $f = 1\text{ MHz}$ diodes not connected	$C_{is}$	< 5	5 pF
Diode capacitance $V_D = 0$ ; source and drain not connected	$C_d$	typ. 0,7	0,7 pF
Diode forward voltage $\pm I_F = 10\text{ mA}$	$V_F$	0,7 to 1,2	0,7 to 1,2 V

\* Device mounted on a ceramic substrate of 8 mm x 10 mm x 0,6 mm.

\*\* Measured under pulse conditions:  $t_p = 100\text{ ms}; \delta \leq 0,1$ .

## SILICON PLANAR EPITAXIAL TRANSISTOR

N-P-N transistor in a microminiature plastic envelope. It is intended for a wide range of v.h.f. and u.h.f. applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter; peak value)	$V_{CBOM}$	max.	25 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	15 V
Collector current (peak value)	$I_{CM}$	max.	50 mA
Total power dissipation up to $T_{amb} = 65\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	250 mW
Junction temperature	$T_j$	max.	175 $^{\circ}\text{C}$
D.C. current gain	$h_{FE}$		20 to 150
$I_C = 2\text{ mA}; V_{CE} = 1\text{ V}$			
Transition frequency	$f_T$	typ.	1,3 GHz
$I_C = 25\text{ mA}; V_{CE} = 5\text{ V}; f = 500\text{ MHz}$			
Noise figure	F	typ.	4,5 dB
$I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; R_S = 50\text{ }\Omega; f = 500\text{ MHz}$			

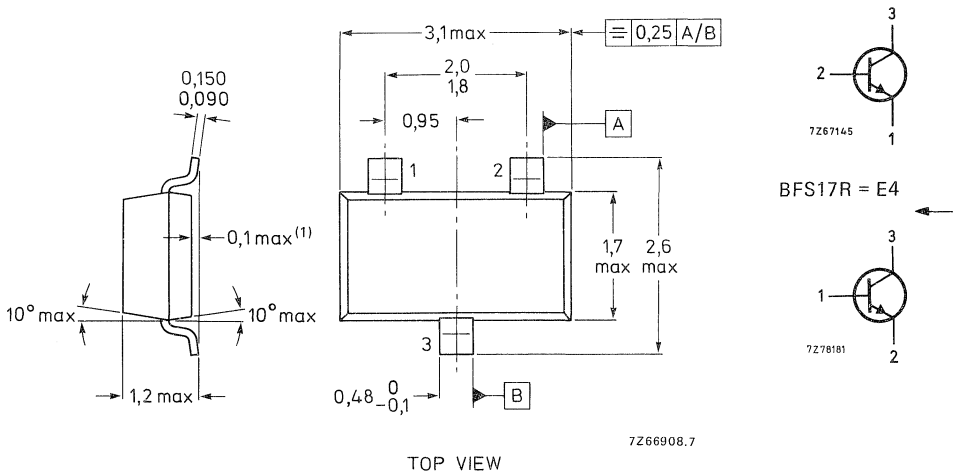
### MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BFS17 = E1



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter; peak value)	$V_{CBOM}$	max.	25 V
Collector-emitter voltage (open base) $I_C = 10 \text{ mA}$	$V_{CEO}$	max.	15 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	2,5 V
Collector current (d.c.)	$I_C$	max.	25 mA
Collector current (peak value)	$I_{CM}$	max.	50 mA
Total power dissipation up to $T_{amb} = 65 \text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	250 mW
Storage temperature	$T_{stg}$		-65 to + 175 $^\circ\text{C}$
Junction temperature	$T_j$	max.	175 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25 \text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 10 \text{ V} \quad I_{CBO} < 10 \text{ nA}$$

$$I_E = 0; V_{CB} = 10 \text{ V}; T_j = 100 \text{ }^\circ\text{C} \quad I_{CBO} < 10 \text{ } \mu\text{A}$$

D.C. current gain

$$I_C = 2 \text{ mA}; V_{CE} = 1 \text{ V} \quad h_{FE} \quad 20 \text{ to } 150$$

$$I_C = 25 \text{ mA}; V_{CE} = 1 \text{ V} \quad h_{FE} > 20$$

Transition frequency

$$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}; f = 500 \text{ MHz} \quad f_T \quad \text{typ.} \quad 1,0 \text{ GHz}$$

$$I_C = 25 \text{ mA}; V_{CE} = 5 \text{ V}; f = 500 \text{ MHz} \quad f_T \quad \text{typ.} \quad 1,3 \text{ GHz}$$

Collector capacitance at  $f = 1 \text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 10 \text{ V} \quad C_C < 1,5 \text{ pF}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

Emitter capacitance at  $f = 1$  MHz

$I_C = I_c = 0; V_{EB} = 0,5$  V

$C_e < 2,0$  pF

Feedback capacitance at  $f = 1$  MHz

$I_C = 1$  mA;  $V_{CE} = 5$  V

$-C_{re}$  typ. 0,65 pF

Noise figure\*

$I_C = 2$  mA;  $V_{CE} = 5$  V;  
 $f = 500$  MHz;  $R_S = 50$   $\Omega$

F typ. 4,5 dB

Intermodulation distortion

$I_C = 10$  mA;  $V_{CE} = 6$  V;  $R_L = 37,5$   $\Omega$ ;  $T_{amb} = 25$   $^{\circ}$ C

$V_o = 100$  mV at  $f_p = 183$  MHz

$V_o = 100$  mV at  $f_q = 200$  MHz

measured at  $f_{(2q-p)} = 217$  MHz

$d_{im}$  typ.  $-45$  dB

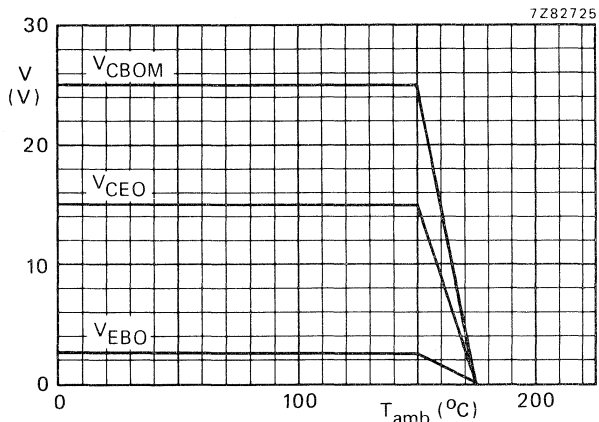


Fig. 2 Voltage derating curve.

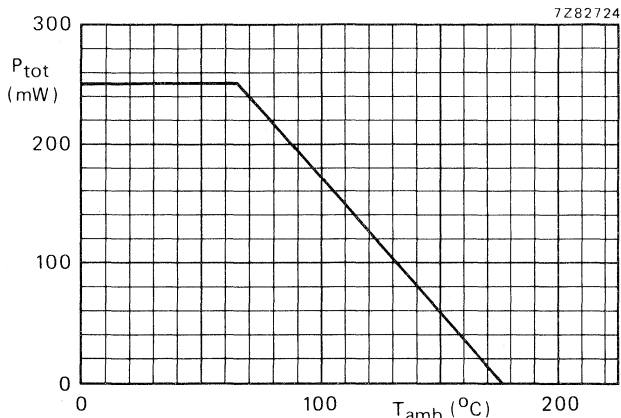
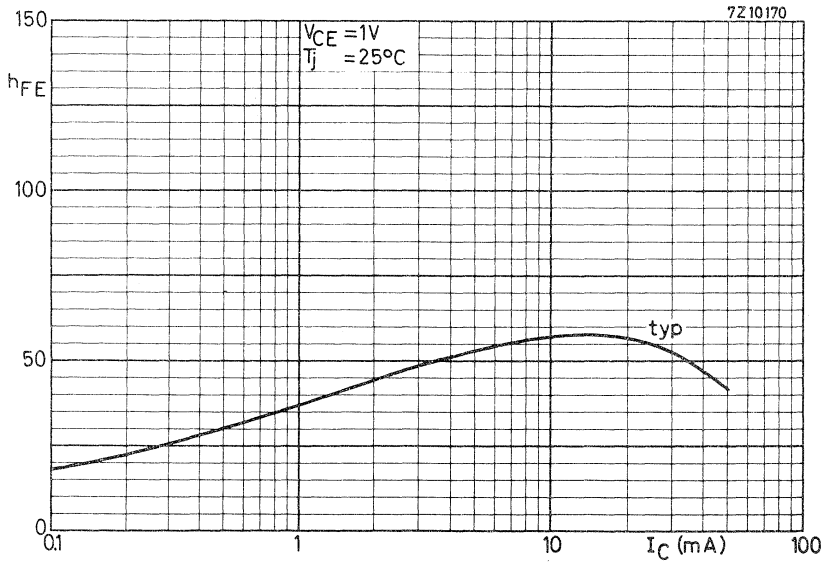
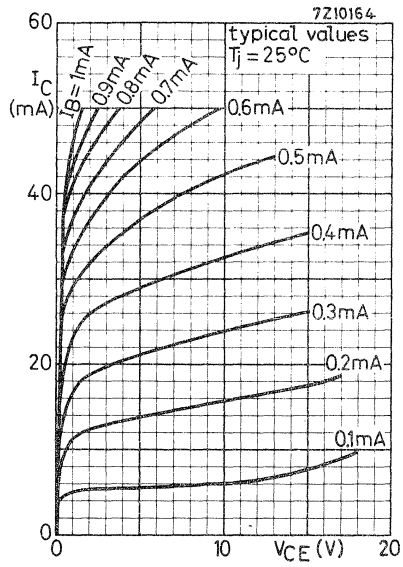
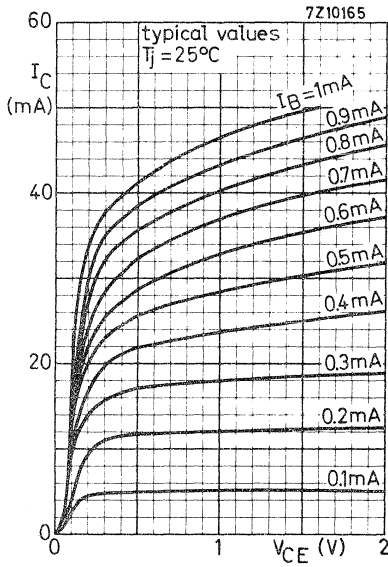
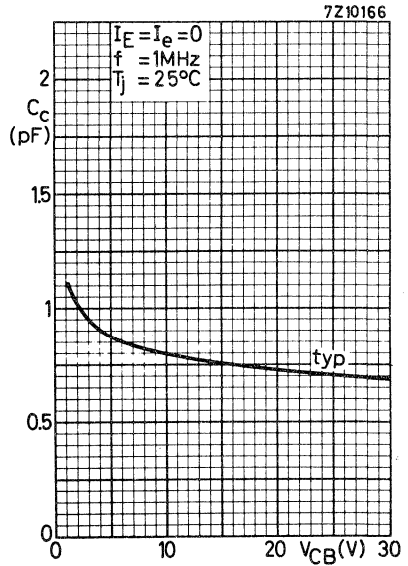
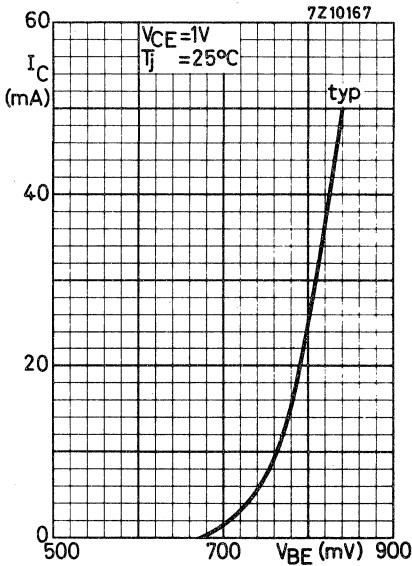
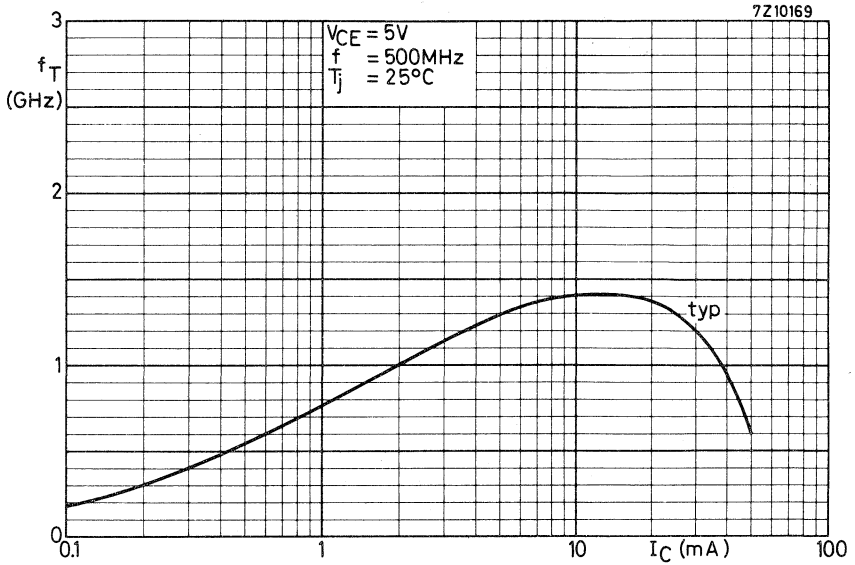
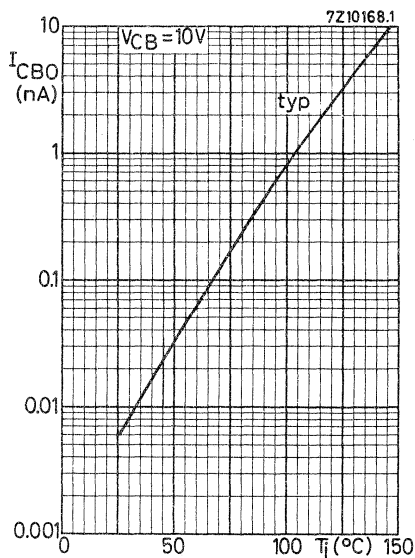
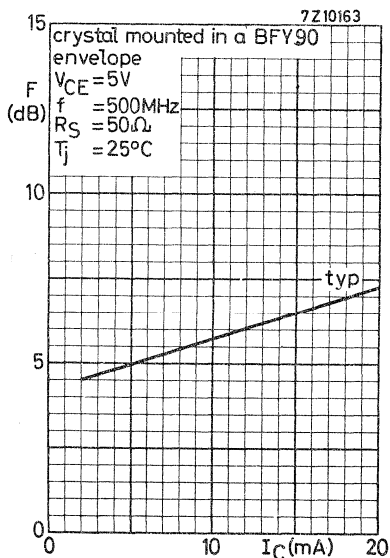
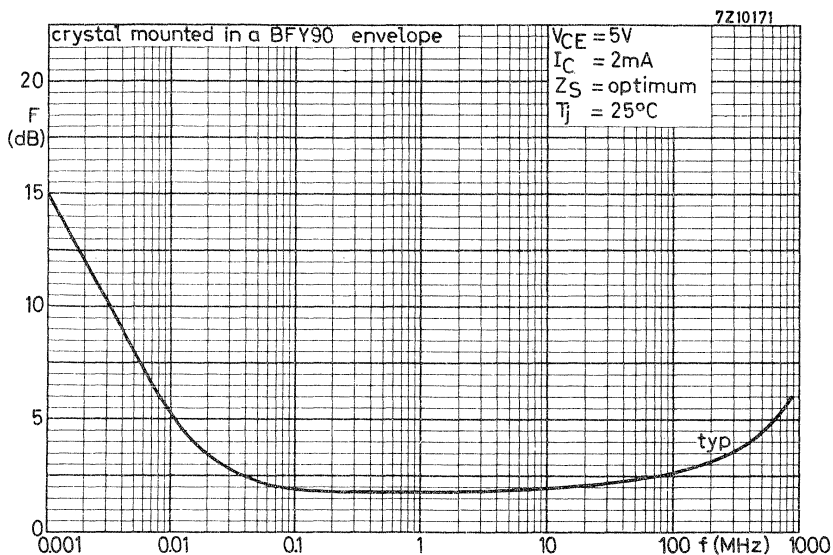


Fig. 3 Power derating curve.

\* Crystal mounted in a BFY90 envelope.









## SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors in a microminiature plastic envelope. They are intended for general purpose and h.f. applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CBO}$	max.	30	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	20	V
Collector current (d.c.)	$I_C$	max.	30	mA
Total power dissipation up to $T_{amb} = 40\text{ }^\circ\text{C}$	$P_{tot}$	max.	250	mW
Junction temperature	$T_j$	max.	150	$^\circ\text{C}$

D.C. current gain	$I_C = 1\text{ mA}; V_{CE} = 10\text{ V}$	BFS18		BFS19	
		BFS18R		BFS19R	
$h_{FE}$		35 to 125		65 to 225	
Transition frequency at $f = 100\text{ MHz}$	$I_C = 1\text{ mA}; V_{CE} = 10\text{ V}$	$f_T$	typ. 200	260	MHz
Noise figure at $f = 100\text{ MHz}$	$I_C = 1\text{ mA}; V_{CE} = 10\text{ V}; G_S = 10\text{ m}\Omega^{-1}$	F	typ. 4		dB

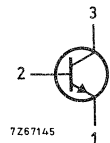
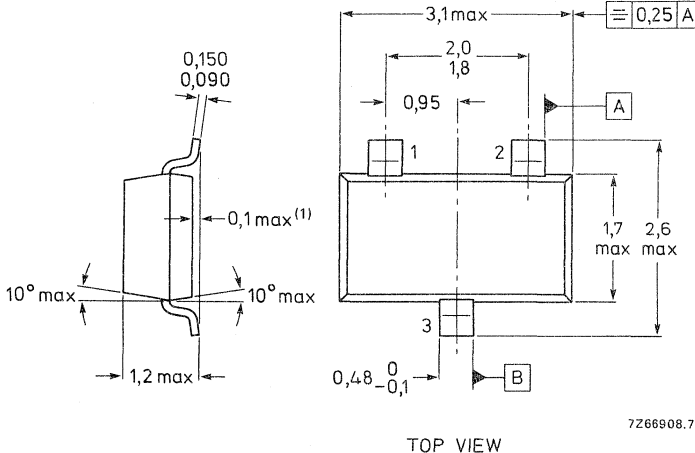
### MECHANICAL DATA

Dimensions in mm

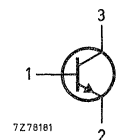
Marking code

Fig. 1 SOT-23.

BFS18 = F1  
BFS19 = F2



BFS18R = F4  
BFS19R = F5



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations.*

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) See Fig. 2	$V_{CBO}$	max.	30	V
Collector-emitter voltage (open base) See Fig. 2	$V_{CEO}$	max.	20	V
$I_C = 2$ mA	$V_{EBO}$	max.	5	V
Emitter-base voltage (open collector) See Fig. 2	$I_C$	max. (d.c.)	30	mA
Collector current (d.c.)	$I_{CM}$	max.	30	mA
Collector current (peak value)	$P_{tot}$	max.	250	mW
Total power dissipation up to $T_{amb} = 40$ °C**	$T_{stg}$		-65 to + 150	°C
Storage temperature	$T_j$	max.	150	°C
Junction temperature				

**THERMAL CHARACTERISTICS\***

$$T_j = P (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60	K/W
From tab to soldering points	$R_{th\ t-s}$	=	280	K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90	K/W

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 20$ V	$I_{CBO}$	<	100	nA
$I_E = 0; V_{CB} = 20$ V; $T_j = 100$ °C	$I_{CBO}$	<	10	μA

Base-emitter voltage

$I_C = 1$ mA; $V_{CE} = 10$ V	$V_{BE}$		0,65 to 0,74	V
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D.C. current gain

$I_C = 1$ mA; $V_{CE} = 10$ V	$h_{FE}$		BFS18 BFS18R	BFS19 BFS19R	
			35 to 125	65 to 225	

Transition frequency at  $f = 100$  MHz

$I_C = 1$ mA; $V_{CE} = 10$ V	$f_T$	typ.	200	260	MHz
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Collector capacitance at  $f = 1$  MHz

$I_E = I_e = 0; V_{CB} = 10$ V	$C_c$	typ.	1	pF
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Feedback capacitance at  $f = 1$  MHz

$I_C = 1$ mA; $V_{CE} = 10$ V	$-C_{re}$	typ.	0,85	pF
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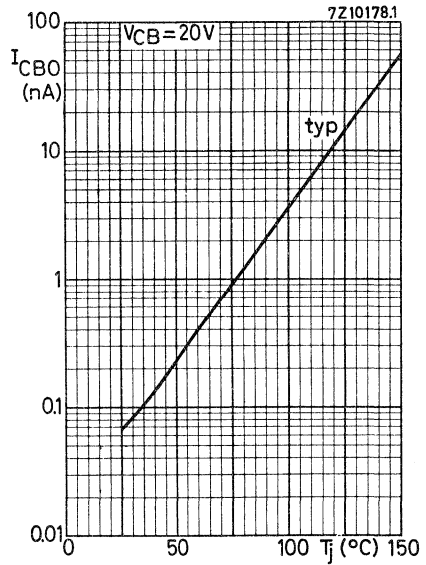
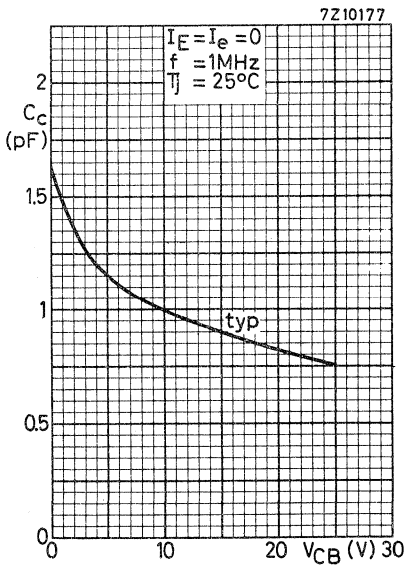
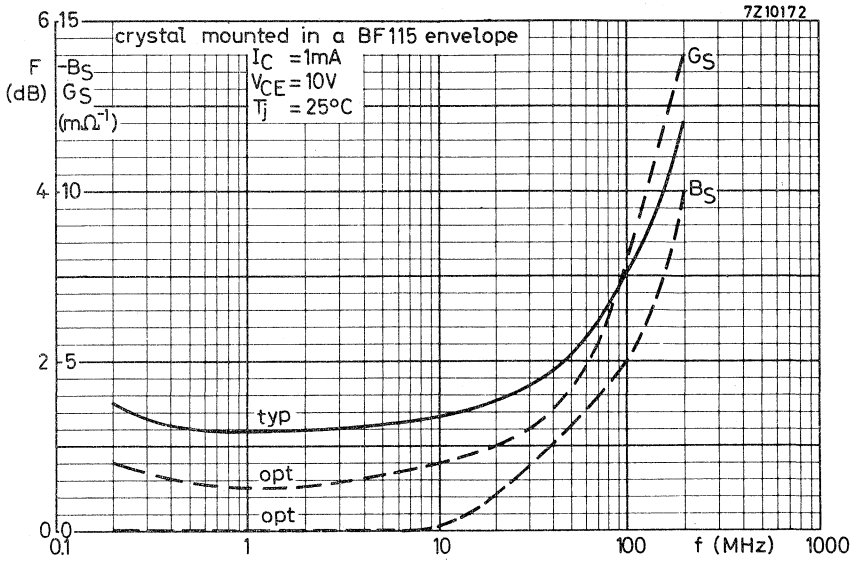
Noise figure  $\Delta$

$I_C = 1$ mA; $V_{CE} = 10$ V; $G_S = 10$ mΩ <sup>-1</sup> ; $f = 100$ MHz	$F$	typ.	4	dB
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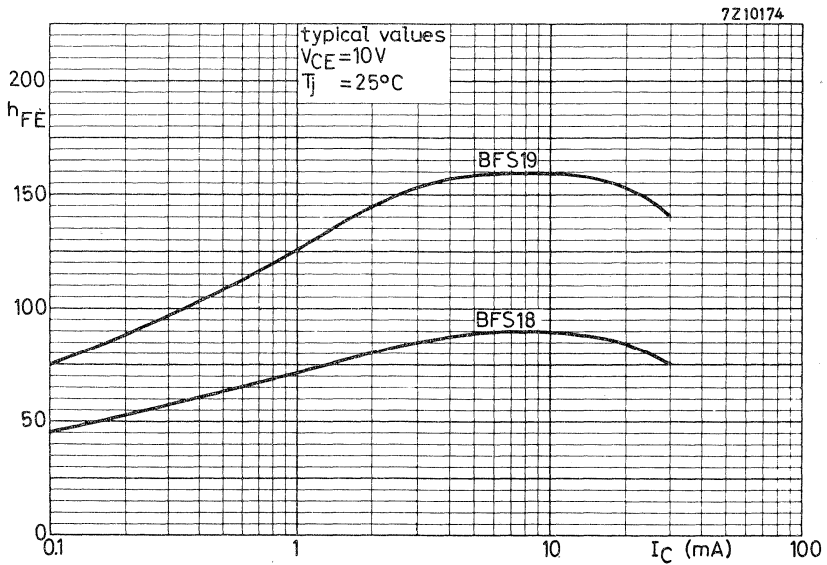
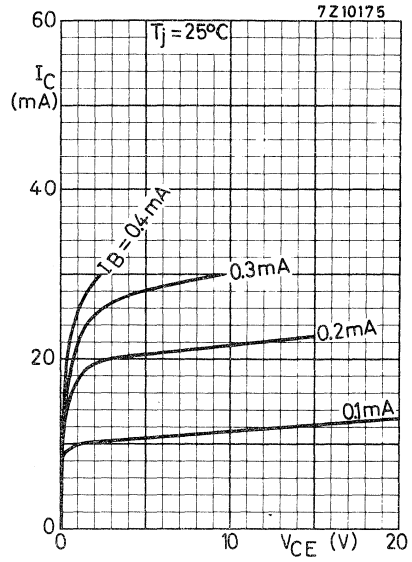
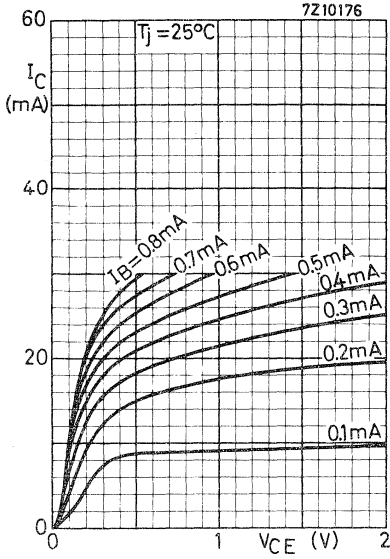
\* See *Thermal characteristics*.

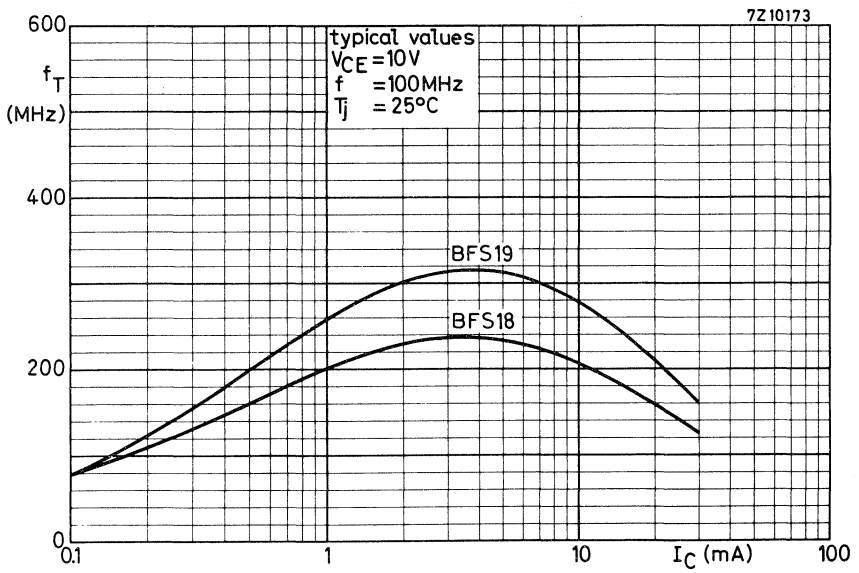
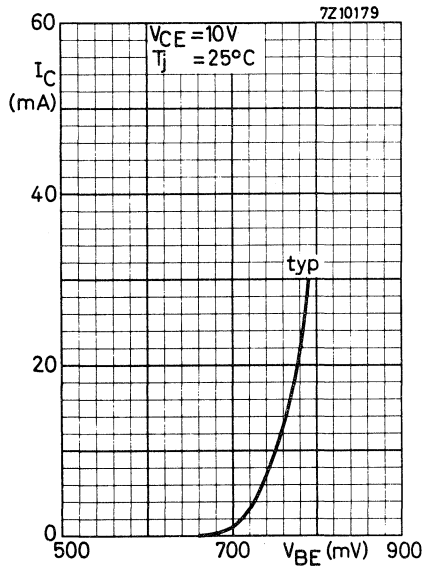
\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

$\Delta$  Crystal mounted in a BF115 envelope.



Typical behaviour of collector current versus collector-emitter voltage







## SILICON PLANAR EPITAXIAL TRANSISTORS

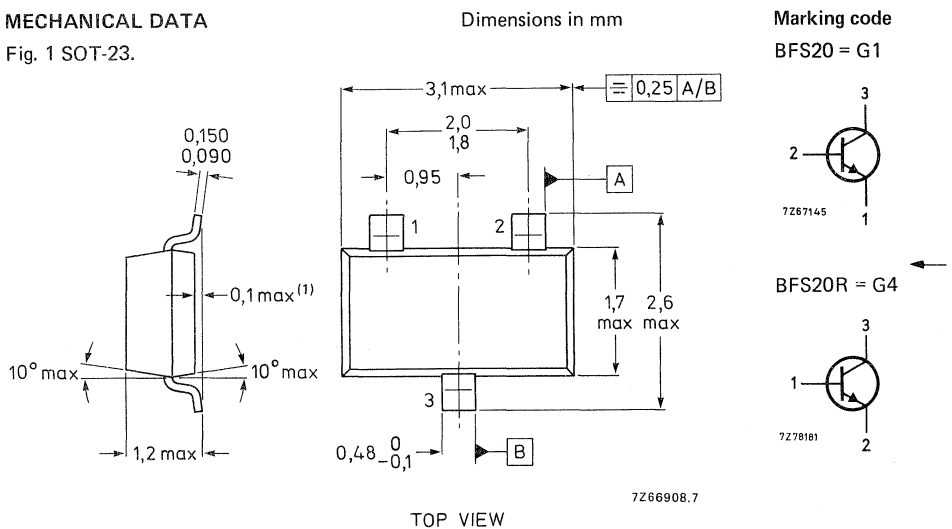
N-P-N transistor in a microminiature plastic envelope. It has a very low feedback capacitance and is intended for i.f. and v.h.f. applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CBO}$	max.	30 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	20 V
Collector current (d.c.)	$I_C$	max.	25 mA
Total power dissipation up to $T_{amb} = 40\text{ }^\circ\text{C}$	$P_{tot}$	max.	250 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
D.C. current gain	$h_{FE}$	>	40
$I_C = 7\text{ mA}; V_{CE} = 10\text{ V}$			
Transition frequency at $f = 100\text{ MHz}$	$f_T$	typ.	450 MHz
$I_C = 5\text{ mA}; V_{CE} = 5\text{ V}$			
Feedback capacitance at $f = 1\text{ MHz}$	$C_{re}$	typ.	350 fF
$I_C = 1\text{ mA}; V_{CE} = 10\text{ V}$			

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 2	$V_{CBO}$	max.	30 V
Collector-emitter voltage (open base) see Fig. 2 $I_C = 2 \text{ mA}$	$V_{CEO}$	max.	20 V
Emitter-base voltage (open collector) see Fig. 2	$V_{EBO}$	max.	4 V
Collector current (d.c.)	$I_C$	max.	25 mA
Collector current (peak value)	$I_{CM}$	max.	25 mA
Total power dissipation up to $T_{amb} = 40 \text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	250 mW
Storage temperature	$T_{stg}$		-65 to +150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL CHARACTERISTICS \***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient **	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25 \text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 20 \text{ V}$$

$$I_{CBO} < 100 \text{ nA}$$

$$I_E = 0; V_{CB} = 20 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$$

$$I_{CBO} < 10 \text{ } \mu\text{A}$$

Base-emitter voltage

$$I_C = 7 \text{ mA}; V_{CE} = 10 \text{ V}$$

$$V_{BE} \begin{matrix} \text{typ.} & 740 \text{ mV} \\ < & 900 \text{ mV} \end{matrix}$$

D.C. current gain

$$I_C = 7 \text{ mA}; V_{CE} = 10 \text{ V}$$

$$h_{FE} \begin{matrix} > & 40 \\ \text{typ.} & 85 \end{matrix}$$

Transition frequency at  $f = 100 \text{ MHz}$

$$I_C = 5 \text{ mA}; V_{CE} = 10 \text{ V}$$

$$f_T \begin{matrix} > & 275 \text{ MHz} \\ \text{typ.} & 450 \text{ MHz} \end{matrix}$$

Collector capacitance at  $f = 1 \text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 10 \text{ V}$$

$$C_c \text{ typ. } 0,8 \text{ pF}$$

Feedback capacitance at  $f = 1 \text{ MHz}$

$$I_C = 1 \text{ mA}; V_{CE} = 10 \text{ V}$$

$$-C_{re} \text{ typ. } 350 \text{ fF}$$

\* See *Thermal characteristics.*

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.



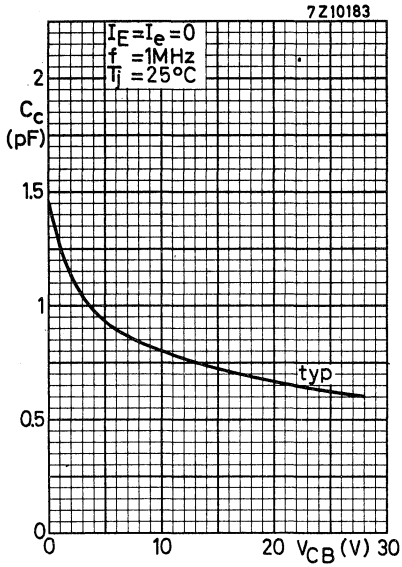


Fig. 2 Voltage derating curves.

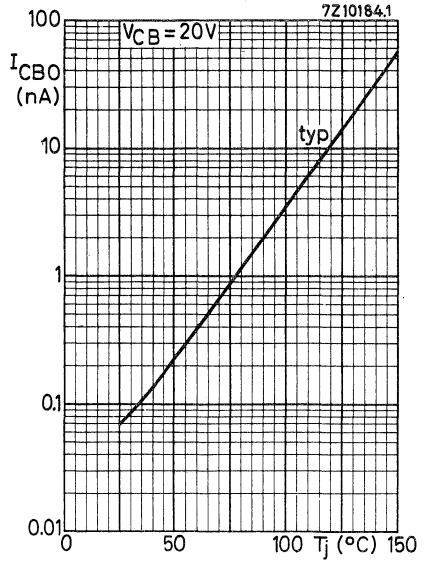
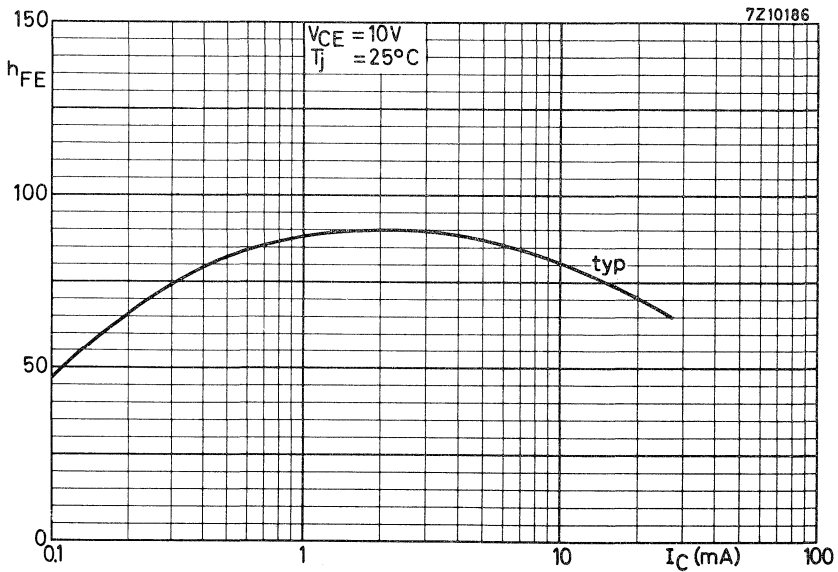
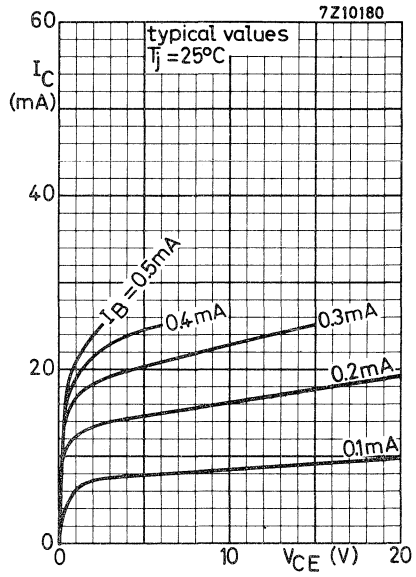
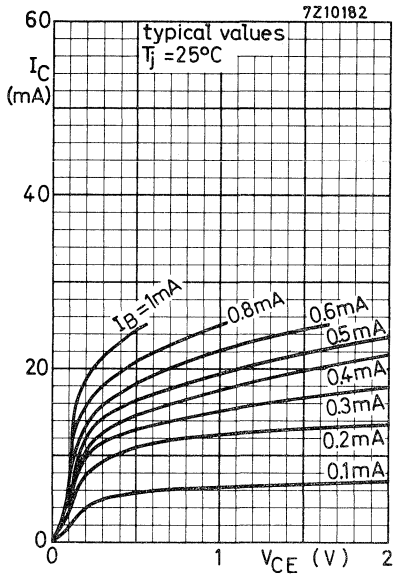
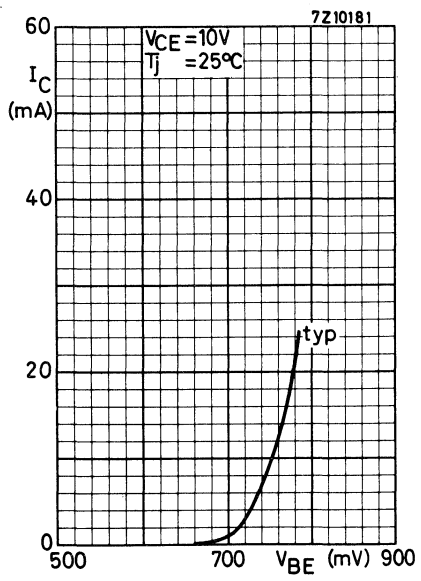
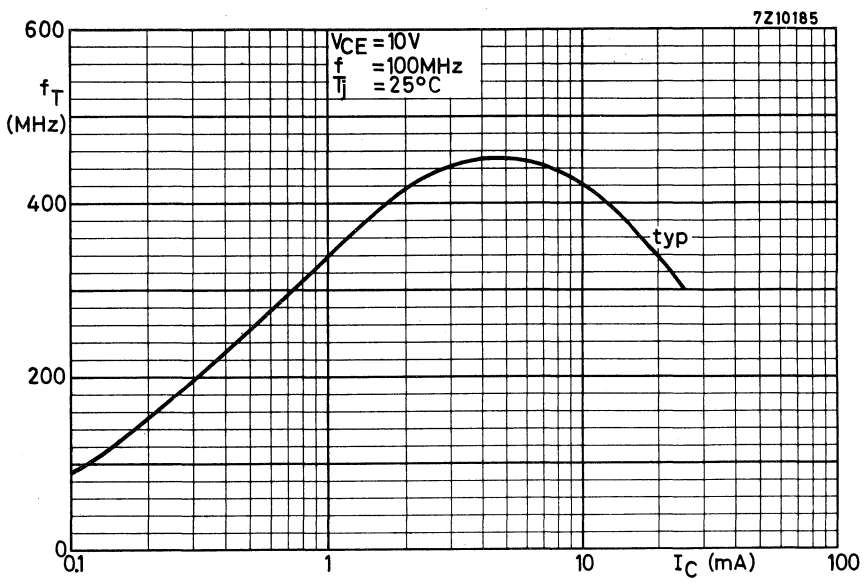


Fig. 3 Power derating curve.







## SILICON PLANAR EPITAXIAL TRANSISTORS

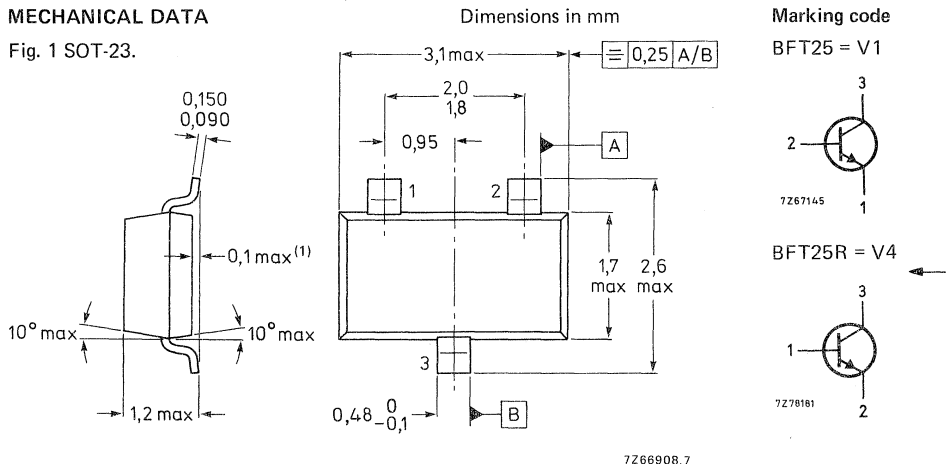
N-P-N transistor in a microminiature plastic envelope, primarily intended for use in u.h.f. low power amplifiers in thick and thin-film circuits, such as in pocket phones, paging systems, etc. The transistor features low current consumption ( $100 \mu\text{A} - 1 \text{ mA}$ ); thanks to its high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CBO}$	max.	8 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	5 V
Collector current (d.c.)	$I_C$	max.	6,5 mA
Total power dissipation up to $T_{amb} = 125 \text{ }^\circ\text{C}$	$P_{tot}$	max.	50 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Transition frequency at $f = 500 \text{ MHz}$ $I_C = 1 \text{ mA}$ ; $V_{CE} = 1 \text{ V}$	$f_T$	typ.	2,3 GHz
Feedback capacitance at $f = 1 \text{ MHz}$ $I_C = 1 \text{ mA}$ ; $V_{CE} = 1 \text{ V}$ ; $T_{amb} = 25 \text{ }^\circ\text{C}$	$C_{re}$	<	0,45 pF
Noise figure at optimum source impedance $I_C = 1 \text{ mA}$ ; $V_{CE} = 1 \text{ V}$ ; $f = 500 \text{ MHz}$ ; $T_{amb} = 25 \text{ }^\circ\text{C}$	F	typ.	3,8 dB
Max. unilateral power gain $I_C = 1 \text{ mA}$ ; $V_{CE} = 1 \text{ V}$ ; $f = 500 \text{ MHz}$ ; $T_{amb} = 25 \text{ }^\circ\text{C}$	GUM	typ.	18 dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 - 0,2 mm version. TOP VIEW

See also *Soldering recommendations*.

# BFT25 BFT25R

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	8 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	5 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	2 V
Collector current (d.c.)	$I_C$	max.	6,5 mA
Collector current (peak value; $f > 1$ MHz)	$I_{CM}$	max.	10 mA
Total power dissipation up to $T_{amb} = 125$ °C**	$P_{tot}$	max.	50 mW
Storage temperature	$T_{stg}$		-65 to + 150 °C
Junction temperature	$T_j$	max.	150 °C

## THERMAL CHARACTERISTICS\*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

### Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

$T_j = 25$  °C unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 5\text{ V}$$

$$I_{CBO} < 50\text{ nA}$$

D.C. current gain $\Delta$

$$I_C = 10\ \mu\text{A}; V_{CE} = 1\text{ V}$$

$$h_{FE} < 20$$

$$\text{typ. } 30$$

$$I_C = 1\text{ mA}; V_{CE} = 1\text{ V}$$

$$h_{FE} < 20$$

$$\text{typ. } 40$$

Saturation voltages

$$I_C = 10\ \mu\text{A}; I_B = 1\ \mu\text{A}$$

$$V_{CEsat} < 200\text{ mV}$$

$$V_{BEsat} < 750\text{ mV}$$

$$I_C = 1\text{ mA}; I_B = 0,1\text{ mA}$$

$$V_{CEsat} < 175\text{ mV}$$

$$V_{BEsat} < 900\text{ mV}$$

Transition frequency at  $f = 500$  MHz $\Delta$

$$I_C = 1\text{ mA}; V_{CE} = 1\text{ V}$$

$$f_T > 1,2\text{ GHz}$$

$$\text{typ. } 2,3\text{ GHz}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

$\Delta$  Measured under pulse conditions.

Collector capacitance at  $f = 1 \text{ MHz}$

$$I_E = I_c = 0; V_{CB} = 0,5 \text{ V}$$

$$C_c < 0,6 \text{ pF}$$

Emitter capacitance at  $f = 1 \text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0$$

$$C_e < 0,5 \text{ pF}$$

Feedback capacitance at  $f = 1 \text{ MHz}$

$$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$C_{re} < 0,45 \text{ pF}$$

Noise figure at optimum source impedance

$$I_C = 0,1 \text{ mA}; V_{CE} = 1 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$F \text{ typ. } 5,5 \text{ dB}$$

$$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$F \text{ typ. } 3,8 \text{ dB}$$

Maximum unilateral power gain ( $s_{re}$  assumed to be zero)

$$G_{UM} \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; f = 200 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$G_{UM} \text{ typ. } 25 \text{ dB}$$

$$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$G_{UM} \text{ typ. } 18 \text{ dB}$$

$$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; f = 800 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$G_{UM} \text{ typ. } 12 \text{ dB}$$

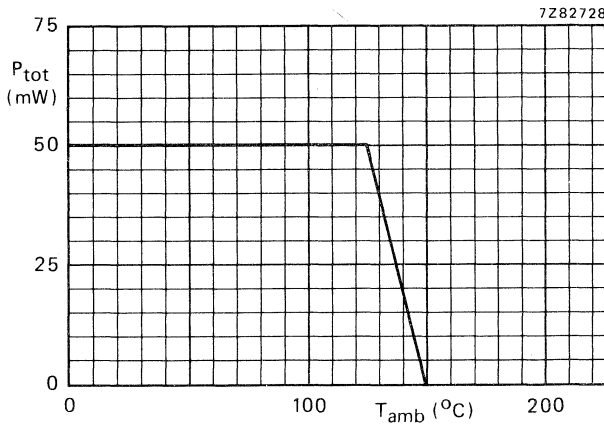
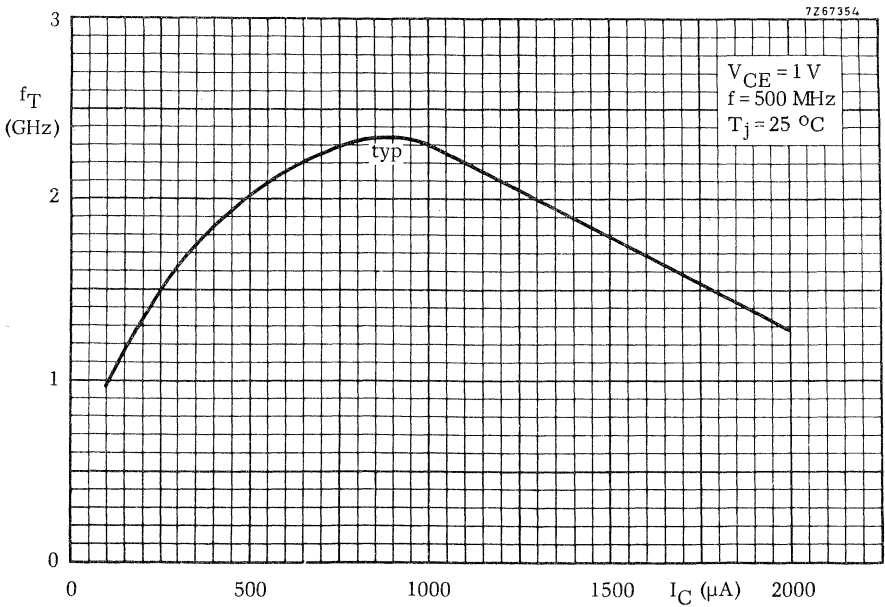
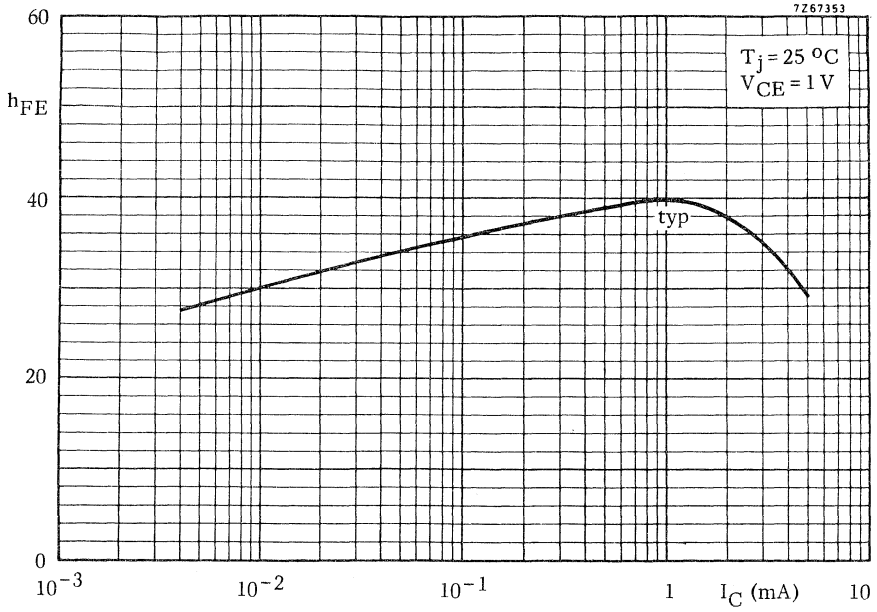
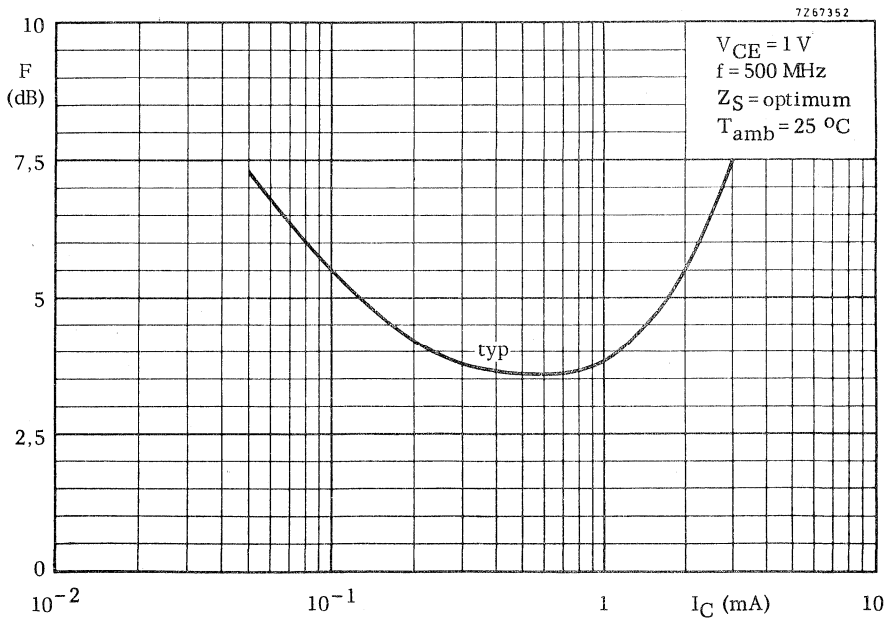
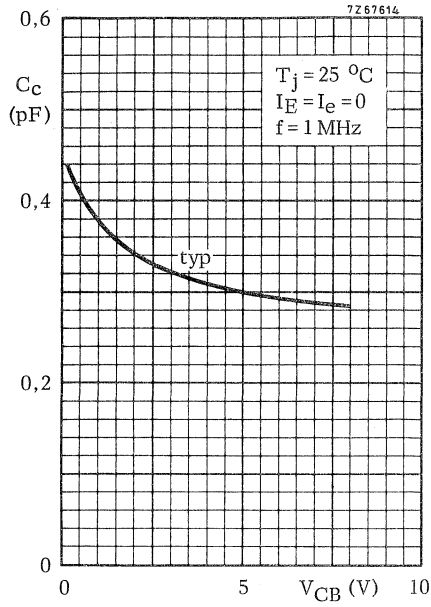


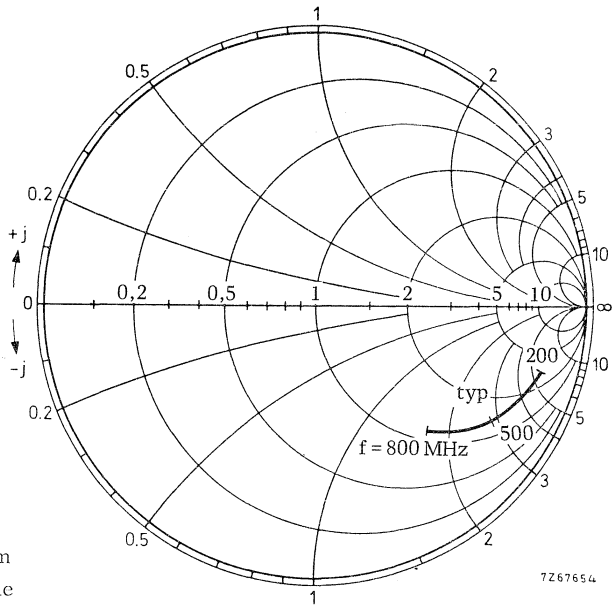
Fig. 2 Power derating curve.







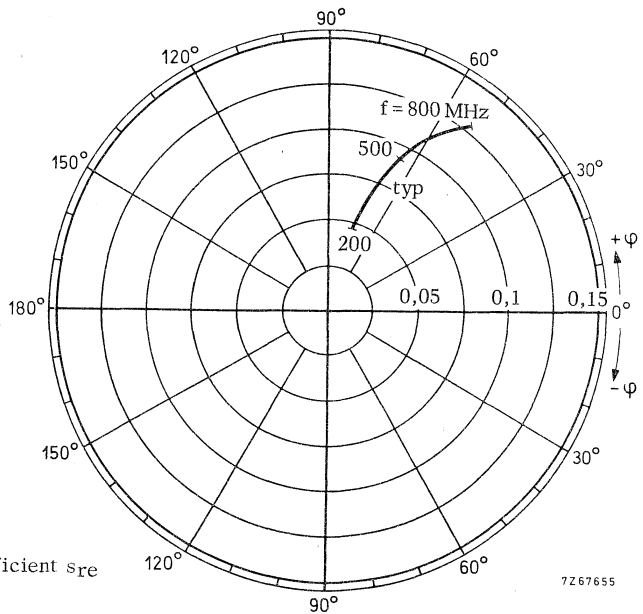
$V_{CE} = 1\text{ V}$   
 $I_C = 1\text{ mA}$   
 $T_{amb} = 25\text{ }^\circ\text{C}$



7267654

Input impedance derived from  
 input reflection coefficient  $s_{ie}$   
 coordinates in ohm x 50

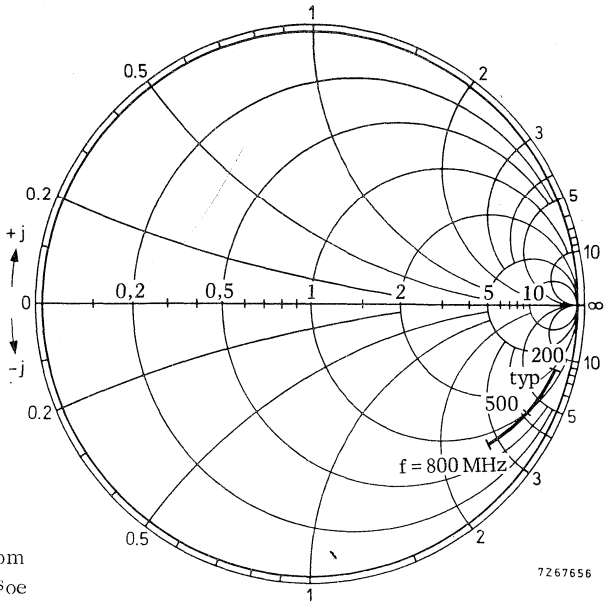
$V_{CE} = 1\text{ V}$   
 $I_C = 1\text{ mA}$   
 $T_{amb} = 25\text{ }^\circ\text{C}$



7267655

Reverse transmission coefficient  $s_{re}$

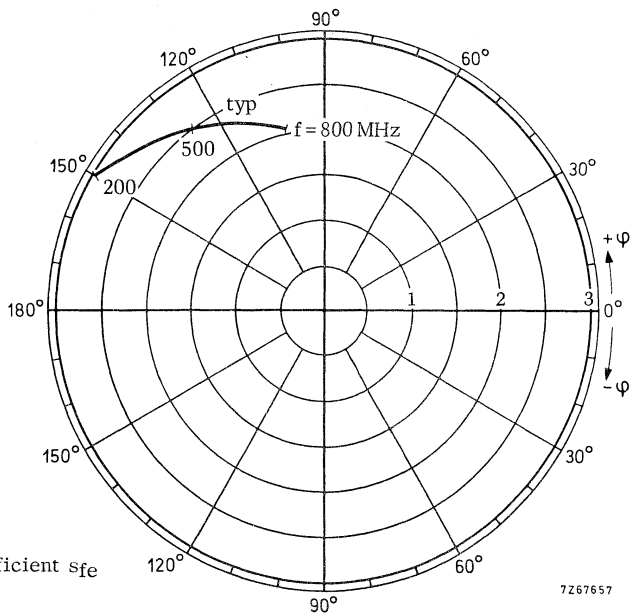
$V_{CE} = 1\text{ V}$   
 $I_C = 1\text{ mA}$   
 $T_{amb} = 25\text{ }^\circ\text{C}$



7267656

Output impedance derived from output reflection coefficient  $s_{oe}$  coordinates in ohm x 50

$V_{CE} = 1\text{ V}$   
 $I_C = 1\text{ mA}$   
 $T_{amb} = 25\text{ }^\circ\text{C}$



7267657

Forward transmission coefficient  $s_{fe}$



## N-CHANNEL SILICON FET

N-channel silicon epitaxial planar junction field-effect transistor in a microminiature plastic envelope. The transistor is intended for low level general purpose amplifiers in thick and thin-film circuits.

## QUICK REFERENCE DATA

Drain-source voltage	$\pm V_{DS}$	max.	25 V
Gate-source voltage (open drain)	$-V_{GSO}$	max.	25 V
Total power dissipation up to $T_{amb} = 65\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	250 mW
Drain current	$I_{DSS}$	>	0,2 mA
$V_{DS} = 10\text{ V}; V_{GS} = 0$		<	1,5 mA
Transfer admittance (common source)	$ y_{fs} $	>	0,5 mA/V
$I_D = 0,2\text{ mA}; V_{DS} = 10\text{ V}; f = 1\text{ kHz}$			
Equivalent noise voltage	$V_n$	<	0,5 $\mu\text{V}$
$V_{DS} = 10\text{ V}; I_D = 200\text{ }\mu\text{A}; B = 0,6\text{ to }100\text{ Hz}$			

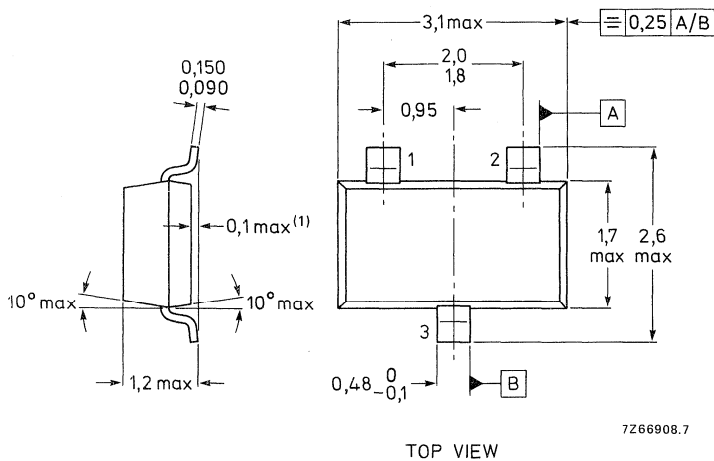
## MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BFT46 = M3



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	$\pm V_{DS}$	max.	25 V
Drain-gate voltage (open source)	$V_{DGO}$	max.	25 V
Gate-source voltage (open drain)	$-V_{GSO}$	max.	25 V
Drain current	$I_D$	max.	10 mA
Gate current	$I_G$	max.	5 mA
Total power dissipation up to $T_{amb} = 65\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	250 mW
Storage temperature	$T_{stg}$		-65 to +175 °C
Junction temperature	$T_j$	max.	175 °C

**THERMAL CHARACTERISTICS\***

$$R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a} = \frac{T_j - T_{amb}}{P}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Gate cut-off current $-V_{GS} = 10\text{ V}; V_{DS} = 0$	$-I_{GSS}$	<	0,2 nA
Drain current ** $V_{DS} = 10\text{ V}; V_{GS} = 0$	$I_{DSS}$	>	0,2 mA
		<	1,5 mA
Gate-source voltage $I_D = 50\text{ }\mu\text{A}; V_{DS} = 10\text{ V}$	$-V_{GS}$	>	0,1 V
		<	1,0 V
Gate-source cut-off voltage $I_D = 0,5\text{ nA}; V_{DS} = 10\text{ V}$	$-V_{(P)GS}$	<	1,2 V
Y parameters at $f = 1\text{ kHz};$ $V_{DS} = 10\text{ V}; V_{GS} = 0; T_{amb} = 25\text{ }^\circ\text{C}$			
Transfer admittance	$ y_{fs} $	>	1,0 mA/V
Output admittance	$ y_{os} $	<	10 $\mu\text{A/V}$
$V_{DS} = 10\text{ V}; I_D = 200\text{ }\mu\text{A};$			
Transfer admittance	$ y_{fs} $	>	0,5 mA/V
Output admittance	$ y_{os} $	<	5 $\mu\text{A/V}$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

Input capacitance at  $f = 1 \text{ MHz}$ ;

$V_{DS} = 10 \text{ V}$ ;  $V_{GS} = 0$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$

$C_{is} < 5 \text{ pF}$

Feedback capacitance at  $f = 1 \text{ MHz}$ ;

$V_{DS} = 10 \text{ V}$ ;  $V_{GS} = 0$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$

$C_{rs} < 1,5 \text{ pF}$

Equivalent noise voltage

$V_{DS} = 10 \text{ V}$ ;  $I_D = 200 \text{ } \mu\text{A}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$

$B = 0,6$  to  $100 \text{ Hz}$

$V_n < 0,5 \text{ } \mu\text{V}$

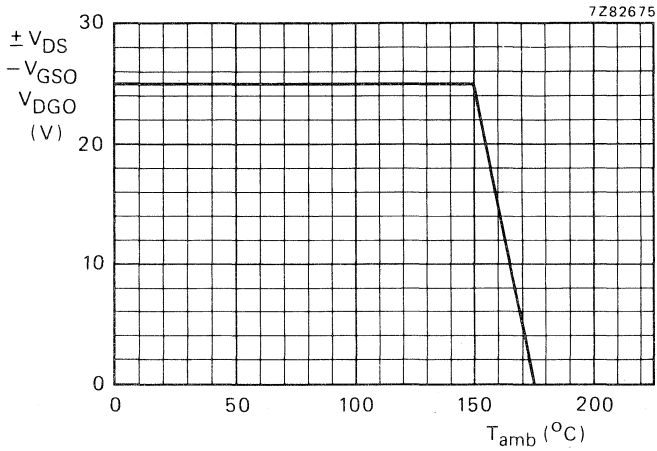


Fig. 2 Voltage derating curve.

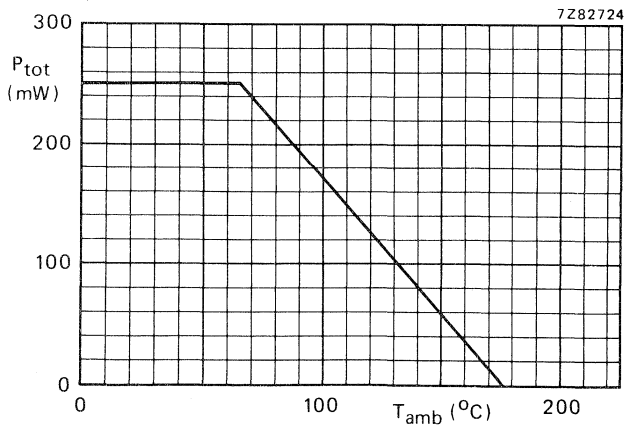
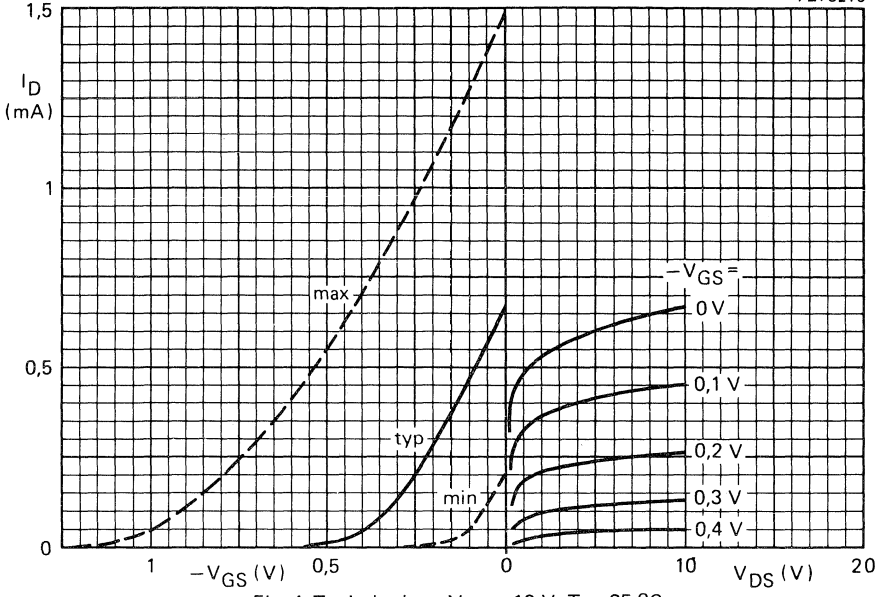
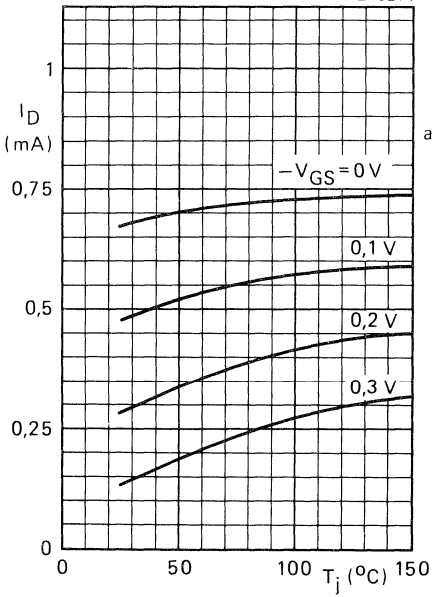


Fig. 3 Power derating curve.

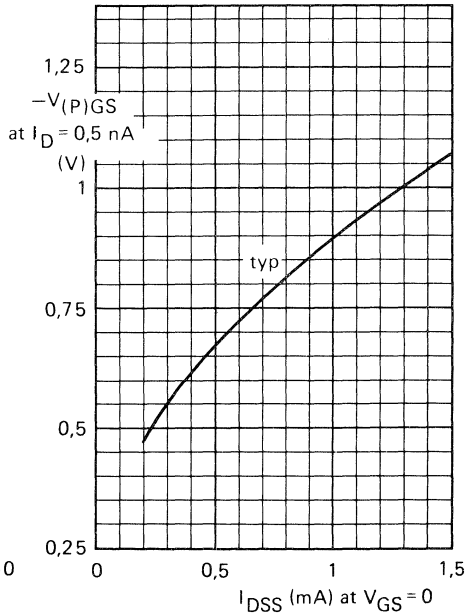
7Z78216



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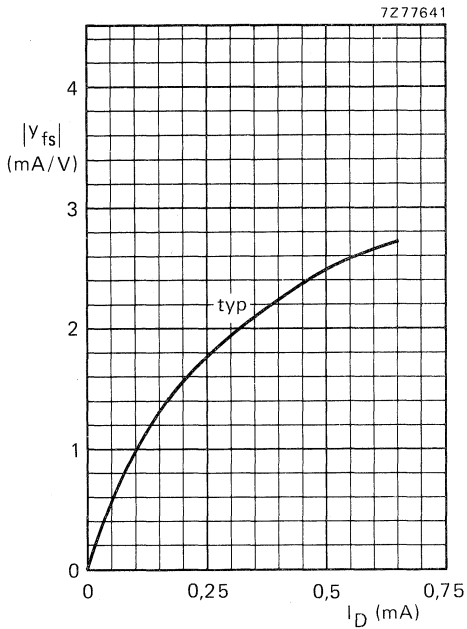


Fig. 7.

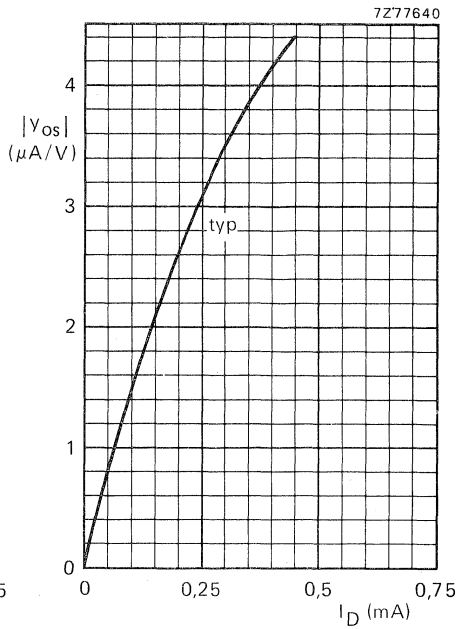


Fig. 8.

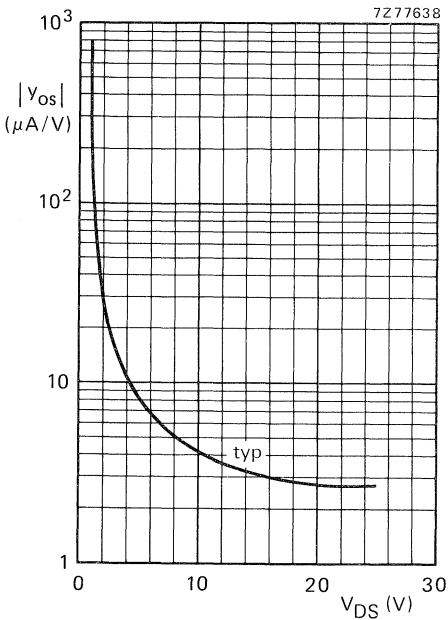


Fig. 9.

Fig. 7  $|Y_{fs}|$  versus  $I_D$ .  
 $V_{DS} = 10$  V;  $f = 1$  kHz;  $T_{amb} = 25$  °C.

Fig. 8  $|Y_{os}|$  versus  $I_D$ .  
 $V_{DS} = 10$  V;  $f = 1$  kHz;  $T_{amb} = 25$  °C.

Fig. 9  $|Y_{os}|$  versus  $V_{DS}$ .  
 $I_D = 0,4$  mA;  $f = 1$  kHz;  $T_{amb} = 25$  °C.

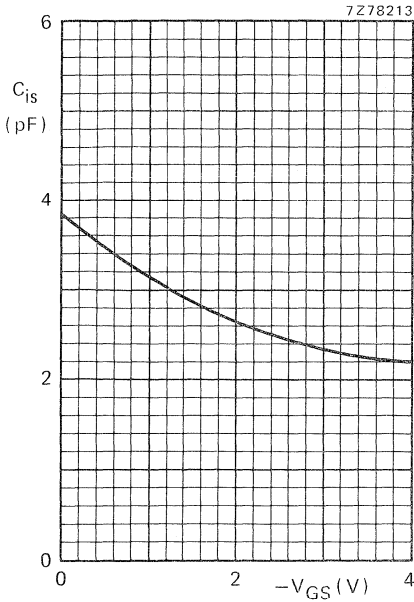


Fig. 10.

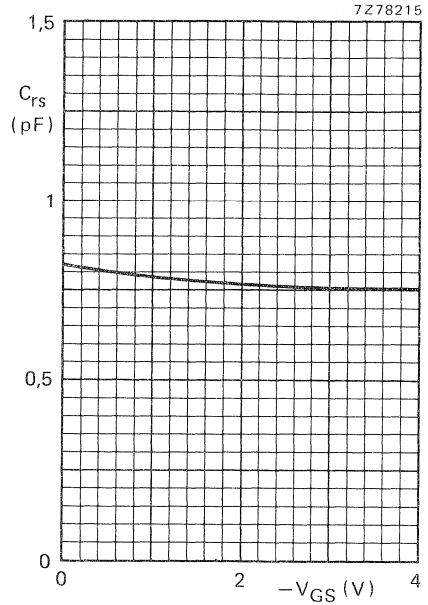


Fig. 11.

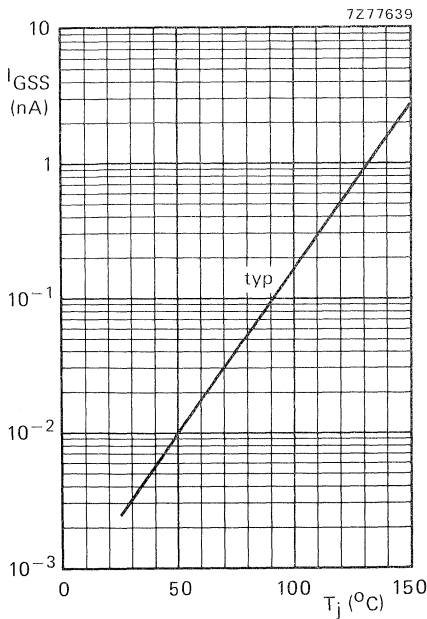


Fig. 12.

Fig.10 Typical values.  
 $V_{DS} = 10$  V,  $T_{amb} = 25$  °C.

Fig.11 Typical values.  
 $V_{DS} = 10$  V,  $T_{amb} = 25$  °C.

Fig.12  $I_{GSS}$  versus  $T_j$ .  
 $-V_{GSS} = 10$ V;  $V_{DS} = 0$ .

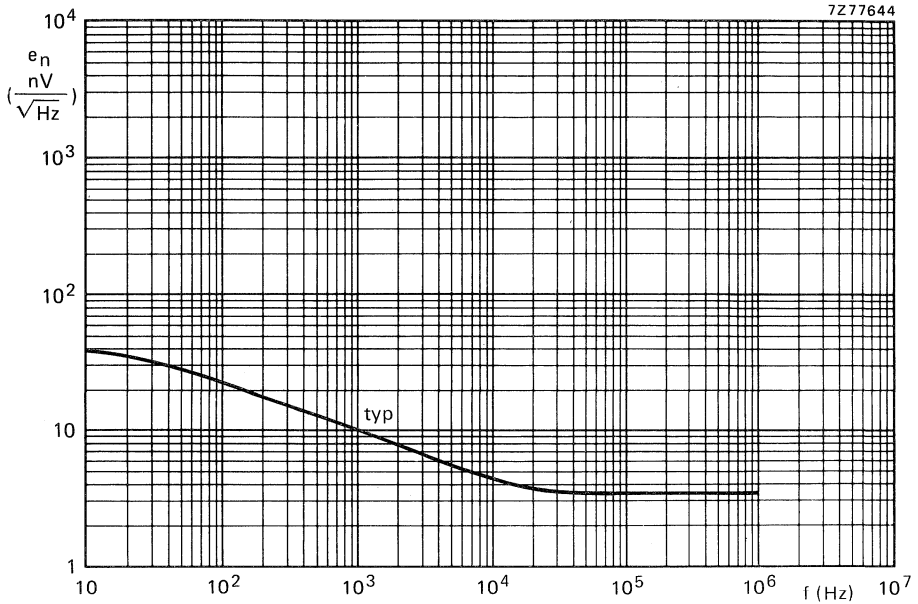


Fig. 13  $V_{DS} = 10 V$ ;  $I_D = 0,2 mA$ ;  $T_{amb} = 25 ^\circ C$ .

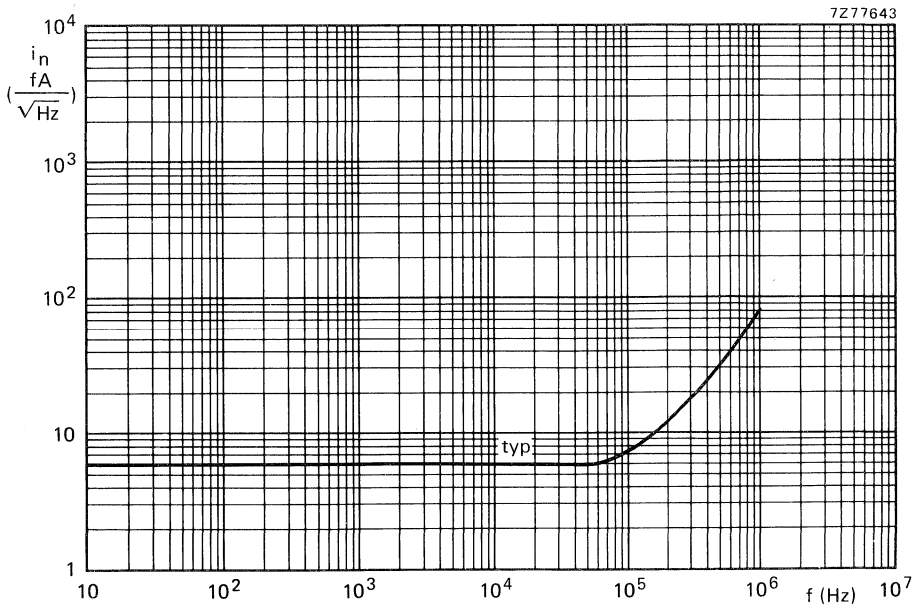


Fig. 14  $V_{DS} = 10 V$ ;  $I_D = 0,2 mA$ ;  $T_{amb} = 25 ^\circ C$ .



## SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistor in a microminiature plastic envelope. It is primarily intended for use in u.h.f. and microwave amplifiers in thick and thin-film circuits, such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analysers, etc.

The transistor features low intermodulation distortion and high power gain; thanks to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

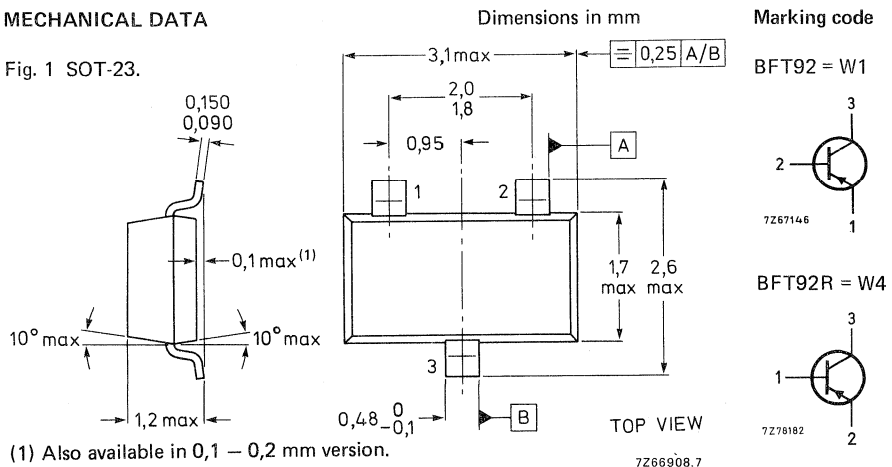
This type is complementary to BFR92.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$-V_{CBO}$ max.	20 V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	15 V
Collector current (d.c.)	$-I_C$ max.	25 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$	$P_{tot}$ max.	200 mW
Junction temperature	$T_j$ max.	$150\text{ }^\circ\text{C}$
Transition frequency at $f = 500\text{ MHz}$ $-I_C = 14\text{ mA}; -V_{CE} = 10\text{ V}$	$f_T$ typ.	5 GHz
Feedback capacitance at $f = 1\text{ MHz}$ $-I_C = 2\text{ mA}; -V_{CE} = 10\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$	$C_{re}$ typ.	0,7 pF
Noise figure at optimum source impedance $-I_C = 2\text{ mA}; -V_{CE} = 10\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$	F typ.	2,7 dB
Max. unilateral power gain $-I_C = 14\text{ mA}; -V_{CE} = 10\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$	$G_{UM}$ typ.	18 dB
Intermodulation distortion at $T_{amb} = 25\text{ }^\circ\text{C}$ $-I_C = 14\text{ mA}; -V_{CE} = 10\text{ V}; R_L = 75\text{ }\Omega; V_o = 150\text{ mV}$ $f(p + q - r) = 493,25\text{ MHz}$	$d_{im}$ typ.	-60 dB

### MECHANICAL DATA

Fig. 1 SOT-23.



**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	20 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	15 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	2,0 V
Collector current (d.c.)	$-I_C$	max.	25 mA
Collector current (peak value; $f > 1$ MHz)	$-I_{CM}$	max.	35 mA
Total power dissipation up to $T_{amb} = 60^\circ\text{C}^{**}$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$	-65 to +150	$^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL CHARACTERISTICS \***

$$T_j = P (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient **	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 10\text{ V}$$

$$-I_{CBO} < 50\text{ nA}$$

D.C. current gain \*

$$-I_C = 14\text{ mA}; -V_{CE} = 10\text{ V}$$

$$h_{FE} > \begin{matrix} 20 \\ \text{typ. } 50 \end{matrix}$$

Transition frequency at  $f = 500\text{ MHz}^\Delta$

$$-I_C = 14\text{ mA}; -V_{CE} = 10\text{ V}$$

$$f_T \text{ typ. } 5\text{ GHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_e = 0; -V_{CB} = 10\text{ V}$$

$$C_c \text{ typ. } 0,75\text{ pF}$$

Emitter capacitance at  $f = 1\text{ MHz}$

$$I_C = I_c = 0; -V_{EB} = 0,5\text{ V}$$

$$C_e \text{ typ. } 0,8\text{ pF}$$

$\Delta$  Measured under pulse conditions.

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

**CHARACTERISTICS** (continued) $T_{amb} = 25\text{ }^{\circ}\text{C}$ Feedback capacitance at  $f = 1\text{ MHz}$  $-I_C = 2\text{ mA}; -V_{CE} = 10\text{ V}$  $C_{re}$  typ. 0,7 pF

Noise figure at optimum source impedance \*

 $-I_C = 2\text{ mA}; -V_{CE} = 10\text{ V}; f = 500\text{ MHz}$ 

F typ. 2,7 dB

Max. unilateral power gain ( $s_{re}$  assumed to be zero)

$$G_{UM}(\text{in dB}) = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

 $-I_C = 14\text{ mA}; -V_{CE} = 10\text{ V}; f = 500\text{ MHz}$  $G_{UM}$  typ. 18 dB

Intermodulation distortion \*

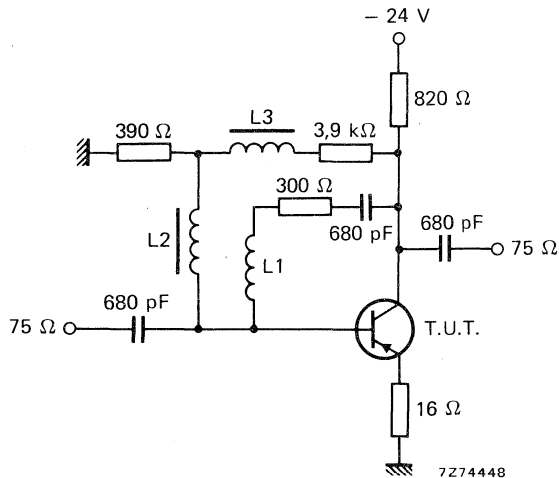
 $-I_C = 14\text{ mA}; -V_{CE} = 10\text{ V}; R_L = 75\ \Omega; VSWR < 2$  $V_p = V_o = 150\text{ mV}$  at  $f_p = 495,25\text{ MHz}$  $V_q = V_o - 6\text{ dB}$  at  $f_q = 503,25\text{ MHz}$  $V_r = V_o - 6\text{ dB}$  at  $f_r = 505,25\text{ MHz}$ Measured at  $f(p + q - r) = 493,25\text{ MHz}$  $d_{im}$  typ. -60 dB

Fig. 2 Intermodulation test circuit.

L1 = 4 turns Cu wire (0,35 mm); winding pitch 1 mm; int. dia. 4 mm.

L2 = L3 = 5  $\mu\text{H}$  (catalogue number: 3122 108 20150).

\* Crystal mounted in SOT-37 envelope.

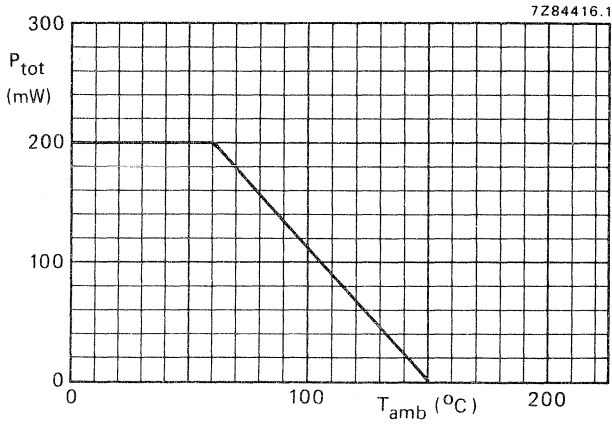


Fig. 3 Power derating curve.



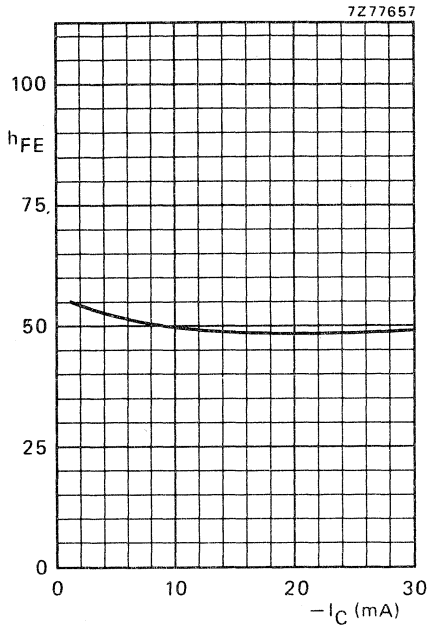


Fig. 4  $-V_{CE} = 10$  V;  $T_j = 25$  °C.

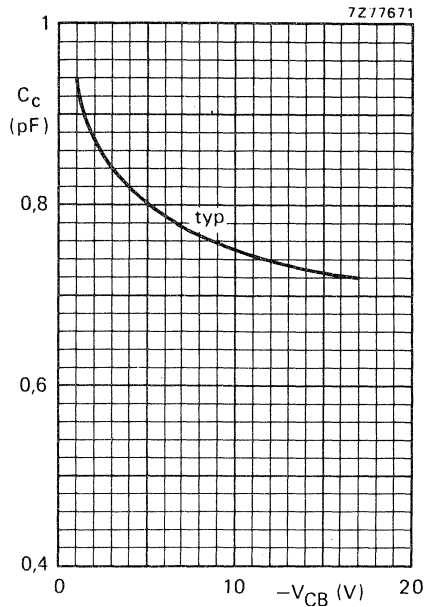


Fig. 5  $I_E = I_e = 0$ ;  $T_j = 25$  °C;  $f = 1$  MHz.

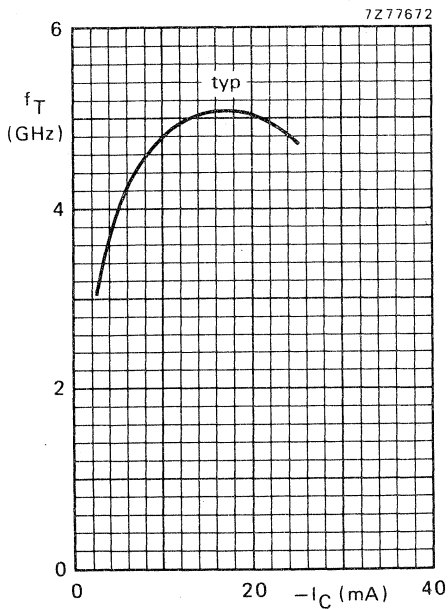


Fig. 6  $-V_{CE} = 10$  V;  $f = 500$  MHz;  $T_j = 25$  °C.

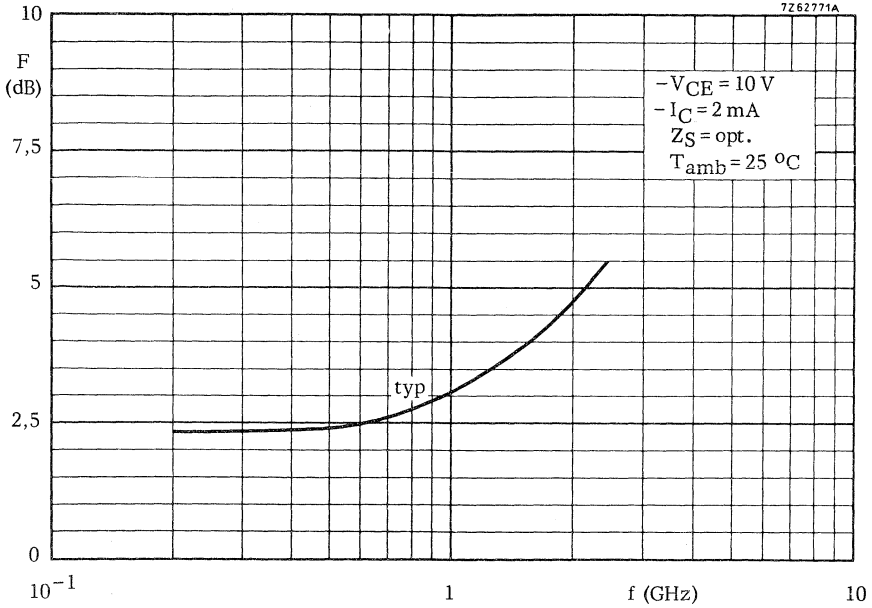


Fig. 7.

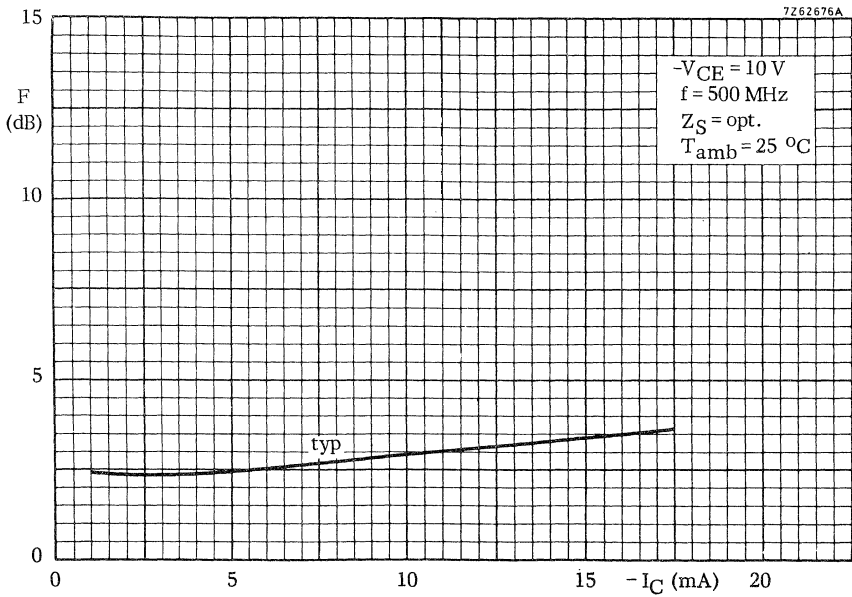


Fig. 8.

## SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistor in a microminiature plastic envelope. It is primarily intended for use in u.h.f. and microwave amplifiers in thick and thin-film circuits, such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analysers, etc.

The transistor features low intermodulation distortion and high power gain; thanks to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

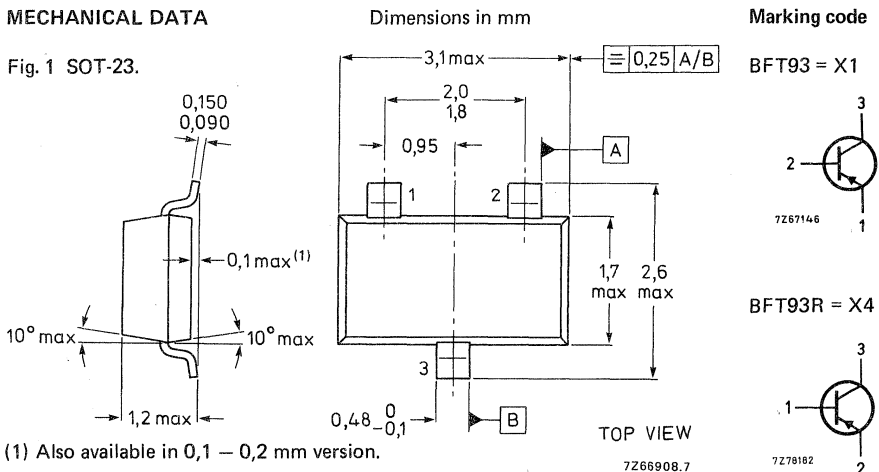
This type is complementary to BFR93.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$-V_{CBO}$ max.	15 V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	12 V
Collector current (d.c.)	$-I_C$ max.	35 mA
Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$	$P_{tot}$ max.	200 mW
Junction temperature	$T_j$ max.	150 $^\circ\text{C}$
Transition frequency at $f = 500\text{ MHz}$ $-I_C = 30\text{ mA}$ ; $-V_{CE} = 5\text{ V}$	$f_T$ typ.	5 GHz
Feedback capacitance at $f = 1\text{ MHz}$ $-I_C = 2\text{ mA}$ ; $-V_{CE} = 5\text{ V}$ ; $T_{amb} = 25\text{ }^\circ\text{C}$	$C_{re}$ typ.	1,0 pF
Noise figure at optimum source impedance $-I_C = 2\text{ mA}$ ; $-V_{CE} = 5\text{ V}$ ; $f = 500\text{ MHz}$ ; $T_{amb} = 25\text{ }^\circ\text{C}$	F typ.	2,4 dB
Max. unilateral power gain $-I_C = 30\text{ mA}$ ; $-V_{CE} = 5\text{ V}$ ; $f = 500\text{ MHz}$ ; $T_{amb} = 25\text{ }^\circ\text{C}$	G <sub>UM</sub> typ.	16,5 dB
Intermodulation distortion at $T_{amb} = 25\text{ }^\circ\text{C}$ $-I_C = 30\text{ mA}$ ; $-V_{CE} = 5\text{ V}$ ; $R_L = 75\text{ }\Omega$ ; $V_o = 300\text{ mV}$ $f(p + q - r) = 493,25\text{ MHz}$	$d_{im}$ typ.	-60 dB

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	15 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	12 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	2,0 V
Collector current (d.c.)	$-I_C$	max.	35 mA
Collector current (peak value; $f > 1$ MHz)	$-I_{CM}$	max.	50 mA
Total power dissipation up to $T_{amb} = 60$ °C **	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		-65 to +150 °C
Junction temperature	$T_j$	max.	150 °C

**THERMAL CHARACTERISTICS \***

$$T_j = P \times (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th j-t}$	=	60 K/W
From tab to soldering points	$R_{th t-s}$	=	280 K/W
From soldering points to ambient **	$R_{th s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 5 \text{ V} \quad -I_{CBO} < 50 \text{ nA}$$

D.C. current gain \*

$$-I_C = 30 \text{ mA}; -V_{CE} = 5 \text{ V} \quad h_{FE} > 20$$

Transition frequency at  $f = 500$  MHz  $\Delta$

$$-I_C = 30 \text{ mA}; -V_{CE} = 5 \text{ V} \quad f_T \text{ typ. } 5 \text{ GHz}$$

Collector capacitance at  $f = 1$  MHz

$$I_E = I_e = 0; -V_{CB} = 10 \text{ V} \quad C_c \text{ typ. } 0,95 \text{ pF}$$

Emitter capacitance at  $f = 1$  MHz

$$I_C = I_c = 0; -V_{EB} = 0,5 \text{ V} \quad C_e \text{ typ. } 1,8 \text{ pF}$$

$\Delta$  Measured under pulse conditions.

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

## CHARACTERISTICS (continued)

 $T_{amb} = 25\text{ }^{\circ}\text{C}$ Feedback capacitance at  $f = 1\text{ MHz}$  $-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$  $C_{re}$  typ. 1,0 pF

Noise figure at optimum source impedance \*

 $-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}; f = 500\text{ MHz}$ 

F typ. 2,4 dB

Max. unilateral power gain ( $s_{re}$  assumed to be zero)

$$G_{UM}(\text{in dB}) = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

 $-I_C = 30\text{ mA}; -V_{CE} = 5\text{ V}; f = 500\text{ MHz}$  $G_{UM}$  typ. 16,5 dB

Intermodulation distortion \*

 $-I_C = 30\text{ mA}; -V_{CE} = 5\text{ V}; R_L = 75\text{ }\Omega; \text{VSWR} < 2$  $V_p = V_o = 300\text{ mV}$  at  $f_p = 495,25\text{ MHz}$  $V_q = V_o - 6\text{ dB}$  at  $f_q = 503,25\text{ MHz}$  $V_r = V_o - 6\text{ dB}$  at  $f_r = 505,25\text{ MHz}$ Measured at  $f(p + q - r) = 493,25\text{ MHz}$ 

dim typ. -60 dB

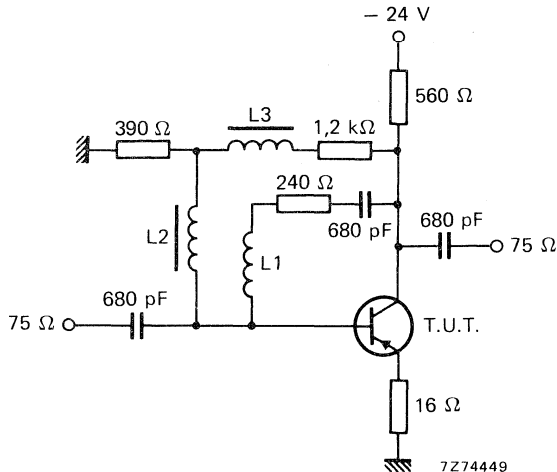


Fig. 2 Intermodulation test circuit.

L1 = 4 turns Cu wire (0,35); winding pitch 1 mm; int. dia. 4 mm.

L2 and L3 = 5  $\mu\text{H}$  (catalogue number: 3122 108 20150).

\* Crystal mounted in SOT-37 envelope.

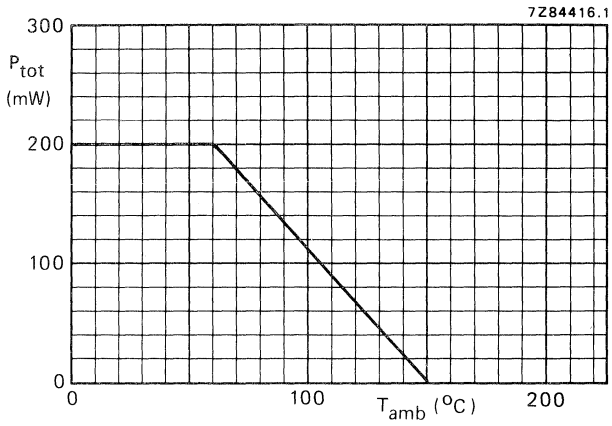


Fig. 3 Power derating curve.

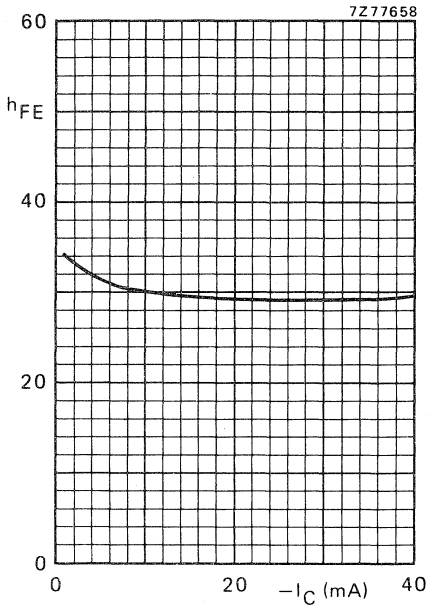


Fig. 4  $-V_{CE} = 5$  V;  $T_j = 25$  °C.

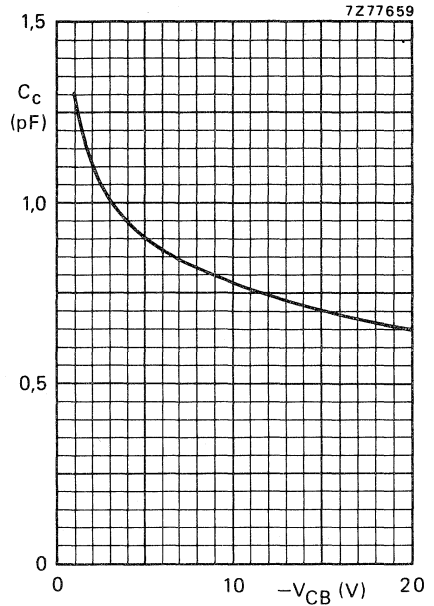


Fig. 5  $I_E = I_e = 0$ ;  $T_j = 25$  °C;  $f = 1$  MHz.

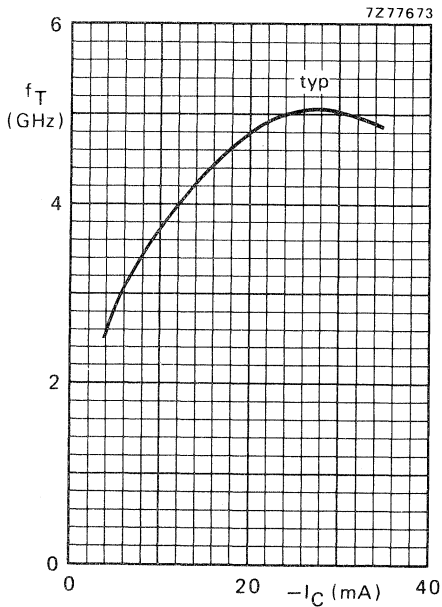


Fig. 6  $-V_{CE} = 5$  V;  $T_j = 25$  °C;  $f = 500$  MHz.

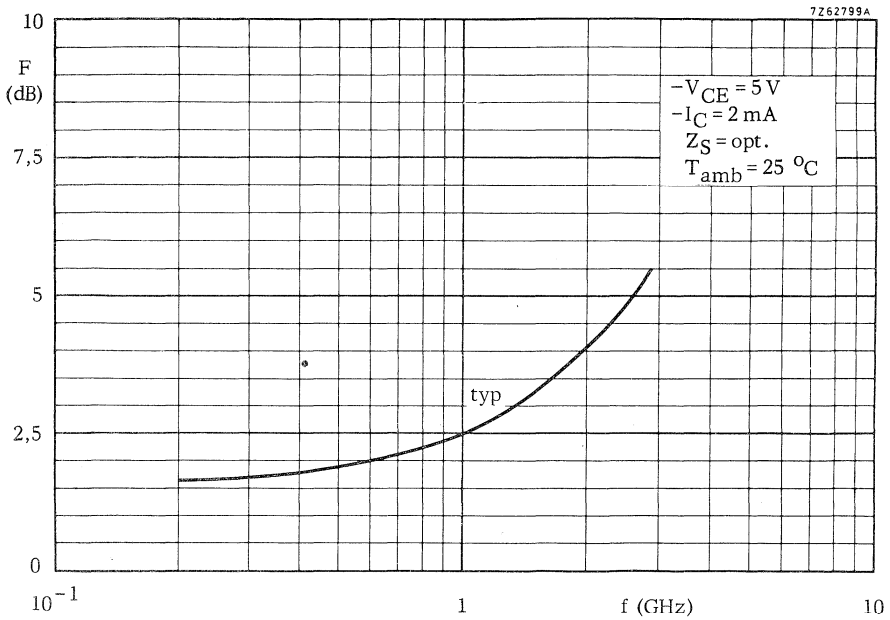


Fig. 7.

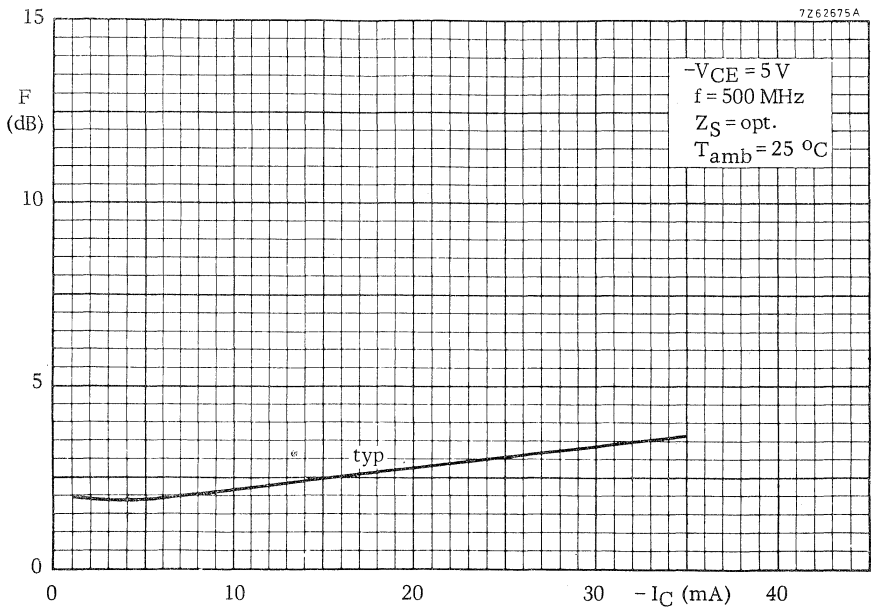


Fig. 8.



## PROGRAMMABLE UNIJUNCTION TRANSISTOR

Planar p-n-p-n trigger device in a microminiature plastic envelope intended for applications in thick and thin-film circuits. It is intended for use in switching applications such as motor control, oscillators, relay replacement, timers, pulse shaper, trigger device etc.

### QUICK REFERENCE DATA

Gate-anode voltage	$V_{GA}$	max.	70 V
Anode current (d.c.) up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$I_A$	max.	175 mA
Junction temperature	$T_j$	max.	150 $^{\circ}\text{C}$
Peak point current $V_S = 10\text{ V}; R_G = 10\text{ k}\Omega$	$I_p$	<	5 $\mu\text{A}$
Valley point current $V_S = 10\text{ V}; R_G = 10\text{ k}\Omega$	$I_V$	>	30 $\mu\text{A}$

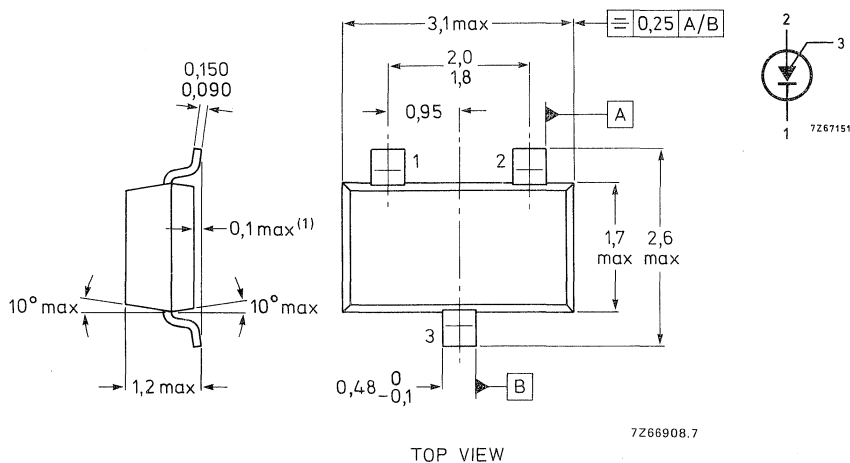
### MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BRY61 = A5



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering Recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Gate-anode voltage	$V_{GA}$	max.	70 V
Anode current (d.c.) up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$I_A$	max.	175 mA
Repetitive peak anode current $t = 10\text{ }\mu\text{s}; \delta = 0,01$	$I_{ARM}$	max.	2,5 A
Non-repetitive peak anode current $t = 10\text{ }\mu\text{s}; T_j = 150\text{ }^{\circ}\text{C}$	$I_{ASM}$	max.	3 A
Rate of rise of anode current up to $I_A = 2,5\text{ A}$	$\frac{dI_A}{dt}$	max.	20 A/ $\mu\text{s}$
Storage temperature	$T_{stg}$		-65 to +150 $^{\circ}\text{C}$
Junction temperature	$T_j$	max.	150 $^{\circ}\text{C}$
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}^{**}$	$P_{tot}$	max.	275 mW

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_{amb} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified

Peak point current (see Figs 2, 3 and 4)

$$V_S = 10\text{ V}; R_G = 10\text{ k}\Omega$$

$$V_S = 10\text{ V}; R_G = 1\text{ M}\Omega$$

$I_P$	<	5 $\mu\text{A}$
$I_P$	<	1 $\mu\text{A}$

Valley point current (see also Figs 2, 3 and 4)

$$V_S = 10\text{ V}; R_G = 10\text{ k}\Omega$$

$$V_S = 10\text{ V}; R_G = 1\text{ M}\Omega$$

$I_V$	>	30 $\mu\text{A}$
$I_V$	<	50 $\mu\text{A}$

Offset voltage (see Fig. 12)

$$I_A = 0 \text{ (for } V_P \text{ see Fig. 2; for } V_S \text{ see Fig. 4)}$$

$$V_{offset} = V_P - V_S \text{ V}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

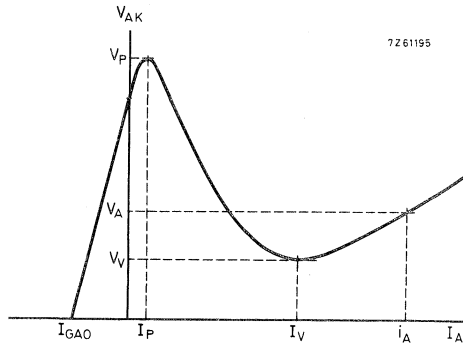


Fig. 2 See also Fig. 11.

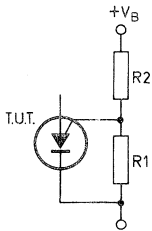


Fig. 3 BRY61 with "program" resistors R1 and R2.

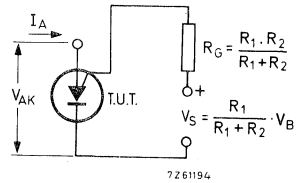


Fig. 4 Equivalent test circuit for characteristics testing.

Gate-anode leakage current (Fig. 5a)

$$I_K = 0; V_{GA} = 70 \text{ V}$$

$$I_{GAO} < 10 \text{ nA}$$

Gate-cathode leakage current (Fig. 5b)

$$V_{AK} = 0; V_{GK} = 70 \text{ V}$$

$$I_{GKS} < 100 \text{ nA}$$

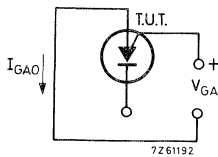


Fig. 5a.

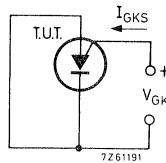


Fig. 5b.

Anode voltage

$$I_A = 100 \text{ mA}$$

$$I_A = 180 \text{ mA}$$

$$V_A < 1,4 \text{ V}$$

$$V_A < 1,6 \text{ V}$$

Peak output voltage

$$V_{AA} = 20 \text{ V}; C = 200 \text{ nF (see Fig. 12)}$$

$$V_{OM} > 6 \text{ V}$$

Rise time

$$V_{AA} = 20 \text{ V}; C = 10 \text{ nF (see Fig. 12)}$$

$$t_r < 80 \text{ ns}$$

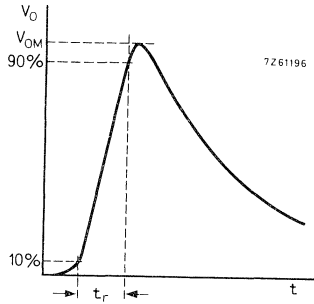


Fig. 6 Output voltage waveform.

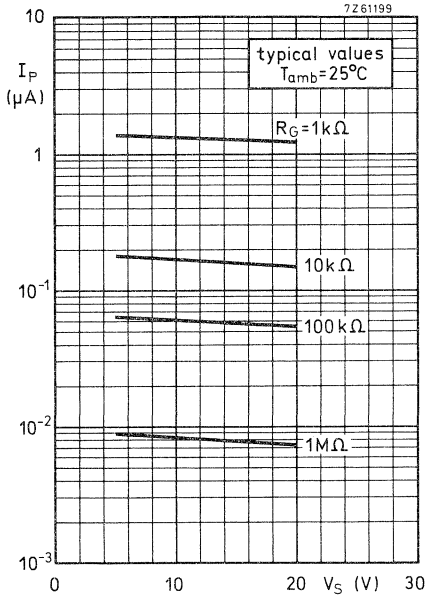


Fig. 7.

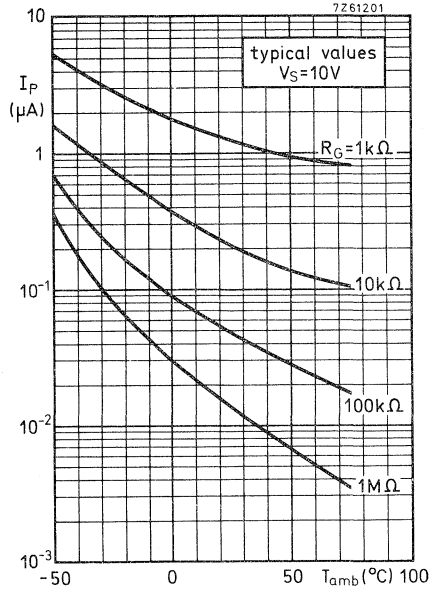


Fig. 8.

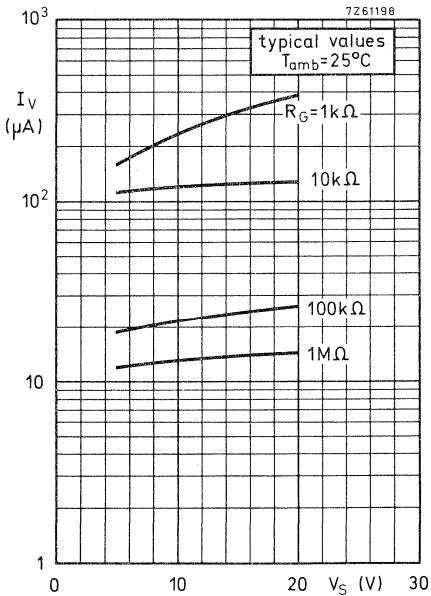


Fig. 9.

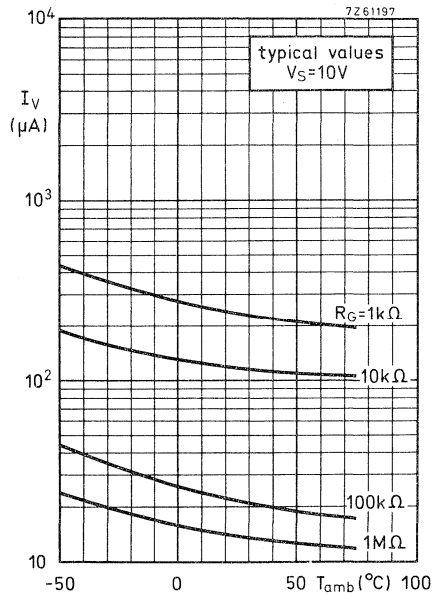


Fig. 10.

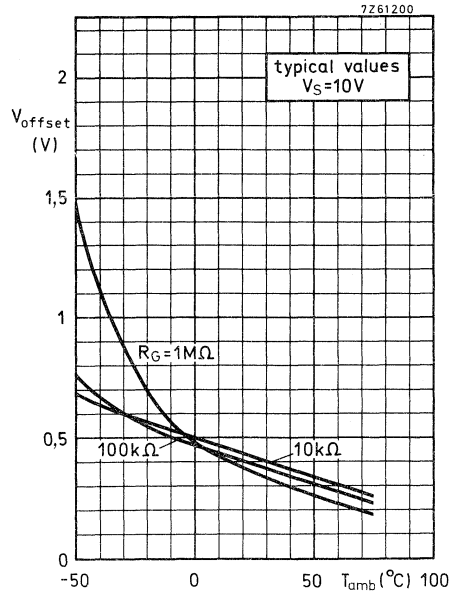


Fig. 11.

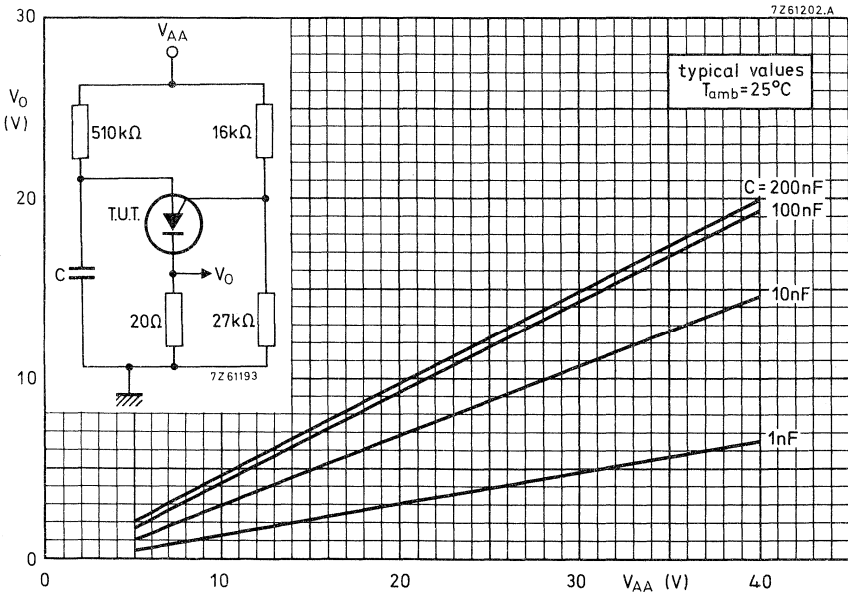


Fig. 12.

## SILICON P-N-P-N PLANAR TETRODE THYRISTOR

Planar p-n-p-n trigger device in a microminiature plastic envelope. It is intended for use as a programmable trigger device (SCS = silicon controlled switch).

### QUICK REFERENCE DATA

Anode gate – cathode voltage	$V_{ga-kR}$	max.	70 V
Anode gate – anode voltage (open cathode)	$V_{ga-aO}$	max.	70 V
Average anode current	$I_A(AV)$	max.	175 mA
Total power dissipation at $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	275 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Gate-controlled turn-on time $R_{gk-k} = 1\text{ k}\Omega$	$t_{gt}$	<	0,25 $\mu\text{s}$
Circuit-commutated turn-off time $R_{gk-k} = 1\text{ k}\Omega$	$t_q$	<	5 $\mu\text{s}$

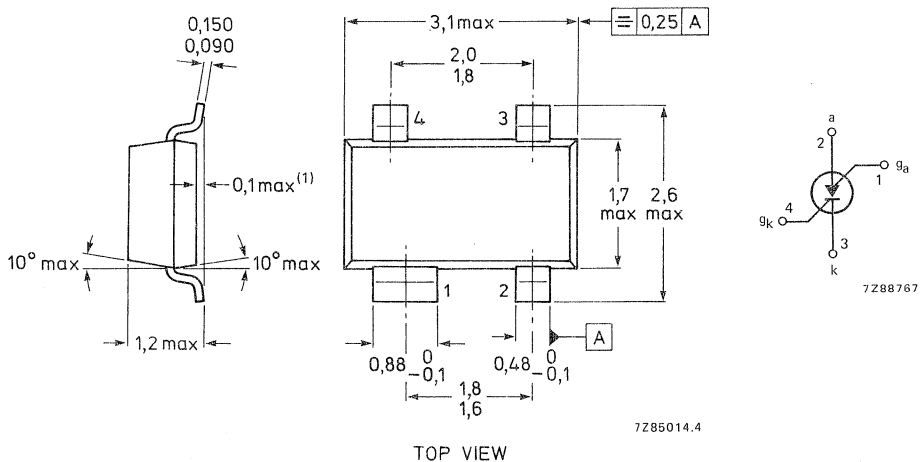
### MECHANICAL DATA

Fig. 1 SOT-143.

Dimensions in mm

Marking code

BRY62 = A51



(1) Also available in 0,1 - 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

**Transistor 1 (T1)**

Collector-base voltage (open emitter)	$V_{CBO}$	max.	70 V
Collector-emitter voltage ( $R_{BE} = 10\text{ k}\Omega$ )	$V_{CEO}$	max.	70 V
Emitter-collector voltage ( $I_{C1} = 0$ )	$V_{EBO}$	max.	5 V
Average collector current	$I_{C(AV)}$	max.	175 mA <sup>▲</sup>
→ Collector current (peak value)	$I_{CM}$	max.	175 mA <sup>**</sup>
Average emitter current	$I_E(AV)$	max.	175 mA
Emitter current (peak value) $t_p = 10\ \mu\text{s}; \delta = 1\%$	$I_{EM}$	max.	2,5 A

**Transistor 2 (T2)**

Collector-base voltage ( $I_{E2} = 0$ )	$-V_{CBO}$	max.	70 V
Collector-emitter voltage ( $I_{B2} = 0$ )	$-V_{CEO}$	max.	70 V
Emitter-base voltage ( $I_{C2} = 0$ )	$-V_{EBO}$	max.	70 V
Emitter current (average)	$I_E(AV)$	max.	175 mA
Emitter current (peak value) $t_p = 10\ \mu\text{s}; \delta = 1\%$	$I_{EM}$	max.	2,5 A
Reverse gate to cathode voltage	$V_{ga-kR}$	max.	70 V
Gate to anode voltage (open cathode)	$V_{ga-aO}$	max.	70 V
Gate to cathode voltage (open anode)	$V_{gk-kO}$	max.	5 V
Average anode current	$I_A(AV)$	max.	175 mA
Anode current (peak value) $t_p = 10\ \mu\text{s}; \delta = 1\%$	$I_{AM}$	max.	2,5 A
Anode gate current (average)	$I_{GA(AV)}$	max.	175 mA
Anode gate current (peak value)	$I_{GAM}$	max.	**
Total power dissipation at $T_{amb} = 25\text{ }^\circ\text{C}^*$	$P_{tot}$	max.	275 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
Storage temperature	$T_{stg}$		$-65\text{ to } +150\text{ }^\circ\text{C}$

**THERMAL RESISTANCE**

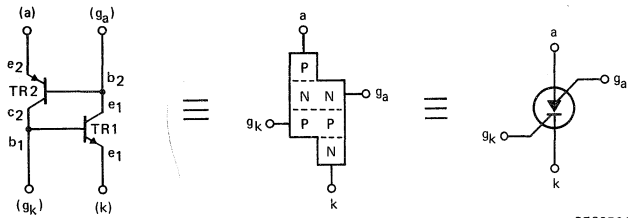
From junction to ambient*	$R_{th\ j-a}$	=	450 K/W
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\* Device mounted on a ceramic substrate of 15 mm x 15 mm x 0,5 mm.

\*\* During switching on, the device can withstand the discharge of a capacitor of maximum value of 500 pF. This capacitor is charged when the transistor is in cut-off condition, with a collector supply voltage of 160 V and a series resistance of 100 k $\Omega$ .

▲ Provided the  $I_E$  rating is not exceeded.





7288764

Fig. 2 Circuit diagram.

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

**Transistor 1 (TR1)**

Collector-emitter cut-off current

$$V_{CE} = 70\text{ V}; R_{BE} = 10\text{ k}\Omega$$

$$V_{CE} = 70\text{ V}; R_{BE} = 10\text{ k}\Omega; T_j = 150\text{ }^\circ\text{C}$$

Emitter cut-off current

$$V_{EB} = 5\text{ V}; I_C = 0; T_j = 150\text{ }^\circ\text{C}$$

Saturation voltages

$$I_C = 10\text{ mA}; I_B = 1\text{ mA}$$

D.C. current gain

$$V_{CE} = 2\text{ V}; I_C = 10\text{ mA}$$

Collector capacitance

$$V_{CB} = 20\text{ V}; I_E = I_e = 0$$

Emitter capacitance

$$V_{EB} = 1\text{ V}; I_C = I_c = 0$$

Transition frequency at  $f = 100\text{ MHz}$

$$V_{CE} = 2\text{ V}; I_C = 10\text{ mA}$$

**Transistor 2 (TR2)**

Collector-emitter cut-off current

$$-V_{CE} = 70\text{ V}; I_B = 0; T_j = 150\text{ }^\circ\text{C}$$

Emitter cut-off current

$$-V_{EB} = 70\text{ V}; I_C = I_c = 0; T_j = 150\text{ }^\circ\text{C}$$

D.C. current gain

$$V_{CB} = 0\text{ V}; I_E = 1\text{ mA}$$

$$I_{CER} < 100\text{ nA}$$

$$I_{CER} < 10\text{ }\mu\text{A}$$

$$I_{EBO} < 10\text{ }\mu\text{A}$$

$$V_{CEsat} < 0,5\text{ V}$$

$$V_{BEsat} < 0,9\text{ V}$$

$$h_{FE} > 50$$

$$C_c < 5\text{ pF}$$

$$C_e < 25\text{ pF}$$

$$f_T = 300\text{ MHz} \leftarrow$$

$$-I_{CEO} < 10\text{ }\mu\text{A} \leftarrow$$

$$-I_{EBO} < 10\text{ }\mu\text{A} \leftarrow$$

$$h_{FE} \quad 0,25\text{ to }2,5 \leftarrow$$

**THYRISTOR**

Anode to cathode

On-state voltage

$I_A = 50 \text{ mA}; I_{ga} = 0; R_{gk-k} = 10 \text{ k}\Omega$

$V_T < 1,4 \text{ V}$

$I_A = 1 \text{ mA}; I_{ga} = 10 \text{ mA}; R_{gk-k} = 10 \text{ k}\Omega$

$V_T < 1,2 \text{ V}$

Holding current

$I_{ga} = 10 \text{ mA}; -V_{gk} = 2 \text{ V}; R_{gk-k} = 10 \Omega$

$I_H < 1 \text{ mA}$

**Switching characteristics**

Gate-controlled turn-on time ( $t_{gt} = t_d + t_r$ )  
when switched from  $V_{gk} = -0,5 \text{ V}$  to  $4,5 \text{ V}$

at  $R_{gk-k} = 1 \text{ k}\Omega$

$t_{gt} < 0,25 \mu\text{s}$

at  $R_{gk-k} = 10 \text{ k}\Omega$

$t_{gt} < 1,5 \mu\text{s}$

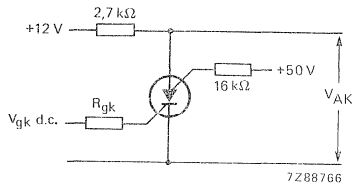


Fig. 3 Switching times test circuit.  
The pulse time of  $V_{gk}$  can be adjusted in such a way that the broken line in Fig. 4 disappears, which means that the thyristor starts triggering.

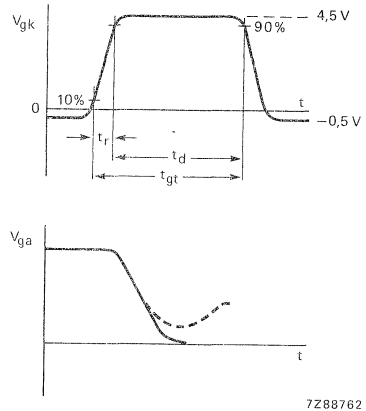


Fig. 4 Switching times waveforms.

Turn-off time (Figs 5 and 6)

$R_{gk} = 1 \text{ k}\Omega$

$R_{gk} = 10 \text{ k}\Omega$

$R_{gk} = 10 \text{ k}\Omega; T_j = 125 \text{ }^\circ\text{C}$

$t_q$	<	5 $\mu\text{s}$
$t_q$	<	8 $\mu\text{s}$
$t_q$	<	15 $\mu\text{s}$

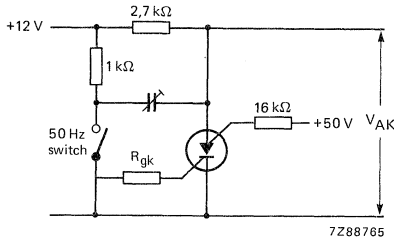


Fig. 5 Switching times test circuit.

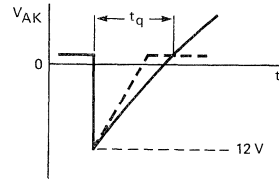


Fig. 6 Switching times waveforms.

The capacitor can be adjusted in such a way that the broken line disappears, which means that the thyristor will not trigger any more.



# DEVELOPMENT SAMPLE DATA

This information is derived from development samples made available for evaluation. It does not necessarily imply that the device will go into regular production.

**BSD20**  
**BSD22**

## MOSFET N-CANNEL DEPLETION SWITCHING TRANSISTORS

Symmetrical insulated-gate silicon MOS field-effect transistors of the N-channel depletion mode type. The transistor is sealed in a SOT-143 envelope and features a low ON-resistance and low capacitances. The transistor is protected against excessive input voltages by integrated back-to-back diodes between gate and substrate.

### Applications:

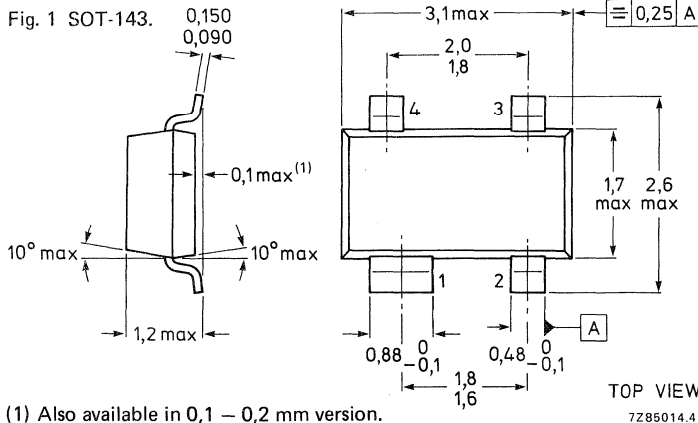
- analog and/or digital switch
- switch driver
- convertor
- chopper

### QUICK REFERENCE DATA

		BSD20		BSD22	
Drain-source voltage	$V_{DS}$	max.	10	20 V	
Gate-source voltage	$V_{GS}$	max.	+10 -30	+20 V -40 V	
Drain current (d.c.)	$I_D$	max.	50 mA		
Total power dissipation up to $T_{amb} = 25^\circ C$	$P_{tot}$	max.	230 mW		
Junction temperature	$T_j$	max.	125 $^\circ C$		
Drain-source ON-resistance	$R_{DSon}$	<	30 $\Omega$		
Feed-back capacitance					
$V_{GS} = V_{BS} = -5 V; V_{DS} = 10 V; f = 1 MHz$		$C_{rss}$	typ.	0,6 pF	

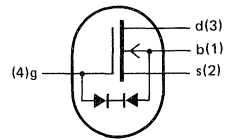
### MECHANICAL DATA

Fig. 1 SOT-143.



Dimensions in mm

Marking code:  
BSD20 = M31  
BSD22 = M32



(1) Also available in 0,1 - 0,2 mm version.

7285014.4

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

			BSD20	BSD22
Drain-source voltage	$V_{DS}$	max.	10	20 V
Source-drain voltage	$V_{SD}$	max.	10	20 V
Drain-substrate voltage	$V_{DB}$	max.	15	25 V
Source-substrate voltage	$V_{SB}$	max.	15	25 V
Gate-substrate voltage	$V_{GB}$	max.	$\pm 15$	$\pm 25$ V
Gate-source voltage	$V_{GS}$	max.	+15 -30	+15 -40 V
Drain current (d.c.)	$I_D$	max.	50	mA
Total power dissipation up to $T_{amb} = 25^\circ\text{C}$ *	$P_{tot}$	max.	230	mW
Storage temperature	$T_{stg}$		-65 to +150	$^\circ\text{C}$
Junction temperature	$T_j$	max.	125	$^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air \*  $R_{th\ j-a} = 430$  K/W

**CHARACTERISTICS**

$T_{amb} = 25^\circ\text{C}$  unless otherwise specified

			BSD20	BSD22
Drain-source breakdown voltage $V_{GS} = V_{BS} = -5\text{ V}; I_S = 10\text{ nA}$	$V_{(BR)DSX}$	>	10	20 V
Source-drain breakdown voltage $V_{GD} = V_{BD} = -5\text{ V}; I_D = 10\text{ nA}$	$V_{(BR)SDX}$	>	10	20 V
Drain-substrate breakdown voltage $V_{GB} = 0; I_D = 10\text{ nA};$ open source	$V_{(BR)DBO}$	>	15	25 V
Source-substrate breakdown voltage $V_{GB} = 0; I_S = 10\text{ nA};$ open drain	$V_{(BR)SBO}$	>	15	25 V
Drain-source leakage current $V_{GS} = V_{BS} = -5\text{ V}; V_{DS} = 20\text{ V}$	$I_{DSoff}$	typ.	1,0	nA
Source-drain leakage current $V_{GD} = V_{BD} = -5\text{ V}; V_{SD} = 20\text{ V}$	$I_{SDoff}$	typ.	1,0	nA
Gate-substrate leakage current $V_{DB} = V_{SB} = 0; V_{GB} = \pm 15\text{ V}$	$I_{GSoff}$	<	10	nA

\* Device mounted on a ceramic substrate of 8 mm x 10 mm x 0,8 mm.

Forward transconductance at  $f = 1 \text{ kHz}$   
 $V_{DS} = 10 \text{ V}; V_{SB} = 0; I_D = 20 \text{ mA}$

$g_{fs} > 10 \text{ mS}$   
 typ. 15 mS

Gate-source cut-off voltage  
 $V_{DS} = 10 \text{ V}; V_{SB} = 0;$   
 $I_S = 10 \mu\text{A}$

$-V_{(P)GS} < 2,0 \text{ V}$

Drain-source ON-resistance  
 $I_D = 1 \text{ mA}; V_{SB} = 0;$   
 $V_{GS} = 5 \text{ V}$

$r_{DSon} < 25 \Omega$   
 typ. 50  $\Omega$

$V_{GS} = 10 \text{ V}$

$r_{DSon} < 15 \Omega$   
 typ. 30  $\Omega$

Capacitances at  $f = 1 \text{ MHz}$   
 $V_{GS} = V_{BS} = -10 \text{ V}; V_{DS} = 10 \text{ V}$

Feed-back capacitance

$C_{rss} \text{ typ. } 0,6 \text{ pF}$

Input capacitance

$C_{iss} \text{ typ. } 1,5 \text{ pF}$

Output capacitance

$C_{oss} \text{ typ. } 1,0 \text{ pF}$

Switching times (see Fig. 2)  
 $V_{DD} = 10 \text{ V}; V_i = 5 \text{ V}$

$t_{on} \text{ typ. } 1,0 \text{ ns}$   
 $t_{off} \text{ typ. } 5,0 \text{ ns}$

DEVELOPMENT SAMPLE DATA

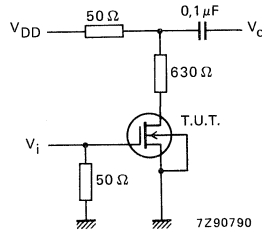


Fig. 2 Switching times test circuit.





## SILICON LOW-POWER SWITCHING TRANSISTORS

P-N-P silicon transistor in a microminiature plastic envelope. It is intended for high-speed, saturated switching applications for industrial service in thick and thin-film circuits.

### QUICK REFERENCE DATA

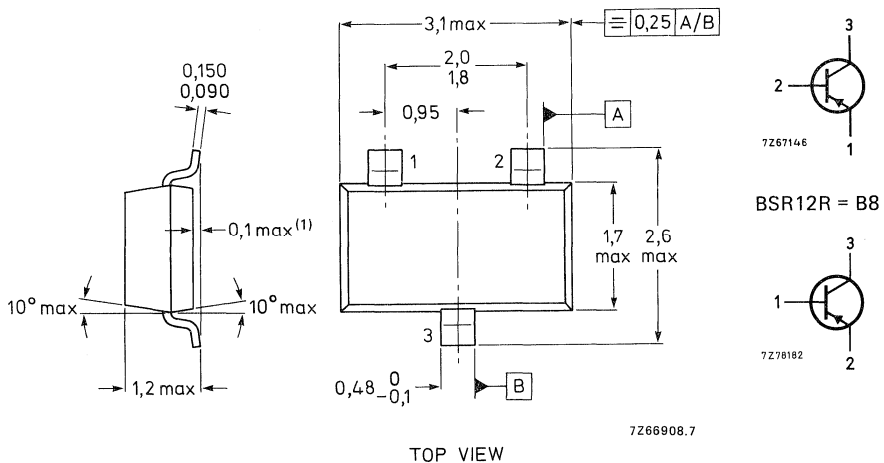
Collector-base voltage (open emitter)	$-V_{CBO}$ max.	15 V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	15 V
Collector current (peak value)	$-I_{CM}$ max.	200 mA
Total power dissipation up to $T_{amb} = 65\text{ }^{\circ}\text{C}$	$P_{tot}$ max.	250 mW
Junction temperature	$T_j$ max.	175 $^{\circ}\text{C}$
D.C. current gain		
$-I_C = 10\text{ mA}; -V_{CE} = 1\text{ V}$	$h_{FE}$	> 30
$-I_C = 50\text{ mA}; -V_{CE} = 1\text{ V}$	$h_{FE}$	30 to 120
Transition frequency at $f = 500\text{ MHz}$		
$-I_C = 50\text{ mA}; -V_{CE} = 10\text{ V}$	$f_T$	> 1,5 GHz
Turn-off time		
$-I_{Con} = 30\text{ mA}; -I_{Bon} = +I_{Boff} = 3,0\text{ mA}$	$t_{off}$	< 30 ns

### MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

### RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) See Fig. 3	$-V_{CB0}$	max.	15 V
Collector-emitter voltage (open base) See Fig. 3	$-V_{CEO}$	max.	15 V
Emitter-base voltage (open collector) See Fig. 3	$-V_{EBO}$	max.	3 V
Collector current (d.c.)	$-I_C$	max.	100 mA
Collector current (peak value)	$-I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 65\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	250 mW
Storage temperature	$T_{stg}$		$-65$ to $+175\text{ }^\circ\text{C}$
Junction temperature	$T_j$	max.	$175\text{ }^\circ\text{C}$

### THERMAL CHARACTERISTICS\*

$$T_j = P_x (R_{thj-t} + R_{tht-s} + R_{th s-a}) + T_{amb}$$

#### Thermal resistance

From junction to tab	$R_{thj-t}$	=	60 K/W
From tab to soldering points	$R_{tht-s}$	=	280 K/W
From soldering points to ambient**	$R_{th s-a}$	=	90 K/W

### CHARACTERISTICS

$T_{amb} = 25\text{ }^\circ\text{C}$  unless otherwise specified

#### Collector cut-off current

$I_E = 0; -V_{CB} = 10\text{ V}$	$-I_{CBO}$	<	50 nA
$I_E = 0; -V_{CB} = 10\text{ V}; T_{amb} = 125\text{ }^\circ\text{C}$	$-I_{CBO}$	<	5 $\mu\text{A}$
$V_{BE} = 0; -V_{CE} = 10\text{ V}$	$-I_{CES}$	<	50 nA

#### Breakdown voltages

$I_E = 0; -I_C = 10\text{ }\mu\text{A}$	$-V_{(BR)CBO}$	>	15 V
$V_{BE} = 0; -I_C = 10\text{ }\mu\text{A}$	$-V_{(BR)CES}$	>	15 V
$I_C = 0; -I_E = 100\text{ }\mu\text{A}$	$-V_{(BR)EBO}$	>	3 V

#### Collector-emitter sustaining voltage

$I_B = 0; -I_C = 10\text{ mA}$	$-V_{CEO_{sust}}$	>	15 V
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#### Saturation voltages<sup>▲</sup>

$-I_C = 10\text{ mA}; -I_B = 1\text{ mA}$	$-V_{CE_{sat}}$	<	130 mV
	$-V_{BE_{sat}}$		725 to 920 mV
$-I_C = 50\text{ mA}; -I_B = 5\text{ mA}$	$-V_{CE_{sat}}$	<	190 mV
	$-V_{BE_{sat}}$		800 to 1150 mV
$-I_C = 100\text{ mA}; -I_B = 10\text{ mA}$	$-V_{CE_{sat}}$	<	450 mV
	$-V_{BE_{sat}}$		900 to 1500 mV

▲ Measured under pulse conditions;  $t_p = 300\text{ }\mu\text{s}$ ;  $\delta = 0,01$ .

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

D.C. current gain \*

- I<sub>C</sub> = 1 mA; -V<sub>CE</sub> = 1 V
- I<sub>C</sub> = 10 mA; -V<sub>CE</sub> = 1 V
- I<sub>C</sub> = 50 mA; -V<sub>CE</sub> = 1 V
- I<sub>C</sub> = 50 mA; -V<sub>CE</sub> = 1 V; T<sub>amb</sub> = 55 °C
- I<sub>C</sub> = 100 mA; -V<sub>CE</sub> = 1 V

h <sub>FE</sub>	>	30
h <sub>FE</sub>	>	30
h <sub>FE</sub>	>	30 to 120
h <sub>FE</sub>	>	30
h <sub>FE</sub>	>	20

Transition frequency at f = 500 MHz

- I<sub>C</sub> = 50 mA; -V<sub>CE</sub> = 10 V

f <sub>T</sub>	>	1,5 GHz
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Collector capacitance

- I<sub>E</sub> = I<sub>e</sub> = 0; -V<sub>CB</sub> = 5 V

C <sub>c</sub>	<	4,5 pF
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Emitter capacitance

- I<sub>C</sub> = I<sub>c</sub> = 0; -V<sub>EB</sub> = 0,5 V

C <sub>e</sub>	<	6,0 pF
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Switching times

Turn-on time

t <sub>on</sub>	<	20 ns
-----------------	---	-------

Turn-off time

t <sub>off</sub>	<	30 ns
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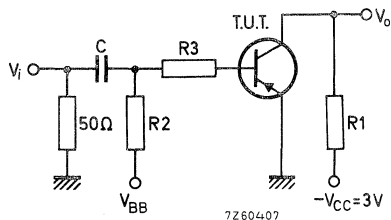


Fig. 2 Test circuit switching times.

Pulse generator

- Pulse duration t<sub>p</sub> = 400 ns
- Rise time t<sub>r</sub> < 1 ns
- Output impedance Z<sub>o</sub> = 50 Ω

Sampling scope

- Rise time t<sub>r</sub> < 1 ns
- Input impedance Z<sub>i</sub> = 100 kΩ

	V <sub>i</sub> V	V <sub>BB</sub> V	R1 Ω	R2 kΩ	R3 kΩ	-I <sub>Con</sub> mA	-I <sub>Bon</sub> mA	I <sub>Boff</sub> mA	C μF
t <sub>on</sub>	-6,85	0	94	1,0	2,0	30	3,0	-	0,1
t <sub>off</sub>	11,7	-9,85	94	1,0	2,0	30	3,0	3,0	0,1

\* Measured under pulse conditions; t<sub>p</sub> = 300 μs; δ = 0,01.

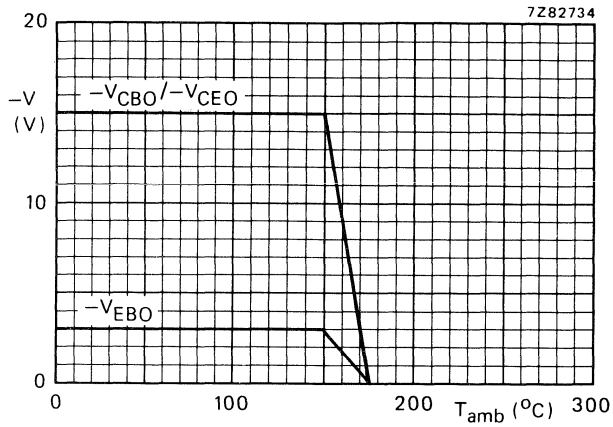


Fig. 3 Voltage derating curves.

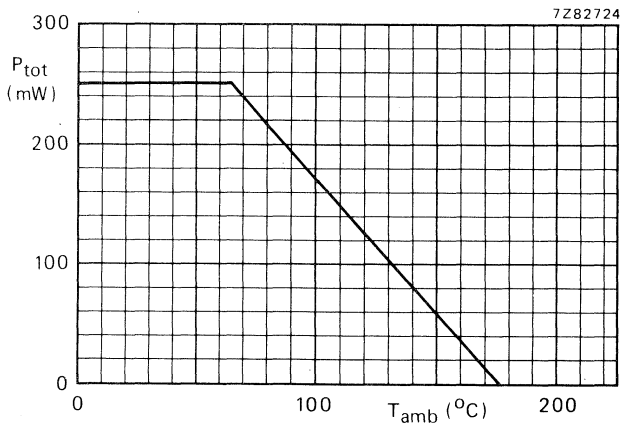


Fig. 4 Power derating curve.

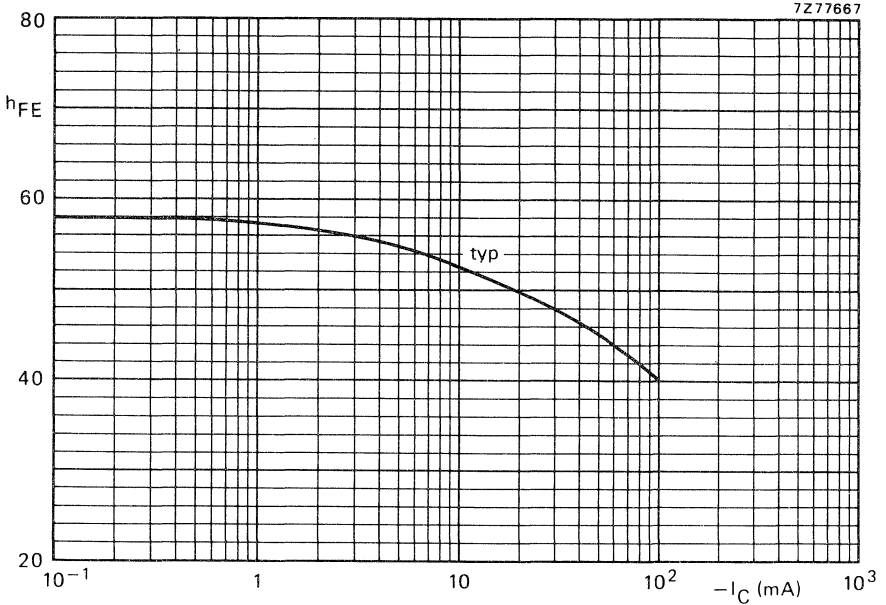


Fig. 5  $-V_{CE} = 1\text{ V}$ ;  $T_{amb} = 25\text{ }^\circ\text{C}$ .

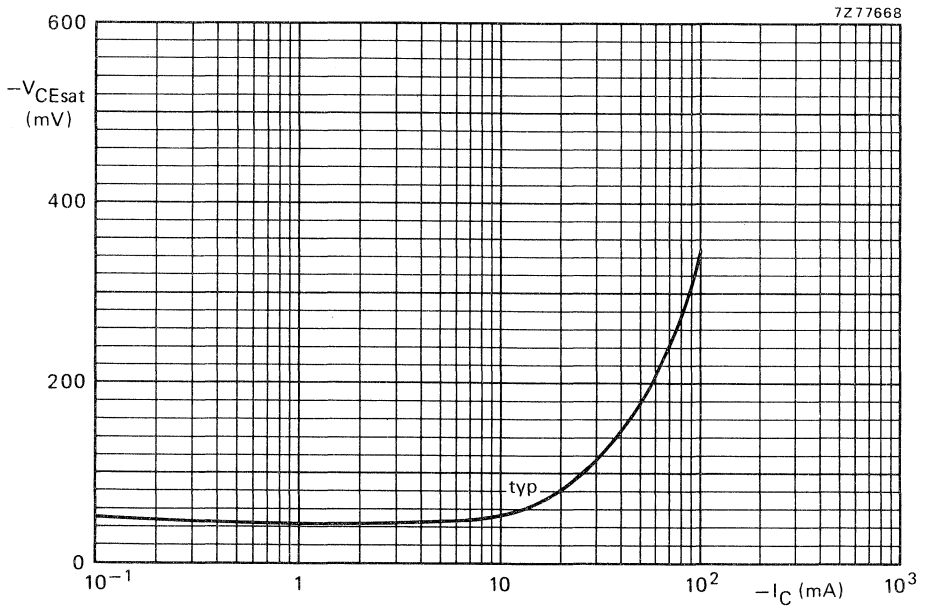


Fig. 6  $V_{CEsat}$  as a function of  $I_C$  at  $I_C/I_B = 10$ .

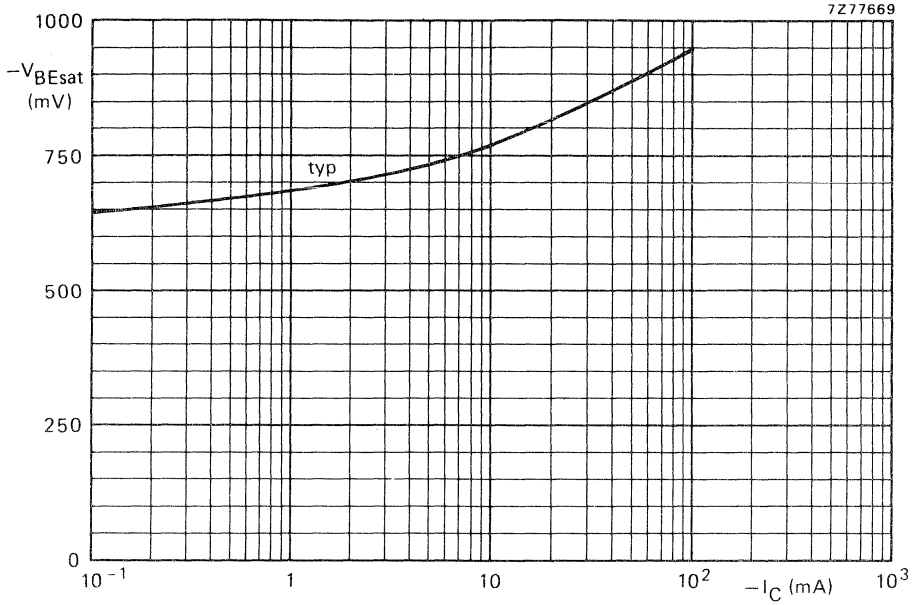


Fig. 7  $V_{BEsat}$  as a function of  $I_C$  at  $I_C/I_B = 10$ .

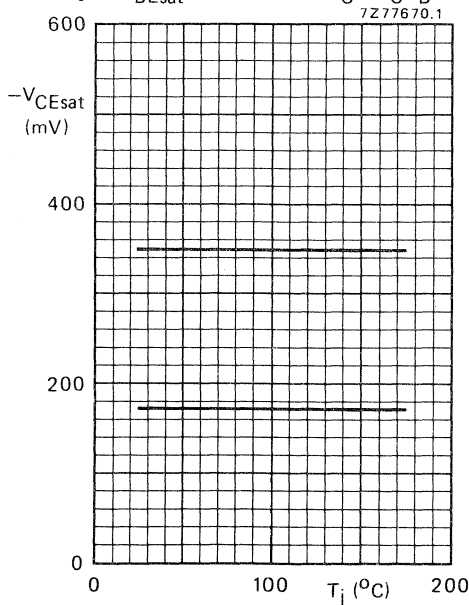


Fig. 8  $V_{CEsat}$  as a function of  $T_j$ ; typical values.

Upper graph at  $I_C = 100$  mA;  $I_B = 10$  mA. Lower graph at  $I_C = 50$  mA and  $I_B = 5$  mA.

## SILICON PLANAR EPITAXIAL TRANSISTORS

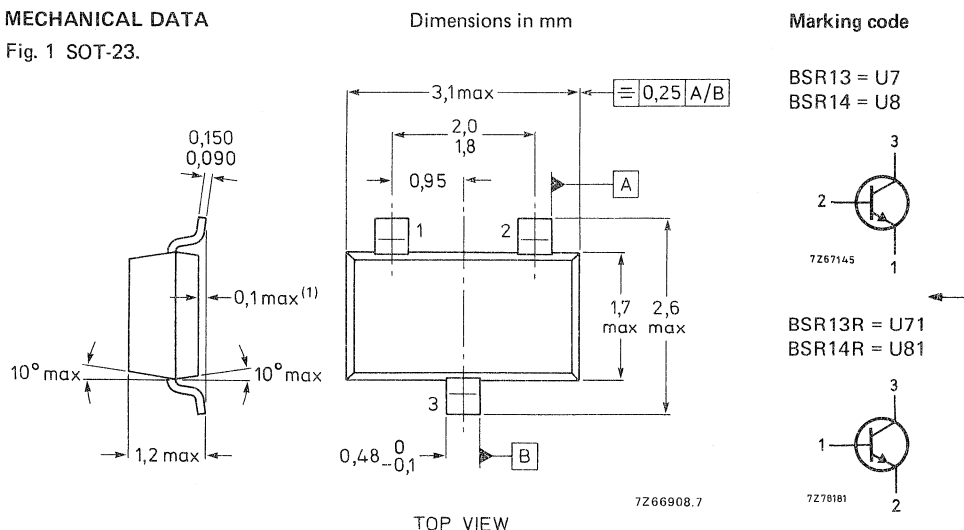
N-P-N silicon transistors, in a microminiature plastic envelope intended for switching and linear applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

		BSR13;R	BSR14;R
Collector-base voltage (open emitter)	$V_{CB0}$	max. 60	75 V
Collector-emitter voltage (open base)	$V_{CE0}$	max. 30	40 V
Emitter-base voltage (open collector)	$V_{EB0}$	max. 5	6 V
Collector current (d.c.)	$I_C$	max. 800	mA
Total power dissipation up to $T_{amb} = 25^\circ\text{C}$	$P_{tot}$	max. 425	mW
Junction temperature	$T_j$	max. 175	$^\circ\text{C}$
D.C. current gain		100 to 300	
$I_C = 150\text{ mA}; V_{CE} = 10\text{ V}$	$h_{FE}$	> 30	40
$I_C = 500\text{ mA}; V_{CE} = 10\text{ V}$	$h_{FE}$	> 30	40
Transition frequency at $f = 100\text{ MHz}$	$f_T$	> 250	300 MHz
$I_C = 20\text{ mA}; V_{CE} = 20\text{ V}$			

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also Soldering recommendations.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

			BSR13; R	BSR14; R	
Collector-base voltage (open emitter) see Fig. 4	$V_{CBO}$	max.	60	75	V
Collector-emitter voltage (open base) see Fig. 4	$V_{CEO}$	max.	30	40	V
Emitter-base voltage (open collector) see Fig. 4	$V_{EBO}$	max.	5	6	V
Collector current (d.c.)	$I_C$	max.	800		mA
Total power dissipation** up to $T_{amb} = 25^\circ C$	$P_{tot}$	max.	425		mW
Storage temperature	$T_{stg}$		-65 to + 175		$^\circ C$
Junction temperature	$T_j$	max.	175		$^\circ C$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	30	K/W
From tab to soldering points	$R_{th\ t-s}$	=	260	K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	60	K/W

**CHARACTERISTICS**

$T_j = 25^\circ C$  unless otherwise specified

			BSR13; R	BSR14; R	
Collector cut-off current					
$I_E = 0; V_{CB} = 50\ V$	$I_{CBO}$	<	30	—	nA
$I_E = 0; V_{CB} = 60\ V$	$I_{CBO}$	<	—	10	nA
$I_E = 0; V_{CB} = 50\ V; T_j = 150^\circ C$	$I_{CBO}$	<	10	—	$\mu A$
$I_E = 0; V_{CB} = 60\ V; T_j = 150^\circ C$	$I_{CBO}$	<	—	10	$\mu A$
$V_{EB} = 3\ V; V_{CE} = 60\ V$	$I_{CEX}$	<	—	10	nA
Base current with reverse biased emitter junction $V_{EB} = 3\ V; V_{CE} = 60\ V$	$I_{BEX}$	<	—	20	nA
Emitter cut-off current $I_C = 0; V_{EB} = 3\ V$	$I_{EBO}$	<	30	15	nA
Saturation voltages $\Delta$ $I_C = 150\ mA; I_B = 15\ mA$	$V_{CEsat}$	<	400	300	mV
	$V_{BEsat}$	<	1300	—	mV
	$V_{BEsat}$	<	—	0,6 to 1,2	V
$I_C = 500\ mA; I_B = 50\ mA$	$V_{CEsat}$	<	1600	1000	mV
	$V_{BEsat}$	<	2600	2000	mV

\* See *Thermal characteristics*.

\*\* Device mounted on a ceramic substrate of 15 mm x 15 mm x 0,7 mm.

$\Delta$  Measured under pulsed conditions to avoid excessive dissipation  $t_p \leq 300\ \mu s; \delta \leq 0,02$ .



## D.C. current gain \*

 $I_C = 0,1 \text{ mA}; V_{CE} = 10 \text{ V}$  $h_{FE} > 35$  $I_C = 1 \text{ mA}; V_{CE} = 10 \text{ V}$  $h_{FE} > 50$  $I_C = 10 \text{ mA}; V_{CE} = 10 \text{ V}$  $h_{FE} > 75$  $I_C = 150 \text{ mA}; V_{CE} = 10 \text{ V}$  $h_{FE} 100 \text{ to } 300$  $I_C = 150 \text{ mA}; V_{CE} = 1 \text{ V}$  $h_{FE} > 50$  $I_C = 500 \text{ mA}; V_{CE} = 10 \text{ V}$  BSR13; R $h_{FE} > 30$  $I_C = 500 \text{ mA}; V_{CE} = 10 \text{ V}$  BSR14; R $h_{FE} > 40$ Transition frequency at  $f = 100 \text{ MHz}$  $I_C = 20 \text{ mA}; V_{CE} = 20 \text{ V}$  BSR13; R $f_T > 250 \text{ MHz}$  $I_C = 20 \text{ mA}; V_{CE} = 20 \text{ V}$  BSR14; R $f_T > 300 \text{ MHz}$ Collector capacitance at  $f = 1 \text{ MHz}$  $I_E = I_e = 0; V_{CB} = 10 \text{ V}$  $C_c < 8 \text{ pF}$ h parameters (common emitter) at  $f = 1 \text{ kHz}$  $I_C = 1 \text{ mA}; V_{CE} = 10 \text{ V}$ 

BSR14;R

input impedance

 $h_{ie} 2 \text{ to } 8 \text{ k}\Omega$ 

reverse voltage transfer ratio

 $h_{re} < 8 \cdot 10^{-4}$ 

small signal current gain

 $h_{fe} 50 \text{ to } 300$ 

output admittance

 $h_{oe} 5 \text{ to } 35 \mu\Omega^{-1}$  $I_C = 10 \text{ mA}; V_{CE} = 10 \text{ V}$ 

input impedance

 $h_{ie} 0,25 \text{ to } 1,25 \text{ k}\Omega$ 

reverse voltage transfer ratio

 $h_{re} < 4 \cdot 10^{-4}$ 

small signal current gain

 $h_{fe} 75 \text{ to } 375$ 

output admittance

 $h_{oe} 25 \text{ to } 200 \mu\Omega^{-1}$ \* Measured under pulsed conditions to avoid excessive dissipation; pulse duration  $t_p \leq 300 \mu\text{s}$ ; duty factor  $\delta \leq 0,02$ .

Switching times (between 10% and 90% levels)

Turn-on time switched to  $I_C = 150 \text{ mA}$  (see Fig. 2)

delay time  
rise time

BSR14;R	
$t_d$	< 10 ns
$t_r$	< 25 ns

Turn-off time switched from  $I_C = 150 \text{ mA}$  (see Fig. 3)

storage time  
fall time

$t_s$	< 225 ns
$t_f$	< 60 ns

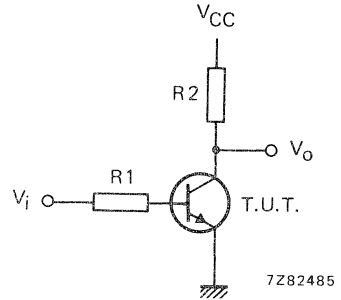
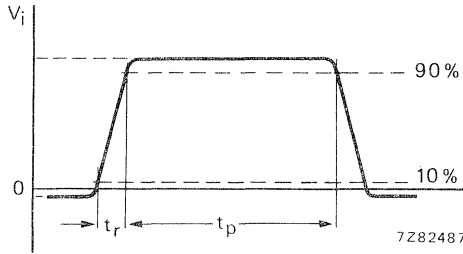


Fig. 2 Waveform and test circuit delay and rise time.

$V_i = -0,5 \text{ to } +9,9 \text{ V}$ ;  $V_{CC} = 30 \text{ V}$ ;  $R_1 = 619 \Omega$ ;  $R_2 = 200 \Omega$ .

Pulse generator:

pulse duration	$t_p \leq 200 \text{ ns}$
rise time	$t_r \leq 2 \text{ ns}$
duty factor	$\delta = 2 \%$

Oscilloscope:

input impedance	$Z_i > 100 \text{ k}\Omega$
input capacitance	$C_i < 12 \text{ pF}$
rise time	$t_r < 5 \text{ ns}$

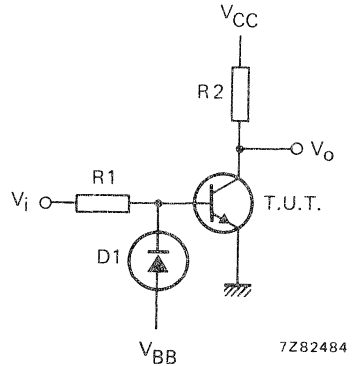
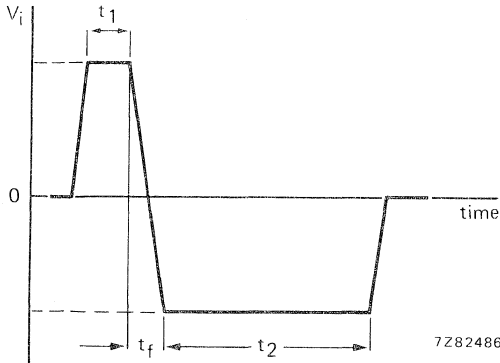


Fig. 3 Waveform and test circuit storage and fall time.

$V_i = -13,8 \text{ to } +16,2 \text{ V}$ ;  $V_{CC} = 30 \text{ V}$ ;  $-V_{BB} = 3 \text{ V}$ ;  $R_1 = 1 \text{ k}\Omega$ ;  $R_2 = 200 \Omega$ .

Pulse generator:

fall time	$t_f < 5 \text{ ns}$
pulse time	$t_1 = 100 \mu\text{s}$
	$t_2 = 500 \mu\text{s}$

Oscilloscope:

input impedance	$Z_i > 100 \text{ k}\Omega$
input capacitance	$C_i < 12 \text{ pF}$
rise time	$t_r < 5 \text{ ns}$

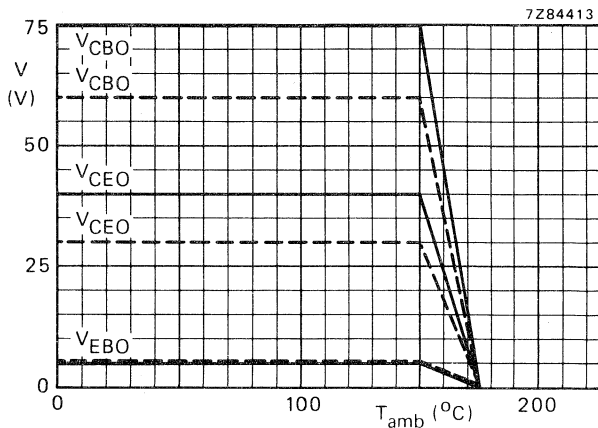


Fig. 4 Voltage derating curve.  
--- BSR13; R — BSR14; R.

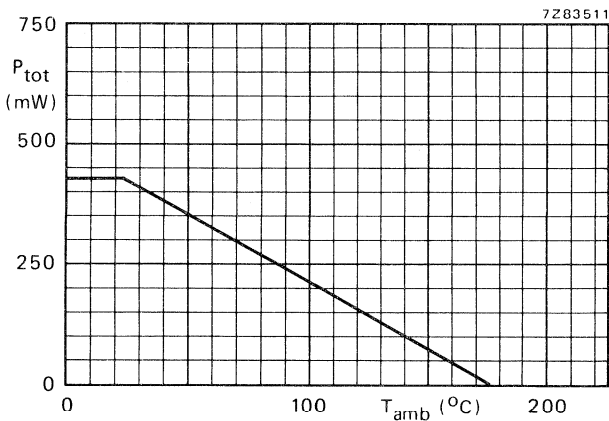


Fig. 5 Power derating curve.



## SILICON PLANAR EPITAXIAL TRANSISTORS

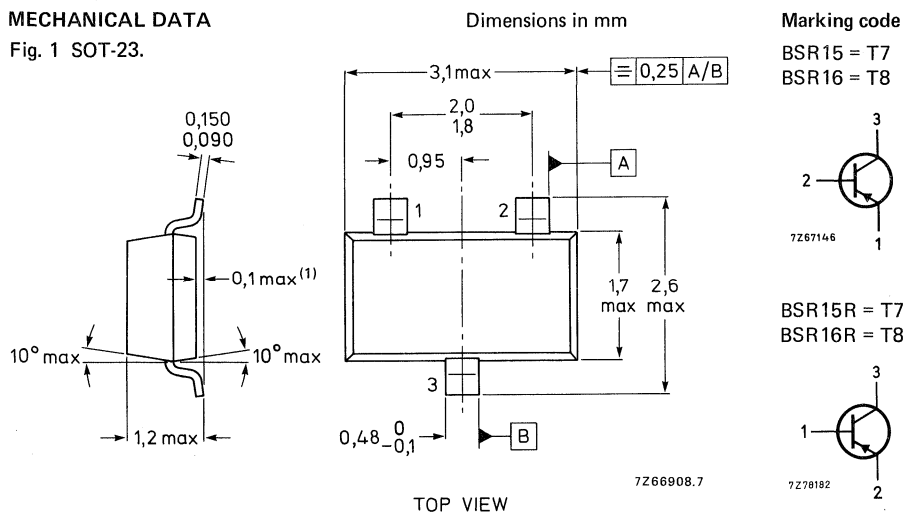
P-N-P silicon transistors, in a microminiature plastic envelope, intended for medium power switching and general purpose amplifier applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

			BSR15; R	BSR16; R	
Collector-base voltage (open emitter)	$-V_{CB0}$	max.	60	60	V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	40	60	V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.		5	V
Collector current (d.c.)	$-I_C$	max.	600		mA
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	425		mW
Junction temperature	$T_j$	max.	175		$^\circ\text{C}$
D.C. current gain					
$-I_C = 500\text{ mA}; -V_{CE} = 10\text{ V}$	$h_{FE}$	>	30	50	
Turn-off switching time					
$-I_{Con} = 150\text{ mA}; -I_{Bon} = I_{Boff} = 15\text{ mA}$	$t_{off}$	>	100		ns
Transition frequency at $f = 100\text{ MHz}$					
$-I_C = 50\text{ mA}; -V_{CE} = 20\text{ V}$	$f_T$	>	200		MHz

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also Soldering recommendations.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BSR15; R	BSR16; R	
Collector-base voltage (open emitter) See Figs 5 and 6	$-V_{CBO}$ max.	60	60	V
Collector-emitter voltage (open base) See Figs 5 and 6	$-V_{CEO}$ max.	40	60	V
Emitter-base voltage (open collector) See Figs 5 and 6	$-V_{EBO}$ max.	5	5	V
Collector current (d.c.)	$-I_C$ max.	600		mA
Power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}^{**}$	$P_{tot}$ max.	425		mW
Storage temperature	$T_{stg}$	-65 to +175		$^\circ\text{C}$
Junction temperature	$T_j$ max.	175		$^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$ =	30	K/W
From tab to soldering points	$R_{th\ t-s}$ =	260	K/W
From soldering points to ambient**	$R_{th\ s-a}$ =	60	K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

		BSR15; R	BSR16; R	
Collector cut-off current				
$I_E = 0; -V_{CB} = 50\text{ V}$	$-I_{CBO} <$	20	10	nA
$I_E = 0; -V_{CB} = 50\text{ V}; T_j = 150\text{ }^\circ\text{C}$	$-I_{CBO} <$	20	10	$\mu\text{A}$
$-V_{EB} = 0,5\text{ V}; -V_{CE} = 30\text{ V}$	$-I_{CEX} <$	50		nA
Base current				
with reverse biased emitter junction				
$-V_{EB} = 3\text{ V}; -V_{CE} = 30\text{ V}$	$-I_{BEX} <$	50		nA
Saturation voltages $\Delta$				
$-I_C = 150\text{ mA}; -I_B = 15\text{ mA}$	$-V_{CEsat} <$	0,4		V
	$-V_{BEsat} <$	1,3		V
$-I_C = 500\text{ mA}; -I_B = 50\text{ mA}$	$-V_{CEsat} <$	1,6		V
	$-V_{BEsat} <$	2,6		V

\* See *Thermal characteristics*.

\*\* Device mounted on a ceramic substrate of 15 mm x 15 mm x 0,7 mm.

$\Delta$  Measured under pulsed conditions to avoid excessive dissipation pulse duration  $t_p \leq 300\text{ }\mu\text{s}$ ; duty factor  $\delta \leq 0,02$ .

	BSR15; R	BSR16; R	
D.C. current gain *			
$-I_C = 0,1 \text{ mA}; -V_{CE} = 10 \text{ V}$	$h_{FE} > 35$	75	
$-I_C = 1 \text{ mA}; -V_{CE} = 10 \text{ V}$	$h_{FE} > 50$	100	
$-I_C = 10 \text{ mA}; -V_{CE} = 10 \text{ V}$	$h_{FE} > 75$	100	
$-I_C = 150 \text{ mA}; -V_{CE} = 10 \text{ V}$	$h_{FE}$	100 to 300	
$-I_C = 500 \text{ mA}; -V_{CE} = 10 \text{ V}$	$h_{FE} > 30$	50	
Transition frequency at $f = 100 \text{ MHz}$			
$-I_C = 50 \text{ mA}; -V_{CE} = 20 \text{ V}; T_{amb} = 25 \text{ }^\circ\text{C}$	$f_T > 200$		MHz
Collector capacitance at $f = 1 \text{ MHz}$			
$I_E = I_e = 0; -V_{CB} = 10 \text{ V}$	$C_c < 8$		pF
Emitter capacitance at $f = 1 \text{ MHz}$			
$I_C = I_c = 0; -V_{EB} = 2 \text{ V}$	$C_e < 30$		pF
Switching times (between 10% and 90% levels)			
Turn-on time when switched to			
$-I_C = 150 \text{ mA}; -I_B = 15 \text{ mA};$ (see Fig. 3)			
delay time	$t_d < 10$		ns
rise time	$t_r < 40$		ns
turn-on time ( $t_d + t_r$ )	$t_{on} < 45$		ns
Turn-off time when switched from			
$-I_C = 150 \text{ mA}; -I_B = 15 \text{ mA}$			
to cut-off with $+I_{BM} = 15 \text{ mA}$ (see Fig. 4)			
storage time	$t_s < 80$		ns
fall time	$t_f < 30$		ns
turn-off time ( $t_s + t_f$ )	$t_{off} < 100$		ns

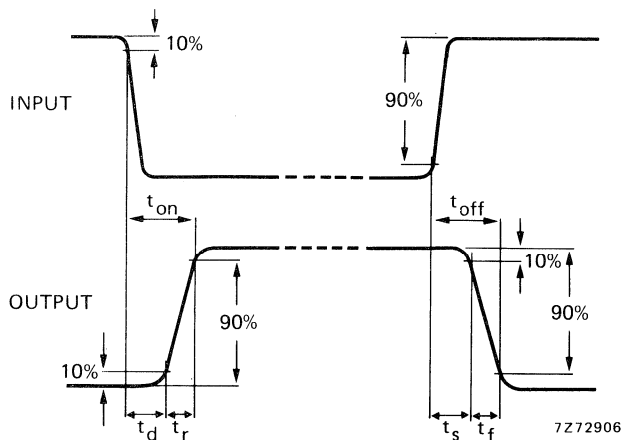


Fig. 2 Switching time waveforms.

\* Measured under pulsed conditions to avoid excessive dissipation; pulse duration  $t_p \leq 300 \mu\text{s}$ ; duty factor  $\delta \leq 0,02$ .

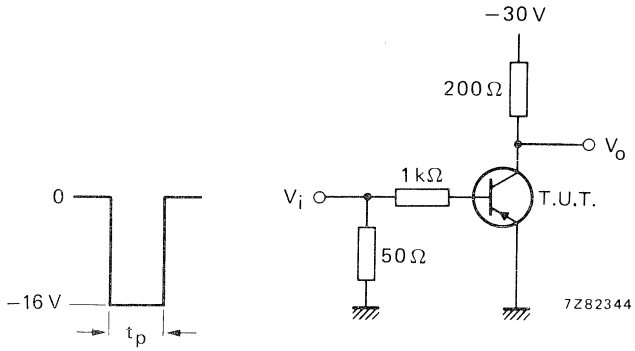


Fig. 3 Turn-on switching time test circuit.

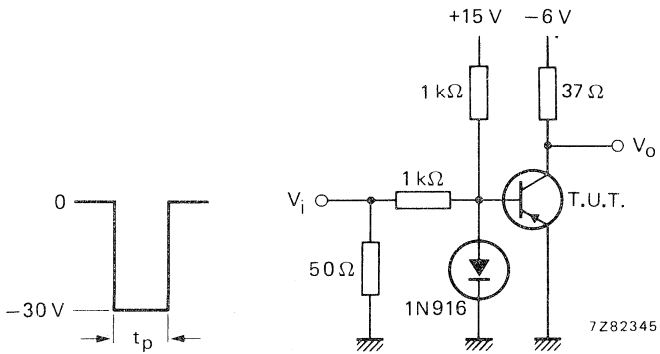


Fig. 4 Turn-off switching time test circuit.

Input pulse generator:	frequency	$f$	=	150	Hz
Fig. 3 and Fig. 4	pulse duration	$t_p$	=	200	ns
	rise time	$t_r$	$\leq$	2	ns
	output impedance	$Z_o$	=	50	$\Omega$
Output oscilloscope:	rise time	$t_r$	$\leq$	5	ns
Fig. 3 and Fig. 4	input impedance	$Z_i$	=	10	M $\Omega$



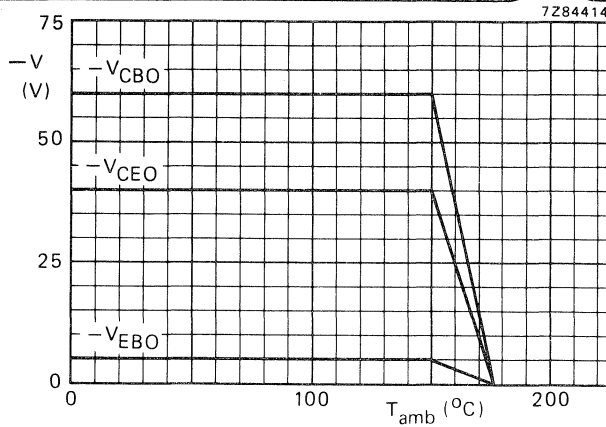


Fig. 5 Voltage derating curves BSR15; R.

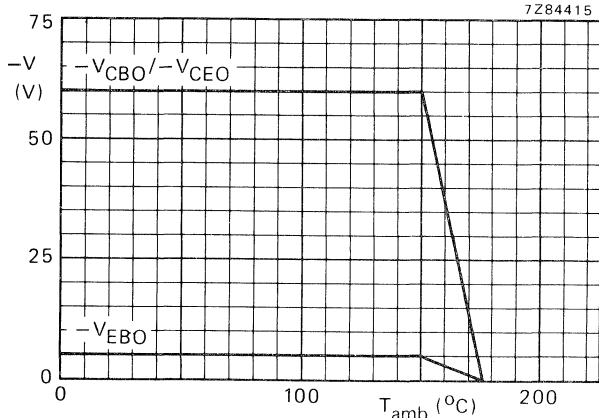


Fig. 6 Voltage derating curves BSR16; R.

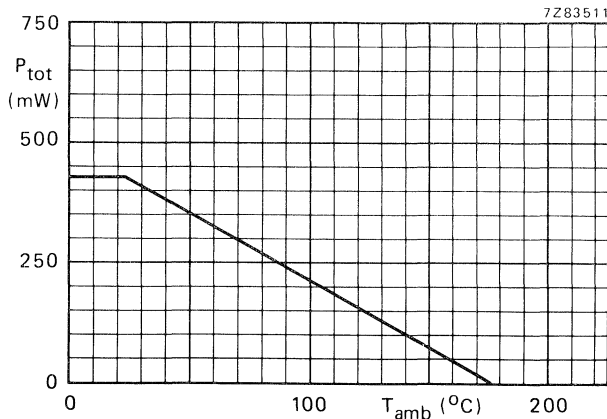


Fig. 7 Power derating curve BSR15; R/BSR16; R.



## SILICON PLANAR EPITAXIAL TRANSISTORS

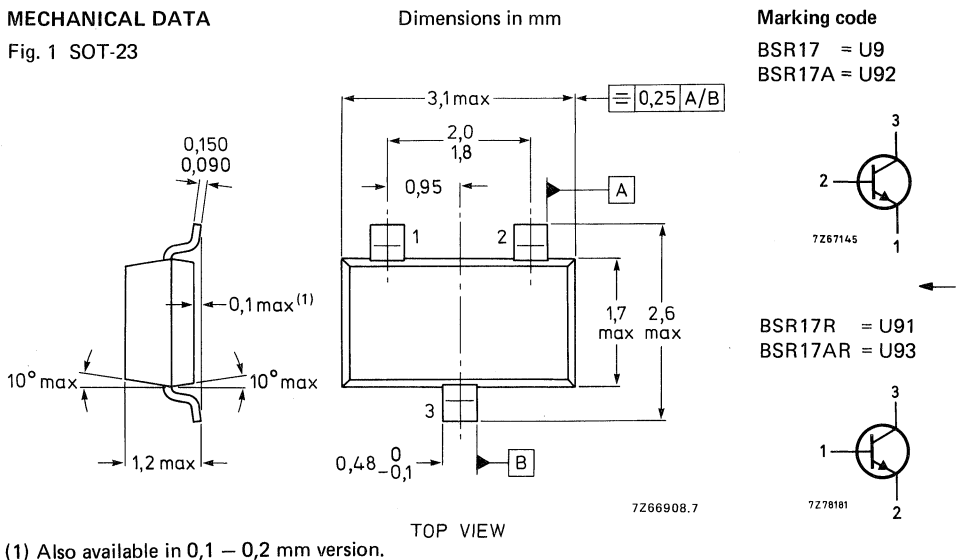
N-P-N silicon transistor in a microminiature plastic envelope intended for switching and linear applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CBO}$	max.	60 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	40 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	6 V
Collector current (d.c.)	$I_C$	max.	200 mA
Total power dissipation up to $T_{amb} = 25^\circ\text{C}$	$P_{tot}$	max.	350 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
D.C. current gain			
$I_C = 10\text{ mA}; V_{CE} = 1\text{ V}$	BSR17;R	$h_{FE}$	50 to 150
$I_C = 10\text{ mA}; V_{CE} = 1\text{ V}$	BSR17A;R	$h_{FE}$	100 to 300
Transition frequency at $f = 500\text{ MHz}$			
$I_C = 10\text{ mA}; V_{CE} = 20\text{ V}$	BSR17;R	$f_T$	> 250 MHz
$I_C = 10\text{ mA}; V_{CE} = 20\text{ V}$	BSR17A;R	$f_T$	> 300 MHz

### MECHANICAL DATA

Fig. 1 SOT-23



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	60 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	40 V
Emitter base voltage (open collector)	$V_{EBO}$	max.	6 V
Collector current (d.c.)	$I_C$	max.	200 mA
Power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}^{**}$	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-55 to + 150 $^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

Collector cut-off current

$$I_E = 0; V_{CB} = 30\text{ V}; T_j = 150\text{ }^\circ\text{C}$$

$$V_{EB} = 3\text{ V}; V_{CE} = 30\text{ V}$$

$I_{CBO}$	<	5 $\mu\text{A}$
$I_{CEX}$	<	50 nA

Base current

with reverse biased emitter junction

$$V_{EB} = 3\text{ V}; V_{CE} = 30\text{ V}$$

$I_{BEX}$	<	50 nA
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Saturation voltages<sup>▲</sup>

$$I_C = 10\text{ mA}; I_B = 1\text{ mA}$$

$V_{CEsat}$	<	200 mV
$V_{BEsat}$		650 to 850 mV
$V_{CEsat}$	<	300 mV
$V_{BEsat}$	<	950 mV

$$I_C = 50\text{ mA}; I_B = 5\text{ mA}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 5\text{ V}$$

$C_c$	<	4 pF
-------	---	------

Emitter capacitance at  $f = 1\text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$$

$C_e$	<	8 pF
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▲ Measured under pulsed conditions; pulse duration  $t_p \leq 300\text{ }\mu\text{s}$ ; duty factor  $\delta \leq 0,02$ .

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

D.C. current gain\*

$I_C = 0,1 \text{ mA}; V_{CE} = 1 \text{ V}$

$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}$

$I_C = 10 \text{ mA}; V_{CE} = 1 \text{ V}$

$I_C = 50 \text{ mA}; V_{CE} = 1 \text{ V}$

$I_C = 100 \text{ mA}; V_{CE} = 1 \text{ V}$

Transition frequency at  $f = 100 \text{ MHz}$

$I_C = 10 \text{ mA}; V_{CE} = 20 \text{ V}$

**h-parameters** (common emitter)

$I_C = 1 \text{ mA}; V_{CE} = 10 \text{ V}; f = 1 \text{ kHz}$

Input impedance

Reverse voltage transfer ratio

Small-signal current gain

Output admittance

Switching times (between 10% and 90% levels)

Turn on time switched to

$I_C = 10 \text{ mA}; I_B = 1 \text{ mA}; V_{EB} = 0,5 \text{ V}$

delay time

rise time

	BSR17	BSR17A
$h_{FE}$	> 20	40
$h_{FE}$	> 35	70
$h_{FE}$	> 50	100
$h_{FE}$	< 150	300
$h_{FE}$	> 30	60
$h_{FE}$	> 15	30
$f_T$	> 250	300 MHz
$h_{ie}$	1 to 8	1 to 10 k $\Omega$
$h_{re}$	0,1 to 5	0,5 to 8 $10^{-4}$
$h_{fe}$	50 to 200	100 to 400
$h_{oe}$	1 to 40	1 to 40 $\mu\text{A/V}$
$t_d$	<	35 ns
$t_r$	<	35 ns

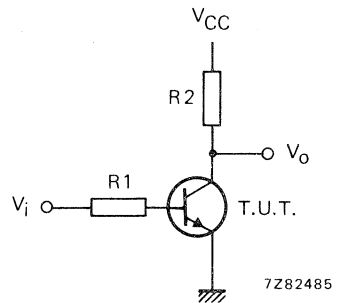
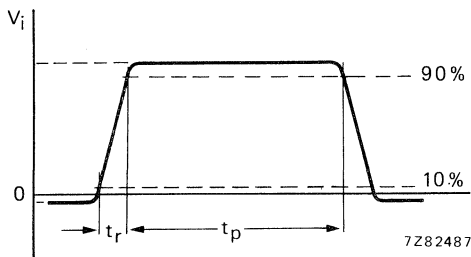


Fig. 2 Delay and rise time equivalent circuit.

$V_i = -0,5 \text{ to } 10,6 \text{ V}; V_{CC} = 3 \text{ V}; R_1 = 10 \text{ k}\Omega; R_2 = 275 \Omega;$

total shunt capacitance of test jig and connectors =  $C_s \leq 4 \text{ pF}$ .

Pulse generator: pulse duration 300 ns; fall time < 1 ns; duty factor 2%.

BSR17;R  
BSR17A;R

Turn off time switched from  
 $I_C = 10 \text{ mA}$ ;  $I_{\text{Bon}} = -I_{\text{Boff}} = 1 \text{ mA}$   
 storage time  
 fall time

	BSR17	BSR17A
$t_s$	< 175	200 ns
$t_f$	< 50	50 ns

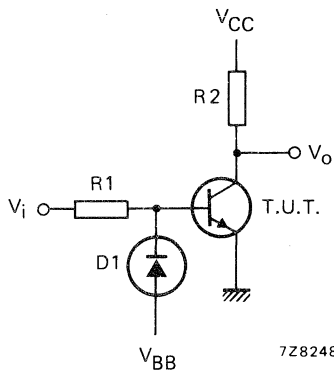
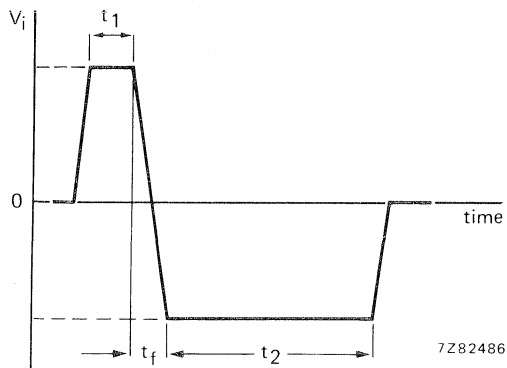


Fig. 3 Storage and fall time equivalent test circuit.

$V_i = -9,1$  to  $+10,9 \text{ V}$ ;  $V_{CC} = 3 \text{ V}$ ;  $V_{BB} = 0 \text{ V}$  (ground);  $R1 = 10 \text{ k}\Omega$ ;  $R2 = 275 \Omega$ ;  
 total shunt capacitance of test jig and connectors =  $C_s \leq 4 \text{ pF}$ .  
 Pulse generator: pulse duration  $t_1 = 10$  to  $500 \mu\text{s}$ ; fall time  $t_f < 1 \text{ ns}$ ; duty factor  $\delta = 2\%$ .

## SILICON LOW-POWER SWITCHING TRANSISTORS

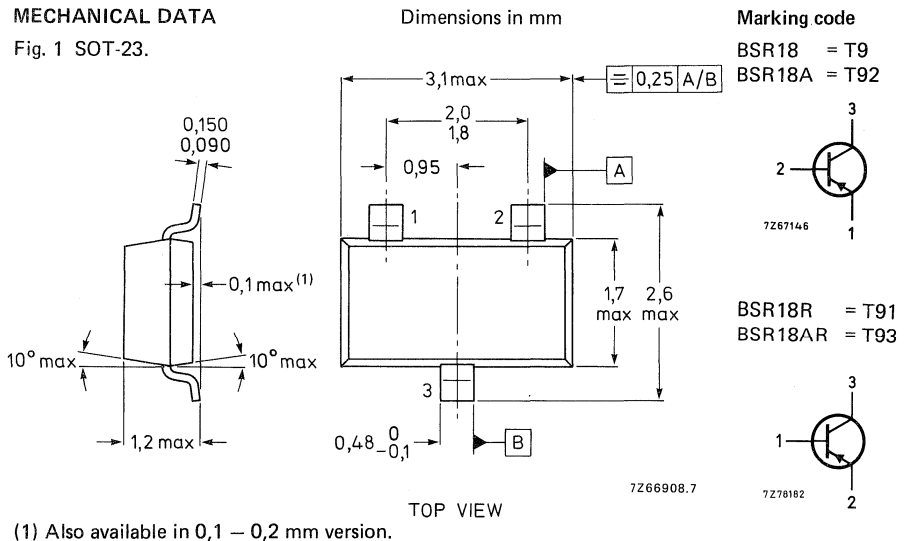
P-N-P silicon transistor in a microminiature plastic envelope, intended for switching and linear applications in thick and thin-film circuits.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	40 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	40 V
Collector current (d.c.)	$-I_C$	max.	200 mA
Total power dissipation up to $T_{amb} = 65^\circ\text{C}$	$P_{tot}$	max.	250 mW
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$
D.C. current gain			
$-I_C = 10\text{ mA}; -V_{CE} = 1\text{ V}$	BSR18; R	$h_{FE}$	50 to 150
$-I_C = 10\text{ mA}; -V_{CE} = 1\text{ V}$	BSR18A; R	$h_{FE}$	100 to 300
Transition frequency at $f = 500\text{ MHz}$			
$-I_C = 10\text{ mA}; -V_{CE} = 20\text{ V}$	BSR18; R	$f_T$	$>$ 200 MHz
$-I_C = 10\text{ mA}; -V_{CE} = 20\text{ V}$	BSR18A; R	$f_T$	$>$ 250 MHz

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	40 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	40 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	200 mA
Total power dissipation up to $T_{amb} \leq 65^\circ\text{C}$	$P_{tot}$	max.	200 mW
Storage temperature	$T_{stg}$		$-55$ to $+150^\circ\text{C}$
Junction temperature	$T_j$	max.	$150^\circ\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_{amb} = 25^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 30\text{ V} \quad -I_{CBO} < 50\text{ nA}$$

Emitter cut-off current

$$I_C = 0; -V_{EB} = 3\text{ V} \quad -I_{EBO} < 50\text{ nA}$$

Saturation voltages  $\Delta$

$$-I_C = 10\text{ mA}; -I_B = 1\text{ mA} \quad \begin{array}{l} -V_{CEsat} < 250\text{ mV} \\ -V_{BEsat} \quad 650\text{ to }850\text{ mV} \end{array}$$

$$-I_C = 50\text{ mA}; -I_B = 5\text{ mA} \quad \begin{array}{l} -V_{CEsat} < 400\text{ mV} \\ -V_{BEsat} < 950\text{ mV} \end{array}$$

Collector capacitance at  $f = 100\text{ kHz}$

$$I_E = I_e = 0; -V_{CB} = 5\text{ V} \quad C_c < 4,5\text{ pF}$$

Emitter capacitance at  $f = 100\text{ kHz}$

$$I_C = I_c = 0; -V_{EB} = 0,5\text{ V} \quad C_e < 10\text{ pF}$$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

$\Delta$  Measured under pulse conditions;  $t_p = 300\text{ }\mu\text{s}$ ;  $\delta = 0,01$ .



D.C. current gain\*

- I<sub>C</sub> = 0,1 mA; -V<sub>CE</sub> = 1 V
- I<sub>C</sub> = 1,0 mA; -V<sub>CE</sub> = 1 V
- I<sub>C</sub> = 10 mA; -V<sub>CE</sub> = 1 V
- I<sub>C</sub> = 50 mA; -V<sub>CE</sub> = 1 V
- I<sub>C</sub> = 100 mA; -V<sub>CE</sub> = 1 V

Transition frequency at f = 100 MHz

- I<sub>C</sub> = 10 mA; -V<sub>CE</sub> = 20 V

Noise figure at R<sub>S</sub> = 1 kΩ

- I<sub>C</sub> = 100 μA; -V<sub>CE</sub> = 5 V
- f = 10 to 15 700 Hz

h parameters (common emitter) at f = 1 kHz

- I<sub>C</sub> = 1 mA; -V<sub>CE</sub> = 10 V
- input impedance
- reverse voltage transfer ratio
- small signal current gain
- output admittance

Switching times (between 10% and 90% levels)

- I<sub>C</sub> = 10 mA; -I<sub>Bon</sub> = +I<sub>Boff</sub> = 1 mA
- delay time
- rise time

	BSR18	BSR18A
h <sub>FE</sub> >	30	60
h <sub>FE</sub> >	40	80
h <sub>FE</sub>	50 to 150	100 to 300
h <sub>FE</sub> >	30	60
h <sub>FE</sub> >	15	30
f <sub>T</sub> >	200	250 MHz
F <	5	4 dB
h <sub>ie</sub>	0,5 to 8	2 to 12 kΩ
h <sub>re</sub>	0,1 to 5.10 <sup>-4</sup>	1 to 10.10 <sup>-4</sup>
h <sub>fe</sub>	50 to 200	100 to 400
h <sub>oe</sub>	1 to 40	3 to 60 μΩ <sup>-1</sup>

t <sub>d</sub> <	35 ns
t <sub>r</sub> <	35 ns

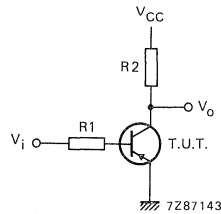
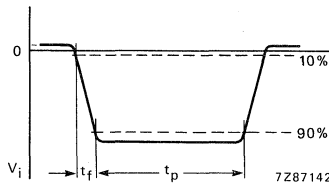


Fig. 2 Waveform and test circuit delay and rise time.

V<sub>i</sub> = +0,5 to -10,6 V; -V<sub>CC</sub> = 3 V; R<sub>1</sub> = 10 kΩ; R<sub>2</sub> = 275 Ω.

Total shunt capacitance of test jig and connectors = C<sub>s</sub> ≤ 4 pF.

Pulse generator: pulse duration 300 ns; fall time < 1 ns; duty factor 2%.

BSR18; R  
BSR18A; R

Switching times (between 10% and 90% levels)  
 $-I_C = 10 \text{ mA}$ ,  $-I_{\text{Bon}} = I_{\text{Boff}} = 1 \text{ mA}$   
 storage time  
 fall time

	BSR18	BSR18A
$t_s$	< 200	225 ns
$t_r$	< 60	75 ns

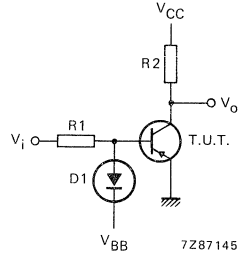
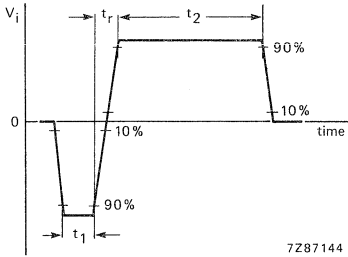


Fig. 3 Waveform and test circuit fall and storage time.

$V_i = -9,1 \text{ to } +10,9 \text{ V}$ ;  $V_{CC} = 3 \text{ V}$ ;  $V_{BB} = 0 \text{ V}$  (ground);  $R_1 = 10 \text{ k}\Omega$ ;  $R_2 = 275 \Omega$ ;  $D_1 = 1N916$ .

Total shunt capacitance of test jig and connectors =  $C_s \leq 4 \text{ pF}$ .

Pulse generator: pulse duration  $t_1 = 10 \text{ to } 500 \mu\text{s}$ ; rise time  $t_r < 1 \text{ ns}$ ; duty factor  $\delta = 2\%$ .

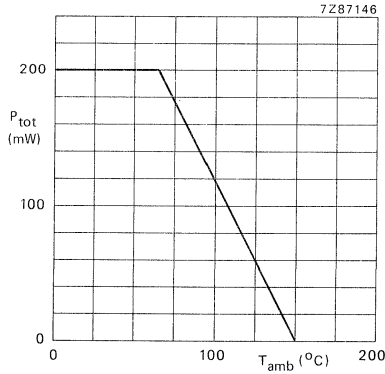


Fig. 4 Power derating curve.

## SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors in miniature plastic envelopes intended for application in thick and thin-film circuits. They are intended for use in telephony and general industrial applications.

## QUICK REFERENCE DATA

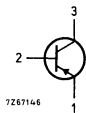
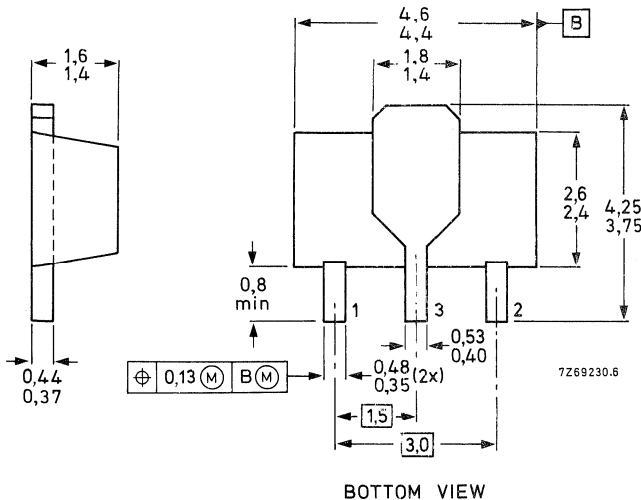
		BSR30	BSR31	BSR32	BSR33
Collector-base voltage (open emitter)	$-V_{CBO}$ max.	70	70	90	90 V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	60	60	80	80 V
Collector current (d.c.)	$-I_C$ max.	1	1	1	1 A
Total power dissipation up to $T_{amb} = 25^\circ\text{C}$	$P_{tot}$ max.	1	1	1	1 W
Junction temperature	$T_j$ max.	150	150	150	150 $^\circ\text{C}$
D.C. current gain					
$-I_C = 100\text{ mA}; -V_{CE} = 5\text{ V}$	$h_{FE} >$	40	100	40	100
	$h_{FE} <$	120	300	120	300
Transition frequency at $f = 35\text{ MHz}$					
$-I_C = 50\text{ mA}; -V_{CE} = 10\text{ V}$	$f_T >$	100	100	100	100 MHz

## MECHANICAL DATA

Dimensions in mm

Mark

Fig. 1 SOT-89.



See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

**Voltages**

			BSR30	BSR31	BSR32	BSR33
Collector-base voltage (open emitter)	$-V_{CBO}$	max.	70	70	90	90 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	60	60	80	80 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5	5	5	5 V

**Currents**

Collector current (d.c.)	$-I_C$	max.			1	A
Base current (d.c.)	$-I_B$	max.			0,1	A

**Power dissipation**

Total power dissipation up to  $T_{amb} = 25\text{ }^\circ\text{C}$   
 mounted on a ceramic substrate  
 area = 2,5 cm<sup>2</sup>; thickness = 0,7 mm

$P_{tot}$	max.			1		W
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**Temperatures**

Storage temperature	$T_{stg}$			-65 to +150		$^\circ\text{C}$
Junction temperature	$T_j$	max.		150		$^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to collector tab	$R_{th\ j-tab}$	=			10	$^\circ\text{C/W}$
From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm <sup>2</sup> ; thickness = 0,7 mm	$R_{th\ j-a}$	=			125	$^\circ\text{C/W}$

## CHARACTERISTICS

$T_{amb} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified

## Collector cut-off current

$I_E = 0; -V_{CB} = 60\text{ V}$	$-I_{CBO}$	<	100	nA
$I_E = 0; -V_{CB} = 60\text{ V}; T_j = 150\text{ }^{\circ}\text{C}$	$-I_{CBO}$	<	50	$\mu\text{A}$

## Breakdown voltages

			BSR30	BSR31	BSR32	BSR33	
$I_B = 0; -I_C = 10\text{ mA}$	$-V_{(BR)CEO}$	>	60	60	80	80	V
$V_{BE} = 0; -I_C = 10\text{ }\mu\text{A}$	$-V_{(BR)CES}$	>	70	70	90	90	V
$I_C = 0; -I_E = 10\text{ }\mu\text{A}$	$-V_{(BR)EBO}$	>	5	5	5	5	V

## Saturation voltages \*

$-I_C = 150\text{ mA}; -I_B = 15\text{ mA}$	$-V_{CEsat}$	<	0,25	0,25	0,25	0,25	V
	$-V_{BEsat}$	<	1,0	1,0	1,0	1,0	V
$-I_C = 500\text{ mA}; -I_B = 50\text{ mA}$	$-V_{CEsat}$	<	0,5	0,5	0,5	0,5	V
	$-V_{BEsat}$	<	1,2	1,2	1,2	1,2	V

## D.C. current gain \*

$-I_C = 100\text{ }\mu\text{A}; V_{CE} = 5\text{ V}$	$h_{FE}$	>	10	30	10	30
$-I_C = 100\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE}$	>	40	100	40	100
	$h_{FE}$	<	120	300	120	300
$-I_C = 500\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE}$	>	30	50	30	50

Transition frequency at  $f = 35\text{ MHz}$ 

$-I_C = 50\text{ mA}; -V_{CE} = 10\text{ V}$	$f_T$	>	100	MHz
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Collector capacitance at  $f = 1\text{ MHz}$ 

$I_E = I_e = 0; -V_{CB} = 10\text{ V}$	$C_c$	<	20	pF
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Emitter capacitance at  $f = 1\text{ MHz}$ 

$I_C = I_c = 0; -V_{EB} = 0,5\text{ V}$	$C_e$	<	120	pF
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Switching times see next page.

\* Measured under pulse conditions:  $t_p = 300\text{ }\mu\text{s}; \delta < 0,01$ .

CHARACTERISTICS (continued)

$T_{amb} = 25\text{ }^{\circ}\text{C}$

Switching times

$-I_{Con} = 100\text{ mA}; -I_{Bon} = +I_{Boff} = 5\text{ mA}$

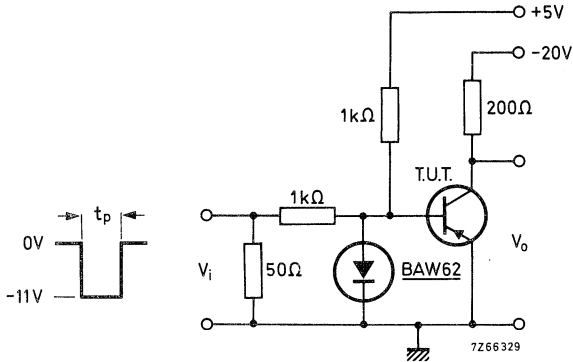
Turn-on time

$t_{on} < 500\text{ ns}$

Turn-off time

$t_{off} < 650\text{ ns}$

Test circuit



Pulse generator:

Pulse duration  $t_p = 10\text{ }\mu\text{s}$

Rise time  $t_r \leq 15\text{ ns}$

Fall time  $t_f \leq 15\text{ ns}$

Source impedance  $Z_S = 50\text{ }\Omega$

Oscilloscope:

Rise time  $t_r \leq 15\text{ ns}$

Input impedance  $Z_I \geq 100\text{ k}\Omega$

## SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors in miniature plastic envelopes intended for application in thick and thin-film circuits. They are intended for use in telephony and general industrial applications.

### QUICK REFERENCE DATA

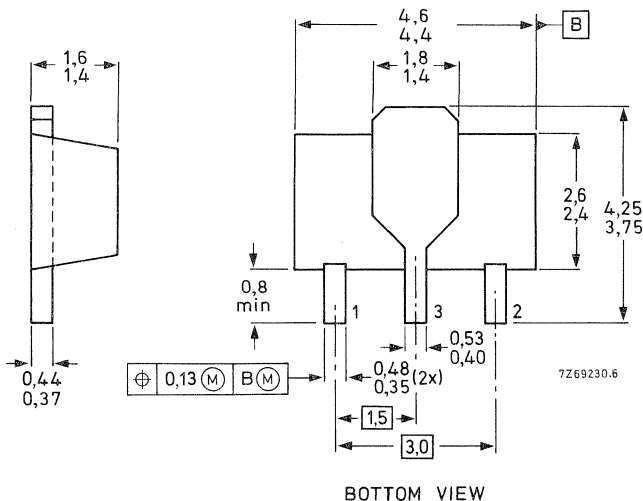
		BSR40	BSR41	BSR42	BSR43
Collector-base voltage (open emitter)	$V_{CBO}$ max.	70	70	90	90 V
Collector-emitter voltage (open base)	$V_{CEO}$ max.	60	60	80	80 V
Collector current (d.c.)	$I_C$ max.	1	1	1	1 A
Total power dissipation up to $T_{amb} = 25^\circ\text{C}$	$P_{tot}$ max.	1	1	1	1 W
Junction temperature	$T_j$ max.	150	150	150	150 $^\circ\text{C}$
D.C. current gain	$h_{FE}$	> 40	100	40	100
$I_C = 100\text{ mA}; V_{CE} = 5\text{ V}$		< 120	300	120	300
Transition frequency at $f = 35\text{ MHz}$	$f_T$	> 100	100	100	100 MHz
$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$					

### MECHANICAL DATA

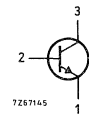
Dimensions in mm

Mark

Fig. 1 SOT-89.



BSR40  
BSR41  
BSR42  
BSR43



## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

## Voltages

			BSR40	BSR41	BSR42	BSR43
Collector-base voltage (open emitter)	$V_{CBO}$	max.	70	70	90	90 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	60	60	80	80 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	5	5	5	5 V

## Currents

Collector current (d.c.)	$I_C$	max.			1	A
Base current (d.c.)	$I_B$	max.			0,1	A

## Power dissipation

Total power dissipation up to  $T_{amb} = 25\text{ }^{\circ}\text{C}$ 

mounted on a ceramic substrate

area = 2,5 cm<sup>2</sup>; thickness = 0,7 mm

$P_{tot}$	max.		1	W
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## Temperatures

Storage temperature	$T_{stg}$		-65 to +150	$^{\circ}\text{C}$
Junction temperature	$T_j$	max.	150	$^{\circ}\text{C}$

## THERMAL RESISTANCE

From junction to collector tab	$R_{th\ j-tab}$	=		10	$^{\circ}\text{C}/\text{W}$
From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm <sup>2</sup> ; thickness = 0,7 m	$R_{th\ j-a}$	=		125	$^{\circ}\text{C}/\text{W}$



**CHARACTERISTICS**

$T_{amb} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified

**Collector cut-off current**

$I_E = 0; V_{CB} = 60\text{ V}$	$I_{CBO}$	<	100	nA
$I_E = 0; V_{CB} = 60\text{ V}; T_j = 150\text{ }^{\circ}\text{C}$	$I_{CBO}$	<	50	$\mu\text{A}$

**Breakdown voltages**

			BSR40	BSR41	BSR42	BSR43	
$I_B = 0; I_C = 10\text{ mA}$	$V_{(BR)CEO}$	>	60	60	80	80	V
$V_{BE} = 0; I_C = 10\text{ }\mu\text{A}$	$V_{(BR)CES}$	>	70	70	90	90	V
$I_C = 0; I_E = 10\text{ }\mu\text{A}$	$V_{(BR)EBO}$	>	5	5	5	5	V

**Saturation voltages \***

$I_C = 150\text{ mA}; I_B = 15\text{ mA}$	$V_{CEsat}$	<	0,25	0,25	0,25	0,25	V
	$V_{BEsat}$	<	1,0	1,0	1,0	1,0	V
$I_C = 500\text{ mA}; I_B = 50\text{ mA}$	$V_{CEsat}$	<	0,5	0,5	0,5	0,5	V
	$V_{BEsat}$	<	1,2	1,2	1,2	1,2	V

**D.C. current gain \***

$I_C = 100\text{ }\mu\text{A}; V_{CE} = 5\text{ V}$	$h_{FE}$	>	10	30	10	30
$I_C = 100\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE}$	>	40	100	40	100
	$h_{FE}$	<	120	300	120	300
$I_C = 500\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE}$	>	30	50	30	50

**Transition frequency at  $f = 35\text{ MHz}$** 

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$	$f_T$	>	100	MHz
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**Collector capacitance at  $f = 1\text{ MHz}$** 

$I_E = I_e = 0; V_{CB} = 10\text{ V}$	$C_c$	<	12	pF
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**Emitter capacitance at  $f = 1\text{ MHz}$** 

$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$	$C_e$	<	90	pF
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Switching times see next page.

\* Measured under pulse conditions:  $t_p = 300\text{ }\mu\text{s}; \delta < 0,01$ .

CHARACTERISTICS (continued)

$T_{amb} = 25\text{ }^{\circ}\text{C}$

Switching times

$I_{Con} = 100\text{ mA}; I_{Bon} = -I_{Boff} = 5\text{ mA}$

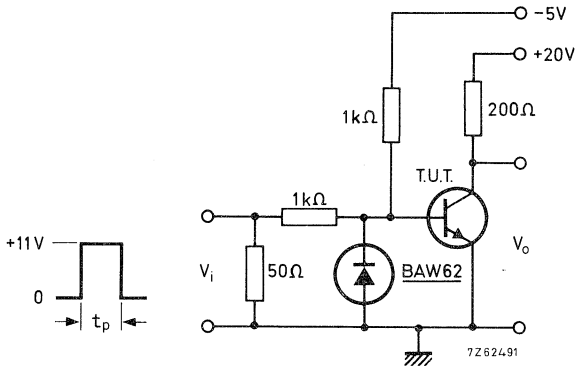
Turn-on time

$t_{on} < 250\text{ ns}$

Turn-off time

$t_{off} < 1000\text{ ns}$

Test circuit



Pulse generator:

Pulse duration  $t_p = 10\text{ }\mu\text{s}$   
 Rise time  $t_r \leq 15\text{ ns}$   
 Fall time  $t_f \leq 15\text{ ns}$   
 Source impedance  $Z_S = 50\text{ }\Omega$

Oscilloscope:

Rise time  $t_r \leq 15\text{ ns}$   
 Input impedance  $Z_I \geq 100\text{ k}\Omega$

## N-CHANNEL FETS

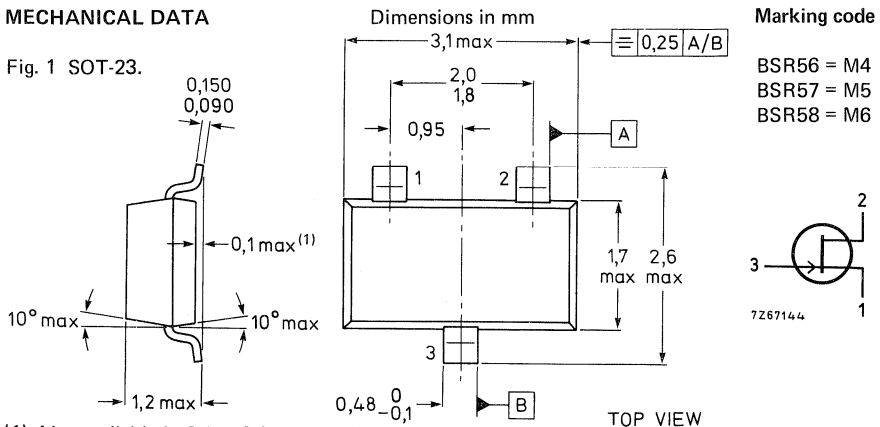
Silicon n-channel depletion type junction field-effect transistors in a plastic microminiature envelope intended for application in thick and thin-film circuits. The transistors are intended for low-power, chopper or switching applications in industrial service.

### QUICK REFERENCE DATA

		BSR56	BSR57	BSR58
Drain-source voltage	$\pm V_{DS}$	max. 40	40	40 V
Total power dissipation up to $T_{amb} = 65^\circ C$	$P_{tot}$	max. 250	250	250 mW
Drain current $V_{DS} = 15 V; V_{GS} = 0$	$I_{DSS}$	> 50	20	8 mA
		< -	100	80 mA
Gate-source cut-off voltage $V_{DS} = 15 V; I_D = 0,5 nA$	$-V_{(P)GS}$	> 4	2	0,8 V
		< 10	6	4 V
Drain-source resistance (on) at $f = 1 kHz$ $I_D = 0; V_{GS} = 0$	$r_{ds on}$	< 25	40	60 $\Omega$
		< 5	5	5 pF
Feedback capacitance at $f = 1 MHz$ $-V_{GS} = 10 V; V_{DS} = 0$	$C_{rs}$	< 5	5	5 pF
		Turn-off time		
$V_{DD} = 10 V; V_{GS} = 0$ $I_D = 20 mA; -V_{GSM} = 10 V$	$t_{off}$	< 25	-	- ns
		$I_D = 10 mA; -V_{GSM} = 6 V$	< -	50
$I_D = 5 mA; -V_{GSM} = 4 V$	$t_{off}$	< -	-	100 ns

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 - 0,2 mm version.  
See also *Soldering Recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage (See Fig. 4)	$\pm V_{DS}$	max.	40 V
Drain-gate voltage (See Fig. 4)	$V_{DGO}$	max.	40 V
Gate-source voltage (See Fig. 4)	$-V_{GSO}$	max.	40 V
Forward gate current	$I_{GF}$	max.	50 mA
Total power dissipation up to $T_{amb} = 65\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	250 mW
Storage temperature	$T_{stg}$		-55 to + 175 $^{\circ}\text{C}$
Junction temperature	$T_j$	max.	175 $^{\circ}\text{C}$

**THERMAL CHARACTERISTICS\***

$$T_j = P (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_{amb} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified

Gate-source cut-off current

$$V_{DS} = 0\text{ V}; -V_{GS} = 20\text{ V} \quad -I_{GSS} < 1 \text{ nA}$$

Drain cut-off current

$$V_{DS} = 15\text{ V}; -V_{GS} = 10\text{ V} \quad I_{DSX} < 1 \text{ nA}$$

		BSR56	BSR57	BSR58
Drain current $\Delta$ $V_{DS} = 15\text{ V}; V_{GS} = 0$	$I_{DSS} >$	50	20	8 mA
	$I_{DSS} <$	—	100	80 mA
Gate-source breakdown voltage $-I_G = 1\text{ }\mu\text{A}; V_{DS} = 0$	$-V_{(BR)GSS} >$	40	40	40 V
Gate-source cut-off voltage $I_D = 0,5\text{ nA}; V_{DS} = 15\text{ V}$	$-V_{(P)GS} >$	4	2	0,8 V
	$-V_{(P)GS} <$	10	6	4 V
Drain-source voltage (on) $I_D = 20\text{ mA}; V_{GS} = 0$ $I_D = 10\text{ mA}; V_{GS} = 0$ $I_D = 5\text{ mA}; V_{GS} = 0$	$V_{DSon} <$	750	—	— mV
	$V_{DSon} <$	—	500	— mV
	$V_{DSon} <$	—	—	400 mV
Drain-source resistance (on) at $f = 1\text{ kHz}$ $I_D = 0; V_{GS} = 0$	$r_{ds\ on} <$	25	40	60 $\Omega$

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

$\Delta$  Measured under pulsed conditions;  $t_p = 100\text{ ms}; \delta \leq 0,1$ .

Switching times\*

$V_{DD} = 10\text{ V}; V_{GS} = 0$   
Conditions  $I_D$  and  $-V_{GSM}$

Delay time  
Rise time  
Turn-off time

$I_D$   
 $-V_{GSM}$   
 $t_d$   
 $t_r$   
 $t_{off}$

	BSR56	BSR57	BSR58
$I_D$	= 20	10	5 mA
$-V_{GSM}$	= 10	6	4 V
Delay time	$t_d < 6$	6	10 ns
Rise time	$t_r < 3$	4	10 ns
Turn-off time	$t_{off} < 25$	50	100 ns

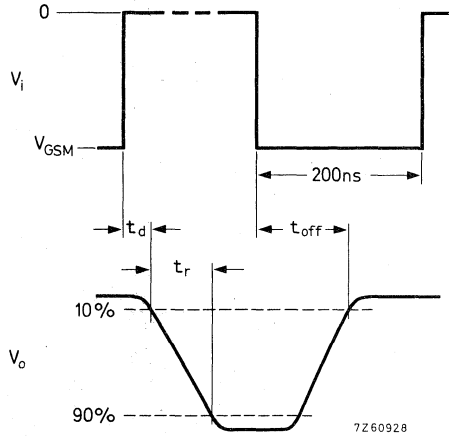


Fig. 2 Switching times waveforms.

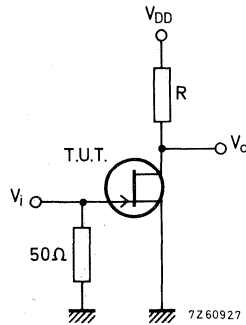


Fig. 3 Test circuit.

BSR56;  $R = 464\ \Omega$   
BSR57;  $R = 953\ \Omega$   
BSR58;  $R = 1910\ \Omega$

Pulse generator

$t_r = t_f \leq 1\text{ ns}$   
 $\delta = 0,02$   
 $Z_o = 50\ \Omega$

Oscilloscope

$t_r \leq 0,75\text{ ns}$   
 $R_i \geq 1\text{ M}\Omega$   
 $C_i \leq 2,5\text{ pF}$

\* Switching times measured on devices in SOT-18 envelope.

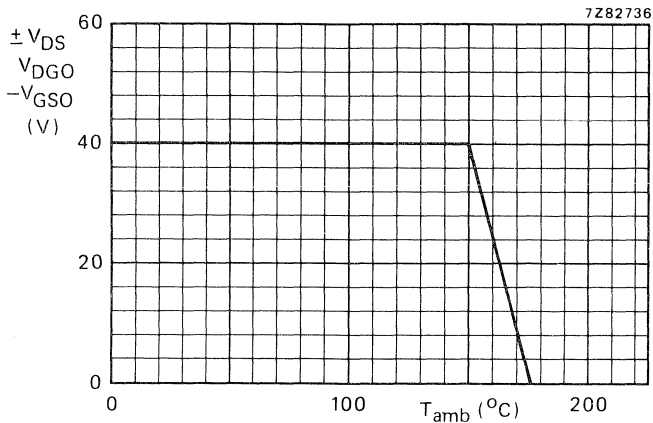


Fig. 4 Voltage derating curve.

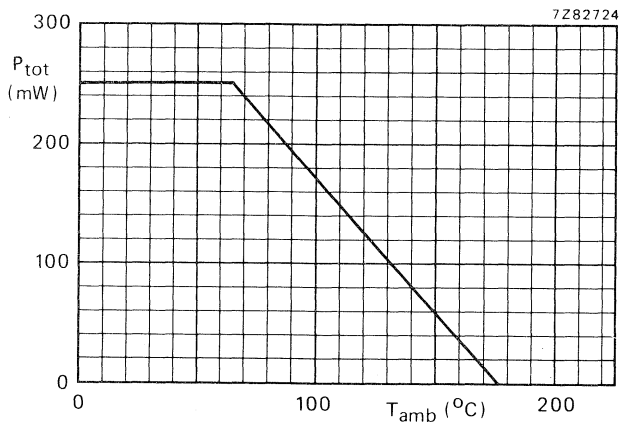


Fig. 5 Power derating curve.

## HIGH VOLTAGE P-N-P TRANSISTORS

Silicon planar epitaxial transistor in a microminiature plastic envelope intended for application in thick and thin-film circuits. This transistor is intended for high voltage general purpose and switching applications.

### QUICK REFERENCE DATA

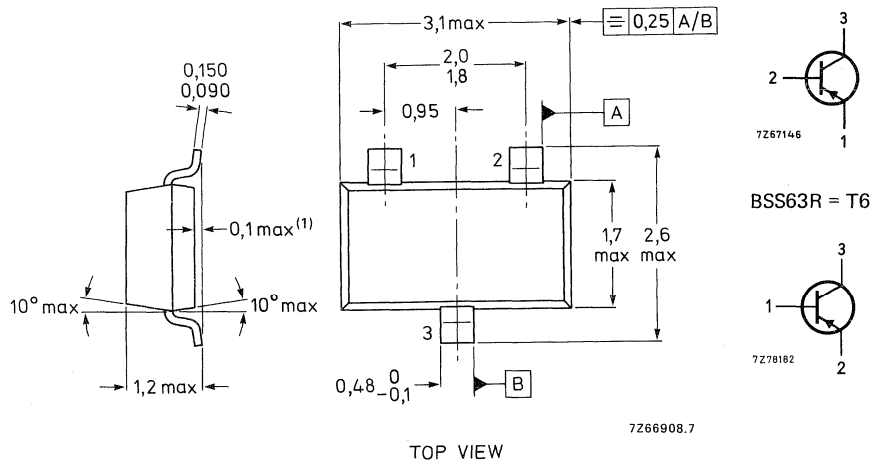
Collector-base voltage (open emitter)	$-V_{CBO}$ max.	110 V
Collector-emitter voltage (open base)	$-V_{CEO}$ max.	100 V
Collector current (peak value)	$-I_{CM}$ max.	100 mA
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$P_{tot}$ max.	350 mW
Junction temperature	$T_j$ max.	175 $^{\circ}\text{C}$
D.C. current gain at $T_j = 25\text{ }^{\circ}\text{C}$ $-I_C = 25\text{ mA}; -V_{CE} = 5\text{ V}$	$h_{FE}$	$> 30$
Transition frequency at $f = 35\text{ MHz}$ $-I_C = 25\text{ mA}; -V_{CE} = 5\text{ V}$	$f_T$	$> 50\text{ MHz}$ typ. 85 MHz

### MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 6			
$-I_C = 10 \mu A$	$-V_{CBO}$	max.	110 V
Collector-emitter voltage (open base) see Fig. 6			
$-I_C = 100 \mu A$	$-V_{CEO}$	max.	100 V
Emitter-base voltage (open collector) see Fig. 6			
$-I_E = 10 \mu A$	$-V_{EBO}$	max.	6 V
Collector current (d.c.)	$-I_C$	max.	100 mA
Collector current (peak value)	$-I_{CM}$	max.	100 mA
Base current (peak value)	$-I_{BM}$	max.	100 mA
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ **	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-65 to + 175 $^\circ\text{C}$
Junction temperature	$T_j$	max.	175 $^\circ\text{C}$

**THERMAL CHARACTERISTICS \***

$$T_j = P_x (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th j-t}$	=	50 K/W
From tab to soldering points	$R_{th t-s}$	=	280 K/W
From soldering points to ambient **	$R_{th s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25 \text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current			
$I_E = 0; -V_{CB} = 90 \text{ V}$	$-I_{CBO}$	<	100 nA
$I_E = 0; -V_{CB} = 90 \text{ V}; T_j = 150 \text{ }^\circ\text{C}$	$-I_{CBO}$	<	50 $\mu A$
Emitter cut-off current			
$I_C = 0; -V_{EB} = 6 \text{ V}$	$-I_{EBO}$	<	200 nA
Saturation voltage			
$-I_C = 25 \text{ mA}; -I_B = 2,5 \text{ mA}$	$-V_{CEsat}$	<	250 mV
	$-V_{BEsat}$	<	900 mV
D.C. current gain			
$-I_C = 10 \text{ mA}; -V_{CE} = 1 \text{ V}$	$h_{FE}$	>	30
$-I_C = 25 \text{ mA}; -V_{CE} = 1 \text{ V}$	$h_{FE}$	>	30
Collector capacitance at $f = 1 \text{ MHz}$			
$I_E = I_e = 0; -V_{CB} = 10 \text{ V}$	$C_c$	typ.	3 pF
Transition frequency at $f = 35 \text{ MHz}$			
$-I_C = 25 \text{ mA}; -V_{CE} = 5 \text{ V}$	$f_T$	>	50 MHz
		typ.	85 MHz

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.



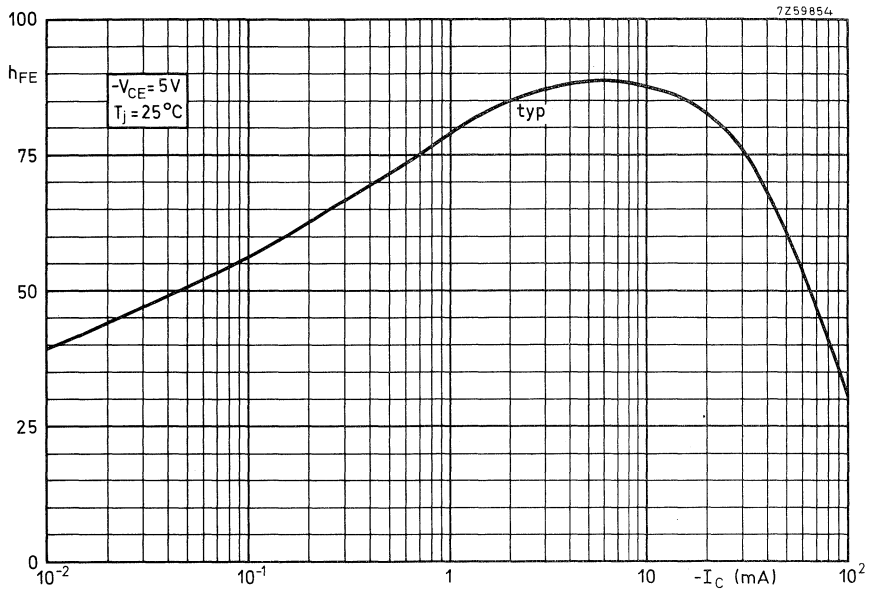


Fig. 2.

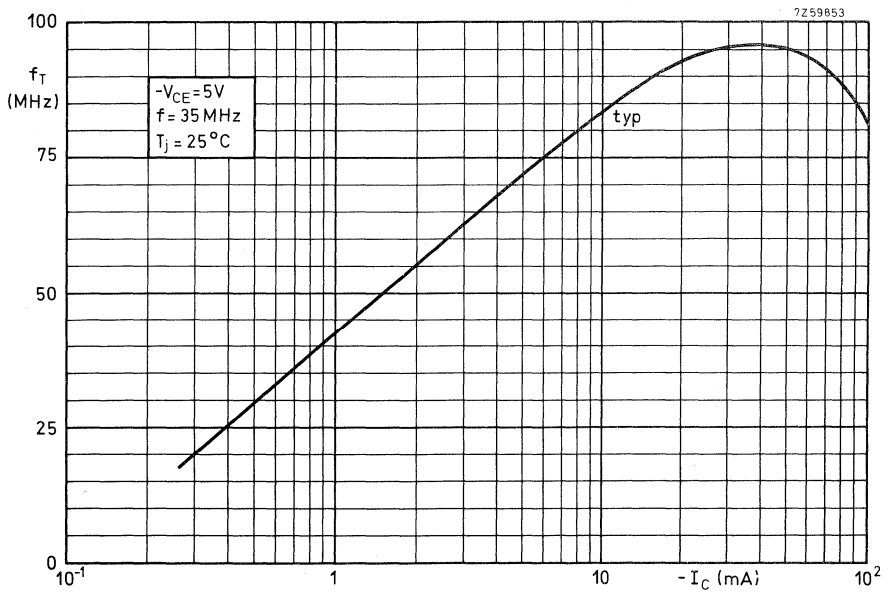


Fig. 3.

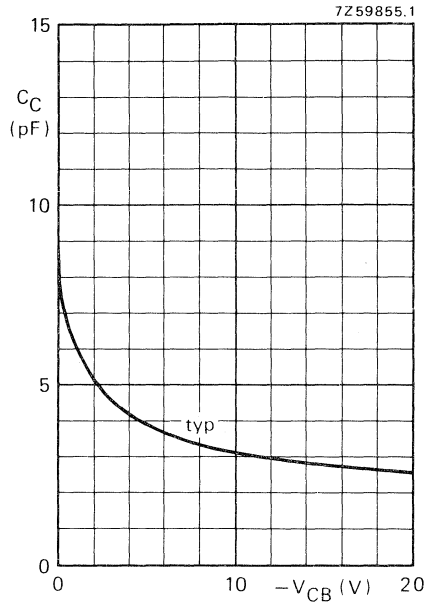


Fig. 4 Typical values collector capacitance as a function of collector-base voltage.  
 $I_E = I_e = 0$ ;  $T_j = 25^\circ\text{C}$ ;  $f = 1\text{ MHz}$ .

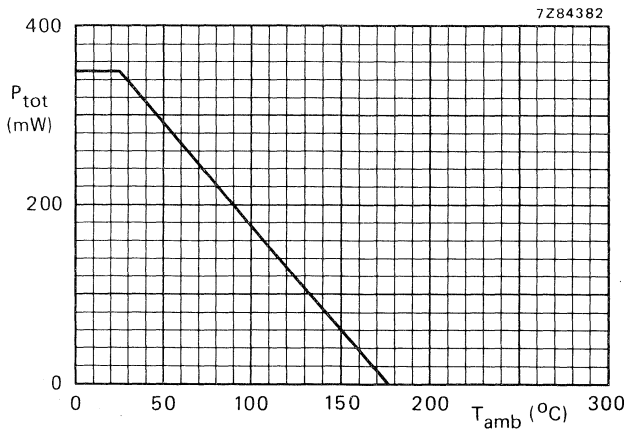


Fig. 5 Power derating curve.

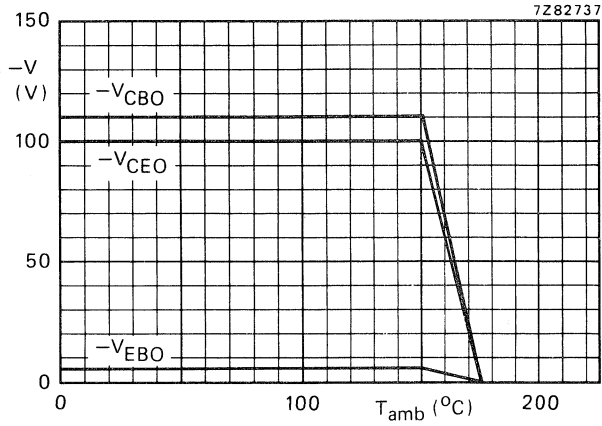


Fig. 6 Voltage derating curves.

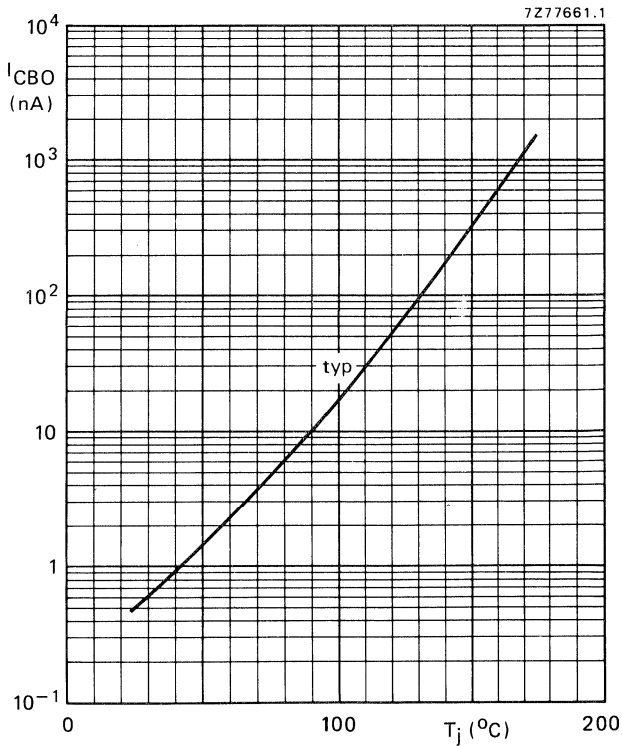


Fig. 7 Typical values collector-base currents as a function of the junction temperature at a collector-base voltage of 90 V.



## HIGH VOLTAGE N-P-N TRANSISTORS

Silicon planar epitaxial transistor in a microminiature plastic envelope intended for application in thick and thin-film circuits. This transistor is intended for high-voltage general purpose and switching applications.

### QUICK REFERENCE DATA

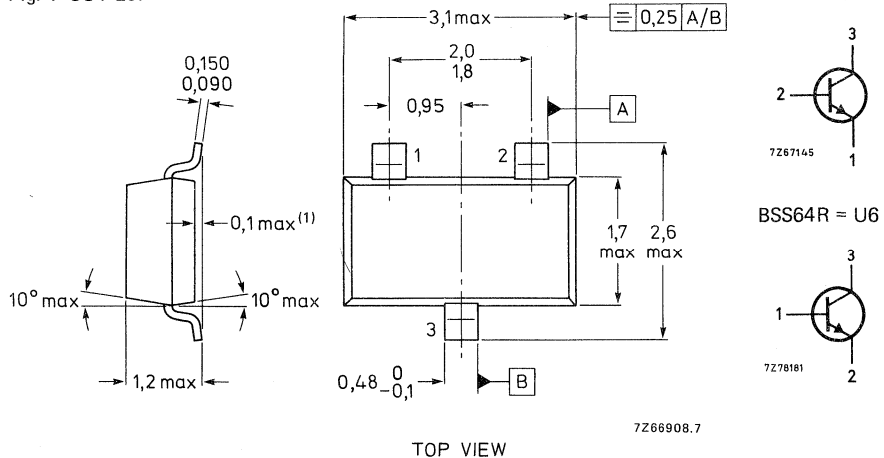
Collector-base voltage (open emitter)	$V_{CBO}$	max.	120 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	80 V
Collector current (peak value)	$I_{CM}$	max.	250 mA
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	350 mW
Junction temperature	$T_j$	max.	175 $^{\circ}\text{C}$
D.C. current gain			
$I_C = 10\text{ mA}; V_{CE} = 1\text{ V}; T_j = 25\text{ }^{\circ}\text{C}$	$h_{FE}$	>	20
		typ.	80
Transition frequency at $f = 35\text{ MHz}$			
$I_C = 4\text{ mA}; V_{CE} = 10\text{ V}$	$f_T$	>	60 MHz
Turn-off time			
$I_C = 15\text{ mA}; I_{Bon} = -I_{Boff} = 1\text{ mA}$	$t_{off}$	<	1 $\mu\text{s}$

### MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version.

See also *Soldering recommendations*.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 2 $I_C = 100 \mu A$	$V_{CBO}$	max.	120 V
Collector-emitter voltage (open base) see Fig. 2 $I_C = 4 \text{ mA}$	$V_{CEO}$	max.	80 V
Emitter-base voltage (open collector) see Fig. 2 $I_E = 100 \mu A$	$V_{EBO}$	max.	5 V
Collector current (d.c. or averaged over any 20 ms period)	$I_C$	max.	100 mA
Collector current (peak value)	$I_{CM}$	max.	250 mA
Base current (peak value)	$I_{BM}$	max.	100 mA
Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ **	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$		-65 to +175 $^\circ\text{C}$
Junction temperature	$T_j$	max.	175 $^\circ\text{C}$

**THERMAL CHARACTERISTICS \***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

**Thermal resistance**

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient **	$R_{th\ s-a}$	=	90 K/W

**CHARACTERISTICS**

$T_j = 25 \text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current $I_E = 0; V_{CB} = 90 \text{ V}$	$I_{CBO}$	<	100 nA
$I_E = 0; V_{CB} = 90 \text{ V}; T_j = 150 \text{ }^\circ\text{C}$	$I_{CBO}$	<	50 $\mu A$
Emitter cut-off current $I_C = 0; V_{EB} = 5 \text{ V}$	$I_{EBO}$	typ. <	0,5 nA 200 nA
Saturation voltages $I_C = 4 \text{ mA}; I_B = 400 \mu A$	$V_{CEsat}$	<	150 mV
	$V_{BEsat}$	<	1200 mV
$I_C = 50 \text{ mA}; I_B = 15 \text{ mA}$	$V_{CEsat}$	<	200 mV
D.C. current gain $I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}$	$h_{FE}$	typ.	60
$I_C = 10 \text{ mA}; V_{CE} = 1 \text{ V}$	$h_{FE}$	> typ.	20 80
$I_C = 20 \text{ mA}; V_{CE} = 1 \text{ V}$	$h_{FE}$	typ.	55

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

Transition frequency at  $f = 35$  MHz

$I_C = 4$  mA;  $V_{CE} = 10$  V

$f_T$	>	60 MHz
	typ.	100 MHz

Collector capacitance at  $f = 1$  MHz

$I_E = I_e = 0$ ;  $V_{CB} = 10$  V

$C_c$	typ.	3 pF
	<	5 pF

Turn-off switching time

$I_{Con} = 15$  mA;  $I_{Bon} = -I_{Boff} = 1$  mA

$t_{off}$	<	1 $\mu$ s
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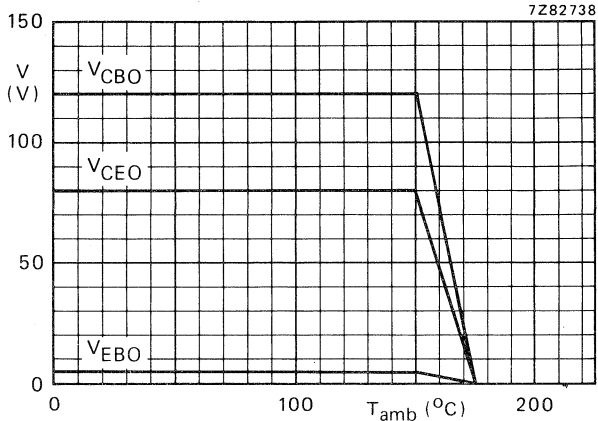


Fig. 2 Voltage derating curves.

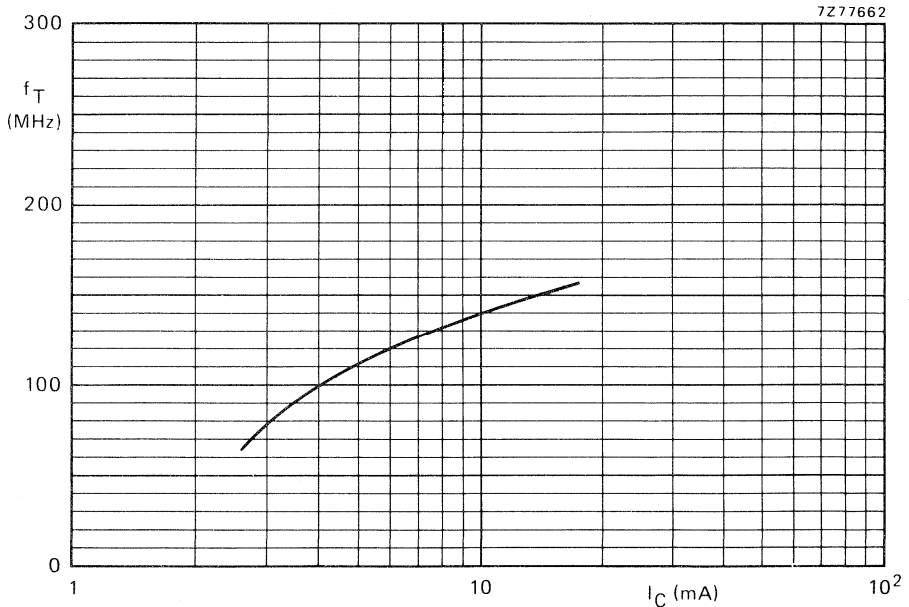


Fig. 3 Typical values transition frequency.  $V_{CE} = 10$  V;  $f = 35$  MHz;  $T_j = 25$  °C.

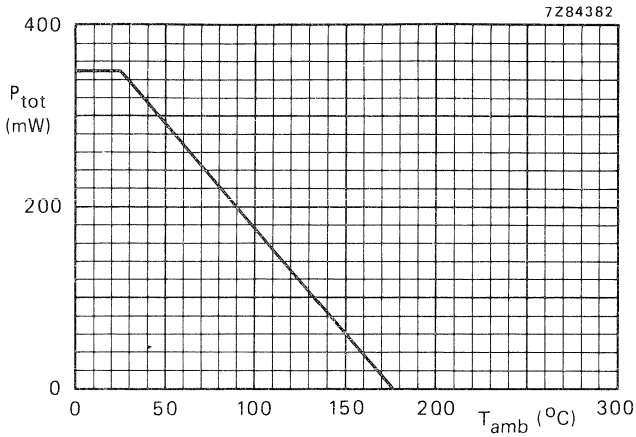


Fig. 4 Power derating curve.

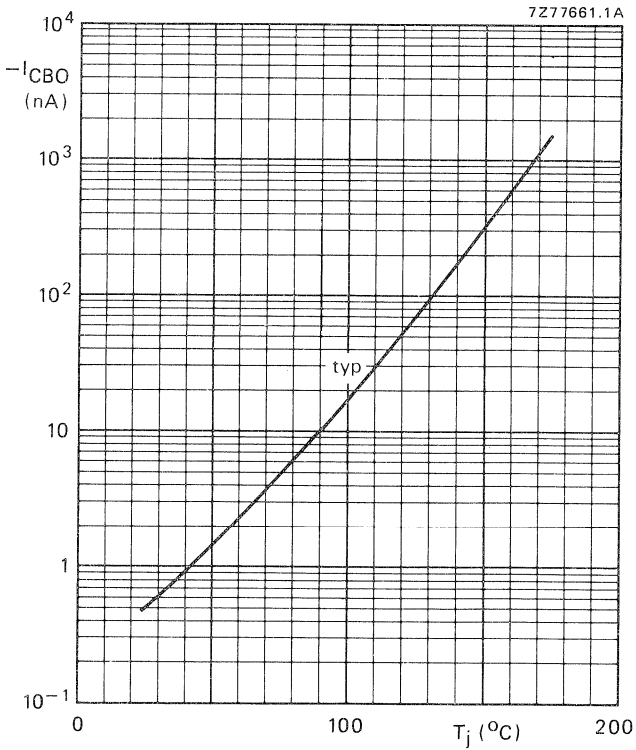


Fig. 5 Typical values collector-base current as a function of the junction temperature at a collector-base voltage of  $-90$  V.



## MOSFET N-CHANNEL ENHANCEMENT SWITCHING TRANSISTOR

Symmetrical insulated-gate silicon MOS field-effect transistor of the N-channel enhancement mode type. The transistor is sealed in a SOT-143 envelope and features a low ON resistance and low capacitances. The transistor is protected against excessive input voltages by integrated back-to-back diodes between gate and substrate.

Applications:

- analog and/or digital switch
- switch driver

### QUICK REFERENCE DATA

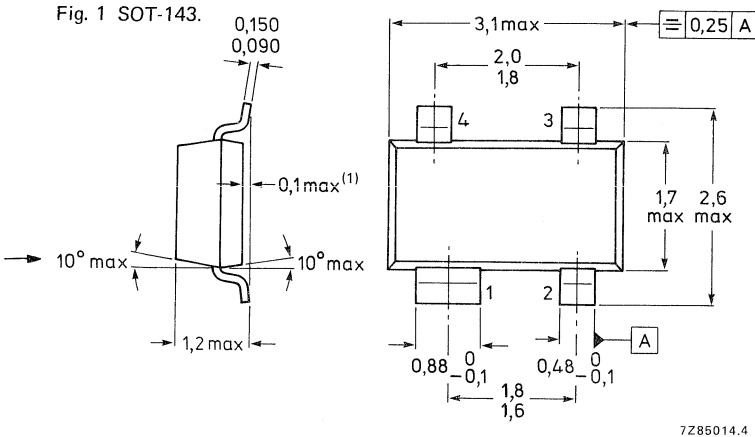
Drain-source voltage	$V_{DS}$	max.	10 V
Source-drain voltage	$V_{SD}$	max.	10 V
Drain-substrate voltage	$V_{DB}$	max.	15 V
Source-substrate voltage	$V_{SB}$	max.	15 V
Drain current (d.c.)	$I_D$	max.	50 mA
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	230 mW
Gate-source cut-off voltage $V_{DS} = V_{GS}; V_{SB} = 0;$ $I_D = 1\text{ }\mu\text{A}$	$V_{(P)GS}$	> <	0,1 V 2,0 V
Drain-source ON-resistance $V_{GS} = 10\text{ V}; V_{SB} = 0; I_D = 0,1\text{ mA}$	$r_{DSon}$	<	45 $\Omega$
Feed-back capacitance $V_{GS} = V_{BS} = -15\text{ V};$ $V_{DS} = 10\text{ V}; f = 1\text{ MHz}$	$C_{rss}$	typ.	0,6 pF

### MECHANICAL DATA

SOT-143 (see Fig. 1).

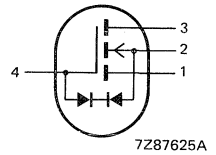
See also *Soldering recommendations*.

Fig. 1 SOT-143.



Dimensions in mm

Marking code:  
BSS83 = M74



7Z85014.4

(1) Also available in 0,1 – 0,2 mm version. TOP VIEW

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	$V_{DS}$	max.	10 V
Source-drain voltage	$V_{SD}$	max.	10 V
Drain-substrate voltage	$V_{DB}$	max.	15 V
Source-substrate voltage	$V_{SB}$	max.	15 V
Drain current (d.c.)	$I_D$	max.	50 mA
Total power dissipation up to $T_{amb} = 25\text{ °C}^*$	$P_{tot}$	max.	230 mW*
Storage temperature	$T_{stg}$		-65 to +150 °C
Junction temperature	$T_j$	max.	125 °C

## THERMAL RESISTANCE

From junction to ambient in free air*	$R_{th\ j-a}$	=	430 K/W*
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## CHARACTERISTICS

$T_{amb} = 25\text{ °C}$  unless otherwise specified

Drain-source breakdown voltage $V_{GS} = V_{BS} = -5\text{ V}; I_D = 10\text{ nA}$	$V_{(BR)DSX}$	>	10 V
Source-drain breakdown voltage $V_{GD} = V_{BD} = -5\text{ V}; I_D = 10\text{ nA}$	$V_{(BR)SDX}$	>	10 V
Drain-substrate breakdown voltage $V_{CB} = 0; I_D = 10\text{ nA};$ open source	$V_{(BR)DBO}$	>	15 V
Source-substrate breakdown voltage $V_{CB} = 0; I_D = 10\text{ nA};$ open drain	$V_{(BR)SBO}$	>	15 V
Drain-source leakage current $V_{GS} = V_{BS} = -2\text{ V}; V_{DS} = 6,6\text{ V}$	$I_{Dsoff}$	<	10 nA

\* Device mounted on a ceramic substrate of 8 mm x 10 mm x 0,6 mm.

Source-drain leakage current

$$V_{GD} = V_{BD} = -2 \text{ V}; V_{SD} = 6,6 \text{ V}$$

$$I_{SDoff} < 10 \text{ mA}$$

Forward transconductance at  $f = 1 \text{ kHz}$

$$V_{DS} = 10 \text{ V}; V_{SB} = 0; I_D = 20 \text{ mA}$$

$$g_{fs} > 10 \text{ mS}$$

$$\text{typ. } 15 \text{ mS}$$

Gate-source cut-off voltage

$$V_{DS} = V_{GS}; V_{SB} = 0; I_D = 1 \mu\text{A}$$

$$V_{(P)GS} > 0,1 \text{ V}$$

$$< 2,0 \text{ V}$$

Drain-source ON-resistance

$$I_D = 0,1 \text{ mA};$$

$$V_{GS} = 5 \text{ V}; V_{SB} = 0$$

$$r_{DSon} < 70 \Omega$$

$$V_{GS} = 10 \text{ V}; V_{SB} = 0$$

$$r_{DSon} < 45 \Omega$$

$$V_{GS} = 3,2 \text{ V}; V_{SB} = 6,8 \text{ V (see Fig. 4)}$$

$$r_{DSon} \text{ typ. } 80 \Omega$$

$$< 120 \Omega \leftarrow$$

Gate-substrate zener voltages

$$V_{DB} = V_{SB} = 0; -I_C = 10 \mu\text{A}$$

$$V_{Z(1)} > 12,5 \text{ V}$$

$$V_{DB} = V_{SB} = 0; +I_G = 10 \mu\text{A}$$

$$V_{Z(2)} > 12,5 \text{ V}$$

Capacitances at  $f = 1 \text{ MHz}$

$$V_{GS} = V_{BS} = -15 \text{ V}; V_{DS} = 10 \text{ V}$$

Feed-back capacitance

$$C_{rss} \text{ typ. } 0,6 \text{ pF}$$

Input capacitance

$$C_{iss} \text{ typ. } 1,5 \text{ pF}$$

Output capacitance

$$C_{oss} \text{ typ. } 1,0 \text{ pF}$$

Switching times (see Fig. 2)

$$V_{DD} = 10 \text{ V}; V_i = 5 \text{ V}$$

$$t_{on} \text{ typ. } 1,0 \text{ ns}$$

$$t_{off} \text{ typ. } 5,0 \text{ ns}$$

Pulse generator:

$$R_i = 50 \Omega$$

$$t_r < 0,5 \text{ ns}$$

$$t_f < 1,0 \text{ ns}$$

$$t_p = 20 \text{ ns}$$

$$\delta < 0,01$$

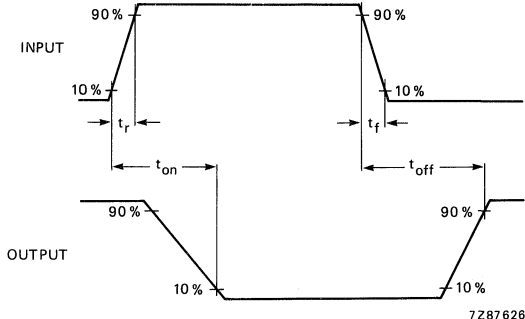
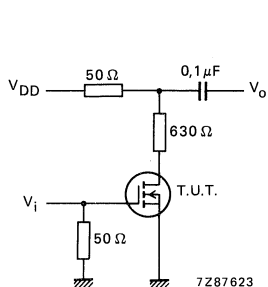


Fig. 2 Switching times test circuit and input and output waveforms.

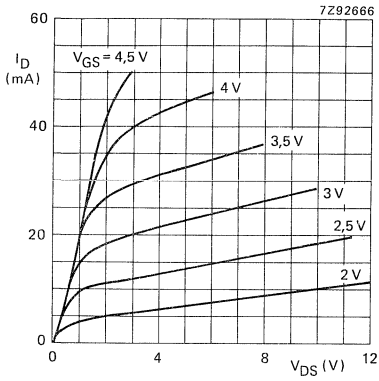


Fig. 3  $V_{SB} = 0$ ; typical values.

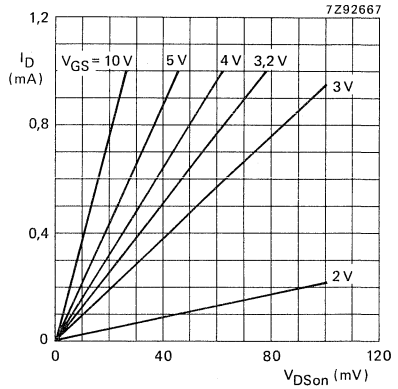


Fig. 4  $V_{SB} = 6,8$  V; typical values.

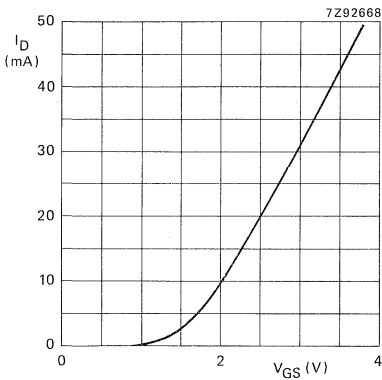


Fig. 5  $V_{DS} = 10$  V;  $V_{BS} = 0$ ; typical values.

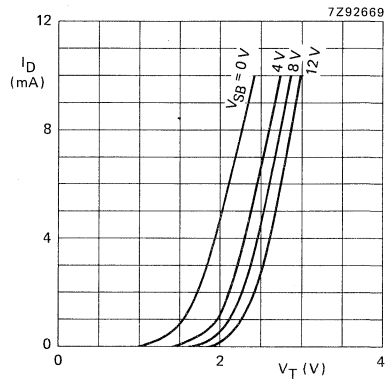


Fig. 6  $V_{DS} = V_{GS} = V_T$ .

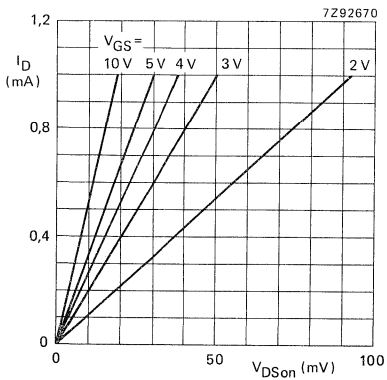


Fig. 7  $V_{SB} = 0$ ; typical values.

Conditions for Figs 3, 4, 5, 6 and 7:  
 $T_j = 25$  °C.

## SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors in miniature plastic envelopes intended for use in amplifier and switching applications. Complementary types are BST39/40.

### QUICK REFERENCE DATA

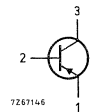
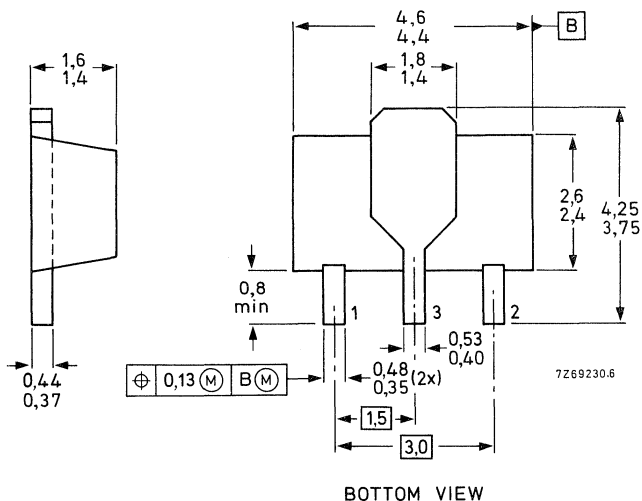
	BST15		BST16	
Collector-base voltage (open emitter)	$-V_{CBO}$	max. 200		350 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max. 200		300 V
Collector current (d.c.)	$-I_C$	max. 1		A
Total power dissipation up to $T_{amb} = 25^\circ\text{C}$	$P_{tot}$	max. 1		W
Junction temperature	$T_j$	max. 150		$^\circ\text{C}$
D.C. current gain	$h_{FE}$	30 to 150		30 to 120
$-V_{CE} = 10\text{ V}; -I_C = 50\text{ mA}$				
Transition frequency	$f_T$	$>$	15	MHz
$-V_{CE} = 10\text{ V}; -I_C = 10\text{ mA}$				

### MECHANICAL DATA

Fig. 1 SOT-89.

Dimensions in mm

Marking:  
BST15  
BST16



See also *Soldering Recommendations*

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BST15	BST16
Collector-base voltage (open emitter)	$-V_{CBO}$	max. 200	350 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max. 200	300 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max. 4	6 V
Collector current (d.c.)	$-I_C$	max. 1	A
Base current	$-I_B$	max. 0,5	A
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}^*$	$P_{tot}$	max. 1	W
Junction temperature	$T_j$	max. 150	$^\circ\text{C}$
Storage temperature	$T_{stg}$	-65 to 150 $^\circ\text{C}$	

**THERMAL RESISTANCE**

from junction to ambient*	$R_{th\ j-mb}$	=	125	K/W
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**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

		BST15	BST16
Collector cut-off current			
$I_E = 0; -V_{CB} = 175\text{ V}$	$-I_{CBO}$	< 1	- $\mu\text{A}$
$I_E = 0; -V_{CB} = 280\text{ V}$	$-I_{CBO}$	< -	1 $\mu\text{A}$
$I_B = 0; -V_{CE} = 150\text{ V}$	$-I_{CEO}$	< 50	- $\mu\text{A}$
$I_B = 0; -V_{CE} = 250\text{ V}$	$-I_{CEO}$	< -	50 $\mu\text{A}$
Emitter cut-off current			
$I_C = 0; -V_{EB} = 4\text{ V}$	$-I_{EBO}$	< 20	- $\mu\text{A}$
$I_C = 0; -V_{EB} = 6\text{ V}$	$-I_{EBO}$	< -	20 $\mu\text{A}$
Collector-emitter breakdown voltage			
$I_B = 0; -I_C = 50\text{ mA}; L = 25\text{ mH}$	$-V_{(BR)CEO}$	> 200	300 V
Collector-emitter saturation voltage			
$-I_C = 50\text{ mA}; -I_B = 5\text{ mA}$	$-V_{CEsat}$	< 2,5	2,0 V
D.C. current gain			
$-V_{CE} = 10\text{ V}; -I_C = 50\text{ mA}$	$h_{FE}$	30 to 150	30 to 120
Transition frequency at $f = 30\text{ MHz}$			
$-I_C = 10\text{ mA}; -V_{CE} = 10\text{ V}$	$f_T$	> 15	MHz
Collector capacitance at $f = 1\text{ MHz}$			
$I_E = I_e = 0; -V_{CB} = 10\text{ V}$	$C_C$	< 15	pF

\* Mounted on an area of  $2,5\text{ cm}^2$  of a ceramic substrate; thickness 0,7 mm.

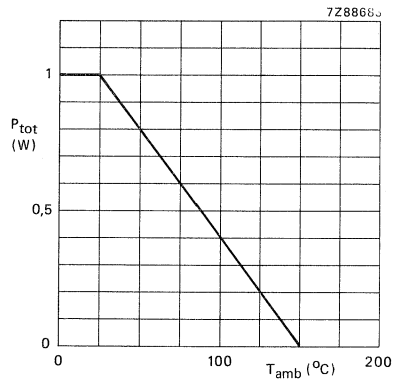


Fig. 2 Power derating curve.





# DEVELOPMENT SAMPLE DATA

This information is derived from development samples made available for evaluation. It does not necessarily imply that the device will go into regular production.

**BST39**  
**BST40**

## SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors in miniature plastic envelopes intended for use in amplifier and switching applications. Complementary p-n-p types are BST15/16.

### QUICK REFERENCE DATA

		BST39	BST40
Collector-base voltage (open emitter)	$V_{CBO}$	max. 450	300 V
Collector-emitter voltage (open base)	$V_{CEO}$	max. 350	250 V
Collector current (d.c.)	$I_C$	max. 1	A
Total power dissipation up to $T_{amb} = 25^\circ C$	$P_{tot}$	max. 1	W
Junction temperature	$T_j$	max. 150	$^\circ C$
D.C. current gain	$h_{FE}$	40 to 160	
$V_{CE} = 10 V; I_C = 20 mA$			
Transition frequency	$f_T$	$\geq$	15 MHz
$V_{CE} = 10 V; I_C = 10 mA$			

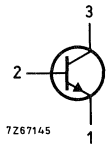
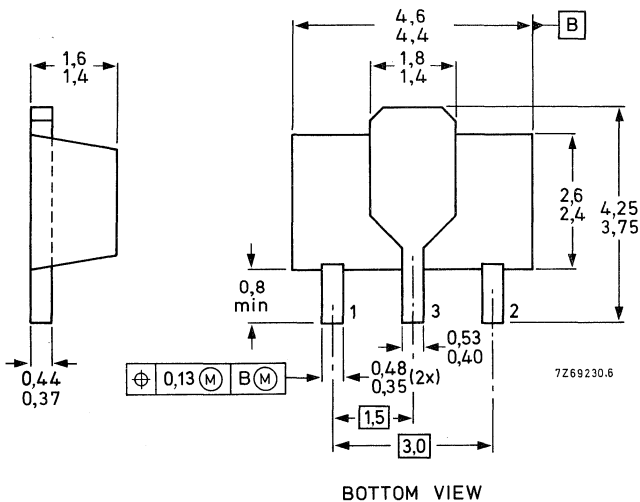
### MECHANICAL DATA

Fig. 1 SOT-89.

Dimensions in mm

Marking

BST39  
BST40



See also *Soldering Recommendations*.

# BST39 BST40

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

			BST39	BST40
Collector-base voltage (open emitter)	$V_{CBO}$	max.	450	300 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	350	250 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	6	V
Collector current (d.c.)	$I_C$	max.	1	A
Base current	$I_B$	max.	0,5	A
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}^*$	$P_{tot}$	max.	1	W
Junction temperature	$T_j$	max.	150	$^\circ\text{C}$
Storage temperature	$T_{stg}$		-65 to 150	$^\circ\text{C}$

## THERMAL RESISTANCE

from junction to ambient*	$R_{th\ j-a}$	=	125	K/W
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## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

			BST39	BST40
Collector cut-off current				
$I_B = 0; V_{CE} = 300\text{ V}$	$I_{CBO}$	$\leq$	1	- $\mu\text{A}$
$I_B = 0; V_{CE} = 200\text{ V}$	$I_{CBO}$	$\leq$	-	1 $\mu\text{A}$
$V_{BE} = 1,5\text{ V}; V_{CE} = 450\text{ V}$	$I_{CEV}$	$\leq$	500	- $\mu\text{A}$
$V_{BE} = 1,5\text{ V}; V_{CE} = 300\text{ V}$	$I_{CEV}$	$\leq$	-	500 $\mu\text{A}$
Emitter cut-off current				
$I_C = 0; V_{EB} = 6\text{ V}$	$I_{EBO}$	$\leq$	20	$\mu\text{A}$
Collector-emitter saturation voltage				
$I_C = 50\text{ mA}; I_B = 4\text{ mA}$	$V_{CEsat}$	$\leq$	0,5	V
Base-emitter saturation voltage				
$I_C = 50\text{ mA}; I_B = 4\text{ mA}$	$V_{BEsat}$	$\leq$	1,3	V
D.C. current gain				
$V_{CE} = 10\text{ V}; I_C = 20\text{ mA}$	$h_{FE}$		40 to 160	
$V_{CE} = 10\text{ V}; I_C = 2\text{ mA}$	$h_{FE}$	$\geq$	30	
Transition frequency at $f = 5\text{ MHz}$				
$V_{CE} = 10\text{ V}; I_C = 10\text{ mA}$	$f_T$	$\geq$	15	MHz
Collector capacitance at $f = 1\text{ MHz}$				
$I_E = I_C = 0; V_{CB} = 10\text{ V}$	$C_c$	$\leq$	10	pF

\* Mounted on an area of  $2,5\text{ cm}^2$  of a ceramic substrate; thickness 0,7 mm.

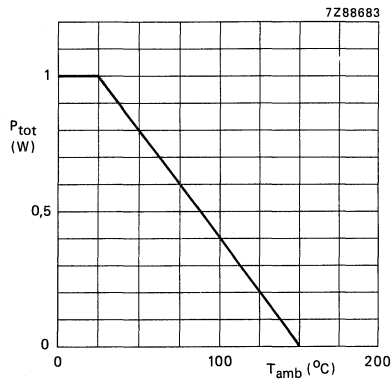


Fig. 2 Power derating curve.

DEVELOPMENT SAMPLE DATA



## N-P-N SILICON PLANAR DARLINGTON TRANSISTORS

Silicon n-p-n planar Darlington transistors for industrial switching applications, e.g. print hammer, solenoid, relay and lamp driving. Encapsulated in a microminiature SOT-89 envelope.

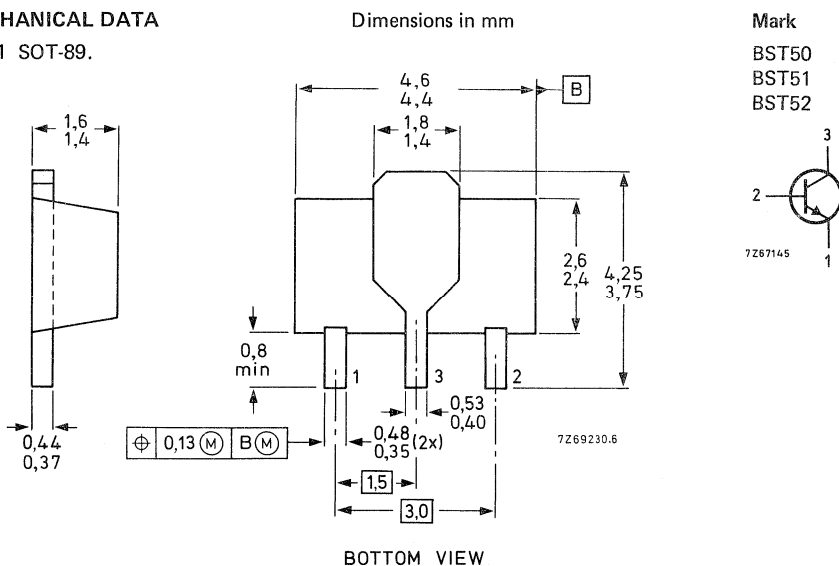
P-N-P complements are BST60, 61, 62 respectively.

### QUICK REFERENCE DATA

		BST50	BST51	BST52	
Collector-base voltage (open emitter)	$V_{CBO}$	max. 60	80	90	V
Collector-emitter voltage	$V_{CER}$	max. 45	60	80	V
Collector current	$I_C$	max. 0,5	0,5	0,5	A
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max. 1			W
D.C. current gain $I_C = 500\text{ mA}; V_{CE} = 10\text{ V}$	$h_{FE}$	> 2000			
Collector-emitter saturation voltage $I_C = 500\text{ mA}; I_B = 0,5\text{ mA}$	$V_{CEsat}$	< 1,3			V
Turn-off time $I_C = 500\text{ mA}; I_{B(on)} = -I_{B(off)} = 0,5\text{ mA}$	$t_{off}$	typ.	1500		ns

### MECHANICAL DATA

Fig. 1 SOT-89.



See also *Soldering recommendations*.

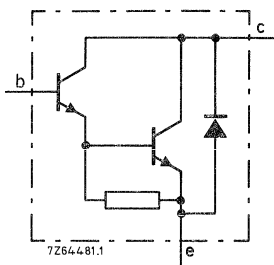


Fig. 2 Circuit diagram.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

			BST50	BST51	BST52
→ Collector-base voltage (open emitter)	$V_{CBO}$	max.	60	80	90 V
Collector-emitter voltage*	$V_{CER}$	max.	45	60	80 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	5		V
Collector current (d.c.)	$I_C$	max.	0,5		A
Collector current (peak)	$I_{CM}$	max.	1,5		A
Base current (d.c.)	$I_B$	max.	0,1		A
Total power dissipation $\Delta$ up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	1		W
Storage temperature	$T_{stg}$		-65 to + 150		$^\circ\text{C}$
Junction temperature**	$T_j$	max.	150		$^\circ\text{C}$

**THERMAL RESISTANCE\*\***

From junction to ambient $\Delta$	$R_{thj-a}$	=	125	K/W
From junction to tab	$R_{thj-tab}$	=	10	K/W

\* External  $R_{BE}$  not to exceed value shown in Fig. 5.

\*\* Based on maximum average junction temperature in line with common industrial practice. The resulting higher junction temperature of the output transistor part is taken into account.

$\Delta$  Device mounted on a ceramic substrate; area = 2,5 cm<sup>2</sup>, thickness = 0,7 mm.

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$V_{BE} = 0; V_{CE} = V_{CErmax}$   $I_{CES} < 10\text{ }\mu\text{A}$

Emitter cut-off current

$I_C = 0; V_{EB} = 4\text{ V}$   $I_{EBO} < 10\text{ }\mu\text{A}$

D.C. current gain\*

$I_C = 150\text{ mA}; V_{CE} = 10\text{ V}$   $h_{FE} > 1000$

$I_C = 500\text{ mA}; V_{CE} = 10\text{ V}$   $h_{FE} > 2000$

Collector-emitter saturation voltage

$I_C = 500\text{ mA}; I_B = 0,5\text{ mA}$   $V_{CEsat} < 1,3\text{ V}$

$I_C = 500\text{ mA}; I_B = 0,5\text{ mA}; T_j = 150\text{ }^\circ\text{C}$   $V_{CEsat} < 1,3\text{ V}$

Base-emitter saturation voltage

$I_C = 500\text{ mA}; I_B = 0,5\text{ mA}$   $V_{BEsat} < 1,9\text{ V}$

Switching times (see also Fig. 3 and Fig. 4)

$I_C = 500\text{ mA}; I_{Bon} = -I_{Boff} = 0,5\text{ mA}$

Turn-on time  $t_{on}$  typ. 400 ns

Turn-off time  $t_{off}$  typ. 1500 ns

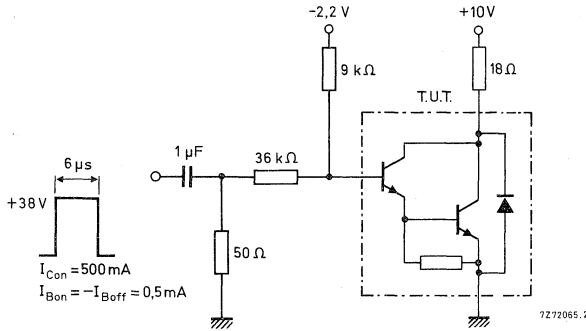


Fig. 3 Switching times test circuit.

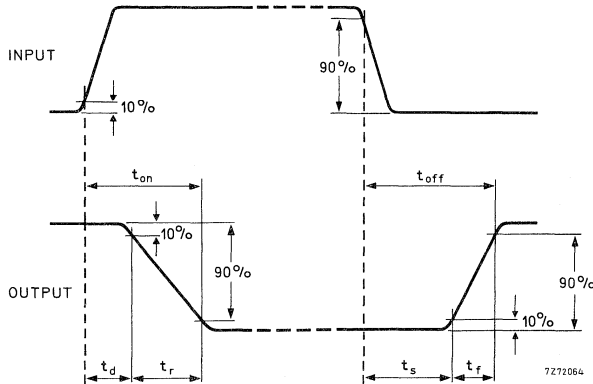


Fig. 4 Switching times waveform.

\* Measured under pulsed conditions.

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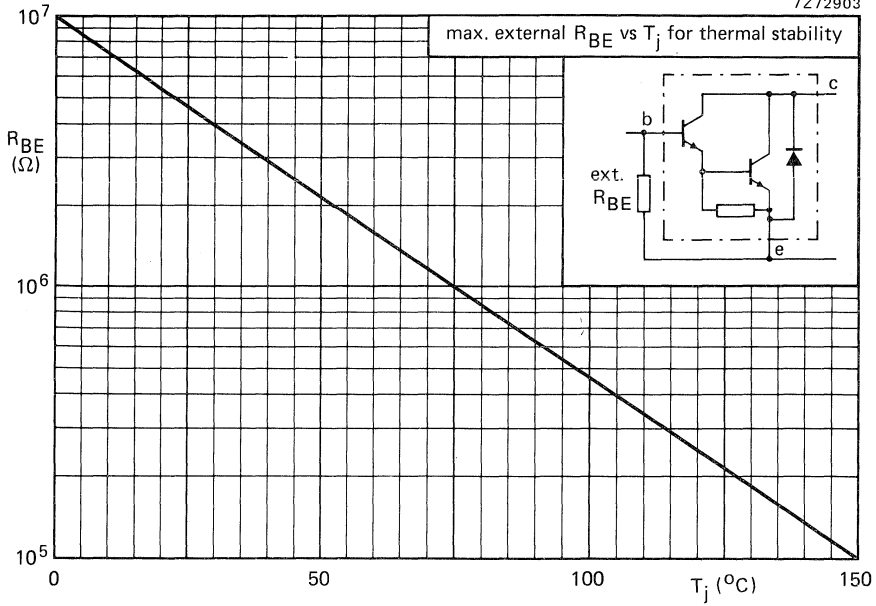


Fig. 5 Maximum values external  $R_{BE}$  as a function of junction temperature.

7Z67585.2

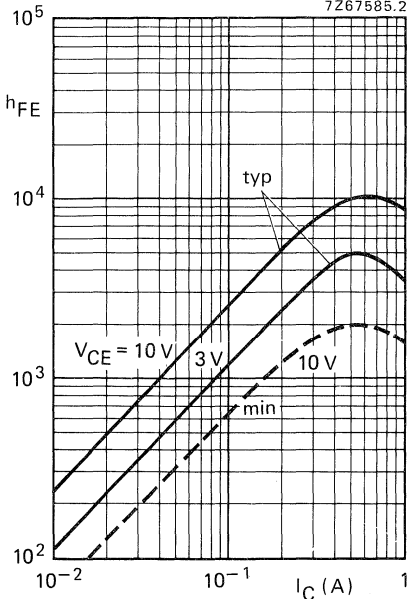


Fig. 6  $T_j = 25^{\circ}\text{C}$ .

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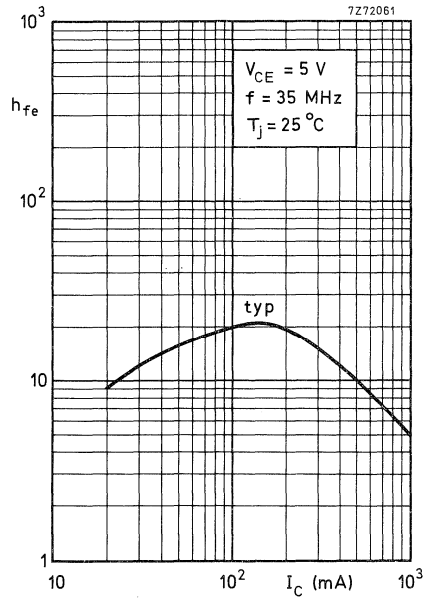


Fig. 7.



## P-N-P SILICON PLANAR DARLINGTON TRANSISTORS

Silicon p-n-p planar Darlington transistors for industrial switching applications, e.g. print hammer, solenoid, relay and lamp driving. Encapsulated in a microminiature plastic SOT-89 envelope.

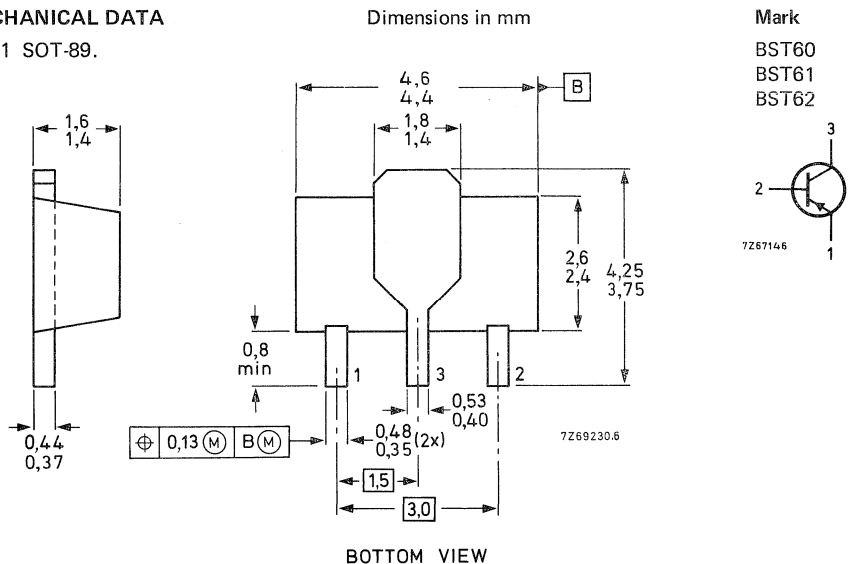
N-P-N complements are BST50, BST51 and BST52 respectively.

### QUICK REFERENCE DATA

		BST60	BST61	BST62	
Collector-base voltage (open emitter)	$-V_{CBO}$	max. 60	80	90	V
Collector-emitter voltage	$-V_{CEr}$	max. 45	60	80	V
Collector current	$-I_C$	max. 0,5	0,5	0,5	A
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	1		W
D.C. current gain $-I_C = 500\text{ mA}; -V_{CE} = 10\text{ V}$	$h_{FE}$	>	2000		
Collector-emitter saturation voltage $-I_C = 0,5\text{ A}; -I_B = 0,5\text{ mA}$	$-V_{CEsat}$	<	1,3		V
Turn-off time $-I_C = 500\text{ mA}; -I_{Bon} = I_{Boff} = 0,5\text{ mA}$	$t_{off}$	typ.	1500		ns

### MECHANICAL DATA

Fig. 1 SOT-89.



See also *Soldering recommendations*.

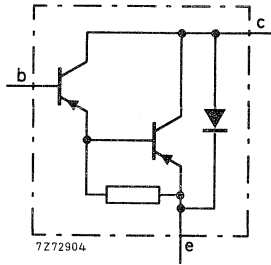


Fig. 2 Circuit diagram.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

			BST60	BST61	BST62	
→ Collector-base voltage (open emitter)	$-V_{CB0}$	max.	60	80	90	V
Collector-emitter voltage*	$-V_{CEr}$	max.	45   60   80			V
Emitter-base voltage (open collector)	$-V_{EB0}$	max.	5			V
Collector current (d.c.)	$-I_C$	max.	0,5			A
Collector current (peak)	$-I_{CM}$	max.	1,5			A
Base current (d.c.)	$-I_B$	max.	0,1			A
Total power dissipation <sup>▲</sup> up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	1			W
Storage temperature	$T_{stg}$		-65 to + 150			$^\circ\text{C}$
Junction temperature**	$T_j$	max.	150			$^\circ\text{C}$

**THERMAL RESISTANCE\*\***

From junction to ambient <sup>▲</sup>	$R_{th\ j-a}$	=	125	K/W
From junction to tab	$R_{th\ j-tab}$	=	10	K/W

\* External  $R_{BE}$  not to exceed value shown in Fig. 5.

\*\* Based on maximum average junction temperature in line with common industrial practice. The resulting higher junction temperature of the output transistor part is taken into account.

▲ Device mounted on a ceramic substrate area 2,5 cm<sup>2</sup>, thickness = 0,7 mm.

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$V_{BE} = 0; -V_{CE} = -V_{CERmax}$

$-I_{CES} < 10\text{ }\mu\text{A}$

Emitter cut-off current

$I_C = 0; V_{EB} = 4\text{ V}$

$-I_{EBO} < 10\text{ }\mu\text{A}$

D.C. current gain\*

$-I_C = 150\text{ mA}; -V_{CE} = 10\text{ V}$

$h_{FE} > 1000$

$-I_C = 500\text{ mA}; -V_{CE} = 10\text{ V}$

$h_{FE} > 2000$

Collector-emitter saturation voltage

$-I_C = 500\text{ mA}; -I_B = 0,5\text{ mA}$

$-V_{CEsat} < 1,3\text{ V}$

$-I_C = 500\text{ mA}; -I_B = 0,5\text{ mA}; T_j = 150\text{ }^\circ\text{C}$

$-V_{CEsat} < 1,3\text{ V}$

Base-emitter saturation voltage

$-I_C = 500\text{ mA}; -I_B = 0,5\text{ mA}$

$-V_{BEsat} < 1,9\text{ V}$

Switching times (see also Fig. 3 and Fig. 4)

$-I_C = 500\text{ mA}; -I_{Bon} = -I_{Boff} = 0,5\text{ mA}$

Turn-on time

$t_{on}$  typ. 400 ns

Turn-off time

$t_{off}$  typ. 1500 ns

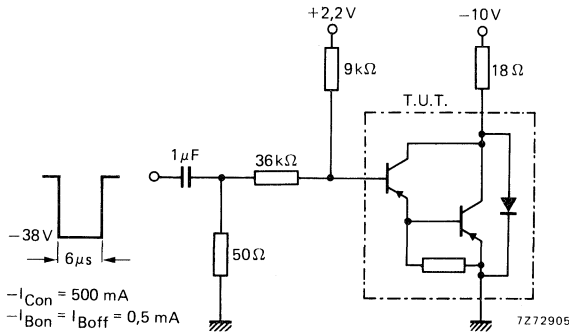


Fig. 3 Switching times test circuit.

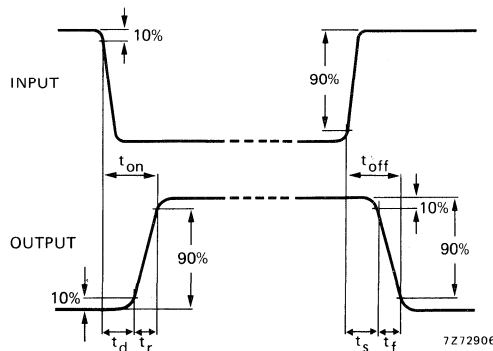


Fig. 4 Switching times waveform.

\* Measured under pulsed conditions.

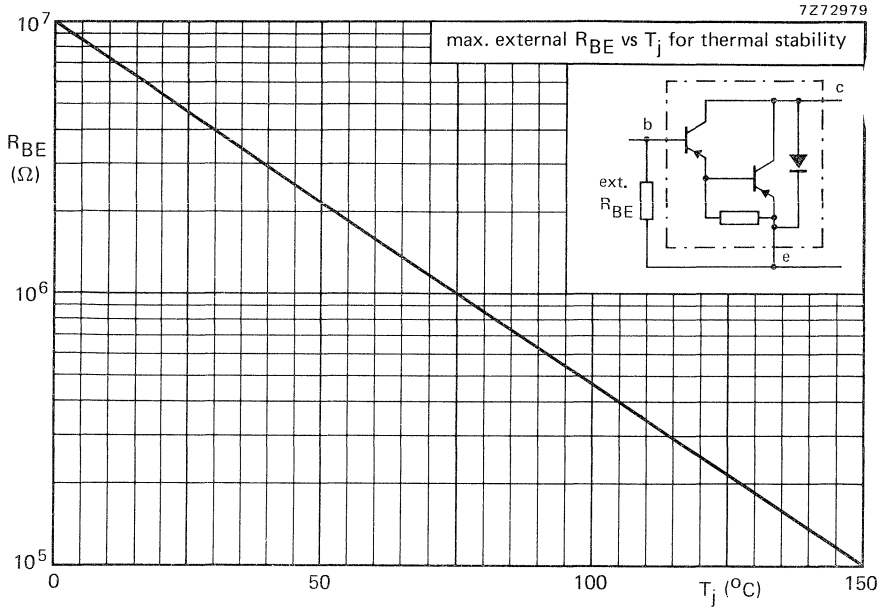


Fig. 5 Maximum values external  $R_{BE}$  as a function of junction temperature.

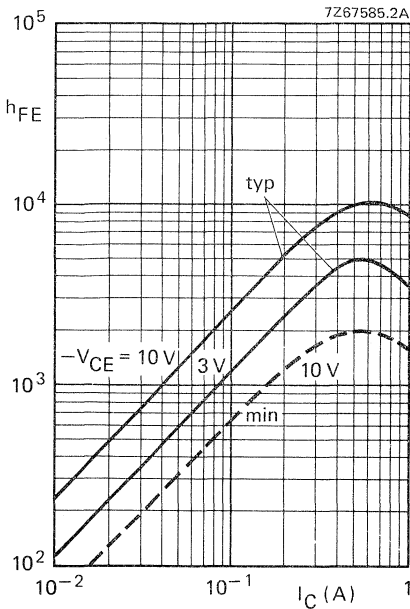


Fig. 6  $T_j = 25^{\circ}\text{C}$ .

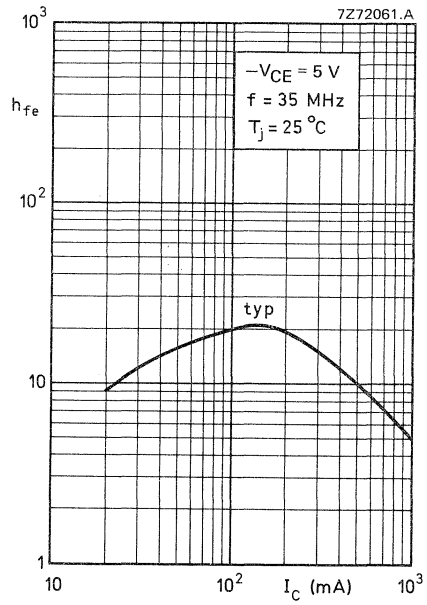


Fig. 7.

## SILICON PLANAR EPITAXIAL TRANSISTORS

● High-speed switching

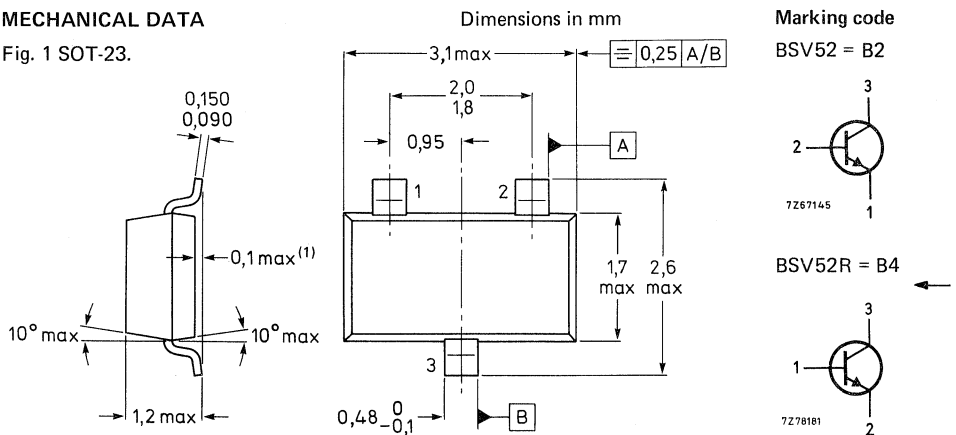
N-P-N transistor in a microminiature plastic envelope. It is intended for very high-speed saturated switching in thick and thin-film circuits.

### QUICK REFERENCE DATA

Collector-base voltage (open emitter)	$V_{CB0}$	max.	20 V
Collector-emitter voltage ( $V_{BE} = 0$ )	$V_{CES}$	max.	20 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	12 V
Collector current (peak value)	$I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 65\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	250 mW
Junction temperature	$T_j$	max.	175 $^{\circ}\text{C}$
D.C. current gain			
$I_C = 10\text{ mA}; V_{CE} = 1\text{ V}$	$h_{FE}$		40 to 120
$I_C = 50\text{ mA}; V_{CE} = 1\text{ V}$	$h_{FE}$	>	25
Transition frequency at $f = 100\text{ MHz}$			
$I_C = 10\text{ mA}; V_{CE} = 10\text{ V}$	$f_T$	>	400 MHz
		typ.	500 MHz
Storage time			
$I_C = I_B = -I_{BM} = 10\text{ mA}$	$t_s$	<	13 ns

### MECHANICAL DATA

Fig. 1 SOT-23.



7266908.7

(1) Also available in 0,1 – 0,2 mm version. TOP VIEW

See also *Soldering recommendations*.

# BSV52 BSV52R

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) See Fig. 4	$V_{CB0}$	max.	20 V
Collector-emitter voltage ( $V_{BE} = 0$ ) See Fig. 4	$V_{CES}$	max.	20 V
Collector-emitter voltage (open base) $I_C = 10$ mA (see Fig. 4)	$V_{CEO}$	max.	12 V
Emitter-base voltage (open collector) See Fig. 4	$V_{EBO}$	max.	5 V
Collector current (d.c.)	$I_C$	max.	100 mA
Collector current (peak value)	$I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 65$ °C **	$P_{tot}$	max.	250 mW
Storage temperature	$T_{stg}$		-65 to + 175 °C
Junction temperature	$T_j$	max.	175 °C

## THERMAL CHARACTERISTICS\*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

### Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	60 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

$T_j = 25$  °C unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 10\text{ V}$$

$$I_E = 0; V_{CB} = 10\text{ V}; T_j = 125\text{ °C}$$

$I_{CBO}$	<	100 nA
$I_{CBO}$	<	5 $\mu$ A

Saturation voltages

$$I_C = 10\text{ mA}; I_B = 300\ \mu\text{A}$$

$$I_C = 10\text{ mA}; I_B = 1\text{ mA}$$

$$I_C = 50\text{ mA}; I_B = 5\text{ mA}$$

$V_{CEsat}$	<	300 mV
$V_{CEsat}$	<	250 mV
$V_{BEsat}$		700 to 850 mV
$V_{CEsat}$	<	400 mV
$V_{BEsat}$	<	1200 mV

D.C. current gain

$$I_C = 1\text{ mA}; V_{CE} = 1\text{ V}$$

$$I_C = 10\text{ mA}; V_{CE} = 1\text{ V}$$

$$I_C = 50\text{ mA}; V_{CE} = 1\text{ V}$$

$h_{FE}$	>	25
$h_{FE}$		40 to 120
$h_{FE}$	>	25

Transition frequency at  $f = 100$  MHz

$$I_C = 10\text{ mA}; V_{CE} = 10\text{ V}$$

$f_T$	>	400 MHz
	typ.	500 MHz

\* See *Thermal characteristics*.

\*\* Mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

Collector capacitance at  $f = 1 \text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 5 \text{ V}$$

$$C_c < 4 \text{ pF}$$

Emitter capacitance at  $f = 1 \text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 1 \text{ V}$$

$$C_e < 4,5 \text{ pF}$$

Switching times

Storage time  $I_C = I_B = -I_{BM} = 10 \text{ mA}$

$$t_s < 13 \text{ ns}$$

Turn on time when switched from

$$-V_{BE} = 1,5 \text{ V to } I_C = 10 \text{ mA}; I_B = 3 \text{ mA}$$

$$t_{on} < 12 \text{ ns}$$

Turn off time when switched from

$$I_C = 10 \text{ mA}; I_B = 3 \text{ mA}$$

to cut-off with  $-I_{BM} = 1,5 \text{ mA}$

$$t_{off} < 18 \text{ ns}$$

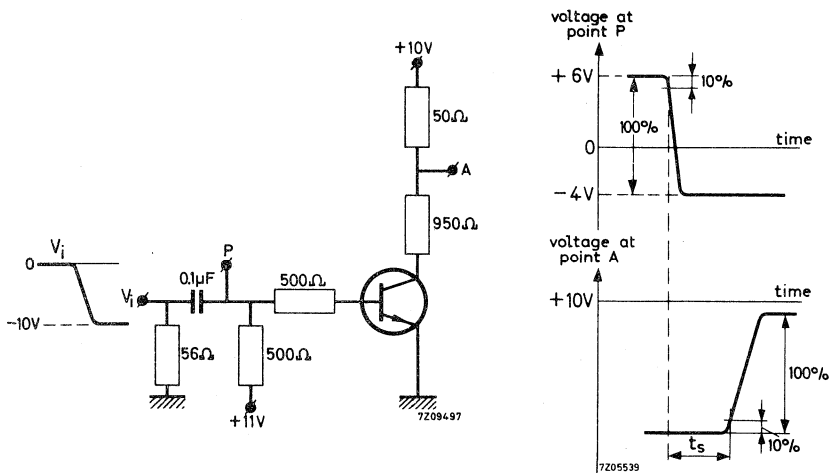


Fig. 2 Test circuit and waveform storage time.

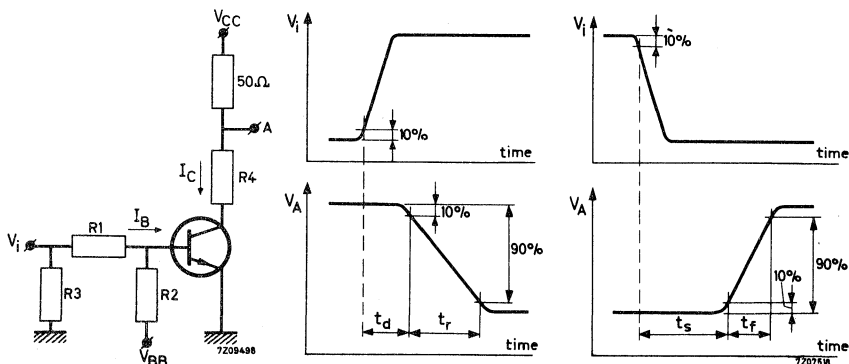


Fig. 3 Test circuit and waveforms turn on and turn off time.

# BSV52 BSV52R

## Pulse generator:

Rise time  $t_r < 1 \text{ ns}$   
 Pulse duration  $t > 300 \text{ ns}$   
 Duty cycle  $\delta < 0,02$   
 Source impedance  $R_S = 50 \Omega$

## Oscilloscope:

Input impedance  $R_i = 50 \Omega$   
 Rise time  $t_r < 1 \text{ ns}$

$I_C$ mA	$I_B$ mA	$-I_{BM}$ mA	$V_{CC}$ V	$R_1; R_2$ k $\Omega$	$R_3$ $\Omega$	$R_4$ $\Omega$	turn on time			turn off time	
							$-V_{BB}$ V	$-V_{BE}$ V	$V_i$ V	$V_{BB}$ V	$-V_i$ V
10	3	1,5	3	3,3	50	220	3,0	1,5	15	12,0	15

$-I_{BM}$  is the reverse current that can flow during switching off. The indicated  $-I_{BM}$  is determined and limited by the applied cut-off voltage and series resistance.

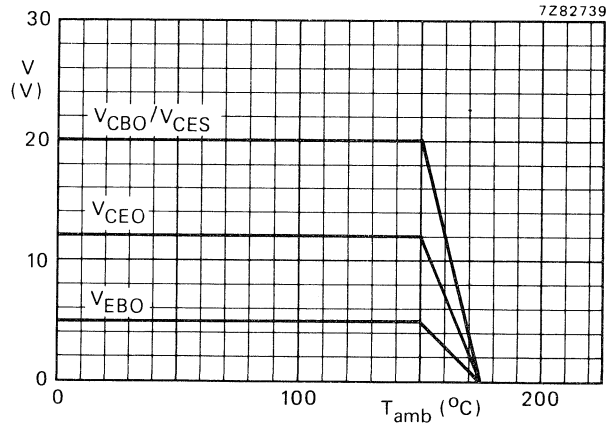


Fig. 4 Voltage derating curves.

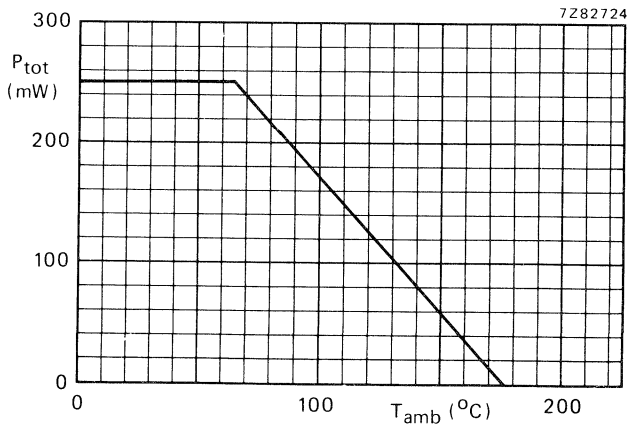
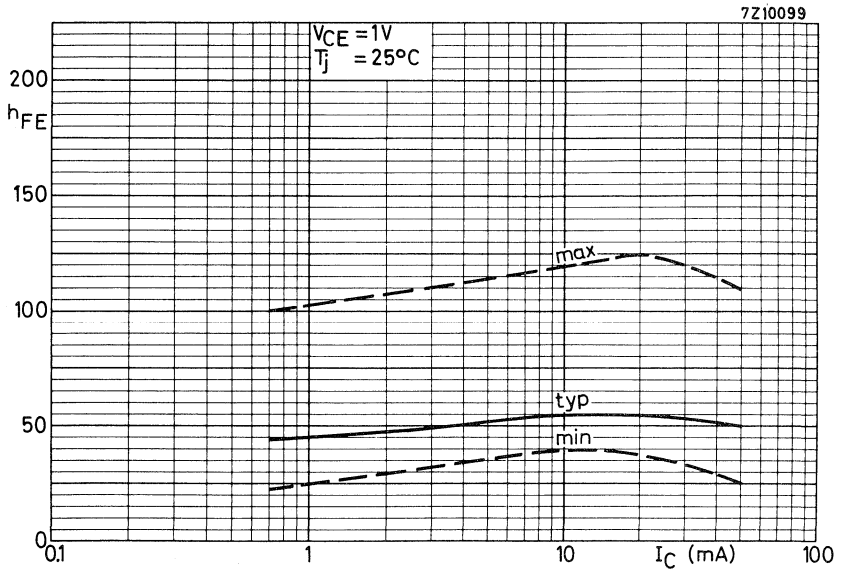
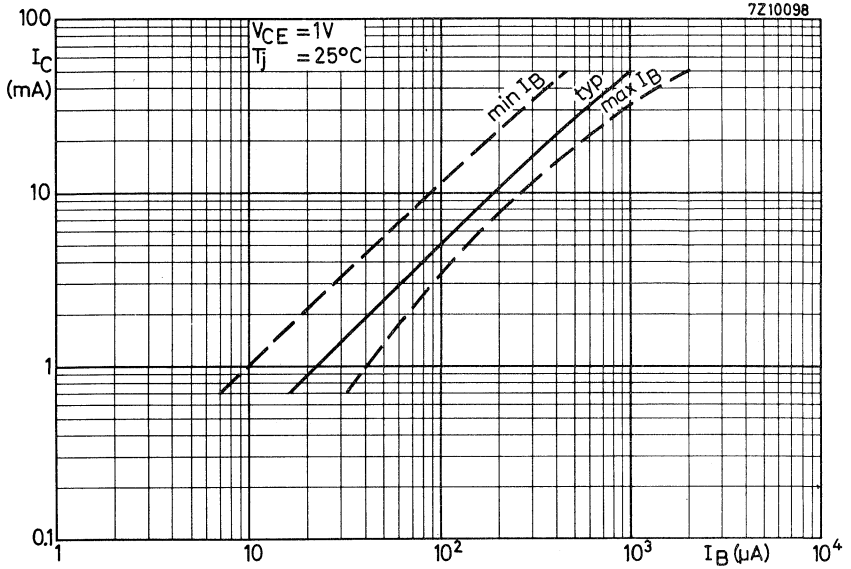
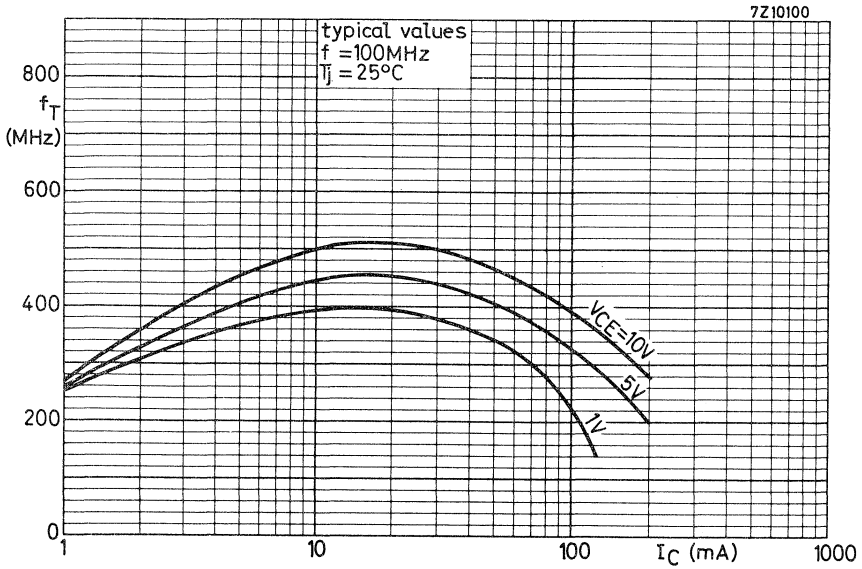
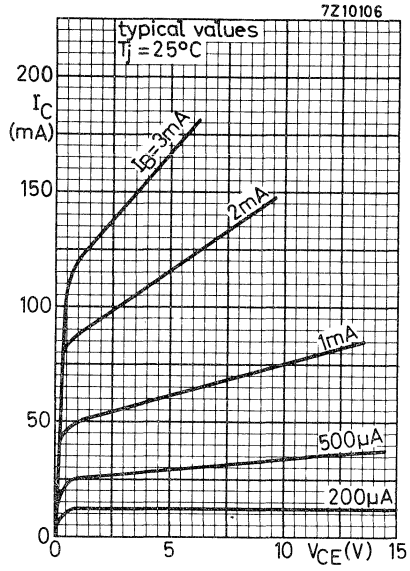
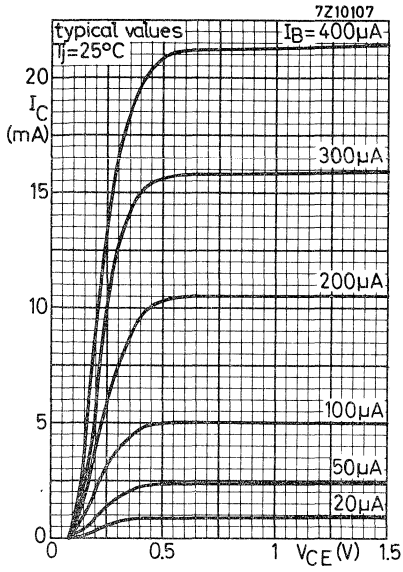
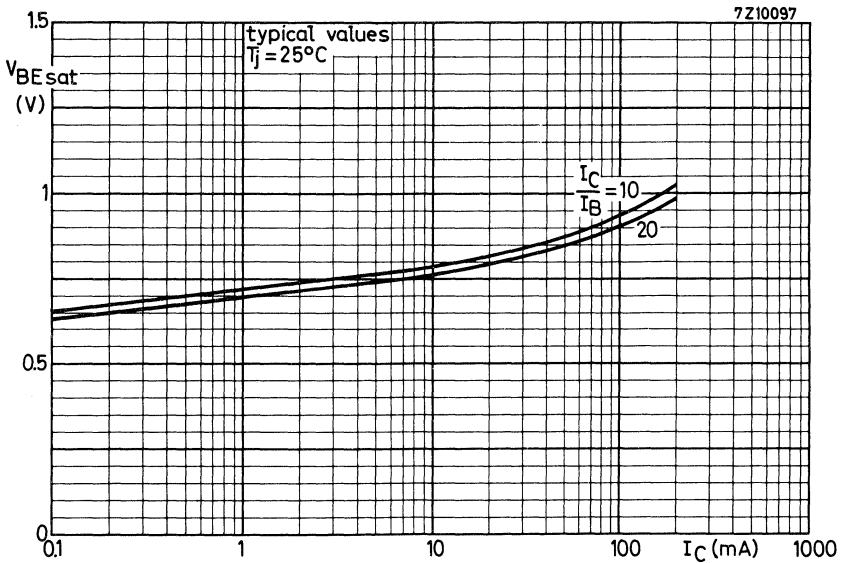
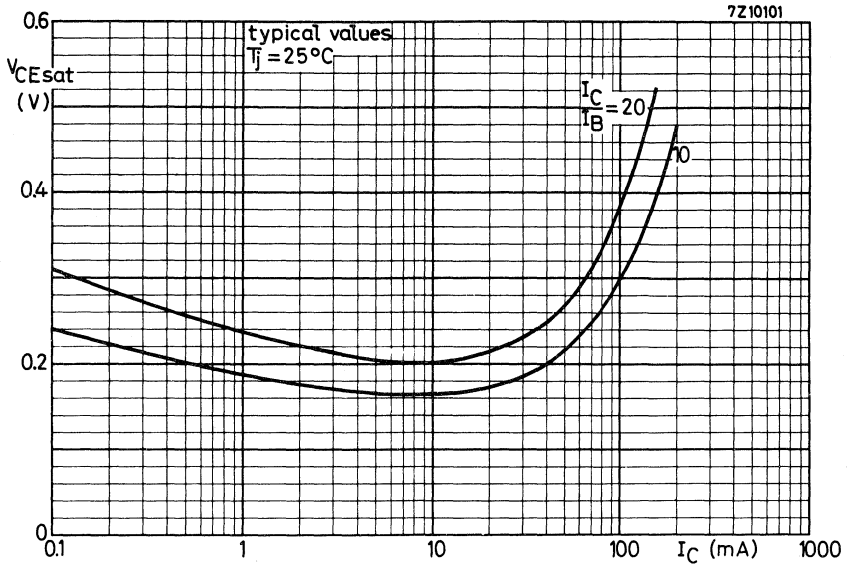


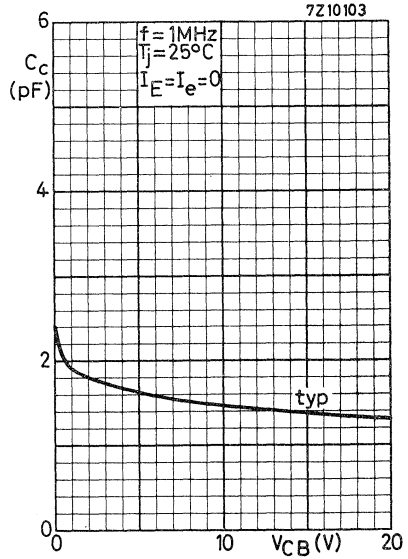
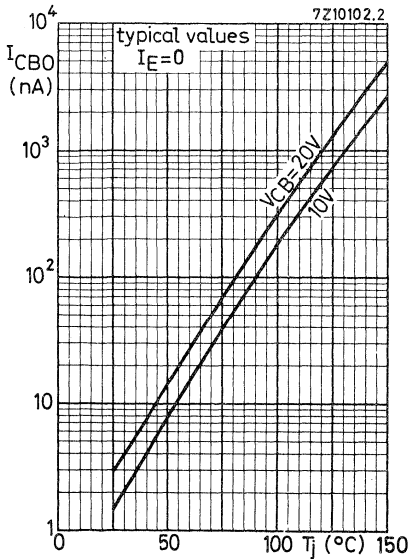
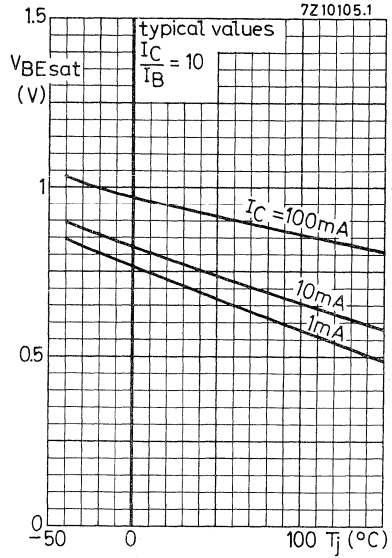
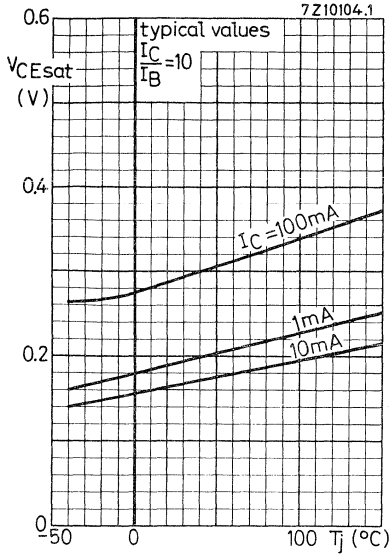
Fig. 5 Power derating curve.











## SILICON PLANAR VOLTAGE REGULATOR DIODES

Silicon planar voltage regulator diodes, in a SOT-89 plastic envelope, intended for stabilization applications in thick and thin-film circuits.

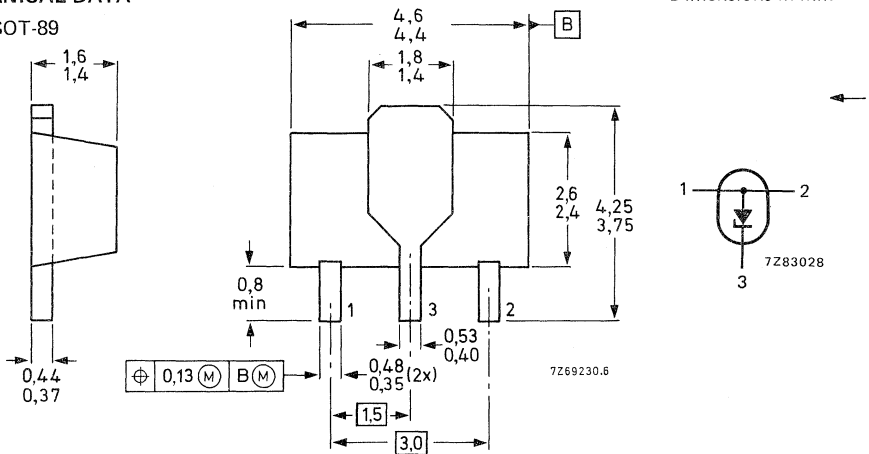
The series covers the normalized range of nominal working voltages from 2,4 V to 75 V with a tolerance of  $\pm 5\%$  (international standard E24 range).

### QUICK REFERENCE DATA

Working voltage range	$V_Z$	nom.	2,4 to 75 V
Working voltage tolerance (E24 range)			$\pm 5\%$
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	1 W
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

### MECHANICAL DATA

Fig. 1 SOT-89



### BOTTOM VIEW

#### Marking code

BZV49- C2V4 = 2Y4	C5V1 = 5Y1	C12 = 12Y	C33 = 33Y
C2V7 = 2Y7	C5V6 = 5Y6	C13 = 13Y	C36 = 36Y
C3V0 = 3Y0	C6V2 = 6Y2	C15 = 15Y	C39 = 39Y
C3V3 = 3Y3	C6V8 = 6Y8	C16 = 16Y	C43 = 43Y
C3V6 = 3Y6	C7V5 = 7Y5	C18 = 18Y	C47 = 47Y
C3V9 = 3Y9	C8V2 = 8Y2	C20 = 20Y	C51 = 51Y
C4V3 = 4Y3	C9V1 = 9Y1	C22 = 22Y	C56 = 56Y
C4V7 = 4Y7	C10 = 10Y	C24 = 24Y	C62 = 62Y
	C11 = 11Y	C27 = 27Y	C68 = 68Y
		C30 = 30Y	C75 = 75Y

# BZV49 SERIES

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Average forward current (averaged over any 20 ms period)	$I_F(AV)$	max.	250 mA
Working current (d.c.)	$I_Z$	limited by $P_{tot}$ max	
Total power dissipation * $t_{TP}$ to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	1 W
Non-repetitive peak reverse power dissipation * $T_j = 25\text{ }^\circ\text{C}$ ; $t_p = 100\text{ }\mu\text{s}$	$P_{ZSM}$	max.	40 W
Storage temperature	$T_{stg}$	-65 to +150 $^\circ\text{C}$	
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

## THERMAL RESISTANCE

From junction to collector tab	$R_{th\ j-tab}$	=	15 K/W
From junction to ambient in free air *	$R_{th\ j-a}$	=	125 K/W

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$

Forward voltage

$I_F = 50\text{ mA}$

$V_F < 1,0\text{ V}$

Reverse current

BZV49- C2V4

$V_R = 1\text{ V}$

$I_R < 50\text{ }\mu\text{A}$

C2V7

$V_R = 1\text{ V}$

$I_R < 20\text{ }\mu\text{A}$

C3V0

$V_R = 1\text{ V}$

$I_R < 10\text{ }\mu\text{A}$

C3V3

$V_R = 1\text{ V}$

$I_R < 5\text{ }\mu\text{A}$

C3V6

$V_R = 1\text{ V}$

$I_R < 5\text{ }\mu\text{A}$

C3V9

$V_R = 1\text{ V}$

$I_R < 3\text{ }\mu\text{A}$

C4V3

$V_R = 1\text{ V}$

$I_R < 3\text{ }\mu\text{A}$

C4V7

$V_R = 2\text{ V}$

$I_R < 3\text{ }\mu\text{A}$

C5V1

$V_R = 2\text{ V}$

$I_R < 2\text{ }\mu\text{A}$

C5V6

$V_R = 2\text{ V}$

$I_R < 1\text{ }\mu\text{A}$

C6V2

$V_R = 4\text{ V}$

$I_R < 3\text{ }\mu\text{A}$

C6V8

$V_R = 4\text{ V}$

$I_R < 2\text{ }\mu\text{A}$

C7V5

$V_R = 5\text{ V}$

$I_R < 1\text{ }\mu\text{A}$

C8V2

$V_R = 5\text{ V}$

$I_R < 700\text{ nA}$

C9V1

$V_R = 6\text{ V}$

$I_R < 500\text{ nA}$

C10

$V_R = 7\text{ V}$

$I_R < 200\text{ nA}$

C11 to C13

$V_R = 8\text{ V}$

$I_R < 100\text{ nA}$

C15 to C75

$V_R = 0,7\text{ }V_{Znom}$

$I_R < 50\text{ nA}$

\* Device mounted on a ceramic substrate: area = 2,5 cm<sup>2</sup>; thickness = 0,7 mm.

$T_j = 25\text{ }^\circ\text{C}$ E24 logarithmic range (tolerance  $\pm 5\%$ )

BZV49-...	working voltage		differential resistance		temperature coefficient			diode capacitance	
	$V_Z$ (V)		$r_{\text{diff}}$ ( $\Omega$ )		$S_Z$ (mV/K)			$C_d$ (pF); $f = 1\text{ MHz}$	
	at $I_{Z\text{test}} = 5\text{ mA}$		at $I_{Z\text{test}} = 5\text{ mA}$		at $I_{Z\text{test}} = 5\text{ mA}$			$V_R = 0$	
	min.	max.	typ.	max.	min.	typ.	max.	typ.	max.
C2V4	2,2	2,6	70	100	-3,5	-1,6	0	375	450
C2V7	2,5	2,9	75	100	-3,5	-2,0	0	350	450
C3V0	2,8	3,2	80	95	-3,5	-2,1	0	350	450
C3V3	3,1	3,5	85	95	-3,5	-2,4	0	325	450
C3V6	3,4	3,8	85	90	-3,5	-2,4	0	300	450
C3V9	3,7	4,1	85	90	-3,5	-2,5	0	300	450
C4V3	4,0	4,6	80	90	-3,5	-2,5	0	275	450
C4V7	4,4	5,0	50	80	-3,5	-1,4	0,2	130	180
C5V1	4,8	5,4	40	60	-2,7	-0,8	1,2	110	160
C5V6	5,2	6,0	15	40	-2,0	1,2	2,5	95	140
C6V2	5,8	6,6	6	10	0,4	2,3	3,7	90	130
C6V8	6,4	7,2	6	15	1,2	3,0	4,5	85	110
C7V5	7,0	7,9	6	15	2,5	4,0	5,3	80	100
C8V2	7,7	8,7	6	15	3,2	4,6	6,2	75	95
C9V1	8,5	9,6	6	15	3,8	5,5	7,0	70	90
C10	9,4	10,6	8	20	4,5	6,4	8,0	70	90
C11	10,4	11,6	10	20	5,4	7,4	9,0	65	85
C12	11,4	12,7	10	25	6,0	8,4	10,0	65	85
C13	12,4	14,1	10	30	7,0	9,4	11,0	60	80
C15	13,8	15,6	10	30	9,2	11,4	13,0	55	75
C16	15,3	17,1	10	40	10,4	12,4	14,0	52	75
C18	16,8	19,1	10	45	12,4	14,4	16,0	47	70
C20	18,8	21,2	15	55	14,4	16,4	18,0	36	60
C22	20,8	23,3	20	55	16,4	18,4	20,0	34	60
C24	22,8	25,6	25	70	18,4	20,4	22,0	33	55
	at $I_{Z\text{test}} = 2\text{ mA}$		at $I_{Z\text{test}} = 2\text{ mA}$		at $I_{Z\text{test}} = 2\text{ mA}$				
C27	25,1	28,9	25	80	21,4	23,4	25,3	30	50
C30	28,0	32,0	30	80	24,4	26,6	29,4	27	50
C33	31,0	35,0	35	80	27,4	29,7	33,4	25	45
C36	34,0	38,0	35	90	30,4	33,0	37,4	23	45
C39	37,0	41,0	40	130	33,4	36,4	41,2	21	45
C43	40,0	46,0	45	150	37,6	41,2	46,6	21	40
C47	44,0	50,0	50	170	42,0	46,1	51,8	19	40
C51	48,0	54,0	60	180	46,6	51,0	57,2	19	40
C56	52,0	60,0	70	200	52,2	57,0	63,8	18	40
C62	58,0	66,0	80	215	58,8	64,4	71,6	17	35
C68	64,0	72,0	90	240	65,6	71,7	79,8	17	35
C75	70,0	79,0	95	255	73,4	80,2	88,6	16,5	35

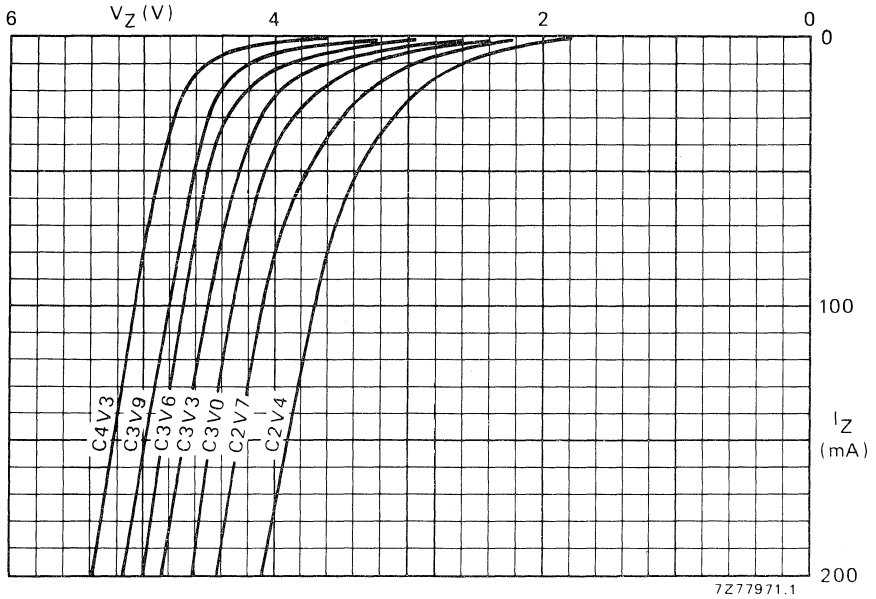


Fig. 2 Dynamic characteristics; typical values;  $T_j = 25^\circ\text{C}$ .

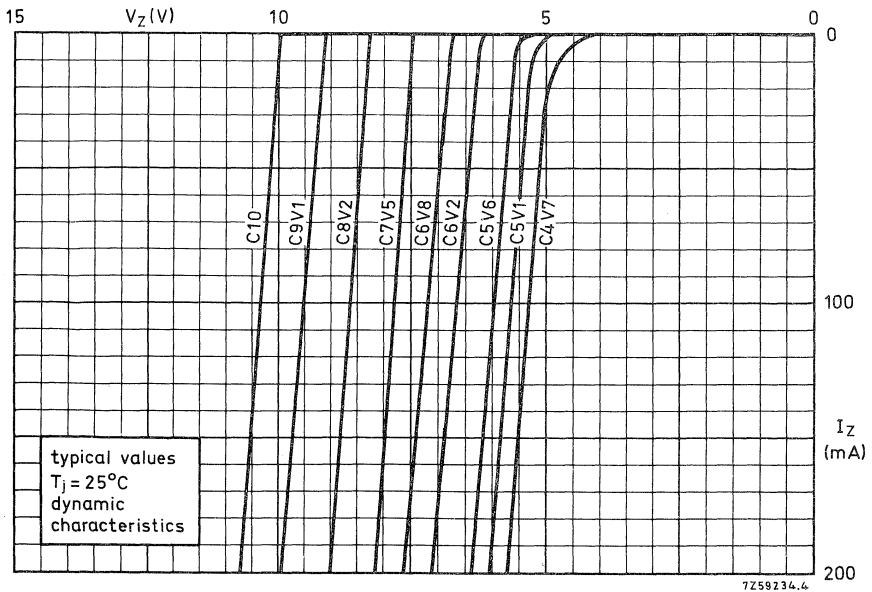


Fig. 3 Dynamic characteristics; typical values at  $T_j = 25^\circ\text{C}$ .



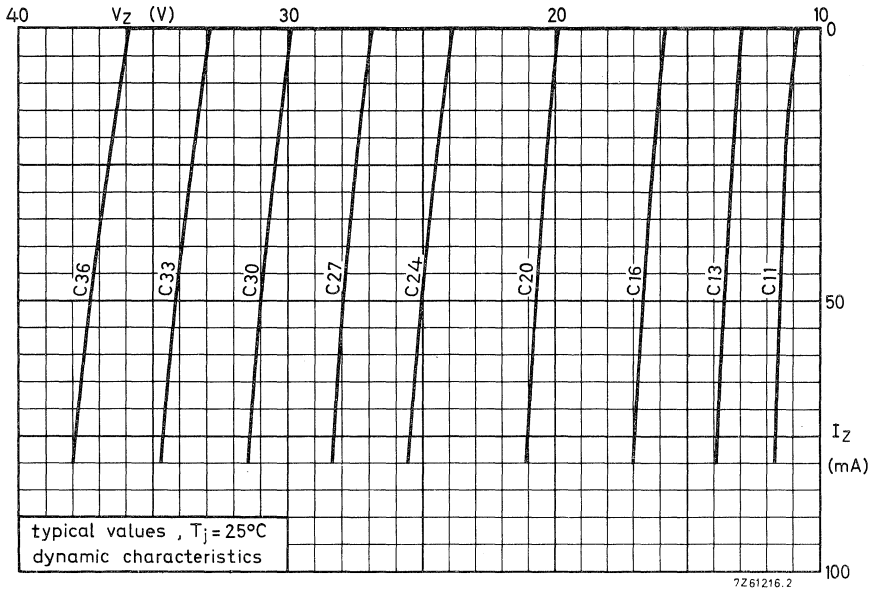


Fig. 4 Dynamic characteristics; typical values;  $T_j = 25^\circ\text{C}$ .

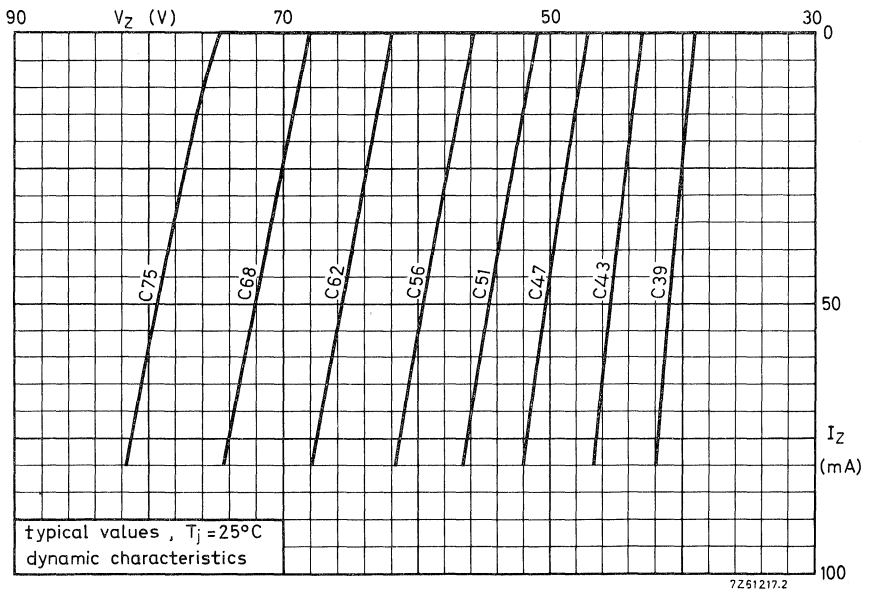


Fig. 5 Dynamic characteristics; typical values at  $T_j = 25^\circ\text{C}$ .

**Model for calculating the static working voltage ( $V_{Z\ stat}$ ).**

This model can be derived from  $V_{Z\ stat} = V_{Z\ dyn} + \Delta V_Z$  of which  $V_{Z\ dyn}$  is given in the preceding tables and can be derived from the typical dynamic characteristic curves (Figs 2, 3, 4 and 5)

$\Delta V_Z = \Delta T \times S_Z$ . For  $S_Z$  see tables and graphs  $S_Z$  versus  $T_j$ .

$\Delta T = P_{tot} \times R_{th\ j-a} = I_Z \times V_{Z\ dyn} \times R_{th\ j-a}$ .

Following  $\Delta V_Z = I_Z \times V_{Z\ dyn} \times R_{th\ j-a} \times S_Z$  and the model will be:

$$V_{Z\ stat} = V_{Z\ dyn} + I_Z \times V_{Z\ dyn} \times R_{th\ j-a} \times S_Z$$

**Calculating example**

BZV49-C24 mounted on a ceramic substrate of 7 x 5 x 0,6 mm; at  $I_Z = 7\ mA$ .

$$V_{Z\ stat} = 24 + \left( \frac{7}{1000} \times 24 \times \frac{125}{1000} \times 20,3 \right)$$

$$= 24 + 0,4 = 24,4\ V.$$

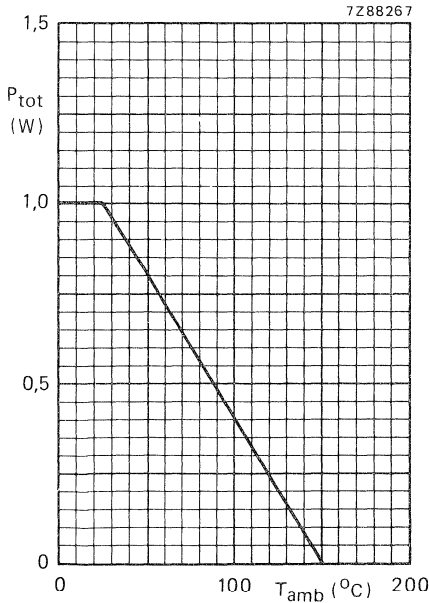


Fig. 6 Power derating curve.

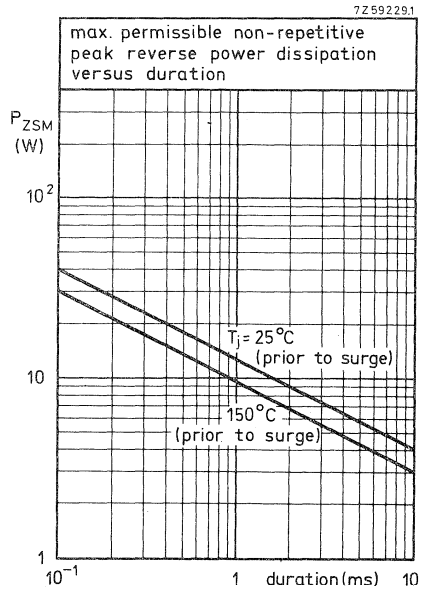


Fig. 7.

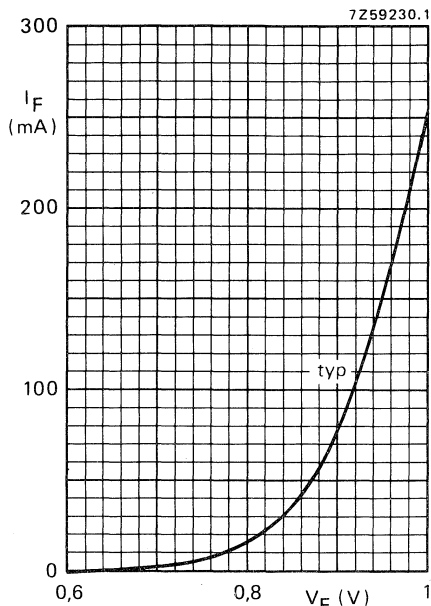


Fig. 8  $T_j = 25^\circ\text{C}$ .

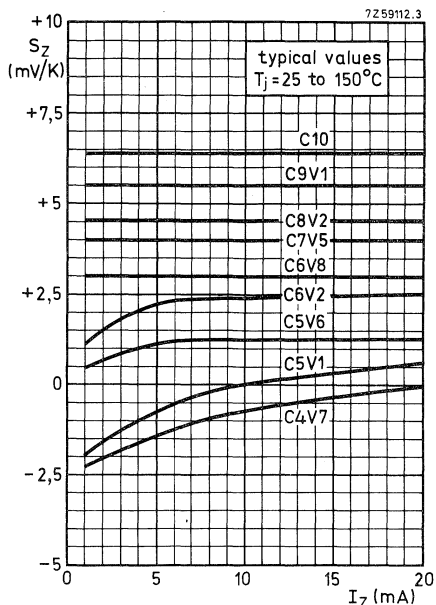


Fig. 9.

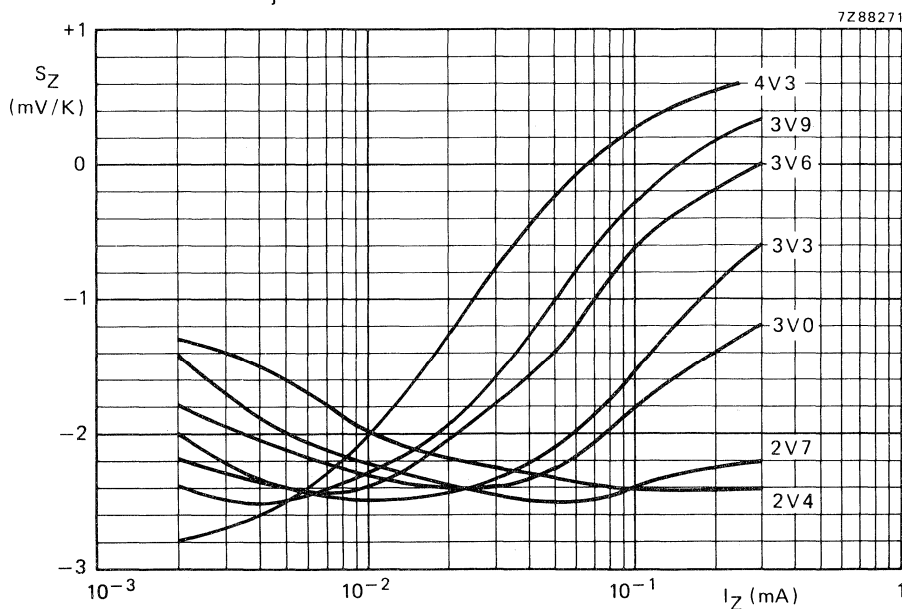


Fig. 10 Typical values temperature coefficient.

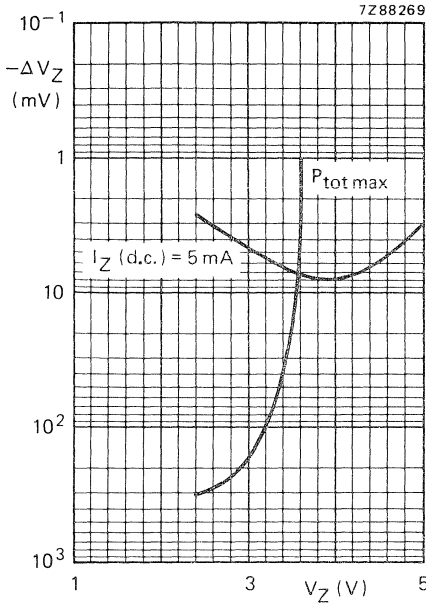


Fig. 11 Typical change of working voltage;  $T_j = 25^\circ\text{C}$ .

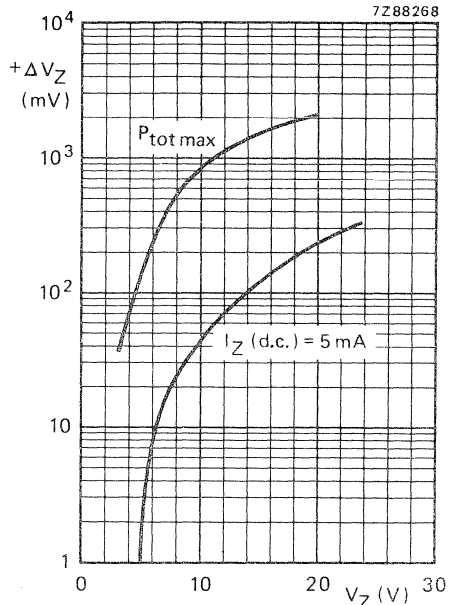


Fig. 12 Typical change of working voltage;  $T_{amb} = 25^\circ\text{C}$ .

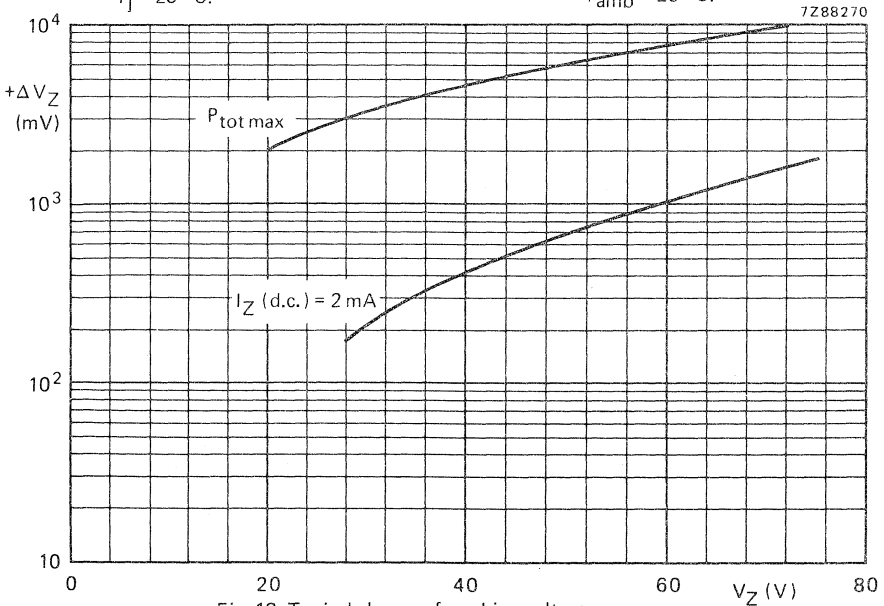


Fig. 13 Typical change of working voltage.

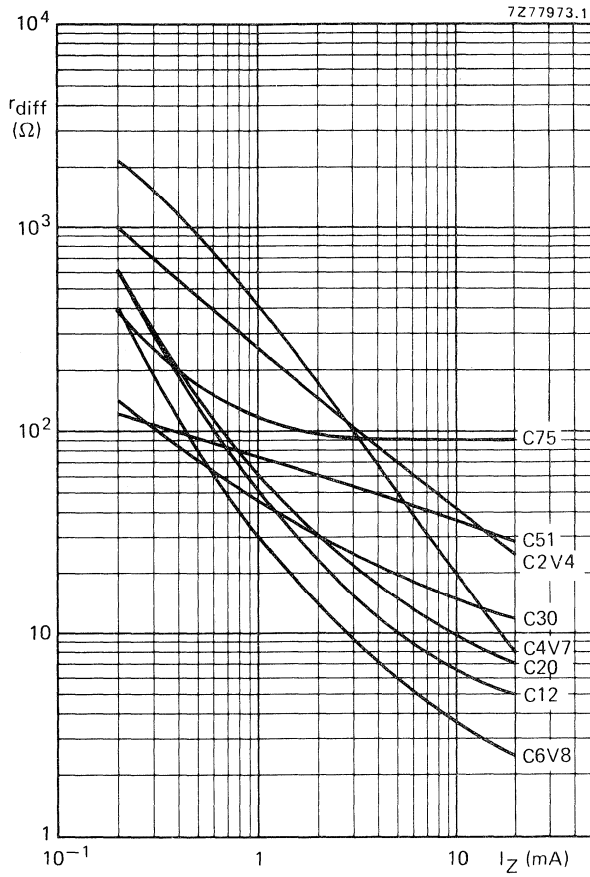


Fig. 14 Typical values;  $T_j = 25^\circ\text{C}$ ;  $f = 1\text{ kHz}$ .



## DEVELOPMENT SAMPLE DATA

This information is derived from development samples made available for evaluation. It does not necessarily imply that the device will go into regular production.

## BZV55 SERIES

### VOLTAGE REGULATOR DIODES FOR SURFACE MOUNTING

Silicon planar diodes designed for use as low-voltage stabilizers or voltage references.

They are available in the international standardized E24 ( $\pm 5\%$ ) range. The series consists of 37 types with nominal working voltages ranging from 2,4 V to 75 V.

The SM diode is a leadless diode in an hermetically sealed glass SOD-80 envelope with tinplated metal discs at each end. It is suitable for "automatic placement" and as such it can withstand immersion soldering.

The diodes are delivered in "super 8" tape.

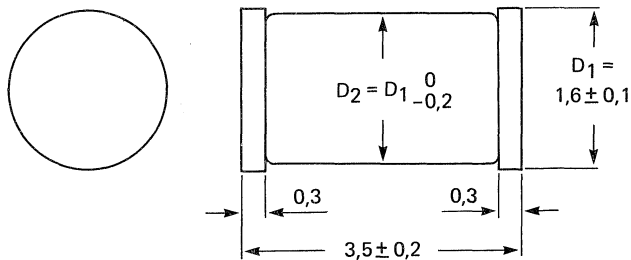
#### QUICK REFERENCE DATA

Working voltage range	$V_Z$	nom. 2,4 to 75 V
Total power dissipation up to flange temperature of 50 °C	$P_{tot}$	max. 500 mW
Non-repetitive peak reverse power dissipation	$P_{ZSM}$	max. 30 W
Junction temperature	$T_j$	max. 200 °C
Thermal resistance from junction to tie-point	$R_{th\ j-tp}$	= 0,30 K/mW

#### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOD-80.



7Z91084

The BZV55 cathode is indicated by a yellow band.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134).

Average forward current (averaged over any 20 ms period)	$I_{F(AV)}$	max.	250 mA
Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Total power dissipation up to $T_{flange} = 50\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	500 mW
up to $T_{amb} = 50\text{ }^{\circ}\text{C}$ and mounted on a ceramic substrate of 10 mm x 10 mm x 0,6 mm	$P_{tot}$	max.	400 mW
Non-repetitive peak reverse power dissipation $t = 100\text{ }\mu\text{s}; T_j = 150\text{ }^{\circ}\text{C}$	$P_{ZSM}$	max.	30 W
Storage temperature	$T_{stg}$	-65 to +200	$^{\circ}\text{C}$
Junction temperature	$T_j$	max.	200 $^{\circ}\text{C}$

## THERMAL RESISTANCE

From junction to tie-point (flanges)	$R_{th\ j-tp}$	=	0,30 K/mW
From junction to ambient when mounted on a ceramic substrate of 10 mm x 10 mm x 0,6 mm	$R_{th\ j-a}$	=	0,38 K/mW

## CHARACTERISTICS

$T_j = 25\text{ }^{\circ}\text{C}$  unless otherwise specified

Forward voltage $I_F = 10\text{ mA}$	$V_F$	<	0,9 V
Reverse current	$I_R$	<	50 $\mu\text{A}$
BZV55-.2V4 $V_R = 1\text{ V}$	$I_R$	<	20 $\mu\text{A}$
.2V7 $V_R = 1\text{ V}$	$I_R$	<	10 $\mu\text{A}$
.3V0 $V_R = 1\text{ V}$	$I_R$	<	5 $\mu\text{A}$
.3V3 $V_R = 1\text{ V}$	$I_R$	<	5 $\mu\text{A}$
.3V6 $V_R = 1\text{ V}$	$I_R$	<	3 $\mu\text{A}$
.3V9 $V_R = 1\text{ V}$	$I_R$	<	3 $\mu\text{A}$
.4V3 $V_R = 1\text{ V}$	$I_R$	<	3 $\mu\text{A}$
.4V7 $V_R = 2\text{ V}$	$I_R$	<	3 $\mu\text{A}$
.5V1 $V_R = 2\text{ V}$	$I_R$	<	2 $\mu\text{A}$
.5V6 $V_R = 2\text{ V}$	$I_R$	<	1 $\mu\text{A}$
.6V2 $V_R = 4\text{ V}$	$I_R$	<	3 $\mu\text{A}$
.6V8 $V_R = 4\text{ V}$	$I_R$	<	2 $\mu\text{A}$
.7V5 $V_R = 5\text{ V}$	$I_R$	<	1 $\mu\text{A}$
.8V2 $V_R = 5\text{ V}$	$I_R$	<	700 nA
.9V1 $V_R = 6\text{ V}$	$I_R$	<	500 nA
.10 $V_R = 7\text{ V}$	$I_R$	<	200 nA
.11 to .13 $V_R = 8\text{ V}$	$I_R$	<	100 nA
.15 to .75 $V_R = 0,7 V_{Znom}$	$I_R$	<	50 nA

. = C for E24 ( $\pm 5\%$ ) tolerance



$T_j = 25\text{ }^\circ\text{C}$ E24 ( $\pm 5\%$ ) logarithmic range

BZV55- ...	working voltage		differential resistance		temperature coefficient			diode capacitance	
	$V_Z$ (V)		$r_{\text{diff}}$ ( $\Omega$ )		$S_Z$ (mV/K)			$C_d$ (pF)	
	at $I_{Z\text{test}} = 5\text{ mA}$		at $I_{Z\text{test}} = 5\text{ mA}$		at $I_{Z\text{test}} = 5\text{ mA}$			at $f = 1\text{ MHz}$	
	min.	max.	typ.	max.	min.	typ.	max.	typ.	max.
C2V4	2,2	2,6	70	100	-3,5	-1,6	0	375	450
C2V7	2,5	2,9	75	100	-3,5	-2,0	0	350	450
C3V0	2,8	3,2	80	95	-3,5	-2,1	0	350	450
C3V3	3,1	3,5	85	95	-3,5	-2,4	0	325	450
C3V6	3,4	3,8	85	90	-3,5	-2,4	0	300	450
C3V9	3,7	4,1	85	90	-3,5	-2,5	0	300	450
C4V3	4,0	4,6	80	90	-3,5	-2,5	0	275	450
C4V7	4,4	5,0	50	80	-3,5	-1,4	0,2	125	180
C5V1	4,8	5,4	40	60	-2,7	-0,8	1,2	125	180
C5V6	5,2	6,0	15	40	-2,0	1,2	2,5	125	180
C6V2	5,8	6,6	6	10	0,4	2,3	3,7	90	130
C6V8	6,4	7,2	6	15	1,2	3,0	4,5	85	110
C7V5	7,0	7,9	6	15	2,5	4,0	5,3	80	100
C8V2	7,7	8,7	6	15	3,2	4,6	6,2	75	95
C9V1	8,5	9,6	6	15	3,8	5,5	7,0	70	90
C10	9,4	10,6	8	20	4,5	6,4	8,0	70	90
C11	10,4	11,6	10	20	5,4	7,4	9,0	65	85
C12	11,4	12,7	10	25	6,0	8,4	10,0	65	85
C13	12,4	14,1	10	30	7,0	9,4	11,0	60	80
C15	13,8	15,6	10	30	9,2	11,4	13,0	55	75
C16	15,3	17,1	10	40	10,4	12,4	14,0	52	75
C18	16,8	19,1	10	45	12,4	14,4	16,0	47	70
C20	18,8	21,2	15	55	14,4	16,4	18,0	36	60
C22	20,8	23,3	20	55	16,4	18,4	20,0	34	60
C24	22,8	25,6	25	70	18,4	20,4	22,0	33	55
	at $I_{Z\text{test}} = 2\text{ mA}$		at $I_{Z\text{test}} = 2\text{ mA}$		at $I_{Z\text{test}} = 2\text{ mA}$				
C27	25,1	28,9	25	80	21,4	23,4	25,3	30	50
C30	28,0	32,0	30	80	24,4	26,6	29,4	27	50
C33	31,0	35,0	35	80	27,4	29,7	33,4	25	45
C36	34,0	38,0	35	90	30,4	33,0	37,4	23	45
C39	37,0	41,0	40	130	33,4	36,4	41,2	21	45
C43	40,0	46,0	45	150	37,6	41,2	46,6	21	40
C47	44,0	50,0	50	170	42,0	46,1	51,8	19	40
C51	48,0	54,0	60	180	46,6	51,0	57,2	19	40
C56	52,0	60,0	70	200	52,2	57,0	63,8	18	40
C62	58,0	66,0	80	215	58,8	64,4	71,6	17	35
C68	64,0	72,0	90	240	65,6	71,7	79,8	17	35
C75	70,0	79,0	95	255	73,4	80,2	88,6	16,5	35

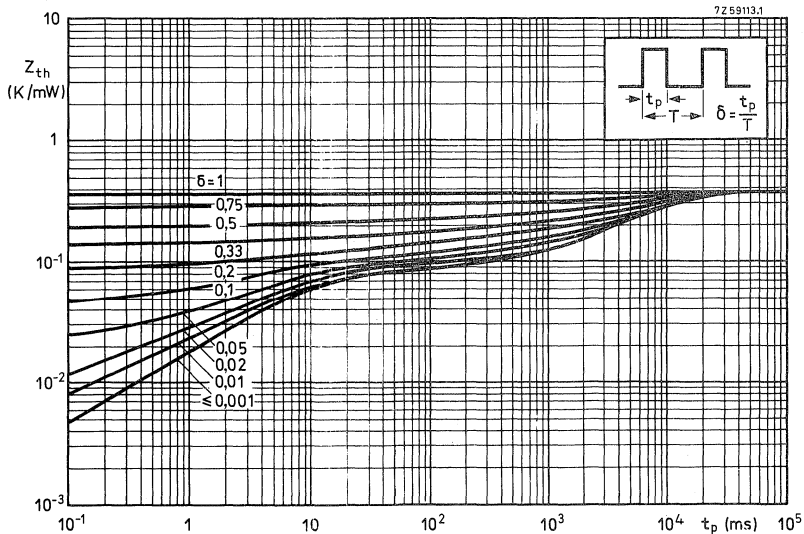
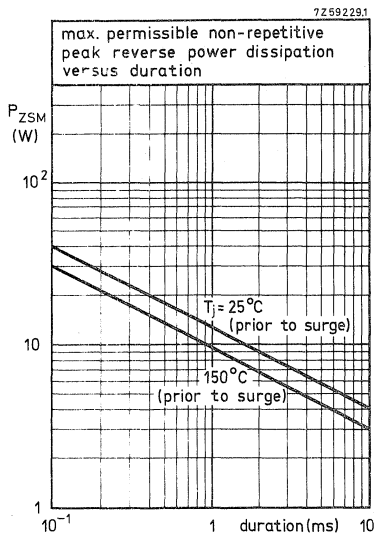
# BZV55 SERIES

$T_j = 25\text{ }^\circ\text{C}$

E24 ( $\pm 5\%$ ) logarithmic range

BZV55- ...	working voltage			differential resistance		working voltage			differential resistance	
	$V_Z$ (V)			$r_{\text{diff}}$ ( $\Omega$ )		$V_Z$ (V)			$r_{\text{diff}}$ ( $\Omega$ )	
	at $I_Z = 1\text{ mA}$			at $I_Z = 1\text{ mA}$		at $I_Z = 20\text{ mA}$			at $I_Z = 20\text{ mA}$	
	min.	nom.	max.	typ.	max.	min.	nom.	max.	typ.	max.
C2V4	1,7	1,9	2,1	275	600	2,6	2,9	3,2	25	50
C2V7	1,9	2,2	2,4	300	600	3,0	3,3	3,6	25	50
C3V0	2,1	2,4	2,7	325	600	3,3	3,6	3,9	25	50
C3V3	2,3	2,6	2,9	350	600	3,6	3,9	4,2	20	40
C3V6	2,7	3,0	3,3	375	600	3,9	4,2	4,5	20	40
C3V9	2,9	3,2	3,5	400	600	4,1	4,4	4,7	15	30
C4V3	3,3	3,6	4,0	410	600	4,4	4,7	5,1	15	30
C4V7	3,7	4,2	4,7	425	500	4,5	5,0	5,4	8	15
C5V1	4,2	4,7	5,3	400	480	5,0	5,4	5,9	6	15
C5V6	4,8	5,4	6,0	80	400	5,2	5,7	6,3	4	10
C6V2	5,6	6,1	6,6	40	150	5,8	6,3	6,8	3	6
C6V8	6,3	6,7	7,2	30	80	6,4	6,9	7,4	2,5	6
C7V5	6,9	7,4	7,9	30	80	7,0	7,6	8,0	2,5	6
C8V2	7,6	8,1	8,7	40	80	7,7	8,3	8,8	3	6
C9V1	8,4	9,0	9,6	40	100	8,5	9,2	9,7	4	8
C10	9,3	9,9	10,6	50	150	9,4	10,1	10,7	4	10
C11	10,2	10,9	11,6	50	150	10,4	11,1	11,8	5	10
C12	11,2	11,9	12,7	50	150	11,4	12,1	12,9	5	10
C13	12,3	12,9	14,0	50	170	12,5	13,1	14,2	5	15
C15	13,7	14,9	15,5	50	200	13,9	15,1	15,7	6	20
C16	15,2	15,9	17,0	50	200	15,4	16,1	17,2	6	20
C18	16,7	17,9	19,0	50	225	16,9	18,1	19,2	6	20
C20	18,7	19,9	21,1	60	225	18,9	20,1	21,4	7	20
C22	20,7	21,9	23,2	60	250	20,9	22,1	23,4	7	25
C24	22,7	23,9	25,5	60	250	22,9	24,1	25,7	7	25
	at $I_Z = 0,1\text{ mA}$			at $I_Z = 0,5\text{ mA}$		at $I_Z = 10\text{ mA}$			at $I_Z = 10\text{ mA}$	
C27	25,0	26,9	28,9	65	300	25,2	27,1	29,3	10	45
C30	27,8	29,9	32,0	70	300	28,1	30,1	32,4	15	50
C33	30,8	32,9	35,0	75	325	31,1	33,1	35,4	20	55
C36	33,8	35,9	38,0	80	350	34,1	36,1	38,4	25	60
C39	36,7	38,9	41,0	80	350	37,1	39,1	41,5	25	70
C43	39,7	42,9	46,0	85	375	40,1	43,1	46,5	25	80
C47	43,7	46,8	50,0	85	375	44,1	47,1	50,5	30	90
C51	47,6	50,8	54,0	90	400	48,1	51,1	54,6	35	100
C56	51,5	55,7	60,0	100	425	52,1	56,1	60,8	45	110
C62	57,4	61,7	66,0	120	450	58,2	62,1	67,0	60	120
C68	63,4	67,7	72,0	150	475	64,2	68,2	73,2	75	130
C75	69,4	74,7	79,0	170	500	70,3	75,3	80,2	90	140

DEVELOPMENT SAMPLE DATA



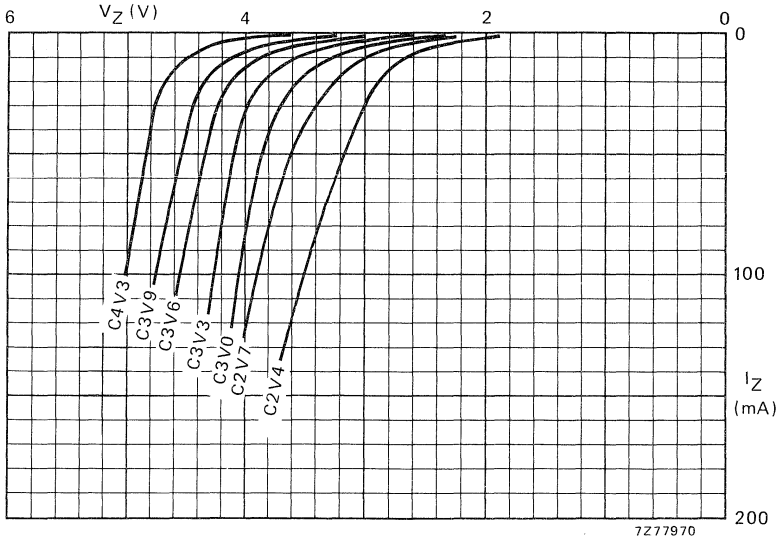


Fig. 4 Static characteristics; typical values;  $T_{amb} = 25\text{ }^\circ\text{C}$ .

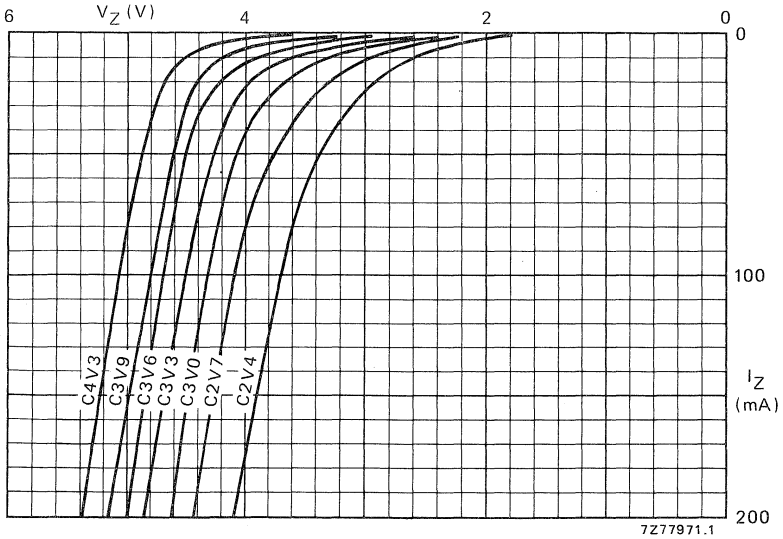


Fig. 5 Dynamic characteristics; typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

DEVELOPMENT SAMPLE DATA

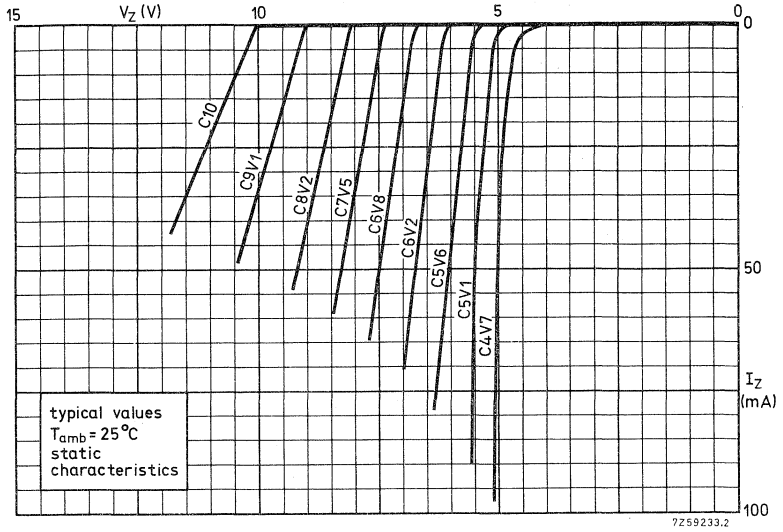


Fig. 6.

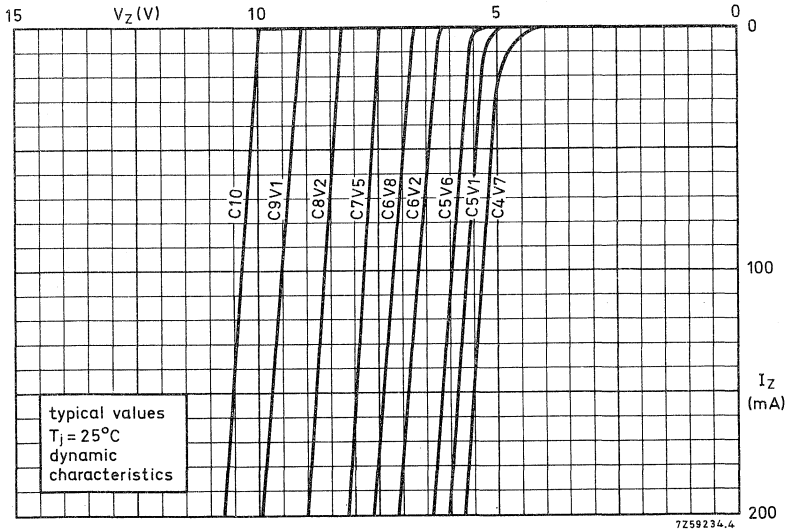


Fig. 7.

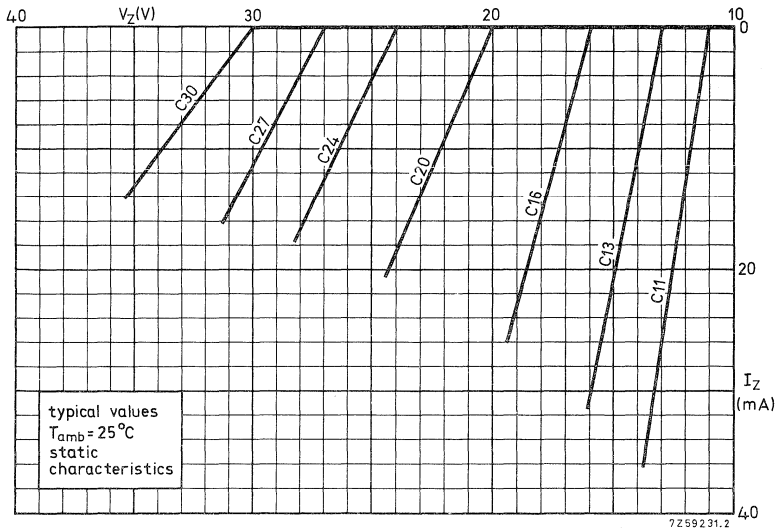


Fig. 8.

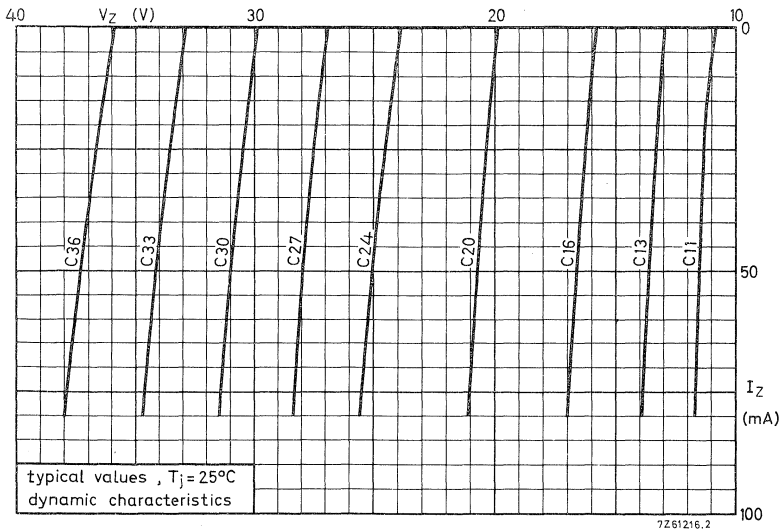


Fig. 9.

DEVELOPMENT SAMPLE DATA

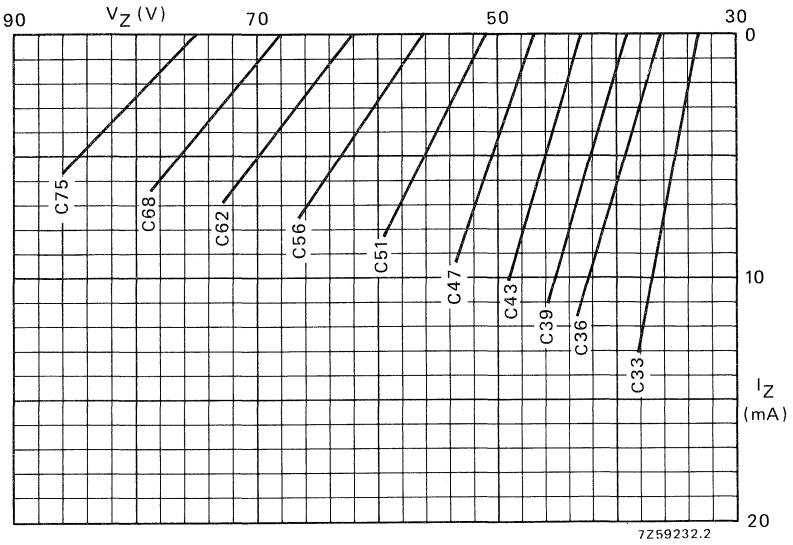


Fig. 10 Static characteristics; typical values;  $T_{amb} = 25^\circ C$ .

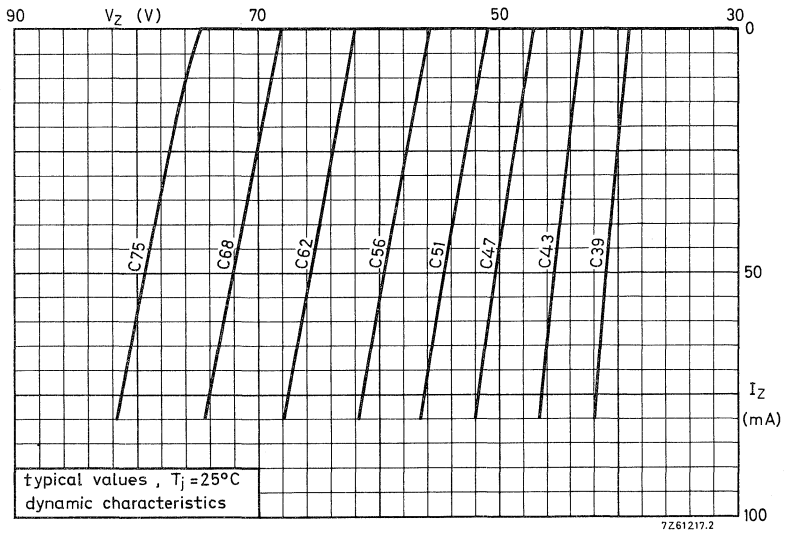


Fig. 11.

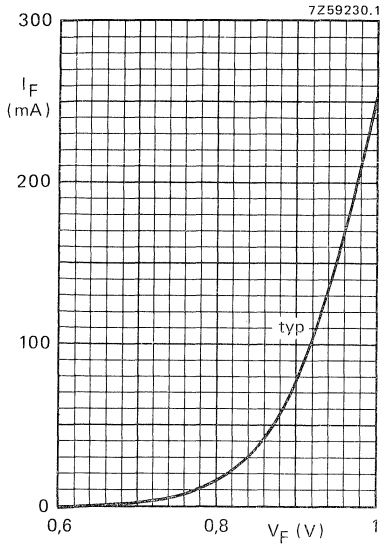


Fig. 12  $T_j = 25^\circ\text{C}$ .

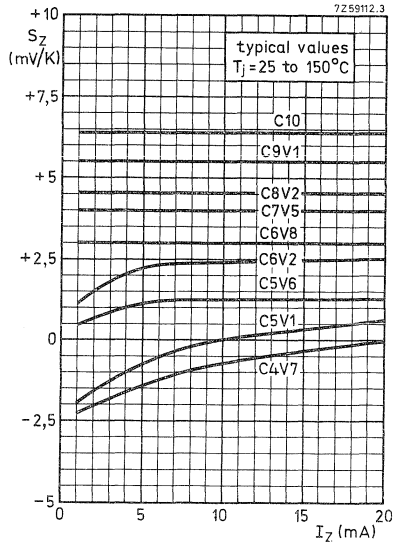


Fig. 13.

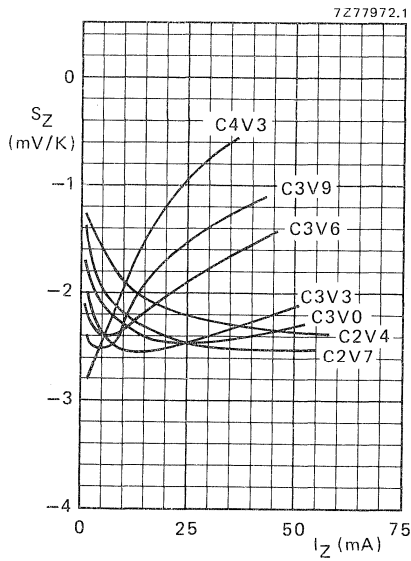


Fig. 14 Typical values;  $T_j = 25$  to  $150^\circ\text{C}$ .



DEVELOPMENT SAMPLE DATA

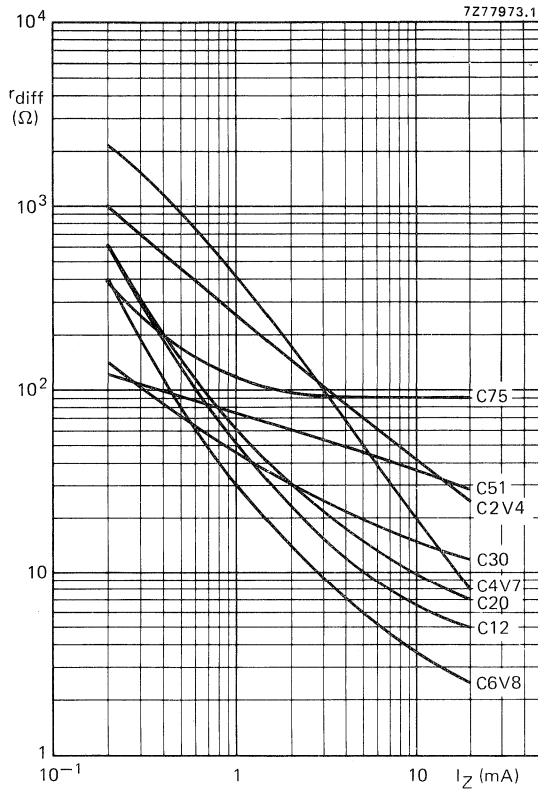


Fig. 15 Typical values;  $T_j = 25^\circ\text{C}$ ;  $f = 1\text{ kHz}$ .

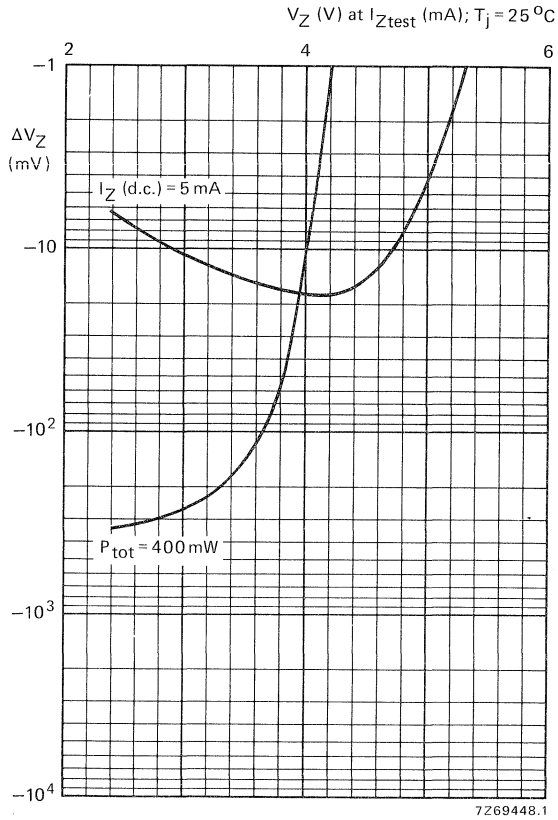


Fig. 16 Typical change of working voltage under operating conditions at  $T_{amb} = 25^\circ\text{C}$ .

DEVELOPMENT SAMPLE DATA

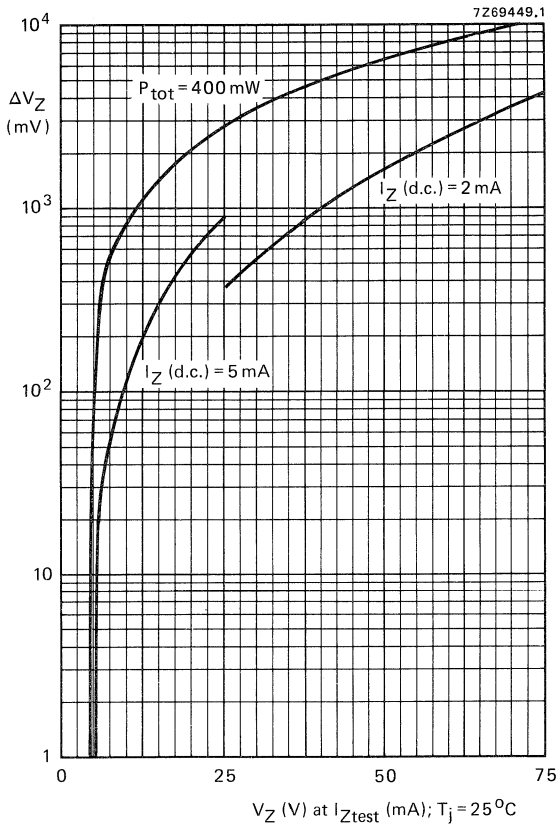


Fig. 17 Typical change of working voltage under operating conditions at  $T_{amb} = 25^\circ\text{C}$ .



## SILICON PLANAR VOLTAGE REGULATOR DIODES

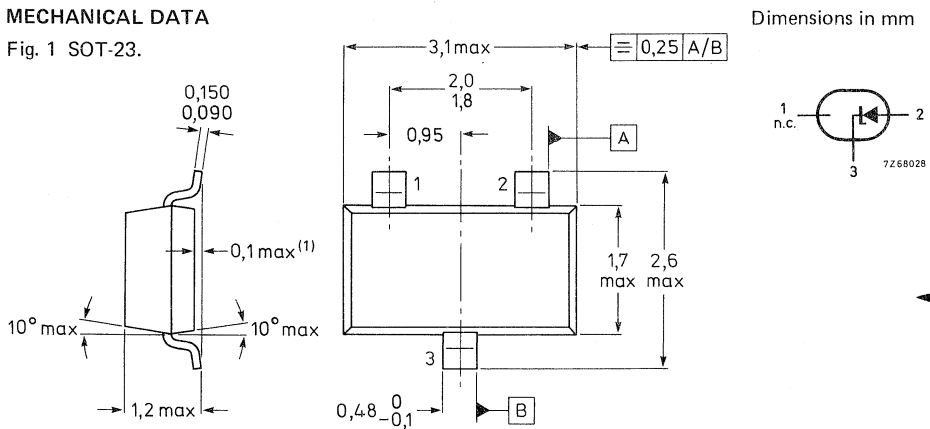
Low power general purpose voltage regulator diodes in a microminiature plastic envelope intended for application in thick and thin-film circuits. The series covers the normalized range of nominal working voltages from 2,4 V to 75 V with a working voltage tolerance of  $\pm 5\%$ .

### QUICK REFERENCE DATA

Working voltage range	$V_Z$	nom.	2,4 to 75 V
Working voltage tolerance			$\pm 5\%$
Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	350 mW
Junction temperature	$T_j$	max.	175 $^\circ\text{C}$

### MECHANICAL DATA

Fig. 1 SOT-23.



(1) Also available in 0,1 – 0,2 mm version. TOP VIEW

See also *Soldering recommendations*.

### Marking code

BZX84-C2V4 = Z11	BZX84-C5V6 = Z3	BZX84-C13 = Y3	BZX84-C33 = Y12
C2V7 = Z12	C6V2 = Z4	C15 = Y4	C36 = Y13
C3V0 = Z13	C6V8 = Z5	C16 = Y5	C39 = Y14
C3V3 = Z14	C7V5 = Z6	C18 = Y6	C43 = Y15
C3V6 = Z15	C8V2 = Z7	C20 = Y7	C47 = Y16
C3V9 = Z16	C9V1 = Z8	C22 = Y8	C51 = Y17
C4V3 = Z17	C10 = Z9	C24 = Y9	C56 = Y18
C4V7 = Z1	C11 = Y1	C27 = Y10	C62 = Y19
C5V1 = Z2	C12 = Y2	C30 = Y11	C68 = Y20
			C75 = Y21

# BZX84 SERIES

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Repetitive peak forward current	$I_{FRM}$	max.	250 mA
Repetitive peak working current	$I_{ZRM}$	max.	250 mA
Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}^{**}$	$P_{tot}$	max.	350 mW
Storage temperature	$T_{stg}$	-65 to + 175	$^{\circ}\text{C}$
Junction temperature	$T_j$	max.	175 $^{\circ}\text{C}$

## THERMAL CHARACTERISTICS\*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

### Thermal resistance

From junction to tab	$R_{th\ j-t}$	=	50 K/W
From tab to soldering points	$R_{th\ t-s}$	=	280 K/W
From soldering points to ambient**	$R_{th\ s-a}$	=	90 K/W

## CHARACTERISTICS

$T_j = 25\text{ }^{\circ}\text{C}$  unless otherwise specified

Forward voltage

$$I_F = 10\text{ mA}$$

$$V_F < 0,9\text{ V}$$

Reverse current

BZX84-C2V4

$$V_R = 1\text{ V}$$

$$I_R < 50\ \mu\text{A}$$

C2V7

$$V_R = 1\text{ V}$$

$$I_R < 20\ \mu\text{A}$$

C3V0

$$V_R = 1\text{ V}$$

$$I_R < 10\ \mu\text{A}$$

C3V3

$$V_R = 1\text{ V}$$

$$I_R < 5\ \mu\text{A}$$

C3V6

$$V_R = 1\text{ V}$$

$$I_R < 5\ \mu\text{A}$$

C3V9

$$V_R = 1\text{ V}$$

$$I_R < 3\ \mu\text{A}$$

C4V3

$$V_R = 1\text{ V}$$

$$I_R < 3\ \mu\text{A}$$

C4V7

$$V_R = 2\text{ V}$$

$$I_R < 3\ \mu\text{A}$$

C5V1

$$V_R = 2\text{ V}$$

$$I_R < 2\ \mu\text{A}$$

C5V6

$$V_R = 2\text{ V}$$

$$I_R < 1\ \mu\text{A}$$

C6V2

$$V_R = 4\text{ V}$$

$$I_R < 3\ \mu\text{A}$$

C6V8

$$V_R = 4\text{ V}$$

$$I_R < 2\ \mu\text{A}$$

C7V5

$$V_R = 5\text{ V}$$

$$I_R < 1\ \mu\text{A}$$

C8V2

$$V_R = 5\text{ V}$$

$$I_R < 700\ \text{nA}$$

C9V1

$$V_R = 6\text{ V}$$

$$I_R < 500\ \text{nA}$$

C10

$$V_R = 7\text{ V}$$

$$I_R < 200\ \text{nA}$$

C11

$$V_R = 8\text{ V}$$

$$I_R < 100\ \text{nA}$$

C12

$$V_R = 8\text{ V}$$

$$I_R < 100\ \text{nA}$$

C13

$$V_R = 8\text{ V}$$

$$I_R < 100\ \text{nA}$$

C15 to C75

$$V_R = 0,7\ V_{Znom}$$

$$I_R < 50\ \text{nA}$$

\* See *Thermal characteristics*.

\*\* Device mounted on a ceramic substrate of 8 mm x 10 mm x 0,7 mm.

BZX84....	working voltage		differential resistance		temperature coefficient			diode capacitance	
	$V_Z$ (V)		$r_{diff}$ ( $\Omega$ )		$S_Z$ (mV/°C)			$C_d$ (pF); $f = 1$ MHz	
	at $I_{Ztest} = 5$ mA		at $I_{Ztest} = 5$ mA		at $I_{Ztest} = 5$ mA			$V_R = 0$	
	min.	max.	typ.	max.	min.	typ.	max.	typ.	max.
C2V4	2,2	2,6	70	100	-3,5	-1,6	0	375	450
C2V7	2,5	2,9	75	100	-3,5	-2,0	0	350	450
C3V0	2,8	3,2	80	95	-3,5	-2,1	0	350	450
C3V3	3,1	3,5	85	95	-3,5	-2,4	0	325	450
C3V6	3,4	3,8	85	90	-3,5	-2,4	0	300	450
C3V9	3,7	4,1	85	90	-3,5	-2,5	0	300	450
C4V3	4,0	4,6	80	90	-3,5	-2,5	0	275	450
C4V7	4,4	5,0	50	80	-3,5	-1,4	0,2	130	180
C5V1	4,8	5,4	40	60	-2,7	-0,8	1,2	110	160
C5V6	5,2	6,0	15	40	-2,0	1,2	2,5	95	140
C6V2	5,8	6,6	6	10	0,4	2,3	3,7	90	130
C6V8	6,4	7,2	6	15	1,2	3,0	4,5	85	110
C7V5	7,0	7,9	6	15	2,5	4,0	5,3	80	100
C8V2	7,7	8,7	6	15	3,2	4,6	6,2	75	95
C9V1	8,5	9,6	6	15	3,8	5,5	7,0	70	90
C10	9,4	10,6	8	20	4,5	6,4	8,0	70	90
C11	10,4	11,6	10	20	5,4	7,4	9,0	65	85
C12	11,4	12,7	10	25	6,0	8,4	10,0	65	85
C13	12,4	14,1	10	30	7,0	9,4	11,0	60	80
C15	13,8	15,6	10	30	9,2	11,4	13,0	55	75
C16	15,3	17,1	10	40	10,4	12,4	14,0	52	75
C18	16,8	19,1	10	45	12,4	14,4	16,0	47	70
C20	18,8	21,2	15	55	14,4	16,4	18,0	36	60
C22	20,8	23,3	20	55	16,4	18,4	20,0	34	60
C24	22,8	25,6	25	70	18,4	20,4	22,0	33	55
	at $I_Z = 2$ mA		at $I_Z = 2$ mA		at $I_Z = 2$ mA			typ.	max.
	min.	max.	typ.	max.	min.	typ.	max.	typ.	max.
C27	25,1	28,9	25	80	21,4	23,4	25,3	30	50
C30	28,0	32,0	30	80	24,4	26,6	29,4	27	50
C33	31,0	35,0	35	80	27,4	29,7	33,4	25	45
C36	34,0	38,0	35	90	30,4	33,0	37,4	23	45
C39	37,0	41,0	40	130	33,4	36,4	41,2	21	45
C43	40,0	46,0	45	150	37,6	41,2	46,6	21	40
C47	44,0	50,0	50	170	42,0	46,1	51,8	19	40
C51	48,0	54,0	60	180	46,6	51,0	57,2	19	40
C56	52,0	60,0	70	200	52,2	57,0	63,8	18	40
C62	58,0	66,0	80	215	58,8	64,4	71,6	17	35
C68	64,0	72,0	90	240	65,6	71,7	79,8	17	35
C75	70,0	79,0	95	255	73,4	80,2	88,6	16,5	35

# BZX84 SERIES

BZX84-....	working voltage			differential resistance		working voltage			differential resistance	
	$V_Z$ (V)			$r_{diff}$ ( $\Omega$ )		$V_Z$ (V)			$r_{diff}$ ( $\Omega$ )	
	at $I_Z = 1$ mA			at $I_Z = 1$ mA		at $I_Z = 20$ mA			at $I_Z = 20$ mA	
	min.	nom.	max.	typ.	max.	min.	nom.	max.	typ.	max.
C2V4	1,7	1,9	2,1	275	600	2,6	2,9	3,2	25	50
C2V7	1,9	2,2	2,4	300	600	3,0	3,3	3,6	25	50
C3V0	2,1	2,4	2,7	325	600	3,3	3,6	3,9	25	50
C3V3	2,3	2,6	2,9	350	600	3,6	3,9	4,2	20	40
C3V6	2,7	3,0	3,3	375	600	3,9	4,2	4,5	20	40
C3V9	2,9	3,2	3,5	400	600	4,1	4,4	4,7	15	30
C4V3	3,3	3,6	4,0	410	600	4,4	4,7	5,1	15	30
C4V7	3,7	4,2	4,7	425	500	4,5	5,0	5,4	8	15
C5V1	4,2	4,7	5,3	400	480	5,0	5,4	5,9	6	15
C5V6	4,8	5,4	6,0	80	400	5,2	5,7	6,3	4	10
C6V2	5,6	6,1	6,6	40	150	5,8	6,3	6,8	3	6
C6V8	6,3	6,7	7,2	30	80	6,4	6,9	7,4	2,5	6
C7V5	6,9	7,4	7,9	30	80	7,0	7,6	8,0	2,5	6
C8V2	7,6	8,1	8,7	40	80	7,7	8,3	8,8	3	6
C9V1	8,4	9,0	9,6	40	100	8,5	9,2	9,7	4	8
C10	9,3	9,9	10,6	50	150	9,4	10,1	10,7	4	10
C11	10,2	10,9	11,6	50	150	10,4	11,1	11,8	5	10
C12	11,2	11,9	12,7	50	150	11,4	12,1	12,9	5	10
C13	12,3	12,9	14,0	50	170	12,5	13,1	14,2	5	15
C15	13,7	14,9	15,5	50	200	13,9	15,1	15,7	6	20
C16	15,2	15,9	17,0	50	200	15,4	16,1	17,2	6	20
C18	16,7	17,9	19,0	50	225	16,9	18,1	19,2	6	20
C20	18,7	19,9	21,1	60	225	18,9	20,1	21,4	7	20
C22	20,7	21,9	23,2	60	250	20,9	22,1	23,4	7	25
C24	22,7	23,9	25,5	60	250	22,9	24,1	25,7	7	25
	at $I_Z = 0,1$ mA			at $I_Z = 0,5$ mA		at $I_Z = 10$ mA			at $I_Z = 10$ mA	
	min.	nom.	max.	typ.	max.	min.	nom.	max.	typ.	max.
C27	25,0	26,9	28,9	65	300	25,2	27,1	29,3	10	45
C30	27,8	29,9	32,0	70	300	28,1	30,1	32,4	15	50
C33	30,8	32,9	35,0	75	325	31,1	33,1	35,4	20	55
C36	33,8	35,9	38,0	80	350	34,1	36,1	38,4	25	60
C39	36,7	38,9	41,0	80	350	37,1	39,1	41,5	25	70
C43	39,7	42,9	46,0	85	375	40,1	43,1	46,5	25	80
C47	43,7	46,8	50,0	85	375	44,1	47,1	50,5	30	90
C51	47,6	50,8	54,0	90	400	48,1	51,1	54,6	35	100
C56	51,5	55,7	60,0	100	425	52,1	56,1	60,8	45	110
C62	57,4	61,7	66,0	120	450	58,2	62,1	67,0	60	120
C68	63,4	67,7	72,0	150	475	64,2	68,2	73,2	75	130
C75	69,4	74,7	79,0	170	500	70,3	75,3	80,2	90	140



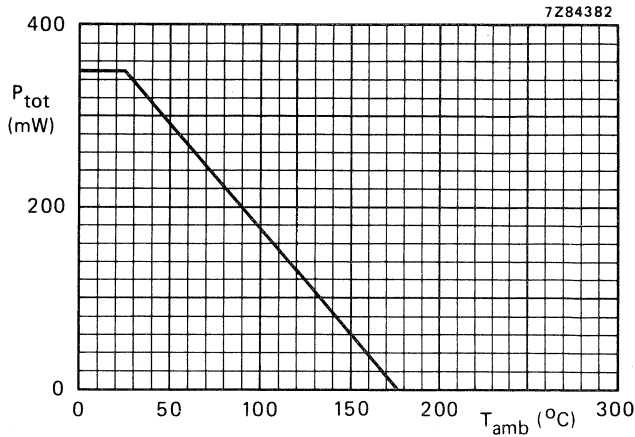


Fig. 2 Power derating curve.

**Model for calculating the static working voltage ( $V_Z$  stat).**

This model can be derived from  $V_Z$  stat =  $V_Z$  dyn +  $\Delta V_Z$  of which  $V_Z$  dyn is given in the preceding tables and can be derived from the typical dynamic characteristic curves in Figs 3 to 6.

$\Delta V_Z = \Delta T \times S_Z$ . For  $S_Z$  see tables and graphs  $S_Z$  versus  $T_j$ .

$\Delta T = P_{tot} \times R_{th\ j-a} = I_Z \times V_Z$  dyn  $\times R_{th\ j-a}$ .

Following  $\Delta V_Z = I_Z \times V_Z$  dyn  $\times R_{th\ j-a} \times S_Z$  and the model will be:

$$V_Z$$
 stat =  $V_Z$  dyn +  $I_Z \times V_Z$  dyn  $\times R_{th\ j-a} \times S_Z$

**Calculating example**

BZX84-C24 mounted on a ceramic substrate of 7 x 5 x 0,6 mm; at  $I_Z = 7$  mA.

$$V_Z$$
 stat =  $24 + \left(\frac{7}{1000} \times 24 \times \frac{430}{1000} \times 20,3\right)$

$$= 24 + 1,47 = 25,47 \text{ V.}$$

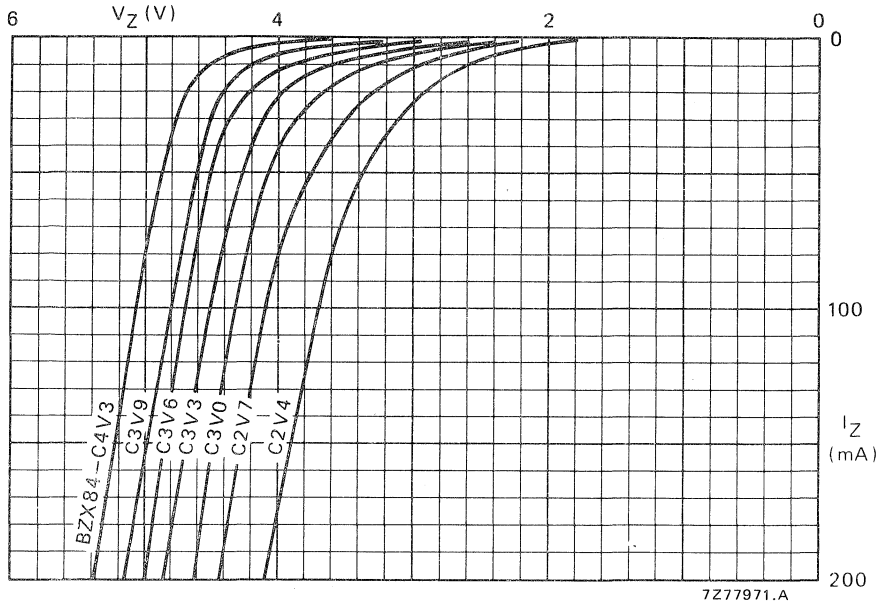


Fig. 3 Dynamic characteristics; typical values;  $T_j = 25^\circ\text{C}$ .

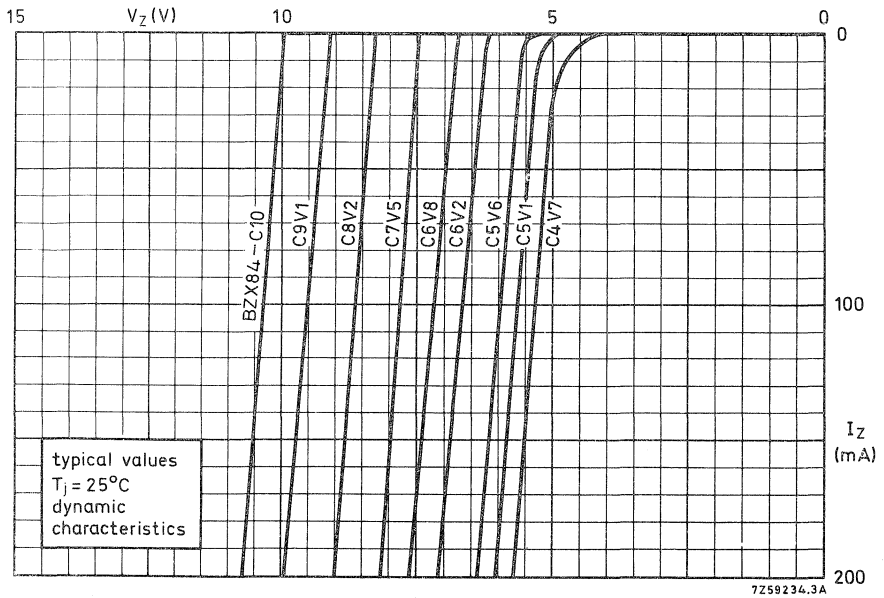


Fig. 4 Dynamic characteristics; typical values;  $T_j = 25^\circ\text{C}$ .

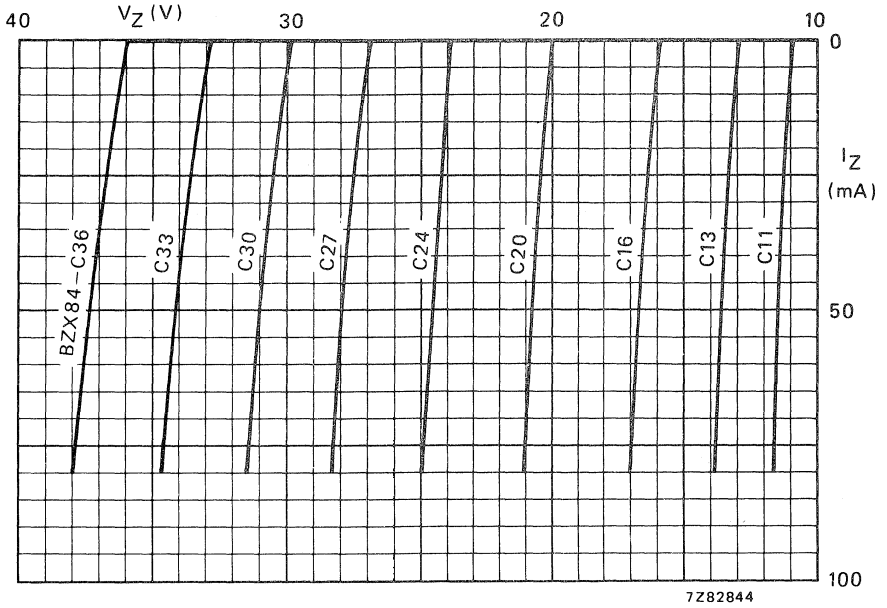


Fig. 5 Dynamic characteristics; typical values;  $T_j = 25^\circ\text{C}$ .

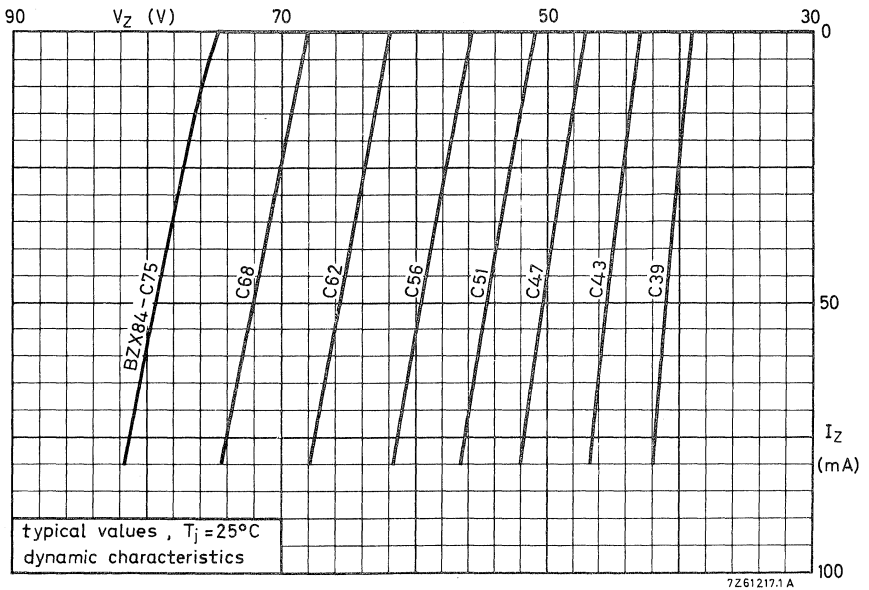


Fig. 6 Dynamic characteristics; typical values;  $T_j = 25^\circ\text{C}$ .

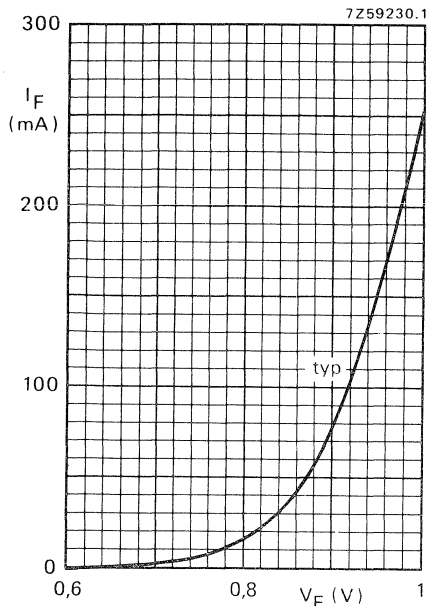


Fig. 7 Typical values at  $T_j = 25^\circ\text{C}$ .

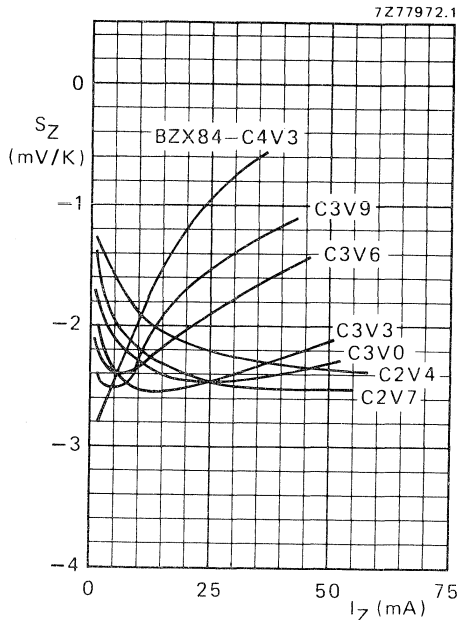


Fig. 8 Typical values;  $T_j = 25$  to  $175^\circ\text{C}$ .

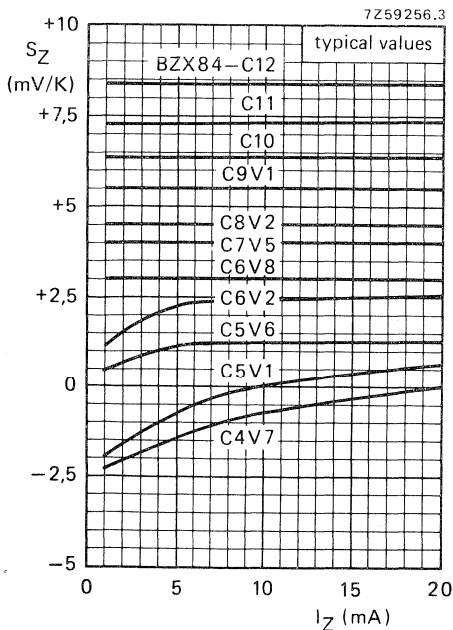


Fig. 9 Typical values;  $T_j = 25$  to  $175^\circ\text{C}$ .

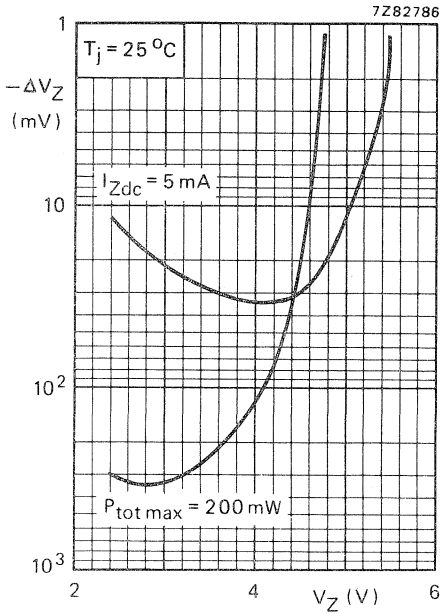


Fig. 10.

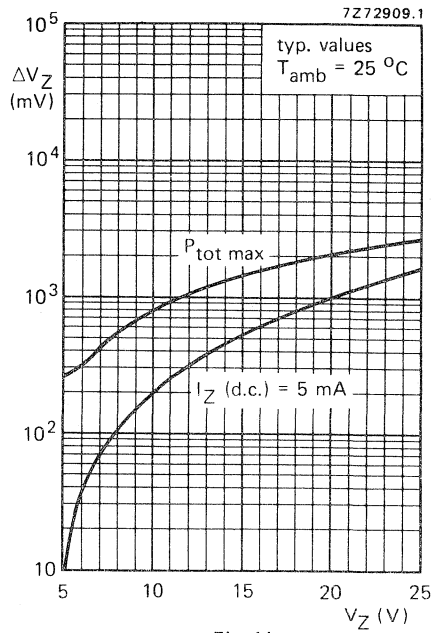


Fig. 11.

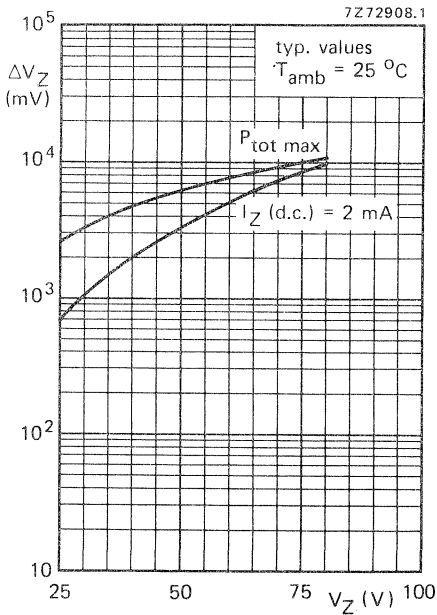


Fig. 12.

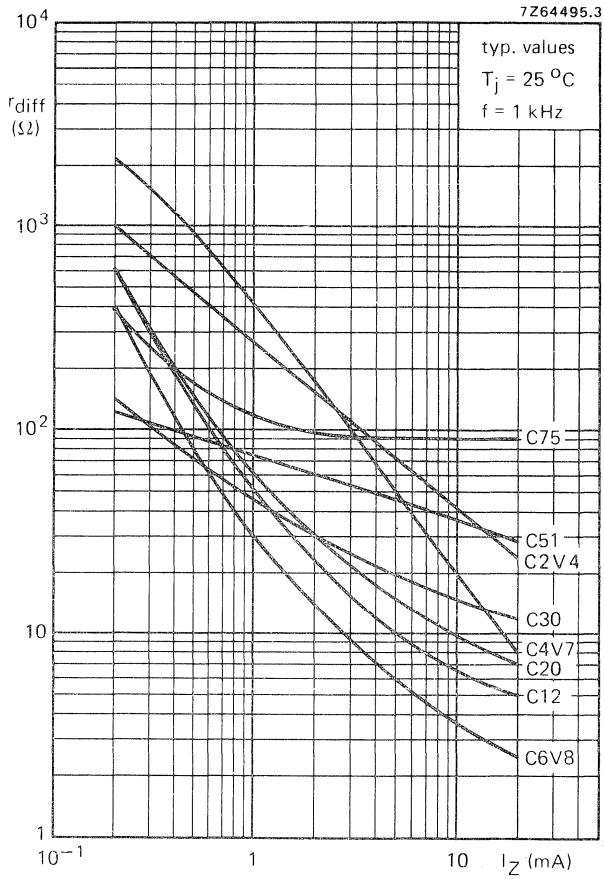
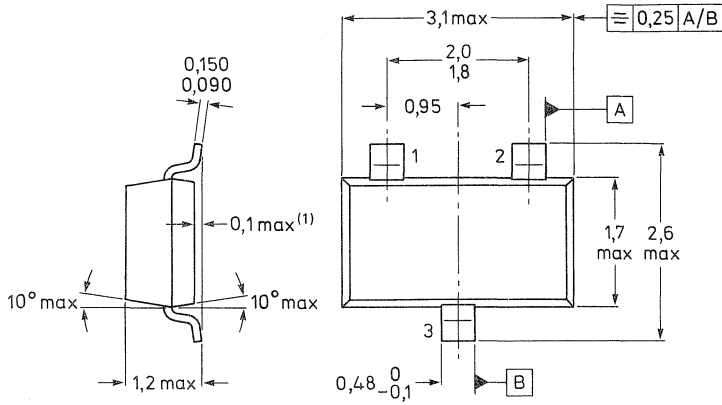


Fig. 13.

**MECHANICAL DATA**  
(European projection)

Dimensions in mm

SOT-23

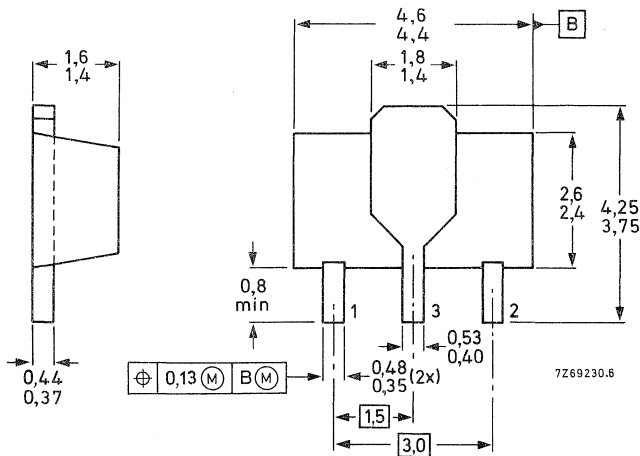


7266908.7

TOP VIEW

(1) Also available in 0,1 – 0,2 mm version.

SOT-89



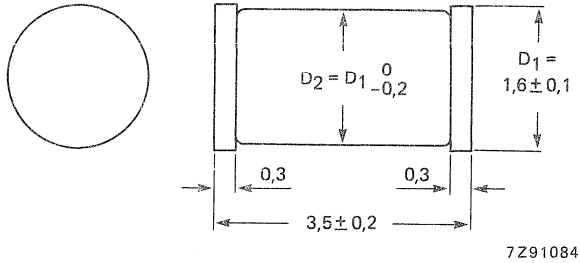
7269230.6

BOTTOM VIEW

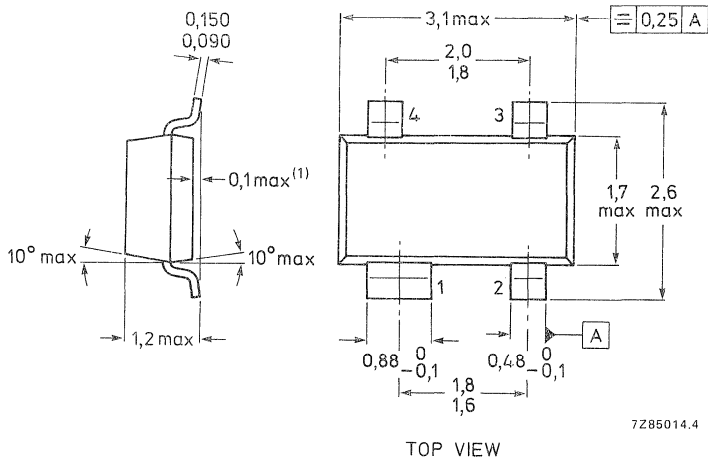
### MECHANICAL DATA (European projection)

Dimensions in mm

#### SOD-80



#### SOT-143



(1) Also available in 0,1 – 0,2 mm version.



## INDEX OF TYPE NUMBERS

## Data Handbooks Semiconductor Devices

The inclusion of a type number in this publication does not necessarily imply its availability.

type no.	book	section	type no.	book	section	type no.	book	section
AA119	S1	GD	BAS19	S7/S1	Mm/SD	BAV102	S7	Mm
AAZ15	S1	GD	BAS20	S7/S1	Mm/SD	BAV103	S7	Mm
AAZ17	S1	GD	BAS21	S7/S1	Mm/SD	BAW56	S7/S1	Mm/SD
AAZ18	S1	GD	BAS28	S7	Mm	BAW62	S1	SD
BA220	S1	SD	BAS29	S7	Mm	BAX12	S1	SD
BA221	S1	SD	BAS31	S7	Mm	BAX12A	S1	SD
BA223	S1	T	BAS32	S7	Mm	BAX14	S1	SD
BA243	S1	T	BAS35	S7	Mm	BAX18	S1	SD
BA244	S1	T	BAT17	S7/S1	Mm/T	BB105B	S1	T
BA280	S1	T	BAT18	S7/S1	Mm/T	BB105G	S1	T
BA314	S1	Vrg	BAT81	S1	T	BB109G	S1	T
BA315	S1	Vrg	BAT82	S1	T	BB112	S1	T
BA316	S1	SD	BAT83	S1	T	BB119	S1	T
BA317	S1	SD	BAT85	S1	T	BB130	S1	T
BA318	S1	SD	BAV10	S1	SD	BB204B	S1	T
BA379	S1	T	BAV18	S1	SD	BB204G	S1	T
BA423	S1	T	BAV19	S1	SD	BB212	S1	T
BA481	S1	T	BAV20	S1	SD	BB405B	S1	T
BA482	S1	T	BAV21	S1	SD	BB405G	S1	T
BA483	S1	T	BAV23	S7	Mm	BB417	S1	T
BA484	S1	T	BAV45	S1	Sp	BB809	S1	T
BAS11	S1	SD	BAV70	S7/S1	Mm/SD	BB909A	S1	T
BAS16	S7/S1	Mm/SD	BAV99	S7/S1	Mm/SD	BB909B	S1	T
BAS17	S7/S1	Mm/Vrg	BAV100	S7	Mm	BBY31	S7/S1	Mm/T
BAS18	S1	SD	BAV101	S7	Mm	BBY40	S7/S1	Mm/T

GD = Germanium diodes  
Mm = Microminiature semiconductors  
for hybrid circuits  
SD = Small-signal diodes

Sp = Special diodes  
T = Tuner diodes  
Vrg = Voltage regulator diodes

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type no.	book	section	type no.	book	section	type no.	book	section
BC107	S3	Sm	BC846	S7	Mm	BCX52	S7	Mm
BC108	S3	Sm	BC847	S7	Mm	BCX53	S7	Mm
BC109	S3	Sm	BC848	S7	Mm	BCX54	S7	Mm
BC146	S3	Sm	BC849	S7	Mm	BCX55	S7	Mm
BC177	S3	Sm	BC850	S7	Mm	BCX56	S7	Mm
BC178	S3	Sm	BC856	S7	Mm	BCX68	S7	Mm
BC179	S3	Sm	BC857	S7	Mm	BCX69	S7	Mm
BC200	S3	Sm	BC858	S7	Mm	BCX70*	S7	Mm
BC264A	S5	FET	BC859	S7	Mm	BCX71*	S7	Mm
BC264B	S5	FET	BC860	S7	Mm	BCY56	S3	Sm
BC264C	S5	FET	BC868	S7	Mm	BCY57	S3	Sm
BC264D	S5	FET	BC869	S7	Mm	BCY58	S3	Sm
BC327;A	S3	Sm	BCF29;R	S7	Mm	BCY59	S3	Sm
BC328	S3	Sm	BCF30;R	S7	Mm	BCY70	S3	Sm
BC337;A	S3	Sm	BCF32;R	S7	Mm	BCY71	S3	Sm
BC338	S3	Sm	BCF33;R	S7	Mm	BCY72	S3	Sm
BC368	S3	Sm	BCF70;R	S7	Mm	BCY78	S3	Sm
BC369	S3	Sm	BCF81;R	S7	Mm	BCY79	S3	Sm
BC375	S3	Sm	BCV61	S7	Mm	BCY87	S3	Sm
BC376	S3	Sm	BCV62	S7	Mm	BCY88	S3	Sm
BC546	S3	Sm	BCV71;R	S7	Mm	BCY89	S3	Sm
BC547	S3	Sm	BCV72;R	S7	Mm	BD131	S4a	P
BC548	S3	Sm	BCW29;R	S7	Mm	BD132	S4a	P
BC549	S3	Sm	BCW30;R	S7	Mm	BD135	S4a	P
BC550	S3	Sm	BCW31;R	S7	Mm	BD136	S4a	P
BC556	S3	Sm	BCW32;R	S7	Mm	BD137	S4a	P
BC557	S3	Sm	BCW33;R	S7	Mm	BD138	S4a	P
BC558	S3	Sm	BCW60*	S7	Mm	BD139	S4a	P
BC559	S3	Sm	BCW61*	S7	Mm	BD140	S4a	P
BC560	S3	Sm	BCW69;R	S7	Mm	BD201	S4a	P
BC635	S3	Sm	BCW70;R	S7	Mm	BD202	S4a	P
BC636	S3	Sm	BCW71;R	S7	Mm	BD203	S4a	P
BC637	S3	Sm	BCW72;R	S7	Mm	BD204	S4a	P
BC638	S3	Sm	BCW81;R	S7	Mm	BD226	S4a	P
BC639	S3	Sm	BCW89;R	S7	Mm	BD227	S4a	P
BC640	S3	Sm	BCX17;R	S7	Mm	BD228	S4a	P
BC807	S7	Mm	BCX18;R	S7	Mm	BD229	S4a	P
BC808	S7	Mm	BCX19;R	S7	Mm	BD230	S4a	P
BC817	S7	Mm	BCX20;R	S7	Mm	BD231	S4a	P
BC818	S7	Mm	BCX51	S7	Mm	BD233	S4a	P

\* = series

FET = Field-effect transistors

Mm = Microminiature semiconductors  
for hybrid circuits

P = Low-frequency power transistors

Sm = Small-signal transistors

type no.	book	section	type no.	book	section	type no.	book	section
BD234	S4a	P	BD434	S4a	P	BD844	S4a	P
BD235	S4a	P	BD435	S4a	P	BD845	S4a	P
BD236	S4a	P	BD436	S4a	P	BD846	S4a	P
BD237	S4a	P	BD437	S4a	P	BD847	S4a	P
BD238	S4a	P	BD438	S4a	P	BD848	S4a	P
BD239	S4a	P	BD645	S4a	P	BD849	S4a	P
BD239A	S4a	P	BD646	S4a	P	BD850	S4a	P
BD239B	S4a	P	BD647	S4a	P	BD933	S4a	P
BD239C	S4a	P	BD648	S4a	P	BD934	S4a	P
BD240	S4a	P	BD649	S4a	P	BD935	S4a	P
BD240A	S4a	P	BD650	S4a	P	BD936	S4a	P
BD240B	S4a	P	BD651	S4a	P	BD937	S4a	P
BD240C	S4a	P	BD652	S4a	P	BD938	S4a	P
BD241	S4a	P	BD675	S4a	P	BD939	S4a	P
BD241A	S4a	P	BD676	S4a	P	BD940	S4a	P
BD241B	S4a	P	BD677	S4a	P	BD941	S4a	P
BD241C	S4a	P	BD678	S4a	P	BD942	S4a	P
BD242	S4a	P	BD679	S4a	P	BD943	S4a	P
BD242A	S4a	P	BD680	S4a	P	BD944	S4a	P
BD242B	S4a	P	BD681	S4a	P	BD945	S4a	P
BD242C	S4a	P	BD682	S4a	P	BD946	S4a	P
BD243	S4a	P	BD683	S4a	P	BD947	S4a	P
BD243A	S4a	P	BD684	S4a	P	BD948	S4a	P
BD243B	S4a	P	BD813	S4a	P	BD949	S4a	P
BD243C	S4a	P	BD814	S4a	P	BD950	S4a	P
BD244	S4a	P	BD815	S4a	P	BD951	S4a	P
BD244A	S4a	P	BD816	S4a	P	BD952	S4a	P
BD244B	S4a	P	BD817	S4a	P	BD953	S4a	P
BD244C	S4a	P	BD818	S4a	P	BD954	S4a	P
BD329	S4a	P	BD825	S4a	P	BD955	S4a	P
BD330	S4a	P	BD826	S4a	P	BD956	S4a	P
BD331	S4a	P	BD827	S4a	P	BDT20	S4a	P
BD332	S4a	P	BD828	S4a	P	BDT21	S4a	P
BD333	S4a	P	BD829	S4a	P	BDT29	S4a	P
BD334	S4a	P	BD830	S4a	P	BDT29A	S4a	P
BD335	S4a	P	BD839	S4a	P	BDT29B	S4a	P
BD336	S4a	P	BD840	S4a	P	BDT29C	S4a	P
BD337	S4a	P	BD841	S4a	P	BDT30	S4a	P
BD338	S4a	P	BD842	S4a	P	BDT30A	S4a	P
BD433	S4a	P	BD843	S4a	P	BDT30B	S4a	P

P = Low-frequency power transistors

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type no.	book	section	type no.	book	section	type no.	book	section
BDT30C	S4a	P	BDT65C	S4a	P	BDX44	S4a	P
BDT31	S4a	P	BDT91	S4a	P	BDX45	S4a	P
BDT31A	S4a	P	BDT92	S4a	P	BDX46	S4a	P
BDT31B	S4a	P	BDT93	S4a	P	BDX47	S4a	P
BDT31C	S4a	P	BDT94	S4a	P	BDX62	S4a	P
BDT32	S4a	P	BDT95	S4a	P	BDX62A	S4a	P
BDT32A	S4a	P	BDT96	S4a	P	BDX62B	S4a	P
BDT32B	S4a	P	BDV64	S4a	P	BDX62C	S4a	P
BDT32C	S4a	P	BDV64A	S4a	P	BDX63	S4a	P
BDT41	S4a	P	BDV64B	S4a	P	BDX63A	S4a	P
BDT41A	S4a	P	BDV64C	S4a	P	BDX63B	S4a	P
BDT41B	S4a	P	BDV65	S4a	P	BDX63C	S4a	P
BDT41C	S4a	P	BDV65A	S4a	P	BDX64	S4a	P
BDT42	S4a	P	BDV65B	S4a	P	BDX64A	S4a	P
BDT42A	S4a	P	BDV65C	S4a	P	BDX64B	S4a	P
BDT42B	S4a	P	BDV66A	S4a	P	BDX64C	S4a	P
BDT42C	S4a	P	BDV66B	S4a	P	BDX65	S4a	P
BDT60	S4a	P	BDV66C	S4a	P	BDX65A	S4a	P
BDT60A	S4a	P	BDV66D	S4a	P	BDX65B	S4a	P
BDT60B	S4a	P	BDV67A	S4a	P	BDX65C	S4a	P
BDT60C	S4a	P	BDV67B	S4a	P	BDX66	S4a	P
BDT61	S4a	P	BDV67C	S4a	P	BDX66A	S4a	P
BDT61A	S4a	P	BDV67D	S4a	P	BDX66B	S4a	P
BDT61B	S4a	P	BDV91	S4a	P	BDX66C	S4a	P
BDT61C	S4a	P	BDV92	S4a	P	BDX67	S4a	P
BDT62	S4a	P	BDV93	S4a	P	BDX67A	S4a	P
BDT62A	S4a	P	BDV94	S4a	P	BDX67B	S4a	P
BDT62B	S4a	P	BDV95	S4a	P	BDX67C	S4a	P
BDT62C	S4a	P	BDV96	S4a	P	BDX68	S4a	P
BDT63	S4a	P	BDW55	S4a	P	BDX68A	S4a	P
BDT63A	S4a	P	BDW56	S4a	P	BDX68B	S4a	P
BDT63B	S4a	P	BDW57	S4a	P	BDX68C	S4a	P
BDT63C	S4a	P	BDW58	S4a	P	BDX69	S4a	P
BDT64	S4a	P	BDW59	S4a	P	BDX69A	S4a	P
BDT64A	S4a	P	BDW60	S4a	P	BDX69B	S4a	P
BDT64B	S4a	P	BDX35	S4a	P	BDX69C	S4a	P
BDT64C	S4a	P	BDX36	S4a	P	BDX77	S4a	P
BDT65	S4a	P	BDX37	S4a	P	BDX78	S4a	P
BDT65A	S4a	P	BDX42	S4a	P	BDX91	S4a	P
BDT65B	S4a	P	BDX43	S4a	P	BDX92	S4a	P

P = Low-frequency power transistors

type no.	book	section	type no.	book	section	type no.	book	section
BDX93	S4a	P	BF469	S4b	HVP	BF964	S5	FET
BDX94	S4a	P	BF470	S4b	HVP	BF966	S5	FET
BDX95	S4a	P	BF471	S4b	HVP	BF967	S3	Sm
BDX96	S4a	P	BF472	S4b	HVP	BF970	S3	Sm
BDY90	S4a	P	BF480	S3	Sm	BF979	S3	Sm
BDY90A	S4a	P	BF494	S3	Sm	BF980	S5	FET
BDY91	S4a	P	BF495	S3	Sm	BF981	S5	FET
BDY92	S4a	P	BF496	S3	Sm	BF982	S5	FET
BF180	S3	Sm	BF510	S7/S5	Mm/FET	BF989	S7/S5	Mm/FET
BF181	S3	Sm	BF511	S7/S5	Mm/FET	BF990	S7/S5	Mm/FET
BF182	S3	Sm	BF512	S7/S5	Mm/FET	BF991	S7/S5	Mm/FET
BF183	S3	Sm	BF513	S7/S5	Mm/FET	BF992	S7/S5	Mm/FET
BF198	S3	Sm	BF536	S7	Mm	BF994	S7/S5	Mm/FET
BF199	S3	Sm	BF550;R	S7	Mm	BF996	S7/S5	Mm/FET
BF200	S3	Sm	BF569	S7	Mm	BFG90A	S10	WBT
BF240	S3	Sm	BF579	S7	Mm	BFG91A	S10	WBT
BF241	S3	Sm	BF620	S7	Mm	BFG96	S10	WBT
BF245A	S5	FET	BF621	S7	Mm	BFP90A	S10	WBT
BF245B	S5	FET	BF622	S7	Mm	BFP91A	S10	WBT
BF245C	S5	FET	BF623	S7	Mm	BFP96	S10	WBT
BF247A	S5	FET	BF660;R	S7	Mm	BFQ10	S5	FET
BF247B	S5	FET	BF689K	S10	WBT	BFQ11	S5	FET
BF247C	S5	FET	BF767	S7	Mm	BFQ12	S5	FET
BF256A	S5	FET	BF819	S4b	HVP	BFQ13	S5	FET
BF256B	S5	FET	BF820	S7	Mm	BFQ14	S5	FET
BF256C	S5	FET	BF821	S7	Mm	BFQ15	S5	FET
BF324	S3	Sm	BF822	S7	Mm	BFQ16	S5	FET
BF370	S3	Sm	BF823	S7	Mm	BFQ17	S7	Mm
BF410A	S5	FET	BF824	S7	Mm	BFQ18A	S7	Mm
BF410B	S5	FET	BF857	S4b	HVP	BFQ19	S7	Mm
BF410C	S5	FET	BF858	S4b	HVP	BFQ22	S10	WBT
BF410D	S5	FET	BF859	S4b	HVP	BFQ22S	S10	WBT
BF419	S4b	HVP	BF869	S4b	HVP	BFQ23	S10	WBT
BF422	S3	Sm	BF870	S4b	HVP	BFQ24	S10	WBT
BF423	S3	Sm	BF871	S4b	HVP	BFQ32	S10	WBT
BF450	S3	Sm	BF872	S4b	HVP	BFQ33	S10	WBT
BF451	S3	Sm	BF926	S3	Sm	BFQ34	S10	WBT
BF457	S4b	HVP	BF936	S3	Sm	BFQ34T	S10	WBT
BF458	S4b	HVP	BF939	S3	Sm	BFQ42	S6	RFP
BF459	S4b	HVP	BF960	S5	FET	BFQ43	S6	RFP

FET = Field-effect transistors  
HVP = High-voltage power transistors  
Mm = Microminiature semiconductors  
for hybrid circuits

P = Low-frequency power transistors  
RFP = R.F. power transistors and modules  
Sm = Small-signal transistors  
WBT = Wideband hybrid IC transistors

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type no.	book	section	type no.	book	section	type no.	book	section
BFQ51	S10	WBT	BFT45	S3	Sm	BGY23	S6	RFP
BFQ52	S10	WBT	BFT46	S7/S5	Mm/FET	BGY23A	S6	RFP
BFQ53	S10	WBT	BFT92;R	S7	Mm	BGY32	S6	RFP
BFQ63	S10	WBT	BFT93;R	S7	Mm	BGY33	S6	RFP
BFQ65	S10	WBT	BFW10	S5	FET	BGY35	S6	RFP
BFQ66	S10	WBT	BFW11	S5	FET	BGY36	S6	RFP
BFQ68	S10	WBT	BFW12	S5	FET	BGY40A	S6	RFP
BFR29	S5	FET	BFW13	S5	FET	BGY40B	S6	RFP
BFR30	S7/S5	Mm/FET	BFW16A	S10	WBT	BGY41A	S6	RFP
BFR31	S7/S5	Mm/FET	BFW17A	S10	WBT	BGY41B	S6	RFP
BFR49	S10	WBT	BFW30	S10	WBT	BGY43	S6	RFP
BFR53;R	S7	Mm	BFW61	S5	FET	BGY45A	S6	RFP
BFR54	S3	Sm	BFW92	S10	WBT	BGY45B	S6	RFP
BFR64	S10	WBT	BFW92A	S10	WBT	BGY46A	S6	RFP
BFR65	S10	WBT	BFW93	S10	WBT	BGY46B	S6	RFP
BFR84	S5	FET	BFX29	S3	Sm	BGY47*	S6	RFP
BFR90	S10	WBT	BFX30	S3	Sm	BGY50	S10	WBM
BFR90A	S10	WBT	BFX34	S3	Sm	BGY51	S10	WBM
BFR91	S10	WBT	BFX84	S3	Sm	BGY52	S10	WBM
BFR91A	S10	WBT	BFX85	S3	Sm	BGY53	S10	WBM
BFR92;R	S7	Mm	BFX86	S3	Sm	BGY54	S10	WBM
BFR92A;R	S7	Mm	BFX87	S3	Sm	BGY55	S10	WBM
BFR93;R	S7	Mm	BFX88	S3	Sm	BGY56	S10	WBM
BFR93A;R	S7	Mm	BFX89	S10	WBT	BGY57	S10	WBM
BFR94	S10	WBT	BFY50	S3	Sm	BGY58	S10	WBM
BFR95	S10	WBT	BFY51	S3	Sm	BGY58A	S10	WBT
BFR96	S10	WBT	BFY52	S3	Sm	BGY59	S10	WBM
BFR96S	S10	WBT	BFY55	S3	Sm	BGY60	S10	WBM
BFR101A;B	S7/S5	Mm/FET	BFY90	S10	WBT	BGY61	S10	WBT
BFS17;R	S7	Mm	BG2000	S1	RT	BGY65	S10	WBT
BFS18;R	S7	Mm	BG2097	S1	RT	BGY67	S10	WBT
BFS19;R	S7	Mm	BGX11*	S2b	ThM	BGY70	S10	WBT
BFS20;R	S7	Mm	BGX12*	S2b	ThM	BGY71	S10	WBT
BFS21	S5	FET	BGX13*	S2b	ThM	BGY74	S10	WBM
BFS21A	S5	FET	BGX14*	S2b	ThM	BGY75	S10	WBM
BFS22A	S6	RFP	BGX15*	S2b	ThM	BGY93A	S6	RFP
BFS23A	S6	RFP	BGX17*	S2b	ThM	BGY93B	S6	RFP
BFT24	S10	WBT	BGX25	S2a	ThM	BGY93C	S6	RFP
BFT25;R	S7	Mm	BGY22	S6	RFP	BLU20/12	S6	RFP
BFT44	S3	Sm	BGY22A	S6	RFP	BLU30/12	S6	RFP

\* = series

FET = Field-effect transistors

Mm = Microminiature semiconductors  
for hybrid circuits

RFP = R.F. power transistors and modules

RT = Tripler

Sm = Small-signal transistors

ThM = Thyristor Modules

WBM = Wideband hybrid IC modules

WBT = Wideband hybrid IC transistors

type no.	book	section	type no.	book	section	type no.	book	section
BLU45/12	S6	RFP	BLW33	S6	RFP	BLX94C	S6	RFP
BLU50	S6	RFP	BLW34	S6	RFP	BLX95	S6	RFP
BLU51	S6	RFP	BLW50F	S6	RFP	BLX96	S6	RFP
BLU52	S6	RFP	BLW60	S6	RFP	BLX97	S6	RFP
BLU53	S6	RFP	BLW60C	S6	RFP	BLX98	S6	RFP
BLU60/12	S6	RFP	BLW76	S6	RFP	BLY85	S6	RFP
BLU97	S6	RFP	BLW77	S6	RFP	BLY87A	S6	RFP
BLU98	S6	RFP	BLW78	S6	RFP	BLY87C	S6	RFP
BLU99	S6	RFP	BLW79	S6	RFP	BLY88A	S6	RFP
BLV10	S6	RFP	BLW80	S6	RFP	BLY88C	S6	RFP
BLV11	S6	RFP	BLW81	S6	RFP	BLY89A	S6	RFP
BLV20	S6	RFP	BLW82	S6	RFP	BLY89C	S6	RFP
BLV21	S6	RFP	BLW83	S6	RFP	BLY90	S6	RFP
BLV25	S6	RFP	BLW84	S6	RFP	BLY91A	S6	RFP
BLV30	S6	RFP	BLW85	S6	RFP	BLY91C	S6	RFP
BLV30/12	S6	RFP	BLW86	S6	RFP	BLY92A	S6	RFP
BLV31	S6	RFP	BLW87	S6	RFP	BLY92C	S6	RFP
BLV32F	S6	RFP	BLW89	S6	RFP	BLY93A	S6	RFP
BLV33	S6	RFP	BLW90	S6	RFP	BLY93C	S6	RFP
BLV33F	S6	RFP	BLW91	S6	RFP	BLY94	S6	RFP
BLV36	S6	RFP	BLW95	S6	RFP	BLY97	S6	RFP
BLV37	S6	RFP	BLW96	S6	RFP	BPF10	S8	PDT
BLV45/12	S6	RFP	BLW97	S6	RFP	BPF24	S8	PDT
BLV57	S6	RFP	BLW98	S6	RFP	BPW22A	S8	PDT
BLV59	S6	RFP	BLW99	S6	RFP	BPW50	S8	PDT
BLV75/12	S6	RFP	BLX13	S6	RFP	BPX25	S8	PDT
BLV80/28	S6	RFP	BLX13C	S6	RFP	BPX29	S8	PDT
BLV90	S6	RFP	BLX14	S6	RFP	BPX40	S8	PDT
BLV91	S6	RFP	BLX15	S6	RFP	BPX41	S8	PDT
BLV92	S6	RFP	BLX39	S6	RFP	BPX42	S8	PDT
BLV93	S6	RFP	BLX65	S6	RFP	BPX71	S8	PDT
BLV94	S6	RFP	BLX65E	S6	RFP	BPX72	S8	PDT
BLV95	S6	RFP	BLX67	S6	RFP	BPX95C	S8	PDT
BLV96	S6	RFP	BLX68	S6	RFP	BR100/03	S2b	Th
BLV97	S6	RFP	BLX69A	S6	RFP	BR101	S3	Sm
BLV98	S6	RFP	BLX91A	S6	RFP	BRY39	S3	Sm
BLV99	S6	RFP	BLX91CB	S6	RFP	BRY56	S3	Sm
BLW29	S6	RFP	BLX92A	S6	RFP	BRY61	S7	Mm
BLW31	S6	RFP	BLX93A	S6	RFP	BRY62	S7	Mm
BLW32	S6	RFP	BLX94A	S6	RFP	BSD10	S5	FET

FET = Field-effect transistors

Mm = Microminiature semiconductors  
for hybrid circuits

PDT = Photodiodes or transistors

RFP = R.F. power transistors and modules

Sm = Small-signal transistors

Th = Thyristors

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type no.	book	section	type no.	book	section	type no.	book	section
BSD12	S5	FET	BSS63;R	S7	Mm	BT136*	S2b	Tri
BSD20	S5/7	FET	BSS64;R	S7	Mm	BT137*	S2b	Tri
BSD22	S5/7	FET	BSS68	S3	Sm	BT138*	S2b	Tri
BSD212	S5	FET	BSS83	S5/7	FET/Mm	BT139*	S2b	Tri
BSD213	S5	FET	BST15	S7	Mm	BT149*	S2b	Th
BSD214	S5	FET	BST16	S7	Mm	BT151*	S2b	Th
BSD215	S5	FET	BST39	S7	Mm	BT152*	S2b	Th
BSR12;R	S7	Mm	BST40	S7	Mm	BT153	S2b	Th
BSR13;R	S7	Mm	BST50	S7	Mm	BT155*	S2b	Th
BSR14;R	S7	Mm	BST51	S7	Mm	BT157*	S2b	Th
BSR15;R	S7	Mm	BST52	S7	Mm	BTV24*	S2b	Th
BSR16;R	S7	Mm	BST60	S7	Mm	BTV34*	S2b	Tri
BSR17;R	S7	Mm	BST61	S7	Mm	BTV58*	S2b	Th
BSR17A;R	S7	Mm	BST62	S7	Mm	BTV59*	S2b	Th
BSR18;R	S7	Mm	BST70A	S5	FET	BTV60*	S2b	Th
BSR18A;R	S7	Mm	BST72A	S5	FET	BTW23*	S2b	Th
BSR30	S7	Mm	BST74A	S5	FET	BTW38*	S2b	Th
BSR31	S7	Mm	BST76A	S5	FET	BTW40*	S2b	Th
BSR32	S7	Mm	BST78	S5	FET	BTW42*	S2b	Th
BSR33	S7	Mm	BSV15	S3	Sm	BTW43*	S2b	Tri
BSR40	S7	Mm	BSV16	S3	Sm	BTW45*	S2b	Th
BSR41	S7	Mm	BSV17	S3	Sm	BTW58*	S2b	Th
BSR42	S7	Mm	BSV52;R	S7	Mm	BTW59*	S2b	Th
BSR43	S7	Mm	BSV64	S3	Sm	BTW63*	S2b	Th
BSR50	S3	Sm	BSV78	S5	FET	BTW92*	S2b	Th
BSR51	S3	Sm	BSV79	S5	FET	BTX18*	S2b	Th
BSR52	S3	Sm	BSV80	S5	FET	BTX94*	S2b	Tri
BSR56	S7/S5	Mm/FET	BSV81	S5	FET	BTY79*	S2b	Th
BSR57	S7/S5	Mm/FET	BSW66A	S3	Sm	BTY91*	S2b	Th
BSR58	S7/S5	Mm/FET	BSW67A	S3	Sm	BU208A	S4b	SP
BSR60	S3	Sm	BSW68A	S3	Sm	BU208B	S4b	SP
BSR61	S3	Sm	BSX19	S3	Sm	BU326	S4b	SP
BSR62	S3	Sm	BSX20	S3	Sm	BU326A	S4b	SP
BSS38	S3	Sm	BSX45	S3	Sm	BU426	S4b	SP
BSS50	S3	Sm	BSX46	S3	Sm	BU426A	S4b	SP
BSS51	S3	Sm	BSX47	S3	Sm	BU433	S4b	SP
BSS52	S3	Sm	BSX59	S3	Sm	BU505	S4b	SP
BSS60	S3	Sm	BSX60	S3	Sm	BU508A	S4b	SP
BSS61	S3	Sm	BSX61	S3	Sm	BU705	S4b	SP
BSS62	S3	Sm	BSY95A	S3	Sm	BU806	S4b	SP

\* = series

FET = Field-effect transistors

Mm = Microminiature semiconductors  
for hybrid circuits

Sm = Small-signal transistors

SP = Low frequency switching power transistors

Th = Thyristors

Tri = Triacs



type no.	book	section	type no.	book	section	type no.	book	section
BUS11;A	S4b	SP	BUZ23	S9	PM	BUZ80A	S9	PM
BUS12;A	S4b	SP	BUZ24	S9	PM	BUZ83	S9	PM
BUS13;A	S4b	SP	BUZ25	S9	PM	BUZ83A	S9	PM
BUS14;A	S4b	SP	BUZ30	S9	PM	BUZ84	S9	PM
BUT11;A	S4b	SP	BUZ31	S9	PM	BUZ84A	S9	PM
BUV82	S4b	SP	BUZ32	S9	PM	BY184	S1	R
BUV83	S4b	SP	BUZ33	S9	PM	BY188G	S1	R
BUV89	S4b	SP	BUZ34	S9	PM	BY224*	S2a	R
BUW11;A	S4b	SP	BUZ35	S9	PM	BY225*	S2a	R
BUW12;A	S4b	SP	BUZ36	S9	PM	BY228	S1	R
BUW13;A	S4b	SP	BUZ40	S9	PM	BY229*	S2a	R
BUW84	S4b	SP	BUZ41A	S9	PM	BY249*	S2a	R
BUW85	S4b	SP	BUZ42	S9	PM	BY260*	S2a	R
BUX46;A	S4b	SP	BUZ43	S9	PM	BY261*	S2a	R
BUX47;A	S4b	SP	BUZ44A	S9	PM	BY329*	S2a	R
BUX48;A	S4b	SP	BUZ45	S9	PM	BY359*	S2a	R
BUX80	S4b	SP	BUZ45A	S9	PM	BY438	S1	R
BUX81	S4b	SP	BUZ45B	S9	PM	BY448	S1	R
BUX82	S4b	SP	BUZ45C	S9	PM	BY458	S1	R
BUX83	S4b	SP	BUZ46	S9	PM	BY476	S1	R
BUX84	S4b	SP	BUZ50A	S9	PM	BY477	S1	R
BUX85	S4b	SP	BUZ50B	S9	PM	BY478	S1	R
BUX86	S4b	SP	BUZ53A	S9	PM	BY505	S1	R
BUX87	S4b	SP	BUZ54	S9	PM	BY509	S1	R
BUX88	S4b	SP	BUZ54A	S9	PM	BY527	S1	R
BUX89	S4b	SP	BUZ60	S9	PM	BY584	S1	R
BUX90	S4b	SP	BUZ60B	S9	PM	BY609	S1	R
BUX98	S4b	SP	BUZ63	S9	PM	BY610	S1	R
BUX98A	S4b	SP	BUZ63B	S9	PM	BYQ28*	S2a	R
BUY89	S4b	SP	BUZ64	S9	PM	BYR29*	S2a	R
BUZ10	S9	PM	BUZ71	S9	PM	BYT79*	S2a	R
BUZ10A	S9	PM	BUZ71A	S9	PM	BYV19*	S2a	R
BUZ11	S9	PM	BUZ72	S9	PM	BYV20*	S2a	R
BUZ11A	S9	PM	BUZ72A	S9	PM	BYV21*	S2a	R
BUZ14	S9	PM	BUZ73A	S9	PM	BYV22*	S2a	R
BUZ15	S9	PM	BUZ74	S9	PM	BYV23*	S2a	R
BUZ20	S9	PM	BUZ74A	S9	PM	BYV24*	S2a	R
BUZ21	S9	PM	BUZ76	S9	PM	BYV27*	S1/S2a	R
			BUZ76A	S9	PM	BYV28*	S1/S2a	R
			BUZ80	S9	PM	BYV29*	S2a	R

\* = series

PM = Power MOS transistors

R = Rectified diodes

SP = Low-frequency switching power transistors

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type no.	book	section	type no.	book	section	type no.	book	section
BYV30*	S2a	R	BYX52*	S2a	R	CNX37	S8	PhC
BYV32*	S2a	R	BYX56*	S2a	R	CNX38	S8	PhC
BYV33*	S2a	R	BYX90	S1	R	CNX44	S8	PhC
BYV34*	S2a	R	BYX94	S1	R	CNX48	S8	PhC
BYV39*	S2a	R	BYX96*	S2a	R	CNX62	S8	PhC
BYV42*	S2a	R	BYX97*	S2a	R	CNY50	S8	PhC
BYV43*	S2a	R	BYX98*	S2a	R	CNY52	S8	PhC
BYV72*	S2a	R	BYX99*	S2a	R	CNY53	S8	PhC
BYV73*	S2a	R	BZT03	S1	Vrg	CNY57	S8	PhC
BYV79*	S2a	R	BZV10	S1	Vrf	CNY57A	S8	PhC
BYV92*	S2a	R	BZV11	S1	Vrf	CNY62	S8	PhC
BYV95A	S1	R	BZV12	S1	Vrf	CNY63	S8	PhC
BYV95B	S1	R	BZV13	S1	Vrf	CQ209S	S8	D
BYV95C	S1	R	BZV14	S1	Vrf	CQ216X	S8	D
BYV96D	S1	R	BZV37	S1	Vrf	CQ216Y	S8	D
BYV96E	S1	R	BZV46	S1	Vrg	CQ327;R	S8	D
BYW25*	S2a	R	BZV49*	S1/S7	Vrg/Mm	CQ330;R	S8	D
BYW29*	S2a	R	BZV55*	S7	Mm	CQ331;R	S8	D
BYW30*	S2a	R	BZW85	S1	Vrg	CQ332;R	S8	D
BYW31*	S2a	R	BZW70*	S2a	TS	CQ427;R	S8	D
BYW54	S1	R	BZW86*	S2a	TS	CQ430;R	S8	D
BYW55	S1	R	BZW91*	S2a	TS	CQ431;R	S8	D
BYW56	S1	R	BZX55	S1	Vrg	CQ432;R	S8	D
BYW92*	S2a	R	BZX70*	S2a	Vrg	CQF24	S8	Ph
BYW93*	S2a	R	BZX75	S1	Vrg	CQL10A	S8	Ph
BYW94*	S2a	R	BZX79*	S1	Vrg	CQL13	S8	Ph
BYW95A	S1	R	BZX84*	S7/S1	Mm/Vrg	CQL13A	S8	Ph
BYW95B	S1	R	BZX87*	S1	Vrg	CQL14A	S8	Ph
BYW95C	S1	R	BZX90	S1	Vrf	CQL14B	S8	Ph
BYW96D	S1	R	BZX91	S1	Vrf	CQN10	S8	LED
BYW96E	S1	R	BZX92	S1	Vrf	CQN11	S8	LED
BYX10	S1	R	BZX93	S1	Vrf	CQT10	S8	LED
BYX25*	S2a	R	BZX94	S1	Vrf	CQT11	S8	LED
BYX30*	S2a	R	BZY91*	S2a	Vrg	CQT12	S8	LED
BYX32*	S2a	R	BZY93*	S2a	Vrg	CQV60(L)	S8	LED
BYX38*	S2a	R	BZY95*	S2a	Vrg	CQV60A(L)	S8	LED
BYX39*	S2a	R	BZY96*	S2a	Vrg	CQV61A(L)	S8	LED
BYX42*	S2a	R	CNX21	S8	PhC	CQV62(L)	S8	LED
BYX46*	S2a	R	CNX35	S8	PhC	CQV70(L)	S8	LED
BYX50*	S2a	R	CNX36	S8	PhC	CQV70A(L)	S8	LED

\* = series

D = Displays

LED = Light-emitting diodes

Mm = Microminiature semiconductors  
for hybrid circuits

Ph = Photoconductive devices

PhC = Photocouplers

R = Rectifier diodes

TS = Transient suppressor diodes

Vrf = Voltage reference diodes

Vrg = Voltage regulator diodes

type no.	book	section	type no.	book	section	type no.	book	section
CQV71A(L)	S8	LED	CQY96(L)	S8	LED	OSS9215	S2a	St
CQV72(L)	S8	LED	CQY97A	S8	LED	OSS9410	S2a	St
CQV80L	S8	LED	OA90	S1	GD	OSS9415	S2a	St
CQV80AL	S8	LED	OA91	S1	GD	PH2222;R	S3	Sm
CQV81L	S8	LED	OA95	S1	GD	PH2222A;RS3		Sm
CQV82L	S8	LED	OM320	S10	WBM	PH2369	S3	Sm
CQW10(L)	S8	LED	OM321	S10	WBM	PH2907;R	S3	Sm
CQW10A(L)	S8	LED	OM322	S10	WBM	PH2907A;RS3		Sm
CQW10B(L)	S8	LED	OM323	S10	WBM	PH2955T	S4a	P
CQW11A(L)	S8	LED	OM323A	S10	WBM	PH3055T	S4a	P
CQW11B(L)	S8	LED	OM335	S10	WBM	PHSD51	S2a	R
CQW12(L)	S8	LED	OM336	S10	WBM	RPY58A	S8	Ph
CQW12B(L)	S8	LED	OM337	S10	WBM	RPY76B	S8	Ph
CQW20A	S8	LED	OM337A	S10	WBM	RPY86	S8	I
CQW21	S8	LED	OM339	S10	WBM	RPY87	S8	I
CQW22	S8	LED	OM345	S10	WBM	RPY88	S8	I
CQW24(L)	S8	LED	OM350	S10	WBM	RPY89	S8	I
CQW54	S8	LED	OM360	S10	WBM	RPY90*	S8	I
CQX10	S8	LED	OM361	S10	WBM	RPY91*	S8	I
CQX11	S8	LED	OM370	S10	WBM	RPY93	S8	I
CQX12	S8	LED	OM931	S4a	P	RPY94	S8	I
CQX24(L)	S8	LED	OM961	S4a	P	RPY95	S8	I
CQX51	S8	LED	OSB9110	S2a	St	RPY96	S8	I
CQX54(L)	S8	LED	OSB9115	S2a	St	RPY97	S8	I
CQX64(L)	S8	LED	OSB9210	S2a	St	RTC901	S8	LED
CQX74(L)	S8	LED	OSB9215	S2a	St	RTC902	S8	LED
CQX74Y	S8	LED	OSB9410	S2a	St	RTC903	S8	LED
CQY11B	S8	LED	OSB9415	S2a	St	RTC904	S8	LED
CQY11C	S8	LED	OSM9110	S2a	St	1N821;A	S1	Vrf
CQY24B(L)	S8	LED	OSM9115	S2a	St	1N823;A	S1	Vrf
CQY49B	S8	LED	OSM9210	S2a	St	1N825;A	S1	Vrf
CQY49C	S8	LED	OSM9215	S2a	St	1N827;A	S1	Vrf
CQY50	S8	LED	OSM9410	S2a	St	1N829;A	S1	Vrf
CQY52	S8	LED	OSM9415	S2a	St	1N914	S1	SD
CQY54A	S8	LED	OSM9510	S2a	St	1N916	S1	SD
CQY58A	S8	LED	OSM9511	S2a	St	1N3879	S2a	R
CQY89A	S8	LED	OSM9512	S2a	St	1N3880	S2a	R
CQY94	S8	LED	OSS9110	S2a	St	1N3881	S2a	R
CQY94B(L)	S8	LED	OSS9115	S2a	St	1N3882	S2a	R
CQY95B	S8	LED	OSS9210	S2a	St	1N3883	S2a	R

GD = Germanium diodes

I = Infrared devices

LED = Light-emitting diodes

P = Low-frequency power transistors

Ph = Photoconductive devices

R = Rectifier diodes

SD = Small-signal diodes

Sm = Small-signal transistors

St = Rectifier stacks

Vrf = Voltage reference diodes

WBM = Wideband hybrid IC modules

# INDEX

type no.	book	section	type no.	book	section	type no.	book	section
1N3889	S2a	R	2N2218	S3	Sm	2N4031	S3	Sm
1N3890	S2a	R	2N2218A	S3	Sm	2N4032	S3	Sm
1N3891	S2a	R	2N2219	S3	Sm	2N4033	S3	Sm
1N3892	S2a	R	2N2219A	S3	Sm	2N4091	S5	FET
1N3893	S2a	R	2N2221	S3	Sm	2N4092	S5	FET
1N3909	S2a	R	2N2221A	S3	Sm	2N4093	S5	FET
1N3910	S2a	R	2N2222	S3	Sm	2N4123	S3	Sm
1N3911	S2a	R	2N2222A	S3	Sm	2N4124	S3	Sm
1N3912	S2a	R	2N2297	S3	Sm	2N4125	S3	Sm
1N3913	S2a	R	2N2368	S3	Sm	2N4126	S3	Sm
1N4001G	S1	R	2N2369	S3	Sm	2N4391	S5	FET
1N4002G	S1	R	2N2369A	S3	Sm	2N4392	S5	FET
1N4003G	S1	R	2N2483	S3	Sm	2N4393	S5	FET
1N4004G	S1	R	2N2484	S3	Sm	2N4427	S6	RFP
1N4005G	S1	R	2N2904	S3	Sm	2N4856	S5	FET
1N4006G	S1	R	2N2904A	S3	Sm	2N4857	S5	FET
1N4007G	S1	R	2N2905	S3	Sm	2N4858	S5	FET
1N4148	S1	SD	2N2905A	S3	Sm	2N4859	S5	FET
1N4150	S1	SD	2N2906	S3	Sm	2N4860	S5	FET
1N4151	S1	SD	2N2906A	S3	Sm	2N4861	S5	FET
1N4154	S1	SD	2N2907	S3	Sm	2N5415	S3	Sm
1N4446	S1	SD	2N2907A	S3	Sm	2N5416	S3	Sm
1N4448	S1	SD	2N3019	S3	Sm	61SV	S8	I
1N4531	S1	SD	2N3020	S3	Sm	375CQY/B	S8	Ph
1N4532	S1	SD	2N3053	S3	Sm	497CQF/A	S8	Ph
1N5059	S1	R	2N3375	S6	RFP	498CQL	S8	Ph
1N5060	S1	R	2N3553	S6	RFP	56201d	S4b	A
1N5061	S1	R	2N3632	S6	RFP	56201j	S4b	A
1N5062	S1	R	2N3822	S5	FET	56245	S3,6,10A	
1N5832	S2a	R	2N3823	S5	FET	56246	S3,5,10A	
1N5833	S2a	R	2N3866	S6	RFP	56261a	S4b	A
1N5834	S2a	R	2N3903	S3	Sm	56264a,b	S2a/b	A
1N6097	S2a	R	2N3904	S3	Sm	56295	S2a/b	A
1N6098	S2a	R	2N3905	S3	Sm	56326	S4b	A
2N918	S10	WBT	2N3906	S3	Sm	56339	S4b	A
2N929	S3	Sm	2N3924	S6	RFP	56352	S4b	A
2N930	S3	Sm	2N3926	S6	RFP	56353	S4b	A
2N1613	S3	Sm	2N3927	S6	RFP	56354	S4b	A
2N1711	S3	Sm	2N3966	S5	FET	56359b	S2,S4b	A
2N1893	S3	Sm	2N4030	S3	Sm	56359c	S2,S4b	A

A = Accessories  
 FET = Field-effect transistors  
 I = Infrared devices  
 Ph = Photoconductive devices  
 R = Rectifier diodes

RFP = R.F. power transistors and modules  
 SD = Small-signal diodes  
 Sm = Small-signal transistors  
 WBT = Wideband hybrid IC transistors

type no.	book	section	type no.	book	section	type no.	book	section
56359d	S2, S4b	A	56368a	S2, S4b	A	56387a, b	S4b	A
56360a	S2, S4b	A	56368b	S2, S4b	A			
56363	S2, S4b	A	56369	S2, S4b	A			
56364	S2, S4b	A	56378	S2, S4b	A			
56367	S2a/b	A	56379	S2, S4b	A			

A = Accessories

NOTES



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